PHILIPS

Data handbook

Electronic components and materials

Integrated circuits

Book IC13 1986

Semi-custom

Programmable Logic Devices (PLD)

SEMI-CUSTOM PROGRAMMABLE LOGIC DEVICES

DATA HANDBOOK SYSTEM

Our Data Handbook System comprises more than 60 books with specifications on electronic components, subassemblies and materials. It is made up of four series of handbooks:

ELECTRON TUBES	BLUE
SEMICONDUCTORS	RED
INTEGRATED CIRCUITS	PURPLE
COMPONENTS AND MATERIALS	GREEN

The contents of each series are listed on pages iv to viii.

The data handbooks contain all pertinent data available at the time of publication, and each is revised and reissued periodically.

When ratings or specifications differ from those published in the preceding edition they are indicated with arrows in the page margin. Where application information is given it is advisory and does not form part of the product specification.

Condensed data on the preferred products of Philips Electronic Components and Materials Division is given in our Preferred Type Range catalogue (issued annually).

Information on current Data Handbooks and on how to obtain a subscription for future issues is available from any of the Organizations listed on the back cover.
Product specialists are at your service and enquiries will be answered promptly.

ELECTRON TUBES (BLUE SERIES)

The blue series of data handbooks comprises:

T1 **Tubes for r.f. heating**

T2a **Transmitting tubes for communications, glass types**

T2b **Transmitting tubes for communications, ceramic types**

T3 **Klystrons**

T4 **Magnetrons for microwave heating**

T5 **Cathode-ray tubes**
Instrument tubes, monitor and display tubes, C.R. tubes for special applications

T6 **Geiger-Müller tubes**

T8 **Colour display systems**
Colour TV picture tubes, colour data graphic display tube assemblies, deflection units

T9 **Photo and electron multipliers**

T10 **Plumbicon camera tubes and accessories**

T11 **Microwave semiconductors and components**

T12 **Vidicon and Newvicon camera tubes**

T13 **Image intensifiers and infrared detectors**

T15 **Dry reed switches**

T16 **Monochrome tubes and deflection units**
Black and white TV picture tubes, monochrome data graphic display tubes, deflection units

SEMICONDUCTORS (RED SERIES)

The red series of data handbooks comprises:

S1 **Diodes**
Small-signal silicon diodes, voltage regulator diodes (< 1,5 W), voltage reference diodes, tuner diodes, rectifier diodes

S2a **Power diodes**

S2b **Thyristors and triacs**

S3 **Small-signal transistors**

S4a **Low-frequency power transistors and hybrid modules**

S4b **High-voltage and switching power transistors**

S5 **Field-effect transistors**

S6 **R.F. power transistors and modules**

S7 **Surface mounted semiconductors**

S8a **Light-emitting diodes**

S8b **Devices for optoelectronics**
Optocouplers, photosensitive diodes and transistors, infrared light-emitting diodes and infrared sensitive devices, laser and fibre-optic components

S9 **Power MOS transistors**

S10 **Wideband transistors and wideband hybrid IC modules**

S11 **Microwave transistors**

S12 **Surface acoustic wave devices**

S13 **Semiconductor sensors**

***S14** **Liquid Crystal Displays**

*To be issued shortly.

INTEGRATED CIRCUITS (PURPLE SERIES)

The NEW SERIES of handbooks is now completed. With effect from the publication date of this handbook the "N" in the handbook code number will be deleted.
Handbooks to be replaced during 1986 are shown below.

The purple series of handbooks comprises:

IC01	**Radio, audio and associated systems** Bipolar, MOS	new issue 1986 IC01N 1985
IC02a/b	**Video and associated systems** Bipolar, MOS	new issue 1986 IC02Na/b 1985
IC03	**Integrated circuits for telephony** Bipolar, MOS	new issue 1986 IC03N 1985
IC04	**HE4000B logic family** CMOS	new issue 1986 IC4 1983
IC05N	**HE4000B logic family – uncased ICs** CMOS	published 1984
IC06N	**High-speed CMOS; PC74HC/HCT/HCU** Logic family	published 1986
IC08	**ECL 10K and 100K logic families**	New issue 1986 IC08N 1984
IC09N	**TTL logic series**	published 1986
IC10	**Memories** MOS, TTL, ECL	new issue 1986 IC7 1982
IC11N	**Linear LSI**	published 1985
Supplement to IC11N	**Linear LSI**	published 1986
IC12	**I^2C-bus compatible ICs**	not yet issued
IC13	**Semi-custom** Programmable Logic Devices (PLD)	new issue 1986 IC13N 1985
IC14N	**Microprocessors, microcontrollers and peripherals** Bipolar, MOS	published 1985
IC15	**FAST TTL logic series**	new issue 1986 IC15N 1985
IC16	**CMOS integrated circuits for clocks and watches**	first issue 1986
IC17	**Integrated Services Digital Networks (ISDN)**	not yet issued
IC18	**Microprocessors and peripherals**	new issue 1986*

* The Microprocessors were included in handbook IC14N 1985, so IC18 will replace that part of IC14N.

COMPONENTS AND MATERIALS (GREEN SERIES)

The green series of data handbooks comprises:

C2 **Television tuners, coaxial aerial input assemblies, surface acoustic wave filters**

C3 **Loudspeakers**

C4 **Ferroxcube potcores, square cores and cross cores**

C5 **Ferroxcube for power, audio/video and accelerators**

C6 **Synchronous motors and gearboxes**

C7 **Variable capacitors**

C8 **Variable mains transformers**

C9 **Piezoelectric quartz devices**

C11 **Varistors, thermistors and sensors**

C12 **Potentiometers, encoders and switches**

C13 **Fixed resistors**

C14 **Electrolytic and solid capacitors**

C15 **Ceramic capacitors**

C16 **Permanent magnet materials**

C17 **Stepping motors and associated electronics**

C18 **Direct current motors**

C19 **Piezoelectric ceramics**

C20 **Wire-wound components for TVs and monitors**

C22 **Film capacitors**

GENERAL CONTENTS

Preface

The continuing trend of system integration has created new challenges for Design Engineering. They must strive to consolidate higher complexity, and more feature intensive circuits into designs without sacrificing flexibility. Today's competitive electronic marketplace has created the need for logic devices, which can provide cost effective methods of reducing random logic requirements, interface with fixed and custom LSI logic, and maintain the flexible features required to make necessary system modifications prior to production. Signetics has responded to this need with Signetics Programmable Logic Devices (Signetics PLD).

The Signetics Programmable Logic family consists of a relatively few devices which are designed to address logic needs ranging from random gates in the case of the Field Programmable Gate Arrays, to highly sophisticated state machines in the case of Field Programmable Logic Sequencers. Signetics pioneered the fully-programmable AND/OR/INVERT architecture in 1975. By using the programmable features allowed by this powerful architecture, Signetics Programmable Logic can encompass wide-ranging levels of integration without the necessity of a multitude of devices, each with a different I/O configuration. The flexible programming structure allows the designer to "mold" the device architecture to the range of applications typically found in system design. In this way, one device can be used to perform several functions in the same design.

The manufacturing processes used in Signetics Programmable Logic Devices are identical to the ones used on Signetics Bipolar PROM family. This makes it possible to produce a highly manufacturable, high-performance, cost-effective family of devices. The 1986 Signetics Programmable Logic Data Manual contains information the designer will require in order to effectively utilize these products.

Signetics Programmable Logic Marketing

Product Status

DEFINITIONS		
Data Sheet Identification	**Product Status**	**Definition**
Objective Specification	**Formative or In Design**	This data sheet contains the design target or goal specifications for product development. Specifications may change in any manner without notice.
Preliminary Specification	**Preproduction Product**	This data sheet contains preliminary data and supplementary data will be published at a later date. Signetics reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.
Product Specification	**Full Production**	This data sheet contains Final Specifications. Signetics reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.

Signetics

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Section 1

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Application Specific Products

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SIGNETICS BIPOLAR PROGRAMMABLE LOGIC QUALITY

Signetics has put together a winning process for manufacturing Programmable Logic. Our standard is zero defects, and current customer quality statistics demonstrate our commitment to this goal.

The PLD's produced in the Application Specific Products Division must meet rigid criteria as defined by our design rules and as evaluated with a thorough product characterization and quality process. The capabilities of our manufacturing process are measured and the results evaluated and reported through our corporate-wide QA05 data base system. The SURE (Systematic Uniform Reliability Evaluation) program monitors the performance of our product in a variety of accelerated environmental stress conditions. All of these programs and systems are intended to prevent product-related problems and to inform our customers and employees of our progress in achieving zero defects.

RELIABILITY BEGINS WITH THE DESIGN

Quality and reliability must begin with design. No amount of extra testing or inspection will produce reliable ICs from a design that is inherently unreliable. Signetics follows very strict design and layout practices with its circuits. To eliminate the possibility of metal migration, current density in any path cannot exceed 2 x 10(fifth) amps/cm(sq). Layout rules are followed to minimize the possibility of shorts, circuit anomalies, and SCR type latch-up effects. Numerous ground-to-substrate connections are required to ensure that the entire chip is at the same ground potential, thereby precluding internal noise problems.

PRODUCT CHARACTERIZATION

Before a new design is released, the characterization phase is completed to insure that the distribution of parameters resulting from lot-to-lot variations is well within specified limits. Such extensive characterization data also provides a basis for identifying unique application-related problems which are not part of normal data sheet guarantees. Characterization takes place from −55°C to +125°C and at +10% supply voltage.

QUALIFICATION

Formal qualification procedures are required for all new or changed products, processes and facilities. These procedures ensure the high level of product reliability our customers expect. New facilities are qualified by corporate groups as well as by the quality organizations of specific units that will operate in the facility. After qualification, products manufactured by the new facility are subjected to highly accelerated environmental stresses to ensure that they can meet rigorous failure rate requirements. New or changed processes are similarly qualified.

QA05 – QUALITY DATA BASE REPORTING SYSTEM

The QA05 data reporting system collects the results of product assurance testing on all finished lots and feeds this data back to concerned organizations where appropriate action can be taken. The QA05 reports EPQ (Estimated Process Quality) and AOQ (Average Outgoing Quality) results for electrical, visual/mechanical, hermeticity, and documentation audits. Data from this system is available on request.

THE SURE PROGRAM

The SURE (Systematic Uniform Reliability Evaluation) program audits/monitors products from all Signetics' divisions under a variety of accelerated environmental stress conditions. This program, first introduced in 1964, has evolved to suit changing product complexities and performance requirements.

The SURE program has two major functions: Long-term accelerated stress performance audit and a short-term accelerated stress monitor. In the case of Bipolar Memory and Programmable Logic products, samples are selected that represent all generic product groups in all wafer fabrication and assembly locations.

THE LONG-TERM AUDIT

One-hundred devices from each generic family are subjected to each of the following stresses every eight weeks:

- High Temperature Operating Life: Tj = 150°C, 1000 hours, static biased or dynamic operation, as appropriate (worst case bias configuration is chosen)
- High Temperature Storage: Tj = 150°C, 1000 hours
- Temperature Humidity Biased Life: 85°C, 85% relative humidity, 1000 hours, static biased
- Temperature Cycling (Air-to-Air): −65°C to +150°C, 1000 cycles

THE SHORT-TERM MONITOR

Every other week a 50-piece sample from each generic family is run to 168 hours of pressure pot (15psig, 121°C, 100% saturated steam) and 300 cycles of thermal shock (−65°C to +150°C)

In addition, each Signetics assembly plant performs SURE product monitor stresses weekly on each generic family and molded package by pin count and frame type. Fifty-piece samples are run on each stress, pressure pot to 96 hours, thermal shock to 300 cycles.

SURE REPORTS

The data from these test matrices provides a basic understanding of product capability, an indication of major failure mechanisms and an estimated failure rate resulting from each stress. This data is compiled periodically and is available to customers upon request.

Many customers use this information in lieu of running their own qualification tests, thereby eliminating time-consuming and costly additional testing.

Quality and Reliability

RELIABILITY ENGINEERING

In addition to the product performance monitors encompassed in the Programmable Logic SURE program, Signetics' Corporate and Division Reliability Engineering departments sustain a broad range of evaluation and qualification activities.

Included in the engineering process are:

- Evaluation and qualification of new or changed materials, assembly/wafer-fab processes and equipment, product designs, facilities and subcontractors.
- Device or generic group failure rate studies.
- Advanced environmental stress development.
- Failure mechanism characterization and corrective action/prevention reporting.

The environmental stresses utilized in the engineering programs are similar to those utilized for the SURE monitor; however, more highly-accelerated conditions and extended durations typify the engineering projects. Additional stress systems such as biased pressure pot, power-temperature cycling, and cycle-biased temperature-humidity, are also included in the evaluation programs.

FAILURE ANALYSIS

The SURE Program and the Reliability Engineering Program both include failure analysis activities and are complemented by corporate, divisional and plant failure analysis departments. These engineering units provide a service to our customers who desire detailed failure analysis support, who in turn provide Signetics with the technical understanding of the failure modes and mechanisms actually experienced in service. This information is essential in our ongoing effort to accelerate and improve our understanding of product failure mechanisms and their prevention.

ZERO DEFECTS PROGRAM

In recent years, United States industry has increasingly demanded improved product quality. We at Signetics believe that the customer has every right to expect quality products from a supplier. The benefits which are derived from quality products can be summed up in the words, *lower cost of ownership.*

Those of you who invest in costly test equipment and engineering to assure that incoming products meet your specifications have a special understanding of the cost of ownership. And your cost does not end there; you are also burdened with inflated inventories, lengthened lead times and more rework.

SIGNETICS UNDERSTANDS CUSTOMERS' NEEDS

Signetics has long had an organization of quality professionals, inside all operating units, coordinated by a corporate quality department. This broad decentralized organization provides leadership, feedback, and direction for achieving a high level of quality. Special programs are targeted on specific quality issues. For example, in 1978 a program to reduce electrically defective units for a major automotive manufacturer improved outgoing quality levels by an order of magnitude.

In 1980 we recognized that in order to achieve outgoing levels on the order of 100PPM (parts per million), down from an industry practice of 10,000PPM, we needed to supplement our traditional quality programs with one that encompassed all activities and all levels of the company. Such unprecedented low defect levels could only be achieved by contributions from all employees, from the R and D laboratory to the shipping dock. In short, from a program that would effect a total cultural change within Signetics in our attitude toward quality.

QUALITY PAYS OFF FOR OUR CUSTOMERS

Signetics' dedicated programs in product quality improvement, supplemented by close working relationships with many of our customers, have improved outgoing product quality more than twenty-fold since 1980. Today, many major customers no longer test Signetics circuits. Incoming product moves directly from the receiving dock to the production line, greatly accelerating throughput and reducing inventories. Other customers have pared significantly the amount of sampling done on our products. Others are beginning to adopt these cost-saving practices.

We closely monitor the electrical, visual, and mechanical quality of all our products and review each return to find and correct the cause. Since 1981, over 90% of our customers report a significant improvement in overall quality (see Figure 1).

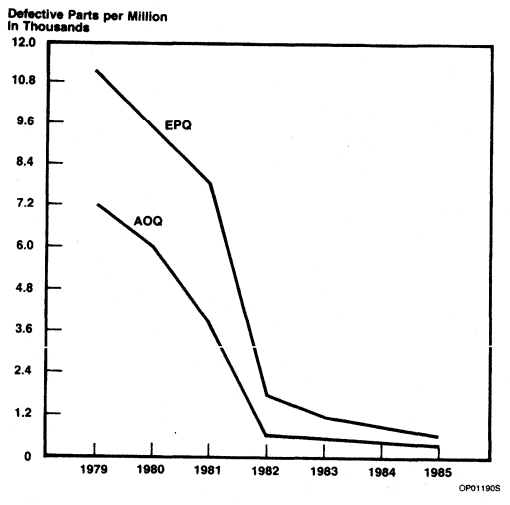


Figure 1. Signetics Quality Progress

Quality and Reliability

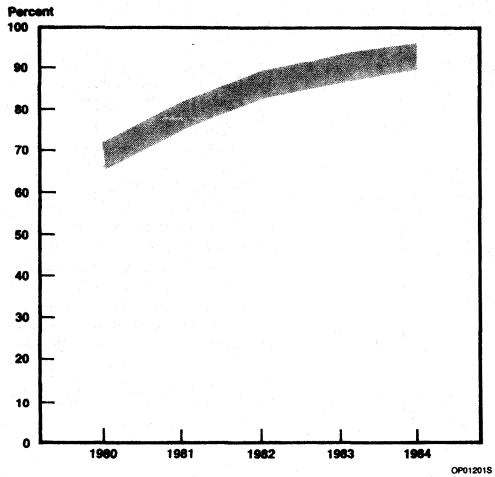


Figure 2. Performance to Schedule On-Time Delivery

At Signetics, quality means more than working circuits. It means on-time delivery of the right product at the agreed upon price (see Figure 2).

ONGOING QUALITY PROGRAM

The quality improvement program at Signetics is based on "Do it Right the First Time". The intent of this innovative program is to change the perception of Signetics' employees that somehow quality is solely a manufacturing issue where some level of defects is inevitable. This attitude has been replaced by one of acceptance of the fact that all errors and defects are preventable, a point of view shared by all technical and administrative functions equally.

This program extends into every area of the company, and more than 40 quality improvement teams throughout the organization drive its ongoing refinement and progress.

Key components of the program are the Quality College, the "Make Certain" Program, Corrective Action Teams, and the Error Cause Removal System.

The core concepts of doing it right the first time are embodied in the four absolutes of quality:

1. The definition of quality is conformance to requirements.
2. The system to achieve quality improvement is prevention.
3. The performance standard is zero defects.
4. The measurement system is the cost of quality.

QUALITY COLLEGE

Almost continuously in session, Quality College is a prerequisite for all employees. The intensive curriculum is built around the four absolutes of quality; colleges are conducted at company facilities throughout the world.

"MAKING CERTAIN" – ADMINISTRATIVE QUALITY IMPROVEMENT

Signetics' experience has shown that the largest source of errors affecting product and service quality is found in paperwork and in other administrative functions. The "Make Certain" program focuses the attention of management and administrative personnel on error prevention, beginning with each employee's own actions.

This program promotes defect prevention in three ways: by educating employees as to the impact and cost of administrative errors, by changing attitudes from accepting occasional errors to one of accepting a personal work standard of zero defects, and by providing a formal mechanism for the prevention of errors.

CORRECTIVE ACTION TEAMS

Employees with the perspective, knowledge, and necessary skills to solve a problem are formed into ad hoc groups called Corrective Action Teams. These teams, a major force within the company for quality improvement, resolve administrative, technical and manufacturing problems.

ECR SYSTEM (ERROR CAUSE REMOVAL)

The ECR System permits employees to report to management any impediments to doing the job right the first time. Once such an impediment is reported, management is obliged to respond promptly with a corrective program. Doing it right the first time in all company activities produces lower cost of ownership through defect prevention.

PRODUCT QUALITY PROGRAM

To reduce defects in outgoing products, we created the Product Quality Program. This is managed by the Product Engineering Council, composed of the top product engineering and test professionals in the company. This group:

1. Sets aggressive product quality improvement goals;
2. provides corporate-level visibility and focus on problem areas;
3. serves as a corporate resource for any group requiring assistance in quality improvement; and
4. drives quality improvement projects.

As a result of this aggressive program, every major customer who reports back to us on product performance is reporting significant progress.

VENDOR CERTIFICATION PROGRAM

Our vendors are taking ownership of their own product quality by establishing improved process control and inspection systems. They subscribe to the zero defects philosophy. Progress has been excellent.

Quality and Reliability

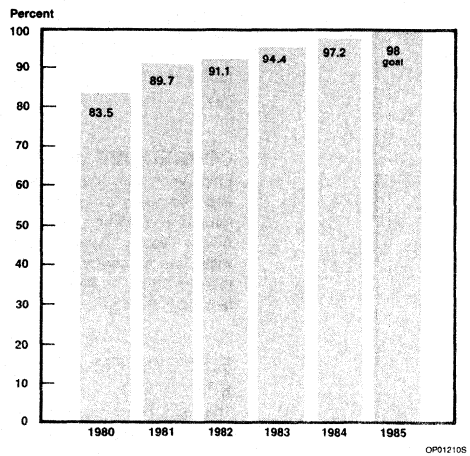


Figure 3. Lot Acceptance Rate from Signetics Vendors

Through intensive work with vendors, we have improved our lot acceptance rate on incoming materials as shown in Figure 3. Simultaneously, waivers of incoming material have been eliminated.

MATERIAL WAIVERS

1985 – (0) (Goal)
1984 – 0
1983 – 0
1982 – 2
1981 – 134

Higher incoming quality material ensures higher outgoing quality products.

QUALITY AND RELIABILITY ORGANIZATION

Quality and reliability professionals at the divisional level are involved with all aspects of the product, from design through every step in the manufacturing process, and provide product assurance testing of outgoing product. A separate corporate-level group provides direction and common facilities.

Quality and Reliability Functions

- Manufacturing quality control
- Product assurance testing
- Laboratory facilities – failure analysis, chemical, metallurgy, thin film, oxides
- Environmental stress testing
- Quality and reliability engineering
- Customer liaison

COMMUNICATING WITH EACH OTHER

For information on Signetics' quality programs or for any question concerning product quality, the field salesperson in your area will provide you with the quickest access to answers. Or, write on your letter-head directly to the corporate director of quality at the corporate address shown at the back of this manual.

We are dedicated to preventing defects. When product problems do occur, we want to know about them so we can eliminate their causes. Here are some ways we can help each other:

- Provide us with one informed contact within your organization. This will establish continuity and build confidence levels.
- Periodic face-to-face exchanges of data and quality improvement ideas between your engineers and ours can help prevent problems before they occur.
- Test correlation data is very useful. Line-pull information and field failure reports also help us improve product performance.
- Provide us with as much specific data on the problem as soon as possible to speed analysis and enable us to take corrective action.
- An advance sample of the devices in question can start us on the problem resolution before physical return of shipment.

This team work with you will allow us to achieve our mutual goal of improved product quality.

MANUFACTURING: DOING IT RIGHT THE FIRST TIME

In dealing with the standard manufacturing flows, it was recognized that significant improvement would be achieved by "doing every job right the first time", a key concept of the quality improvement program. During the development of the program many profound changes were made. Figure 4, *Programmable Logic Process Flow*, shows the result. Key changes included such things as implementing 100% temperature testing on all products as well as upgrading test handlers to insure 100% positive binning. Some of the other changes and additions were to tighten the outgoing QA lot acceptance criteria to the tightest in the industry, with zero defect lot acceptance sampling across all three temperatures.

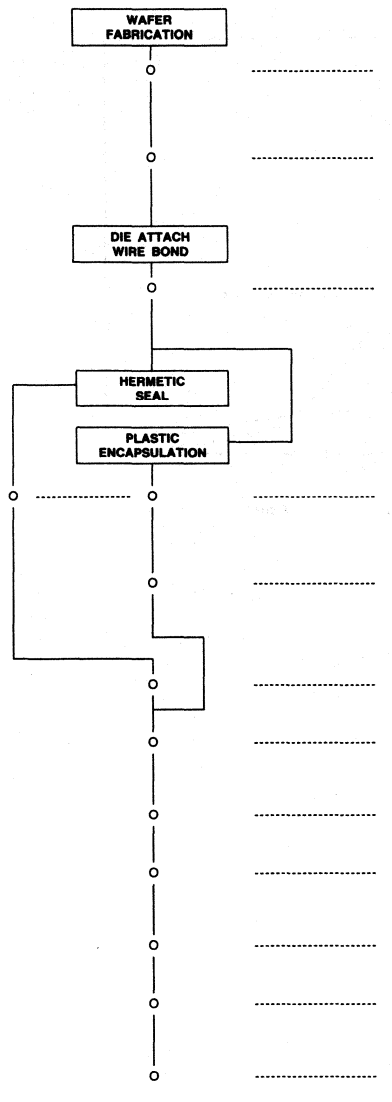
The achievements resulting from the improved process flow have helped Signetics to be recognized as the leading Quality supplier of Programmable Logic. These achievements have also led to our participation in several Ship-to-Stock programs, which our customers use to eliminate incoming inspection. Such programs reduce the user *cost of ownership* by saving both time and money.

OUR GOAL: 100% PROGRAMMING YIELD

Our original goal back in the early 1970s was to develop a broad line of programmable products which would be recognized as having the best programming yield in the industry. Within the framework of a formal quality program, our efforts to improve circuit designs and refine manufacturing controls have resulted in major advances toward that goal.

Also within the framework of our formal quality program we have now established a stated goal of 100% programming yield. Through the increasing effectiveness of a quality attitude of "Do It Right The First Time" we're moving ever closer to that target.

Signetics PLD programming yields have been shown in collected data from internal audits and customer reporting to be consistently higher than comparable devices produced by our competition. We use systematic methods involving publication of exacting specifications of our programming algorithms, and through evaluation of those algorithms as implemented in industry standard programming equipment. Because of this we can assure our customers who program Signetics PLD's on such qualified equipment they will see consistently high yields. Our data base shows that average lot programming yield exceeds 97%.



SCANNING ELECTRON MICROSCOPE CONTROL

Wafers are sampled daily by the Quality Control Laboratory from each fabrication area and subjected to SEM analysis. This process control reveals manufacturing defects such as contact and oxide step coverage in the metalization process which may result in early failures.

DIE SORT VISUAL ACCEPTANCE

Product is inspected for defects caused during fabrication, wafer testing, or the mechanical scribe and break operation. Defects such as scratches, smears and glassivated bonding pads are included in the lot acceptance criteria.

PRE-SEAL VISUAL ACCEPTANCE

Product is inspected to detect any damage incurred at the die attach and wire bonding stations. Defects such as scratches, contamination and smeared ball bonds are included in the lot acceptance criteria.

STABILIZATION BAKE PRECONDITIONING

Plastic molded devices are baked to stress wire and die bonds and help eliminate marginal devices. It also ensures an optimum plastic seal to enhance moisture resistance. Hermetic devices are baked to ensure the elimination of any remaining cavity moisture.

TEMPERATURE CYCLING

Using MIL-STD-883 Method 1010.1 Condition C devices are cycled from cold to hot temperatures imposing a very severe stress which weakens loose bonds and package seals without degrading good devices. A loosened bond is later detected during 100% electrical tests.

SEAL TESTS

Hermetic package seal integrity is ensured by 100% gross leak testing.

100% ELECTRICAL TEST

Every device is tested for functional and AC/DC parameters at high temperature with guard bands to assure performance to data sheet limits.

BURN IN (SUPR II LEVEL B OPTION)

Devices are burned in for 21 hours at 155°C maximum junction temperature.

SYMBOL

Devices are marked with the Signetics logo, device number and date code or custom symbol per individual specification requirements.

VISUAL

All products are 100% visually inspected per the requirements specified in Signetics or customer documents.

100% PRODUCTION ELECTRICAL TESTING

Every device is tested for functional and AC/DC parameters at 25°C with guard bands to assure performance to data sheet limits.

FINAL QUALITY ASSURANCE GATE

The final QA inspection step guarantees that the specified mechanical and electrical AQL's have been met. Every shipment is sealed and identified by QA personnel.

Figure 4. Application Specific Products Programmable Logic Process Flow

Quality and Reliability

As time goes on the drive for a product line that has Zero Defects will grow in intensity. These efforts will provide both Signetics and our customers with the ability to achieve the mutual goal of improved product quality.

The Application Specific Quality Assurance department has monitored PPM progress, which can be seen in Figure 5. We are pleased with the progress that has been made, and expect to achieve even more impressive results as the procedures for accomplishing these tasks are fine tuned.

The real measure of any quality improvement program is the result that our customers see. The meaning of *Quality* is more than just working circuits. It means commitment to *On Time Delivery* at the *Right Place* of the *Right Quantity* of the *Right Product* at the *Agreed Upon Price.*

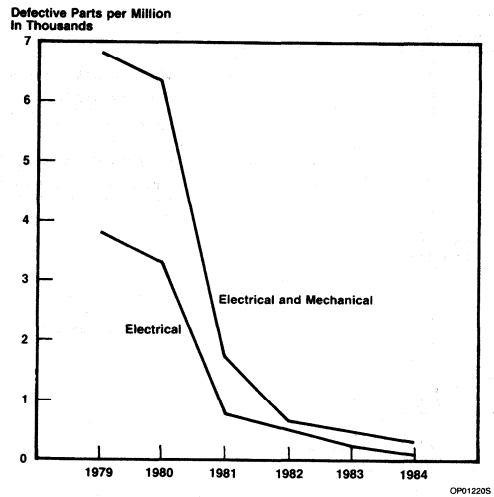


Figure 5. Programmable Logic AOQ (Average Outgoing Quality)

Alphanumeric Index

Application Specific Products

Application Specific Products

SIGNETICS PN	ARCHITECTURE	PACKAGE	TOTAL INPUTS (# DEDICATED)	PRODUCT TERMS	INTERNAL STATE REGISTERS	OUTPUTS	T_{PD}	I_{CC}
						C, I/O, R, RI/O	(Typical Values)[1,2]	
	FPGA							
PLS103	16 × 9 × 9	28 Pin	16	9	0	9 C	20nS	120mA
PLS151	18 × 15 × 12	20 Pin	18 (6)	15	0	12 I/O	16nS	130mA
	FPAD							
PLS162	16 × 5	24 Pin	16	5	0	5 C	20nS	120mA
PLS163	12 × 9	24 Pin	12	9	0	9 C	20nS	120mA
	FPLA							
PLS100	16 × 48 × 8	28 Pin	16	48	0	8C	35nS	120mA
PLS153	18 × 42 × 10	20 Pin	18 (8)	42	0	10 I/O	30nS	130mA
PLS153A	18 × 42 × 10	20 Pin	18 (8)	42	0	10 I/O	20nS	130mA
PLHS153**	18 × 42 × 10	20 Pin	18 (8)	42	0	10 I/O	15nS	150mA
PLC153**	18 × 42 × 10	20 Pin	18 (8)	42	0	10 I/O	TBD	TBD
PLS161	12 × 48 × 8	24 Pin	12	48	0	8 C	35nS	120mA
PLS173	22 × 42 × 10	24 Pin	22 (12)	42	0	10 I/O	20nS	150mA
PLC173**	22 × 42 × 10	24 Pin	22 (12)	42	0	10 I/O	TBD	TBD
PLHS173**	22 × 42 × 10	24 Pin	22 (12)	42	0	10 I/O	15nS	150mA
PLHS473**	20 × 24 × 11	24 Pin	20 (11)	24	0	2 C & 9 I/O	15nS	140mA
PLC473**	20 × 24 × 11	24 Pin	20 (11)	24	0	2 C & 9 I/O	20nS	25mA
PLHS18P8**	18 × 72 × 8	20 Pin	18 (10)	72	0	8 I/O	10nS	120mA
	FPLS							
PLS105	16 × 48 × 8	28 Pin	16	48	6	8 R	60nS	120mA
PLS105A	16 × 48 × 8	28 Pin	16	48	6	8 R	45nS	120mA
PLC105**	16 × 48 × 8	28 Pin	16	48	6	8 R	TBD	TBD
PLHS405**	16 × 64 × 8	28 Pin	16	64	8	8 R	15nS	160mA
PLS155	16 × 45 × 12	20 Pin	16 (4)	45	4*	8 I/O & 4 R I/O	55nS	150mA
PLS157	16 × 45 × 12	20 Pin	16 (4)	45	6*	6 I/O & 6 R I/O	55nS	150mA
PLS159	16 × 45 × 12	20 Pin	16 (4)	45	8*	4 I/O & 8 R I/O	55nS	150mA
PLS167	14 × 48 × 6	24 Pin	14	48	6 plus 2*	6 R	60nS	120mA
PLS167A	14 × 48 × 6	24 Pin	14	48	6 plus 2*	6 R	45nS	120mA
PLS168	12 × 48 × 8	24 Pin	12	48	6 plus 4*	8 R	60nS	120mA
PLS168A	12 × 48 × 8	24 Pin	12	48	6 plus 4*	8 R	45nS	120mA
PLS179**	20 × 45 × 12	24 Pin	20 (8)	45	8*	4 I/O & 8 R I/O	45nS	145mA

OUTPUTS:
C = Combinatorial output
R = Registered output
I/O = Combinatorial I/O
R I/O = Registered I/O
* State registers shared with output registers
** Under development

NOTES:
1. $T_{PD} = T_{IS} + T_{CKO}$ for registered devices
2. For worst case specifications refer to data sheets for individual product.

Selection Guides

DEVICE[5]	ORGANIZATION	OUTPUT CIRCUIT[1]	OUTPUT LOGIC[2]	ACCESS TIME[3]	PACKAGE[4]	PINS	MAX I_{CC}
PROMs							
82S23	32 × 8	OC	—	50	N	16	96
82S23A	32 × 8	OC	—	25	D, N	16	96
82S23B[6]	32 × 8	OC	—	15	D, N	16	110
82S123	32 × 8	TS	—	50	N	16	96
82S123A	32 × 8	TS	—	25	D, N	16	96
82S123B[6]	32 × 8	TS	—	15	D, N	16	110
82S126	256 × 4	OC	—	50	N	16	120
82S126A	256 × 4	OC	—	30	D, N	16	120
82S129	256 × 4	TS	—	50	N	16	120
82S129A	256 × 4	TS	—	27	D, N	16	120
10149	256 × 4	OE	—	20	F	16	150
100149	256 × 4	OE	—	20	F	16	150
82S130	512 × 4	OC	—	50	D, N	16	140
82S130A	512 × 4	OC	—	33	D, N	16	140
82S131	512 × 4	TS	—	50	N	16	140
82S131A	512 × 4	TS	—	30	D, N	16	140
82LS135	256 × 8	TS	—	100	D, N	20	100
82S135	256 × 8	TS	—	45	D, N	20	150
82S115	512 × 8	TS	—	60	N	24	175
82S137	1024 × 4	TS	—	60	N	18	140
82S137A	1024 × 4	TS	—	45	D, N	20, 18	140
82S137B	1024 × 4	TS	—	35	D, N	20, 18	140
82S147	512 × 8	TS	—	60	D, N	20	155
82S147A	512 × 8	TS	—	45	D, N	20	155
82LS181	1024 × 8	TS	—	120	A, N	24	80
82S181	1024 × 8	TS	—	70	N	24	175
82S181A	1024 × 8	TS	—	55	A, N	28, 24	175
82S181C	1024 × 8	TS	—	30	A, N, N3	28, 24	175
82S183	1024 × 8	TS	—	60	N	24	175
82S185	2048 × 4	TS	—	100	N	18	120
82S185A	2048 × 4	TS	—	50	D, N	20, 18	155
82S185B	2048 × 4	TS	—	45	D, N	20, 18	155
82HS187	1024 × 8	TS	R	55	N	24	155
82HS187A	1024 × 8	TS	R	45	N	24	155
82HS189	1024 × 8	TS	R	55	N	24	155
82HS189A	1024 × 8	TS	R	45	N	24	155

Selection Guides

DEVICE[5]	ORGANIZATION	OUTPUT CIRCUIT[1]	OUTPUT LOGIC[2]	ACCESS TIME[3]	PACKAGE[4]	PINS	MAX I_{CC}
PROMs							
82S191	2048 × 8	TS	—	80	N	24	175
82S191A	2048 × 8	TS	—	55	N	24	175
82S191C	2048 × 8	TS	—	35	A, N, N3	24	175
82HS195	4096 × 4	TS	—	45	N	20	145
82HS195A	4096 × 4	TS	—	35	N	20	145
82HS195B	4096 × 4	TS	—	25	N	20	145
82HS197[6]	2048 × 8	TS	R	65	N	24	155
82HS199[6]	2048 × 8	TS	R	65	N	24	155
82S321	4096 × 8	TS	—	70	N	24	175
82HS321	4096 × 8	TS	—	45	N	24	175
82HS321A	4096 × 8	TS	—	35	N	24	175
82HS321B	4096 × 8	TS	—	30	N	24	175
82HS641	8192 × 8	TS	—	55	N	24	175
82HS641A	8192 × 8	TS	—	45	N	24	175
82HS641B	8192 × 8	TS	—	35	N	24	175
82HS1281[6]	16384 × 8	TS	—	45	N	24	175

NOTES:

1. Output circuit
   OE = Open Emitter
   OC = Open Collector
   TS = 3 State
2. Output logic
   T = Transparent — input data appears on output during Write
   B = Blanked — output is blanked during Write
   R = Registers
   I/O = Programmable input/output option
3. Commercial (0°C to +75°C)
4. Packages:
   N = Plastic Dual In Line (N3 = 300 mil wide)
   A = Plastic Square Leaded Chip Carrier
   D = Small Outline Large (SO-L)
   *Whenever a single device is offered in both 300 mil wide and 600 mil wide packages, designate either N3 (300 mil) or N (600 mil) to assure proper order entry and shipment.
5. Part numbers:
   82Sxxx Junction Isolated
   82HSxxx Oxide Isolated
6. Objective spec (under product development)

Signetics

Ordering Information

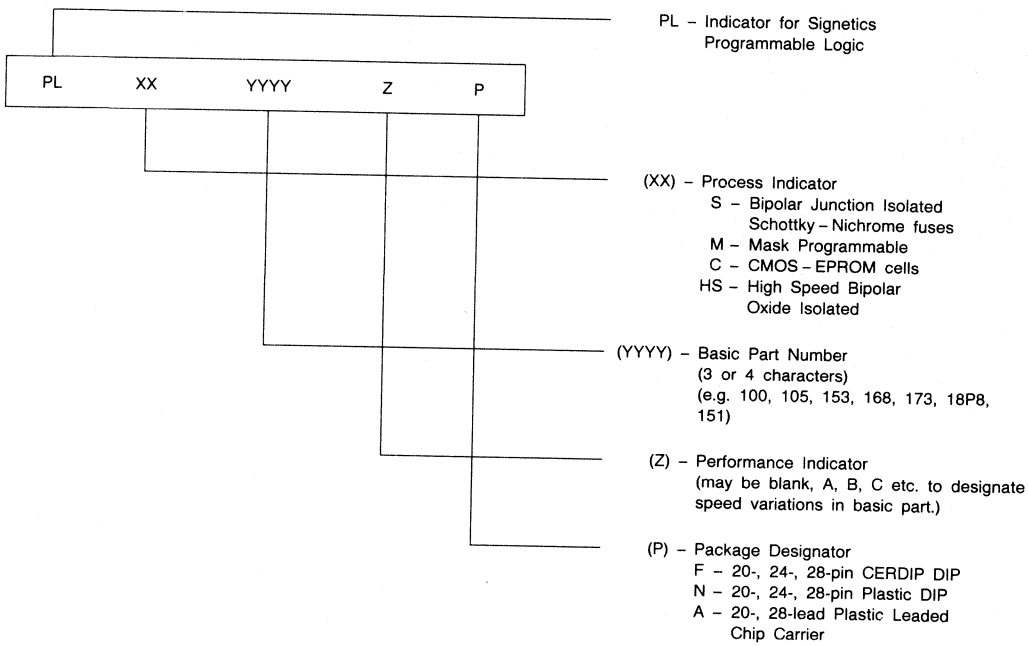
Application Specific Products

Signetics Programmable Logic Devices may be ordered by contacting either the local Signetics sales office, Signetics representatives or authorized distributors. A complete listing is located in the back of this manual.

Table 1 provides part number definition for Signetics PLD's. The Signetics part number system allows complete ordering information to be specified in the part number. The part number and product description is located on each data sheet.

Military versions of these commercial products may be ordered. Please refer to the military products data manual for complete ordering information.

Table 1. New Signetics PLD Part Numbering System



Note To Users Of 82SXXX Part Numbering System

Application Specific Products

Signetics has changed its part numbering system for Programmable Logic Products. The change is simple and straightforward. Simply replace the old temperature code and "82" Bipolar Memory designator with "PL." This change in part numbering has been done to create a unique, identifiable image for Signetics Programmable Logic Products. As we continue to introduce PLD's with new features, processes, and fusing technology, the new system will allow us to better describe these products through the product part number. In addition, more critical information can be placed on the device itself even when plastic leaded chip carriers are used. The new part number system does not indicate any change in process or technology has occurred. The only thing changing is the nomenclature.

We sincerely hope this necessary change causes no inconveniences to our many customers. Thank you for your loyalty.

PART NUMBERING EXAMPLES

OLD PART NUMBER	NEW PART NUMBER	DESCRIPTION
N82S100N	PLS100N	Signetics Programmable Logic Field Programmable Logic Array (FPLA) Bipolar Schottky Process – Nichrome Fuses – 28-Lead Dual-In-line Package.
N82S105AA	PLS105AA	Signetics Programmable Logic Field Programmable Logic Sequencer (FPLS) Bipolar Schottky Process – Nichrome Fuses – High Speed Option – 28-Lead Plastic Leaded Chip Carrier.
N/A	PLC473F	Signetics Programmable Logic Field Programmable Logic Array (FPLA) CMOS – UV Erasable Fuses – 24-Lead Cerdip Dual-In-line Package.
N/A	PLMC153F	Signetics Programmable Logic Programmable Logic Array CMOS – Mask Programmable – 20-Lead Cerdip Dual-In-line Package.
N/A	PLHS18P8A	Signetics Programmable Logic Field Programmable Array Oxide Isolated, Bipolar-Vertical Fuses 20-Pin Plastic Leaded Chip Carrier.

This change affects **commerical product only.**

Signetics

Application Specific Products

Section 2
Introduction

2

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Introduction

Signetics Programmable Logic

WHAT IS PROGRAMMABLE LOGIC

In 1975, Signetics Corporation developed a new product family by combining its expertise in semi-custom gate array products and fuse-link Programmable Read Only Memories (PROMs). Out of this marriage came Signetics Programmable Logic Family. The PLS100 Field Programmable Logic Array (FPLA) was the first member of this family. The FPLA was an important industry first in two ways. First, the AND/OR/INVERT architecture allowed the custom implementations of Sum of Product logic equations. Second, the three-level fusing allows complete flexibility in the use of this device family. All logic interconnections from input to output are programmable.

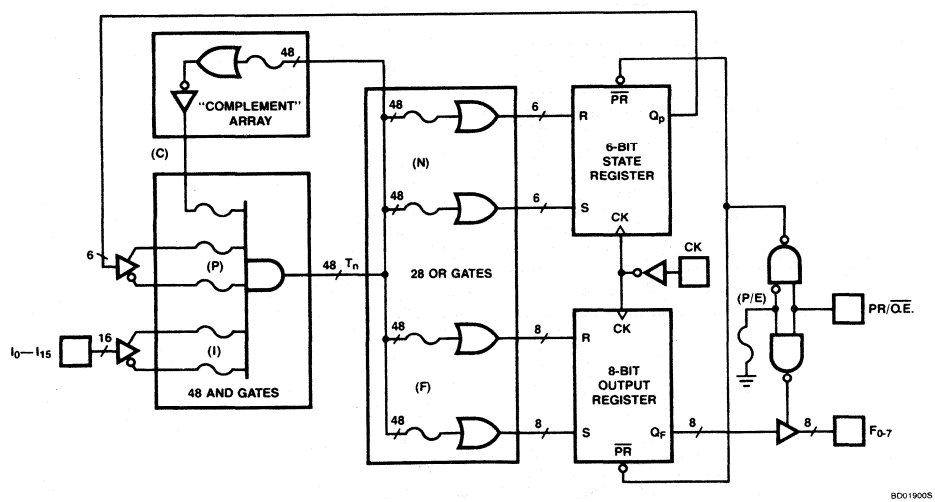
Development of this family did not stop with the PLS100. In 1977, the PLS103 Field Programmable Gate Array (FPGA) and the PLS107 Field Programmable ROM Patch (FPRP) were introduced.

The PLS105 Field Programmable Logic Sequencer (FPLS) was announced in 1979. This device represents a significant step forward for PLD. The FPLS is a fully-implemented Mealy State Machine on a chip. Incorporated into its architecture are 48 P-terms, an 8-bit Output Register, and a 6-bit internal State Register. Reference Figure 1.

The FPLS can synchronously perform sequential routines at 20MHz. All of these products are now known as the Signetics PLD Series 28 Programmable Logic Family.

Signetics' next innovation in this area was the Series 20 Programmable Logic Family. All members of this family are assembled in 20-pin packages. While reducing the number of pins in this family, Signetics has utilized controlled I/O in order to maintain the utility of the Series 20. Appropriate control terms have been included to allow active control of pin direction. Reference Figure 2.

The latest addition to the Signetics Programmable Logic families is the Series 24 devices. The PLS161 FPLA and the PLS167 FPLS are 24-pin devices comparable to the 28-pin PLS100 and PLS105 respectively. These devices have been followed by the PLS162/ PLS163 Field Programmable Address Decoder and the PLS168 FPLS.



NOTE:
I, P, C, N, F and P/E are user-programmable connections.

Figure 1. FPLS

Table 1. PLD Product Family

PART NUMBER	TYPE	CONFIGURATION
20-PIN, SERIES 20		
PLS151	FFGA	18-Input/12-Output
PLS153	FPLA	18-Input/10-Output – 42-Term
PLS155/159	FPLS	16-Input/12-Output – 45-Term
PLS155	FPLS	4 Registered Outputs
PLS157	FPLS	6 Registered Outputs
PLS159	FPLS	8 Registered Outputs
24-PIN, SERIES 24		
PLS161	FPLA	12-Input/8-Output – 48-Term
PLS162	FPGA	16-Input/5-Output
PLS163	FPGA	12-Input/9-Output
PLS167	FPLS	14-Input/6-Output – 48-Term 8-Bit State Registers 6-Output Registers
PLS168	FPLS	12-Input/8-Output – 48-Term 10-Bit State Registers 8-Output Registers
PLS173	FPLA	22-Input/10-Output – 42-Term
PLS179	FPLS	16-Input/12-Output – 42-Term
24-PIN, SERIES 24		
PLS100/101	FPLA	16-Inputs/8-Output – 48-Term
PLS103	FPGA	16-Inputs/9-Output
PLS105	FPLS	16-Inputs/8-Output – 48-Term 6-Bit State Register 8-Output Registers

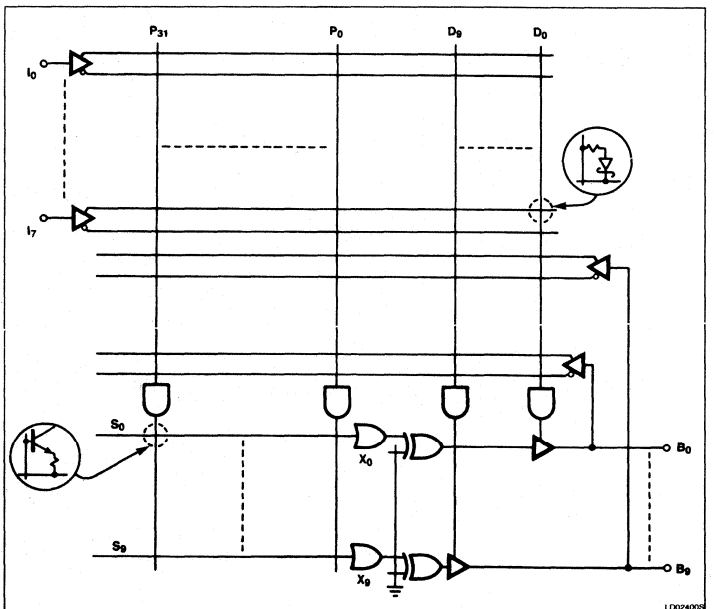
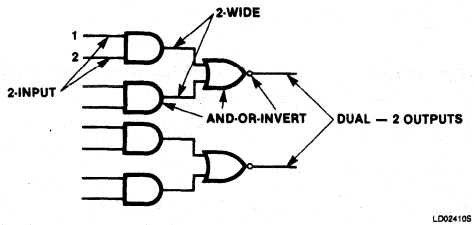
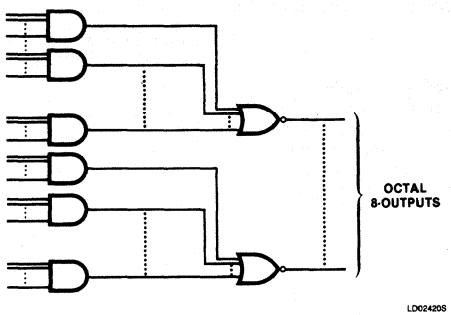


Figure 2. PLS153 20-Pin Functional Diagram



7450 2 x 2 x 2 Fixed Interconnections Dual, 2-Wide, 2-Input, AND/OR/INVERT



PLS100 16 x 48 x 8 Octal, 48-Wide, 16-Input, AND/OR/INVERT

Table 2. Gate Replacement (All Terms Used)

	Gates	I.C.s
Each P-Term = 2 8-Input AND Gates & 1 2-Input AND Gate =	144	108
OR Matrix = 16 4-Input OR Gates =	128	32
	272	140

Table 3. Typical Application

4 Variables/P-Term	40 Gates
4 P-Terms/Output	15-20 I.C.s

PRODUCT DESCRIPTION

While all PLD devices are architecturally similar, the Field Programmable Logic Array is most representative of the concepts involved. The FPLA is an AND/OR/INVERT device, with all internal interconnections programmable via fuse links. If we compare the PLS100 FPLS to the familiar 7450 AOI gate, the similarity of function becomes apparent.

Package-Gate Replacement Potential

All Signetics PLD devices are capable of replacing multiple discrete logic devices. The number of packages is dependent on the application and the device used.

If all product terms and inputs on the PLS100 are utilized, a total of 272 gates and 140 I.C.s can theoretically be replaced. See Table 2. Since the PLS100 is made up of logic structures which are not available as commercial logic devices, such as 32 input AND gates and 48 input OR gates, these numbers are based on breakdowns of these high complexity logic structures into structures which are available as discrete logic.

The typical application does not fully utilize the FPLA, however. We can assume that the typical application is as defined in Table 3.

The replacement of 15-20 I.C.s with one PLS100 is not unusual.

PLD ECONOMICS

The reason any product line exists is because it solves a problem in a cost-effective manner.

PLD is no different in this respect. Let's assume that one PLS100 is replacing only 10 TTL logic packages.

If we assume that the average selling price of an SSI level device is $0.25, then we have a basis for comparison.

10 I.C.s @ 0.35 = $3.50
1 PLS100 FPLA = $7.00

Considering piece-part cost alone does not fare well for the PLS100 FPLA. **But**, part cost is one of the smaller costs in systems manufacturing. Let's next consider PC board costs.

PC BOARD

The purchase price of a PCB is calculated on a per square inch basis. Typical costs at the 5K level are $0.23/in^2, the cost for LS is 1.2in^2 = $0.23/in^2 = $0.28. For a 28-pin FPLA device, the packing density is 1-PLS100 per 2.5in^2, giving a cost of 2.5in^2 x $0.23/in^2 = $0.58.

PCB FABRICATION

Now let's consider the cost of building the board. The primary cost for PCB fabrication is parts preparation and stuffing.

Estimates by PCB manufacturers indicate a nominal cost of $0.14 per device for LS TTL and $0.16 for 28-pin FPLA. There is also a basic cost of $0.02 per in^2 for handling, soldering, and inspecting.

The cost of incoming inspection and inventory/usage must also be considered in any fair comparison.

INCOMING INSPECTION

The cost of incoming inspection can be calculated on a per-pin basis. Assuming an equal mix of 14- and 16-pin SSI parts and a testing cost of $0.01 per pin, the LS TTL cost is $0.15 per I.C. The corresponding cost for the PLS100 would be $0.01 x 28 or $0.28 total.

COMPONENT INVENTORY/ USAGE

The inventory cost for LS TTL parts is dominated by inventory maintenance, while the LSI type parts, the piece price dominates. Assuming a 2% usage rate due to parts breakage, burnout, etc., in the manufacturing process, the parts cost for LS TTL is 2% x $0.25 = $0.005. Adding $0.02 per device for inventory maintenance, the total LS cost $0.03. For FPLA, 2% = $7.00± $0.02 = $0.16.

Consideration must also be given to testing the completed PCB and Rework costs.

PCB TESTING

Testing costs are generally figured on a PCB basis and are usually go-no-go tests using a "bed of nails". For this comparison, assume a PCB of 5" x 7". The cost for testing the completed PCB is estimated to be $3.60 for 20 I.C.s. This breaks down as $0.18 per LS TTL device or about $0.45 per FPLA device.

PCB REWORK

The main causes of rework are poorly plated holes, solder bridges, and parts inserted incorrectly. The "bed of nails" test can usually detect all of the faults. Rework costs about 50% of test costs. The result is $1.80 per PCB, or $0.09 per device for LS TTL and $0.18 for the 28-pin FPLA.

System manufacturing costs are harder to define. For this comparison we estimated $0.28 for each LS device and about $0.65 for the FPLA. These costs include backplane wiring, final system assembly and test costs.

Now using these figures, the comparison in Table 4 can be made.

Table 4. Cost Analysis

	LS TTL	FPLA
IC COMPONENTS	.35	7.00
PCB MANUFACTURING		
Incoming Inspection	.15	.28
Component Inventory/Usage	.03	.16
PC Board	.28	.58
Fabrication	.14	.16
Test	.18	.45
Rework	.09	.18
ASSEMBLY LABOR	.28	.65
COST PER COMPONENT	1.50	9.46
NUMBER OF COMPONENTS	x 10	x 1
TOTAL	15.00	9.46

CONCLUSION:
THE FPLA is a 37% savings over the LS TTL DESIGN.

PLD LOGIC SYNTHESIS

28-PIN

PLD is capable of Logic Synthesis. No intermediate step is required to implement Boolean Logic Equations with PLD. Each term in each equation simply becomes a direct entry into the Logic Program Table. The following example illustrates this straightforward concept:

$X_0 = AB + \overline{C}D + B\overline{D}$

$\overline{X}_1 = \overline{A}B + \overline{C}D + EFG$

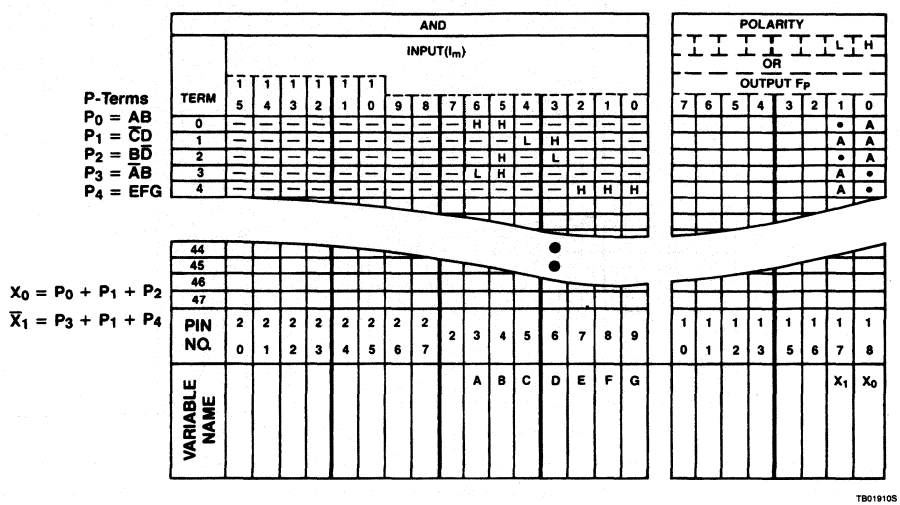


Figure 3. Field Programmable Logic Array (16 x 48 x 8) PLS100/PLS101

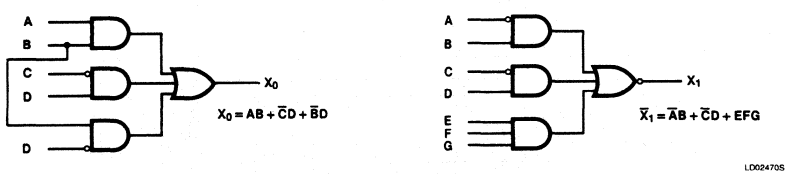


Figure 4. Equivalent Fixed Logic Diagram

In the previous example, the two Boolean Logic equations were broken into Product terms. Each P-term was then programmed into the P-term section of the PLS100 FPLA Program Table. This was accomplished in the following manner:

Step 1

Select which input pins $I_0 - I_{15}$ will correspond to the input variables. In this case A – G are the input variable names. I_6 through I_0 were selected to accept inputs A – G respectively.

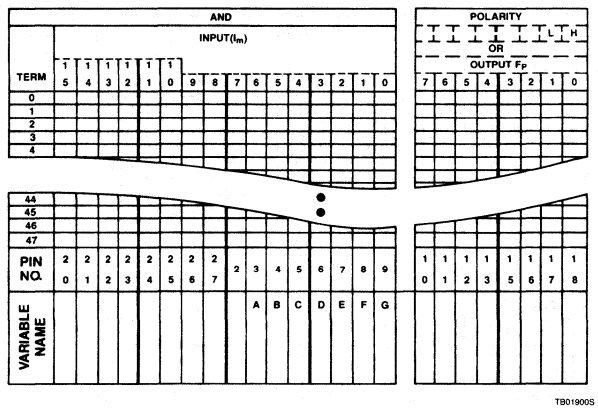


Figure 5

Step 2

Transfer the Boolean Terms to the FPLA Program Table. This is done simply by defining each term and entering it on the Program Table.

e.g., $P_0 = AB$

This P-term translates to the Program Table by selecting $A = I_6 = H$ and $B = I_5 = H$ and entering the information in the appropriate column.

$P_1 = \overline{C}D$

This term is defined by selecting $C = I_4 = L$ and $D = I_3 = H$, and entering the data into the Program Table. Continue this operation until all P-terms are entered into the Program Table.

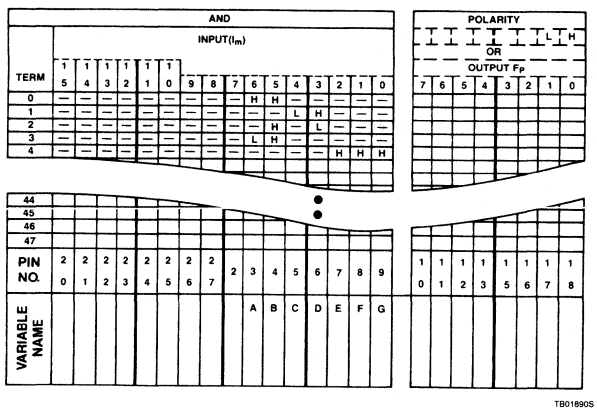


Figure 6

Step 3

Select which output pins correspond to each output function. In this case F_0 = Pin 18 = X_0, and F_1 = Pin 17 = X_1.

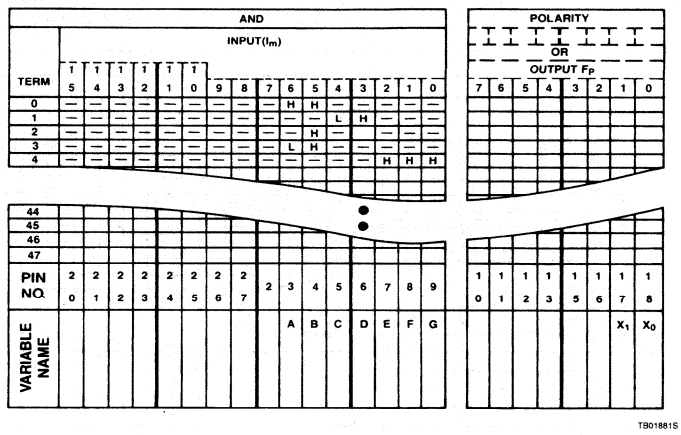


Figure 7

Step 4

Select the Output Active Level desired for each Output Function. For X_0 the active level is high for a positive logic expression of this equation. Therefore, it is only necessary to place an (H) in the Active Level box above Output Function 0, (F_0). Conversely, X_1 can be expressed as $\overline{X}_1$ by placing an (L) in the Active Level box above Output Function 1, (F_1).

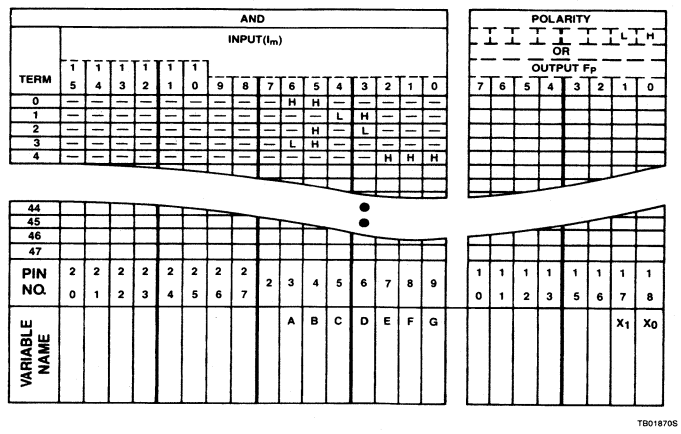


Figure 8

Step 5

Select the P-Terms you wish to make active for each Output Function. In this case $X_0 = P_0 + P_1 + P_2$, so an A has been placed in the intersection box for P_0 and X_0, P_1 and X_0 and P_2 and X_0.

Terms which are not active for a given output are made inactive by placing a (•) in the box under that P-term. Leave all unused P-terms unprogrammed.

Continue this operation until all outputs have been defined in the Program Table.

Step 6

Enter the data into a Signetics approved programmer. The input format is identical to the Signetics Program Table. You specify the P-terms, Output Active Level, and which P-terms are active for each output exactly the way it appears on the Program Table.

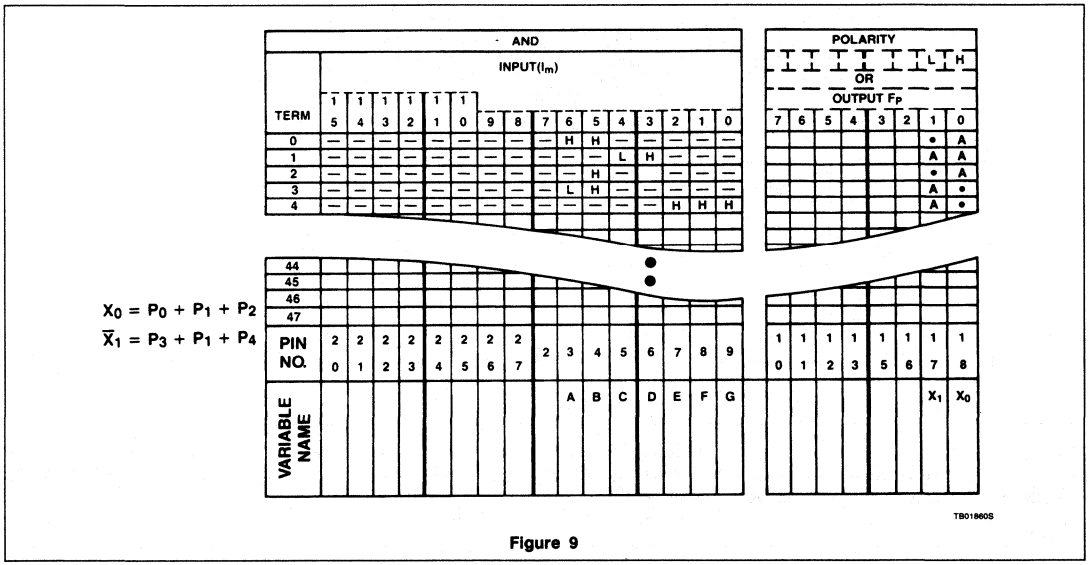


Figure 9

PLD LOGIC SYNTHESIS

20-PIN

When fewer inputs and outputs are required in a logic design and low cost is most important, the Signetics 20-pin PLD should be considered first choice. The PLS153 is an FPLA with 8 inputs, 10 I/O pins, and 42 product terms. The user can configure the device by defining the direction of the I/O pins. This is easily accomplished by using the direction control terms $D_0 - D_9$ to establish the direction of pins $B_0 - B_9$. The D-terms control the Tri-state buffers found on the outputs of the EX-OR gates. Figures 10 and 11 show how the D-term configures each B_x pin.

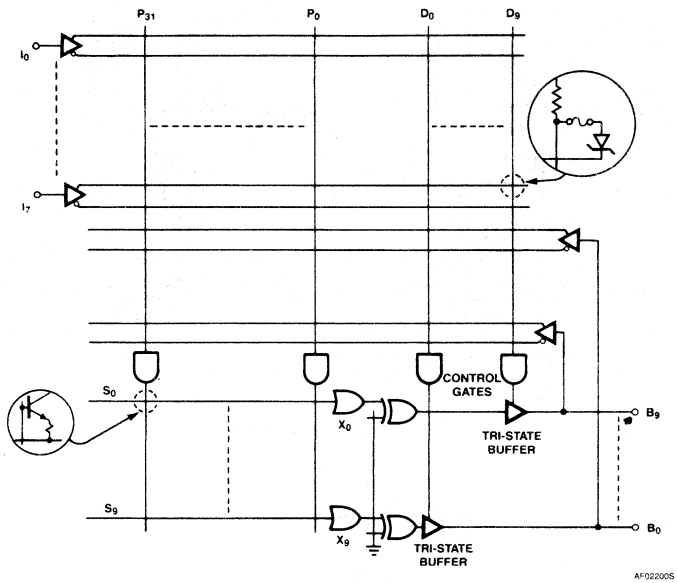
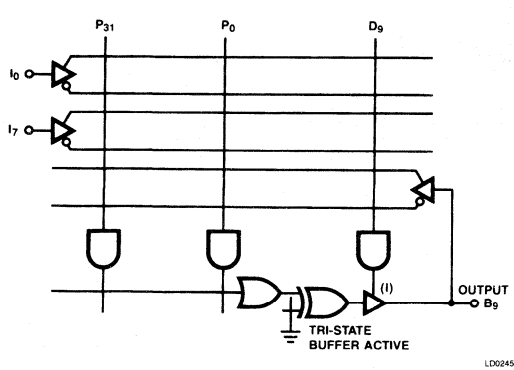
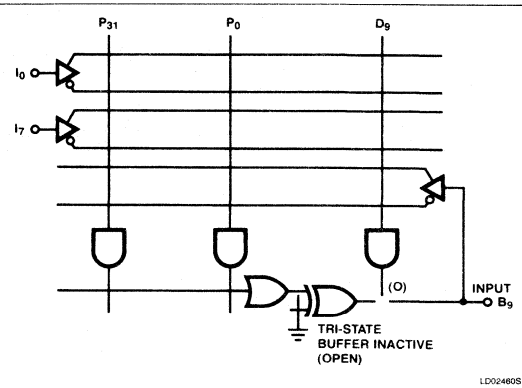


Figure 10. PLS153 Functional Diagram



a. D_9 Active Makes B_9 Appear As An Output With Feedback



b. D_9 Inactive Makes B_9 Appear As An Input

Figure 11

To control each D-term, it is necessary to understand that each control gate is a 36-input AND gate. To make the Tri-state buffer active (B_X pin an output), the output of the control gate must be at logic HIGH (1). This can be accomplished in one of two ways. A HIGH can be forced on all control gate input nodes, or fuses can be programmed. When a fuse is programmed, that control gate input node is internally pulled up to HIGH (1). See Figure 12 and Figure 13.

Programming the fuse permanently places a HIGH (1) on the input to the control gate. The input pin no longer has any effect on that state.

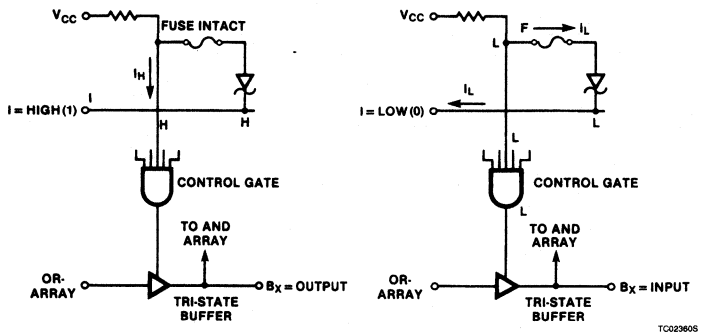


Figure 12. Input Effect On Control Gates (Fuse Intact)

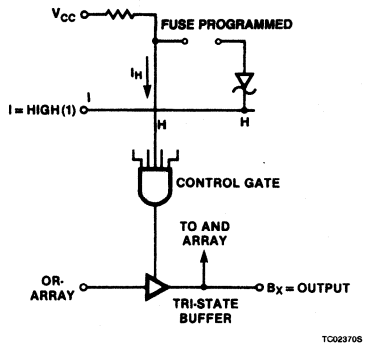


Figure 13. Effect On Control Gate If Fuse Is Programmed

DEDICATING B_X PIN DIRECTION

Since each input to the D-terms is true and complement buffered (see Figure 11), when the device is shipped with all fuses intact, all control gates have half of the 36 input lines at logic low (0). The result of this is all Control Gate outputs are low (0) and the Tri-state buffers are inactive. This results in all B_X pins being in the input condition. The resultant device is, therefore, an 18-input, 0-output FPLA. While useful as a bit bucket or Write-Only-Memory (WOM), most applications require at least one output. Clearly, the first task is to determine which of the B_X pins are to be outputs. The next step is to condition the control gate to make the Tri-state buffer for those gates active. To dedicate B_0 and B_1 as outputs, it is necessary to program all fuses to the inputs to Control Gates D_0 and D_1. This internally pulls all inputs to those gates to HIGH (1) permanently. Since all inputs to the Control Gates are HIGH (1), the output is HIGH (1) and the Tri-state buffers for B_0 and B_1 are active. This permanently enables B_0 and B_1 as outputs. Note that even though B_0 and B_1 are outputs, the output data is available to the AND array via the internal feedback (see Figure 11a).

To program this data, the PLS153 Program Table is used as shown in Figure 14.

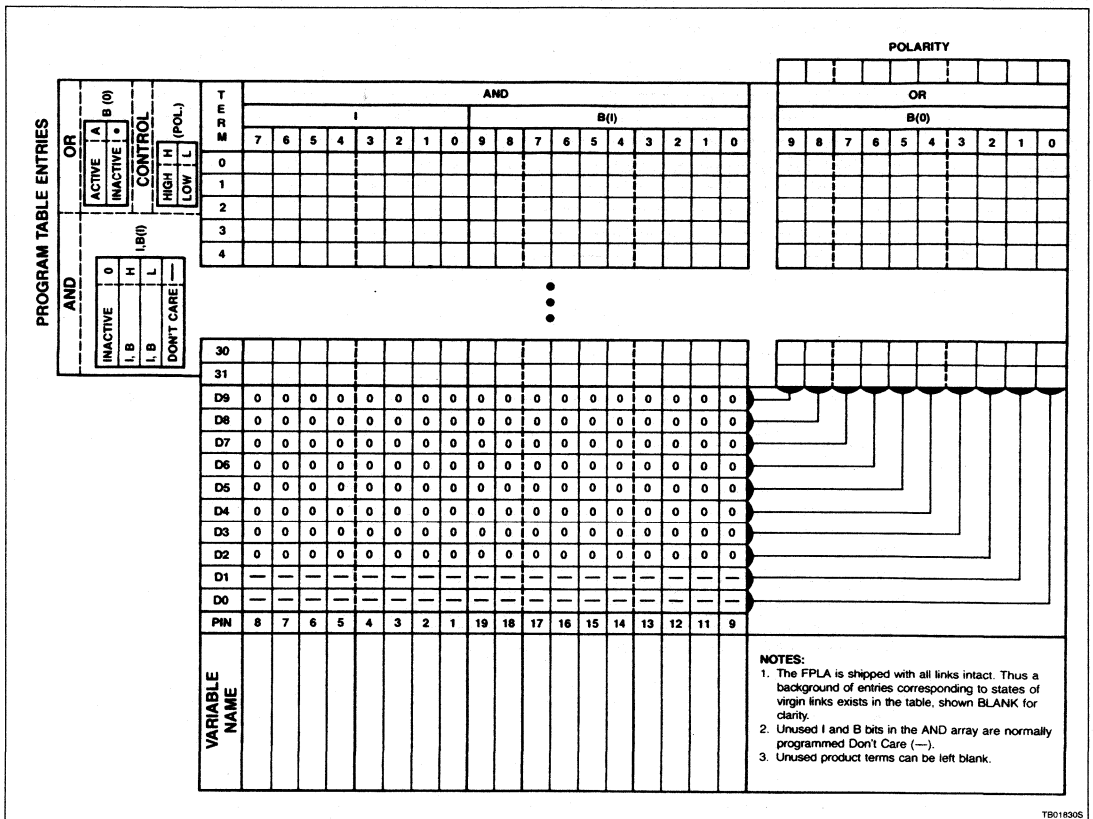


Figure 14. Dedicating B_0 And B_1 As Outputs And B_2 Through B_9 As Inputs

By placing a (—) Don't Care in each input box you are specifying that the True and Complement fuses are programmed on each Control Gate, thus permanently dedicating the B_0 and B_1 pins as outputs. By placing a (0) in all input boxes for $B_2 - B_9$, you are specifying that both True and Complement fuses are intact. This causes a low (0) to be forced on half of the Control Gate inputs, guaranteeing the output of the Control Gate will be low (0). When the Control Gate outputs are low (0), the Tri-state buffer is inactive and the $B_2 - B_9$ pins are enabled as inputs. All B_x pin directions can be controlled in this manner.

ACTIVE DIRECTION CONTROL

Sometimes it is necessary to be able to actively change the direction of the B_x pins without permanently dedicating them. Some applications which require this include Tri-state bus enable, multi-function decoding, etc. This can easily be done by programming the Control Gate to respond to one or more input pins. It is only necessary to select which I_x and B_x pins will control the pin directions and the active level HIGH (H) or LOW (L) that will be used. The PLS153 Program Table in Figure 15 shows the method of controlling $B_0 - B_9$ with I_7. When I_7 is LOW (L), pins $B_0 - B_9$ are outputs when I_7 is HIGH (H), pins $B_0 - B_9$ are inputs. Note that by programming all other I_x and B_x pins as DON'T CARE (—), they are permanently disconnected from control of B_x pin direction.

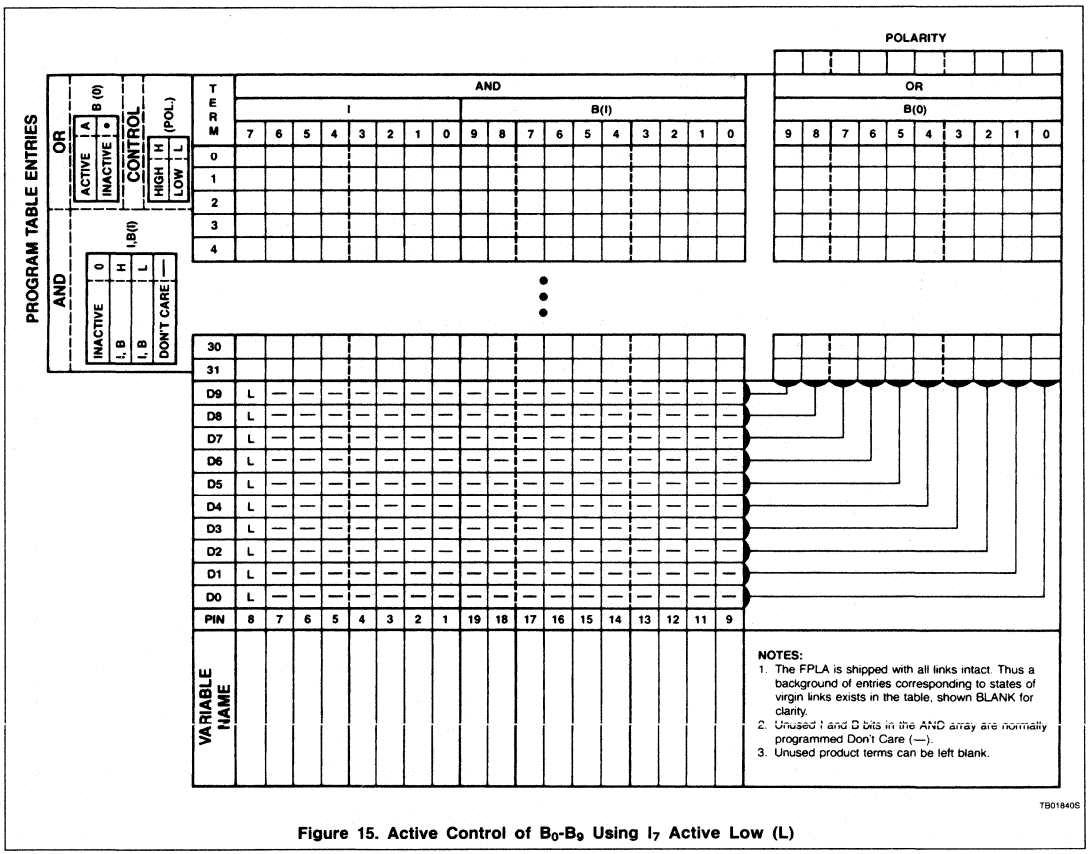


Figure 15. Active Control of B_0-B_9 Using I_7 Active Low (L)

The previous 28-pin logic synthesis example (Page 2-5) could be done on the PLS153 as follows:

$X_0 = AB + \overline{C}D + B\overline{D}$

$\overline{X}_1 = \overline{A}B + \overline{C}D + EFG$

Note that B_0 was used as a CHANGE input. When B_0 is HIGH (H) the outputs appear on B_8 and B_9. When B_0 is LOW (L), the outputs appear on B_6 and B_7. B_1 through B_5 are not used and therefore left unprogrammed.

THE ROLE OF AMAZE (AUTOMATIC MAP AND ZAP ENTRY) IN LOGIC DEVELOPMENT

AMAZE is a software development package which provides the logic designer with a multi-mode data input capability. This software package, which has been developed for both mainframe and microcomputer environments, allows data entry in the program table format previously described, or on one of two equation formats. Both Boolean Logic Equations and State Variable Equations are supported on AMAZE. In addition to the flexible input formats offered, AMAZE also provides full device documentation, and a functional simulator. The simulator features manual and automatic modes. In the automatic mode, the software generates a set of input vectors which can be used as functional test vectors. The manual mode is an interactive procedure which allows the designer to input vectors to the simulator. The AMAZE simulator then responds with the appropriate output vector. In both modes, the simulator uses the functional model generated by the user's input data.

For more information on AMAZE refer to Section 8 of the 1986 Signetics Programmable Logic Data Manual.

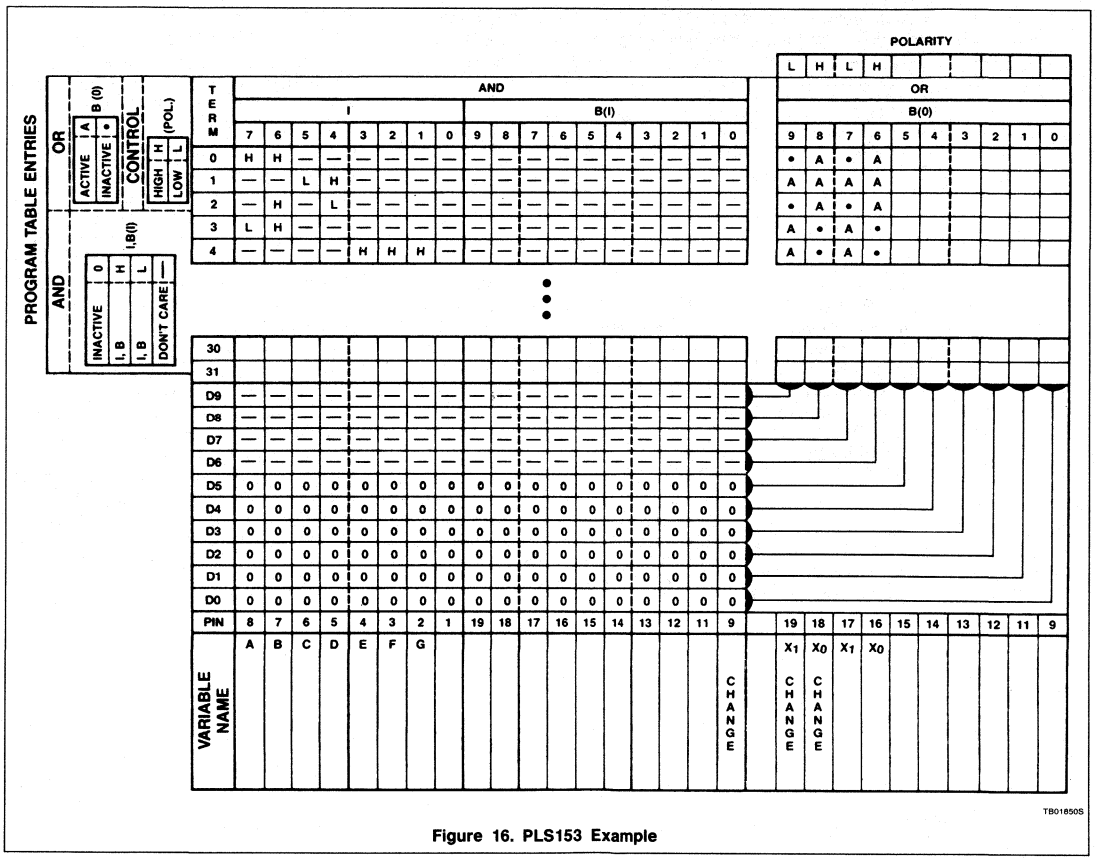


Figure 16. PLS153 Example

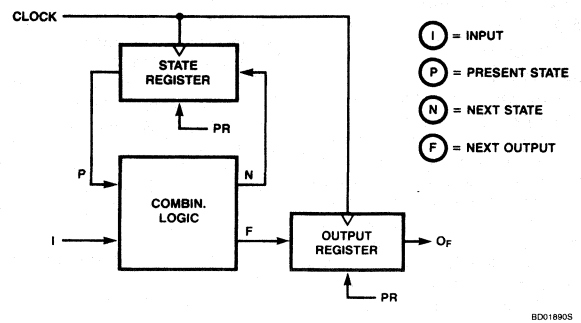


Figure 17. Basic Architecture Of PLS105 FPLS. I, P, N, And F Are Multi-line Paths Denoting Groups Of Binary Variables Programmed By The User.

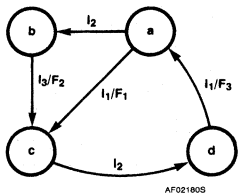


Figure 18. Typical State Diagram. I_{1-3} Are Jump Conditions Which Must Be Satisfied Before Any Transitions Take Place. F_r Are Changes In Output Triggered By I_m, And Stored In The Output Register. State Transitions a → b and c → d Involve No Output Change.

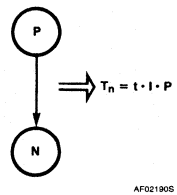


Figure 19. Typical State Transition Between Any Two States Of Figure 18. The Arrow Connecting The Two States Gives Rise To A Transition Term T_n. I Is The Jump Condition.

SEQUENTIAL LOGIC CONSIDERATIONS

The PLS105 and PLS155 – PLS159 represent significant increases in complexity when compared to the combinatorial logic devices previously discussed. By combining the AND/OR combinatorial logic with clocked output flip-flops and appropriate feedback, Signetics has created the first family of totally flexible sequential logic machines.

The PLS105 FPLS (Field Programmable Logic Sequencer) is an example of a high-order machine whose applications are manifold. Application areas for this device include high-speed data controllers, microprocessor and minicomputer bus arbitration, industrial controls, timing generation, multi-function counters and shift registers, and microprocessor-driven microcontrollers. The PLS105 is fully capable of performing fast sequential operations in relatively low-speed processor systems. By placing repetitive sequential operations on the PLS105, processor overhead is reduced. Each PLS105 can be viewed as a high-speed, 48-state subroutine.

The following pages summarize the PLS105 architecture and features.

FPLS Architecture

The PLS105 Logic Sequencer is a programmable state machine of the Mealy type, in which the output is a function of the present state and the present input.

With the FPLS a user can program any logic sequence expressed as a series of jumps between stable states, triggered by a valid input condition (I) at clock time (t). All stable states are arbitrarily assigned and stored in the State Register. The logic output of the machine is also programmable, and is stored in the Output Register.

Clocked Sequence

A synchronous logic sequence can be represented as a group of circles interconnected with arrows. The circles represent stable states, labeled with an arbitrary numerical code (binary, hex, etc.) corresponding to discrete states of a suitable register. The arrows represent state transitions, labeled with symbols denoting the jump condition and the required **change** in output. The number of states in the sequence depends on the length and complexity of the desired algorithm.

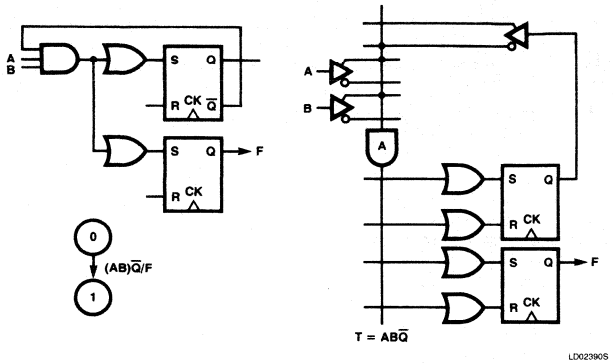


Figure 20. Typical State Jump From State (0) To State (1), If Inputs A = B = "1". The Jump Also Forces F = "1", As Required.

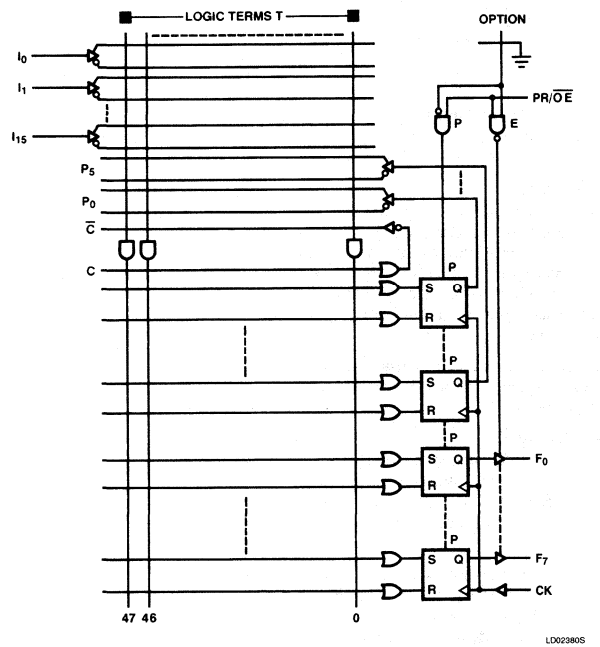


Figure 21. Simplified Logic Diagram Of PLS105 FPLS

State Jumps

The state from which a jump originates is referred to as the Present state (P), and the state to which a jump terminates is defined as the Next state (N). A state jump always causes a change in state, but may or may not cause a change in machine output (F).

State jumps can occur only via "transition terms" T_n. These are logical AND functions of the clock (t), the Present state (P), and a valid input (I). Since the clock is actually applied to the State Register, $T_n = I \bullet P$. When T_n is "true", a control signal is generated and used at clock time (t) to force the contents of the State Register from (P) to (N), and to change the contents of the Output Register (if necessary). The simple state jump in Figure 20, involving 2 inputs, 1 state bit, and 1 output bit, illustrates the equivalence of discrete and programmable logic implementations.

FPLS Logic Structure

The FPLS consists of programmable AND and OR gate arrays which control the Set and Reset inputs of a State Register, as well as monitor its output via an internal feedback path. The arrays also control an independent Output Register, added to store output commands generated during state transitions, and to hold the output constant during state sequences involving no output changes. If desired, any number of bits of the Output Register can be used to extend the width of the State Register, via external feedback.

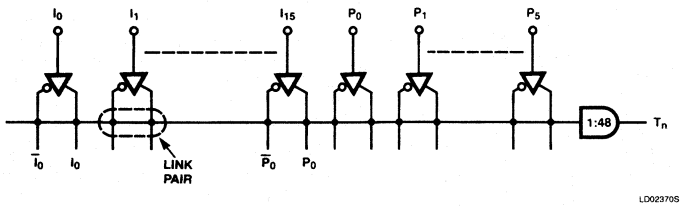


Figure 22. Typical AND Gate Coupled To (I) And (P) Inputs. If At Least One Link Pair Remains Intact, T_n Is Unconditionally Forced Low.

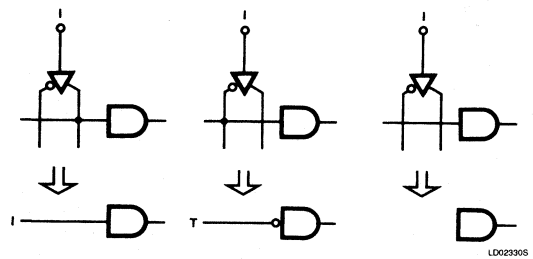


Figure 23. Choice Of Input Polarity Coupling To A Typical AND Gate. With Both Links Open, (I) Is Logically Don't Care.

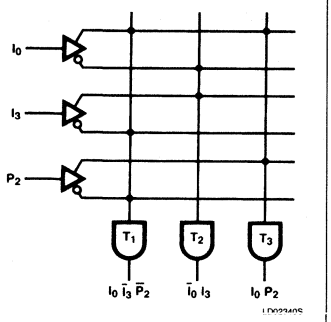


Figure 24. Typical Transition Terms Involving Arbitrary Inputs And State Variables. All Remaining Gate Inputs Are Programmed Don't Care. Note That T_2 Output Is State Independent.

Input Buffers

16 external inputs (I_m) and 6 internal inputs (P_s), fed back from the State Register, are combined in the AND array through two sets of True/Complement (T/C) buffers. There are a total of 22 T/C buffers, all connected to multi-input AND gates via fusible links which are initially intact.

Selective fusing of these links allows coupling either True, Complement, or Don't Care values of (I_m) and (P_s).

"AND" Array

State jumps and output changes are triggered at clock time by valid transition terms T_n. These are logical AND functions of the present state (P) and the present input (I).

The FPLS AND Array contains a total of 48 AND gates. Each gate has 45 inputs — 44 connected to 22 T/C input buffers, and 1 dedicated to the Complement Array. The outputs of all AND gates are propagated through the OR Array, and used at clock time (t) to force the contents of the State Register from (P) to (N). They are also used to control the Output Register, so that the FPLS 8-bit output F_r is a function of the inputs and present state.

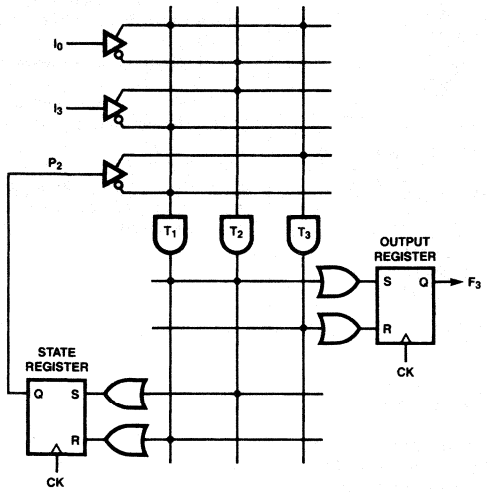


Figure 25. Typical OR Array Gating Of Transition Terms $T_{1,2,3}$ Controlling Arbitrary State And Output Register Stages.

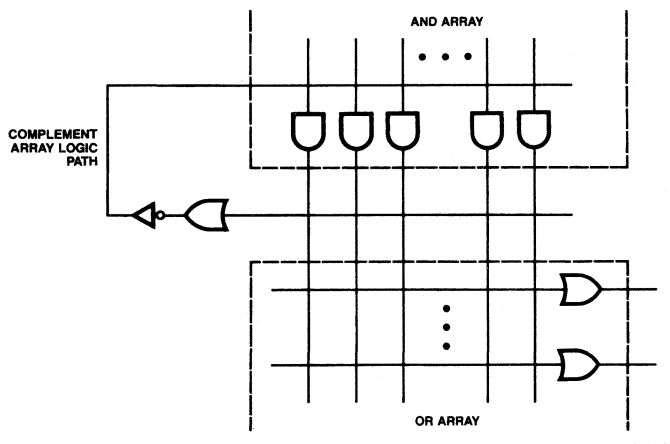


Figure 26. The COMPLEMENT Array Is Logically Constructed From A 48-Input Programmable OR Gate Followed By An Inverter. All AND Terms Coupled To The OR Gate Are Complemented At The Inverter Output, And Can Be Fed Back As Inputs To The AND Array.

"OR" Array

In general, a clocked sequence will consist of several stable states and transitions, as determined by the complexity of the desired algorithm. All state and output changes in the state diagram imply changes in the contents of State and Output Registers.

Thus, each flip-flop in both registers may need to be conditionally set or reset several times with T_n commands. This is accomplished by selectively ORing through a programmable OR Array all AND gate outputs T_n necessary to activate the proper flip-flop control inputs.

The FPLS OR Array consists of 14 pairs of OR gates, controlling the S/R inputs of 14 State and Output Register stages, and a single OR gate for the Complement Array. All gates have 48 inputs for connecting to all 48 AND gates.

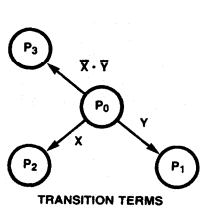
Complement Array

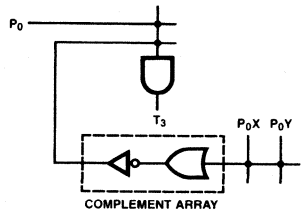
The COMPLEMENT Array provides an asynchronous feedback path from the OR Array back to the AND Array.

This structure enables the FPLS to perform both direct and complement sequential state jumps with a minimum of transition (AND) terms.

Typically direct jumps, such as T_1 and T_2 in Figure 27 require only a single AND gate each.

But a complement jump such as T_3 generally requires many AND gates if implemented as a direct jump. However, by using the Complement Array, the logic requirements for this type of jump can be handled with just one more gate from the AND Array.





DIRECT

$T_1 = P_0X$

$T_2 = P_0Y$

COMPLEMENT

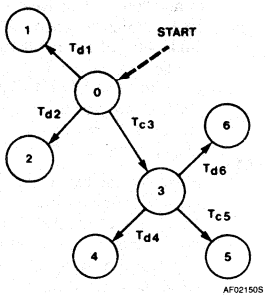
$T_3 = P_0(\overline{X} \cdot \overline{Y}) = P_0(\overline{T_1 + T_2})$

$T_3 = P_0(\overline{P_0X + P_0Y})$
$T_3 = P_0[\overline{P_0(X + Y)}]$
$T_3 = P_0[\overline{P_0} + \overline{(X + Y)}]$
$T_3 = 0 + P_0(\overline{X + Y})$
$T_3 = P_0(\overline{X} \cdot \overline{Y})$

a. Typical State Sequence **b. Complement Jump**

Figure 27. a. X And Y Specify The Conditional Logic For Direct Jump Transition Terms T_1 And T_2. The Complement Jump Term T_3 Is True Only When Both T_1 and T_2 Are False. b. Note That The Complementary Logic Expression For T_3, $\overline{T_1 + T_2}$, Corresponds Exactly To The Logic Structure Of The Complement Array.

As indicated in Figure 28, the single Complement Array gate may be used for many states of the state diagram. This happens because all transition terms linked to the OR gate include the present state as a part of their conditional logic. In any particular state, only those transition terms which are a function of that state are enabled; all other terms coupled to different states are disabled and do not influence the output of the Complement Array. As a general rule of thumb, the Complement Array can be used as many times as there are states.



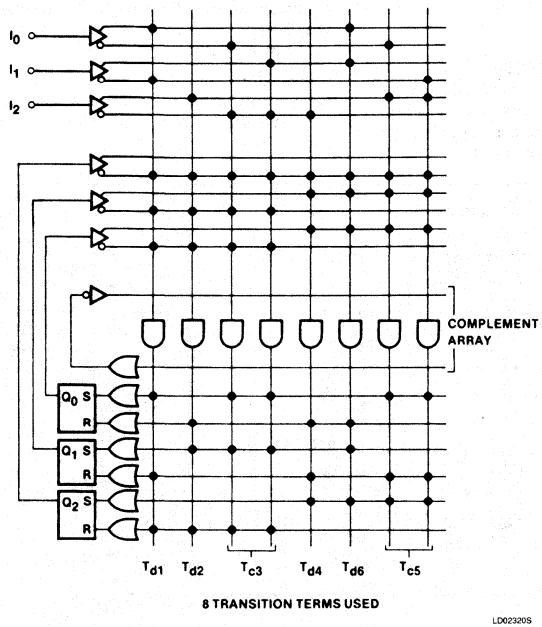
a. State Diagram

$T_{d1} = I_0\bar{I}_1P_0$
$T_{d2} = I_2P_0$
$T_{c3} = \overline{(T_{d1} + T_{d2})}P_0 = \overline{(I_0\bar{I}_1 + I_2)}P_0$

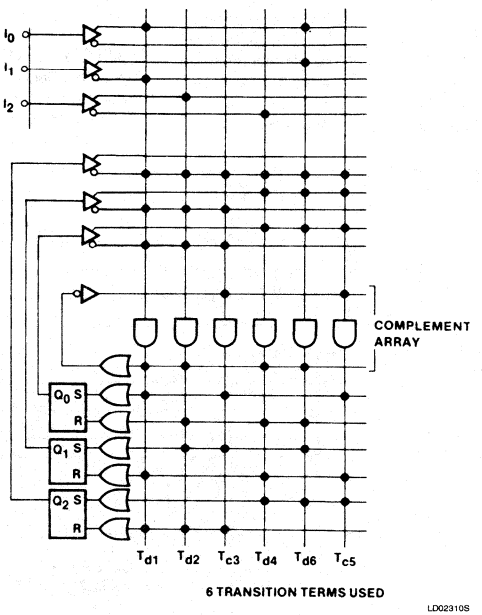
$T_{d4} = \bar{I}_2P_3$
$T_{d6} = I_0I_1P_3$
$T_{c5} = \overline{(T_{d4} + T_{d6})}P_3 = \overline{(I_0\bar{I}_1 + \bar{I}_2)}P_3$

T_{cn} = COMPLEMENT STATE TRANSITION TERM
T_{dn} = DIRECT STATE TRANSITION TERM
P_s = PRESENT STATE

b. Logic Definition



c. State Logic Without Using The Complement Array



d. State Logic Using The Complement Array

Figure 28. Logic Reduction With The Complement Array. The Logic State Diagram In (a) Includes Complement Jumps T_{C3} And T_{C5} Defined In (b). When Using The Complement Array, A Savings Of 2 Transition Terms Results, As Shown In (c) And (d).

Table 5. 20-Pin PLD Sequential Family Summary

DEVICE	REGISTERED OUTPUTS	OUTPUT TYPE
PLS155	4-Bit Register	T.S.
PLS157	6-Bit Register	T.S.
PLS159	8-Bit Register	T.S.

PLD-20 SEQUENTIAL DEVICES

The 20-pin PLD family also includes sequential devices. These devices are all similar in architecture. The major difference consists of the number of outputs which are registered. The following table summarizes the PLD-20 sequential family.

FEATURES

The PLD-20 sequencers have been designed with a maximum of flexibility in mind. Each element of the architecture contributes to the ease of use the PLD-20 family provides. Each part has the features listed:

- **J/K flip-flop Output Register**
- **Dynamic control of flip-flop type (J/K or D)**
- **Parallel bus load**
- **Asynchronous preset and reset capability**
- **Combinational I/O pins**
- **Programmable enable pins**
- **Output feedback to AND Array available**

OUTPUT REGISTER

The Output Register of the PLD-20 sequential devices are comprised of fully implemented J/K flip-flops. Each flip-flop is positive edge-triggered from a common clock.

In addition, a dynamically controllable "fold-back" buffer between the J and K inputs to the flip-flop allows the designer to change the function of the flip-flop from J/K to D-type under the control of the flip-flop control term (F). A fuse allows the designer to dedicate the flip-flop as a permanent D-type by programming the fuse.

By leaving the fuse intact, the flip-flop control line (F) is maintained as the active mode control. If the output of F is logic Low (0), then the flip-flop is configured as a D-type. If the output of F is a logic High (1), then the flip-flop is configured as a J/K type. Term F is programmed in the same manner as the 32 logic transition terms (T). It is well to note at this time that when the flip-flop is configured as a D-type, the OR-term driving the K input must not be active.

During all modes of operation, the output register data is fed back to the AND Array. This feedback is used to establish present-state to next-state jumps.

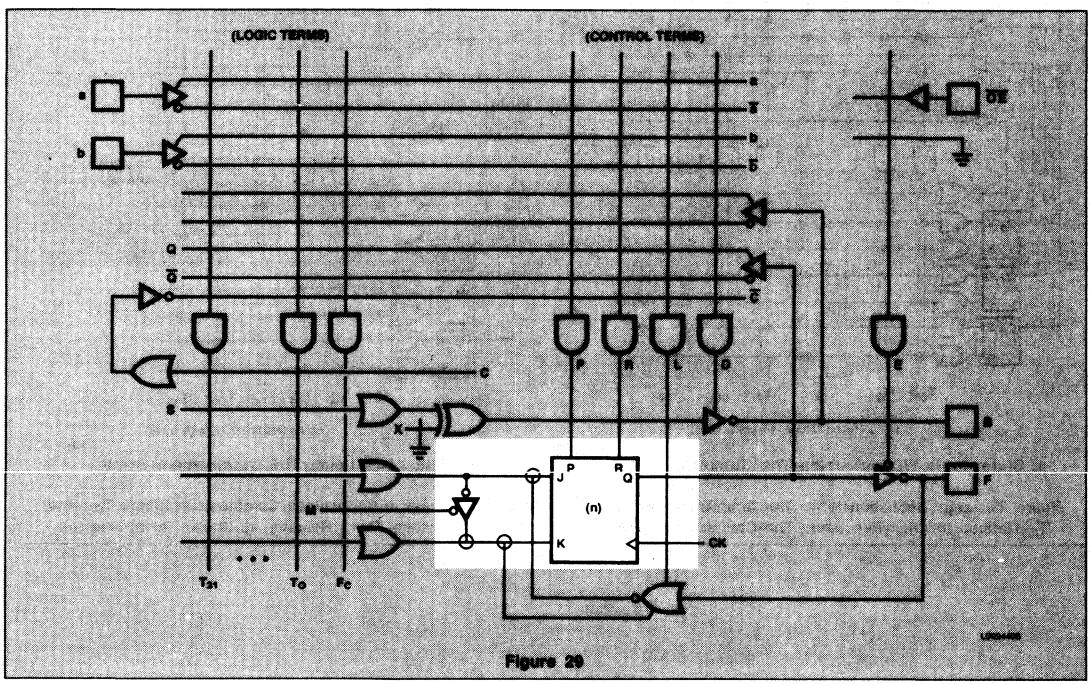


Figure 29

PARALLEL BUS LOADING

The Output Register may be loaded from the bus via the load control term (L). This feature forces the data contained on the F_0 pin into the J/K flip-flop. It operates synchronously with the rising edge of the clock. This feature can be used to preload a state into the machine, or to latch input data into the AND Array.

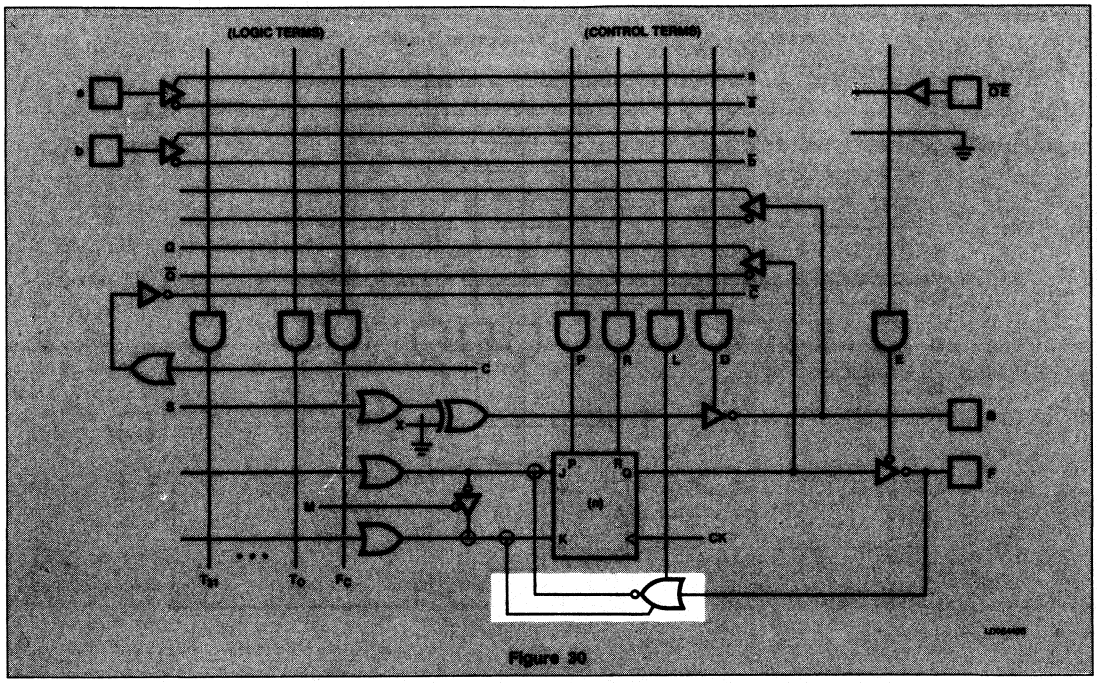


Figure 30

PRESET AND RESET

Asynchronous preset and reset capability has been provided on the PLD-20 sequential devices. This feature is controlled in the AND-Array on the PLS159. The remainder of the PLD-20 devices are controlled via the OR-Array. See the individual data sheet for details.

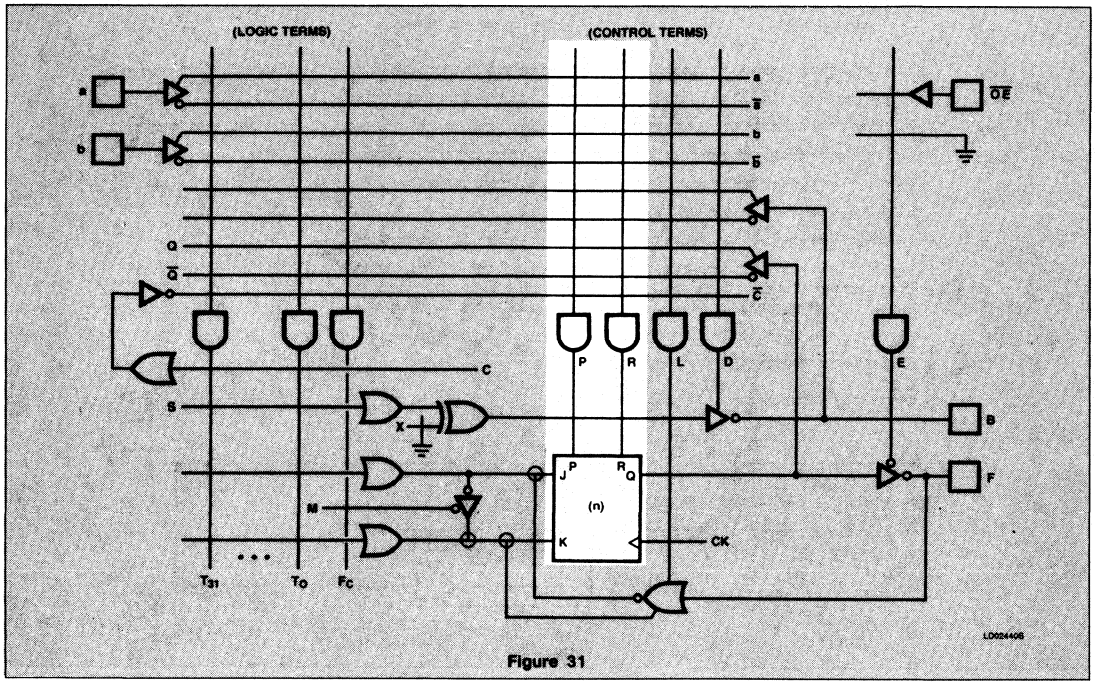


Figure 31

COMBINATIONAL I/O PINS

Each PLD-20 sequential device has a number of combinational pins (B_0) which can be programmed and used exactly as the B pins on the PLS153 FPLA. The direction control term (D) establishes the data flow on these pins. The individual data sheet should be consulted for the quantity and pin number assignment for each device.

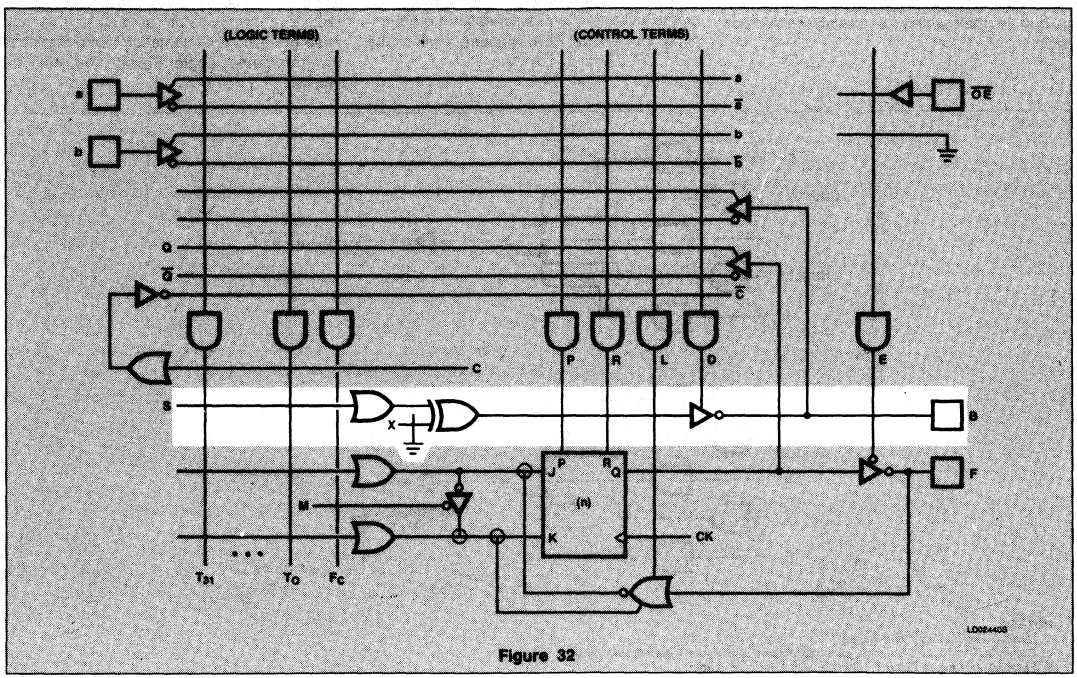


Figure 32

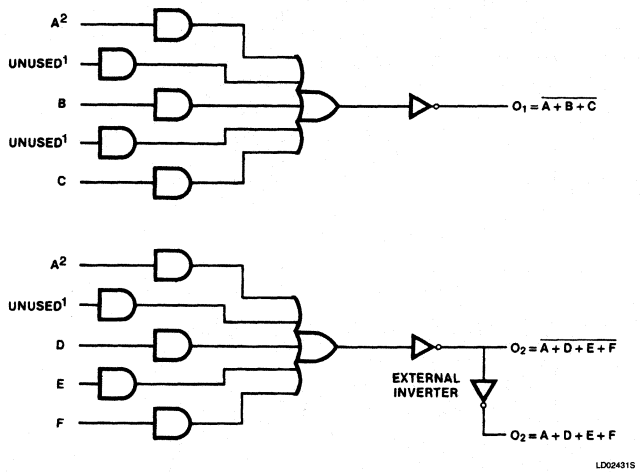
Signetics Programmable Logic — Introduction

PLA vs. PAL® ARRAYS

The PLA architecture provides the most efficient means of implementing logic. The 28-pin devices, PLS100/101 and PLS103 are unique in their ability to directly implement logic.

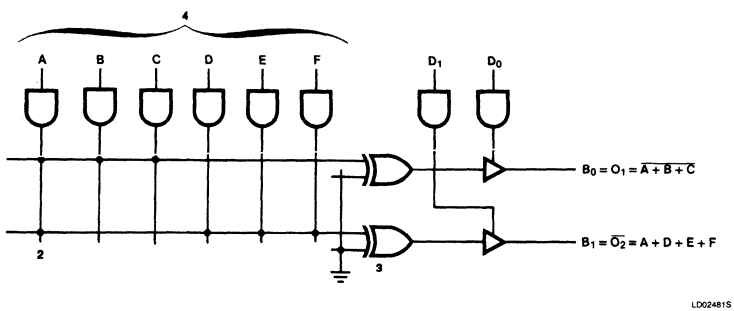
They offer the most useable P-terms, the highest number of inputs and outputs, and the most straightforward programming of any logic device in the industry. The following diagrams illustrate the relative ease of programming the flexible PLA structure against the fixed OR Array of the PAL.

The Signetics approach to programmable logic gives the designer the flexibility he needs where he needs it — in the device itself. The combination of totally flexible architecture, more useable product terms, and ease of logic implementation make Signetics Programmable Logic Family the obvious choice.



NOTES:
1. Unused P-terms lost to designer.
2. Common P-term to 2 or more outputs requires 2 or more P-terms; one on each output.
3. External inverter required to change active level of output.
4. 10 P-terms used.

Figure 33. Application Example PAL Approach



NOTES:
1. All P-terms usable.
2. Common P-terms available to all outputs.
3. Programmable outputs eliminate need for external component.
4. 6 P-terms used.

Figure 34. PLD Approach

*PAL is a registered trademark of Monolithic Memories, Inc.

FPLA PLS153/153A	COMPATIBLE WITH PAL® LOW/MEDIUM COMPLEXITY PRODUCT, i.e., 14H/L4 16H/L2 16LS 10H/LS 16C1, 12H/LS ADDITIONAL FEATURES: 1. PROGRAMMABLE OUTPUT POLARITY 2. PROGRAMMABLE OR ARRAY 3. 10 OUTPUTS vs. 8 FOR PAL 4. 32 PRODUCT TERMS vs. 16 FOR LOW AND MEDIUM PALs
FPLS PLS155/157/159	COMPATIBLE WITH PAL REGISTERED TYPES 16R3, 16R5, 16R4, etc. ADDITIONAL FEATURES: 1. PROGRAMMABLE AND/OR, ALSO CONTROLLABLE FLIP FLOPS; AS D, TOGGLE, OR JK

*PAL is a trademark of Monolithic Memories, Inc.

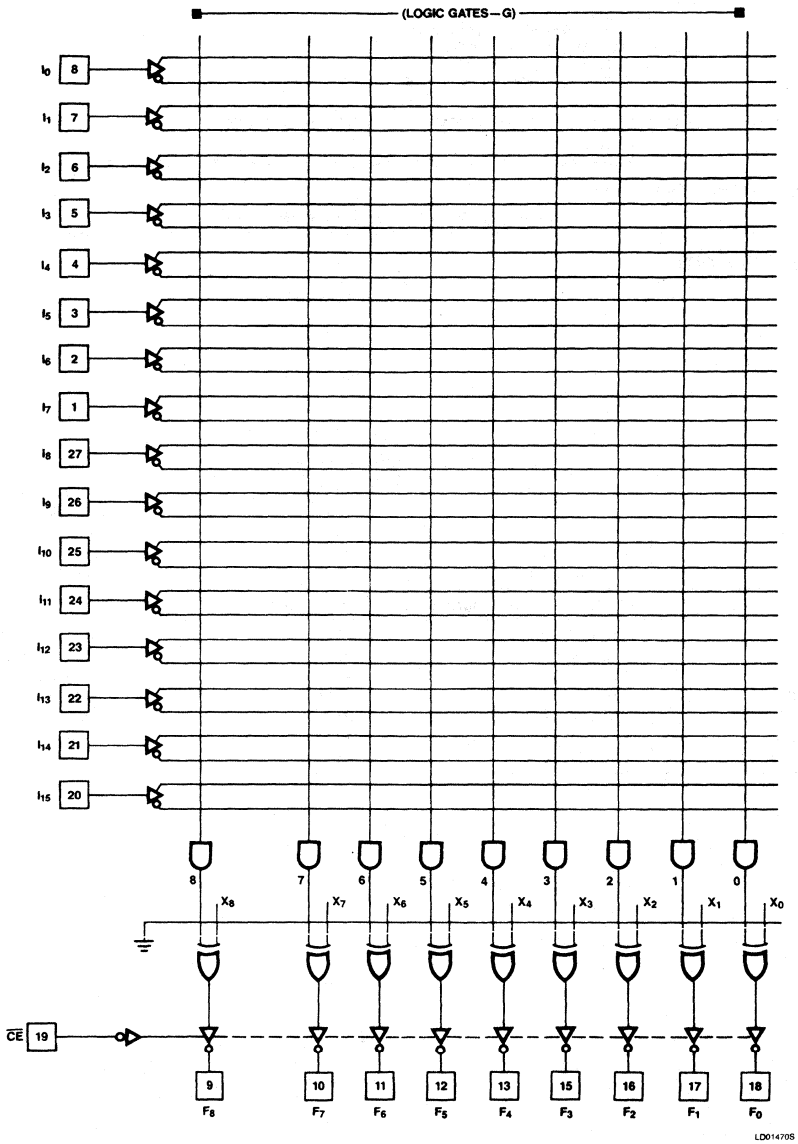
Figure 35. PLD-20 Product Comparison

PLD FAMILY SUMMARY

Field Programmable Gate Arrays			
PLS103	16 x 9	28-Pin	Tri-state
PLS151	18 x 12	20-Pin	Tri-state
Field Programmable Address Decoders			
PLS162	12 x 9	24-Pin	Tri-state
PLS163	16 x 5	24-Pin	Tri-state
Field Programmable Logic Arrays			
PLS100	16 x 48 x 8	28-Pin	Tri-state
PLS101	16 x 48 x 8	28-Pin	Open Collector
PLS153/153A	18 x 45 x 10	20-Pin	Tri-state
PLS161	12 x 48 x 8	24-Pin	Tri-state
PLS173	22 x 45 x 10	24-Pin	Tri-state
Field Programmable Logic Sequencers			
PLS105/105A	16 x 48 x 8	28-Pin	Tri-state Mealy State Machine
PLS155	16 x 32 x 12	20-Pin	Tri-state 4-Bit Sequencer
PLS157	16 x 32 x 12	20-Pin	Tri-state 6-Bit Sequencer
PLS159/159A	16 x 32 x 12	20-Pin	Tri-state 8-Bit Sequencer
PLS167/167A	14 x 48 x 6	24-Pin	Tri-state Mealy State Machine
PLS168/168A	14 x 48 x 8	24-Pin	Tri-state Mealy State Machine
PLS179	20 x 32 x 8	24-Pin	Tri-state 8-Bit Sequencer

FPGA LOGIC DIAGRAM

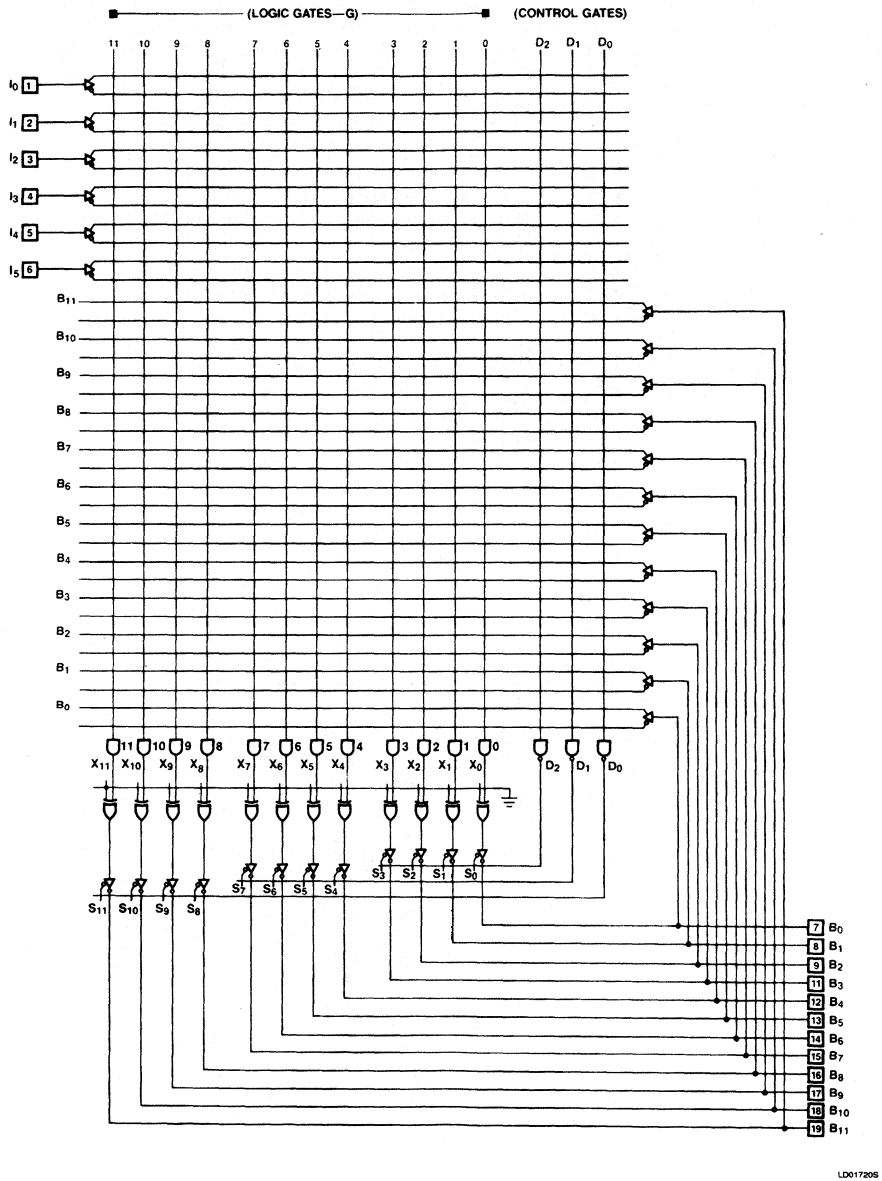
PLS103



NOTES:
1. All gate inputs when a blown link float to a logic "1".
2. Programmable connection.

FPGA LOGIC DIAGRAM

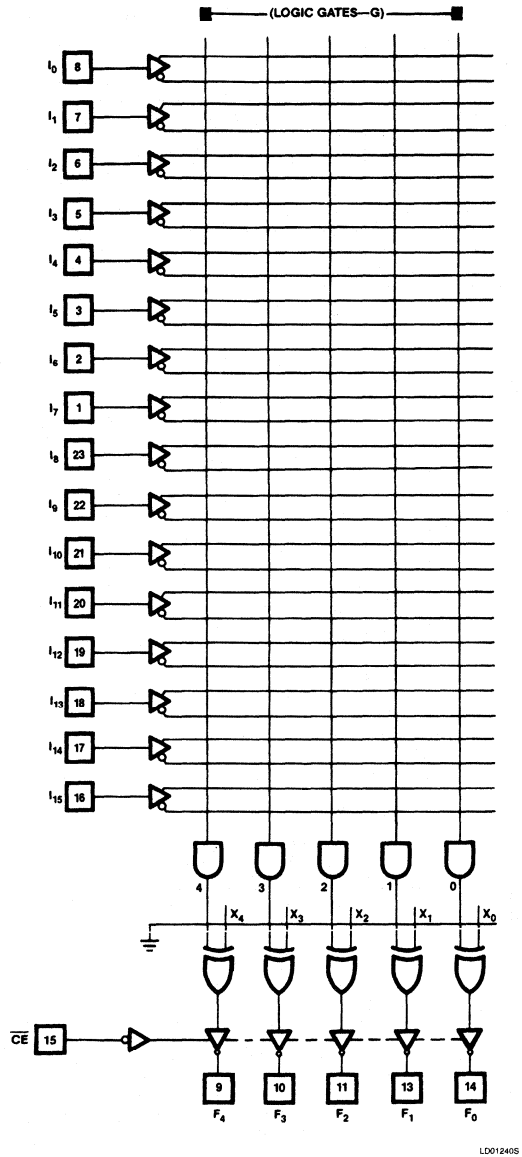
PLS151



NOTES:
1. All gate inputs with a blown link float to a logic "1".
2. Programmable connection.

FPAD LOGIC DIAGRAM

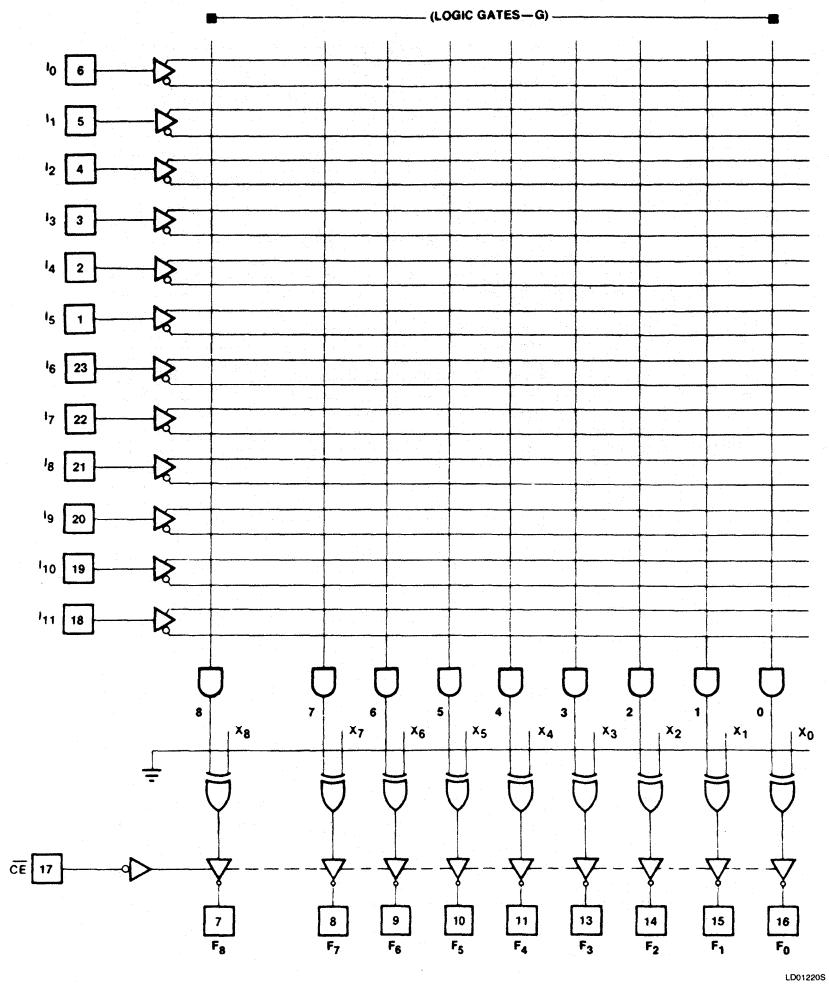
PLS162



NOTE:
1. All gate inputs with a blown link float to a logic "1".
2. Programmable connection.

FPAD LOGIC DIAGRAM

PLS163

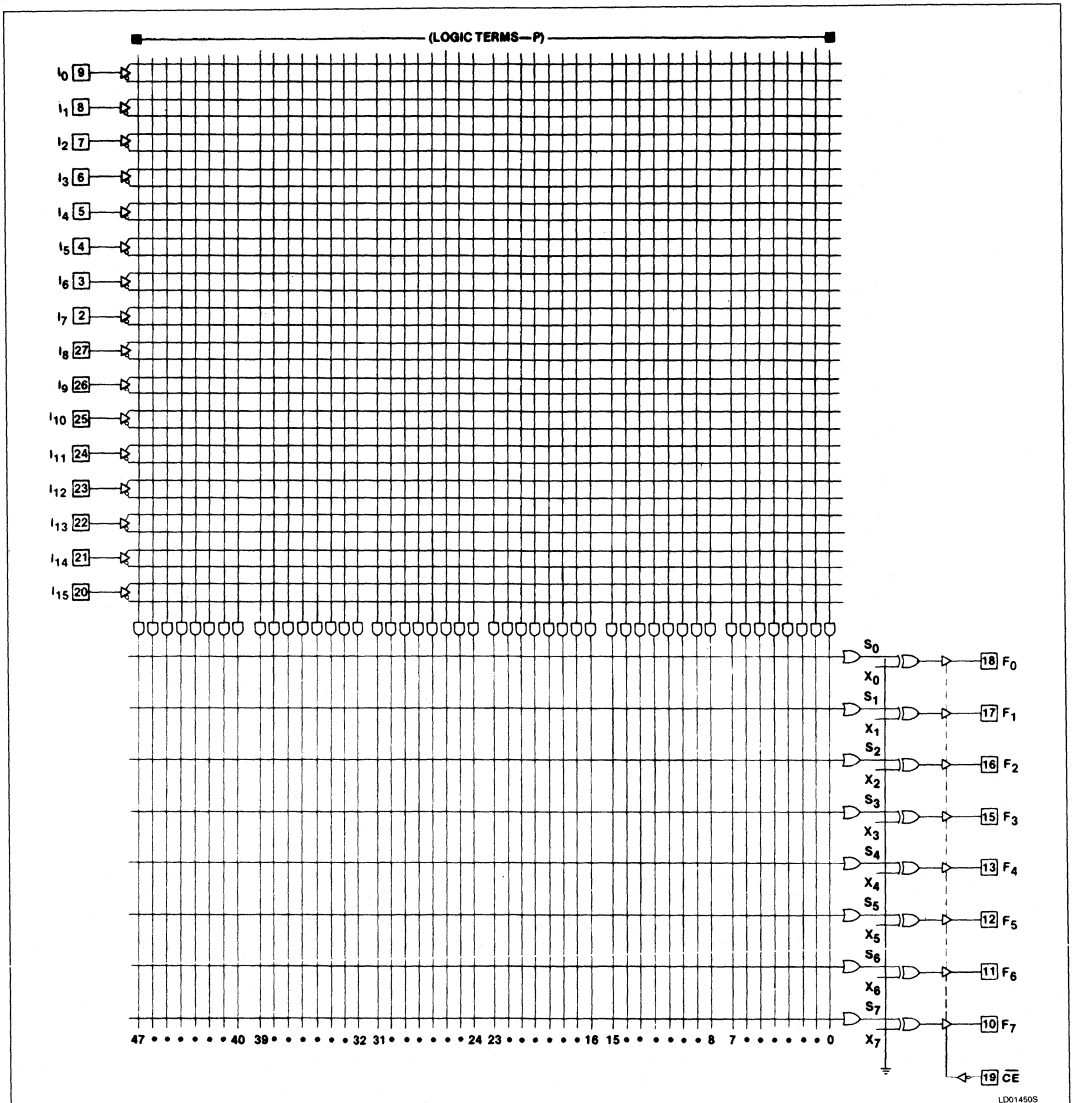


NOTES:
1. All gate inputs with a blown link float to a logic "1".
2. Programmable connection.

Signetics Programmable Logic

FPLA LOGIC DIAGRAM

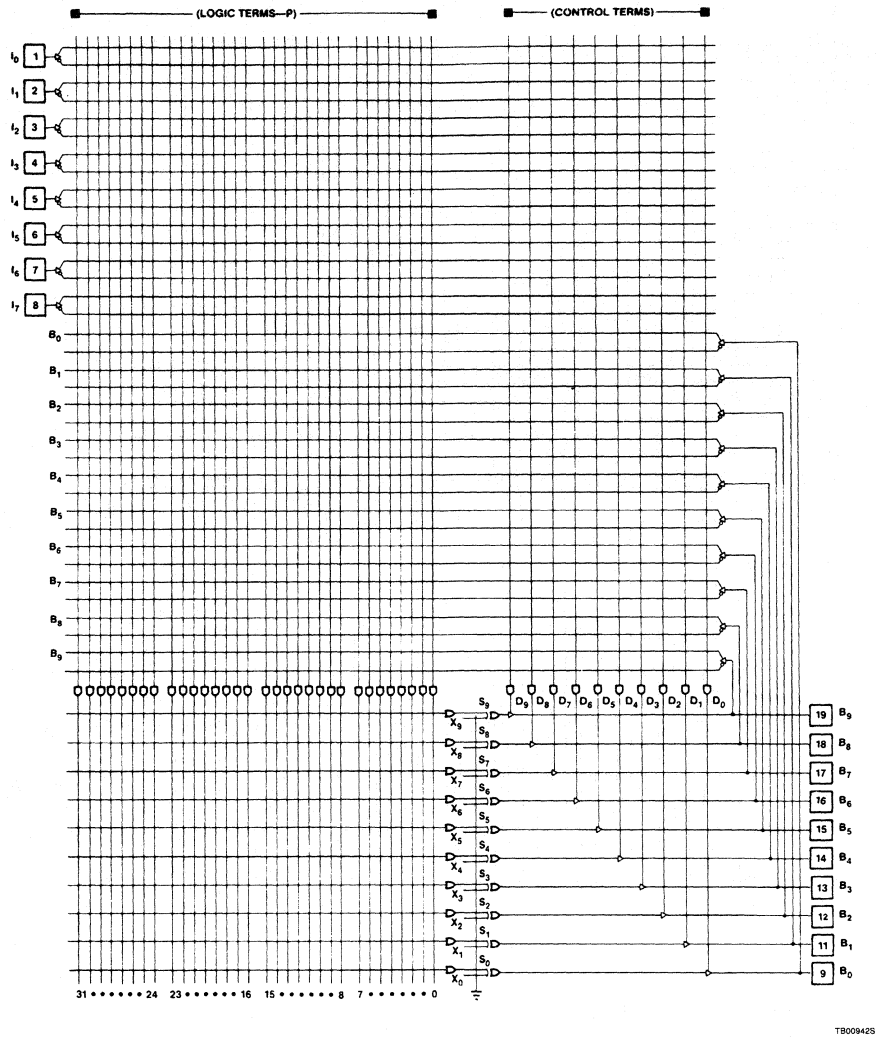
PLS100



NOTES:
1. All AND gate inputs with a blown link float to a logic "1".
2. All OR gate inputs with a blown fuse float to logic "0".
3. Programmable connection.

FPLA LOGIC DIAGRAM

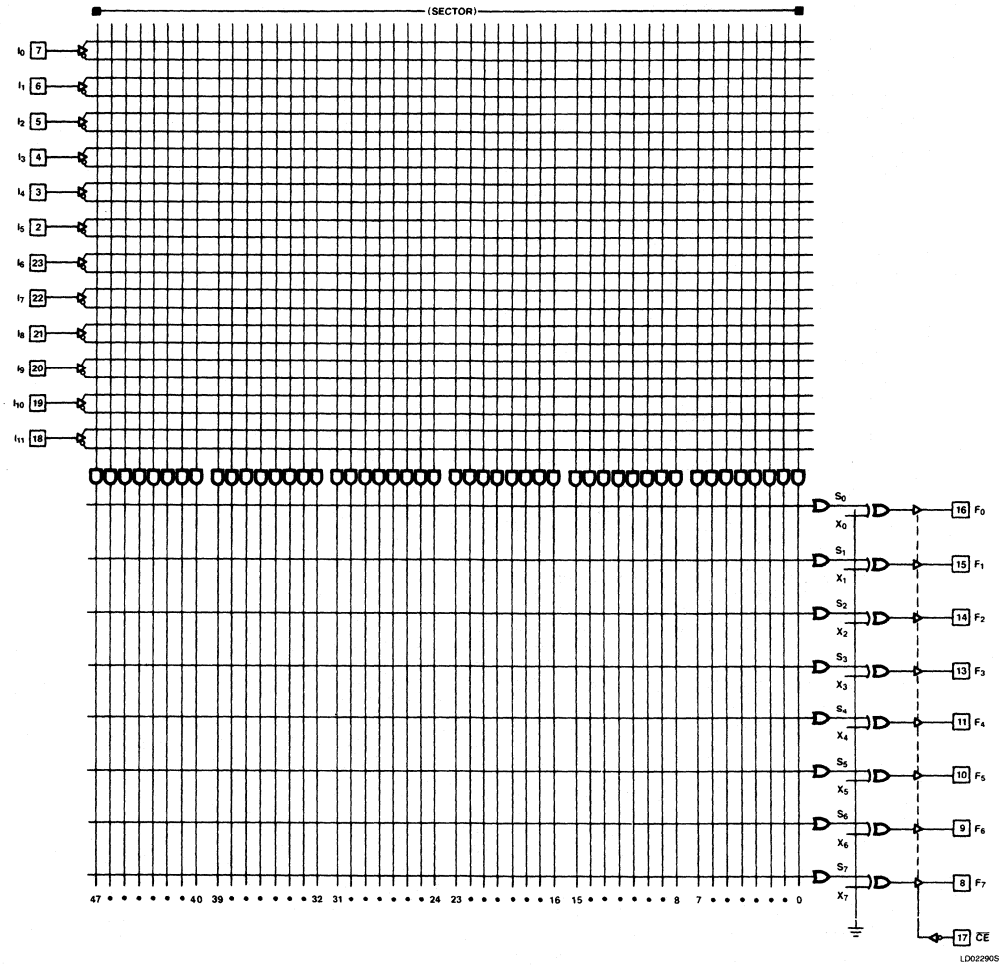
PLS153/153A



NOTES:
1. All programmed "AND" gate locations are pulled to logic "1".
2. All programmed "OR" gate locations are pulled to logic "0".
3. Programmable connection.

FPLA LOGIC DIAGRAM

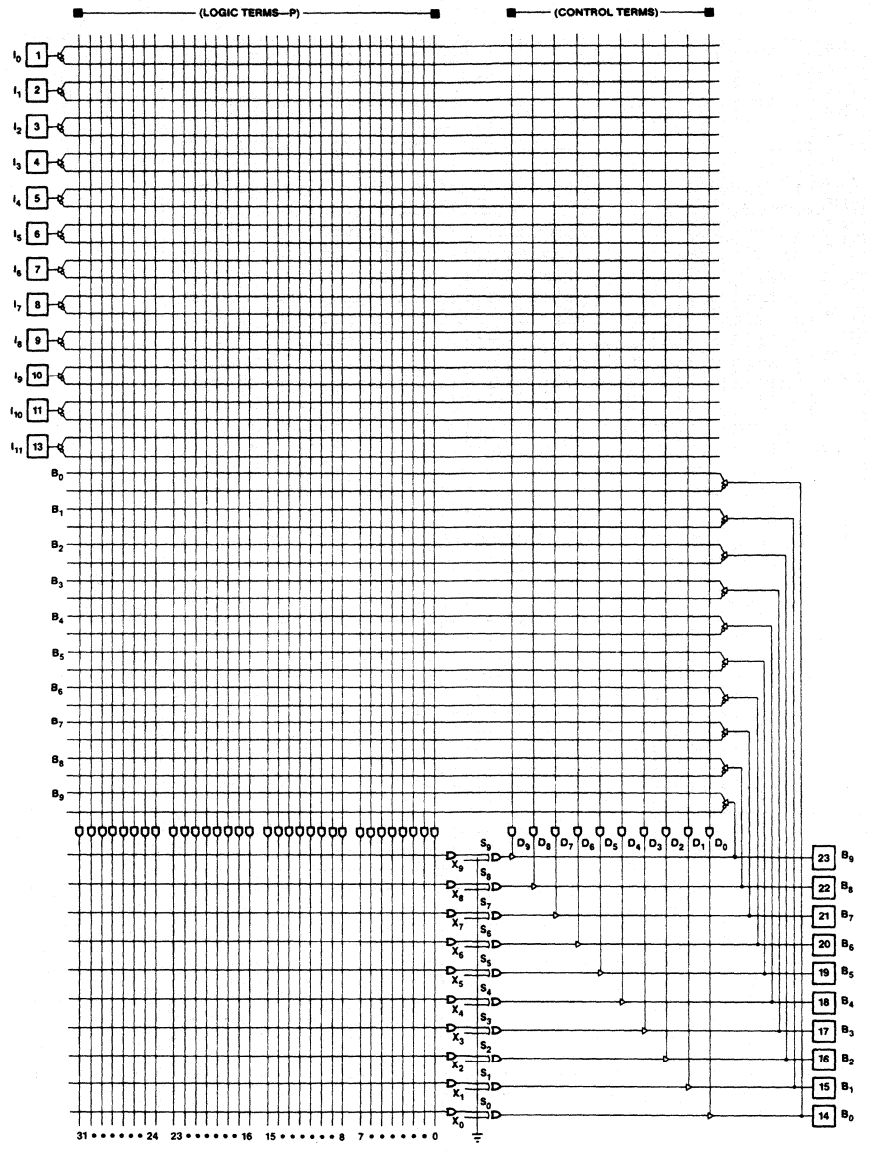
PLS161



NOTES:
1. All AND/EX-OR gate inputs with a blown link float to a logic "1".
2. All OR gate inputs with a blown link float to a logic "0".
3. Programmable connection.

FPLA LOGIC DIAGRAM

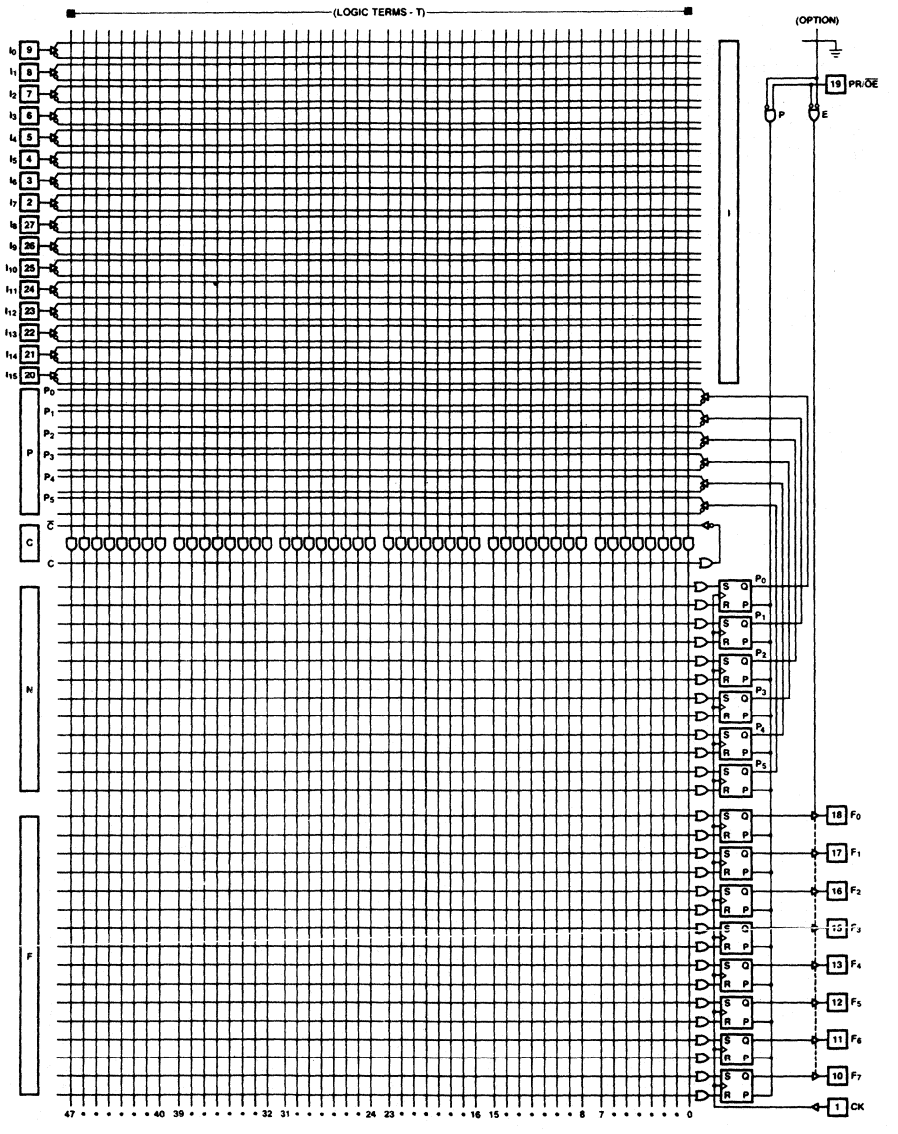
PLS173



NOTES:
1. All programmed "AND" gate locations are pulled to logic "1".
2. All programmed "OR" gate locations are pulled to logic "0".
3. Programmable connection.

FPLS LOGIC DIAGRAM

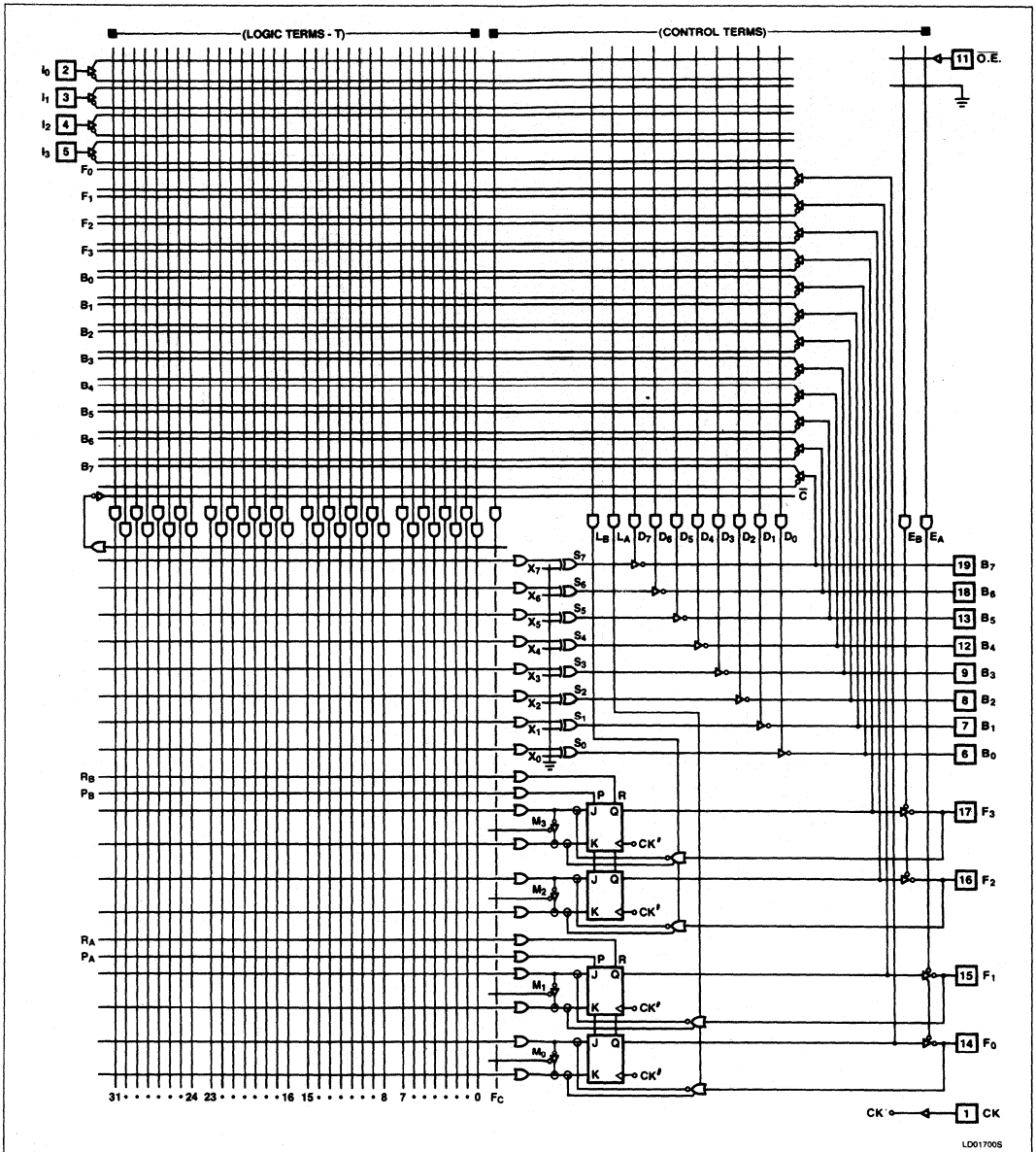
PLS105/105A



NOTES:
1. All AND gate inputs with a blown link float to a logic "1".
2. All OR gate inputs with a blown fuse float to logic "0".
3. Programmable connection.

FPLS LOGIC DIAGRAM

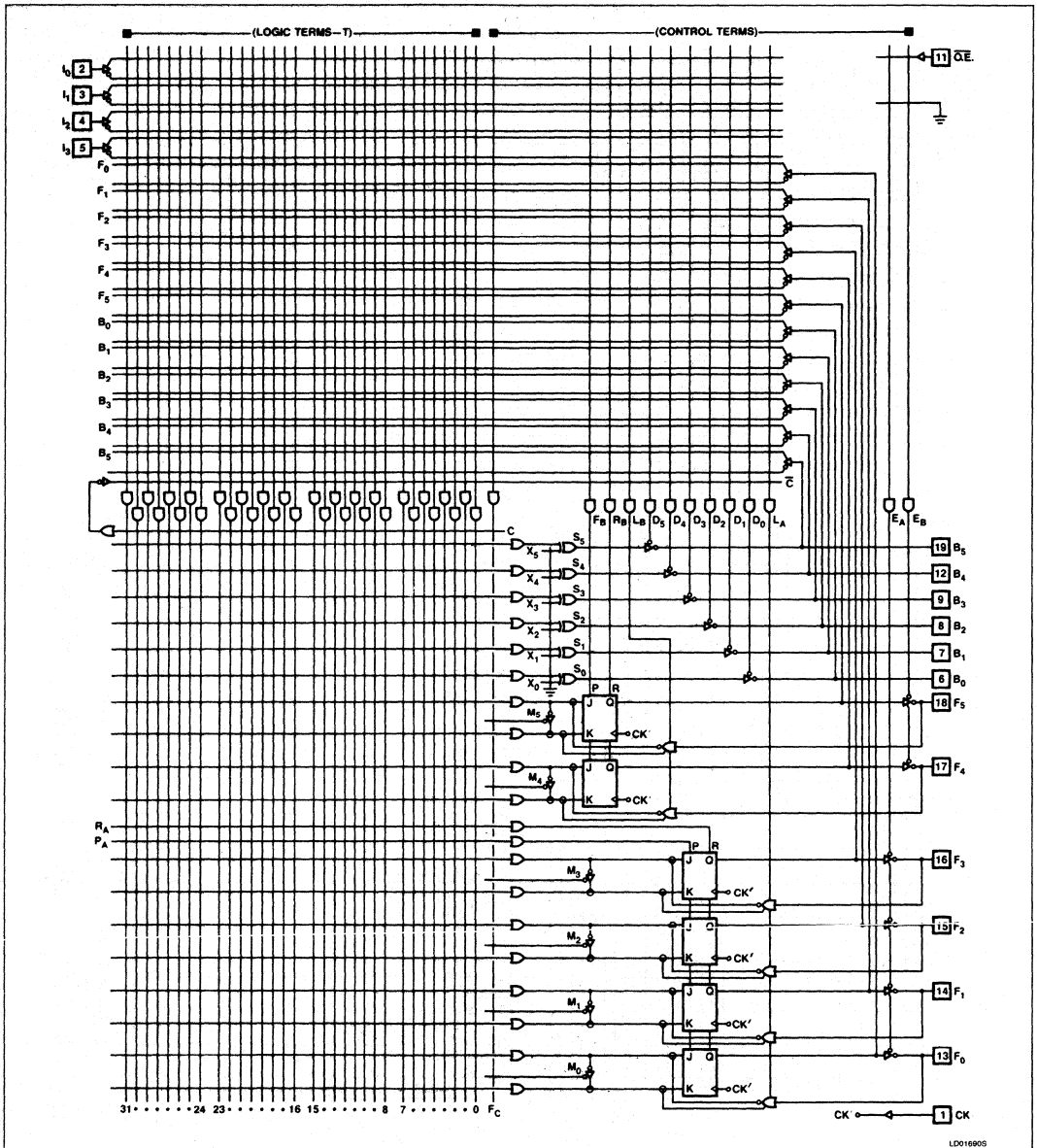
PLS155



NOTES:
1. All OR gate inputs with a blown link float to logic "0".
2. All other gates and control inputs with a blown link float to logic "1".
3. ⊕ denotes WIRE-OR.
4. Programmable connection.

FPLS LOGIC DIAGRAM

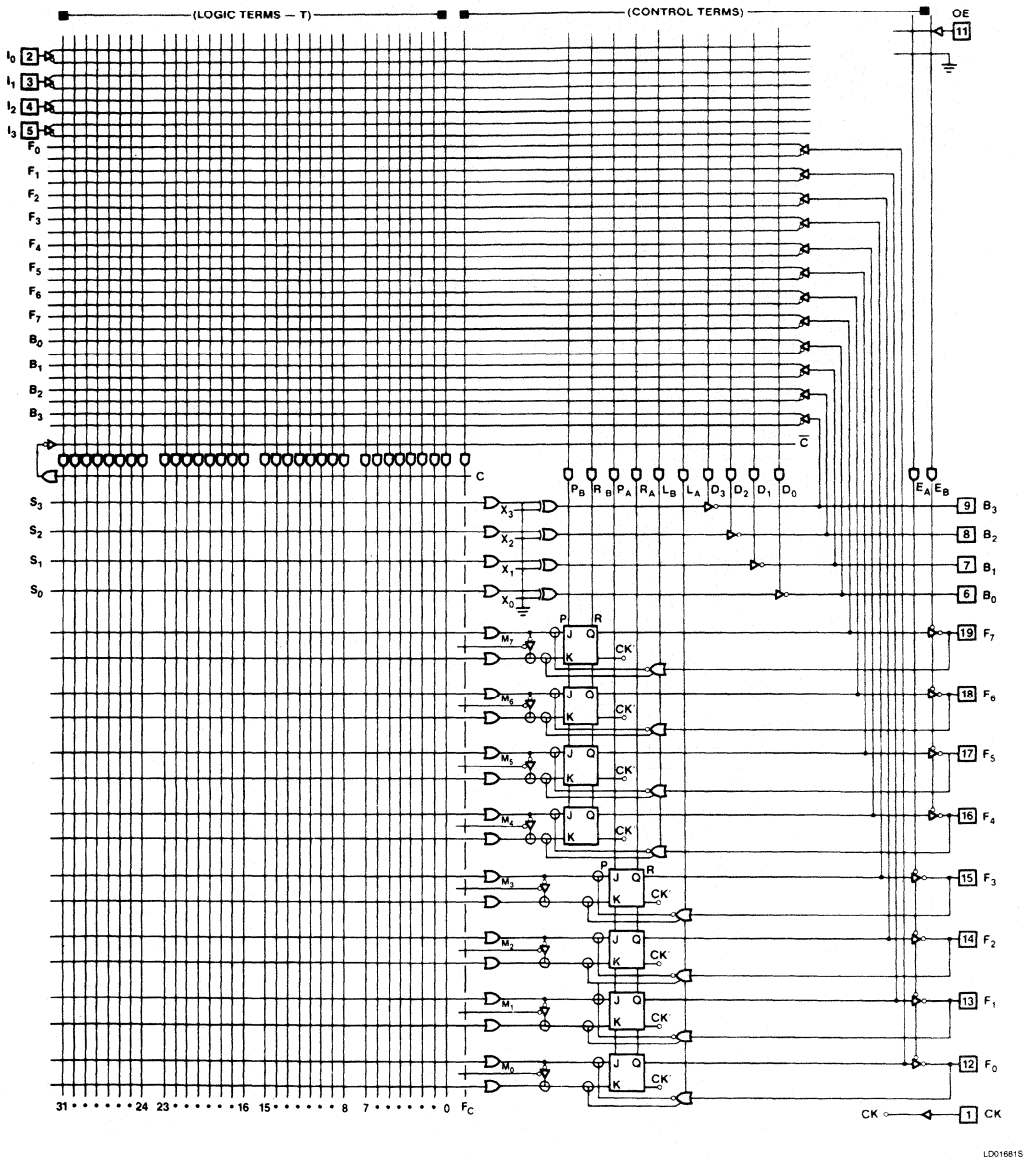
PLS157



NOTES:
1. All OR gate inputs with a blown link float to logic "0".
2. All other gates and control inputs with a blown link float to logic "1".
3. ⊕ denotes WIRE-OR.
4. • Programmable connection.

FPLS LOGIC DIAGRAM

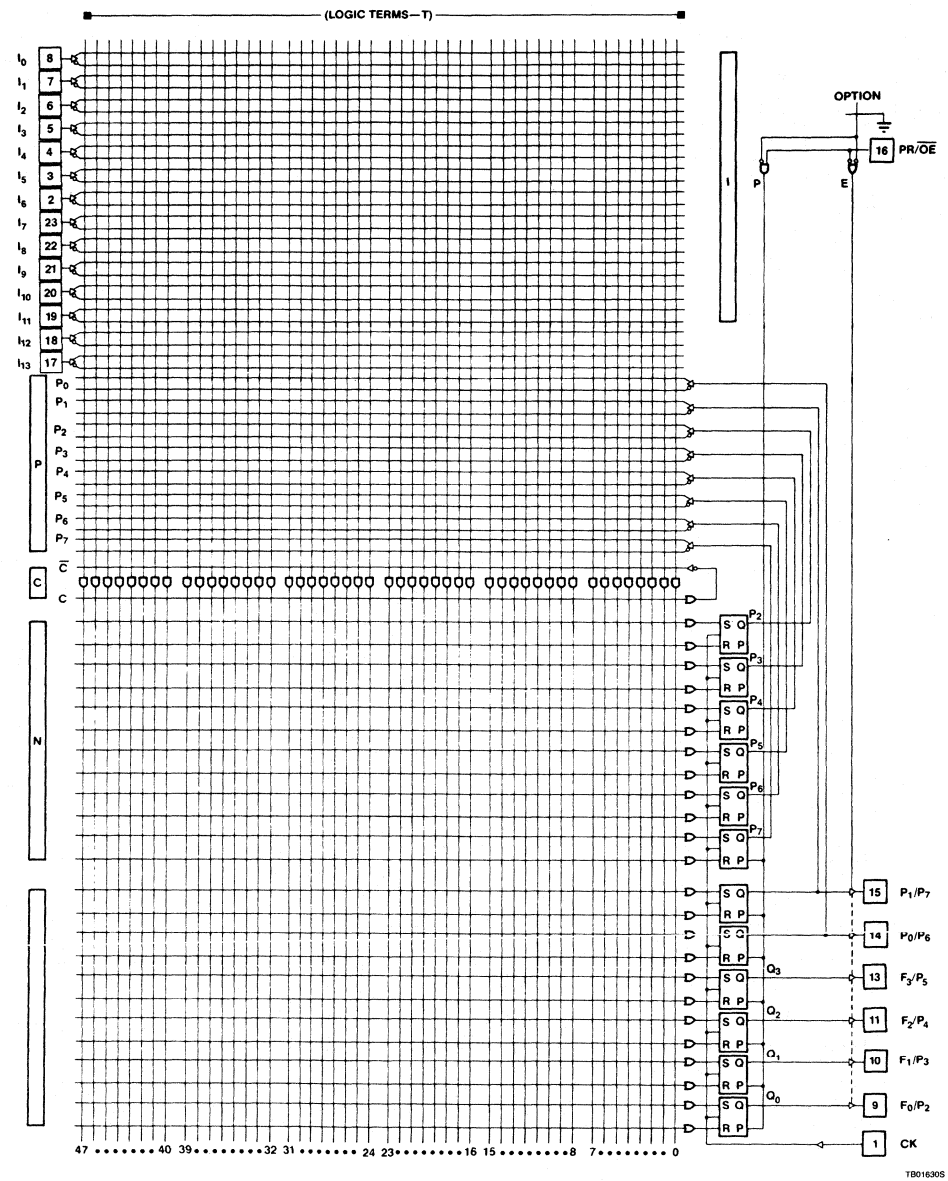
PLS159



NOTES:
1. All OR gate inputs with a blown link float to logic "0".
2. All other gates and control inputs with a blown link float to logic "1".
3. ⊕ denotes WIRE-OR.
4. Programmable connection.

FPLS LOGIC DIAGRAM

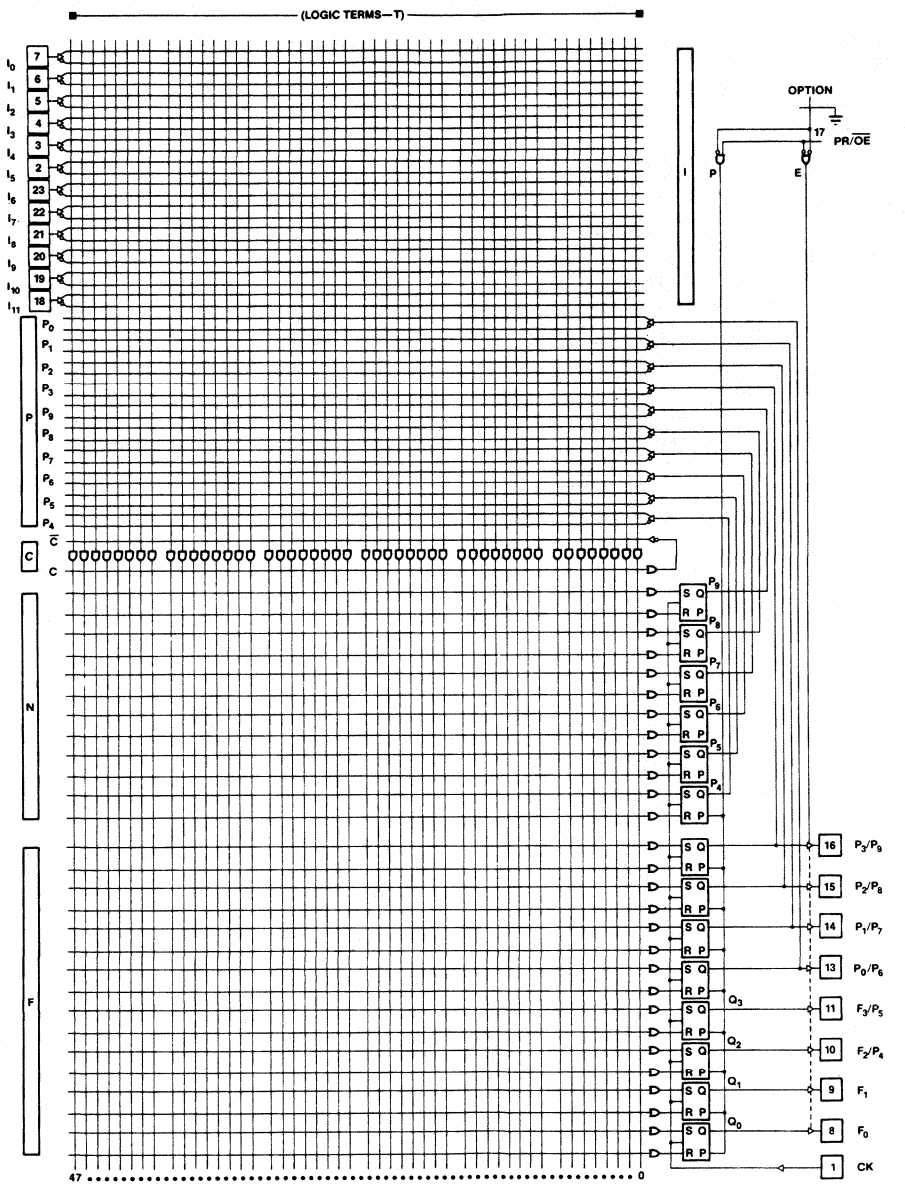
PLS167/167A



NOTES:
1. All AND gate inputs with a blown link float to a logic "1".
2. All OR gate inputs with a blown link float to a logic "0".
3. Programmable connection.

FPLS LOGIC DIAGRAM

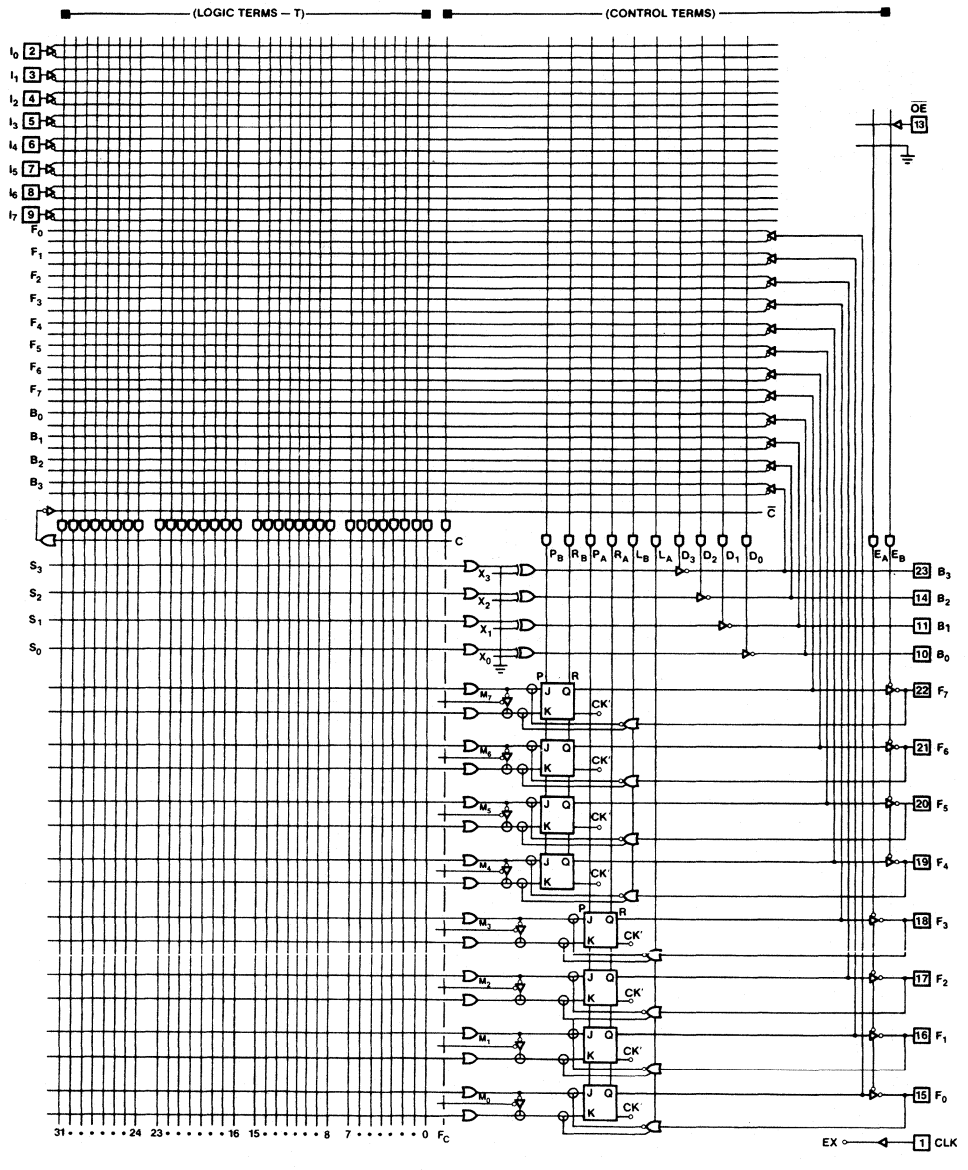
PLS168/168A



NOTES:
1. All programmed "AND" gate locations are pulled to logic "1".
2. All programmed "OR" gate locations are pulled to logic "0".
3. Programmable connection.

Signetics Programmable Logic — Introduction

FPLS LOGIC DIAGRAM — PLS179



1. All OR gate inputs with a blown link float to logic "0".
2. All other gates and control inputs with a blown link float to logic "1".
3. ⊕ denotes WIRE-OR.
4. Programmable connection.

Signetics Programmable Logic — Programming Information

PLD PROGRAMMING

The current Signetics family of Programmable Logic (PLD) products are high-performance bipolar devices which use a nickel-chromium (Ni-Cr) alloy fuse to provide the many benefits of field programming. Programming is accomplished by application of voltages above those used for normal operation; therefore, no special pins are required for programming. The programming voltages and timing requirements make unintentional programming virtually impossible.

PROGRAMMING INFORMATION

Complete programming system specifications for PLD 20-, 24-, and 28-pin products are available upon request from Application Specific Product Marketing.

Signetics encourages the purchase of programming equipment from a manufacturer who has a full-line of programming products to offer. Signetics also encourages the manufacturers of PLD programming equipment to submit their equipment for verification of electrical parameters and programming procedures. Information on manufacturers offering equipment certified by Signetics is available on request from Application Specific Product Marketing.

SIGNETICS DISCOURAGES THE CONSTRUCTION AND USE OF "HOMEMADE" PROGRAMMING EQUIPMENT

In order to consistently achieve excellent programming yields, periodic calibration of the programming equipment is required. Consult the equipment manufacturer for the recommended calibration interval. Records of programming yield, by device type, should be kept and any downward trend or sudden change should be considered as an indication of a need to recalibrate the programming equipment.

Signetics

Application Specific Products

Section 3
Advanced Product Preview

3

INDEX

January 1986

Signetics

PLC105
Field Programmable Logic Sequencer (16 x 48 x 8)

Signetics Programmable Logic
Objective Specification

Application Specific Products
- **Series 28**

DESCRIPTION

The PLC105 is a CMOS, EPROM state machine of the Mealy type. It contains logic AND-OR gate arrays with user-programmable connections which control the inputs of on-chip State and Output Registers. These consist respectively of 6 Q_P and 8 Q_F edge-triggered, clocked S/R flip-flops, with an Asynchronous Preset option.

All flip-flops are unconditionally preset to "1" during power turn-on.

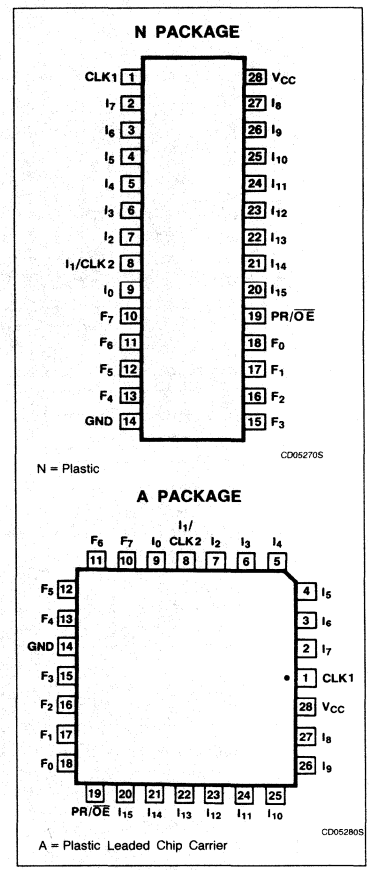
The AND Array combines 16 external inputs I_{0-15} with six internal inputs P_{0-5} which are fed back from the State Register to form up to 48 transition terms (AND terms).

All transition terms can include True, False, or Don't Care states of the controlling variables, and are merged in the OR array to issue next-state and next-output commands to their respective registers on the LOW-to-HIGH transition of the Clock pulse. Both True and Complement transition terms can be generated by optional use of the internal input variable (C) from the Complement Array. Also, if desired, the Preset input can be converted to Output Enable function, as an additional user-programmable option.

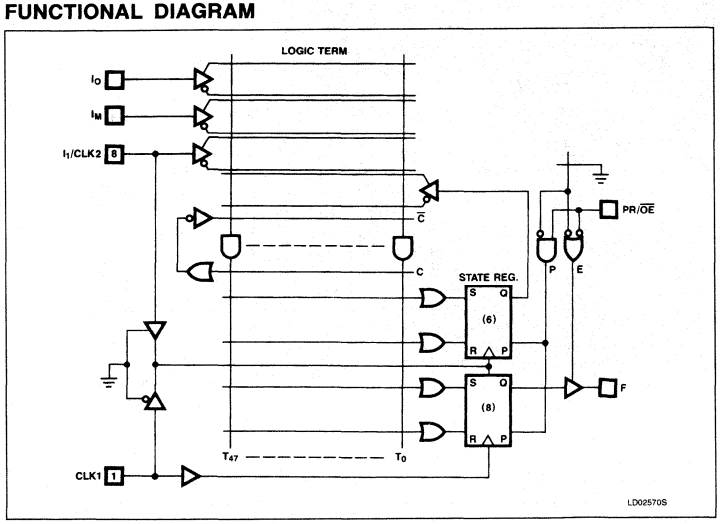
FEATURES

- **Electrical programmable, UV erasable**
- **16 input variables**
- **8 output functions**
- **48 transition terms**
- **6-bit State Register**
- **8-bit Output Register**
- **Transition Complement Array**
- **Positive edge-triggered clock**
- **Programmable Asynchronous Preset or Output Register**
- **Power-on preset to all "1" of internal registers**
- **f_{MAX} = 20MHz (commercial)**
- **Power dissipation: 200mW (typical at 20MHz)**
- **TTL compatible**
- **Single +5V supply**
- **Pin-to-pin compatible with PLS105/105A**
- **Tri-state outputs**
- **Multiple clock option**
- **Threshold monitor mode**
- **State and Output Register preload feature**
- **Diagnostic Mode**
- **Verify lock**

PIN CONFIGURATION



FUNCTIONAL DIAGRAM

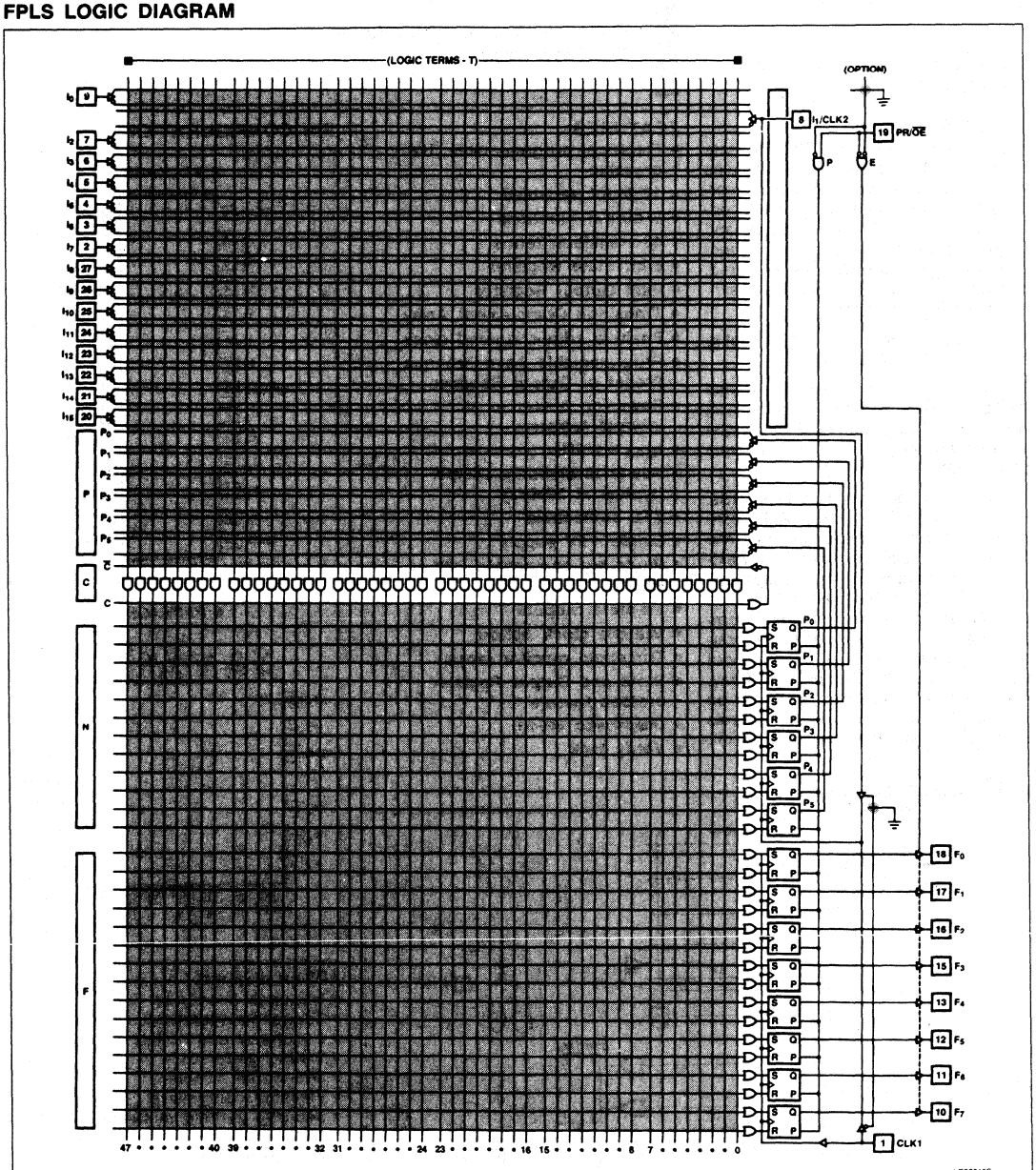


APPLICATIONS

- **Interface protocols**
- **Sequence detectors**
- **Peripheral controllers**
- **Timing generators**
- **Sequential circuits**
- **Elevator controllers**
- **Security locking systems**
- **Counters**
- **Shift registers**

Field Programmable Logic Sequencer (16 x 48 x 8) PLC105

FPLS LOGIC DIAGRAM



NOTES:
1. All AND inputs with a blown link float to a logic "1".
2. All OR gate inputs with a blown link float to logic "0".
3. ● Programmable connection.

Signetics

PLHS153
Field Programmable Logic Array (18 x 42 x 10)

Signetics Programmable Logic
Objective Specification

Application Specific Products
- **Series 20**

DESCRIPTION

The PLHS153 is a high-speed version of the PLS153 and PLS153A FPLAs. The Signetics state-of-the-art Oxide Isolated Bipolar fabrication process is employed to produce performance levels not yet achieved in devices of this complexity.

The PLHS153 is a two-level logic elements, consisting of 42 AND gates and 10 OR gates with fusible link connections for programming I/O polarity and direction.

All AND gates are linked to 8 inputs (I) and 10 bidirectional I/O lines (B). These yield variable I/O gate configurations via 10 direction control gates (D), ranging from 18 inputs to 10 outputs.

On chip T/C buffers couple either True (I, B) or Complement ($\overline{I}$, $\overline{B}$) input polarities to all AND gates, whose outputs can be optionally linked to all OR gates. Their output polarity, in turn, is individually programmable through a set of EX-OR gates for implementing AND/OR or AND/NOR logic functions.

The PLHS153 is field programmable, enabling the user to quickly generate custom patterns using standard programming equipment.

FEATURES

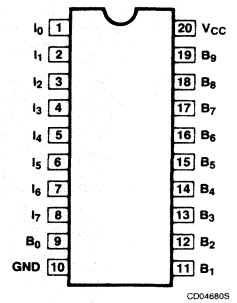
- **Field Programmable (Ni-Cr links)**
- **Functionally identical to PLS153/153A**
- **8 inputs**
- **42 AND gates**
- **10 OR gates**
- **10 bidirectional I/O lines**
- **Active high or low outputs**
- **42 Product Terms:**
  - **32 Logic Terms**
  - **10 Control Terms**
- **I/O propagation delay: 20ns (max)**
- **Input loading: −100μA (max)**
- **Power dissipation: 650mW (typ)**
- **Tri-state Outputs**
- **TTL compatible**

APPLICATIONS

- **Random logic**
- **Code converters**
- **Fault detectors**
- **Function generators**
- **Address mapping**
- **Multiplexing**

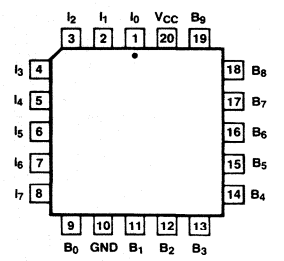
PIN CONFIGURATION

N PACKAGE



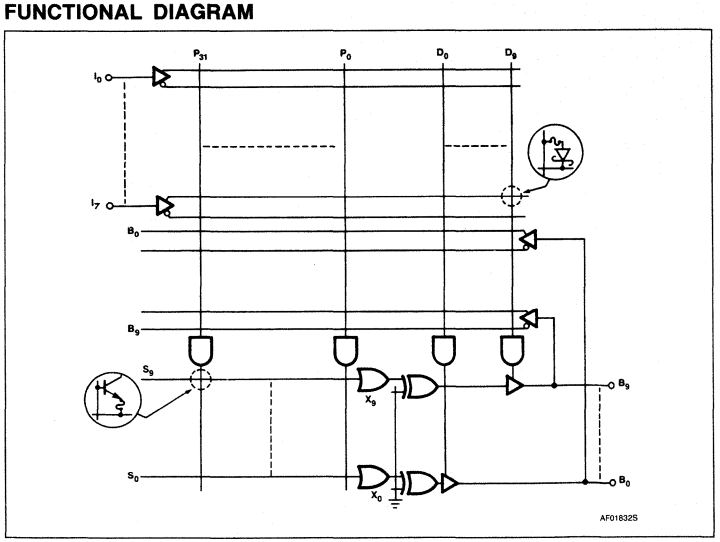
N = Plastic

A PACKAGE



A = Plastic Leaded Chip Carrier

FUNCTIONAL DIAGRAM



LOGIC FUNCTION

TYPICAL PRODUCT TERM:
$Pn = A \cdot B \cdot C \cdot D \cdot \ldots$

TYPICAL LOGIC FUNCTION:

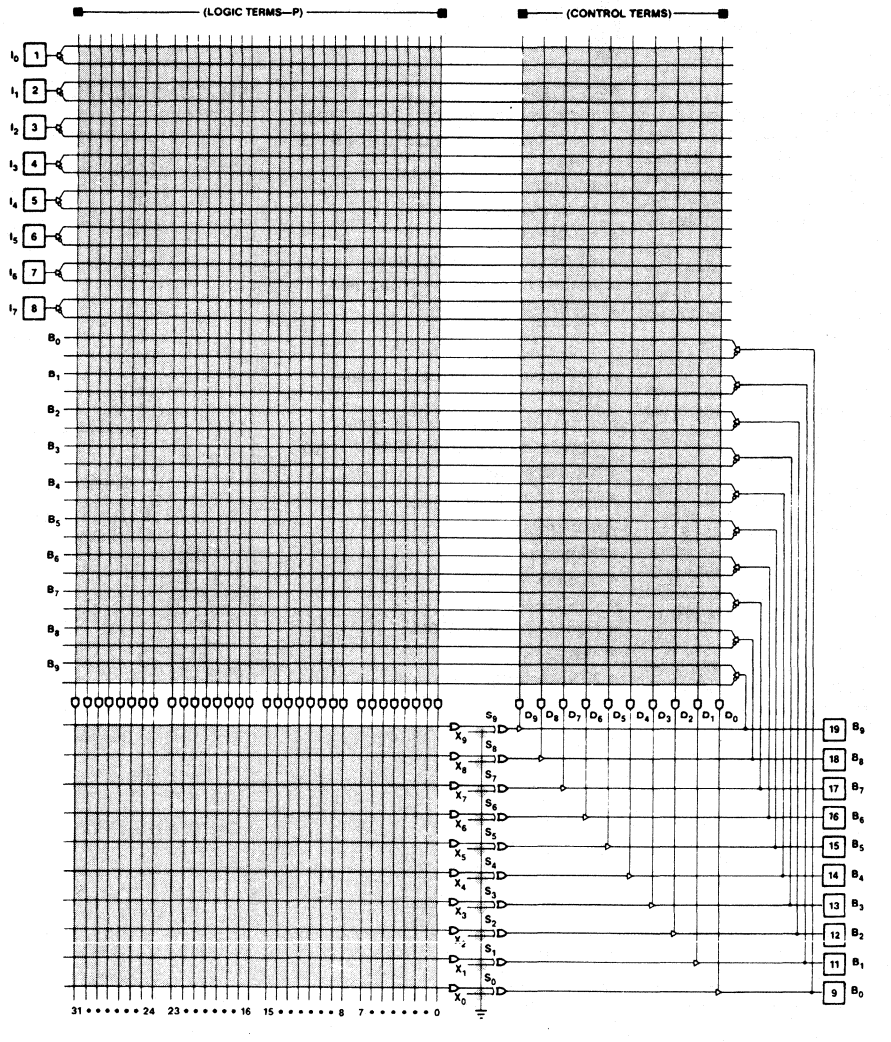
AT OUTPUT POLARITY = H
$Z = P0 + P1 + P2 \ldots$

AT OUTPUT POLARITY = L
$Z = \overline{P0 + P1 + P2} + \ldots$
$Z = \overline{P0} \cdot \overline{P1} \cdot \overline{P2} \ldots$

NOTES:
1. For each of the 10 outputs, either function Z (active-high) or $\overline{Z}$ (active-low) is available, but not both. The desired output polarity is programmed via the EX-OR gates.
2. Z, A, B, C, etc. are user defined connections to fixed inputs (I) and bidirectional pins (B).

Field Programmable Logic Array (18 x 42 x 10) PLHS153

FPLA LOGIC DIAGRAM



NOTES:
1. All unprogrammed or virgin "AND" gate locations are pulled to logic "1" .
2. All unprogrammed or virgin "OR" gate locations are pulled to logic "0" .
3. Programmable connection.

Signetics

PLMC153
Field Programmable Logic Array (18 x 42 x 10)

Signetics Programmable Logic
Objective Specification

Application Specific Products
- **Series 20**

DESCRIPTION

The PLMC153 is a CMOS, mask-programmable functional equivalent of the PLS153 and PLS153A FPLAs. Custom logic patterns can be generated directly from working bipolar PLS153/153A devices. This enables the user to prototype and debug a device in a system prior to committing the pattern to a mask set. The single mask-programmed PLMC153 provides maximum production economy, while the CMOS process technology reduces the power consumption of the PLMC153 to less than one third of its bipolar counterparts.

Identical to the PLS153 and 153A, the PLMC153 is a two-level logic element, consisting of 42 AND gates and 10 OR gates, featuring programmable I/O polarity and direction.

All AND gates are linked to 8 inputs (I) and 10 bidirectional I/O lines (B). These yield variable I/O gate configurations via 10 direction control gates (D), ranging from 18 inputs to 10 outputs.

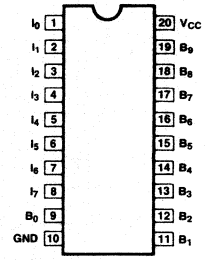
On chip T/C buffers couple either True (I, B) or Complement ($\bar{I}$, $\bar{B}$) input polarities to all AND gates, whose outputs can be optionally linked to all OR gates. Their output polarity, in turn, is individually programmable through a set of EX-OR gates for implementing AND/OR or AND/NOR logic functions.

FEATURES

- **Single mask-programmable**
- **Functionally identical to PLS153 and PLS153A**
- **8 inputs**
- **42 AND gates**
- **10 OR gates**
- **10 bidirectional I/O lines**
- **Active high or low outputs**
- **42 Product Terms:**
  - **32 Logic Terms**
  - **10 Control Terms**
- **I/O propagation delay: 35ns (max)**
- **Power dissipation: (typ)**
  - **DC: 1mA**
  - **AC: 1mA/MHz**
- **Input Loading: −100μA (max)**
- **Output: Tri-state**
- **TTL compatible**

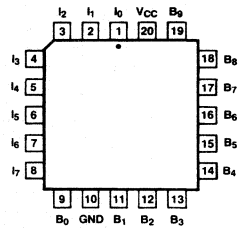
PIN CONFIGURATION

N PACKAGE



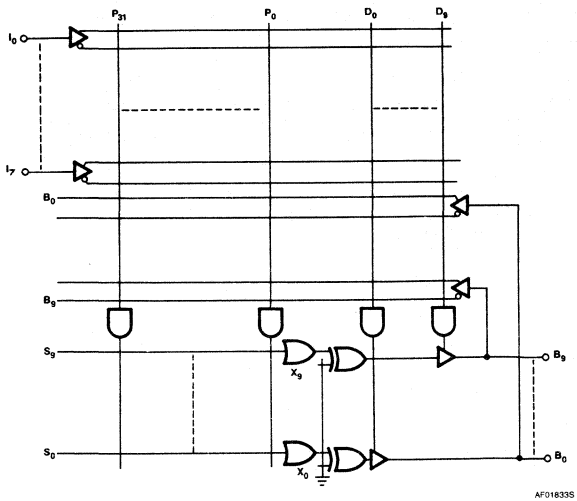
N = Plastic

A PACKAGE



A = Plastic Leaded Chip Carrier

FUNCTIONAL DIAGRAM



NOTE:
All points are mask-programmable.

LOGIC FUNCTION

TYPICAL PRODUCT TERM:
$Pn = A \cdot B \cdot C \cdot D \cdot \ldots$

TYPICAL LOGIC FUNCTION:

AT OUTPUT POLARITY = H
$Z = P0 + P1 + P2 \ldots$

AT OUTPUT POLARITY = L
$\overline{Z} = \overline{P0 + P1 + P2} + \ldots$
$Z = \overline{P0} \cdot \overline{P1} \cdot \overline{P2} \ldots$

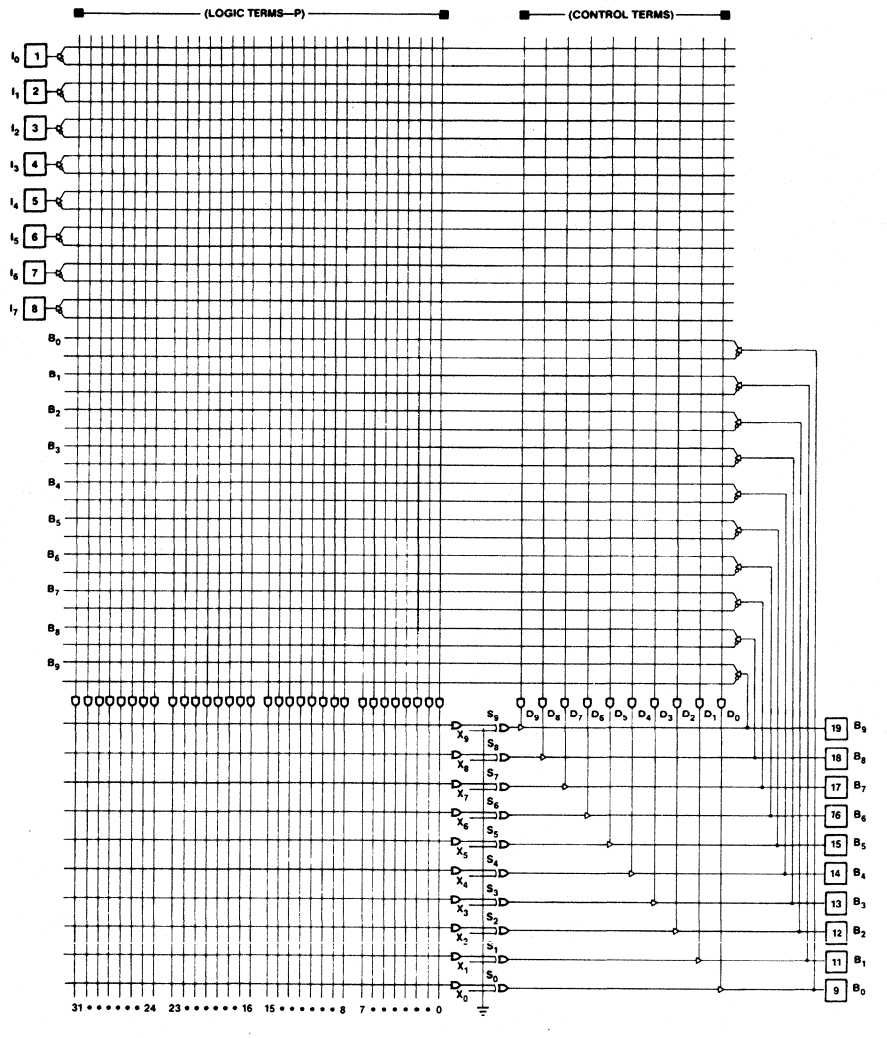
NOTES:
1. For each of the 10 outputs, either function Z (active-high) or $\overline{Z}$ (active-low) is available, but not both. The desired output polarity is programmed via the EX-OR gates.
2. Z, A, B, C, etc. are user defined connections to fixed inputs (I) and bidirectional pins (D).

APPLICATIONS

- **Random logic**
- **Code converters**
- **Fault detectors**
- **Function generators**
- **Address mapping**
- **Multiplexing**

Field Programmable Logic Array (18 x 42 x 10) PLMC153

FPLS LOGIC DIAGRAM



NOTE:
1. All points are mask-programmable.

Signetics

PLHS173
Field Programmable Logic Array (22 x 42 x 10)

Signetics Programmable Logic
Objective Specification

Application Specific Products
- **Series 24**

DESCRIPTION

The PLHS173 is a high-speed version of the PLS173 FPLA. The Signetics state-of-the-art Oxide Isolated Bipolar fabrication process is employed to produce performance levels not yet achieved in devices of this complexity.

The PLHS173 is a two-level logic element consisting of 42 AND gates and 10 OR gates with fusible link connections for programming I/O polarity and direction.

All AND gates are linked to 12 inputs (I) and 10 bidirectional I/O lines (B). These yield variable I/O gate configurations via 10 direction control gates (D), ranging from 22 inputs to 10 outputs.

On chip T/C buffers couple either True (I, B) or Complement ($\overline{I}$, $\overline{B}$) input polarities to all AND gates, whose outputs can be optionally linked to all OR gates. Their output polarity, in turn, is individually programmable through a set of EX-OR gates for implementing AND/OR or AND/NOR logic functions.

The PLHS173 is field-programmable, enabling the user to quickly generate custom patterns using standard programming equipment.

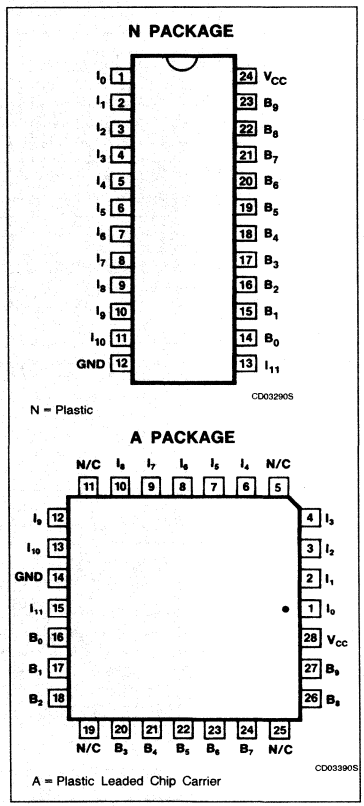
FEATURES

- **Field Programmable (Ni-Cr links)**
- **Functionally identical to PLS173**
- **12 inputs**
- **42 AND gates**
- **10 OR gates**
- **10 bidirectional I/O lines**
- **Active high or low outputs**
- **42 Product Terms:**
  - **32 Logic Terms**
  - **10 Control Terms**
- **I/O propagation delay: 20ns (max)**
- **Input loading: −100μA max**
- **Power dissipation: 750mW (typ)**
- **Output: Tri-state**
- **TTL compatible**

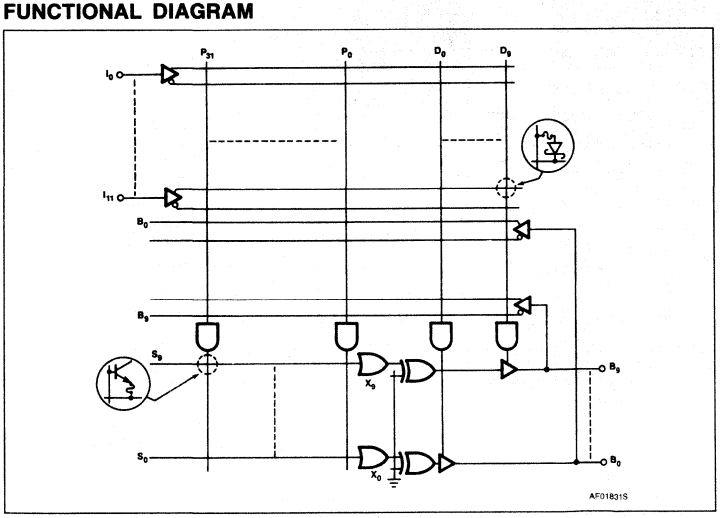
APPLICATIONS

- **Random logic**
- **Code converters**
- **Fault detectors**
- **Function generators**
- **Address mapping**
- **Multiplexing**

PIN CONFIGURATION



FUNCTIONAL DIAGRAM



LOGIC FUNCTION

TYPICAL PRODUCT TERM:
$Pn = A \cdot B \cdot C \cdot D \cdot \ldots$

TYPICAL LOGIC FUNCTION:

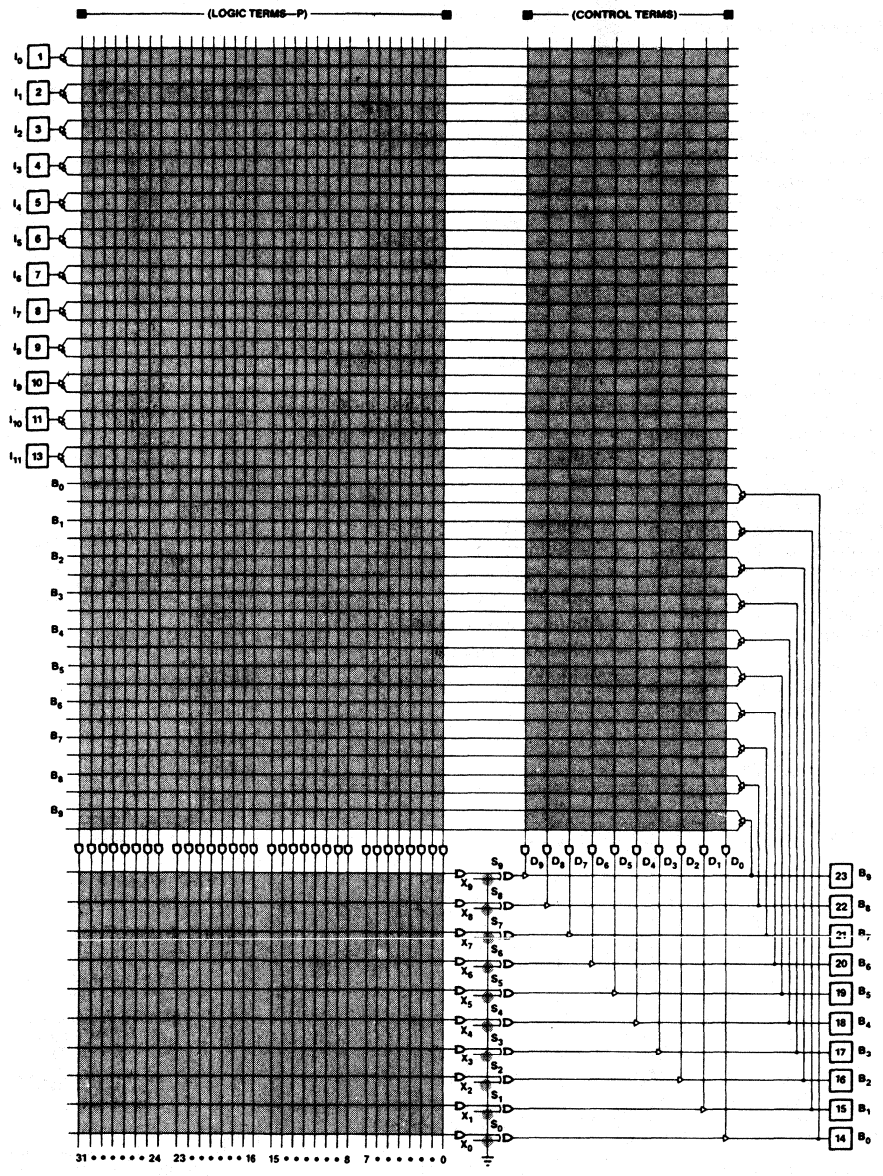
AT OUTPUT POLARITY = H
$Z = P0 + P1 + P2 \ldots$

AT OUTPUT POLARITY = L
$Z = \overline{P0 + P1 + P2} + \ldots$
$Z = \overline{P0} \cdot \overline{P1} \cdot \overline{P2} \cdot \ldots$

NOTES:
1. For each of the 10 outputs, either function Z (active-high) or $\overline{Z}$ (active-low) is available, but not both. The desired output polarity is programmed via the EX-OR gates.
2. Z, A, B, C, etc. are user defined connections to fixed inputs (I) and bidirectional pins (B).

Field Programmable Logic Array (22 x 42 x 10) PLHS173

FPLA LOGIC DIAGRAM



NOTES:
1. All unprogrammed or virgin "AND" gate locations are pulled to logic "1".
2. All unprogrammed or virgin "OR" gate locations are pulled to logic "0".
3. ⊛ Programmable connection.

Signetics

PLC473
Field Programmable Logic Array (20 x 24 x 11)

Signetic Programmable Logic
Objective Specification

Application Specific Products
- **Series 24**

DESCRIPTION

The PLC473 is a two-level logic CMOS Erasable Programmable Logic Device (EPLD) consisting of 24 AND gates and 22 OR gates with EPROM cell connections for programming I/O polarity and direction. The Signetics state-of-the-art Floating Gate CMOS process is used to produce performance not yet achieved in devices of this complexity.

All AND gates are linked to 11 dedicated input pins and 9 bidirectional I/O pins. These bidirectional pins are controlled via the OR array. Employing the 2 dedicated outputs and the programmable I/O direction feature, the PLC473 can be configured with up to 20 inputs — and as many as 11 outputs.

On-chip True/Complement input buffers can be programmed to couple either the true or complement of all inputs ($I_0 - I_{10}$) and bidirectional pins ($B_0 - B_8$) to all AND gates. All 24 AND gates may be optionally linked to any OR gate feeding a bidirectional pin or dedicated output pin ($O_A - O_B$). The output polarity is controlled by using the programmable option on the EX-OR gates found on all bidirectional and output pins. This makes the implementation of AND/OR and AND/NOR functions possible.

The PLC473 contains three new features of significance. A code verification lock has been incorporated to improve user security. Additional testing capability includes stress test mode, whereby all cells can be stressed to insure reliability. In another test mode, the threshold voltage of each cell can be individually checked to ensure charge retention.

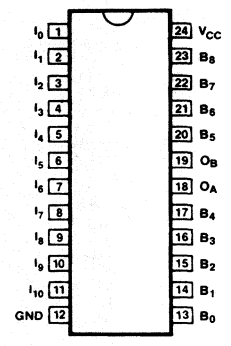
The PLC473 is field programmable using Floating Gate Ultraviolet Erasable Cells. This enables the generation of custom logic patterns using standard programming equipment.

FEATURES

- **Electrically programmable; UV erasable**
- **11 dedicated inputs**
- **2 dedicated outputs**
- **9 bi-directional I/O lines**
- **24 Product Terms**
- **I/O direction decoded in OR array**
- **I/O propagation delay: 35ns (max)**
- **Input loading: −100μA (max)**
- **Power dissipation: (max)**
  - **DC: 100mW**
  - **AC: 250mW**

PIN CONFIGURATION

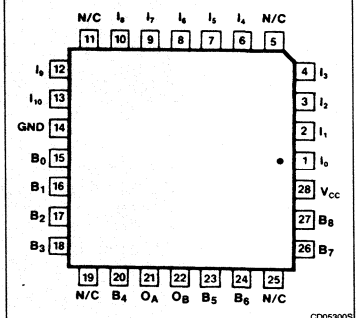
N PACKAGE



CD05290S

N = Plastic

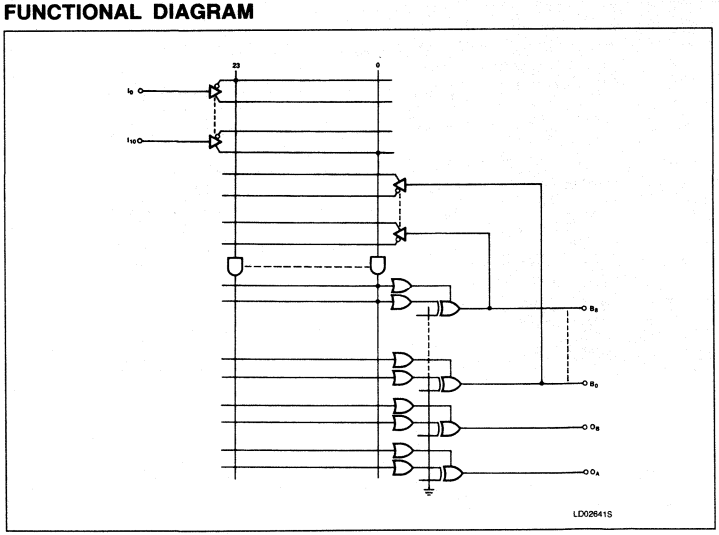
A PACKAGE



CD05300S

A = Plastic Leaded Chip Carrier

FUNCTIONAL DIAGRAM



LD02641S

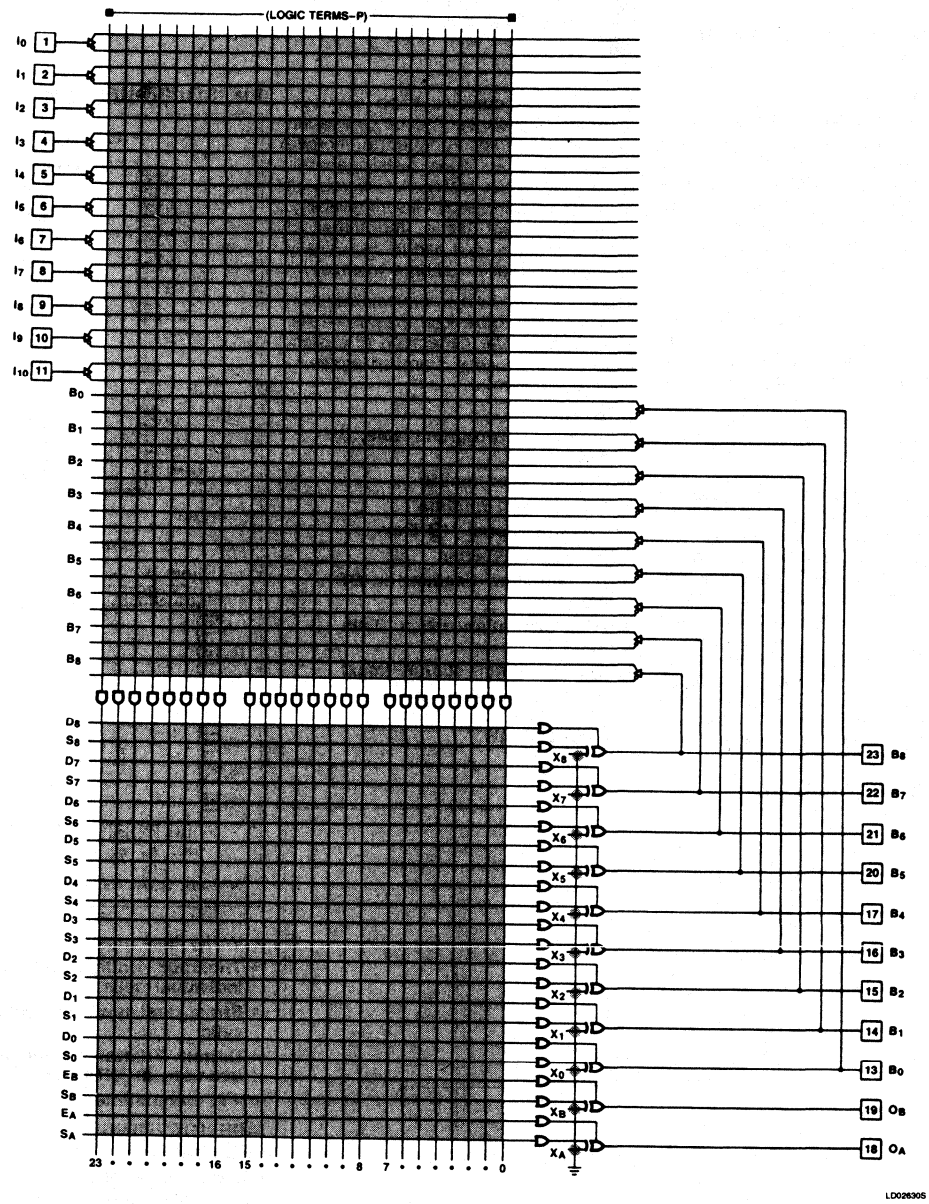
- **Verify lock fuse**
- **Threshold voltage test mode for individual cells**
- **Stress test mode for individual cells**
- **Output: Tri-state condition decoded in OR array**
- **TTL compatible**

APPLICATIONS

- **Random logic**
- **Code converters**
- **Fault detectors**
- **Function generators**
- **Address mapping**
- **Multiplexing**

Field Programmable Logic Array (20 x 24 x 11) PLC473

FPLA LOGIC DIAGRAM



NOTES:
1. All unprogrammed or virgin "AND" gate locations are pulled to logic "1".
2. All unprogrammed or virgin "OR" gate locations are pulled to logic "0".
3. ⊗ Programmable connection.

Signetics

PLHS473
Field Programmable Logic Array (20 x 24 x 11)

Signetics Programmable Logic
Preliminary Specification

Application Specific Products
- **Series 24**

DESCRIPTION

The PLHS473 is a two level logic device consisting of 24 AND gates and 22 OR gates with fusible link connections for programming I/O polarity and direction. The Signetics state of the art Oxide Isolated Bipolar process is used to produce performance not yet achieved in devices of this complexity.

All AND gates are linked to 11 input pins, 9 bidirectional I/O pins, and 2 dedicated output pins. The bidirectional pins are controlled via the OR array. Using these features, the PLHS473 can be configured with up to 20 inputs and as many as 11 outputs.

On chip True/Complement buffers couple either the true or complement of all inputs ($I_0 - I_{10}$)) and bidirectional pins ($B_0 - B_8$) to all AND gates. All 24 AND gates may be optionally linked to any OR gate feeding a bidirectional pin or output pin ($O_A - O_B$). The output polarity is controlled by using the fuse option on the EX-OR gates found on all bidirectional and output pins. This makes the implementation of AND/OR and AND/NOR functions possible.

The PLHS473 contains two new features of significance. A code verification lock has been incorporated to improve user security. The addition of three test columns and one test row enables the user to test the device in an unprogrammed state.

The PLHS473 is field programmable using Vertical Avalanche Migration Programmed (VAMP)™ fuses to program the cells. This enables the generation of custom logic patterns using standard programming equipment.

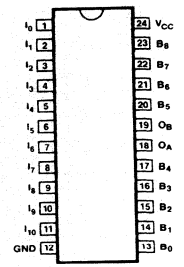
Order codes for this device are contained in the pages following.

FEATURES

- **Field programmable**
- **11 dedicated inputs**
- **2 dedicated outputs**
- **9 bi-directional I/O lines**
- **24 Product Terms**
- **22 OR gates**
- **I/O direction decoded in OR array**
- **Output enable decoded in OR array**
- **I/O propagation delay: 20nSec (max)**
- **Input loading: −100μA (max)**
- **Power dissipation: 700mW (typ)**
- **Security fuse**
- **Testable in unprogrammed state**
- **Output: Programmable as Tri-State or Open Collector.**
- **TTL compatible**

PIN CONFIGURATION

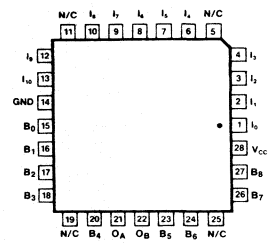
N PACKAGE



CD05290S

N = Plastic

A PACKAGE



CD05300S

A = Plastic Leaded Chip Carrier

LOGIC FUNCTION

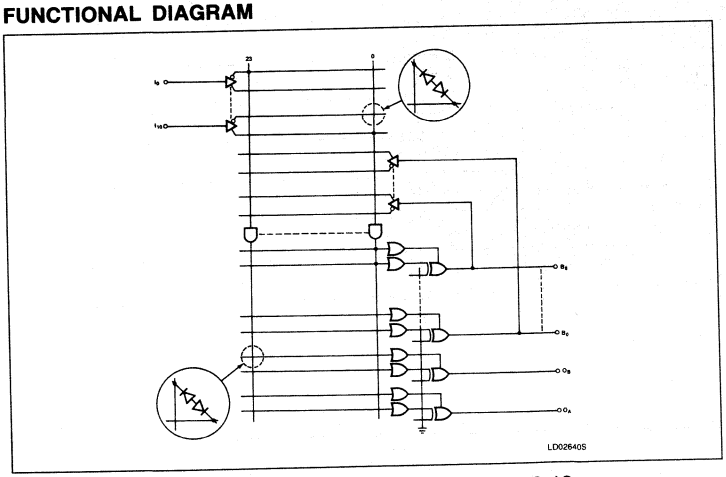
TYPICAL PRODUCT TERM:
$Pn = A \cdot \overline{B} \cdot C \cdot D \cdot \ldots$

TYPICAL LOGIC FUNCTION:
AT OUTPUT POLARITY = H
$Z = P0 + P1 + P2 \ldots$

AT OUTPUT POLARITY = L
$Z = \overline{P0 + P1 + P2 + \ldots}$
$Z = \overline{P0} \cdot \overline{P1} \cdot \overline{P2} \cdot \ldots$

NOTES:
1. For each of the 11 outputs, either function Z (active-high) or $\overline{Z}$ (active-low) is available, but not both. The desired output polarity is programmed via the EX-OR gates.
2. Z, A, B, C, etc. are user defined connections to fixed inputs (I), fixed output pins (O) and bidirectional pins (B).

FUNCTIONAL DIAGRAM



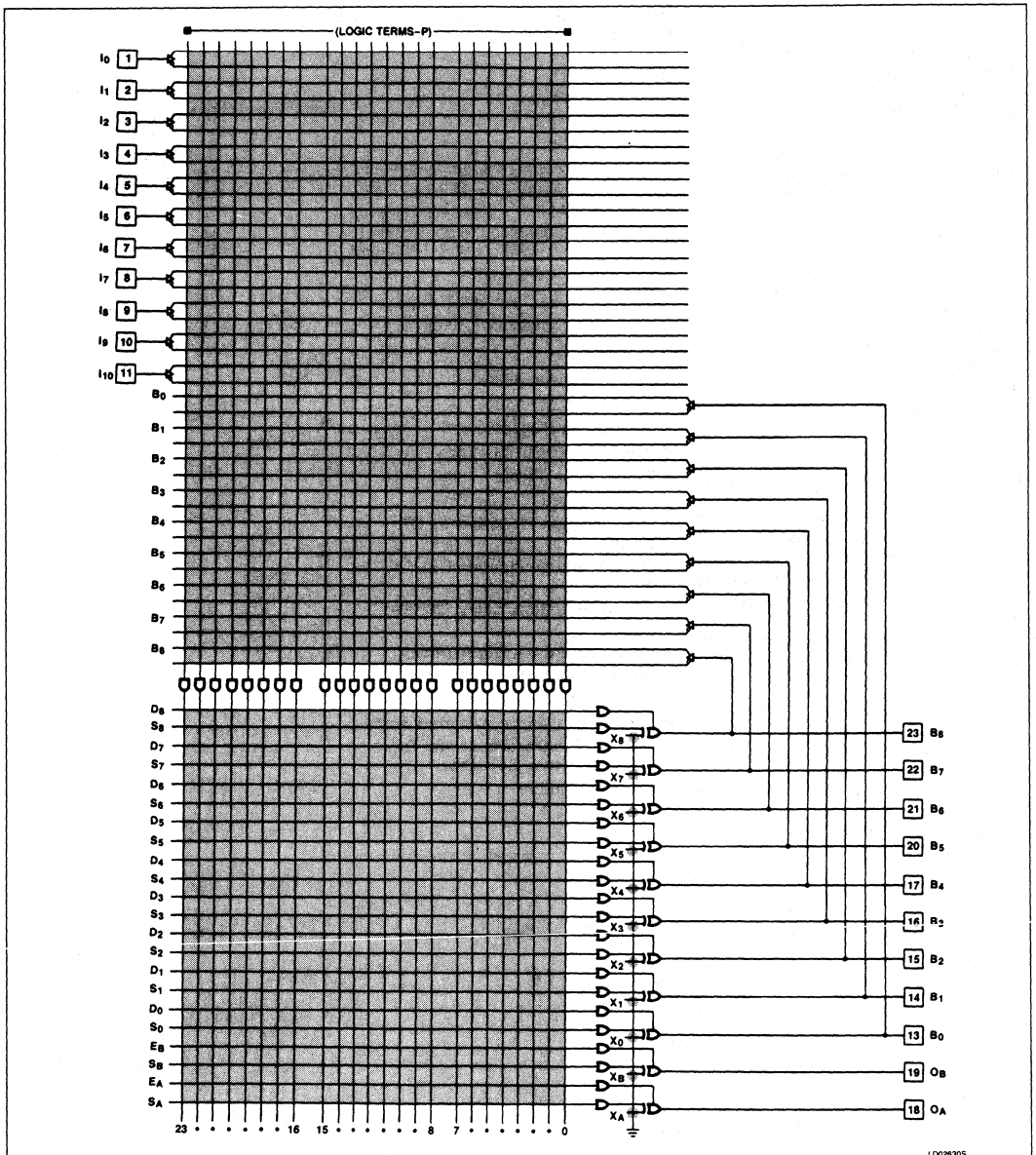
LD02640S

APPLICATIONS

- **Random logic**
- **Code converters**
- **Fault detectors**
- **Function generators**
- **Address mapping**
- **Multiplexing**

Field Programmable Logic Array (20 x 24 x 11) PLHS473

FPLA LOGIC DIAGRAM



NOTES:
1. All unprogrammed or virgin "AND" gate locations are pulled to logic "1".
2. All unprogrammed or virgin "OR" gate locations are pulled to logic "0".
3. ● Programmable connection.

Field Programmable Logic Array (20 x 24 x 11) PLHS473

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 300mil wide 24 pin	PLHS473N
Plastic Leaded Chip Carrier 28 pin	PLHS473A

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING Min	RATING Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input currents	−30	+30	mA
I_{OUT}	Output currents		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	−65	+150	

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq +75°C$, $4.75 \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage[3]						
V_{IL}	Low	V_{CC} = Min			0.80	V
V_{IH}	High	V_{CC} = Max	2.0			
V_{IC}	Clamp[4]	V_{CC} = Min, I_{in} = −12mA		−0.8	−1.2	
Output voltage[3]		V_{CC} = Min				
V_{OL}	Low[5]	I_{OL} = 15mA			0.5	V
V_{OH}	High[6]	I_{OH} = −2mA	2.4			
Input current		V_{CC} = Max				
I_{IL}	Low	V_{IN} = 0.45V			−100	μA
I_{IH}	High	V_{IN} = 5.5V			40	
Output current		V_{CC} = Max				
$I_{O(OFF)}$	Hi-Z State[10]	V_{OUT} = 5.5V			40	μA
		V_{OUT} = .45V			−100	
I_{OS}	Short circuit[4, 6, 7]	V_{OUT} = 0V	−15		−70	mA
I_{CC}	V_{CC} supply current[8]	V_{CC} = Max		140	155	mA
Capacitance		V_{CC} = 5V				
I_{IN}	Input	V_{IN} = 2.0V		8		pF
C_B	I/O	V_B = 2.0V		15		

AC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq +75°C$, $4.75 \leq V_{CC} \leq 5.25V$, $R_1 = 470\Omega$, $R_2 = 1k\Omega$

PARAMETER		TO	FROM	TEST CONDITIONS	LIMITS Min	LIMITS Typ	LIMITS Max	UNIT
T_{PD}	Propagation delay	Output ±	Input ±	C_L = 30pF		15	20	ns
T_{OE}	Output enable	Output −	Input ±			15	20	
T_{OD}	Output disable[9]	Output +	Input ±	C_L = 5pF		15	20	ns

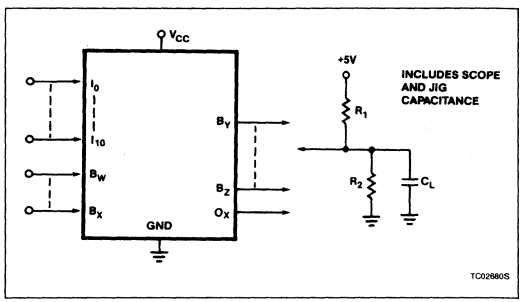
Notes on following page

Field Programmable Logic Array (20 x 24 x 11) PLHS473

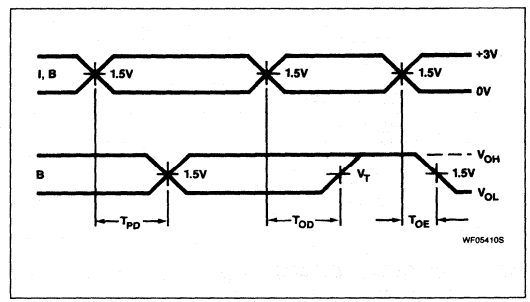
NOTES:

1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other condition above those indicated in the operational and programming specification of the device is not implied.
2. All typical values are at V_{CC} = 5V. T_A = 25°C.
3. All voltage values are with respect to network ground terminal.
4. Test one at a time.
5. Measured with Pins 1 – 5 = 0V, Pins 6, 8 = 4.5V, and Pins 7, 9 – 11 = 10V.
6. Same conditions as Note 5 except Pin 9 = 4.5V.
7. Duration of short circuit should not exceed 1 second.
8. I_{CC} is measured with all inputs and bidirectional pins at 4.5V. Part in Virgin State. .
9. Measured at $V_T = V_{OL} + 0.5V$.
10. Leakage values are a combination of input and output leakage.

TEST LOAD CIRCUIT



TIMING DIAGRAM



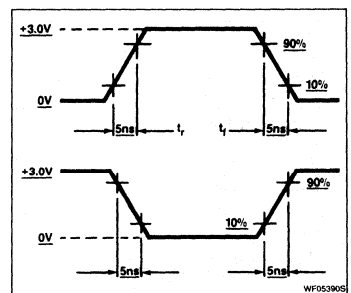
TIMING DEFINITIONS

T_{PD} Propagation delay between input and output.

T_{OD} Delay between input change and when output is off (Hi-Z or High).

T_{OE} Delay between input change and when output reflects specified output level.

VOLTAGE WAVEFORM



MEASUREMENTS:
All circuit delays are measured at the + 1.5V level of inputs and outputs, unless otherwise specified.

Input Pulses

Field Programmable Logic Array (20 x 24 x 11) PLHS473

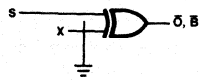
LOGIC PROGRAMMING

The FPLS can be programmed by means of Logic programming equipment.

With Logic programming, the AND/OR/EX-OR gate input connections necessary to implement the desired logic function are coded directly from logic equations using the Program Table on the following page.

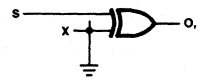
In this table, the logic state of variables I, P, and B associated with each Sum Term S is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

OUTPUT POLARITY - (O, B)



ACTIVE LEVEL	CODE
LOW[1]	L

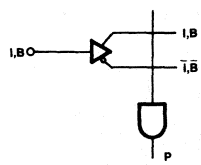
TC02560S



ACTIVE LEVEL	CODE
HIGH	H

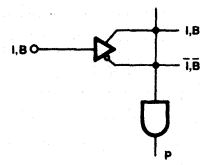
TC02570S

"AND" ARRAY - (I, B)



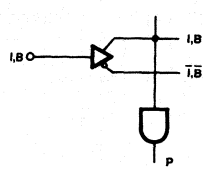
STATE	CODE
DON'T CARE[1]	-

TC02600S



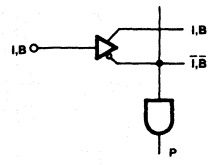
STATE	CODE
INACTIVE[2]	O

TC02630S



STATE	CODE
I, B	H

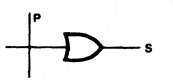
TC02610S



STATE	CODE
Ī, B̄	L

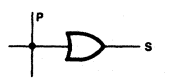
TC02620S

OR ARRAY - (O, B)



P_n STATUS	CODE
INACTIVE[1]	•

TC02580S



P_n STATUS	CODE
ACTIVE	A

TC02590S

NOTES:

1. This is the initial unprogrammed state of all link pairs.
2. Any gate P_n will be unconditionally inhibited if any one of its (I, B) link pairs is programmed for a connection.

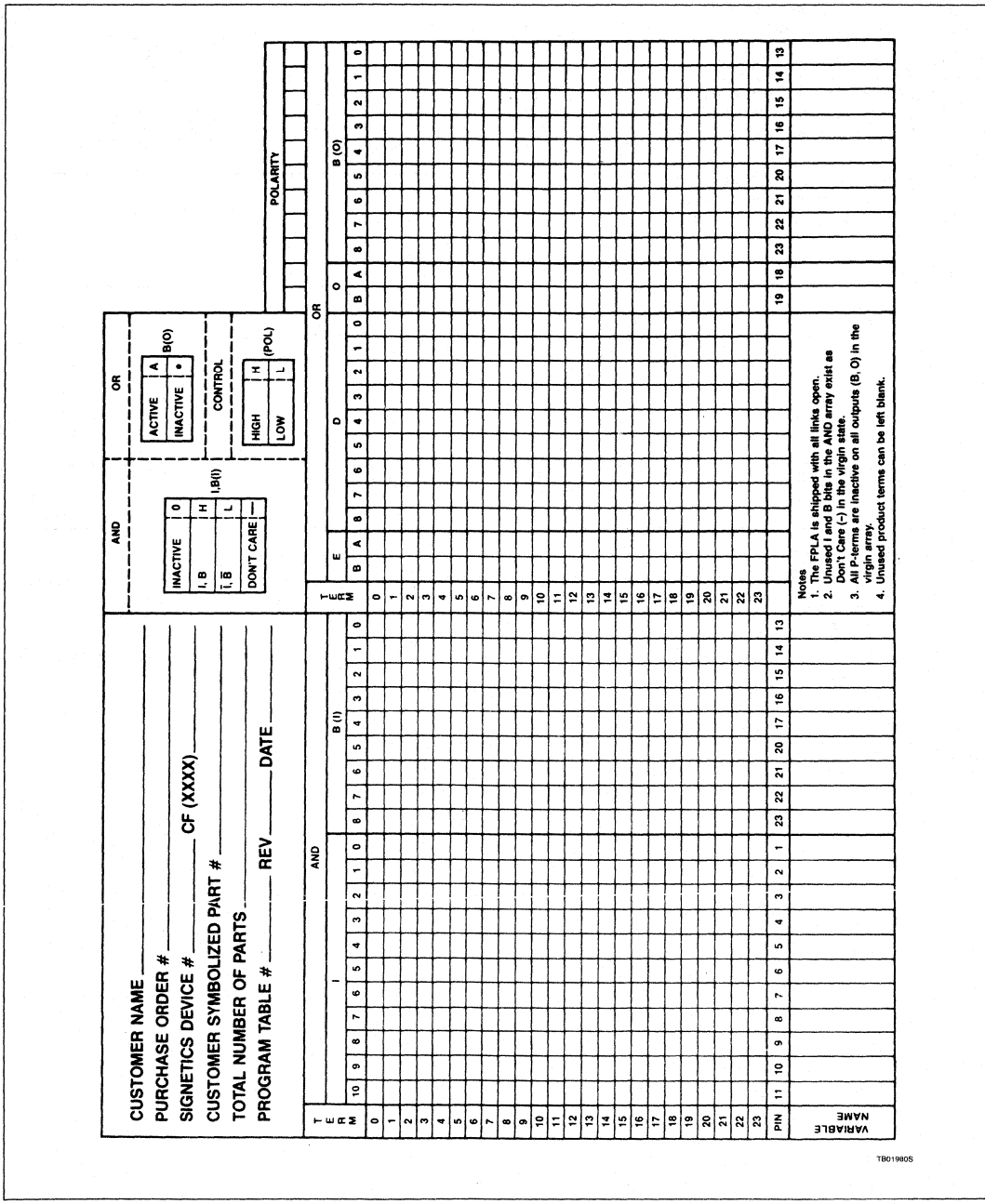
VIRGIN STATE

A factory shipped virgin device contains all fusible links intact, such that:

1. All outputs at "L" polarity.
2. All P_n terms are enabled.
3. All P_n terms are active on all outputs.

Field Programmable Logic Array (20 x 24 x 11) PLHS473

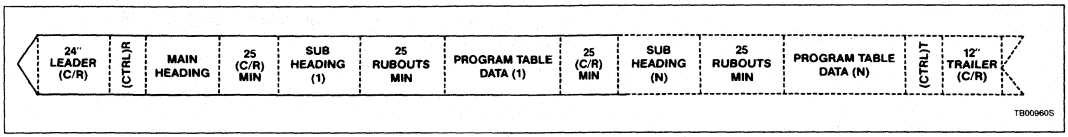
FPLA PROGRAM TABLE



TWX TAPE CODING (LOGIC FORMAT)

The FPLA Program Table can be sent to Signetics in ASCII code format via airmail using any type of 8-level tape (paper, mylar, fanfold, etc.), or via TWX: just dial (910) 339-9283, tell the operator to turn the paper puncher on, and acknowledge. At the end of transmission instruct the operator to send tape to Signetics Order Entry.

A number of Program Tables can be sequentially assembled on a continuous tape as follows, however, limit tape length to a roll of 1.75 inch inside diameter and 4.25 inch outside diameter.



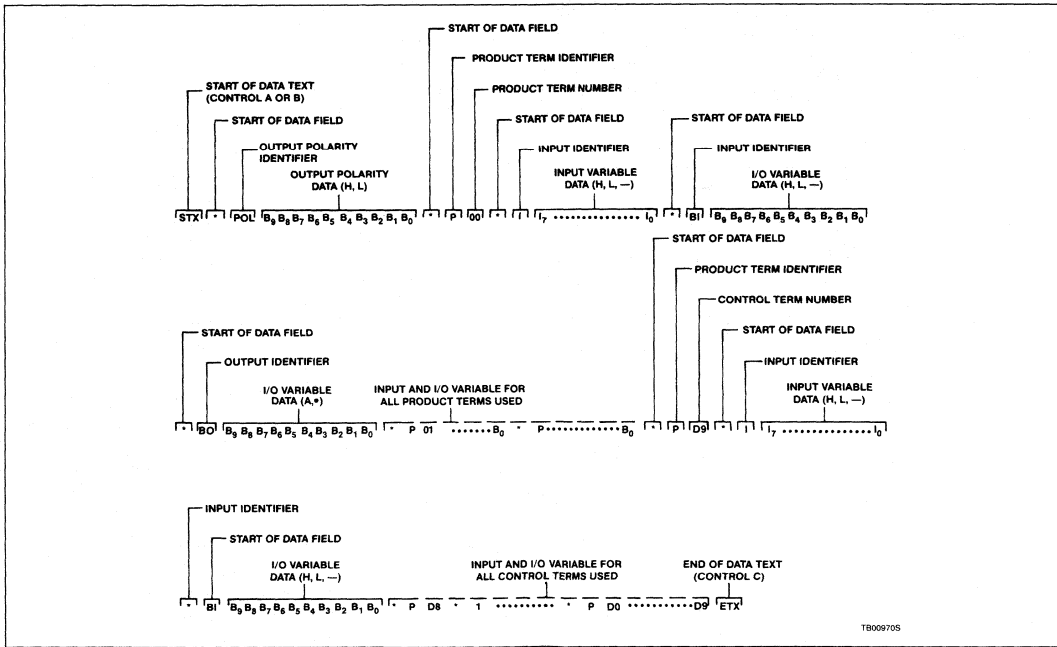
A. The MAIN HEADING at the beginning of tape includes the following information, with each entry preceded by a ($) character, whether used or not:

1. Customer Name
2. Customer TWX No.
3. Date
4. Purchase Order No.
5. Number of Program Tables
6. Total Number of Parts

B. Each SUB HEADING should contain specific information pertinent to each Program Table as follows, with each entry preceded by a ($) character, whether used or not:

1. Signetics Device No.
2. Program Table No.
3. Revision
4. Date
5. Customer Symbolized Part No.
6. Number of Parts

C. Program Table data blocks are initiated with an STX character, and terminated with an ETX character. The body of the data consists of output polarity, product term, and output information separated by appropriate identifiers in accordance with the following format. Entries for the data fields correspond to those defined in the Logic PROGRAM TABLE:



Signetics

PLHS18P8
Programmable AND Array Logic (18 x 72 x 8)

Signetics Programmable Logic
Preliminary Specification

Application Specific Products
- **Series 20**

DESCRIPTION

The PLHS18P8 is a two-level logic element consisting of 72 AND gates and 8 OR gates with fusible connections for programming I/O polarity and direction.

All AND gates are linked to 10 inputs (I) and 8 bidirectional I/O lines (B). These yield variable I/O gate configurations via 8 direction control gates, ranging from 18 inputs to 8 outputs.

On-chip T/C buffers couple either True (I, B) or Complement ($\overline{I}$, $\overline{B}$) input polarities to all AND gates. The 72 AND gates are separated into 8 groups of 9 each. Each group of 9 is associated with one bidirectional pin. In each group, eight of the AND terms are ORed together, while the ninth is used to establish I/O direction. All outputs are individually programmable via an EX-OR gate to allow implementation of AND/OR or NAND/NOR logic functions.

In the virgin state, the AND array fuses are back-to-back CB-EB diode pairs which will act as open connections. Current is avalanched across individual diode pairs during fusing, which essentially short circuits the diode and provides the connection for the associated product term.

The PLHS18P8 is field-programmable, allowing the user to quickly generate custom pattern using standard programming equipment.

Order codes are contained in the pages following.

FEATURES

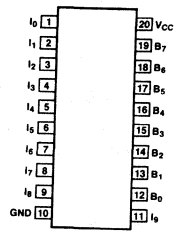
- **100% functionally compatible with AmPAL18P8**
- **Field-programmable**
- **10 inputs**
- **8 bidirectional I/O lines**
- **72 AND gates/product terms – configured into eight groups of nine**
- **Programmable output polarity (Tri-state output)**
- **I/O propagation delay: 15ns (max)**
- **Power dissipation: 750mW (nominal)**
- **TTL compatible**
- **Verify Lock Fuse**

APPLICATIONS

- **100% functional replacement for all 20-pin combinatorial PALs***

PIN CONFIGURATION

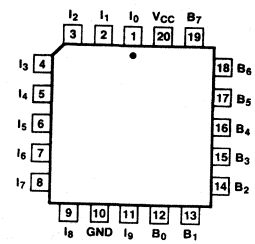
N PACKAGE



CD05320S

N = Plastic

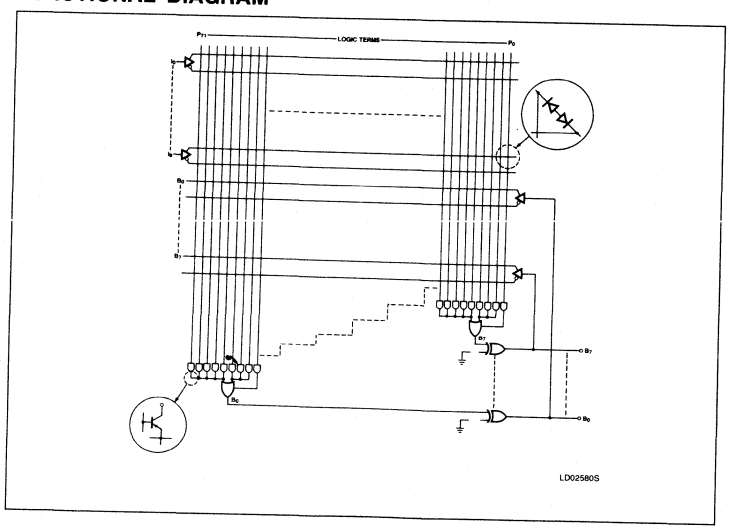
A PACKAGE



CD05330S

A = Plastic Leader Chip Carrier

FUNCTIONAL DIAGRAM



LOGIC FUNCTION

TYPICAL PRODUCT TERM:
$Pn = A \cdot \overline{B} \cdot C \cdot D \cdot \ldots$

TYPICAL LOGIC FUNCTION:

AT OUTPUT POLARITY = H
$Z = P0 + P1 + P2 \ldots$

AT OUTPUT POLARITY = L
$Z = \overline{P0 + P1 + P2} + \ldots$
$Z = \overline{P0} \cdot \overline{P1} \cdot \overline{P2} \cdot \ldots$

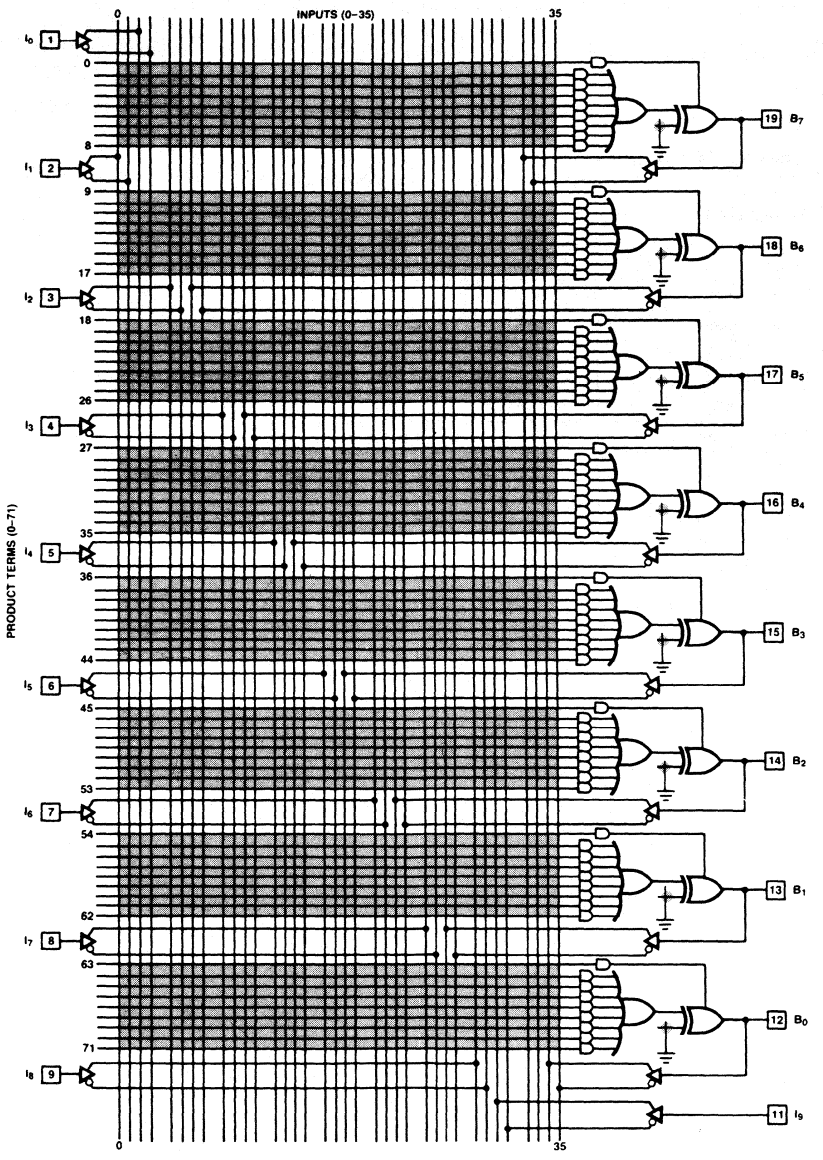
NOTES:
1. For each of the 8 outputs, either function Z (active-high) or $\overline{Z}$ (active-low) is available, but not both. The desired output polarity is programmed via the EX-OR gates.
2. Z, A, B, C, etc. are user defined connections to fixed inputs (I) and bidirectional pins (B).

- **Random logic**
- **Code converters**
- **Fault detectors**
- **Function generators**
- **Address mapping**
- **Multiplexing**

*PAL is a registered trademark of Monolithic Memories, Inc.

Programmable AND Array Logic (18 x 72 x 8) PLHS18P8

LOGIC DIAGRAM



NOTES:
1. All unprogrammed or virgin "AND" gate locations are pulled to logic "1".
2. All unprogrammed or virgin "OR" gate locations are pulled to logic "1".
3. ● Programmable connections.

Programmable AND Array Logic (18 x 72 x 8) PLHS18P8

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 300mil wide 20 pin	PLHS18P8N
Plastic Leaded Chip Carrier 20 pin	PLHS18P8A

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING MIN	RATING MAX	UNIT
V_{CC}	Supply voltage	−0.5	+7	V_{dc}
V_{IN}	Input voltage	−0.5	+5.5	V_{dc}
V_{OUT}	Output voltage	−0.5	V_{CC} max	V_{dc}
V_{OUTPRG}	Output voltage (programming)		+21	V_{dc}
I_{IN}	Input current	−30	+5	mA
I_{OUT}	Output current		+100	mA
I_{OUTPRG}	Output current (programming)		+180	mA
	Temperature range			
T_A	Operating temp	0	+75	°C
T_{STG}	Storage temp	−65	+150	°C

Notes on following page

Programmable AND Array Logic (18 x 72 x 8) PLHS18P8

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq 75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS			UNIT
			Min	Typ[2]	Max	
Input voltage[3]						
V_{IL}	Low	V_{CC} = Min			+0.8	V
V_{IH}	High	V_{CC} = Max	+2.0			
V_I	Clamp	V_{CC} = Min, I_{IN} = −18mA		−0.9	−1.2	
Output voltage		V_{CC} = Min, V_{IN} = V_{IH} or V_{IL}				
V_{OL}	Low	I_{OL} = +24mA			+0.50	V
V_{OH}	High	I_{OH} = −3.2	+2.4	+3.5		
Input current		V_{CC} = Max				
I_{IL}	Low	V_{IN} = +.40V		−20	−250	μA
I_{IH}	High	V_{IN} = +2.7V			+25	μA
I_I	High	V_{IN} = +5.5V			+1.0	mA
Output current		V_{CC} = Max, V_{IL} = 0.8V, V_{IH} = 2.0V				
I_{OZH}	Output leakage	V_{OUT} = +2.7V			+100	μA
I_{OZL}	Output leakage	V_{OUT} = +.40V			−250	μA
I_{SC}	Short Circuit[4]	V_{OUT} = +0.5V	−30	−60	−90	mA
I_{CC}	V_{CC} Current	V_{CC} = Max, All inputs = GND			+155	mA
Capacitance[5]		V_{CC} = +5V				
C_{IN}	Input	V_{IN} = 2.0V @ f = 1Mhz		6		pF
C_{OUT}	I/O	V_{OUT} = 2.0V @ f = 1Mhz		9		pF

NOTES:

1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other condition above those indicated in the operational and programming specification of the device is not implied.
2. Typical limits are at V_{CC} = 5.0V and T_A = 25°C.
3. These are absolute values with respect to device ground and all overshoots due to system or tester noise are included.
4. Not more than one output should be tested at a time. Duration of the short circuit should not be more than one second. V_{OUT} = 0.5V has been chosen to avoid test problems caused by tester ground degradation.
5. These parameters are not 100% tested, but are periodically sampled.

Programmable AND Array Logic (18 × 72 × 8) PLHS18P8

AC ELECTRICAL CHARACTERISTICS $R_1 = 470\Omega$, $R_2 = 1k\Omega$, $0°C \leq T_A \leq +75°C$, $4.75V \leq V_{CC} \leq 5.25V$

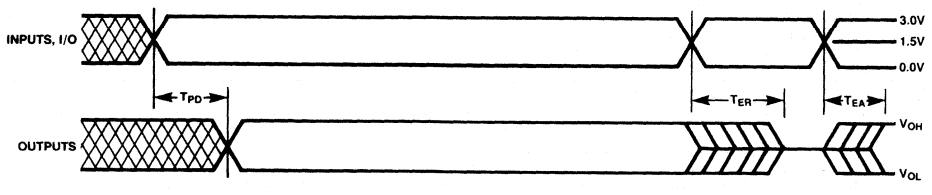
PARAMETER		TO	FROM	TEST CONDITIONS	LIMITS			UNIT
					Min	Typ	Max	
T_{PD}	Propagation delay	Input ±	Output ±	$C_L = 50pF$		8	15	ns
T_{EA}	Output enable	Input ±	Output –	$C_L = 50pF$		8	15	ns
T_{ER}	Output disable	Input ±	Output +	$C_L = 5pF$		8	15	ns

NOTES:
1. Typical limits are at $V_{CC} = 5.0V$ and $T_A = 25°C$.
2. T_{PD} is tested with switch S_1 closed and $C_L = 50pF$.
3. For three-state output; output enable times are tested with $C_L = 50pF$ to the 1.5V level, and S_1 is open for high impedance to HIGH tests and closed for high impedance to LOW tests. Output disable times are tested with $C_L = 5pF$. High to high impedance tests are made to an output voltage of $V_{OH} = -0.5V$ with S_1 open, and LOW to high impedance tests are made to the $V_{OL} = +0.5V$ level with S_1 closed.

VIRGIN STATE

A factory shipped virgin device contains all fusible links open, such that:
1. All outputs are at "L" polarity.
2. All outputs are enabled.
3. All p-terms are enabled.

TIMING DIAGRAM

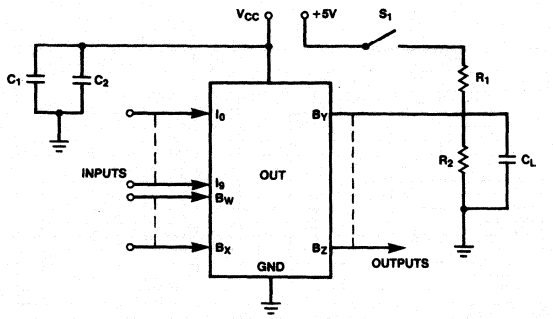


WAVEFORM	INPUTS	OUTPUTS
	MUST BE STEADY	WILL BE STEADY
	DON'T CARE; ANY CHANGE PERMITTED	CHANGING; STATE UNKNOWN
	DOES NOT APPLY	CENTER LINE IS HIGH IMPEDANCE "OFF" STATE

WF07380S

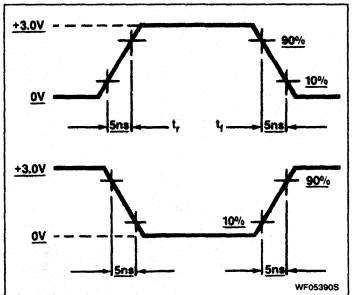
Programmable AND Array Logic (18 x 72 x 8) PLHS18P8

AC TEST LOAD CIRCUIT



NOTE:
C_1 and C_2 are to bypass V_{CC} to GND.

VOLTAGE WAVEFORM



MEASUREMENTS:
All circuit delays are measured at the +1.5V level of inputs and outputs, unless otherwise specified.

Input Pulses

TIMING DEFINITIONS

T_{PD} Input to output propagation delay.
T_{ER} Input to output disable (Tri-state) delay (output disable).
T_{EA} Input to output enable delay (output enable).

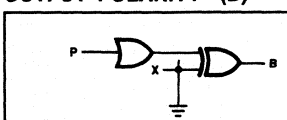
LOGIC PROGRAMMING

The FPLA can be programmed by means of Logic programming equipment.

With Logic programming, the AND/EX-OR gate input connections necessary to implement the desired logic function are coded directly from logic equations using the Program Table on the following page.

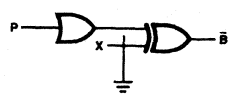
In this Table the logic state of variables I, P, and B associated with each Sum Term, S, is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

OUTPUT POLARITY - (B)



ACTIVE LEVEL	CODE
HIGH	H

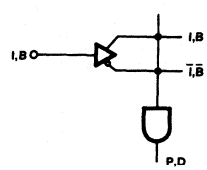
TC02530S



ACTIVE LEVEL	CODE
LOW[1]	L

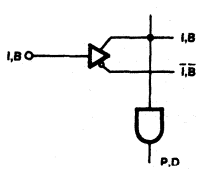
TC02541S

"AND" ARRAY - (I, B)



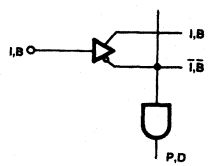
STATE	CODE
INACTIVE[2]	O

TC02650S



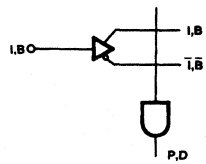
STATE	CODE
I, B	H

TC02660S



STATE	CODE
Ī, B̄	L

TC02670S



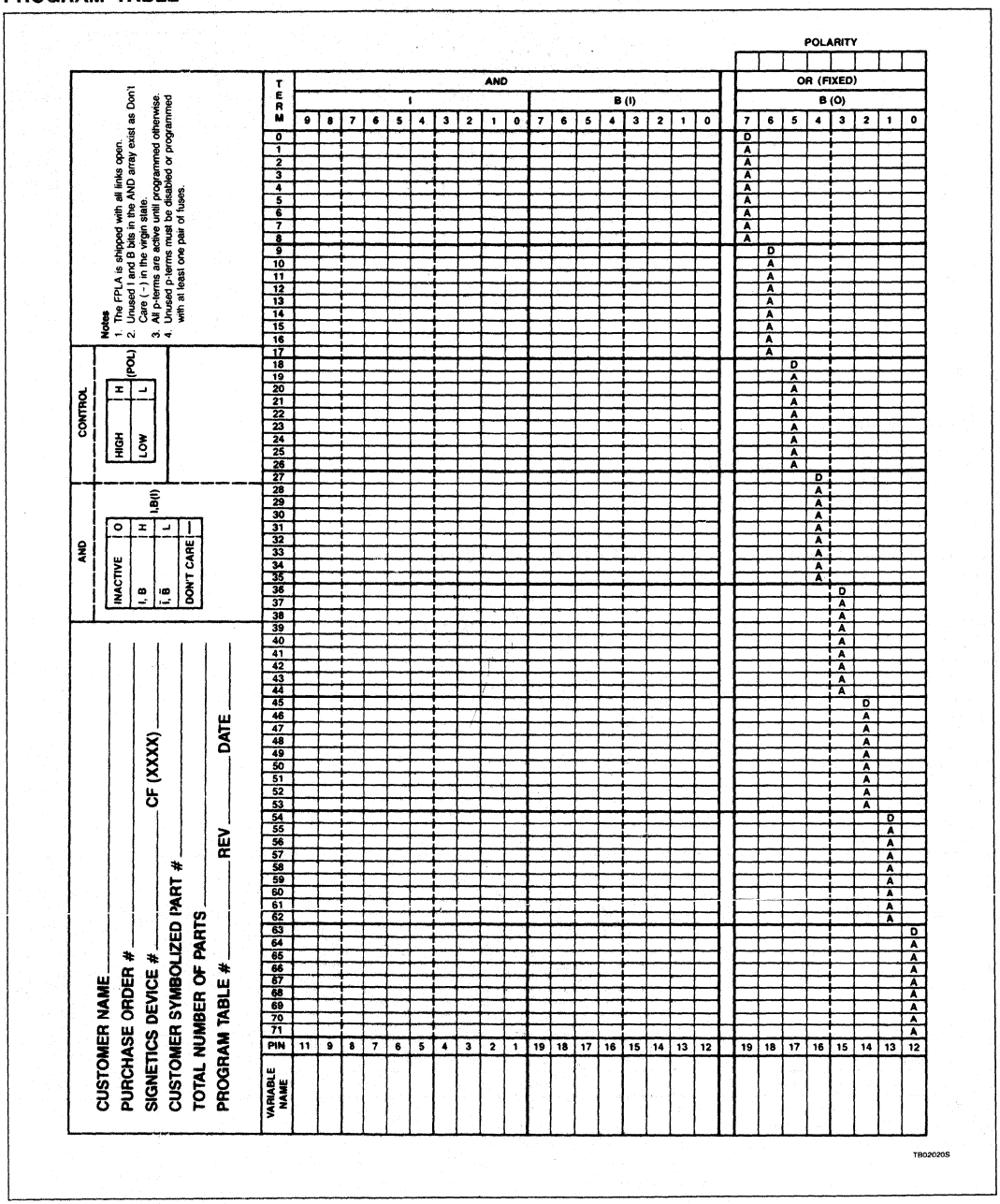
STATE	CODE
DON'T CARE[1]	-

TC02640S

NOTES:
1. This is the initial state of all link pairs.
2. All unused product terms must be programmed with at least one pair of fuses.

Programmable AND Array Logic (18 x 72 x 8) PLHS18P8

PROGRAM TABLE



Signetics

Application Specific Products

Section 4
PLD Data Sheets

4

INDEX

Signetics

PLS151
Field Programmable Gate Array (18 x 15 x 12)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 20**

DESCRIPTION

The PLS151 is a single level logic element, consisting of 15 AND gates with fusible link connections for programming I/O polarity, I/O direction and output enable control.

All gates are linked to 6 inputs (I) and 12 bidirectional I/O lines (B). These yield variable I/O gate configurations via 3 direction control gates (D), ranging from 18 inputs to 12 outputs.

On chip T/C buffers couple either True (I, B) or Complement ($\overline{I}$, $\overline{B}$) input polarities to each AND gate. The polarity of all gate outputs is individually programmable through a set of EX-OR gates for implementing AND/NAND logic functions. Alternately, if desired, OR/NOR logic functions can also be realized by programming for each gate the complement of its inputs and outputs (DeMorgan's Theorem).

The PLS151 is field programmable, enabling the user to quickly generate custom patterns using standard programming equipment.

Order codes are contained on the pages following.

FEATURES

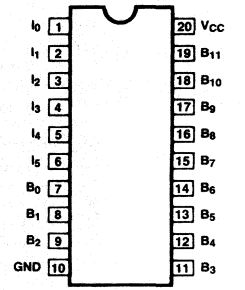
- **Field Programmable (Ni-Cr link)**
- **6 inputs**
- **15 Product Terms:**
  - **12 Logic Terms**
  - **3 Control Terms**
- **12 bidirectional I/O lines**
- **Active high or low outputs**
- **Programmable output enable**
- **Power dissipation: 575mW (typ)**
- **I/O propagation delay: 25ns (max)**
- **Input loading**
  - **PLS151: −100μA (max)**
- **TTL compatible**
- **Tri-state Outputs**

APPLICATIONS

- **Random gating functions**
- **Address decoding**
- **Code detectors**
- **Memory mapped I/O**
- **Fault monitors**
- **I/O port decoders**

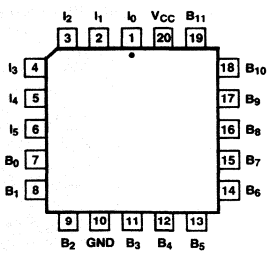
PIN CONFIGURATION

N PACKAGE



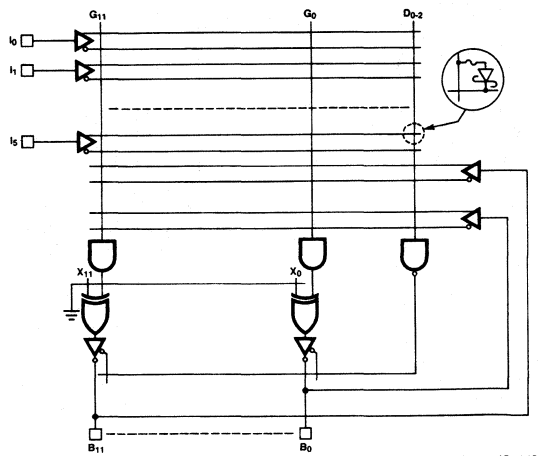
N = Plastic

A PACKAGE



A = Plastic Leaded Chip Carrier

FUNCTIONAL DIAGRAM



All Ni-Cr links are initially intact.

LOGIC FUNCTION

TYPICAL OUTPUT FUNCTIONS:

ACTIVE-HIGH

$X = A \cdot \overline{B} \cdot C \cdot \ldots$

ACTIVE-LOW

$\overline{X} = A \cdot \overline{B} \cdot C \cdot \ldots$

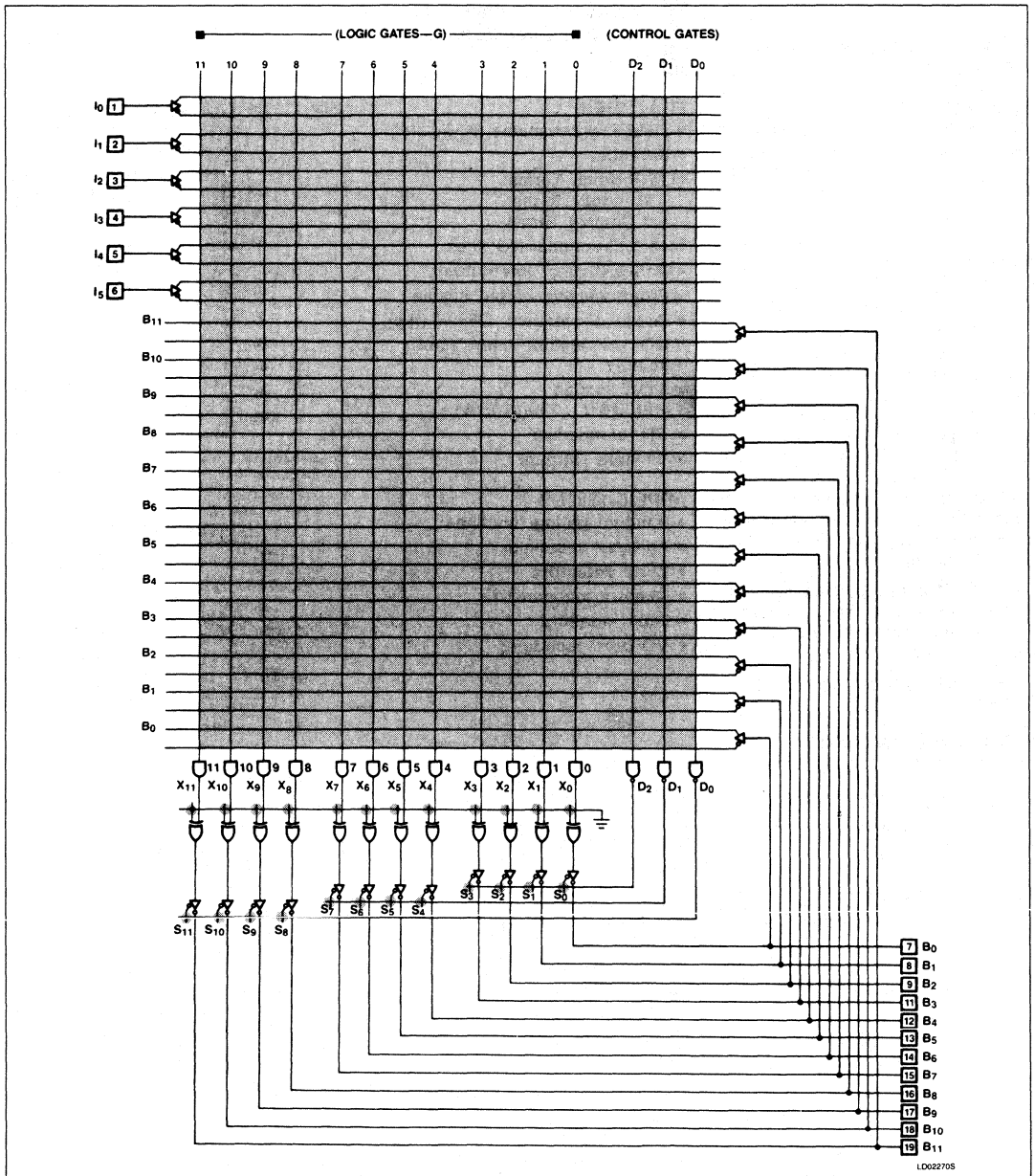
$X = \overline{A} + B + \overline{C} + \ldots$

NOTES:
1. For each of the 12 outputs, either function X (active-high) or $\overline{X}$ (active-low) is available, but not both. The desired output polarity is programmed via the EX-OR gates.
2. X, A, B, C, etc. are user defined connections to fixed inputs (I) and bidirectional pins (B).

4

Field Programmable Gate Array (18 x 15 x 12) PLS151

FPGA LOGIC DIAGRAM



NOTES:
1. All gate inputs with a blown link float to a logic "1".
2. ◍ Programmable connection.

Field Programmable Gate Array (18 x 15 x 12) PLS151

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 300mil 20 pin	PLS151N
Plastic Leaded Chip Carrier 20 pin	PLS151A

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING[1] Min	RATING[1] Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input currents	-30	+30	mA
I_{OUT}	Output currents		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	-65	+150	

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq +75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage[3]						
V_{IL}	Low	V_{CC} = Min			.80	V
V_{IH}	High	V_{CC} = Max	2.0			
V_{IC}	Clamp[3, 4]	V_{CC} = Min, I_{IN} = -12mA		-.8	-1.2	
Output voltage[3]		V_{CC} = Min				
V_{OL}	Low	I_{OL} = 10mA			.5	V
V_{OH}	High	I_{OH} = -2mA	2.4			
Input current		V_{CC} = MAX				
I_{IL}	Low	V_{IN} = 0.45V			-100	μA
I_{IH}	High	V_{IN} = 5.5V			40	
Output current		V_{CC} = Max				
$I_{O(OFF)}$	Hi-Z State	V_{OUT} = 5.5V			80	μA
		V_{OUT} = .45V			-140	
I_{OS}	Short circuit[4, 5]	V_{OUT} = 0V	-15		-70	mA
I_{CC}	V_{CC} supply current	V_{CC} = Max		115	155	mA
Capacitance		V_{CC} = 5V				
C_{IN}	Input	V_{IN} = 2.0V		8		pF
C_B	I/O	V_B = 2.0V		15		

Notes on following page.

AC ELECTRICAL CHARACTERISTICS $R_1 = 470\Omega$, $R_2 = 1k\Omega$, $0°C \leq T_A \leq +75°C$, $4.75V \leq V_{CC} \leq 5.25V$

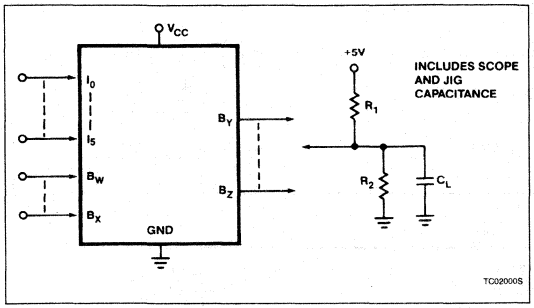
	PARAMETER	TO	FROM	TEST CONDITIONS	LIMITS			UNIT
					Min	Typ[2]	Max	
T_{PD}	Propagation delay	Output ±	Input ±	C_L = 30pF		16	25	ns
T_{OE}	Output enable	Output –	Input ±			17	25	ns
T_{OD}	Output disable[6]	Ouput +	Input ±	C_L = 5pF		17	25	ns

NOTES:

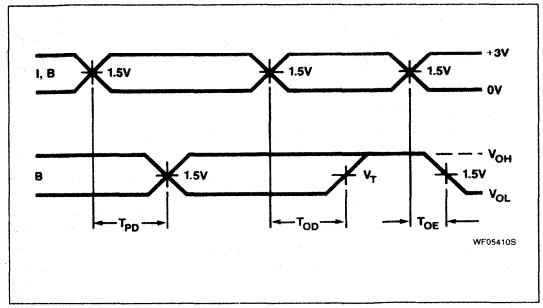
1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other conditions above those indicated in the operational and programming specification of the device is not implied.
2. All typical values are at $V_{CC} = 5V$, $T_A = 25°C$.
3. All voltage values are with respect to network ground terminal.
4. Test one pin at a time.
5. Duration of short circuit should not exceed 1 second.
6. Measured at $V_T = V_{OL} + 0.5V$.

Field Programmable Gate Array (18 x 15 x 12) PLS151

TEST LOAD CIRCUIT



TIMING DIAGRAM



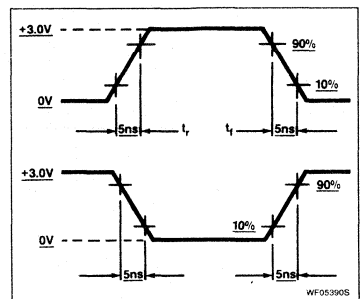
TIMING DEFINITIONS

T_{PD} Propagation delay between input and output.

T_{OD} Delay between input change and when output is off (Hi-Z or High).

T_{OE} Delay between input change and when output reflects specified output level.

VOLTAGE WAVEFORM



MEASUREMENTS:
All circuit delays are measured at the +1.5V level of inputs and outputs, unless otherwise specified.

Input Pulses

4

Field Programmable Gate Array (18 x 15 x 12) PLS151

LOGIC PROGRAMMING

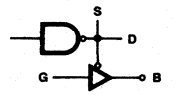
In a virgin device all Ni-Cr links are intact.

The FPGA can be programmed by means of Logic programming equipment.

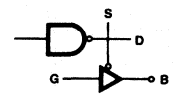
With Logic programming, the AND/EX-OR gate input connections necessary to implement the desired logic function are coded directly from logic equations using the Program Table on the following page.

In this Table the logic state of variables I and B associated with each gate G_n, D_n is assigned a symbol which results in the proper fusing pattern of corresponding links defined as follows:

I/O DIRECTION – (B)

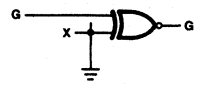


DIRECTION	CODE
I/O	A

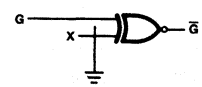


DIRECTION	CODE
INPUT	•

OUTPUT POLARITY – (B)

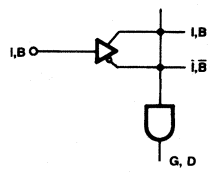


ACTIVE LEVEL	CODE
HIGH	H

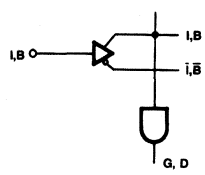


ACTIVE LEVEL	CODE
LOW	L

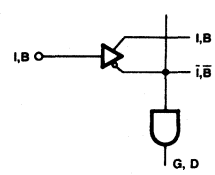
"AND" ARRAY – (I, B)



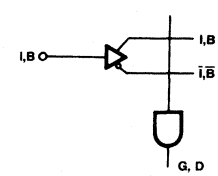
STATE	CODE
INACTIVE[1,2]	O



STATE	CODE
I, B	H



STATE	CODE
$\overline{I}$, $\overline{B}$	L



STATE	CODE
DON'T CARE	-

NOTES:

1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates G_n, D_n.
2. Any gate G_n, D_n will be unconditionally inhibited if any one of the (I, B) link pairs is left intact.

Field Programmable Gate Array (18 x 15 x 12) PLS151

FPGA PROGRAM TABLE

CUSTOMER NAME _____

PURCHASE ORDER # _____

SIGNETICS DEVICE # _____ CF (XXXX) _____

CUSTOMER SYMBOLIZED PART # _____

TOTAL NUMBER OF PARTS _____

PROGRAM TABLE # _____ REV _____ DATE _____

D2 = _____

G0 = _____

G1 = _____

G2 = _____

G3 = _____

D1 = _____

G4 = _____

G5 = _____

G6 = _____

G7 = _____

D0 = _____

G8 = _____

G9 = _____

G10 = _____

G11 = _____

NOTES

1. The FPGA is shipped with all links intact. Thus a background of entries corresponding to states of virgin links exists in the table, shown BLANK for clarity.
2. Unused I and B bits are normally programmed Don't Care (—).
3. Unused Gates can be left blank.
4. Disregard Polarity for Gates used only as inputs.

CONTROL

	(POL.)
HIGH	H
LOW	L

	(DIR.)
I/O	A
INPUT	●

AND

I, B

INACTIVE	0
I, B	H
$\bar{I}$, $\bar{B}$	L
Don't Care	—

PIN	GATE	DIR.	POL.	AND I 5	I 4	I 3	I 2	I 1	I 0	B (I) 11	B (I) 10	B (I) 9	B (I) 8	B (I) 7	B (I) 6	B (I) 5	B (I) 4	B (I) 3	B (I) 2	B (I) 1	B (I) 0
	D2																				
7	00																				
8	01																				
9	02																				
11	03																				
	D1																				
12	04																				
13	05																				
14	06																				
15	07																				
	D0																				
16	08																				
17	09																				
18	10																				
19	11																				
			PIN	6	5	4	3	2	1	19	18	17	16	15	14	13	12	11	9	8	7
	VARIABLE NAME																				

TB01720S

Signetics

PLS153
Field Programmable Logic Array (18 x 42 x 10)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 20**

DESCRIPTION

The PLS153 is a two-level logic element, consisting of 42 AND gates and 10 OR gates with fusible link connections for programming I/O polarity and direction.

All AND gates are linked to 8 inputs (I) and 10 bidirectional I/O lines (B). These yield variable I/O gate configurations via 10 direction control gates (D), ranging from 18 inputs to 10 outputs.

On chip T/C buffers couple either True (I, B) or Complement ($\overline{I}$, $\overline{B}$) input polarities to all AND gates, whose outputs can be optionally linked to all OR gates. Their output polarity, in turn, is individually programmable through a set of EX-OR gates for implementing AND/OR or AND/NOR logic functions.

The PLS153 is field programmable, enabling the user to quickly generate custom patterns using standard programming equipment.

Order codes are contained on the pages following.

FEATURES

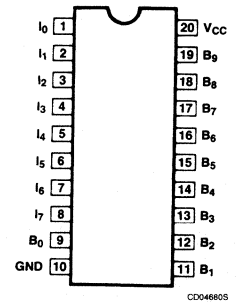
- **Field Programmable (Ni-Cr links)**
- **8 inputs**
- **42 AND gates**
- **10 OR gates**
- **10 bidirectional I/O lines**
- **Active high or low outputs**
- **42 Product Terms:**
  - **32 Logic Terms**
  - **10 Control Terms**
- **I/O propagation delay: 40ns (max)**
- **Input loading: −100μA (max)**
- **Power dissipation: 650mW (typ)**
- **Tri-State Outputs**
- **TTL compatible**

APPLICATIONS

- **Random logic**
- **Code converters**
- **Fault detectors**
- **Function generators**
- **Address mapping**
- **Multiplexing**

PIN CONFIGURATION

N PACKAGE



N = Plastic

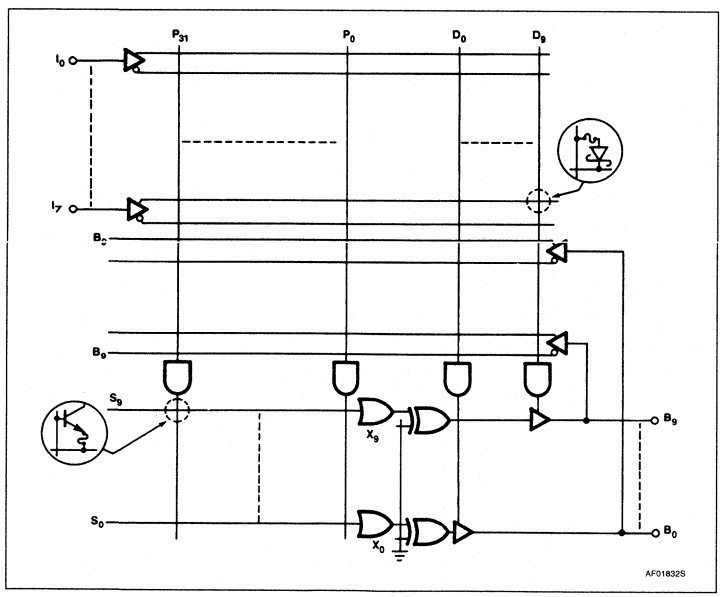
LOGIC FUNCTION

TYPICAL PRODUCT TERM:
$Pn = A \cdot B \cdot C \cdot D \cdot \ldots$
TYPICAL LOGIC FUNCTION:
AT OUTPUT POLARITY = H
$Z = P0 + P1 + P2 \ldots$

AT OUTPUT POLARITY = L
$\overline{Z} = \overline{P0 + P1 + P2 +} \ldots$
$\overline{Z} = \overline{P0} \cdot \overline{P1} \cdot \overline{P2} \cdot \ldots$

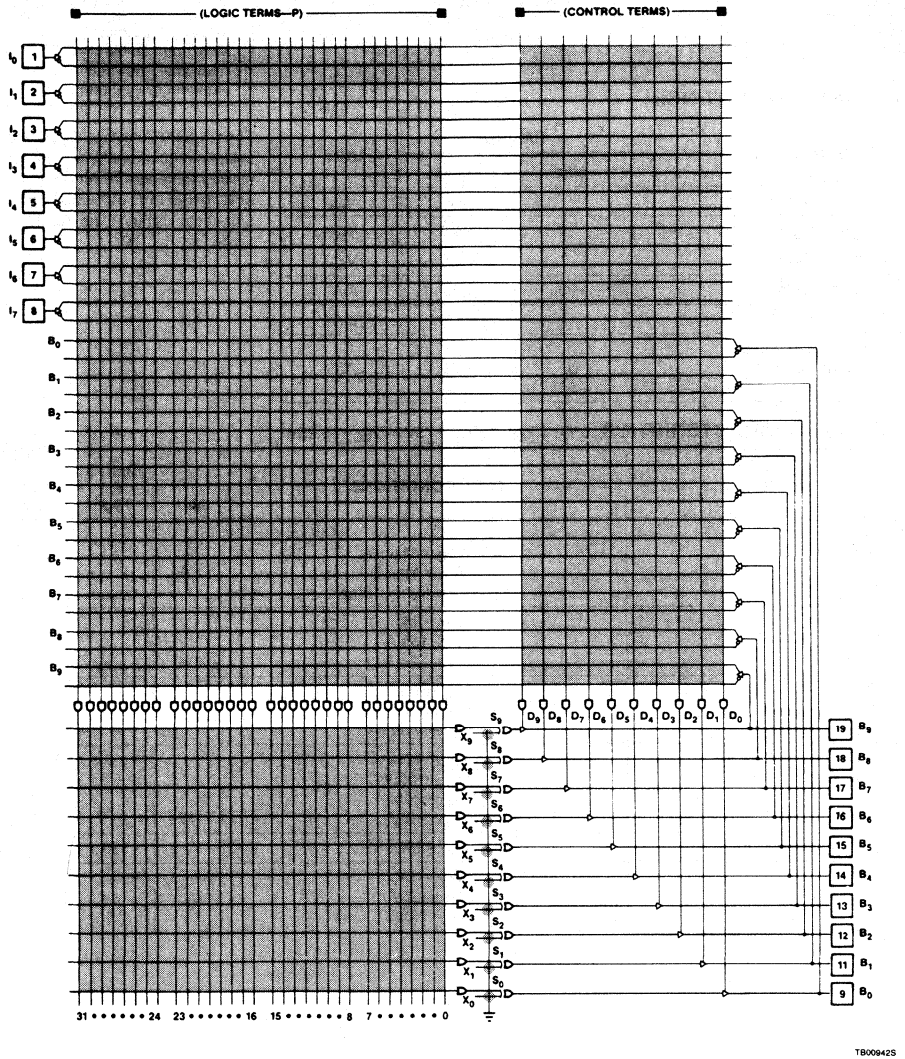
NOTES:
1. For each of the 10 outputs, either function Z (active-high) or $\overline{Z}$ (active-low) is available, but not both. The desired output polarity is programmed via the EX-OR gates.
2. Z, A, B, C, etc. are user defined connections to fixed inputs (I) and bidirectional pins (B).

FUNCTIONAL DIAGRAM



Field Programmable Logic Array (18 x 42 x 10) PLS153

FPLA LOGIC DIAGRAM



NOTES:
1. All programmed "AND" gate locations are pulled to logic "1".
2. All programmed "OR" gate locations are pulled to logic "0".
3. ● Programmable connection.

Field Programmable Logic Array (18 x 42 x 10) PLS153

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 300mil 20 pin	PLS153N

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

The PLS153 device is also processed to military requirements for operation over the military temperature range. For specifications and ordering information consult the Signetics Military Data Book.

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING Min	RATING Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input currents	−30	+30	mA
I_{OUT}	Output currents		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	−65	+150	

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq 75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage[3]						
V_{IL}	Low	V_{CC} = Min			0.80	V
V_{IH}	High	V_{CC} = Max	2.0			
V_{IC}	Clamp[3, 4]	V_{CC} = Min, I_{IN} = −12mA		−.8	−1.2	
Output voltage		V_{CC} = Min				
V_{OL}	Low[3, 5]	I_{OL} = 15mA			0.5	V
V_{OH}	High[3, 6]	I_{OH} = −2mA	2.4			
Input current		V_{CC} = Max				
I_{IL}	Low	V_{IN} = 0.45V			−100	μA
I_{IH}	High	V_{IN} = 5.5V			40	
Output current		V_{CC} = Max				
$I_{O(OFF)}$	Hi-Z State[10]	V_{OUT} = 5.5V			80	μA
		V_{OUT} = .45V			−140	
I_{OS}	Short circuit[4, 6, 7]	V_{OUT} = 0V	−15		−70	mA
I_{CC}	V_{CC} supply current[8]	V_{CC} = Max		130	155	mA
Capacitance		V_{CC} = 5V				
C_{IN}	Input	V_{IN} = 2.0V		8		pF
C_B	I/O	V_B = 2.0V		15		

Notes on following page

Field Programmable Logic Array (18 x 42 x 10) PLS153

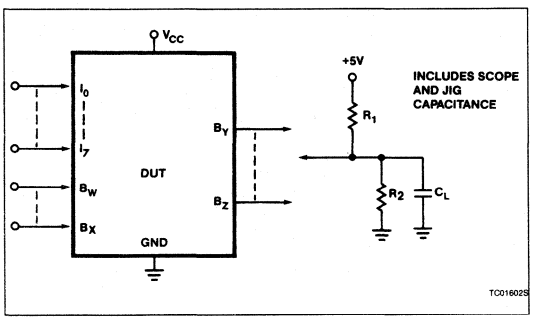
AC ELECTRICAL CHARACTERISTICS $R_1 = 470\Omega$, $R_2 = 1k\Omega$, $0°C \leq T_A \leq +75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TO	FROM	TEST CONDITIONS	LIMITS			UNIT
					Min	Typ[2]	Max	
T_{PD} T_{OE}	Propagation delay Output enable	Output ± Output –	Input ± Input ±	C_L = 30pF		30 25	40 35	ns
T_{OD}	Output disable[9]	Output +	Input ±	C_L = 5pF		25	35	ns

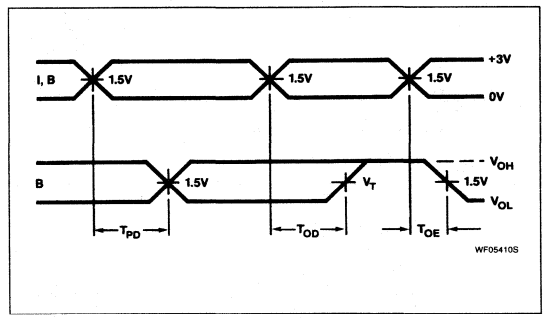
NOTES:
1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other conditions above those indicated in the operational and programming specification of the device is not implied.
2. All typical values are at $V_{CC} = 5V$, $T_A = 25°C$
3. All voltage values are with respect to network ground terminal.
4. Test one at a time.
5. Measured with +10V applied to I_7.
6. Measured with +10V applied to I_{0-7}. Output sink current is supplied thru a resistor to V_{CC}.
7. Duration of short circuit should not exceed 1 second.
8. I_{CC} is measured with I_0, I_1 at 0V, $I_2 - I_7$ and B_{0-9} at 4.5V.
9. Measured at $V_T = V_{OL} + 0.5V$.
10. Leakage values are a combination of input and output leakage.

4

TEST LOAD CIRCUIT



TIMING DIAGRAM



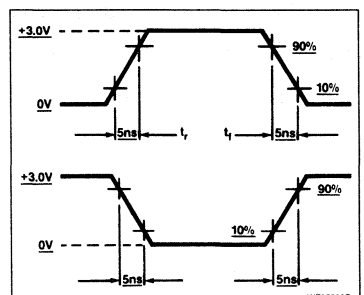
TIMING DEFINITIONS

T_{PD} Propagation delay between input and output.

T_{OD} Delay between input change and when output is off (Hi-Z or High).

T_{OE} Delay between input change and when output reflects specified output level.

VOLTAGE WAVEFORM



MEASUREMENTS:
All circuit delays are measured at the +1.5V level of inputs and outputs, unless otherwise specified.

Input Pulses

Field Programmable Logic Array (18 x 42 x 10) PLS153

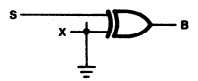
LOGIC PROGRAMMING

The FPLA can be programmed by means of Logic programming equipment.

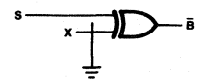
With Logic programming, the AND/OR/EX-OR gate input connections necessary to implement the desired logic function are coded directly from logic equations using the Program Table on the following page.

In this Table the logic state of variables I, P, and B associated with each Sum Term S is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

OUTPUT POLARITY – (B)

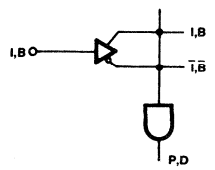


ACTIVE LEVEL	CODE
HIGH	H

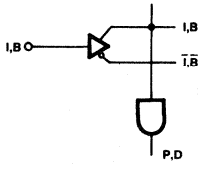


ACTIVE LEVEL	CODE
LOW	L

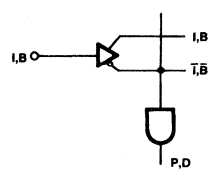
"AND" ARRAY – (I, B)



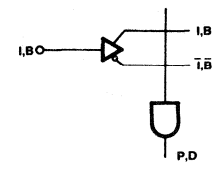
STATE	CODE
INACTIVE[1,2]	O



STATE	CODE
I, B	H

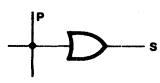


STATE	CODE
Ī, B̄	L

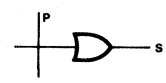


STATE	CODE
DON'T CARE	-

OR ARRAY – (B)



P_n STATUS	CODE
ACTIVE	A



P_n STATUS	CODE
INACTIVE	•

NOTES:

1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates P_n, D_n.
2. Any gate P_n, D_n will be unconditionally inhibited if any one of its (I, B) link pairs is left intact.

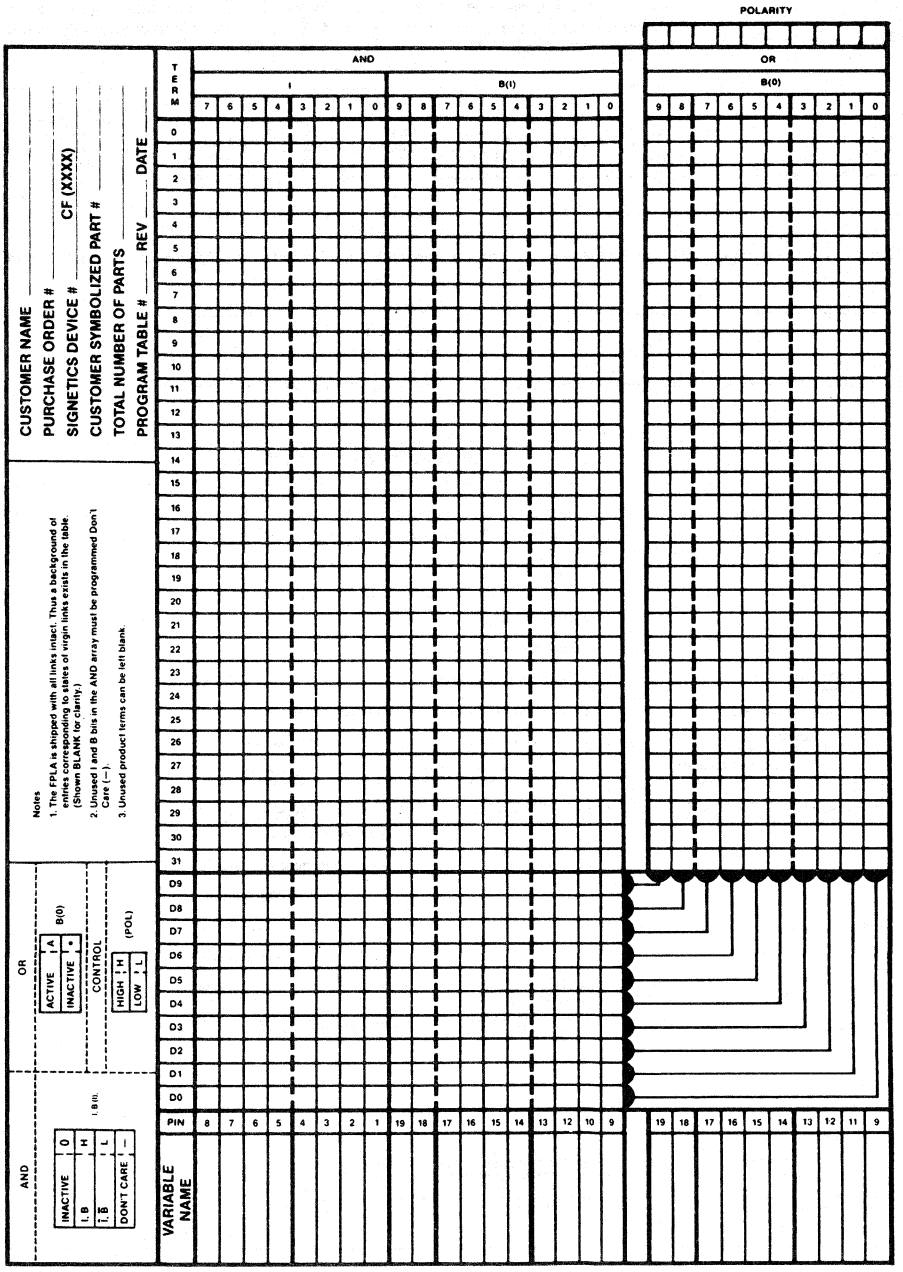
VIRGIN STATE

A factory shipped virgin device contains all fusible links intact, such that:

1. All outputs at "H" polarity.
2. All P_n terms are disabled.
3. All P_n terms are active on all outputs.

Field Programmable Logic Array (18 x 42 x 10) PLS153

FPLA PROGRAM TABLE

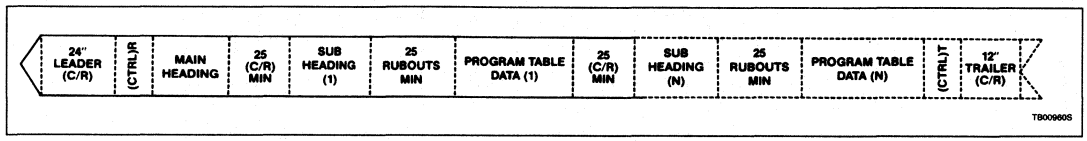


TB00952S

TWX TAPE CODING (LOGIC FORMAT)

The FPLA Program Table can be sent to Signetics in ASCII code format via airmail using any type of 8-level tape (paper, mylar, fanfold, etc.), or via TWX: just dial (910) 339-9283, tell the operator to turn the paper puncher on, and acknowledge. At the end of transmission instruct the operator to send tape to Signetics Order Entry.

A number of Program Tables can be sequentially assembled on a continuous tape as follows, however, limit tape length to a roll of 1.75 inch inside diameter and 4.25 inch outside diameter.



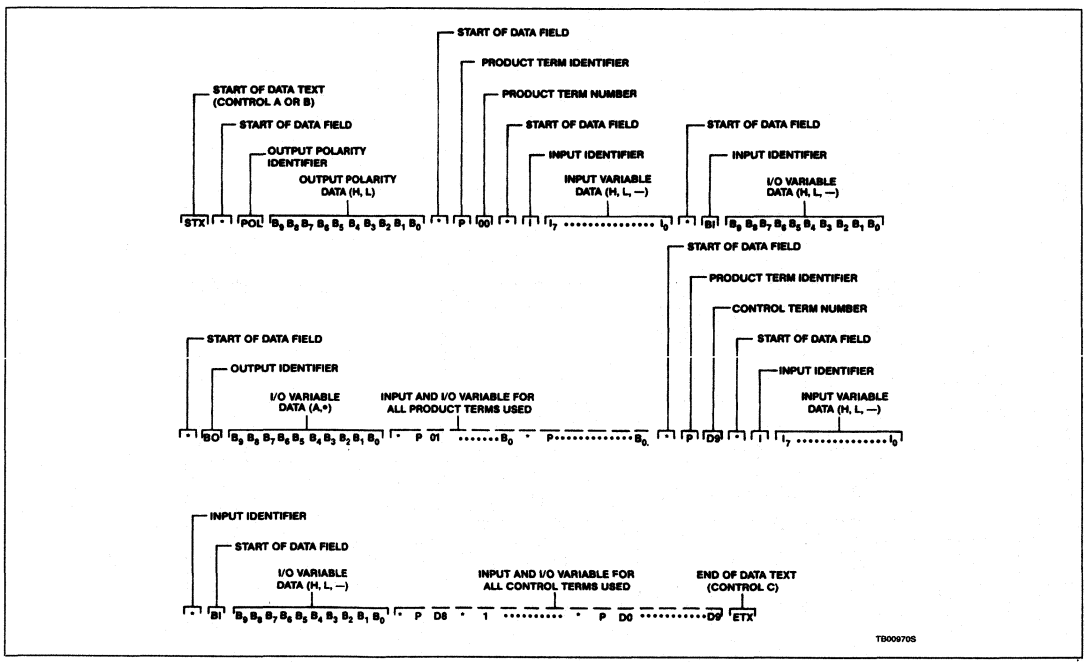
A. The MAIN HEADING at the beginning of tape includes the following information, with each entry preceded by a ($) character, whether used or not:

1. Customer Name
2. Customer TWX No.
3. Date
4. Purchase Order No.
5. Number of Program Tables
6. Total Number of Parts

B. Each SUB HEADING should contain specific information pertinent to each Program Table as follows, with each entry preceded by a ($) character, whether used or not:

1. Signetics Device No.
2. Program Table No.
3. Revision
4. Date
5. Customer Symbolized Part No.
6. Number of Parts

C. Program Table data blocks are initiated with an STX character, and terminated with an ETX character. The body of the data consists of output polarity, product term, and output information separated by appropriate identifiers in accordance with the following format. Entries for the data fields correspond to those defined in the Logic PROGRAM TABLE:



Signetics

PLS153A
Field Programmable Logic Array (18 x 42 x 10)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 20**

DESCRIPTION

The PLS153A is a two-level logic elements, consisting of 42 AND gates and 10 OR gates with fusible link connections for programming I/O polarity and direction.

All AND gates are linked to 8 inputs (I) and 10 bidirectional I/O lines (B). These yield variable I/O gate configurations via 10 direction control gates (D), ranging from 18 inputs to 10 outputs.

On chip T/C buffers couple either True (I, B) or Complement ($\overline{I}$, $\overline{B}$) input polarities to all AND gates, whose outputs can be optionally linked to all OR gates. Their output polarity, in turn, is individually programmable through a set of EX-OR gates for implementing AND/OR or AND/NOR logic functions.

The PLS153A is field programmable, enabling the user to quickly generate custom patterns using standard programming equipment.

Order codes are contained on the pages following.

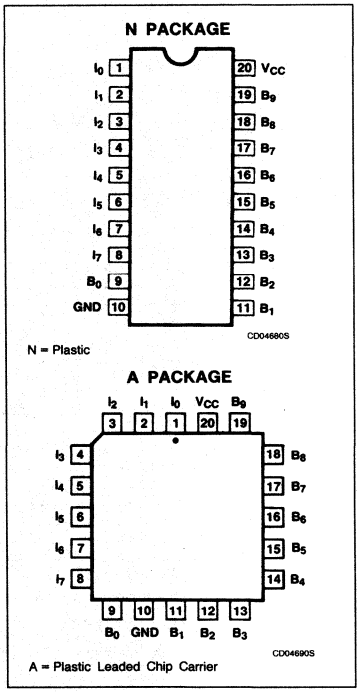
FEATURES

- **Field Programmable (Ni-Cr links)**
- **8 inputs**
- **42 AND gates**
- **10 OR gates**
- **10 bidirectional I/O lines**
- **Active high or low outputs**
- **42 Product Terms:**
  - **32 Logic Terms**
  - **10 Control Terms**
- **I/O propagation delay: 30ns (max)**
- **Input loading: −100μA (max)**
- **Power dissipation: 650mW (typ)**
- **Tri-State Outputs**
- **TTL compatible**

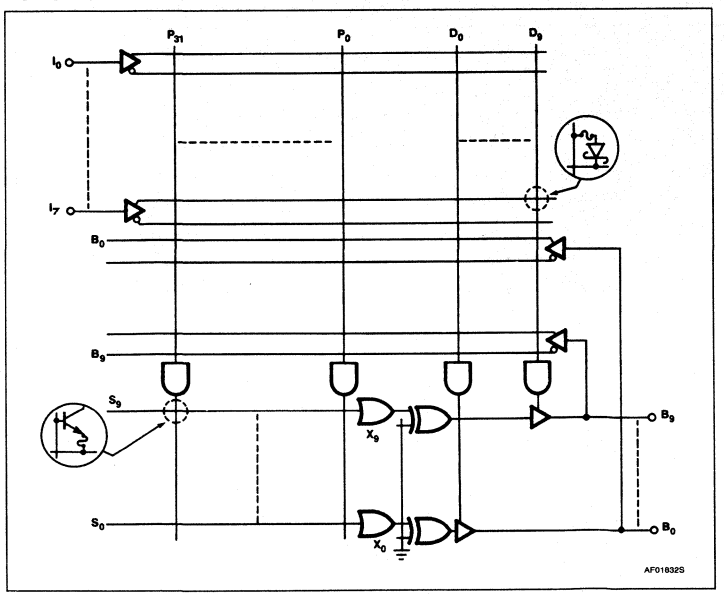
APPLICATIONS

- **Random logic**
- **Code converters**
- **Fault detectors**
- **Function generators**
- **Address mapping**
- **Multiplexing**

PIN CONFIGURATION



FUNCTIONAL DIAGRAM



LOGIC FUNCTION

TYPICAL PRODUCT TERM:
$Pn = A \cdot B \cdot C \cdot D \cdot \ldots$
TYPICAL LOGIC FUNCTION:
AT OUTPUT POLARITY = H
$Z = P0 + P1 + P2 \ldots$

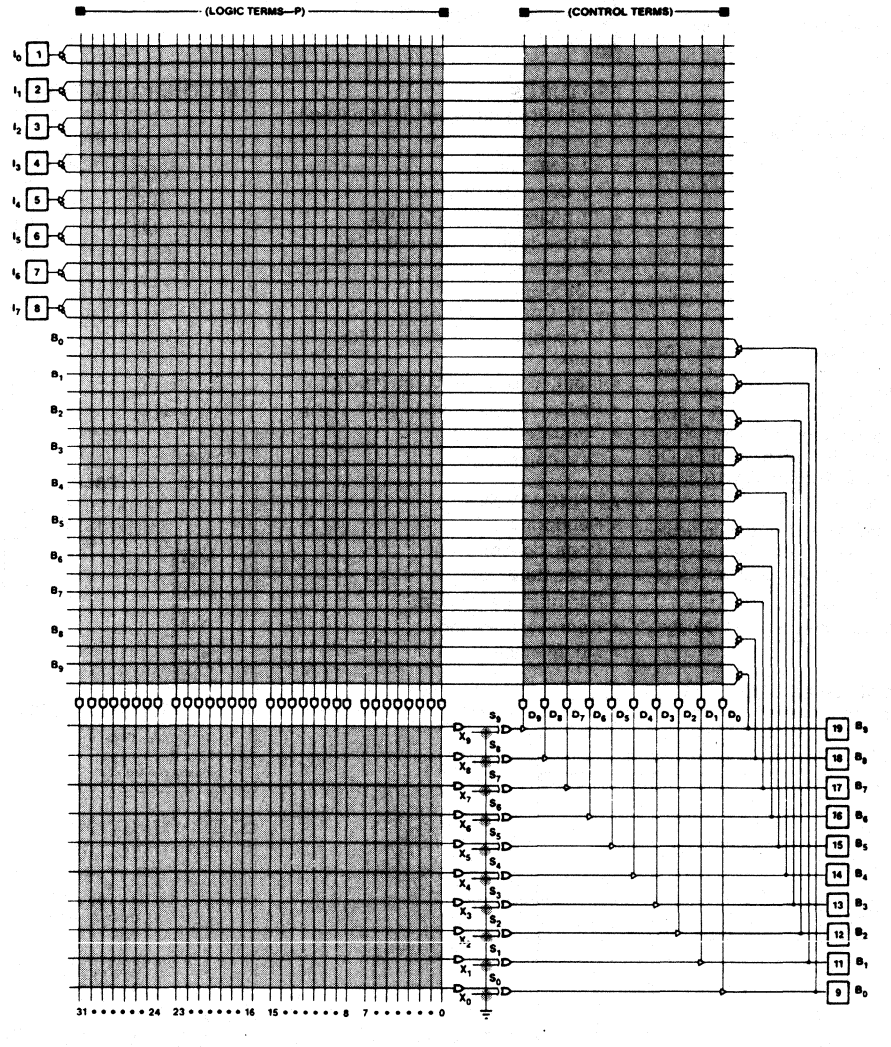
AT OUTPUT POLARITY = L
$\overline{Z} = \overline{P0} + \overline{P1} + \overline{P2} + \ldots$
$Z = \overline{P0} \cdot \overline{P1} \cdot \overline{P2} \ldots$

NOTES:
1. For each of the 10 outputs, either function Z (active-high) or $\overline{Z}$ (active-low) is available, but not both. The desired output polarity is programmed via the EX-OR gates.
2. Z, A, B, C, etc. are user defined connections to fixed inputs (I) and bidirectional pins (B).

4

Field Programmable Logic Array (18 x 42 x 10) PLS153A

FPLA LOGIC DIAGRAM



NOTES:
1. All programmed "AND" gate locations are pulled to logic "1".
2. All programmed "OR" gate locations are pulled to logic "0".
3. ◌ Programmable connection.

Field Programmable Logic Array (18 x 42 x 10) PLS153A

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 300mil 20 pin	PLS153AN
Plastic Leaded Chip Carrier 20 pin	PLS153AA

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING Min	RATING Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input currents	−30	+30	mA
I_{OUT}	Output currents		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	−65	+150	

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq 75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage[3]						
V_{IL}	Low	V_{CC} = Min			0.80	V
V_{IH}	High	V_{CC} = Max	2.0			
V_{IC}	Clamp[3, 4]	V_{CC} = Min, I_{IN} = −12mA		−0.8	−1.2	
Output voltage		V_{CC} = Min				
V_{OL}	Low[3, 5]	I_{OL} = 15mA			0.5	V
V_{OH}	High[3, 6]	I_{OH} = −2mA	2.4			
Input current		V_{CC} = Max				
I_{IL}	Low	V_{IN} = 0.45V			−100	μA
I_{IH}	High	V_{IN} = 5.5V			40	
Output current		V_{CC} = Max				
$I_{O(OFF)}$	Hi-Z State[10]	V_{OUT} = 5.5V			80	μA
		V_{OUT} = .45V			−140	
I_{OS}	Short circuit[4, 6, 7]	V_{OUT} = 0V	−15		−70	mA
I_{CC}	V_{CC} supply current[8]	V_{CC} = Max		130	155	mA
Capacitance		V_{CC} = 5V				
C_{IN}	Input	V_{IN} = 2.0V		8		pF
C_B	I/O	V_B = 2.0V		15		

Notes on following page.

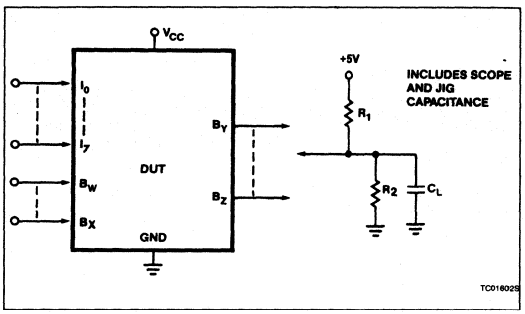
Field Programmable Logic Array (18 x 42 x 10) PLS153A

AC ELECTRICAL CHARACTERISTICS $R_A = 470\Omega$, $R_2 = 1k\Omega$, $0°C \leq T_A \leq +75°C$, $4.75V \leq V_{CC} \leq 5.25V$

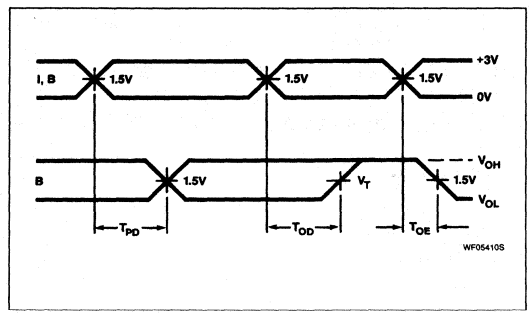
PARAMETER		TO	FROM	TEST CONDITIONS	LIMITS			UNIT
					Min	Typ[2]	Max	
T_{PD}	Propagation delay	Output ±	Input ±	C_L = 30pF		20	30	ns
T_{OE}	Output enable	Output –	Input ±			20	30	
T_{OD}	Output disable[9]	Output +	Input ±	C_L = 5pF		20	30	ns

NOTES:
1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other conditions above those indicated in the operational and programming specification of the device is not implied.
2. All typical values are at V_{CC} = 5V, T_A = 25°C
3. All voltage values are with respect to network ground terminal.
4. Test one at a time.
5. Measured with +10V applied to I_7.
6. Measured with +10V applied to I_{0-7}. Output sink current is supplied thru a resistor to V_{CC}.
7. Duration of short circuit should not exceed 1 second.
8. I_{CC} is measured with $I_{0,1}$ at 0V and I_{2-7} and B_{0-9} at 4.5V.
9. Measured at $V_T = V_{OL} + 0.5V$.
10. Leakage values are a combination of input and output leakage.

TEST LOAD CIRCUIT



TIMING DIAGRAM



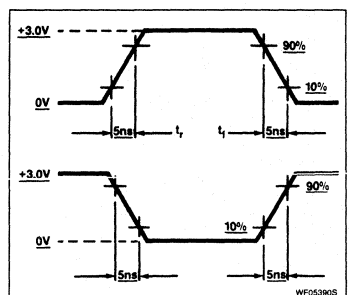
TIMING DEFINITIONS

T_{PD} Propagation delay between input and output.

T_{OD} Delay between input change and when output is off (Hi-Z or High).

T_{OE} Delay between input change and when output reflects specified output level.

VOLTAGE WAVEFORM



MEASUREMENTS:
All circuit delays are measured at the +1.5V level of inputs and outputs, unless otherwise specified.

Input Pulses

Field Programmable Logic Array (18 x 42 x 10) PLS153A

LOGIC PROGRAMMING

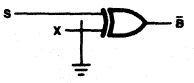
The FPLA can be programmed by means of Logic programming equipment.

With Logic programming, the AND/OR/EX-OR gate input connections necessary to implement the desired logic function are coded directly from logic equations using the Program Table on the following page.

In this Table the logic state of variables I, P, and B associated with each Sum Term S is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

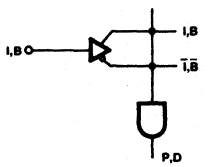
OUTPUT POLARITY - (B)

ACTIVE LEVEL	CODE
HIGH	H

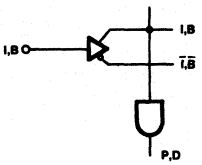


ACTIVE LEVEL	CODE
LOW	L

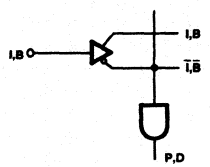
"AND" ARRAY - (I, B)



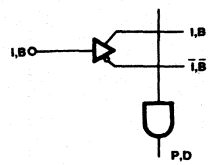
STATE	CODE
INACTIVE[1,2]	O



STATE	CODE
I, B	H

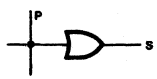


STATE	CODE
Ī, B̄	L

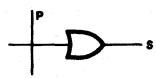


STATE	CODE
DON'T CARE	-

OR ARRAY - (B)



P_n STATUS	CODE
ACTIVE	A



P_n STATUS	CODE
INACTIVE	•

NOTES:

1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates P_n, D_n.
2. Any gate P_n, D_n will be unconditionally inhibited if any one of its (I, B) link pairs is left intact.

VIRGIN STATE

A factory shipped virgin device contains all fusible links intact, such that:

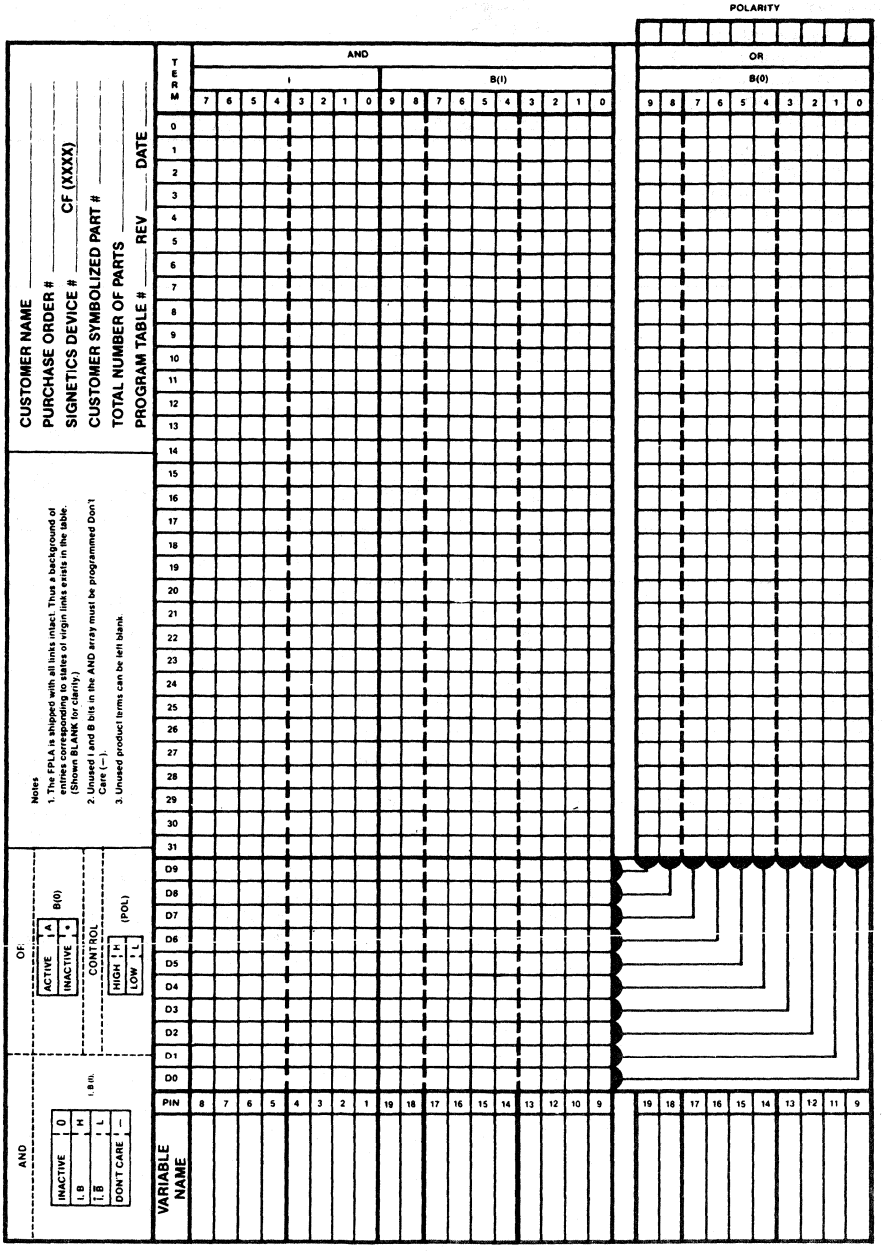
1. All outputs at "H" polarity.
2. All P_n terms are disabled.
3. All P_n terms are active on all outputs.

CAUTION: PLS153A TEST COLUMNS

The PLS153A incorporates two columns not shown in the logic block diagram. These columns are used for in-house testing of the device in the unprogrammed state. These columns must be disabled prior to using the PLS153A in your application. If you are using a Signetics approved programmer the disabling is accomplished during the device programming sequence. If these columns are not disabled, abnormal operation is possible.

Field Programmable Logic Array (18 x 42 x 10) PLS153A

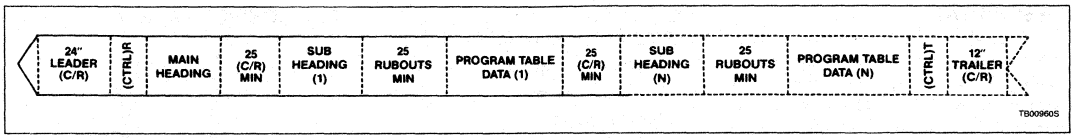
FPLA PROGRAM TABLE



TWX TAPE CODING (LOGIC FORMAT)

The FPLA Program Table can be sent to Signetics in ASCII code format via airmail using any type of 8-level tape (paper, mylar, fanfold, etc.), or via TWX: just dial (910) 339-9283, tell the operator to turn the paper puncher on, and acknowledge. At the end of transmission instruct the operator to send tape to Signetics Order Entry.

A number of Program Tables can be sequentially assembled on a continuous tape as follows, however, limit tape length to a roll of 1.75 inch inside diameter and 4.25 inch outside diameter.



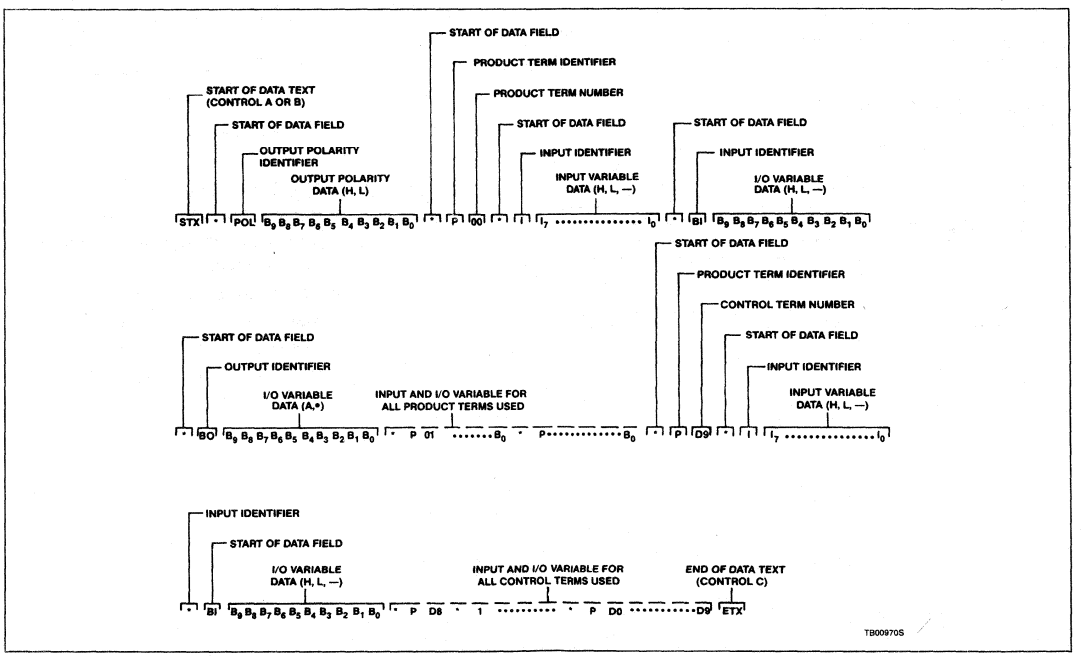
A. The MAIN HEADING at the beginning of tape includes the following information, with each entry preceded by a ($) character, whether used or not:

1. Customer Name
2. Customer TWX No.
3. Date
4. Purchase Order No.
5. Number of Program Tables
6. Total Number of Parts

B. Each SUB HEADING should contain specific information pertinent to each Program Table as follows, with each entry preceded by a ($) character, whether used or not:

1. Signetics Device No.
2. Program Table No.
3. Revision
4. Date
5. Customer Symbolized Part No.
6. Number of Parts

C. Program Table data blocks are initiated with an STX character, and terminated with an ETX character. The body of the data consists of output polarity, product term, and output information separated by appropriate identifiers in accordance with the following format. Entries for the data fields correspond to those defined in the Logic PROGRAM TABLE:



Signetics

PLS155
Field Programmable Logic Sequencer (16 x 45 x 12)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 20**

DESCRIPTION

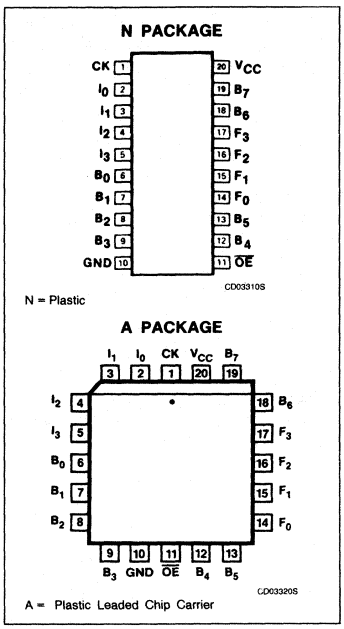
The PLS155 is a Three-State output, registered logic element combining AND/OR gate arrays with clocked J-K flip-flops. These J-K flip-flops are dynamically convertible to D-type via a "fold-back" inverting buffer and control gate F_C. It features 4 registered I/O outputs (F) in conjunction with 8 bidirectional I/O lines (B). These yield variable I/O gate and register configurations via control gates (D, L) ranging from 16 inputs to 12 outputs.

The AND/OR arrays consist of 32 logic AND gates, 13 control AND gates, and 21 OR gates with fusible link connections for programming I/O polarity and direction. All AND gates are linked to 4 inputs (I), bidirectional I/O lines (B), internal flip-flop outputs (Q), and Complement Array output ($\overline{C}$). The Complement Array consists of a NOR gate optionally linked to all AND gates for generating and propagating complementary AND terms.

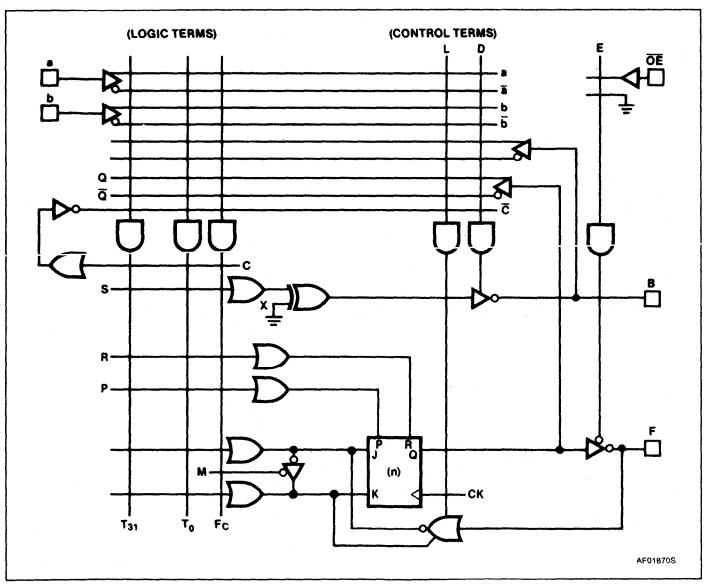
FEATURES

- **Field programmable (Ni-Cr link)**
- **4 dedicated inputs**
- **13 control gates**
- **32 AND gates**
- **21 OR gates**
- **45 product terms:**
  - **32 logic terms**
  - **13 control terms**
- **8 bidirectional I/O lines**
- **4 bidirectional registers**
- **J-K, T, or D-type flip-flops**
- **Asynchronous Preset/Reset**
- **Complement Array**
- **Active HIGH or LOW outputs**
- **Programmable $\overline{OE}$ control**
- **Positive edge-triggered clock**
- **Clock frequency: 15MHz (max)**
- **Input loading: −100μA (max)**
- **Power dissipation: 750mW (typ)**
- **TTL compatible**
- **Three-State Outputs**

PIN CONFIGURATION



FUNCTIONAL DIAGRAM



APPLICATIONS

- **Random sequential logic**
- **Synchronous up/down counters**
- **Shift registers**
- **Bidirectional data buffers**
- **Timing function generators**
- **System controllers/synchronizers**
- **Priority encoder/registers**

Field Programmable Logic Sequencer (16 x 45 x 12) PLS155

On-chip T/C buffers couple either True (I, B, Q) or Complement ($\overline{I}$, $\overline{B}$, $\overline{Q}$, $\overline{C}$) input polarities to all AND gates, whose outputs can be optionally linked to all OR gates. One group of AND gates drives bidirectional I/O lines (B), whose output polarity is individually programmable through a set of EX-OR gates for implementing AND-OR or AND-NOR logic functions. Another group drives the J-K inputs of all flip-flops. The Asynchronous Preset and Reset lines (P, R), are driven from the OR matrix.

All flip-flops are positive edge-triggered and can be used as input, output or I/O (for interfacing with a bi-directional data bus) in conjunction with load control gates (L), steering inputs (I), (B), (Q) and programmable output select lines (E).

The PLS155 is field programmable, enabling the user to quickly generate custom patterns using standard programming equipment.

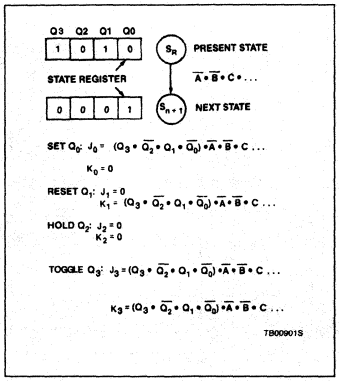
Order codes are contained on the pages following.

VIRGIN STATE

The factory shipped virgin device contains all fusible links intact, sucht that:

1. $\overline{OE}$ is always enabled.
2. Preset and Reset are always disabled.
3. All transition terms are disabled.
4. All flip-flops are in D-mode unless otherwise programmed to J/K only or J/K or D (controlled).
5. All B pins are inputs and all F pins are outputs unless otherwise programmed.

LOGIC FUNCTION



NOTES:
Similar logic functions are applicable for D and T mode flip-flops.

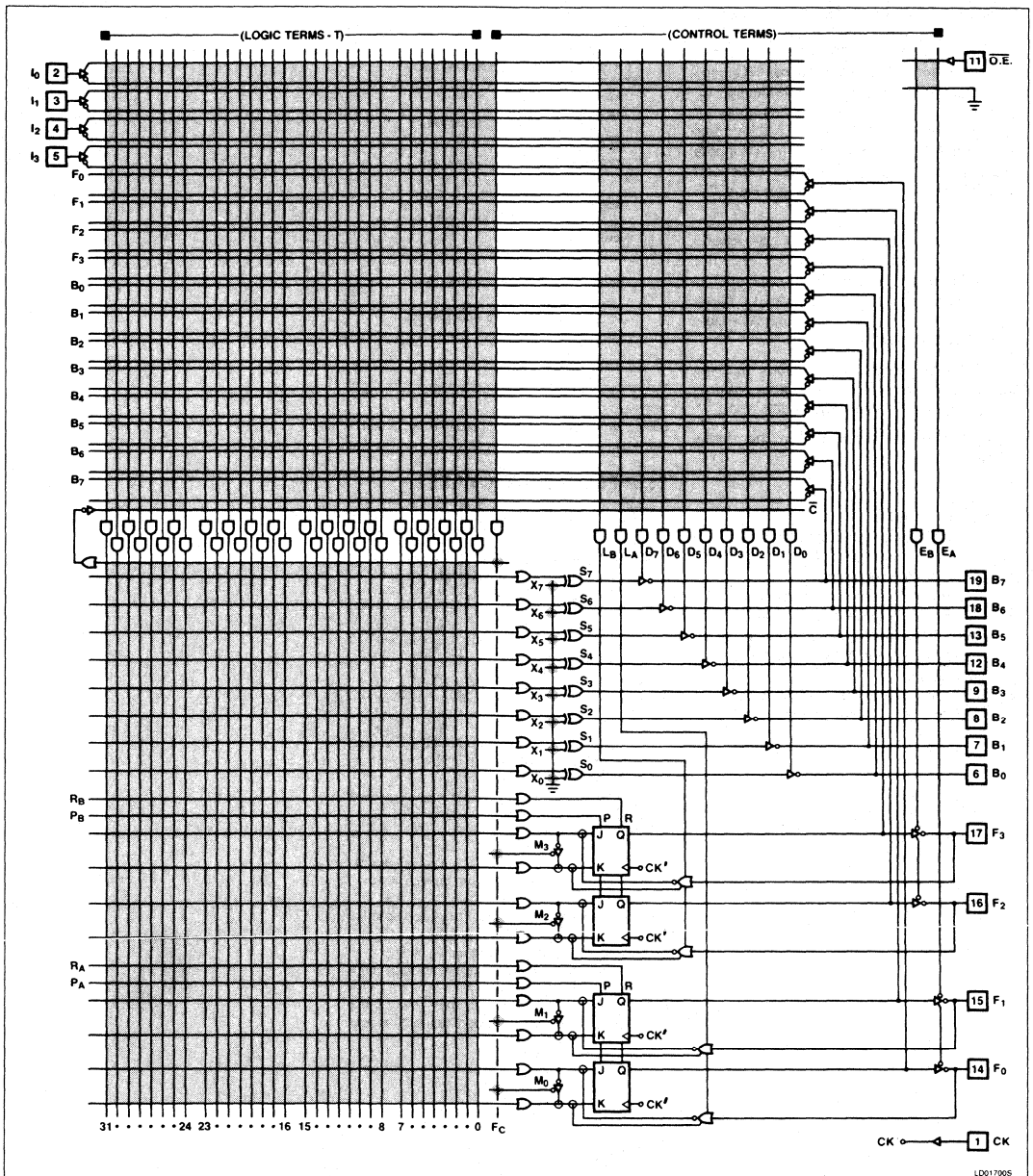
FLIP-FLOP TRUTH TABLE

$\overline{O.E.}$	L	CK	P	R	J	K	Q	F
H								Hi-Z
L	X	X	H	L	X	X	H	L
L	X	X	L	H	X	X	L	H
L	L	↑	L	L	L	L	Q	$\overline{Q}$
L	L	↑	L	L	L	H	L	H
L	L	↑	L	L	H	L	H	L
L	L	↑	L	L	H	H	$\overline{Q}$	Q
H	H	↑	L	L	L	H	L	H*
H	H	↑	L	L	H	L	H	L*
+10V	X	↑	X	X	L	H	L	H**
	X	↑	X	X	H	L	H	L**

NOTES:
1. Positive Logic:
   $J/K = T_0 + T_1 + T_2 \ldots\ldots\ldots\ldots T_{45}$
   $T_n = \overline{C} \bullet (I_0 \bullet I_1 \bullet I_2 \ldots) \bullet (Q_0 \bullet Q_1 \ldots) \bullet (B_0 \bullet B_1 \bullet \ldots)$
2. ↑ denotes transition from Low to High level.
3. X = Don't care
4. * = Forced at F_n pin for loading J/K flip-flop in I/O mode. L must be enabled, and other active T_n disabled via steering input(s) I, B, or Q.
5. At P = R = H, Q = H. The final state of Q depends on which is released first.
6. * * = Forced at F_n pin to load J/K flip-flop independent of program code (Diagnostic mode).

Field Programmable Logic Sequencer (16 x 45 x 12) PLS155

FPLS LOGIC DIAGRAM



NOTES:
1. All OR gate inputs with a blown link float to logic "0".
2. All other gates and control inputs with a blown link float to logic "1".
3. ⊕ denotes WIRE-OR.
4. ▒ Programmable connection.

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ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 300mil 20 pin	PLS155N
Plastic Leaded Chip Carrier 20 pin	PLS155A

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING Min	RATING Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input currents	-30	+30	mA
I_{OUT}	Output currents		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	-65	+150	

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq +75°C$, $4.75 \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage[3]						
V_{IH}	High	V_{CC} = MAX	2			V
V_{IL}	Low	V_{CC} = MIN			0.80	V
V_{IC}	Clamp	V_{CC} = MIN, I_{IN} = -12mA		-0.8	-1.2	V
Output voltage[3]		V_{CC} = MIN				
V_{OH}	High	I_{OH} = -2mA	2.4			V
V_{OL}	Low	I_{OL} = 10mA		0.35	0.5	V
Input current[8]		V_{CC} = MAX				
I_{IH}	High	V_{IN} = 5.5V		< 1	80	μA
I_{IL}	Low	V_{IN} = 0.45V		-10	-100	μA
Output current		V_{CC} = MAX				
$I_{O\ (OFF)}$	Hi-Z State[8]	V_{OUT} = 5.5V		1	80	μA
		V_{OUT} = 0.45V		-1	-140	μA
I_{OS}	Short circuit[4]	V_{OUT} = 0V	-15		-70	mA
I_{CC}	V_{CC} supply current[7]	V_{CC} = MAX		150	190	mA
Capacitance		V_{CC} = 5.0V				
C_{IN}	Input	V_{IN} = 2.0V		8		pF
C_{OUT}	Output	V_{OUT} = 2.0V		15		pF

NOTES:

1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other condition above those indicated in the operational and programming specification of the device is not implied.
2. All typical values are at V_{CC} = 5V, T_A = 25°C.
3. All voltage values are with respect to network ground terminal.
4. Test one at a time.
5. Measured with V_{IH} applied to $\overline{OE}$.
6. Duration of short circuit shouid not exceed 1 second.
7. I_{CC} is measured with the $\overline{OE}$ input grounded, all other inputs at 4.5V, and the outputs open.
8. Leakage values are a combination of input and output leakage.

Field Programmable Logic Sequencer (16 x 45 x 12) PLS155

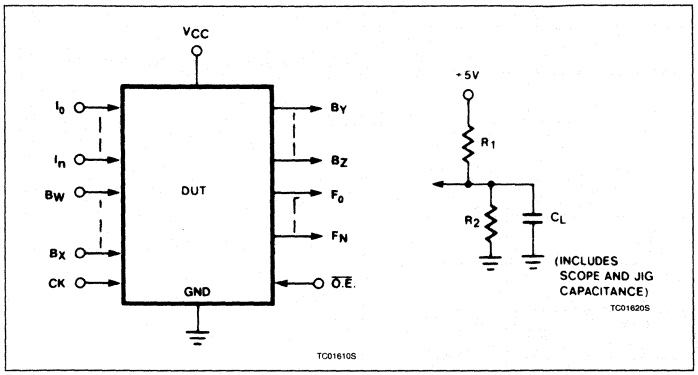
AC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq +75°C$, $4.75 \leq V_{CC} \leq 5.25V$, $R_1 = 470\Omega$, $R_2 = 1k\Omega$

PARAMETER		TO	FROM	TEST CONDITIONS	LIMITS			UNIT
					Min[5]	Typ[1]	Max	
Pulse width								
T_{CKH}	Clock[2] high	CK –	CK +		25	20		
T_{CKL}	Clock low	CK +	CK –	$C_L = 30pF$	30	20		ns
T_{CKP}	Period	CK +	CK +		70	50		
T_{PRH}	Preset/Reset pulse	(I,B) +	(I,B) –		40	30		
Set-up time								
T_{IS1}	Input	CK +	(I,B) ±		40	30		
T_{IS2}	Input (through F_n)	CK +	F ±	$C_L = 30pF$	–	10		ns
T_{IS3}	Input (through Complement array)[4]	CK +	(I,B) ±		65	40		
Hold time								
T_{IH1}	Input	CK +	(I,B) ±	$C_L = 30pF$	0	–10		ns
T_{IH2}		CK +	F ±		–	10		
Propagation delays								
T_{CKO}	Clock	F ±	CK +	$C_L = 30pF$		25	30	ns
T_{OE1}	Output enable	F –	$\overline{O.E.}$ –	$C_L = 30pF$		20	30	
T_{OD1}	Output disable[3]	F +	$\overline{O.E.}$ +	$C_L = 5pF$		20	55	
T_{PD}	Output	B ±	(I,B) ±	$C_L = 30pF$		40	50	ns
T_{OE2}	Output enable	B ±	(I,B) +			35	55	
T_{OD2}	Output disable[3]	B +	(I,B) –	$C_L = 5pF$		30	35	
T_{PRO}	Preset/Reset	F ±	(I,B) +	$C_L = 30pF$		50	55	

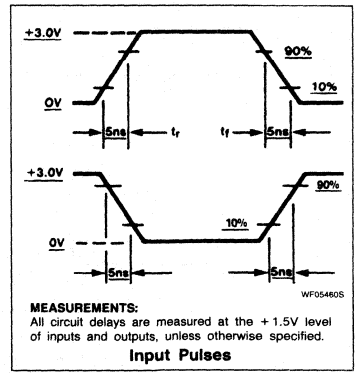
NOTES:
1. All typical values are at $V_{CC} = 5V$, $T_A = 25°C$.
2. To prevent spurious clocking, clock rise time (10% – 90%) ≤ 10ns.
3. Measured at $V_T = V_{OL} + 0.5V$.
4. When using the Complement Array $T_{CKP} = 95ns$ (min).
5. Limits are guaranteed with 12 product terms maximum connected to each sum term line.
6. For test circuits, waveforms and timing diagrams see pages 6 and 7.

Field Programmable Logic Sequencer (16 x 45 x 12) PLS155

TEST LOAD CIRCUIT



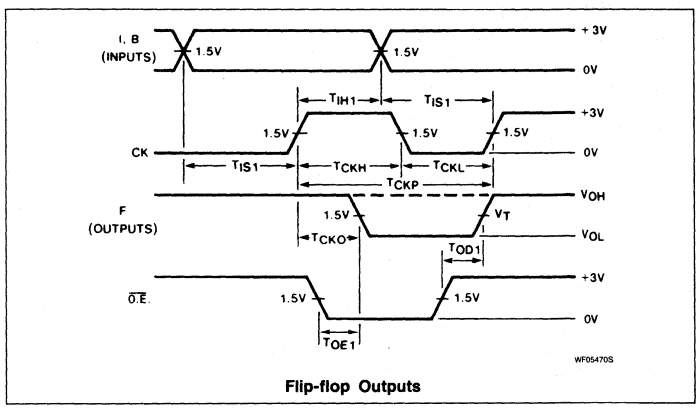
VOLTAGE WAVEFORM



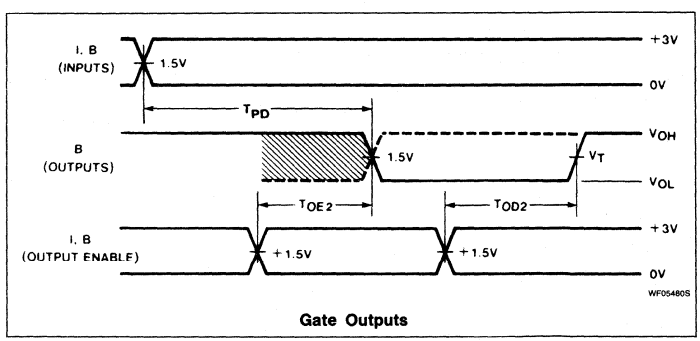
MEASUREMENTS:
All circuit delays are measured at the +1.5V level of inputs and outputs, unless otherwise specified.

Input Pulses

TIMING DIAGRAMS



Flip-flop Outputs



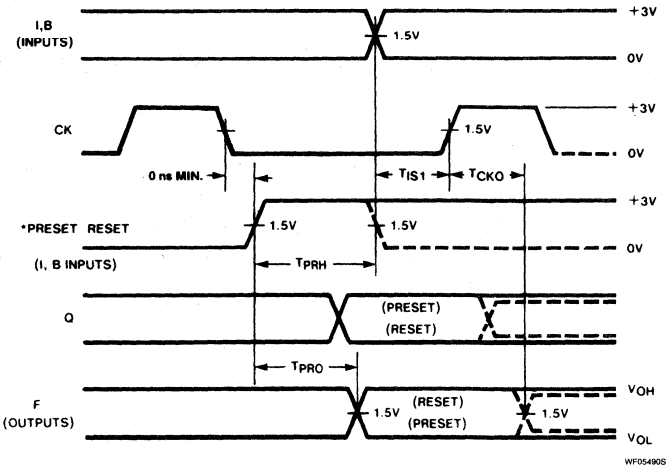
Gate Outputs

MEMORY TIMING DEFINITIONS

T_{CKH}	Width of input clock pulse.
T_{CKL}	Interval between clock pulses.
T_{CKP}	Clock period.
T_{PRH}	Width of preset input pulse.
T_{IS1}	Required delay between beginning of valid input and positive transition of clock.
T_{IS2}	Required delay between beginning of valid input forced at flip-flop output pins, and positive transition of clock.
T_{IH1}	Required delay between positive transition of clock and end of valid input data.
T_{IH2}	Required delay between positive transition of clock and end of valid input data forced at flip-flop output pins.
T_{CKO}	Delay between positive transition of clock and when Outputs become valid (with $\overline{O.E.}$ low).
T_{OE1}	Delay between beginning of Output Enable Low and when Outputs become valid.
T_{OD1}	Delay between beginning of Output Enable High and when Outputs are in the off state.
T_{PD}	Propagation delay between combinational inputs and outputs.
T_{OE2}	Delay between predefined Output Enable High, and when combinational Outputs become valid.
T_{OD2}	Delay between predefined Output Enable Low, and when combinational Outputs are in the off state.
T_{PRO}	Delay between positive transition of predefined Preset/Reset input, and when flip-flop outputs become valid.

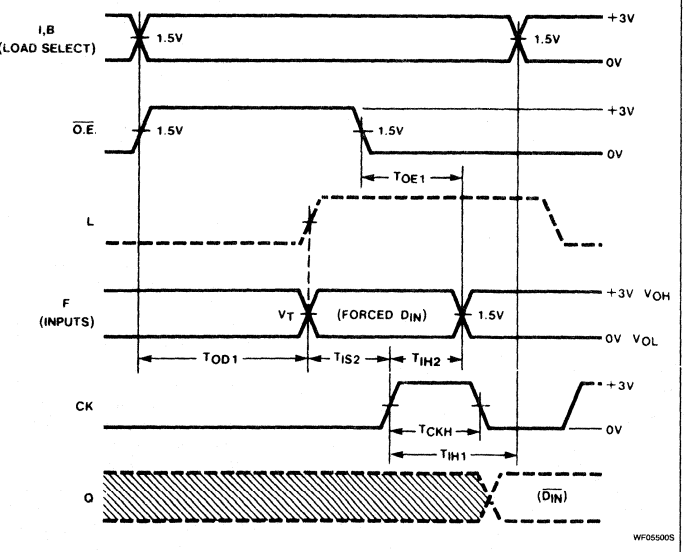
4

TIMING DIAGRAMS (Continued)



* The leading edge of preset/reset must occur only when the input clock is "low", and must remain "high" as long as required to override clock. The falling edge of preset/reset can never go "low" when the input clock is "high".

Asynchronous Preset/Reset



Flip-flop Input Mode

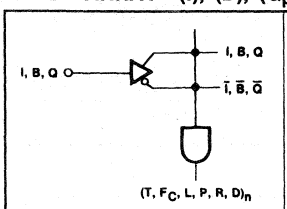
Field Programmable Logic Sequencer (16 x 45 x 12) PLS155

The FPLS can be programmed by means of Logic Programming equipment.

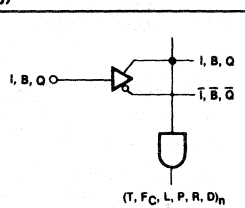
With Logic programming, the AND/OR-EX-OR input connections necessary to implement the desired logic function are coded directly from the State Diagram using the Program Tables on the following pages.

In these tables, the logic state or action of all I/O, control, and state variables is assigned a symbol which results in the proper fusing pattern of corresponding links, defined as follows:

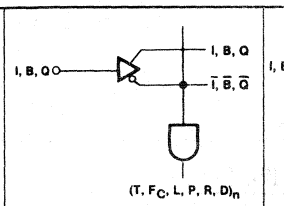
"AND" ARRAY – (I), (B), (Q_p)



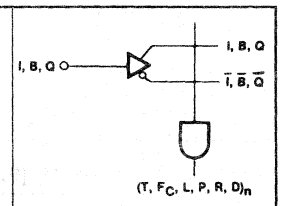
STATE	CODE
INACTIVE[1,2]	O



STATE	CODE
I, B, Q	H

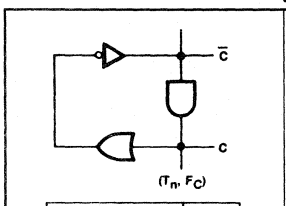


STATE	CODE
Ī, B̄, Q̄	L

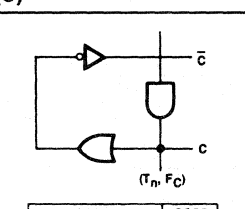


STATE	CODE
DON'T CARE	–

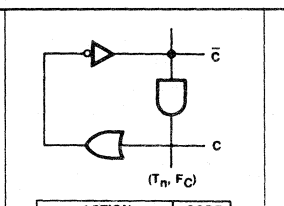
"COMPLEMENT" ARRAY – (C)



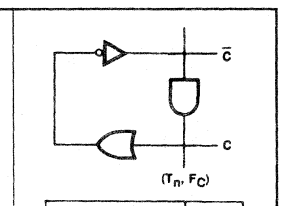
ACTION	CODE
INACTIVE[1,3,5]	O



ACTION	CODE
GENERATE[5]	A

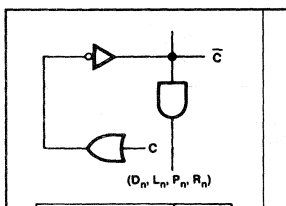


ACTION	CODE
PROPAGATE	•

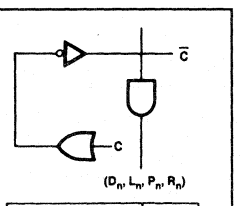


ACTION	CODE
TRANSPARENT	–

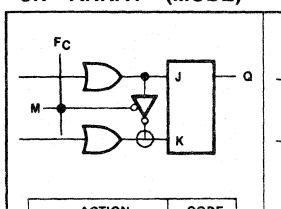
"OR" ARRAY – (MODE)



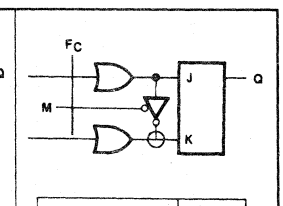
ACTION	CODE
PROPAGATE	•



ACTION	CODE
TRANSPARENT	–

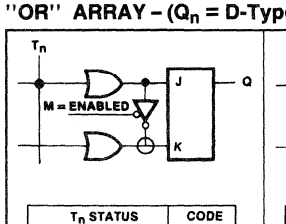


ACTION	CODE
J/K OR D (CONTROLLED)	A

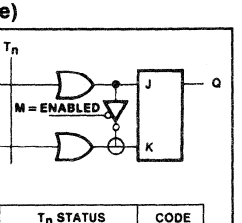


ACTION	CODE
J-K	•

"OR" ARRAY – (Q_n = D-Type)



T_n STATUS	CODE
ACTIVE (Set)	A

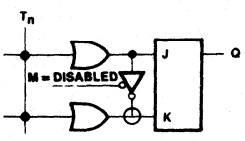


T_n STATUS	CODE
INACTIVE (Reset)	•

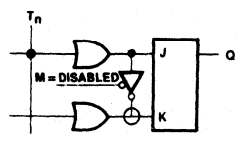
Notes on following page.

Field Programmable Logic Sequencer (16 x 45 x 12) PLS155

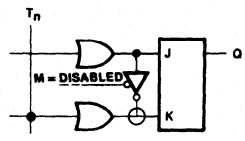
"OR" ARRAY – (Q_n = J-K Type)



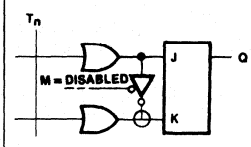
ACTION	CODE
TOGGLE	O



ACTION	CODE
SET	H

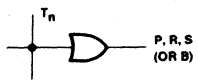


ACTION	CODE
RESET	L

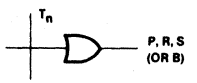


ACTION	CODE
HOLD	–

"OR" Array – (S or B), (P), (R)



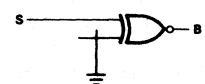
T_n STATUS	CODE
ACTIVE	A



T_n STATUS	CODE
INACTIVE	•

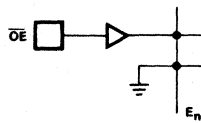
"EX-OR" ARRAY – (B)

POLARITY	CODE
LOW	L

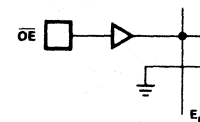


POLARITY	CODE
HIGH	H

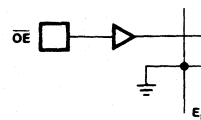
"$\overline{O.E.}$" ARRAY – (E)



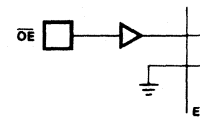
ACTION	CODE
IDLE[4]	O



ACTION	CODE
CONTROL	A



ACTION	CODE
ENABLE[4]	•



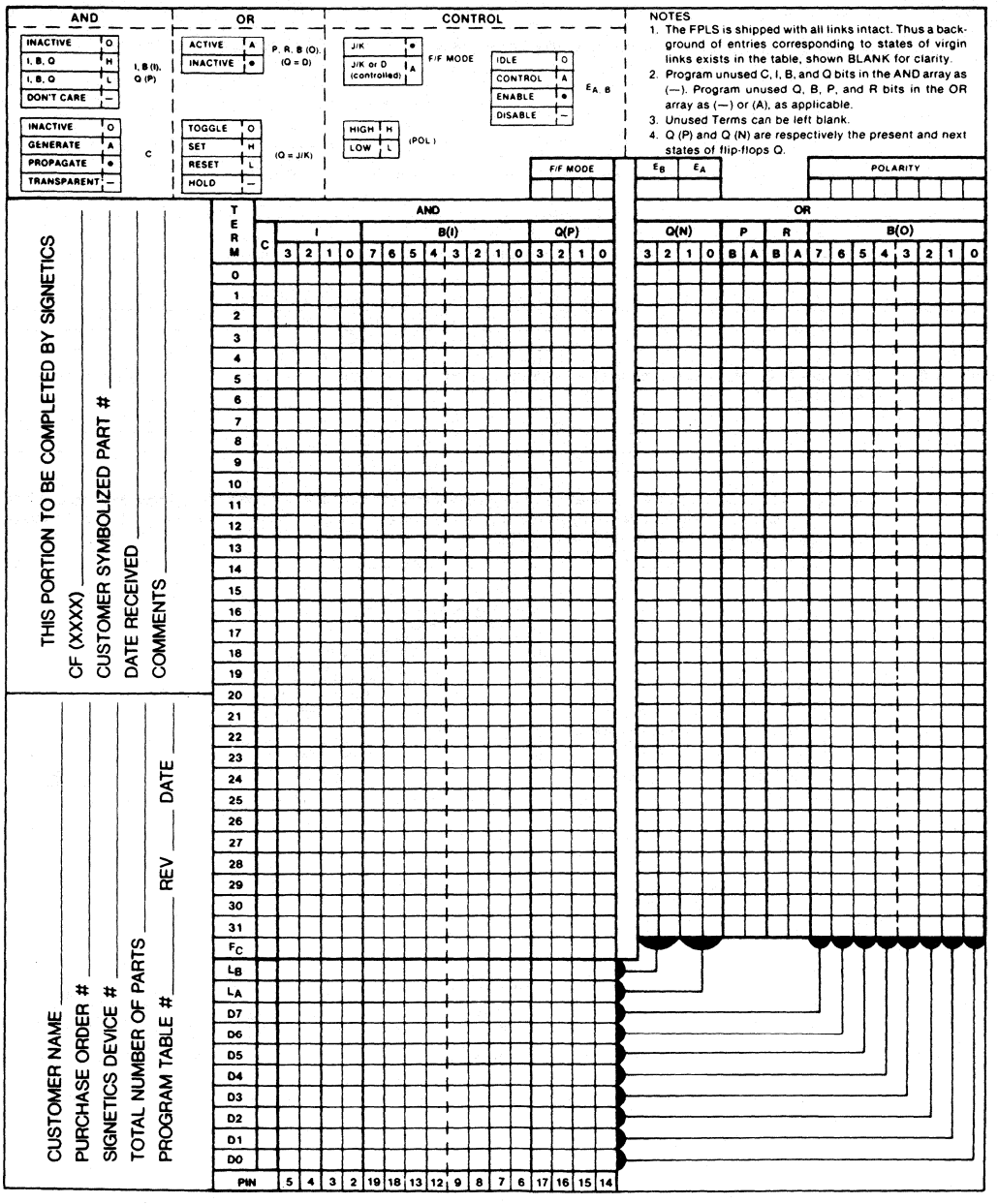
ACTION	CODE
DISABLE	–

NOTES:

1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates.
2. Any gate (T, F_C, L, P, R, D)$_n$ will be unconditionally inhibited if any one of the I, B, or Q link pairs is left intact.
3. To prevent oscillations, this state is not allowed for C link pairs coupled to active gates T_n, F_C.
4. E_n = O and E_n = • are logically equivalent states, since both cause F_n outputs to be unconditionally enabled.
5. These states are not allowed for control gates (L, P, R, D)$_n$ due to their lack of "OR" array links.

Field Programmable Logic Sequencer (16 x 45 x 12) PLS155

FPLS PROGRAM TABLE



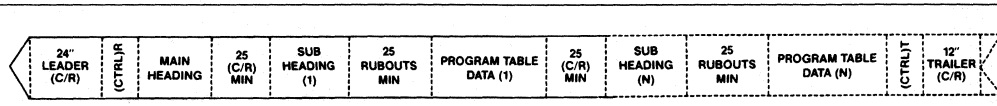
TB01210S

Field Programmable Logic Sequencer (16 x 45 x 12) PLS155

TWX TAPE CODING (LOGIC FORMAT)

The FPLS Program Table can be sent to Signetics in ASCII code format via airmail using any type of 8-level tape (paper, mylar, fanfold, etc.), or via TWX: just dial (910) 339-9283, tell the operator to turn the paper puncher on, and acknowledge. At the end of transmission instruct the operator to send tape to Signetics Order Entry.

A number of Program Tables can be sequentially assembled on a continuous tape as follows, however, limit tape length to a roll of 1.75 inch inside diameter and 4.25 inch outside diameter.



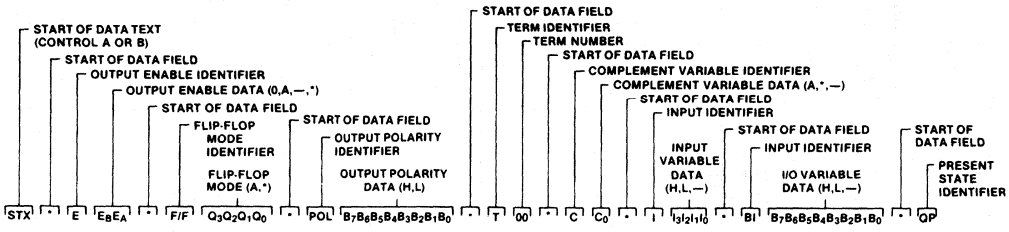
A. The MAIN HEADING at the beginning of tape includes the following information, with each entry preceded by a ($) character, whether used or not:

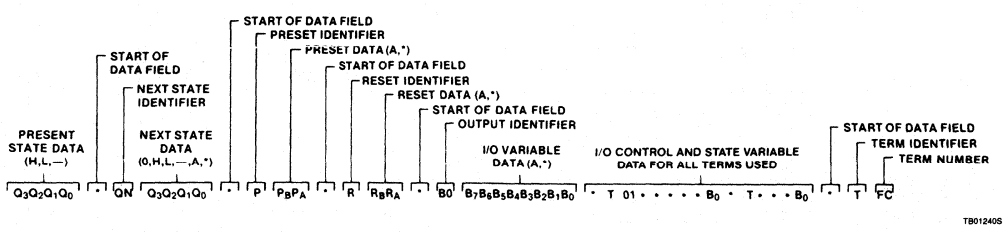
1. Customer Name
2. Customer TWX No.
3. Date
4. Purchase Order No.
5. Number of Program Tables
6. Total Number of Parts

B. Each SUB HEADING should contain specific information pertinent to each Program Table as follows, with each entry preceded by a ($) character, whether used or not:

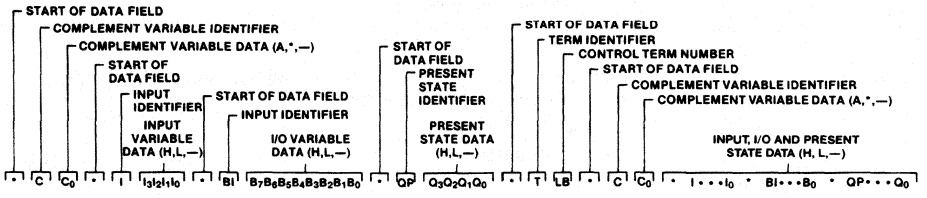
1. Signetics Device No.
2. Program Table No.
3. Revision
4. Date
5. Customer Symbolized Part No.
6. Number of Parts

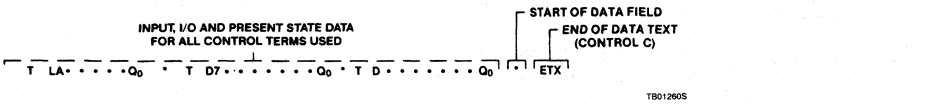
C. Program Table data blocks are initiated with an STX character, and terminated with an ETX character. The body of the data consists of output polarity, product term, and output information separated by appropriate identifiers in accordance with the following format. Entries for the data fields correspond to those defined in the Logic PROGRAM TABLE:





TWX TAPE CODING (Continued)





4

Signetics

PLS157
Field Programmable Logic Sequencer (16 x 45 x 12)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 20**

DESCRIPTION

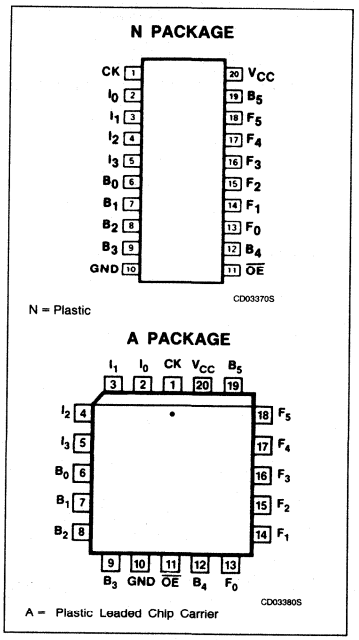
The PLS157 is a Three-State output, registered logic element combining AND/OR gate arrays with clocked J-K flip-flops. These J-K flip-flops are dynamically convertible to D-type via a "fold-back" inverting buffer and control gate F_C. It features 6 registered I/O outputs (F) in conjunction with 6 bidirectional I/O lines (B). These yield variable I/O gate and register configurations via control gates (D, L) ranging from 16 inputs to 12 outputs.

The AND/OR arrays consist of 32 logic AND gates, 13 control AND gates, and 21 OR gates with fusible link connections for programming I/O polarity and direction. All AND gates are linked to 4 inputs (I), bidirectional I/O lines (B), internal flip-flop outputs (Q), and Complement Array output ($\overline{C}$). The Complement Array consists of a NOR gate optionally linked to all AND gates for generating and propagating complementary AND terms.

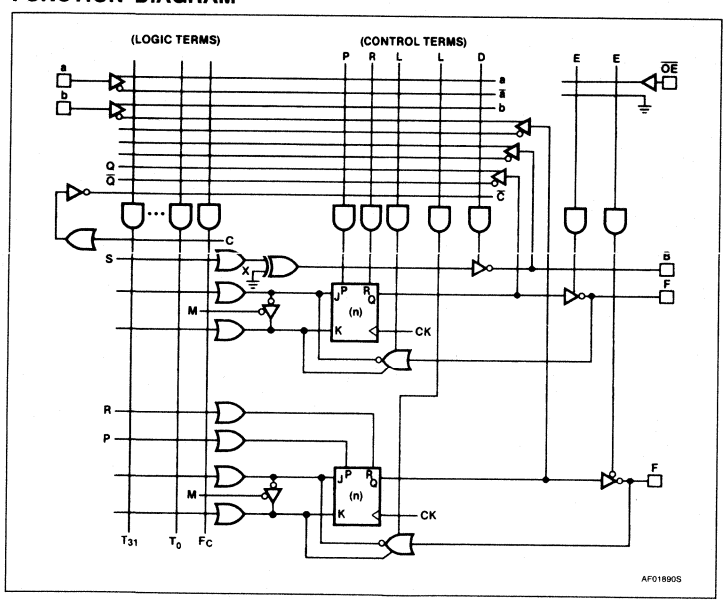
FEATURES

- **Field programmable (Ni-Cr link)**
- **4 dedicated inputs**
- **13 control gates**
- **32 AND gates**
- **21 OR gates**
- **45 product terms:**
  - **32 logic terms**
  - **13 control terms**
- **6 bidirectional I/O lines**
- **6 bidirectional registers**
- **J-K, T, or D-type flip-flops**
- **Three-State Outputs**
- **Asynchronous Preset/Reset**
- **Complement Array**
- **Active HIGH or LOW outputs**
- **Programmable $\overline{OE}$ control**
- **Positive edge-triggered clock**
- **Clock frequency: 15MHz (max)**
- **Input loading: −100μA (max)**
- **Power dissipation: 750mW (typ)**
- **TTL compatible**

PIN CONFIGURATION



FUNCTION DIAGRAM



APPLICATIONS

- **Random sequential logic**
- **Synchronous up/down counters**
- **Shift registers**
- **Bidirectional data buffers**
- **Timing function generators**
- **System controllers/synchronizers**
- **Priority encoder/registers**

Field Programmable Logic Sequencer (16 x 45 x 12) PLS157

On-chip T/C buffers couple either True (I, B, Q) or Complement ($\overline{I}$, $\overline{B}$, $\overline{Q}$, $\overline{C}$) input polarities to all AND gates, whose outputs can be optionally linked to all OR gates. One group of AND gates drives bidirectional I/O lines (B), whose output polarity is individually programmable through a set of EX-OR gates for implementing AND-OR or AND-NOR logic functions. Another group drives the J-K inputs of all flip-flops. The Asynchronous Preset and Reset lines (P, R), for two of the registers are driven from the AND matrix. The Preset and Reset lines (P, R) controlling the lower four registers are driven from the OR matrix.

All flip-flops are positive edge-triggered and can be used as input, output or I/O (for interfacing with a bi-directional data bus) in conjunction with load control gates (L), steering inputs (I), (B), (Q) and programmable output select lines (E).

The PLS157 is field programmable, enabling the user to quickly generate custom patterns using standard programming equipment.

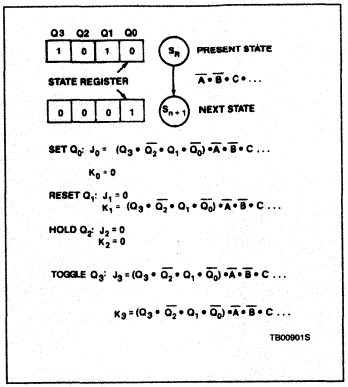
Order codes are contained on the pages following.

VIRGIN STATE

The factory shipped virgin device contains all fusible links intact, such that:

1. $\overline{OE}$ is always enabled.
2. Preset and Reset are always disabled.
3. All transition terms are disabled.
4. All flip-flops are in D-mode unless otherwise programmed to J/K only or J/K or D (controlled).
5. All B pins are inputs and all F pins are outputs unless otherwise programmed.

LOGIC FUNCTION



NOTES:
Similar logic functions are applicable for D and T mode flip-flops.

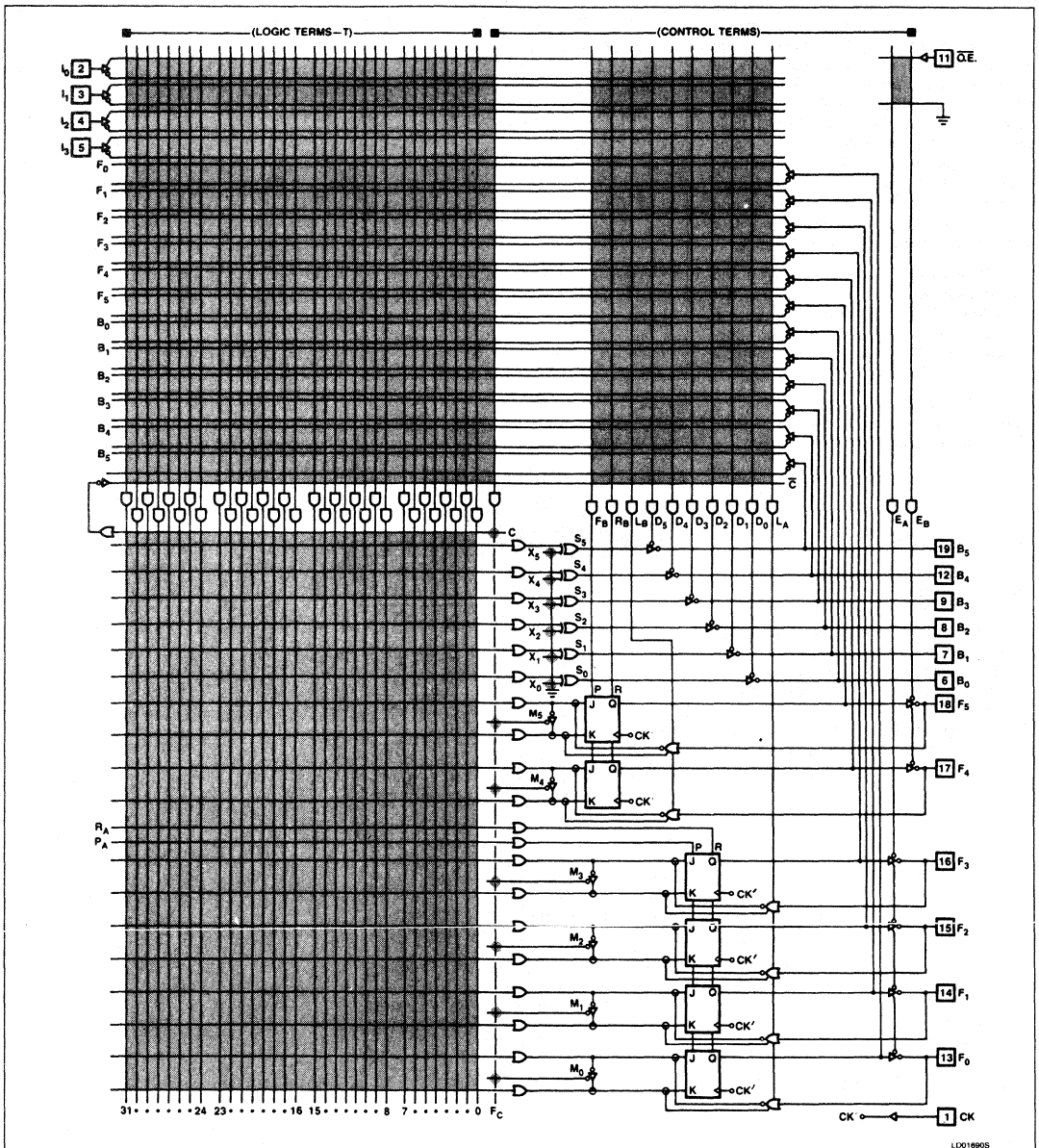
FLIP-FLOP TRUTH TABLE

$\overline{O.E.}$	L	CK	P	R	J	K	Q	F
H								Hi-Z
L	X	X	H	L	X	X	H	L
L	X	X	L	H	X	X	L	H
L	L	↑	L	L	L	L	Q	$\overline{Q}$
L	L	↑	L	L	L	H	L	H
L	L	↑	L	L	H	L	H	L
L	L	↑	L	L	H	H	$\overline{Q}$	Q
H	H	↑	L	L	L	H	L	H*
H	H	↑	L	L	H	L	H	L*
+10V	X	↑	X	X	L	H	L	H**
	X	↑	X	X	H	L	H	L**

NOTES:
1. Positive Logic:
   $J/K = T_0 + T_1 + T_2$ ..... T_{45}
   $T_n = \overline{C} \bullet (I_0 \bullet I_1 \bullet I_2 \ldots) \bullet (Q_0 \bullet Q_1 \ldots) \bullet (B_0 \bullet B_1 \bullet \ldots)$
2. ↑ denotes transition from Low to High level.
3. X = Don't care
4. * = Forced at F_n pin for loading J/K flip-flop in I/O mode. L must be enabled, and other active T_n disabled via steering input(s) I, B, or Q.
5. At P = R = H, Q = H. The final state of Q depends on which is released first.
6. * * = Forced at F_n pin to load J/K flip-flop independent of program code (Diagnostic mode).

Field Programmable Logic Sequencer (16 x 45 x 12) PLS157

FPLS LOGIC DIAGRAM



NOTES:
1. All OR gate inputs with a blown link float to logic "0".
2. All other gates and control inputs with a blown link float to logic "1".
3. ⊕ denotes WIRE-OR.
4. ▒ Programmable connection.

Field Programmable Logic Sequencer (16 x 45 x 12) PLS157

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 300mil wide 20 pin	PLS157N
Plastic Leaded Chip Carrier 20 pin	PLS157A

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING Min	RATING Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input currents	−30	+30	mA
I_{OUT}	Output currents		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	−65	+150	

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq +75°C$, $4.75 \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage[3]						V
V_{IH}	High	V_{CC} = MAX	2			
V_{IL}	Low	V_{CC} = MIN			0.80	
V_{IC}	Clamp	V_{CC} = MIN, I_{IN} = −12mA		−0.8	−1.2	
Output voltage[3]		V_{CC} = MIN				V
V_{OH}	High	I_{OH} = −2mA	2.4			
V_{OL}	Low	I_{OL} = 10mA		0.35	0.5	
Input current						μA
I_{IH}	High	V_{IN} = 5.5V		< 1	80	
I_{IL}	Low	V_{IN} = 0.45V		−10	−100	
Output current		V_{CC} = MAX				
$I_{O\ (OFF)}$	Hi-Z State[8]	V_{OUT} = 5.5V		1	80	μA
		V_{OUT} = 0.45V		−1	−140	
I_{OS}	Short circuit[4]	V_{OUT} = 0V	−15		−70	mA
I_{CC}	V_{CC} supply current[7]	V_{CC} = MAX		150	190	mA
Capacitance		V_{CC} = 5.0V				pF
C_{IN}	Input	V_{IN} = 2.0V		8		
C_{OUT}	Output	V_{OUT} = 2.0V		15		

NOTES:

1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other condition above those indicated in the operational and programming specification of the device is not implied.
2. All typical values are at V_{CC} = 5V, T_A = 25°C.
3. All voltage values are with respect to network ground terminal.
4. Test one at a time.
5. Measured with V_{IH} applied to $\overline{OE}$.
6. Duration of short circuit should not exceed 1 second.
7. I_{CC} is measured with the $\overline{OE}$ input grounded, all other inputs at 4.5V, and the outputs open.
8. Leakage values are a combination of input and output leakage.

Field Programmable Logic Sequencer (16 x 45 x 12) PLS157

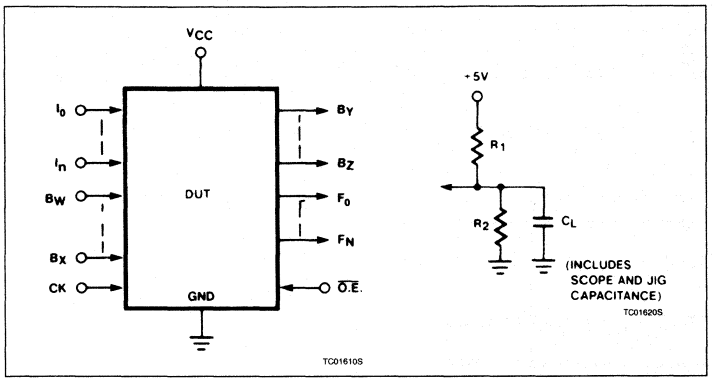
AC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq +75°C$, $4.75 \leq V_{CC} \leq 5.25V$, $R_1 = 470\Omega$, $R_2 = 1k\Omega$

PARAMETER		TO	FROM	TEST CONDITIONS	LIMITS			UNIT
					Min[5]	Typ[1]	Max	
Pulse width								
T_{CKH}	Clock[2] high	CK −	CK +		25	20		
T_{CKL}	Clock low	CK +	CK −	$C_L = 30pF$	30	20		ns
T_{CKP}	Period	CK +	CK +		70	50		
T_{PRH}	Preset/Reset pulse	(I,B) +	(I,B) −		40	30		
Set-up time								
T_{IS1}	Input	CK +	(I,B) ±		40	30		
T_{IS2}	Input (through F_n)	CK +	F ±	$C_L = 30pF$	−	10		ns
T_{IS3}	Input (through Complement array)[4]	CK +	(I,B) ±		65	40		
Hold time								
T_{IH1}	Input	CK +	(I,B) ±	$C_L = 30pF$	0	−10		ns
T_{IH2}		CK +	F ±		−	10		
Propagation delays								
T_{CKO}	Clock	F ±	CK +	$C_L = 30pF$		25	30	ns
T_{OE1}	Output enable	F −	$\overline{O.E.}$ −	$C_L = 30pF$		20	30	
T_{OD1}	Output disable[3]	F +	$\overline{O.E.}$ +	$C_L = 5pF$		20	55	
T_{PD}	Output	B ±	(I,B) ±	$C_L = 30pF$		40	50	ns
T_{OE2}	Output enable	B ±	(I,B) +			35	55	
T_{OD2}	Output disable[3]	B +	(I,B) −	$C_L = 5pF$		30	35	
T_{PRO}	Preset/Reset	F ±	(I,B) +	$C_L = 30pF$		50	55	

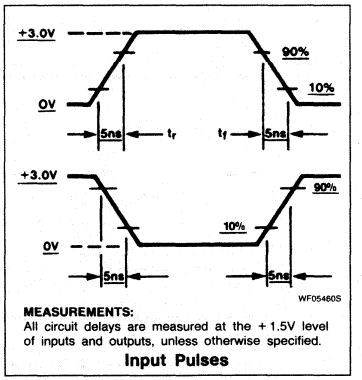
NOTE:
1. All typical values are at $V_{CC} = 5V$, $T_A = 25°C$.
2. To prevents spurious clocking, clock rise time (10% − 90%) ≤ 10ns.
3. Measured at $V_T = V_{OL} + 0.5V$.
4. When using the Complement Array $T_{CKP} = 95ns$ (min).
5. Limits are guaranteed with 12 product terms maximum connected to each sum term line.
6. For test circuits, waveforms and timing diagrams see pages 6 and 7.

Field Programmable Logic Sequencer (16 x 45 x 12) PLS157

TEST LOAD CIRCUIT



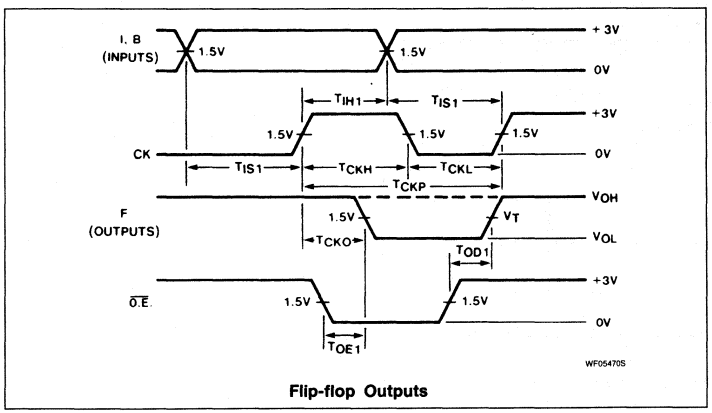
VOLTAGE WAVEFORM



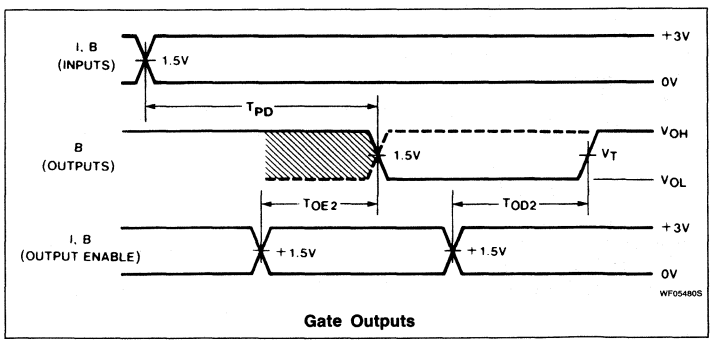
MEASUREMENTS:
All circuit delays are measured at the + 1.5V level of inputs and outputs, unless otherwise specified.

Input Pulses

TIMING DIAGRAMS



Flip-flop Outputs



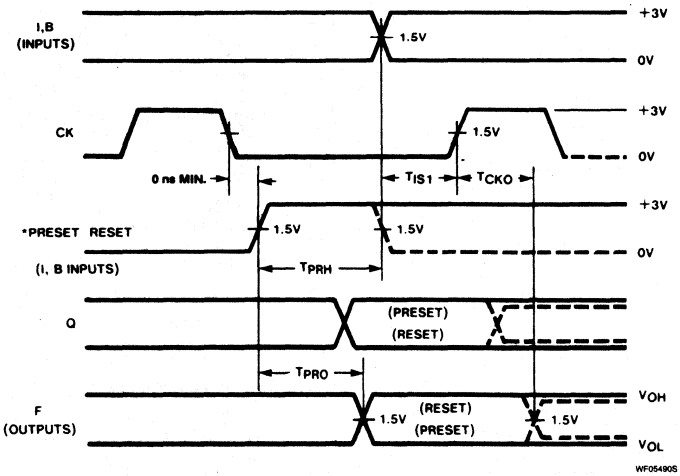
Gate Outputs

MEMORY TIMING DEFINITIONS

T_{CKH}	Width of input clock pulse.
T_{CKL}	Interval between clock pulses.
T_{CKP}	Clock period.
T_{PRH}	Width of preset input pulse.
T_{IS1}	Required delay between beginning of valid input and positive transition of clock.
T_{IS2}	Required delay between beginning of valid input forced at flip-flop output pins, and positive transition of clock.
T_{IH1}	Required delay between positive transition of clock and end of valid input data.
T_{IH2}	Required delay between positive transition of clock and end of valid input data forced at flip-flop output pins.
T_{CKO}	Delay between positive transition of clock and when Outputs become valid (with $\overline{O.E.}$ low).
T_{OE1}	Delay between beginning of Output Enable Low and when Outputs become valid.
T_{OD1}	Delay between beginning of Output Enable High and when Outputs are in the off state.
T_{PD}	Propagation delay between combinational inputs and outputs.
T_{OE2}	Delay between predefined Output Enable High, and when combinational Outputs become valid.
T_{OD2}	Delay between predefined Output Enable Low, and when combinational Outputs are in the off state.
T_{PRO}	Delay between positive transition of predefined Preset/Reset input, and when flip-flop outputs become valid.

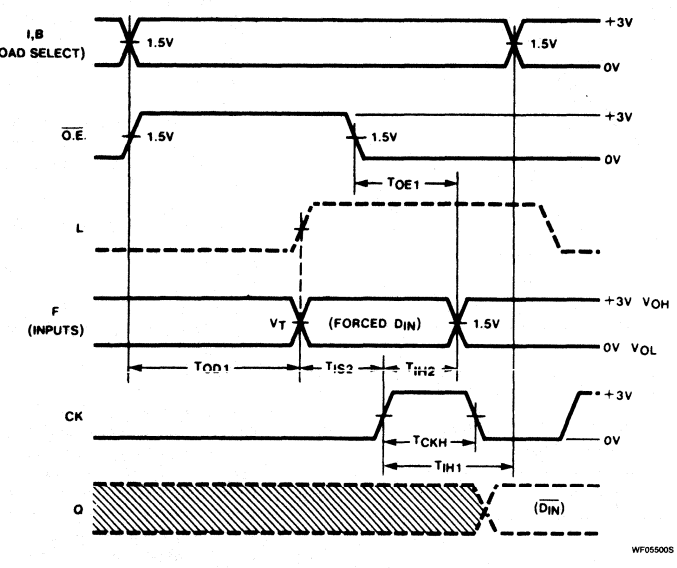
4

TIMING DIAGRAMS (Continued)



* The leading edge of preset/reset must occur only when the input clock is "low", and must remain "high" as long as required to override clock. The falling edge of preset/reset can never go "low" when the input clock is "high".

Asynchronous Preset/Reset



Flip-flop Input Mode

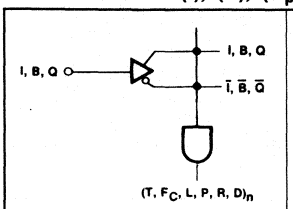
Field Programmable Logic Sequencer (16 x 45 x 12) PLS157

The FPLS can be programmed by means of Logic Programming equipment.

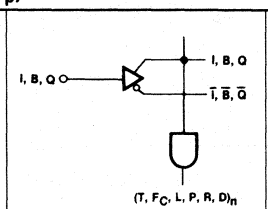
With Logic programming, the AND/OR-EX-OR input connections necessary to implement the desired logic function are coded directly from the State Diagram using the Program Tables on the following pages.

In these tables, the logic state or action of all I/O, control, and state variables is assigned a symbol which results in the proper fusing pattern of corresponding links defined as follows:

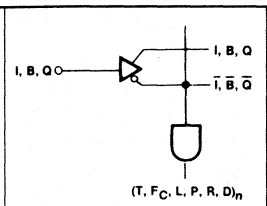
"AND" ARRAY – (I), (B), (Q_p)



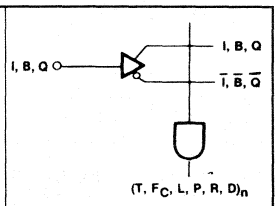
STATE	CODE
INACTIVE[1,2]	O



STATE	CODE
I, B, Q	H

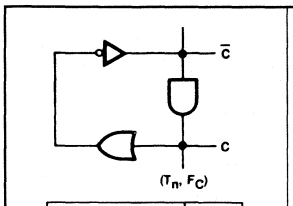


STATE	CODE
$\bar{I}, \bar{B}, \bar{Q}$	L

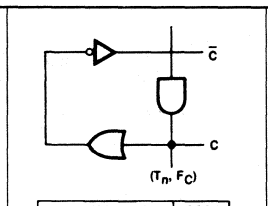


STATE	CODE
DON'T CARE	–

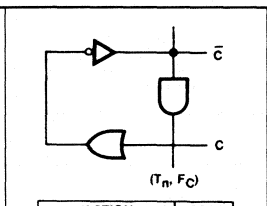
"COMPLEMENT" ARRAY – (C)



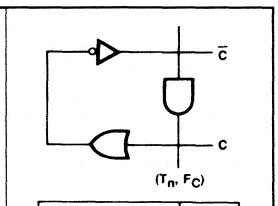
ACTION	CODE
INACTIVE[1,3,5]	O



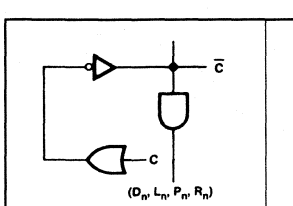
ACTION	CODE
GENERATE[5]	A



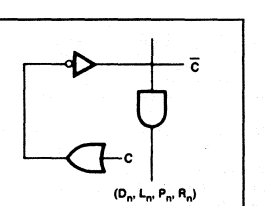
ACTION	CODE
PROPAGATE	•



ACTION	CODE
TRANSPARENT	–

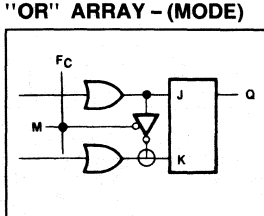


ACTION	CODE
PROPAGATE	•

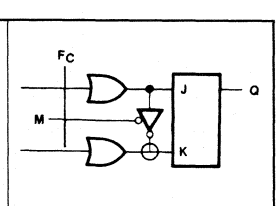


ACTION	CODE
TRANSPARENT	–

"OR" ARRAY – (MODE)

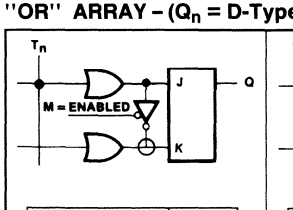


ACTION	CODE
J/K OR D (CONTROLLED)	A

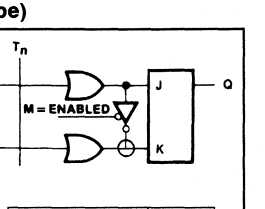


ACTION	CODE
J-K	•

"OR" ARRAY – (Q_n = D-Type)



T_n STATUS	CODE
ACTIVE (Set)	A



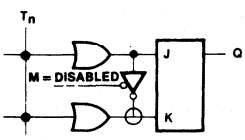
T_n STATUS	CODE
INACTIVE (Reset)	•

Notes on following page.

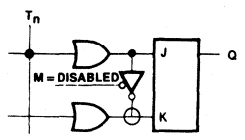
4

Field Programmable Logic Sequencer (16 x 45 x 12) PLS157

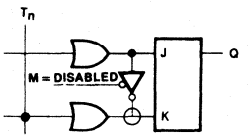
"OR" ARRAY – (Q_n = J-K Type)



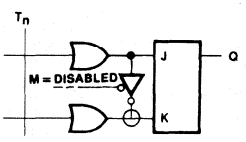
ACTION	CODE
TOGGLE	O



ACTION	CODE
SET	H

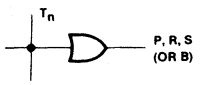


ACTION	CODE
RESET	L

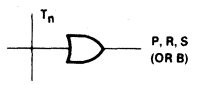


ACTION	CODE
HOLD	–

"OR" Array – (S or B), (P), (R)

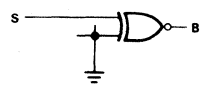


T_n STATUS	CODE
ACTIVE	A

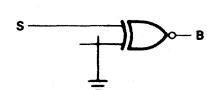


T_n STATUS	CODE
INACTIVE	•

"EX-OR" ARRAY – (B)

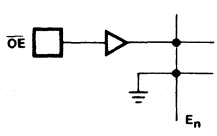


POLARITY	CODE
LOW	L

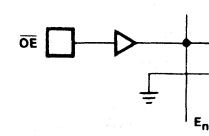


POLARITY	CODE
HIGH	H

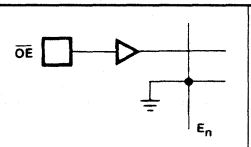
"$\overline{O.E.}$" ARRAY – (E)



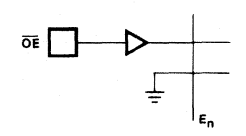
ACTION	CODE
IDLE[4]	O



ACTION	CODE
CONTROL	A



ACTION	CODE
ENABLE[4]	•

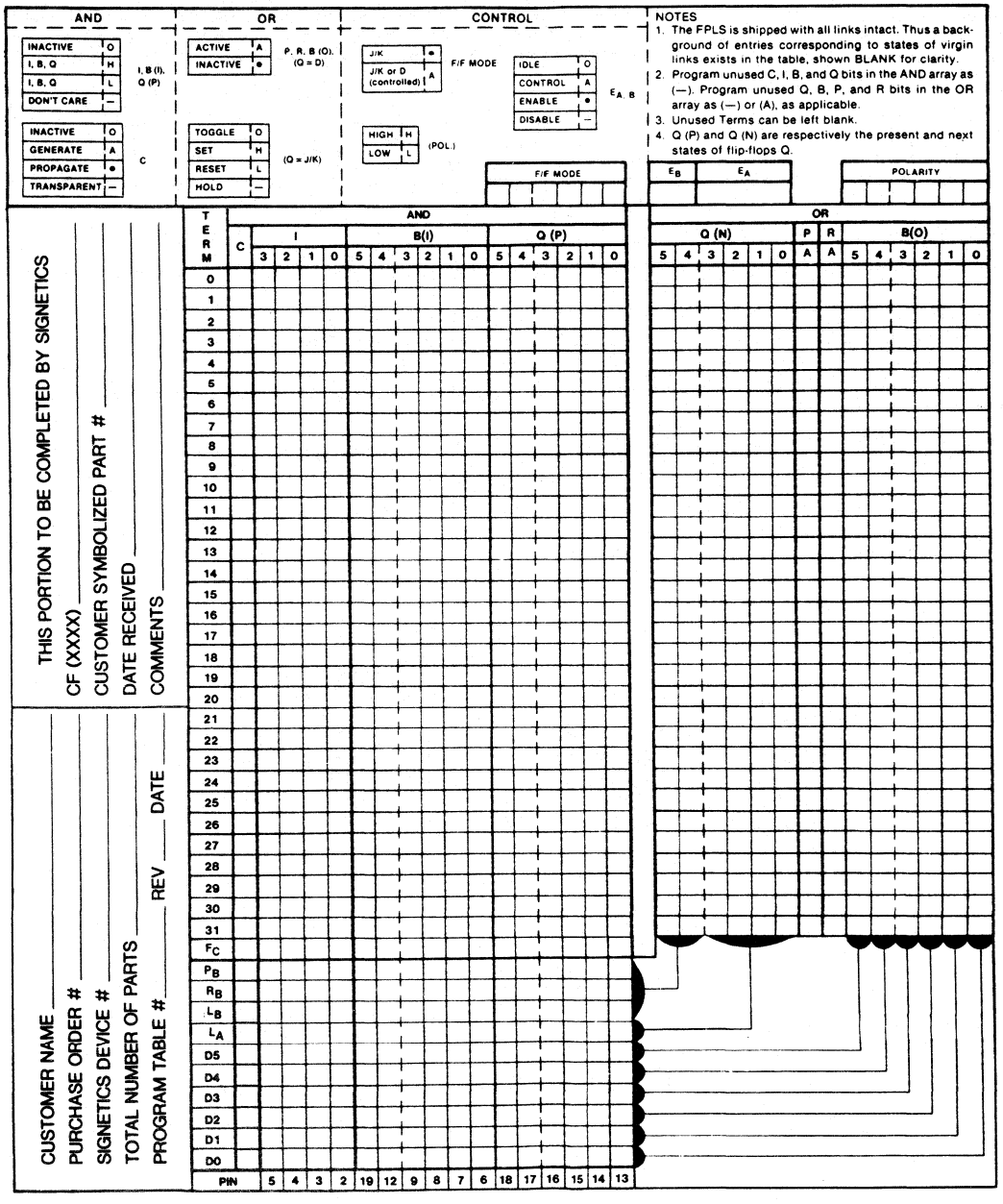


ACTION	CODE
DISABLE	–

NOTES:
1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates.
2. Any gate (T, F_C, L, P, R, $D)_n$ will be unconditionally inhibited if any one of the I, B, or Q link pairs is left intact.
3. To prevent oscillations, this state is not allowed for C link pairs coupled to active gates T_n, F_C.
4. E_n = O and E_n = • are logically equivalent states, since both cause F_n outputs to be unconditionally enabled.
5. These states are not allowed for control gates (L, P, R, $D)_n$ due to their lack of "OR" array links.

Field Programmable Logic Sequencer (16 x 45 x 12) PLS157

FPLS PROGRAM TABLE

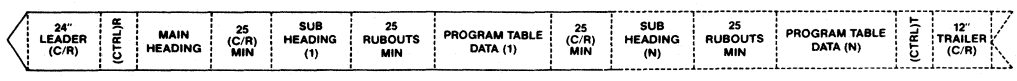


TB01350S

TWX TAPE CODING (LOGIC FORMAT)

The FPLS Program Table can be sent to Signetics in ASCII code format via airmail using any type of 8-level tape (paper, mylar, fanfold, etc.), or via TWX: just dial (910) 339-9283, tell the operator to turn the paper puncher on, and acknowledge. At the end of transmission instruct the operator to send tape to Signetics Order Entry.

A number of Program Tables can be sequentially assembled on a continuous tape as follows, however, limit tape length to a roll of 1.75 inch inside diameter and 4.25 inch outside diameter.



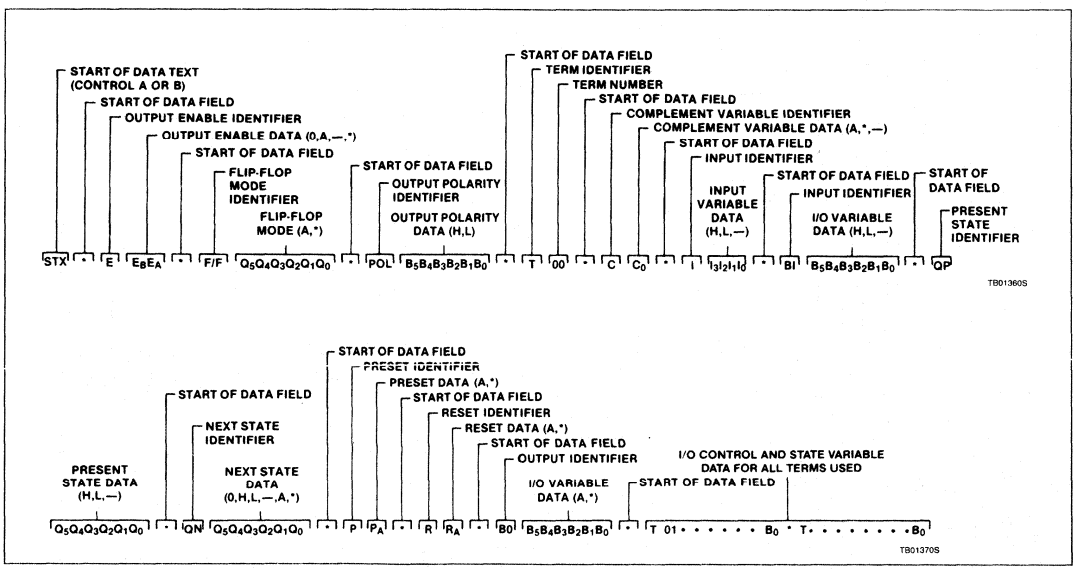
A. The MAIN HEADING at the beginning of tape includes the following information, with each entry preceded by a ($) character, whether used or not:

1. Customer Name
2. Customer TWX No.
3. Date
4. Purchase Order No.
5. Number of Program Tables
6. Total Number of Parts

B. Each SUB HEADING should contain specific information pertinent to each Program Table as follows, with each entry preceded by a ($) character, whether used or not:

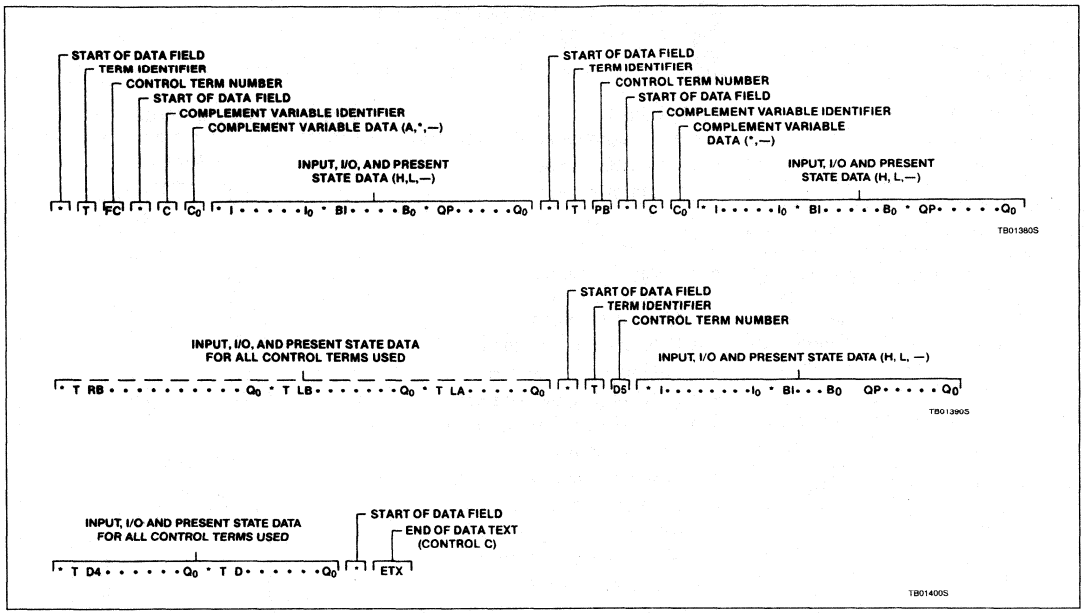
1. Signetics Device No.
2. Program Table No.
3. Revision
4. Date
5. Customer Symbolized Part No.
6. Number of Parts

C. Program Table data blocks are initiated with an STX character, and terminated with an ETX character. The body of the data consists of output polarity, product term, and output information separated by appropriate identifiers in accordance with the following format. Entries for the data fields correspond to those defined in the Logic PROGRAM TABLE:



Field Programmable Logic Sequencer (16 x 45 x 12) PLS157

TWX TAPE CODING (Continued)



4

Signetics

PLS159
Field Programmable Logic Sequencer (16 x 45 x 12)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 20**

DESCRIPTION

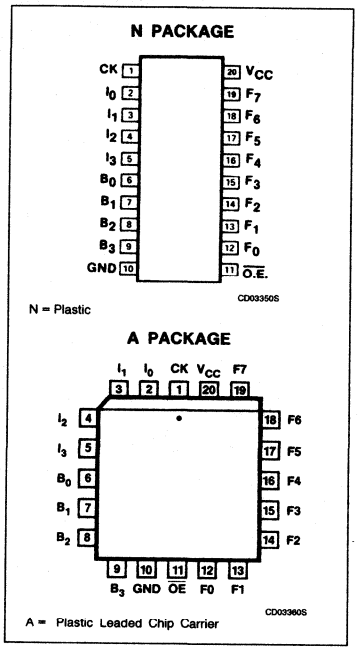
The PLS159 is a Three-State output, registered logic element combining AND/OR gate arrays with clocked J-K flip-flops. These J-K flip-flops are dynamically convertible to D-type via a "fold-back" inverting buffer and control gate F_C. It features 8 registered I/O outputs (F) in conjunction with 4 bidirectional I/O lines (B). These yield variable I/O gate and register configurations via control gates (D, L) ranging from 16 inputs to 12 outputs.

The AND/OR arrays consist of 32 logic AND gates, 13 control AND gates, and 21 OR gates with fusible link connections for programming I/O polarity and direction. All AND gates are linked to 4 inputs (I), bidirectional I/O lines (B), internal flip-flop outputs (Q), and Complement Array output ($\overline{C}$). The Complement Array consists of a NOR gate optionally linked to all AND gates for generating and propagating complementary AND terms.

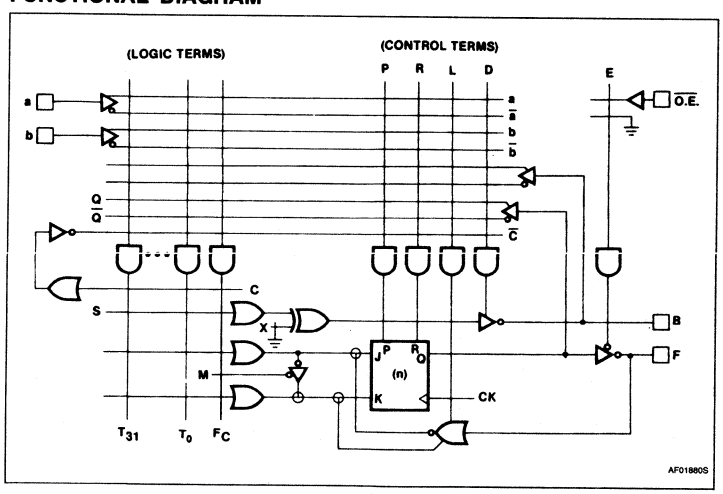
FEATURES

- **Field programmable (Ni-Cr link)**
- **4 dedicated inputs**
- **13 control gates**
- **32 AND gates**
- **21 OR gates**
- **45 product terms:**
  - **32 logic terms**
  - **13 control terms**
- **4 bidirectional I/O lines**
- **8 bidirectional registers**
- **J/K, T, or D-type flip-flops**
- **Asynchronous Preset/Reset**
- **Complement Array**
- **Active high or low outputs**
- **Programmable $\overline{O.E.}$ control**
- **Positive edge trigger clock**
- **Clock frequency: 15MHz (max)**
- **Input loading: −100μA (max)**
- **Power dissipation: 750mW (typ)**
- **TTL compatible**
- **Three-State Outputs**

PIN CONFIGURATION



FUNCTIONAL DIAGRAM



APPLICATIONS

- **Random sequential logic**
- **Synchronous up/down counters**
- **Shift registers**
- **Bidirectional data buffers**
- **Timing function generators**
- **System controllers/synchronizers**
- **Priority encoder/registers**

Field Programmable Logic Sequencer (16 x 45 x 12) PLS159

On-chip T/C buffers couple either True (I, B, Q) or Complement ($\overline{I}$, $\overline{B}$, $\overline{Q}$, $\overline{C}$) input polarities to all AND gates, whose outputs can be optionally linked to all OR gates. One group of AND gates drives bidirectional I/O lines (B), whose output polarity is individually programmable through a set of EX-OR gates for implementing AND-OR or AND-NOR logic functions. Another group drives the J-K inputs of all flip-flops, as well as asynchronous Preset and Reset lines (P, R).

All flip-flops are positive edge-triggered and can be used as input, output or I/O (for interfacing with a bi-directional data bus) in conjunction with load control gates (L), steering inputs (I), (B), (Q) and programmable output select lines (E).

The PLS159 is field programmable, enabling the user to quickly generate custom patterns using standard programming equipment.

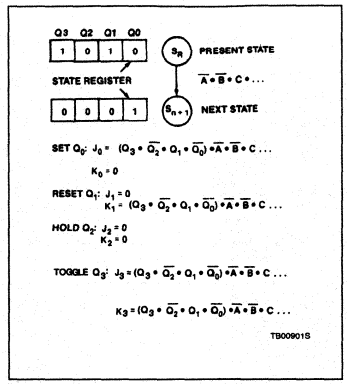
Order codes are contained on the pages following.

VIRGIN STATE

The factory shipped virgin device contains all fusible links intact, such that:

1. $\overline{OE}$ is always enabled.
2. Preset and Reset are always disabled.
3. All transition terms are disabled.
4. All flip-flops are in D-mode unless otherwise programmed to J/K only or J/K or D (controlled).
5. All B pins are inputs and all F pins are outputs unless otherwise programmed.

LOGIC FUNCTION



NOTE:
Similar logic functions are applicable for D and T mode flip-flops.

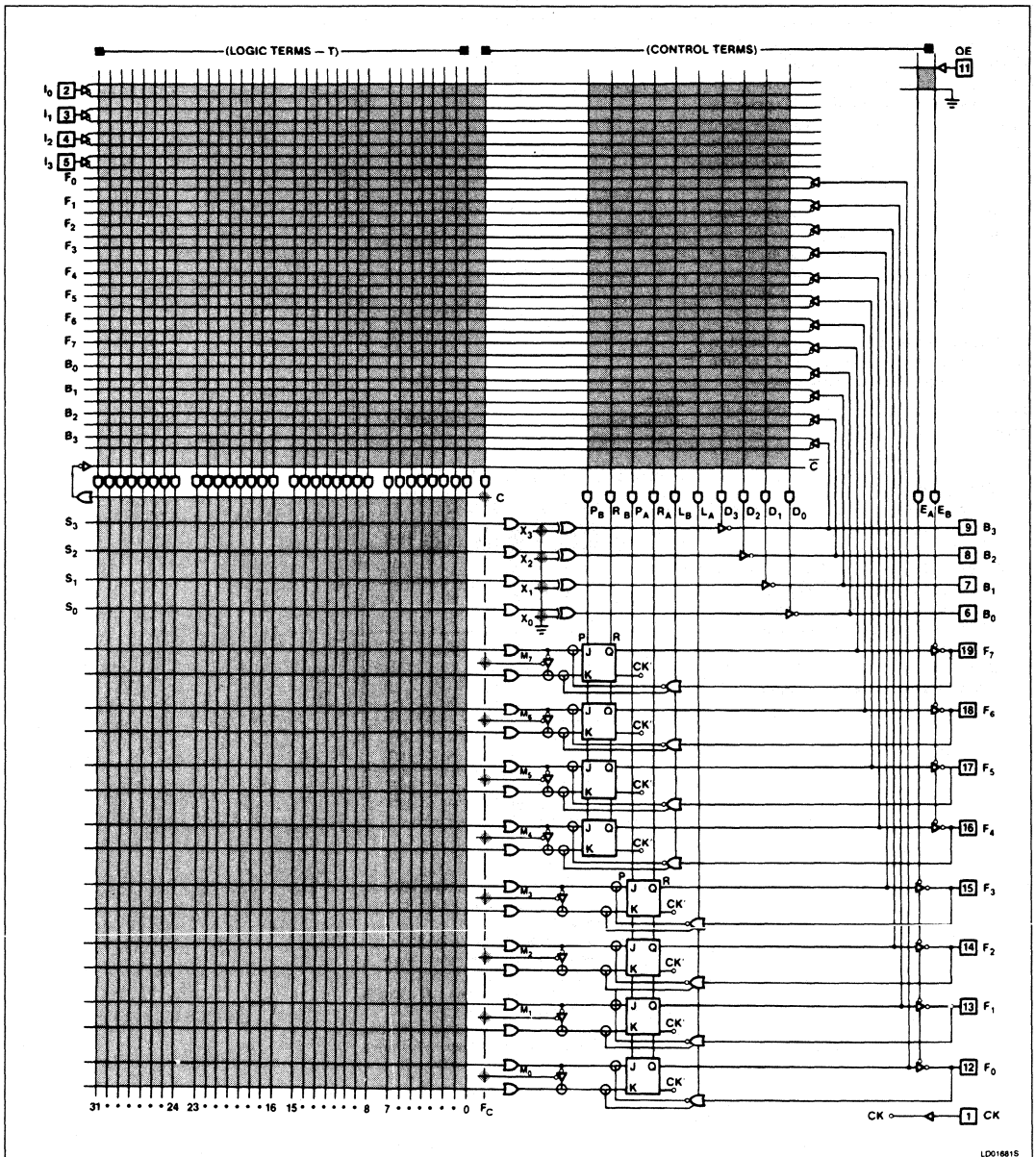
FLIP-FLOP TRUTH TABLE

$\overline{O.E.}$	L	CK	P	R	J	K	Q	F
H								HI-Z
L	X	X	L	X	X	X	L	H
L	X	X	H	L	X	X	H	L
L	X	X	L	H	X	X	L	H
L	L	↑	L	L	L	L	Q	$\overline{Q}$
L	L	↑	L	L	L	H	L	H
L	L	↑	L	L	H	L	H	L
L	L	↑	L	L	H	H	$\overline{Q}$	Q
H	H	↑	L	L	L	H	L	H*
H	H	↑	L	L	H	L	H	L*
+10V	X	↑	X	X	L	H	L	H**
	X	↑	X	X	H	L	H	L**

NOTES:
1. Positive Logic:
   $J/K = T_0 + T_1 + T_2 \ldots\ldots\ldots\ldots T_{45}$
   $T_n = \overline{C} \cdot (I_0 \cdot I_1 \cdot I_2 \ldots) \cdot (Q_0 \cdot Q_1 \ldots) \cdot (B_0 \cdot B_1 \cdot \ldots)$
2. ↑ denotes transition from Low to High level.
3. X = Don't care
4. * = Forced at F_n pin for loading J/K flip-flop in I/O mode. L must be enabled, and other active T_n disabled via steering input(s) I, B, or Q.
5. At P = R = H, Q = H. The final state of Q depends on which is released first.
6. * * = Forced at F_n pin to load J/K flip-flop independent of program code (Diagnostic mode).

Field Programmable Logic Sequencer (16 x 45 x 12) PLS159

FPLS LOGIC DIAGRAM



NOTES:
1. All OR gate inputs with a blown link float to logic "0".
2. All other gates and control inputs with a blown link float to logic "1".
3. ⊕ denotes WIRE-OR.
4. ■ Programmable connection.

Field Programmable Logic Sequencer (16 x 45 x 12) PLS159

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 300mil wide 20 pin	PLS159N
Plastic Leaded Chip Carrier 20 pin	PLS159A

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING Min	RATING Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input currents	−30	+30	mA
I_{OUT}	Output currents		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	−65	+150	

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq +75°C$, $4.75 \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage[3]						
V_{IH}	High	V_{CC} = MAX	2			V
V_{IL}	Low	V_{CC} = MIN			0.80	
V_{IC}	Clamp	V_{CC} = MIN, I_{IN} = −12mA		−0.8	−1.2	
Output voltage[3]		V_{CC} = MIN				
V_{OH}	High	I_{OH} = −2mA	2.4			V
V_{OL}	Low	I_{OL} = 10mA		0.35	0.5	
Input current[8]		V_{CC} = MAX				
I_{IH}	High	V_{IN} = 5.5V		< 1	80	
I_{IL}	Low	V_{IN} = 0.45V		−10	−100	μA
Output current		V_{CC} = MAX				
$I_{O\ (OFF)}$	Hi-Z State[8]	V_{OUT} = 5.5V		1	80	μA
		V_{OUT} = 0.45V		−1	−140	
I_{OS}	Short circuit[4]	V_{OUT} = 0V	−15		−70	mA
I_{CC}	V_{CC} supply current[7]	V_{CC} = MAX		150	190	mA
Capacitance		V_{CC} = 5.0V				
C_{IN}	Input	V_{IN} = 2.0V		8		pF
C_{OUT}	Output	V_{OUT} = 2.0V		15		

NOTES:
1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other condition above those indicated in the operational and programming specification of the device is not implied.
2. All typical values are at V_{CC} = 5V, T_A = 25°C.
3. All voltage values are with respect to network ground terminal.
4. Test one at a time.
5. Measured with V_{IH} applied to $\overline{OE}$.
6. Duration of short circuit should not exceed 1 second.
7. I_{CC} is measured with the $\overline{OE}$ input grounded, all other inputs at 4.5V, and the outputs open.
8. Leakage values are a combination of input and output leakage.

Field Programmable Logic Sequencer (16 x 45 x 12) PLS159

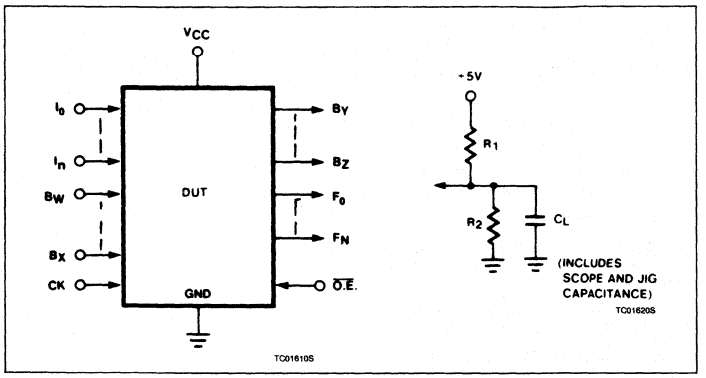
AC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq +75°C$, $4.75 \leq V_{CC} \leq 5.25V$, $R_1 = 470\Omega$, $R_2 = 1k\Omega$

PARAMETER		TO	FROM	TEST CONDITIONS	LIMITS			UNIT
					Min[5]	Typ[1]	Max	
Pulse width								
T_{CKH}	Clock[2] high	CK −	CK +		25	20		
T_{CKL}	Clock low	CK +	CK −	$C_L = 30pF$	30	20		ns
T_{CKP}	Period	CK +	CK +		70	50		
T_{PRH}	Preset/Reset pulse	(I,B) +	(I,B) −		40	30		
Set-up time								
T_{IS1}	Input	CK +	(I,B) ±		40	30		
T_{IS2}	Input (through F_n)	CK +	F ±	$C_L = 30pF$	−	10		ns
T_{IS3}	Input (through Complement array)[4]	CK +	(I,B) ±		65	40		
Hold time								
T_{IH1}	Input	CK +	(I,B) ±	$C_L = 30pF$	0	−10		ns
T_{IH2}		CK +	F ±		−	10		
Propagation delays								
T_{CKO}	Clock	F ±	CK +	$C_L = 30pF$		25	30	ns
T_{OE1}	Output enable	F −	$\overline{O.E.}$ −	$C_L = 30pF$		20	30	
T_{OD1}	Output disable[3]	F +	$\overline{O.E.}$ +	$C_L = 5pF$		20	55	
T_{PD}	Output	B ±	(I,B) ±	$C_L = 30pF$		40	50	ns
T_{OE2}	Output enable	B ±	(I,B) +			35	55	
T_{OD2}	Output disable[3]	B +	(I,B) −	$C_L = 5pF$		30	35	
T_{PRO}	Preset/Reset	F ±	(I,B) +	$C_L = 30pF$		50	55	

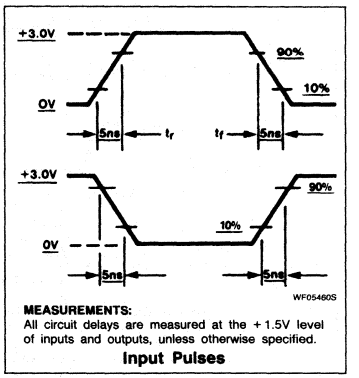
NOTES:
1. All typical values are at $V_{CC} = 5V$, $T_A = 25°C$.
2. To prevents spurious clocking, clock rise time (10% − 90%) ≤ 10ns.
3. Measured at $V_T = V_{OL} + 0.5V$.
4. When using the Complement Array $T_{CKP} = 95ns$ (min).
5. Limits are guaranteed with 12 product terms maximum connected to each sum term line.
6. For test circuits, waveforms and timing diagrams see pages 6 and 7.

Field Programmable Logic Sequencer (16 x 45 x 12) PLS159

TEST LOAD CIRCUIT



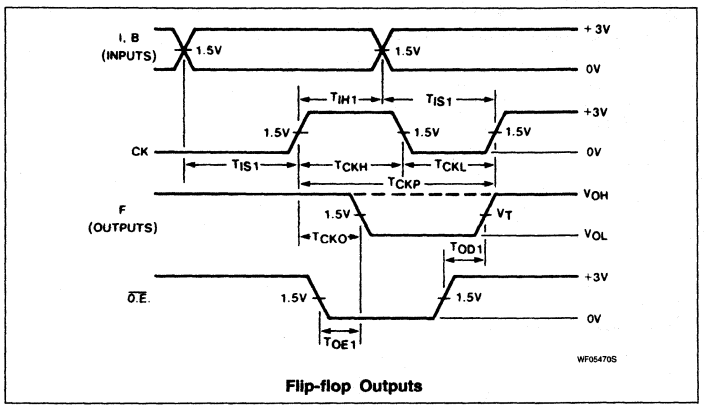
VOLTAGE WAVEFORM



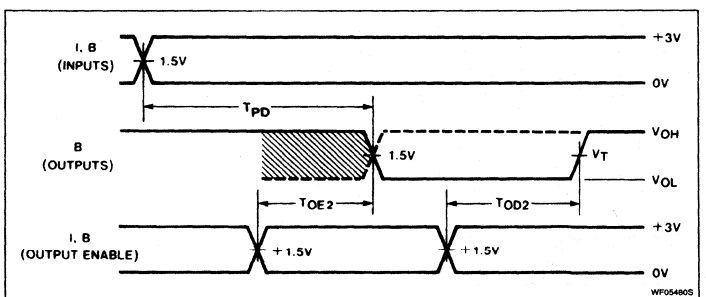
MEASUREMENTS:
All circuit delays are measured at the +1.5V level of inputs and outputs, unless otherwise specified.

Input Pulses

TIMING DIAGRAMS



Flip-flop Outputs



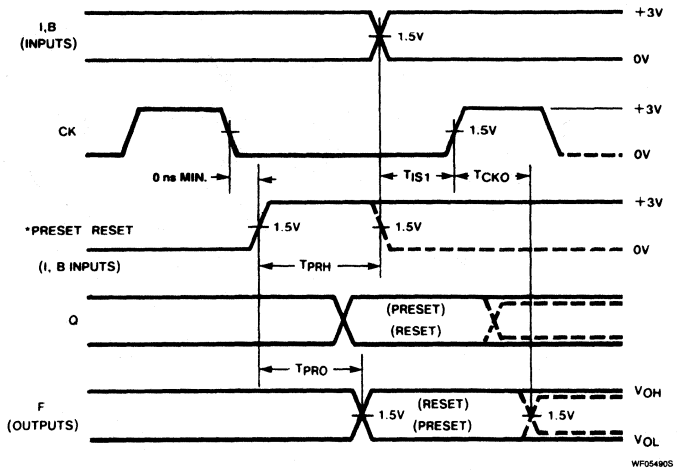
Gate Outputs

MEMORY TIMING DEFINITIONS

T_{CKH}	Width of input clock pulse.
T_{CKL}	Interval between clock pulses.
T_{CKP}	Clock period.
T_{PRH}	Width of preset input pulse.
T_{IS1}	Required delay between beginning of valid input and positive transition of clock.
T_{IS2}	Required delay between beginning of valid input forced at flip-flop output pins, and positive transition of clock.
T_{IH1}	Required delay between positive transition of clock and end of valid input data.
T_{IH2}	Required delay between positive transition of clock and end of valid input data forced at flip-flop output pins.
T_{CKO}	Delay between positive transition of clock and when Outputs become valid (with $\overline{O.E.}$ low).
T_{OE1}	Delay between beginning of Output Enable Low and when Outputs become valid.
T_{OD1}	Delay between beginning of Output Enable High and when Outputs are in the off state.
T_{PD}	Propagation delay between combinational inputs and outputs.
T_{OE2}	Delay between predefined Output Enable High, and when combinational Outputs become valid.
T_{OD2}	Delay between predefined Output Enable Low, and when combinational Outputs are in the off state.
T_{PRO}	Delay between positive transition of predefined Preset/Reset input, and when flip-flop outputs become valid.

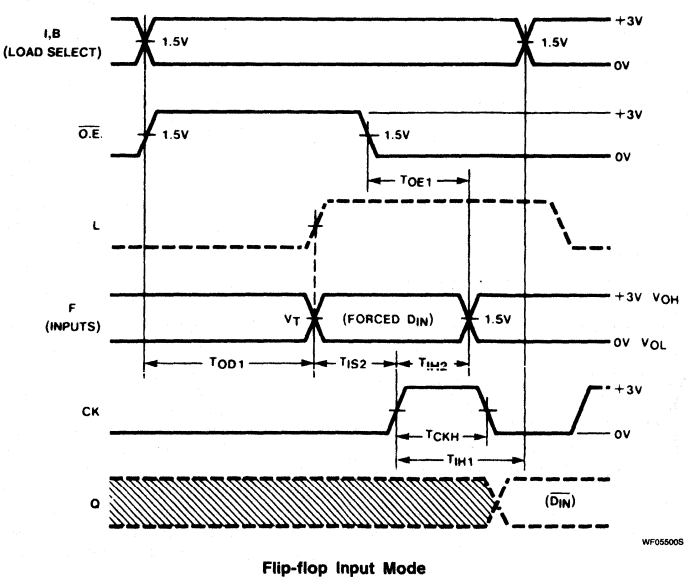
4

TIMING DIAGRAMS (Continued)



* The leading edge of preset/reset must occur only when the input clock is "low", and must remain "high" as long as required to override clock. The falling edge of preset/reset can never go "low" when the input clock is "high".

Asynchronous Preset/Reset



Flip-flop Input Mode

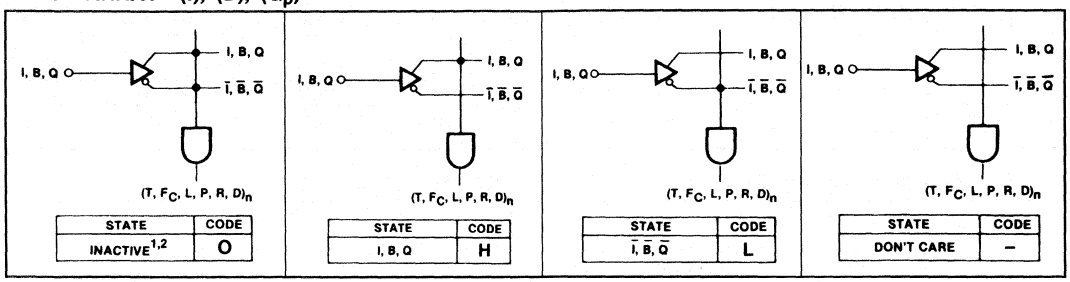
Field Programmable Logic Sequencer (16 x 45 x 12) PLS159

The FPLS can be programmed by means of Logic Programming equipment.

With Logic programming, the AND/OR-EX-OR input connections necessary to implement the desired logic function are coded directly from the State Diagram using the Program Tables on the following pages.

In these tables, the logic state or action of all I/O, control, and state variables is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

"AND" ARRAY – (I), (B), (Q_P)



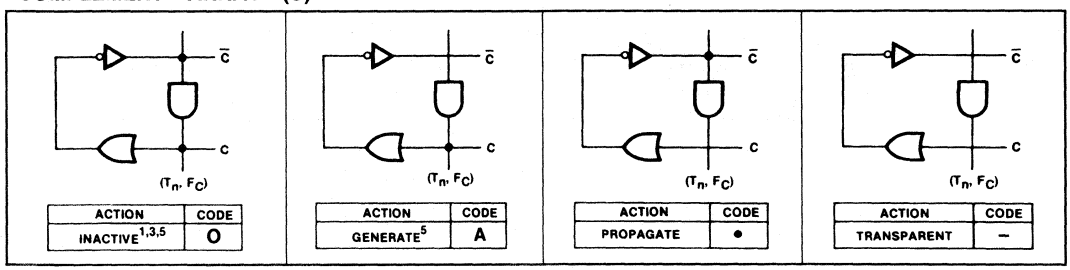
STATE	CODE
INACTIVE[1,2]	O

STATE	CODE
I, B, Q	H

STATE	CODE
Ī, B̄, Q̄	L

STATE	CODE
DON'T CARE	–

"COMPLEMENT" ARRAY – (C)



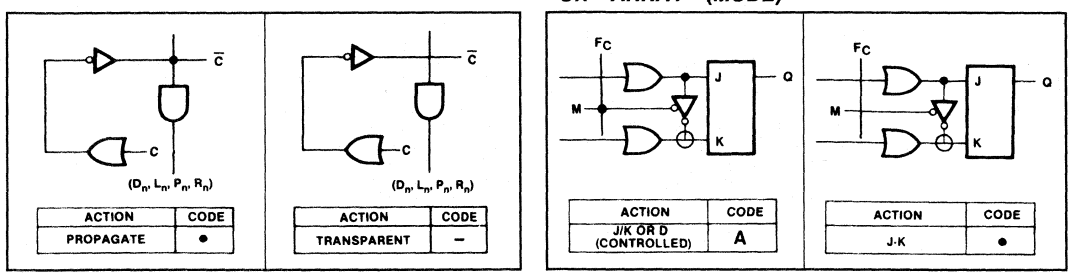
ACTION	CODE
INACTIVE[1,3,5]	O

ACTION	CODE
GENERATE[5]	A

ACTION	CODE
PROPAGATE	•

ACTION	CODE
TRANSPARENT	–

"OR" ARRAY – (MODE)



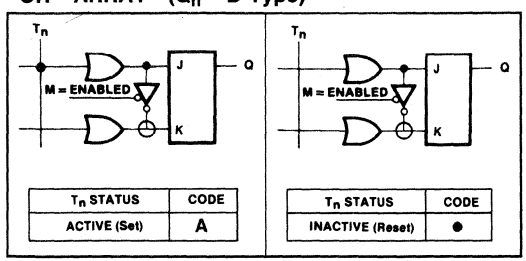
ACTION	CODE
PROPAGATE	•

ACTION	CODE
TRANSPARENT	–

ACTION	CODE
J/K OR D (CONTROLLED)	A

ACTION	CODE
J-K	•

"OR" ARRAY – (Q_n = D-Type)



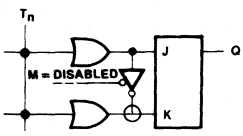
Tn STATUS	CODE
ACTIVE (Set)	A

Tn STATUS	CODE
INACTIVE (Reset)	•

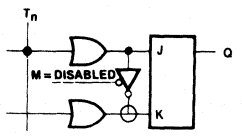
Notes on following page.

Field Programmable Logic Sequencer (16 x 45 x 12) PLS159

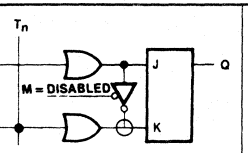
"OR" ARRAY – (Q_n = J-K Type)



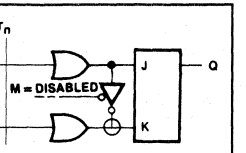
ACTION	CODE
TOGGLE	O



ACTION	CODE
SET	H

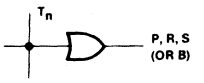


ACTION	CODE
RESET	L

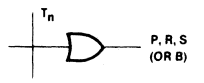


ACTION	CODE
HOLD	–

"OR" Array – (S or B), (P), (R)

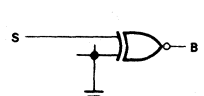


T_n STATUS	CODE
ACTIVE	A

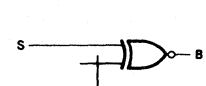


T_n STATUS	CODE
INACTIVE	•

"EX-OR" ARRAY – (B)

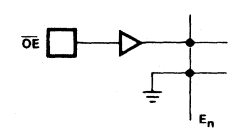


POLARITY	CODE
LOW	L

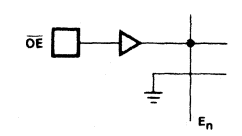


POLARITY	CODE
HIGH	H

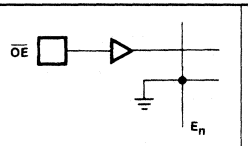
"$\overline{O.E.}$" ARRAY – (E)



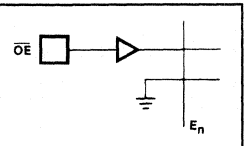
ACTION	CODE
IDLE[4]	O



ACTION	CODE
CONTROL	A



ACTION	CODE
ENABLE[4]	•

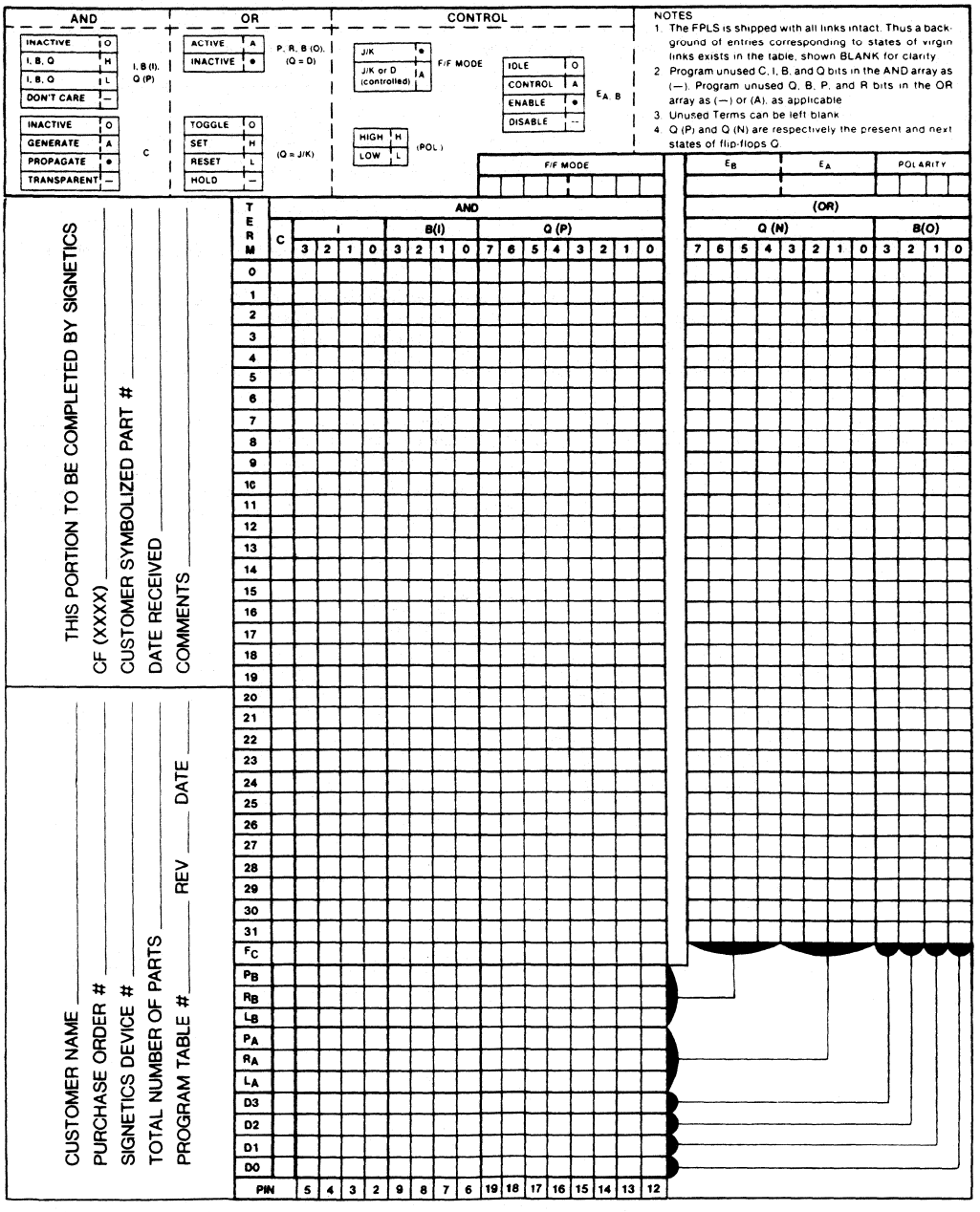


ACTION	CODE
DISABLE	–

NOTES:
1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates.
2. Any gate (T, F_C, L, P, R, D)$_n$ will be unconditionally inhibited if any one of the I, B, or Q link pairs is left intact.
3. To prevent oscillations, this state is not allowed for C link pairs coupled to active gates T_n, F_C.
4. E_n = O and E_n = • are logically equivalent states, since both cause F_n outputs to be unconditionally enabled.
5. These states are not allowed for control gates (L, P, R, D)$_n$ due to their lack of "OR" array links.

Field Programmable Logic Sequencer (16 x 45 x 12) PLS159

FPLS PROGRAM TABLE



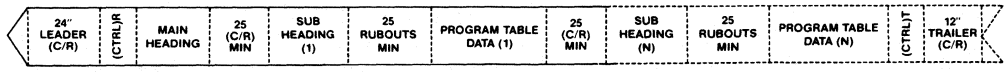
TB01290S

Field Programmable Logic Sequencer (16 x 45 x 12) PLS159

TWX TAPE CODING (LOGIC FORMAT)

The FPLS Program Table can be sent to Signetics in ASCII code format via airmail using any type of 8-level tape (paper, mylar, fanfold, etc.), or via TWX: just dial (910) 339-9283, tell the operator to turn the paper puncher on, and acknowledge. At the end of transmission instruct the operator to send tape to Signetics Order Entry.

A number of Program Tables can be sequentially assembled on a continuous tape as follows, however, limit tape length to a roll of 1.75 inch inside diameter and 4.25 inch outside diameter.



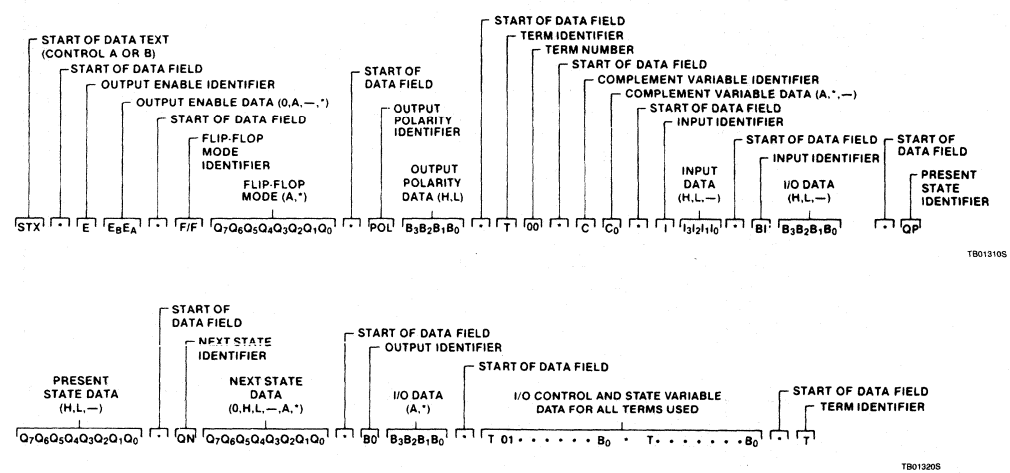
A. The MAIN HEADING at the beginning of tape includes the following information, with each entry preceded by a ($) character, whether used or not:

1. Customer Name
2. Customer TWX No.
3. Date
4. Purchase Order No.
5. Number of Program Tables
6. Total Number of Parts

B. Each SUB HEADING should contain specific information pertinent to each Program Table as follows, with each entry preceded by a ($) character, whether used or not:

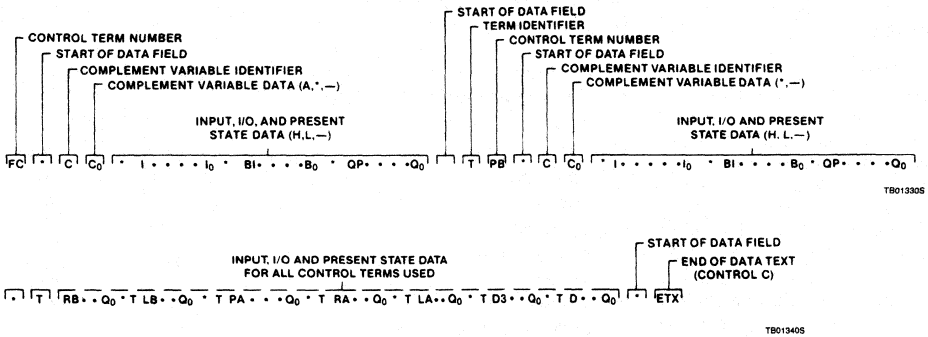
1. Signetics Device No.
2. Program Table No.
3. Revision
4. Date
5. Customer Symbolized Part No.
6. Number of Parts

C. Program Table data blocks are initiated with an STX character, and terminated with an ETX character. The body of the data consists of output polarity, product term, and output information separated by appropriate identifiers in accordance with the following format. Entries for the data fields correspond to those defined in the Logic PROGRAM TABLE:



Field Programmable Logic Sequencer (16 x 45 x 12) PLS159

TWX TAPE CODING (Continued)



4

Signetics

PLS159A
Field Programmable Logic Sequencer (16 x 45 x 12)

Signetics Programmable Logic
Objective Specification

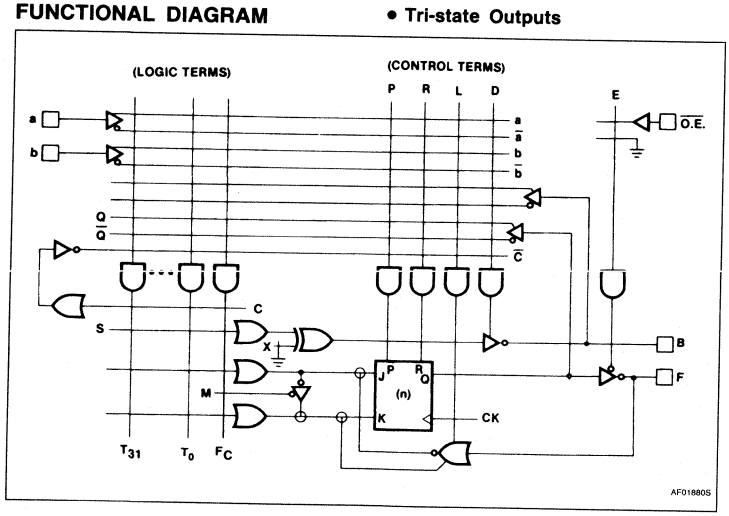
Application Specific Products
- **Series 20**

DESCRIPTION

The PLS159A is a Tri-state output, registered logic element combining AND/OR gate arrays with clocked J-K flip-flops. These J-K flip-flops are dynamically convertible to D-type via a "fold-back" inverting buffer and control gate F_C. It features 8 registered I/O outputs (F) in conjunction with 4 bidirectional I/O lines (B). These yield variable I/O gate and register configurations via control gates (D, L) ranging from 16 inputs to 12 outputs.

The AND/OR arrays consist of 32 logic AND gates, 13 control AND gates, and 21 OR gates with fusible link connections for programming I/O polarity and direction. All AND gates are linked to 4 inputs (I), bidirectional I/O lines (B), internal flip-flop outputs (Q), and Complement Array output ($\overline{C}$). The Complement Array consists of a NOR gate optionally linked to all AND gates for generating and propagating complementary AND terms.

FUNCTIONAL DIAGRAM

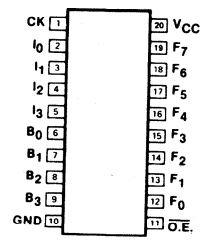


FEATURES

- **Field programmable (Ni-Cr link)**
- **4 dedicated inputs**
- **13 control gates**
- **32 AND gates**
- **21 OR gates**
- **45 product terms:**
  - **32 logic terms**
  - **13 control terms**
- **4 bidirectional I/O lines**
- **8 bidirectional registers**
- **J/K, T, or D-type flip-flops**
- **Power on reset feature on all flip-flops (F_n = 1)**
- **Asynchronous Preset/Reset**
- **Complement Array**
- **Active high or low outputs**
- **Programmable $\overline{O.E.}$ control**
- **Positive edge-trigger clock**
- **Clock frequency: 18MHz (max)**
- **Input loading: −100μA (max)**
- **Power dissipation: 725mW (typ)**
- **TTL compatible**
- **Tri-state Outputs**

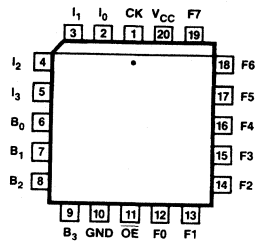
PIN CONFIGURATION

N PACKAGE



N = Plastic

A PACKAGE



A = Plastic Leaded Chip Carrier

APPLICATIONS

- **Random sequential logic**
- **Synchronous up/down counters**
- **Shift registers**
- **Bidirectional data buffers**
- **Timing function generators**
- **System controllers/synchronizers**
- **Priority encoder/registers**

Field Programmable Logic Sequencer (16 x 45 x 12) PLS159A

On-chip T/C buffers couple either True (I, B, Q) or Complement ($\overline{I}$, $\overline{B}$, $\overline{Q}$, $\overline{C}$) input polarities to all AND gates, whose outputs can be optionally linked to all OR gates. One group of AND gates drives bidirectional I/O lines (B), whose output polarity is individually programmable through a set of EX-OR gates for implementing AND-OR or AND-NOR logic functions. Another group drives the J-K inputs of all flip-flops, as well as asynchronous Preset and Reset lines (P, R).

All flip-flops are positive edge-triggered and can be used as input, output or I/O (for interfacing with a bi-directional data bus) in conjunction with load control gates (L), steering inputs (I), (B), (Q) and programmable output select lines (E).

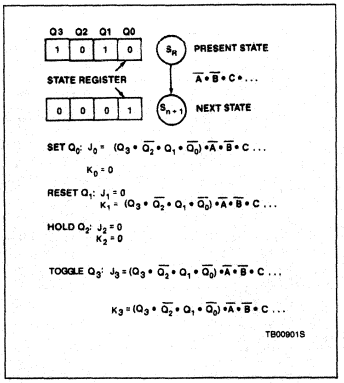
The PLS159A is field programmable, enabling the user to quickly generate custom patterns using standard programming equipment.

VIRGIN STATE

The factory shipped virgin device contains all fusible links intact, such that:

1. $\overline{OE}$ is always enabled.
2. Preset and Reset are always disabled.
3. All transition terms are disabled.
4. All flip-flops are in D-mode unless otherwise programmed to J/K only or J/K or D (controlled).
5. All B pins are inputs and all F pins are outputs unless otherwise programmed.

LOGIC FUNCTION



NOTE:
Similar logic functions are applicable for D and T mode flip-flops.

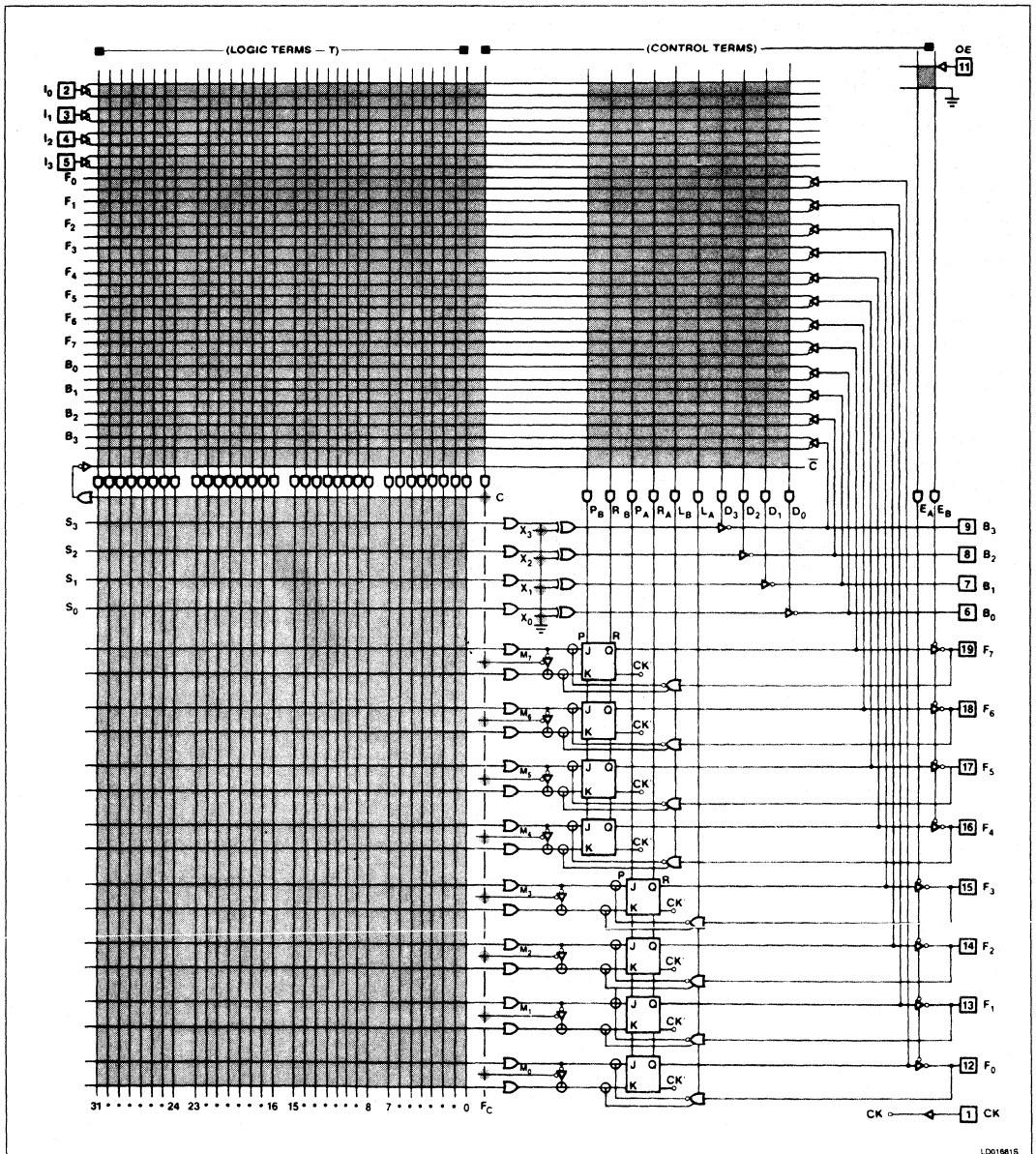
FLIP-FLOP TRUTH TABLE

$\overline{O.E.}$	L	CK	P	R	J	K	Q	F
H								Hi-Z
L	X	X	L	X	X	X	L	H
L	X	X	H	L	X	X	H	L
L	X	X	L	H	X	X	L	H
L	L	↑	L	L	L	L	Q	$\overline{Q}$
L	L	↑	L	L	L	H	L	H
L	L	↑	L	L	H	L	H	L
L	L	↑	L	L	H	H	$\overline{Q}$	Q
H	H	↑	L	L	L	H	L	H*
H	H	↑	L	L	H	L	H	L*
+10V	X	↑	X	X	L	H	L	H**
	X	↑	X	X	H	L	H	L**

NOTES:
1. Positive Logic:
   $J/K = T_0 + T_1 + T_2$ ..... T_{45}
   $T_n = \overline{C} \bullet (I_0 \bullet I_1 \bullet I_2 \ldots) \bullet (Q_0 \bullet Q_1 \ldots) \bullet (B_0 \bullet B_1 \bullet \ldots)$
2. ↑ denotes transition from Low to High level.
3. X = Don't care
4. * = Forced at F_n pin for loading J/K flip-flop in I/O mode. L must be enabled, and other active T_n disabled via steering input(s) I, B, or Q.
5. At P = R = H, Q = H. The final state of Q depends on which is released first.
6. * * = Forced at F_n pin to load J/K flip-flop independent of program code (Diagnostic mode).

Field Programmable Logic Sequencer (16 x 45 x 12) PLS159A

FPLS LOGIC DIAGRAM



NOTES:
1. All OR gate inputs with a blown link float to logic "0".
2. All other gates and control inputs with a blown link float to logic "1".
3. ⊕ denotes WIRE-OR.
4. ◉ Programmable connection.

Signetics

Application Specific Products

Section 5
PLD Data Sheets

INDEX

Signetics

PLS161
Field Programmable Logic Array (12 x 48 x 8)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 24**

DESCRIPTION

The PLS161 is a bipolar, Field Programmable Logic Array (FPLA). The device utilizes the standard AND/OR/Invert architecture to directly implement custom sum of product logic equations.

This device consists of 12 dedicated inputs and 8 dedicated outputs. Each output is capable of being actively controlled by any or all of the 48 product terms. The True, Complement, or Don't Care condition of each of the 12 inputs ANDed together comprise one P-term. All 48 P-terms are selectively ORed to each output. The user must then only select which P-terms will activate an output by disconnecting terms which do not affect the output. In addition each output can be fused as active-high (H) or active-low (L).

The PLS161 is fully TTL compatible, and includes a chip enable input for output inhibit control and expansion of input variables.

Order codes are contained on the pages following.

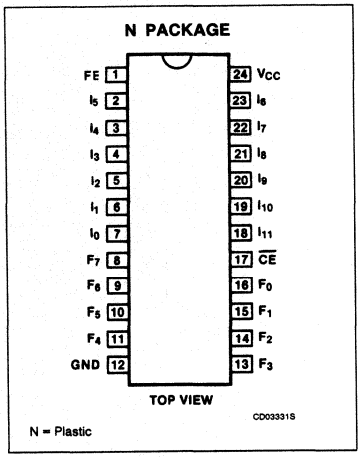
FEATURES

- **Field programmable (Ni-Cr Link)**
- **Input variables: 12**
- **Output functions: 8**
- **Product terms: 48**
- **I/O propagation delay: 50ns (max)**
- **Power dissipation: 600mW typ.**
- **Input loading: −100μA (max)**
- **Chip enable input**
- **Output disable function**
- **Separate I/O architecture**
- **Tri-state outputs**

APPLICATIONS

- **CRT display systems**
- **Random logic**
- **Code conversion**
- **Peripheral controllers**
- **Function generators**
- **Look-up and decision tables**
- **Microprogramming**
- **Address mapping**
- **Character generators**
- **Sequential controllers**
- **Data security encoders**
- **Fault detectors**
- **Frequency synthesizers**

PIN CONFIGURATION



N = Plastic

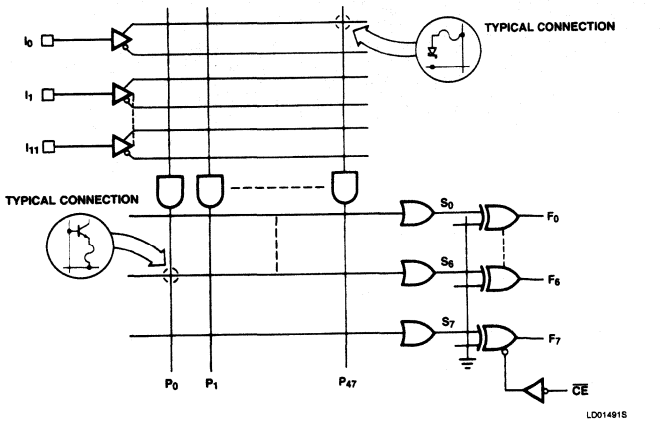
LOGIC FUNCTION

TYPICAL PRODUCT TERM
$P_0 = I_0 \cdot I_1 \cdot \overline{I_2} \cdot I_5 \cdot \overline{I_{11}}$

TYPICAL OUTPUT FUNCTIONS:
@ $\overline{CE} = 0$:
$F_0 = (P_0 + P_1 + P_2)$ @ L = CLOSED
$F_0 = (\overline{P_0} \cdot \overline{P_1} \cdot \overline{P_2})$ @ L = OPEN

NOTE:
For each of the 8 outputs either the function F_p (active-high) or F_p (active-low) is available, but not both. The required function polarity is programmed via link (L).

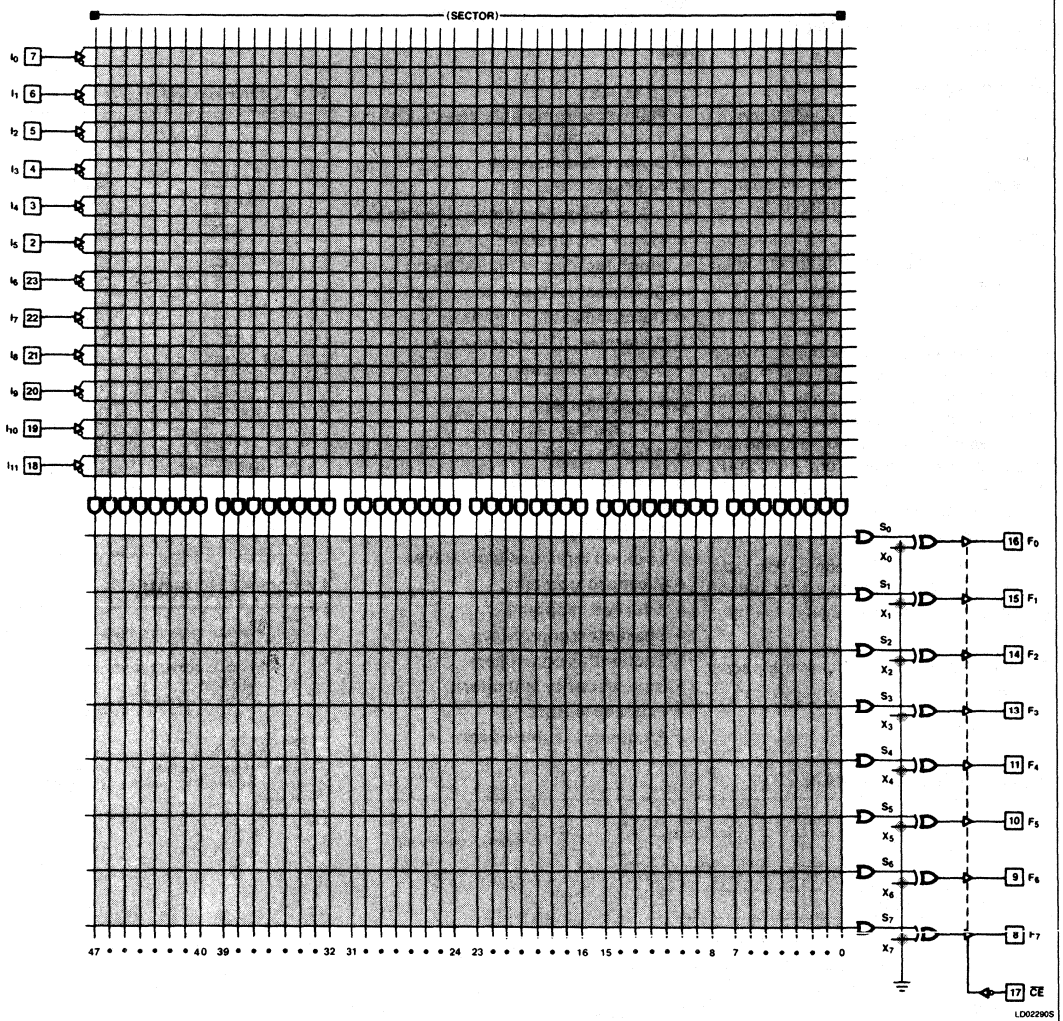
FUNCTIONAL DIAGRAM



NOTE:
1. Fusible Ni-Cr links are initially at all array cross-points.

Field Programmable Logic Array (12 x 48 x 8) PLS161

FPLA LOGIC DIAGRAM



NOTES:
1. All AND/EX-OR gate inputs with a blown link float to a logic "1".
2. All OR gate inputs with a blown link float to a logic "0".
3. ⊗ Programmable connection.

Field Programmable Logic Array (12 x 48 x 8) PLS161

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 300mil 24 pin	PLS161N

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING Min	RATING Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input currents	−30	+30	mA
I_{OUT}	Output currents		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	−65	+150	

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq 75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage[3]						
V_{IH}	High	V_{CC} = Max	2			V
V_{IL}	Low	V_{CC} = Min			0.8	
V_{IC}	Clamp[4]	V_{CC} = Min, I_{IN} = −12mA		−0.8	−1.2	
Output voltage[3]		V_{CC} = Min				
V_{OH}	High[5]	I_{OH} = −2mA	2.4			V
V_{OL}	Low[6]	I_{OL} = 9.6mA		0.35	0.45	
Input current		V_{CC} = MAX				
I_{IH}	High	V_{IN} = 5.5V		< 1	40	μA
I_{IL}	Low	V_{IN} = 0.45V		−10	−100	
Output current		$\overline{CE}$ = HIGH, V_{CC} = Max				
$I_{O(OFF)}$	Hi-Z State	V_{OUT} = 5.5V		1	40	μA
		V_{OUT} = 0.45V		−1	−40	
I_{OS}	Short circuit[4, 7]	$\overline{CE}$ = LOW, V_{OUT} = 0V	−15		−70	mA
I_{CC}	V_{CC} supply current[8]	V_{CC} = Max		120	170	mA
Capacitance		$\overline{CE}$ = HIGH, V_{CC} = 5.0V				
C_{IN}	Input	V_{IN} = 2V		8		pF
C_{OUT}	Output	V_{OUT} = 2V		17		

Notes on following page.

Field Programmable Logic Array (12 x 48 x 8) PLS161

AC ELECTRICAL CHARACTERISTICS $R_1 = 470\Omega$, $R_2 = 1k\Omega$, $C_L = 30pF$, $0°C \leq T_A \leq +75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TO	FROM	LIMITS			UNIT
				Min	Typ[2]	Max	
Propagation delay							
T_{PD}	Input	Output	Input		35	50	ns
T_{CE}	Chip enable	Output	Chip enable		15	30	
Disable time							
T_{CD}	Chip disable	Output	Chip enable		15	30	ns

NOTES:

1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other conditions above those indicated in the operational and programming specification of the device is not implied.
2. All values are at $V_{CC} = 5V$, $T_A = 25°C$.
3. All voltage values are with respect to network ground terminal.
4. Test one pin at a time.
5. Measured with V_{IL} applied to $\overline{CE}$ and a logic high stored.
6. Measured with a programmed logic condition for which the output test is at a low logic level. Output sink current is applied thru a resistor to V_{CC}.
7. Duration of short circuit should not exceed 1 second.
8. I_{CC} is measured with the chip enable input grounded, all other inputs at 4.5V and the outputs open.

Field Programmable Logic Array (12 x 48 x 8) PLS161

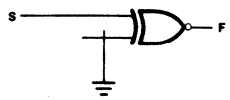
LOGIC PROGRAMMING

The FPLA can be programmed by means of Logic programming equipment.

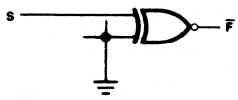
With Logic programming, the AND/OR/EX-OR gate input connections necessary to implement the desired logic function are coded directly from logic equations using the Program Table on the following page.

In this Table the logic state or action of variables I, P, and F, associated with each Sum Term S_n, is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

EX-OR ARRAY – (F)

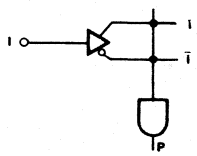


ACTIVE LEVEL	CODE
HIGH	H

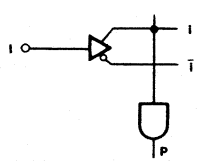


ACTIVE LEVEL	CODE
LOW	L

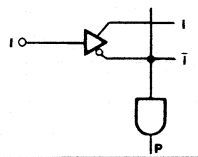
"AND" ARRAY – (I)



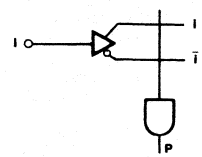
STATE	CODE
INACTIVE[1,2]	O



STATE	CODE
I	H

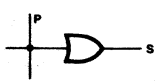


STATE	CODE
I	L

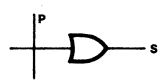


STATE	CODE
DON'T CARE	—

"OR" ARRAY – (F)



P_n STATUS	CODE
ACTIVE	A



P_n STATUS	CODE
INACTIVE	•

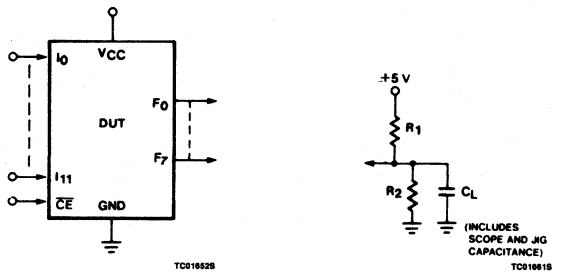
NOTES:

1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates P_n.
2. Any gate P_n will be unconditionally inhibited if any one of its (I) link pairs is left intact.

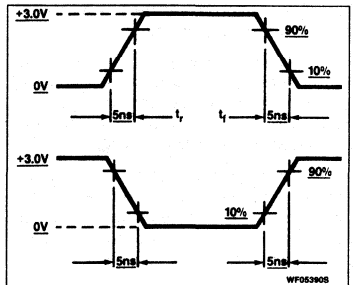
5

Field Programmable Logic Array (12 x 48 x 8) PLS161

TEST LOAD CIRCUIT



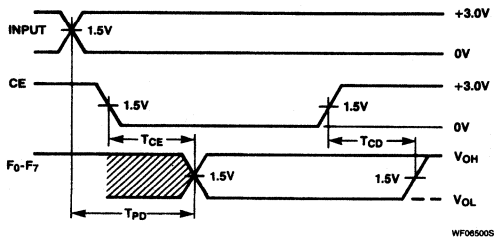
VOLTAGE WAVEFORM



MEASUREMENTS:
All circuit delays are measured at the +1.5V level of inputs and outputs, unless otherwise specified.

Input Pulses

TIMING DIAGRAMS



Read Cycle

TIMING DEFINITIONS

T_{CE} Delay between beginning of Chip Enable low (with Input valid) and when Data Output becomes valid.

T_{CD} Delay between when Chip Enable becomes high and Data Output is in off state (Hi-Z or high).

T_{PD} Delay between beginning of valid Input (with Chip Enable low) and when Data Output becomes valid.

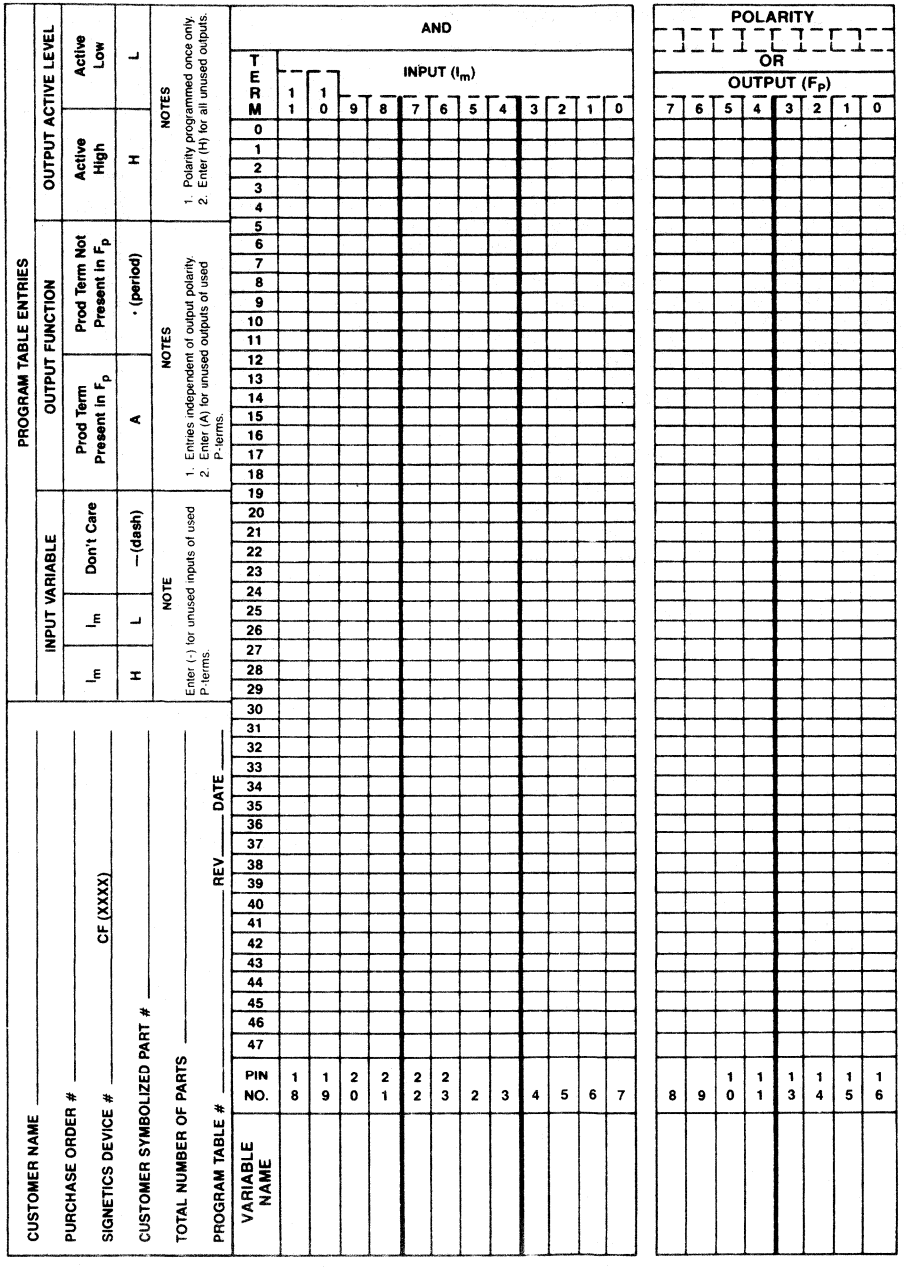
VIRGIN STATE

The PLS161 virgin device is factory shipped in an unprogrammed state, characterized by:

1. All internal Ni-Cr links are intact.
2. Each product term (P-term) contains both true and complement values of every input variable I_m (P-terms always logically "false").
3. The "OR" Matrix contains all 48 P-terms.
4. The polarity of each output is set to active high (F_p Function).
5. All outputs are at a low logic level.

Field Programmable Logic Array (12 x 48 x 8) PLS161

FPLA PROGRAM TABLE



TB01540S

5

Signetics

PLS162
Field Programmable Address Decoder (16 x 5)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 24**

DESCRIPTION

The PLS162 is a bipolar, Field Programmable Address Decoder. The device consists of five AND/NAND gates which share 16 common inputs. The type of gate is selected by programming the output as active-HIGH (H) or active-LOW (L). Each of the 16 inputs $I_0 - I_{15}$ can be programmed to provide the True (H), Complement (L), or Don't Care (—) state to each of the five AND/NAND gates. OR/NOR logic functions can also be implemented by complementing the inputs and outputs via on-chip inverting buffers.

The device is field programmable, which means that custom patterns are immediately available.

The PLS162 includes chip-enable control for output strobing and inhibit. It features Tri-State outputs for ease of expansion of input variables and application in bus-organized systems.

Order codes are contained on the following pages.

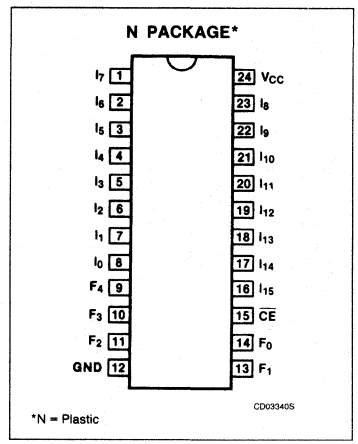
FEATURES

- **Field programmable (Ni-Cr link)**
- **16 input variables**
- **5 output functions**
- **Chip enable input**
- **I/O propagation delay: 30ns max**
- **Power dissipation: 500mW typ**
- **Input loading: −100μA max**
- **Output: Tri-State**
- **Output disable function: Hi-Z**
- **Fully TTL compatible**

APPLICATIONS

- **Random logic**
- **Address decoders**
- **Code detectors**
- **Peripheral selectors**
- **Fault monitors**
- **Machine state decoders**

PIN CONFIGURATION



*N = Plastic

LOGIC FUNCTION

TYPICAL OUTPUT FUNCTIONS:

ACTIVE-HIGH

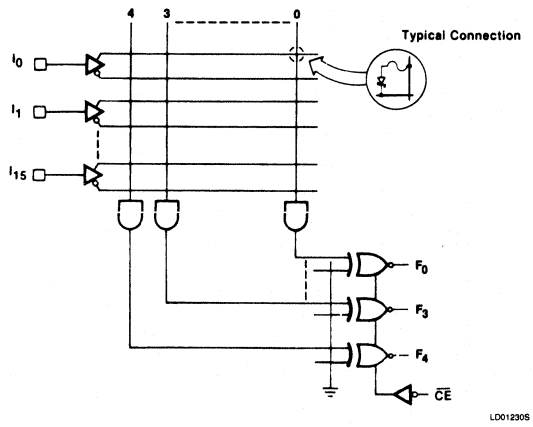
$X = A \cdot \overline{B} \cdot C \cdot \ldots$

ACTIVE-LOW

$\overline{X} = A \cdot \overline{B} \cdot C \cdot \ldots$
$X = \overline{A} + B + \overline{C} + \ldots$

NOTES:
1. For each of the 5 outputs, either function X (active-high) or $\overline{X}$ (active-low) is available, but not both. The desired output polarity is programmed via the EX-OR gates.
2. X, A, B, C, etc. are user defined connections to fixed inputs (I) and output pins (F).

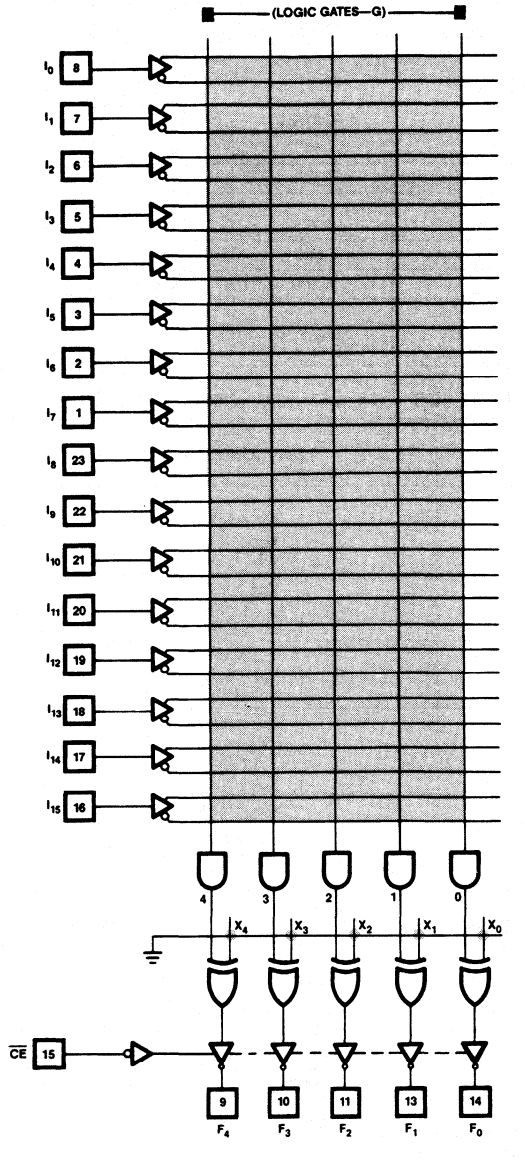
FUNCTIONAL DIAGRAM



Fusible Ni-Cr links are initially intact at all array cross-points.

Field Programmable Address Decoder (16 x 5) PLS162

FPAD LOGIC DIAGRAM



NOTE:
1. All gate inputs with a blown link float to a logic "1".
2. Programmable connection.

Field Programmable Address Decoder (16 x 5) PLS162

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 300mil 24 pin	PLS162N

ABSOLUTE MAXIMUM RATINGS

PARAMETER		RATING	UNIT
V_{CC}	Supply voltage	+7	V_{dc}
V_{IN}	Input voltage	+5.5	V_{dc}
V_O	Output voltage Off-state	+5.5	V_{dc}
I_{IN}	Input current	±30	mA
I_{OUT}	Output current	+100	mA
T_A T_{STG}	Temperature range Operating Storage	0 to +75 −65 to +150	°C

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq +75°C$, $4.75 \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS			UNIT
			Min	Typ[2]	Max	
Input voltage[1]						
V_{IH}	High	V_{CC} = MAX	2.0			V
V_{IL}	Low	V_{CC} = MIN			0.8	
V_{IC}	Clamp[3]	V_{CC} = MIN, I_{IN} = −12mA		−0.8	−1.2	
Output voltage[1]		V_{CC} = MIN				
V_{OH}	High[5]	I_{OH} = −2mA	2.4			V
V_{OL}	Low[4]	I_{OL} = 15mA		0.35	0.5	
Input current		V_{CC} = MAX				
I_{IH}	High	V_{IN} = 5.5V		< 1	40	μA
I_{IL}	Low	V_{IN} = 0.45V		−10	−100	
Output current		V_{CC} = MAX				
$I_{O\ (OFF)}$	Hi-Z State[6]	V_{OUT} = 5.5V		1	40	μA
		V_{OUT} = 0.45V		−1	−40	
I_{OS}	Short circuit[3, 7]	V_{OUT} = 0V	−15		−70	mA
I_{CC}	V_{CC} supply current[8]	V_{CC} = MAX		100	155	mA
Capacitance		V_{CC} = 5.0V				
C_{IN}	Input	V_{IN} = 2.0V		8		pF
C_{OUT}	Output[6]	V_{OUT} = 2.0V		15		

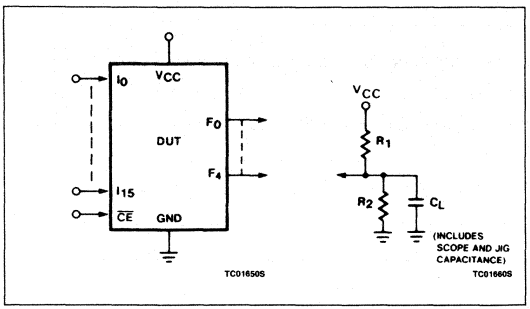
AC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq +75°C$, $4.75 \leq V_{CC} \leq 5.25V$, $R_1 = 470\Omega$, $R_2 = 1k\Omega$

PARAMETER		TO	FROM	TEST CONDITIONS	LIMITS			UNIT
					Min	Typ[1]	Max	
T_{PD}	Propagation delay	Output	Input	C_L = 30pF		20	30	ns
T_{CE}	Chip enable	Output	Chip enable	C_L = 30pF		20	30	ns
T_{CD}	Chip disable	Output	Chip enable	C_L = 5pF		20	30	ns

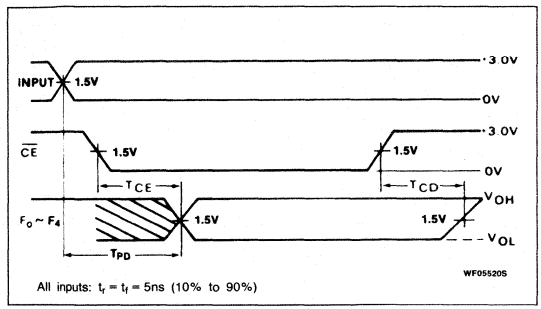
NOTES:
1. All voltage values are with respect to network ground terminal.
2. All typical values are at V_{CC} = 5V, T_A = 25°C.
3. Test each pin one at a time.
4. Measure with a programmed logic condition for which the output under test is at low logic level. Output sink current is supplied through a resistor to V_{CC}.
5. Measured with V_{IL} applied to $\overline{CE}$ and logic high at the output.
6. Measured with V_{IH} applied to $\overline{CE}$.
7. Duration of short circuit should not exceed 1 second.
8. I_{CC} is measured with the chip enable input grounded, all other inputs at 4.5V, and the outputs open.

Field Programmable Address Decoder (16 x 5) PLS162

TEST LOAD CIRCUIT



VOLTAGE WAVEFORM



All inputs: $t_r = t_f = 5ns$ (10% to 90%)

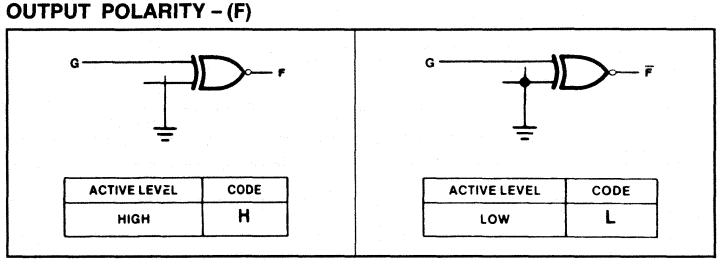
LOGIC PROGRAMMING

In a virgin device all Ni-Cr links are intact. The FPAD can be programmed by means of Logic Programming equipment.

With Logic programming, the AND/EX-OR gate input connections necessary to implement the desired logic function are coded directly from the logic equations using the Program Table on the following page.

In this table, the logic state of variables I and F associated with each gate G_n is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

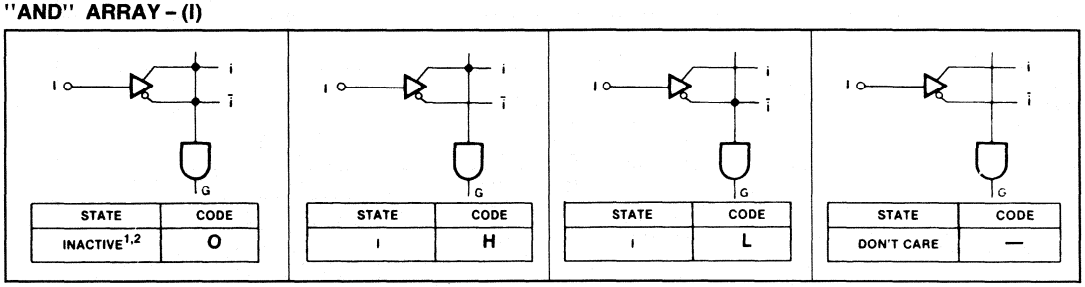
OUTPUT POLARITY - (F)



ACTIVE LEVEL	CODE
HIGH	H

ACTIVE LEVEL	CODE
LOW	L

"AND" ARRAY - (I)



STATE	CODE
INACTIVE[1,2]	O

STATE	CODE
I	H

STATE	CODE
I	L

STATE	CODE
DON'T CARE	—

NOTES:
1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates G_n.
2. Any gate G_n will be unconditionally inhibited if any one of its (I) link pairs is left intact.

VIRGIN DEVICE

The PLS162 is shipped in an unprogrammed state, characterized by:

1. All internal Ni-Cr links are intact.
2. Each gate contains both true and complement values of every input variable I_m (logic Null state).
3. The polarity of each output is set to active low ($\overline{F}_p$ function).
4. All outputs are at a high logic level.

5

Field Programmable Address Decoder (16 x 5) PLS162

FPAD PROGRAM TABLE

CUSTOMER NAME _____	THIS PORTION TO BE COMPLETED BY SIGNETICS
PURCHASE ORDER # _____	CF (XXXX) _____
SIGNETICS DEVICE # _____	CUSTOMER SYMBOLIZED PART # _____
TOTAL NUMBER OF PARTS _____	DATE RECEIVED _____
PROGRAM TABLE # _____	COMMENTS _____

F_0 (14) _____ = _____

F_1 (13) _____ = _____

F_2 (11) _____ = _____

F_3 (10) _____ = _____

F_4 (9) _____ = _____

GATE	INPUT															
POLARITY	I_{15}	I_{14}	I_{13}	I_{12}	I_{11}	I_{10}	I_9	I_8	I_7	I_6	I_5	I_4	I_3	I_2	I_1	I_0
F_0																
F_1																
F_2																
F_3																
F_4																
PIN NO.	16	17	18	19	20	21	22	23	1	2	3	4	5	6	7	8
VARIABLE NAME																

NOTES
1. The FPAD is shipped with all links intact. Thus a background of entries corresponding to states of virgin links exists in the table, shown BLANK for clarity.
2. Unused I bits are normally programmed Don't Care (—).
3. Unused Gates can be left blank.

PROGRAM TABLE ENTRIES

AND	
INACTIVE	0
I	H
$\overline{I}$	L
Don't Care	—

(I)

CONTROL	
HIGH	H
LOW	L

(POL.)

TB01281S

Signetics

PLS163
Field Programmable Address Decoder (12 x 9)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 24**

DESCRIPTION

The PLS163 is a bipolar, Field Programmable Address Decoder. The device consists of nine AND/NAND gates which share 12 common inputs. The type of gate is selected by programming the output as active-HIGH (H) or active-LOW (L). Each of the 12 inputs $I_0 - I_{11}$ can be programmed to provide the True (H), Complement (L), or Don't Care (—) state to each of the nine AND/NAND gates. OR/NOR logic functions can also be implemented by complementing the inputs and outputs via on-chip inverting buffers.

The device is field programmable, which means that custom patterns are immediately available.

The PLS163 includes chip-enable control for output strobing and inhibit. It features Tri-State outputs for ease of expansion of input variables and application in bus-organized systems.

Order codes are contained on the following pages.

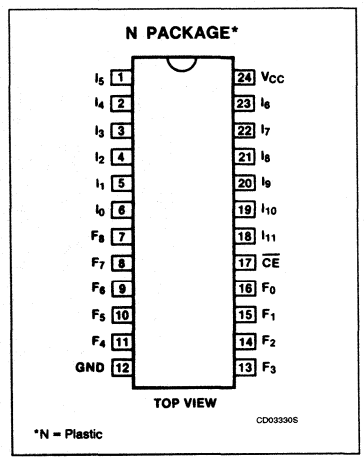
FEATURES

- **Field programmable (Ni-Cr link)**
- **12 input variables**
- **9 output functions**
- **Chip enable input**
- **I/O propagation delay: 30ns max**
- **Power dissipation: 600mW typ**
- **Input loading: −100μA max**
- **Output: Tri-State**
- **Output disable function: HI-Z**
- **Fully TTL compatible**

APPLICATIONS

- **Random logic**
- **Address decoders**
- **Code detectors**
- **Peripheral selectors**
- **Fault monitors**
- **Machine state decoders**

PIN CONFIGURATION



*N = Plastic

LOGIC FUNCTION

TYPICAL OUTPUT FUNCTIONS:

ACTIVE-HIGH

$X = A \cdot \overline{B} \cdot C \cdot \ldots$

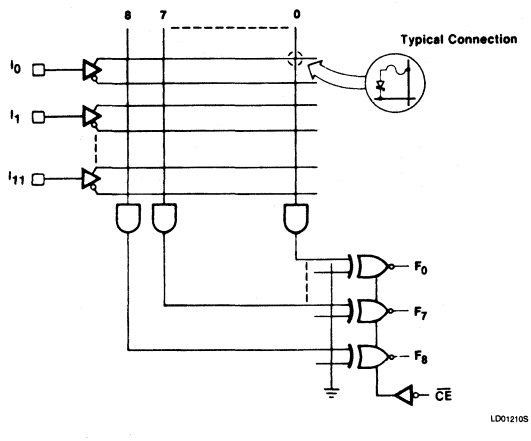
ACTIVE-LOW

$\overline{X = A \cdot \overline{B} \cdot C \cdot \ldots}$

$X = \overline{A} + B + \overline{C} + \ldots$

NOTES:
1. For each of the 9 outputs, either function X (active-high) or $\overline{X}$ (active-low) is available, but not both. The desired output polarity is programmed via the EX-OR gates.
2. X, A, B, C, etc. are user defined connections to fixed inputs (I) and output pins (F).

FUNCTIONAL DIAGRAM

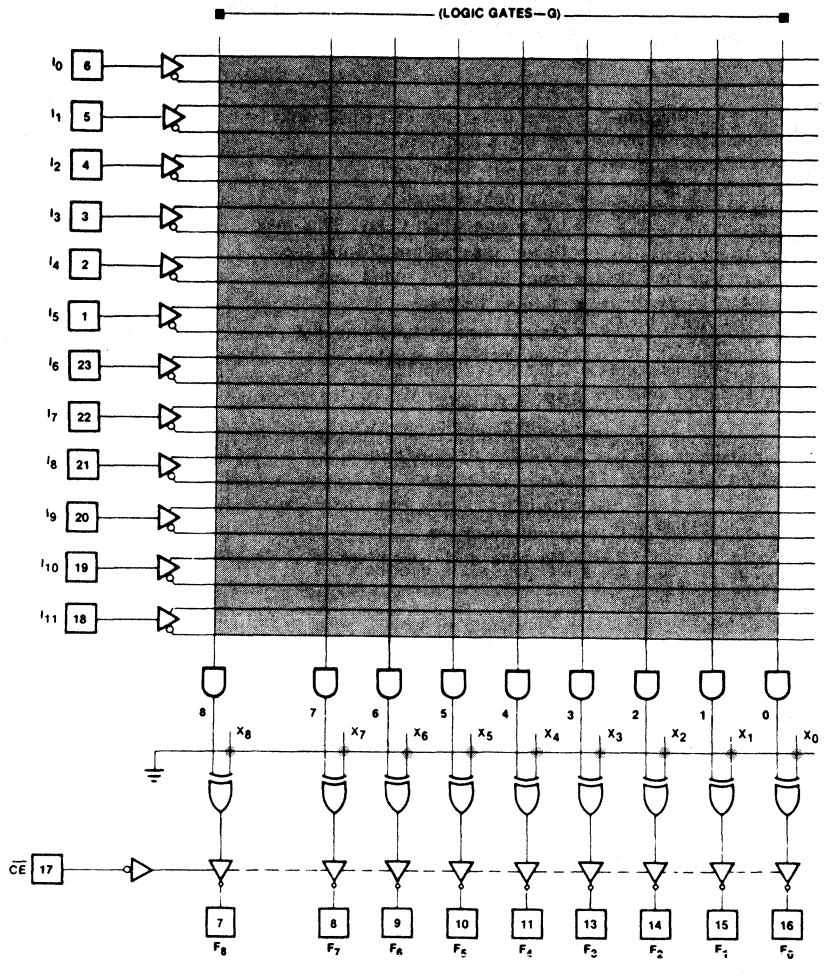


Fusible Ni-Cr links are initially intact at all array cross-points.

5

Field Programmable Address Decoder (12 x 9) PLS163

FPAD LOGIC DIAGRAM



NOTES:
1. All gate inputs with a blown link float to a logic "1".
2. ◉ Programmable connection.

Field Programmable Address Decoder (12 x 9) PLS163

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 300mil 24 pin	PLS163N

ABSOLUTE MAXIMUM RATINGS

PARAMETER		RATING	UNIT
V_{CC}	Supply voltage	+7	V_{dc}
V_{IN}	Input voltage	+5.5	V_{dc}
V_O	Output voltage Off-state	+5.5	V_{dc}
I_{IN}	Input current	±30	mA
I_{OUT}	Output current	+100	mA
T_A T_{STG}	Temperature range Operating Storage	0 to +75 −65 to +150	°C

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq +75°C$, $4.75 \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage						
V_{IH}	High[1]	V_{CC} = MAX	2.0			V
V_{IL}	Low[1]	V_{CC} = MIN			0.8	
V_{IC}	Clamp[1, 3]	V_{CC} = MIN, I_{IN} = −12mA		−0.8	−1.2	
Output voltage		V_{CC} = MIN				
V_{OH}	High[1, 5]	I_{OH} = −2mA	2.4			V
V_{OL}	Low[1, 4]	I_{OL} = 15mA		0.35	0.5	
Input current		V_{CC} = MAX				
I_{IH}	High	V_{IN} = 5.5V		< 1	40	µA
I_{IL}	Low	V_{IN} = 0.45V		−10	−100	
Output current		V_{CC} = MAX				
$I_{O\ (OFF)}$	Hi-Z State[6]	V_{OUT} = 5.5V		1	40	µA
		V_{OUT} = 0.45V		−1	−40	
I_{OS}	Short circuit[3, 7]	V_{OUT} = 0V	−15		−70	mA
I_{CC}	V_{CC} supply current[8]	V_{CC} = MAX		120	155	mA
Capacitance		V_{CC} = 5.0V				
C_{IN}	Input	V_{IN} = 2.0V		8		pF
C_{OUT}	Output[6]	V_{OUT} = 2.0V		15		

AC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq +75°C$, $4.75 \leq V_{CC} \leq 5.25V$, $R_1 = 470\Omega$, $R_2 = 1k\Omega$

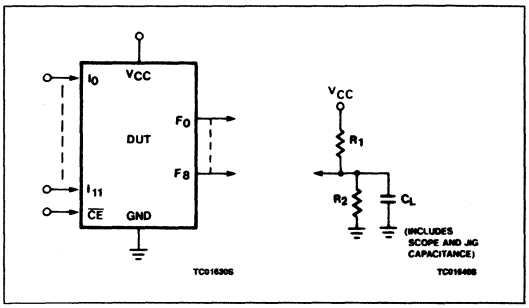
PARAMETER		TO	FROM	TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
T_{PD}	Propagation delay	Output	Input	C_L = 30pF		20	30	ns
T_{CE}	Chip enable	Output	Chip enable	C_L = 30pF		20	30	ns
T_{CD}	Chip disable	Output	Chip enable	C_L = 5pF		20	30	ns

NOTES:
1. All voltage values are with respect to network ground terminal.
2. All typical values are at V_{CC} = 5V, T_A = 25°C.
3. Test each pin one at a time.
4. Measure with a programmed logic condition for which the output under test is at low logic level. Output sink current is supplied through a resistor to V_{CC}.
5. Measured with V_{IL} applied to $\overline{CE}$ and logic high at the output.
6. Measured with V_{IH} applied to $\overline{CE}$.
7. Duration of short circuit should not exceed 1 second.
8. I_{CC} is measured with the chip enable input grounded, all other inputs at 4.5V, and the outputs open.

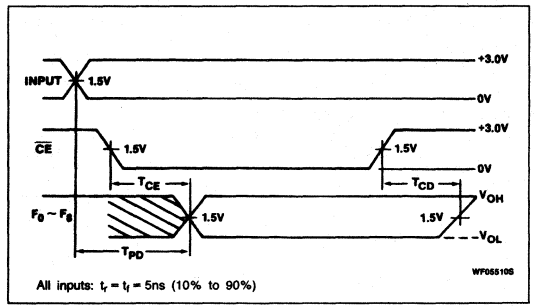
5

Field Programmable Address Decoder (12 x 9) PLS163

TEST LOAD CIRCUIT



VOLTAGE WAVEFORM



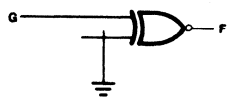
LOGIC PROGRAMMING

In a virgin device all Ni-Cr links are intact. The FPAD can be programmed by means of Logic Programming equipment.

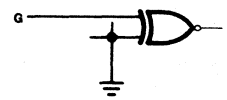
With Logic programming, the AND/EX-OR gate input connections necessary to implement the desired logic function are coded directly from the logic equations using the Program Table on the following page.

In this table, the logic state of variables I and F associated with each gate G_n is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

OUTPUT POLARITY - (F)

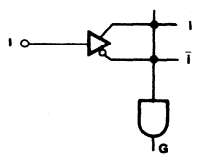


ACTIVE LEVEL	CODE
HIGH	H

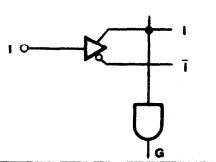


ACTIVE LEVEL	CODE
LOW	L

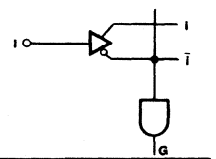
"AND" ARRAY - (I)



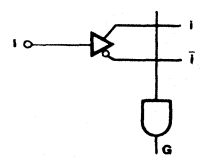
STATE	CODE
INACTIVE[1,2]	O



STATE	CODE
I	H



STATE	CODE
I	L



STATE	CODE
DON'T CARE	—

NOTES:
1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates G_n.
2. Any gate G_n will be unconditionally inhibited if any one of its (I) link pairs is left intact.

VIRGIN DEVICE

The PLS163 is shipped in an unprogrammed state, characterized by:

1. All internal Ni-Cr links are intact.
2. Each gate contains both true and complement values of every input variable I_m (logic Null state).
3. The polarity of each output is set to active low ($\overline{F}_p$ function).
4. All outputs are at a high logic level.

Field Programmable Address Decoder (12 x 9) PLS163

FPAD PROGRAM TABLE

CUSTOMER NAME _____	THIS PORTION TO BE COMPLETED BY SIGNETICS
PURCHASE ORDER # _____	CF (XXXX) _____
SIGNETICS DEVICE # _____	CUSTOMER SYMBOLIZED PART # _____
TOTAL NUMBER OF PARTS _____	DATE RECEIVED _____
PROGRAM TABLE # _____	COMMENTS _____

F_0 (16) _____ =
F_1 (15) _____ =
F_2 (14) _____ =
F_3 (13) _____ =
F_4 (11) _____ =
F_5 (10) _____ =
F_6 (9) _____ =
F_7 (8) _____ =
F_8 (7) _____ =

GATE		INPUT											
POLARITY		I_{11}	I_{10}	I_9	I_8	I_7	I_6	I_5	I_4	I_3	I_2	I_1	I_0
F_0													
F_1													
F_2													
F_3													
F_4													
F_5													
F_6													
F_7													
F_8													
PIN NO.		18	19	20	21	22	23	1	2	3	4	5	6
VARIABLE NAME													

NOTES
1. The FPAD is shipped with all links intact. Thus a background of entries corresponding to states of virgin links exists in the table, shown BLANK for clarity.
2. Unused I bits are normally programmed Don't Care (—).
3. Unused Gates can be left blank.

PROGRAM TABLE ENTRIES

AND (I)		CONTROL (POL.)	
INACTIVE	0	HIGH	H
I	H	LOW	L
$\overline{I}$	L		
Don't Care	—		

TB01271S

Signetics

PLS167
Field Programmable Logic Sequencer (14 x 48 x 6)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 24**

DESCRIPTION

The PLS167 is a bipolar, programmable state machine of the Mealy type. The Field Programmable Logic Sequencer (FPLS) contains logic AND-OR gate arrays with user programmable connections which control the inputs of on-chip state and output registers. These consist respectively of 8 Q_p, and 4 Q_f edge-triggered, clocked S/R flip-flops, with an asynchronous preset option.

All flip-flops are unconditionally preset to "1" during power turn-on.

The AND Array combines 14 external inputs, $I_{0\text{-}13}$, with 8 internal inputs, $P_{0\text{-}7}$, fed back from the State Register to form up to 48 transition terms (AND terms). In addition, P_0 and P_1 of the internal state register are brought off-chip to allow extending the Output Register to 6 bits, if so desired.

All transition terms can include True, False, or Don't Care states of the controlling variables, and are merged in the OR Array to issue next-state and next-output commands to their respective registers on the Low to High transition of the Clock pulse.

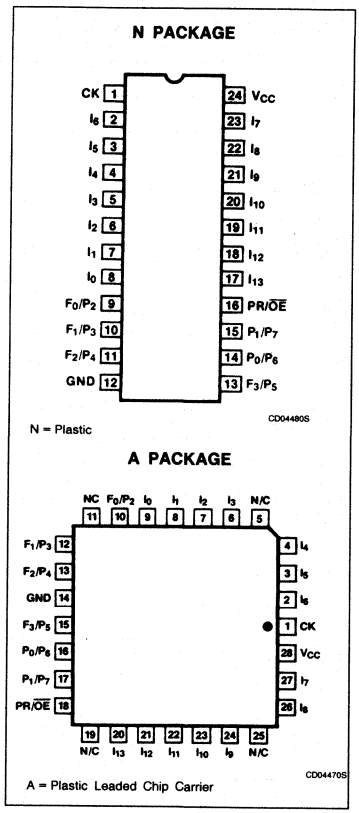
Both True and Complement transition terms can be generated by optional use of the internal variable (C) from the Complement Array. Also, if desired, the Preset input can be converted to output-enable function, as an additional user programmable option.

Order codes are contained on the pages following.

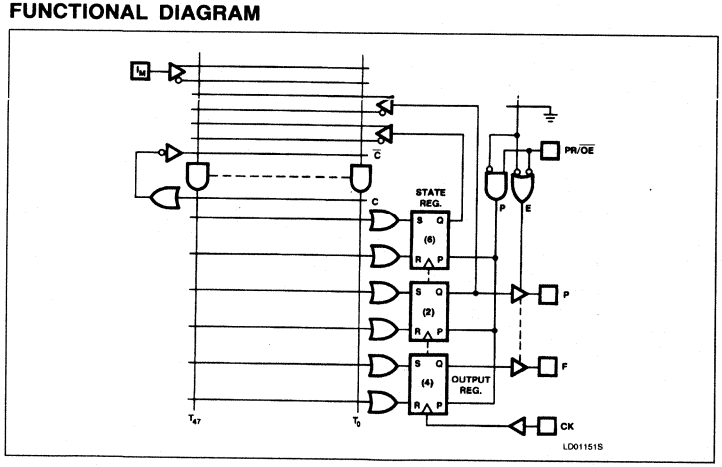
FEATURES

- **Field programmable (Ni-Cr link)**
- **14 True/Complement buffered inputs**
- **48 programmable AND gates**
- **25 programmable OR gates**
- **8-bit State Register**
- **2-bit shared State/Output Register**
- **4-bit Output Register**
- **Transition Complement Array**
- **Programmable asynchronous preset/output enable**
- **Positive edge-trigger clock**
- **Power-on preset to logic "1" of all registers**
- **Automatic logic "HOLD" state via S/R flip-flops**
- **On-chip Test Array**
- **$f_{(max)}$: 13.9MHz**
- **Power: 650mW (typ)**
- **TTL compatible**
- **Tri-state outputs**
- **Single +5V supply**
- **300 mil wide 24-pin DIP**

PIN CONFIGURATION



FUNCTIONAL DIAGRAM



APPLICATIONS

- **Interface protocols**
- **Sequence detectors**
- **Peripheral controllers**
- **Timing generators**
- **Sequential circuits**
- **Security locking systems**

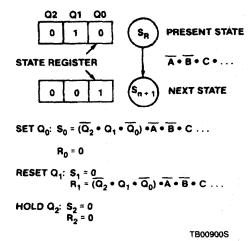
Field Programmable Logic Sequencer (14 x 48 x 6) PLS167

PIN DESCRIPTION

PIN NO.	SYMBOL	NAME AND FUNCTION	POLARITY
1	CK	**Clock:** The Clock input to the state and output registers. A low-to-high transition on this line is necessary to update the contents of both registers.	Active-high
2 – 7 17 – 23	I_{1-13}	**Logic Inputs:** The 13 external inputs to the AND array used to program jump conditions between machine states, as determined by a given logic sequence.	Active-high/low
8	I_0	**Logic/Diagnostic Input:** A 14th external logic input to the AND array, as above, when exercised with standard TTL levels. When I_0 is held at +10V, device outputs F_{0-3} and P_{0-1} reflect the contents of state register bits P_{2-7} (see Diagnostic Output Mode diagram on page 7). The contents of flip-flops P_{0-1} and F_{0-3} remain unaltered.	Active-high/low
9 – 11 13	F_{0-3}	**Logic/Diagnostic Outputs:** Four device outputs which normally reflect the contents of output register bits Q_{0-3}, when enabled. When I_0 is held at +10V, $F_{0-3} = (P_{2-5})$.	Active-high
14 – 15	P_{0-1}	**Logic/Diagnostic Outputs:** Two register bits with shared function as least significant state register bits, or most significant output register bits. When I_0 is held at +10V, $P_{0-1} = (P_{6-7})$.	Active-high
16	PR/$\overline{OE}$	**Preset or $\overline{\text{Output Enable}}$ Input:** A user programmable function: • **Preset:** Provides an asynchronous preset to logic "1" of all state and output register bits. Preset overrides Clock, and when held high, clocking is inhibited and P_{0-1} and F_{0-3} are high. Normal clocking resumes with the first full clock pulse following a high-to-low clock transition, after Preset goes low.	Active-high (H)
		• **$\overline{\text{Output Enable}}$:** Provides an Output Enable function to all output buffers.	Active-low (L)

LOGIC FUNCTION

Typical State Transition:



VIRGIN STATE

A factory shipped virgin device contains all fusible links intact, such that:

1. PR/$\overline{OE}$ option is set to PR. Thus, all outputs will be at "1", as preset by initial power-up procedure.
2. All transition terms are disabled (0).
3. All S/R flip-flop inputs are disabled (0).
4. The device can be clocked via a Test Array pre-programmed with a standard test pattern.
   NOTE: The Test Array pattern MUST be deleted before incorporating a user program.

TRUTH TABLE [1, 2, 3, 4, 5, 6]

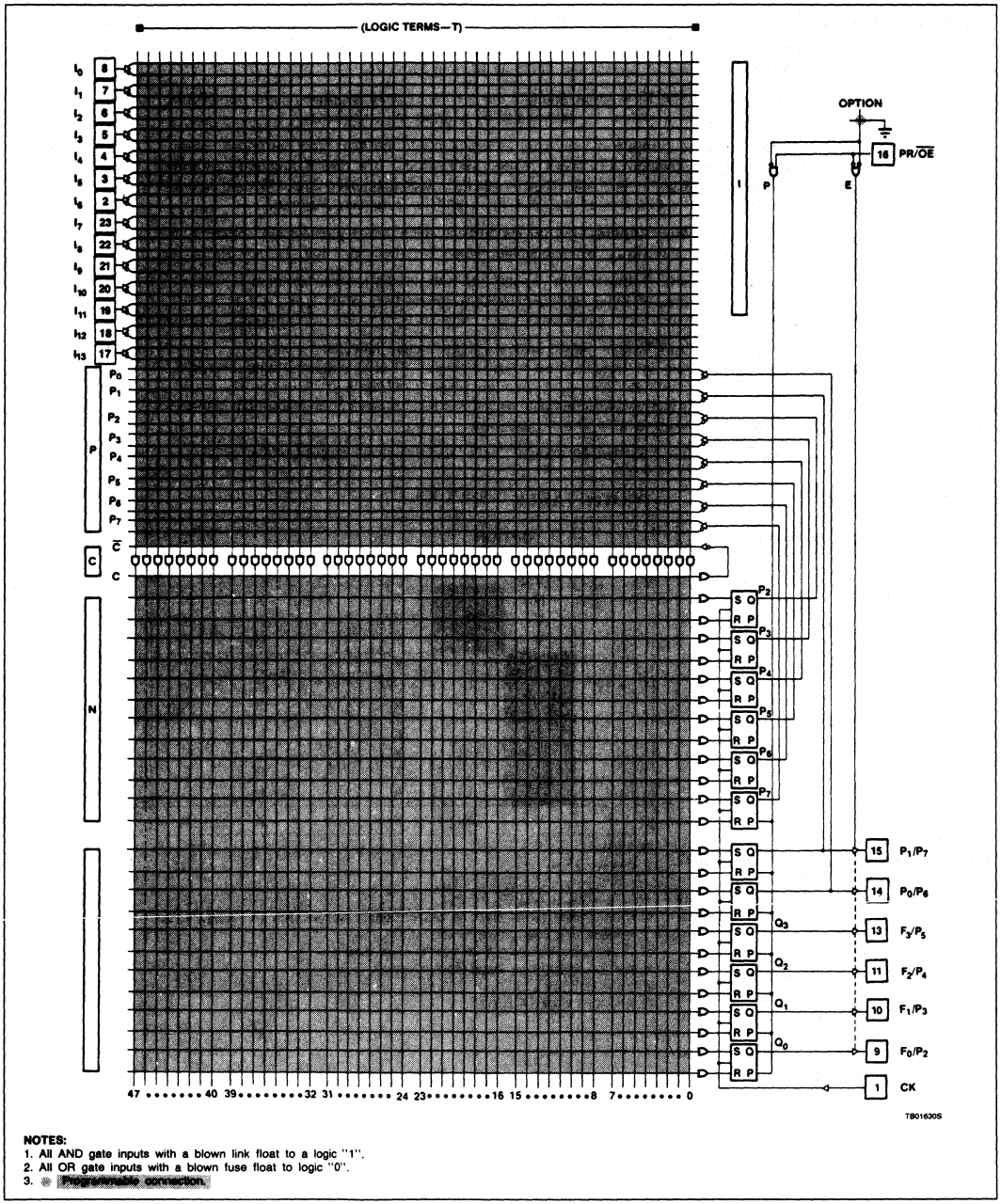
V_{CC}	OPTION		I_0	CK	S	R	$Q_{P/F}$	F
	PR	$\overline{O.E.}$						
+5V	H		*	X	X	X	H	H
	L		+10V	X	X	X	Q_n	$(Q_P)_n$
	L		X	X	X	X	Q_n	$(Q_F)_n$
		H	*	X	X	X	Q_n	Hi-Z
		L	+10V	X	X	X	Q_n	$(Q_P)_n$
		L	X	X	X	X	Q_n	$(Q_F)_n$
		L	X	↑	L	L	Q_n	$(Q_F)_n$
		L	X	↑	L	H	L	L
		L	X	↑	H	L	H	H
		L	X	↑	H	H	IND.	IND.
↑	X	X	X	X	X	X	H	

NOTES:

1. Positive Logic:
   $S/R = T_0 + T_1 + T_2 + \ldots + T_{47}$
   $T_n = C(I_0\ I_1\ I_2 \ldots)\ (P_0\ P_1 \ldots P_5)$
2. Either Preset (active-High) or $\overline{\text{Output Enable}}$ (active-LOW) are available, but not both. The desired function is a user programmable option.
3. ↑ denotes transition from Low to High level.
4. R = S = HIGH is an illegal input condition.
5. * = H/L/+10V
6. X = Don't Care (≤ 5.5V)

Field Programmable Logic Sequencer (14 x 48 x 6) PLS167

FPLS LOGIC DIAGRAM



NOTES:
1. All AND gate inputs with a blown link float to a logic "1".
2. All OR gate inputs with a blown fuse float to logic "0".
3. ⊗ Programmable connection.

Field Programmable Logic Sequencer (14 x 48 x 6) PLS167

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 300mil 24 pin	PLS167N
Plastic Leaded Chip Carrier 28 pin	PLS167A

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING Min	RATING Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input currents	-30	+30	mA
I_{OUT}	Output currents		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	-65	+150	

DC ELECTRICAL CHARACTERISTICS 0°C ≤ T_A ≤ 75°C, 4.75V ≤ V_{CC} ≤ 5.25V

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage[3]						
V_{IH}	High	V_{CC} = Max	2			V
V_{IL}	Low	V_{CC} = Min			0.8	
V_{IC}	Clamp[4]	V_{CC} = Min, I_{IN} = -12mA		-0.8	-1.2	
Output voltage[3]		V_{CC} = Min				
V_{OH}	High[5]	I_{OH} = -2mA	2.4			V
V_{OL}	Low[6]	I_{OL} = 9.6mA		0.35	0.45	
Input current						
I_{IH}	High	V_{IN} = 5.5V		< 1	25	μA
I_{IL}	Low	V_{IN} = 0.45V		-10	-100	
I_{IL}	Low (CK input)	V_{IN} = 0.45V		-50	-250	
Output current		V_{CC} = Max				
$I_{O(OFF)}$	Hi-Z state[7]	V_{CC} = 5.5V		1	40	μA
		V_{OUT} = 0.45V		-1	-40	
I_{OS}	Short circuit[4, 8]	V_{OUT} = 0V	-15		-70	mA
I_{CC}	V_{CC} supply current[9]	V_{CC} = Max		120	180	mA
Capacitance[7]		V_{CC} = 5.0V				
C_{IN}	Input	V_{IN} = 2.0V		8		pF
C_{OUT}	Output	V_{OUT} = 2.0V		10		

NOTES:

1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other condition above those indicated in the operational and programming specification of the device is not implied.
2. All typical values are at V_{CC} = 5V, T_A = 25°C.
3. All voltage values are with respect to network ground terminal.
4. Test one at a time.
5. Measured with V_{IL} applied to $\overline{O.E.}$ and a logic high stored, or with V_{IH} applied to PR.
6. Measured with a programmed logic condition for which the output is at a low logic level, and V_{IL} applied to PR/$\overline{O.E.}$ Output sink current is supplied through a resistor to V_{CC}.
7. Measured with V_{IH} applied to PR/$\overline{O.E.}$.
8. Duration of short circuit should not exceed 1 second.
9. I_{CC} is measured with the PR/$\overline{O.E.}$ input grounded, all other inputs at 4.5V and the outputs open.

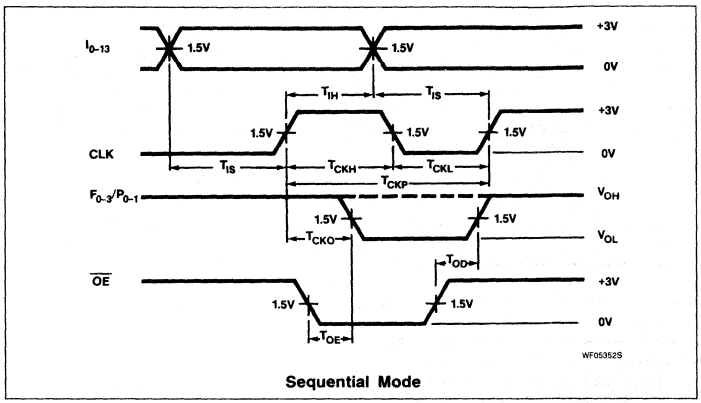
AC ELECTRICAL CHARACTERISTICS $R_1 = 470\Omega$, $R_2 = 1k\Omega$, $C_L = 30pF$, $0°C \leq T_A \leq +75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TO	FROM	LIMITS			UNIT
				Min	Typ[1]	Max	
Pulse width							
T_{CKH}	Clock[2] high	CK –	CK +	25	15		ns
T_{CKL}	Clock low	CK +	CK –	25	15		
$T_{CKP1}B$	Period (w/o c-array)	CK +	CK +	80	40		
$T_{CKP2}B$	Period (w/c-array)	CK +	CK +	120	60		
T_{PRH}	Preset pulse	PR +	PR –	25	15		
Set-up time[3]							
$T_{IS1}A$	Input	CK +	Input ±	60			ns
$T_{IS1}B$	Input	CK +	Input ±	50			
$T_{IS1}C$	Input	CK +	Input ±	42			
$T_{IS2}A$	Input (through Complement array)	CK +	Input ±	90			
$T_{IS2}B$	Input (through Complement array)	CK +	Input	80			
$T_{IS2}C$	Input (through Complement array)	CK +	Input	72			
T_{VS}	Power-on preset	CK –	V_{CC} +	0	–10		
T_{PRS}	Preset	CK –	PR –	0	–10		
Hold time							
T_{IH}	Input	Input ±	CK +	5	–10		ns
Propagation delay							
T_{CKO}	Clock	Output ±	CK +		15	30	ns
T_{OE}	Output enable	Output –	O.E. –		20	30	
T_{OD}	Output disable	Output +	O.E. +		20	30	
T_{PR}	Preset	Output +	PR +		18	30	
T_{PPR}	Power-on preset	Output +	V_{CC} +		0	10	
Frequency of operation[3]							
$f_{MAX}C$	w/o c-array					13.9	MHz
$f_{MAX}C$	w/c-array					9.8	

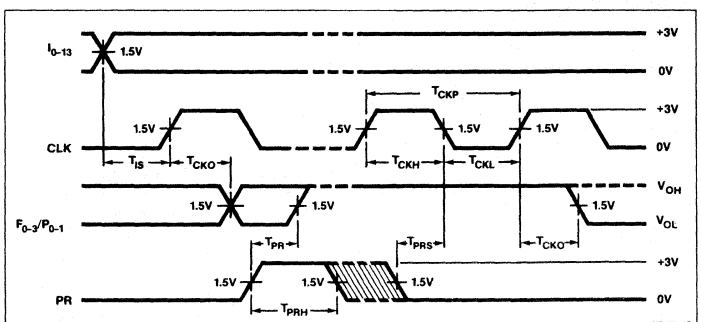
NOTES:
1. All typical values are at $V_{CC} = 5V$, $T_A = 25°C$.
2. To prevent spurious clocking, clock rise time (10% – 90%) ≤ 30ns.
3. See "Speed vs. OR Loading" on page 8.

Field Programmable Logic Sequencer (14 x 48 x 6) PLS167

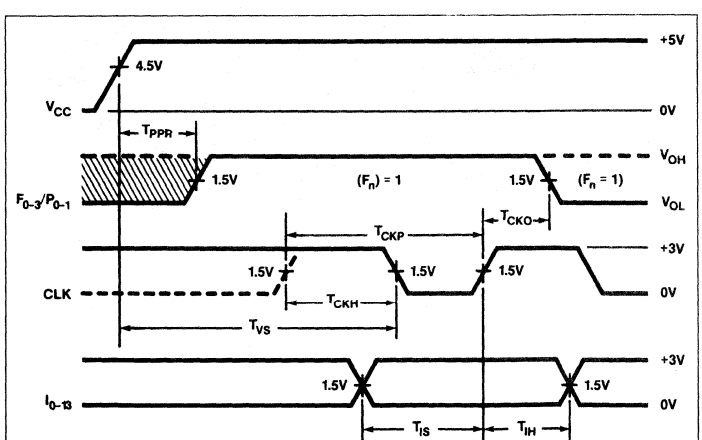
TIMING DIAGRAMS



Sequential Mode



Asynchronous Preset

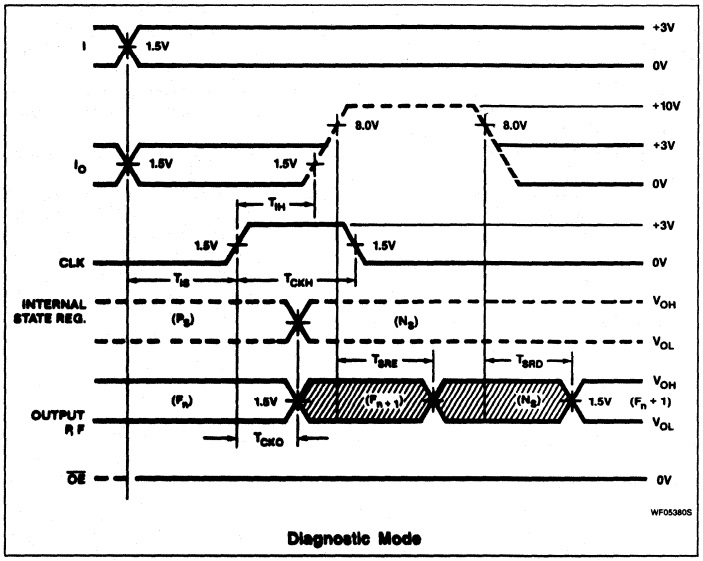


Power-on Preset

TIMING DEFINITIONS

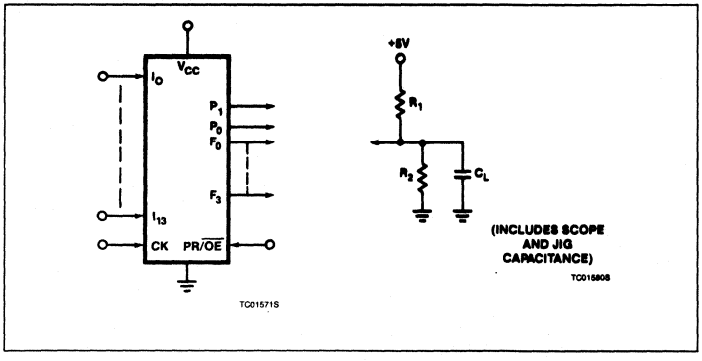
T_{CKH}	Width of input clock pulse.
T_{CKL}	Interval between clock pulses.
T_{CKP1}	Clock period – when not using Complement array.
T_{IS1}	Required delay between beginning of valid input and positive transition of clock.
T_{CKP2}	Clock period – when using complement array.
T_{IS2}	Required delay between beginning of valid input and positive transition of clock, when using optional Complement Array (two passes necessary through the AND array).
T_{VS}	Required delay between V_{CC} (after power-on) and negative transition of clock preceding first reliable clock pulse.
T_{PRS}	Required delay between negative transition of asynchronous Preset and negative transition of clock preceding first reliable clock pulse.
T_{IH}	Required delay between positive transition of clock and end of valid Input data.
T_{CKO}	Delay between positive transition of clock and when Outputs become valid (with PR/$\overline{O.E.}$ low).
T_{OE}	Delay between beginning of Output Enable Low and when Outputs become valid.
T_{OD}	Delay between beginning of Output Enable High and when Outputs are in the off state.
T_{SRE}	Delay between input I_0 transition to Diagnostic mode and when the Outputs reflect the contents of the State Register.
T_{SRD}	Delay between input I_0 transition to Logic mode and when the Outputs reflect the contents of the Output Register.
T_{PR}	Delay between positive transition of Preset and when Outputs become valid at "1".
T_{PPR}	Delay between V_{CC} (after power-on) and when Outputs become preset at "1".
T_{PRH}	Width of preset input pulse.
f_{MAX}	Maximum clock frequency.

TIMING DIAGRAMS (Continued)

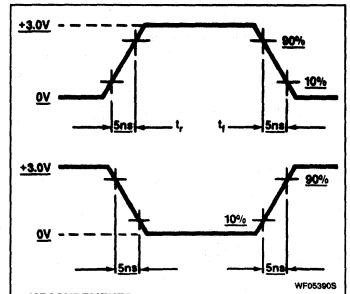


Diagnostic Mode

TEST LOAD CIRCUIT



VOLTAGE WAVEFORM



MEASUREMENTS:
All circuit delays are measured at the +1.5V level of inputs and outputs, unless otherwise specified.

Input Pulses

SPEED VS. "OR" LOADING

The maximum frequency at which the FPLS can be clocked while operating in *sequential mode* is given by:

$(1/f_{MAX}) = T_{CY} = T_{IS} + T_{CKO}$

This frequency depends on the number of transition terms T_n used. Having all 48 terms connected in the AND array does not appreciably impact performance; but the number of terms connected to each OR line affects T_{IS}, due to capacitive loading. The effect of this loading can be seen in Figure 1, showing the variation of T_{IS1} with the number of terms connected per OR.

The AC electrical characteristics contain three limits for the parameters T_{IS1} and T_{IS2}. The first, T_{IS1A} is guaranteed for a device with 48 terms connected to any OR line. T_{IS1B} is guaranteed for a device with 32 terms connected to any OR line. And T_{IS1C} is guaranteed for a device with 24 terms connected to any OR line.

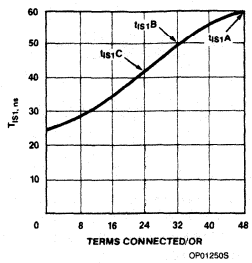


Figure 1. T_{IS1} vs. Terms/OR Connected.

The Three other entries in the AC table, T_{IS2} A, B, and C are corresponding 48, 32, and 24 term limits when using the on-chip Complement Array.

The worst case T_{IS} for a given application can be determined by identifying the OR line with the maximum number of T_n connections. This can be done by referring to the interconnect pattern in the FPLS logic diagram, typically illustrated in Figure 2, or by counting the maximum number of "H" or "L" entries in one of the columns of the device Program Table.

This number plotted on the curve in Figure 1 will yield the worst case T_{IS} and, by implication, the maximum clocking frequency for reliable operation.

Note that for maximum speed all UNUSED transition terms should be disconnected from the OR array.

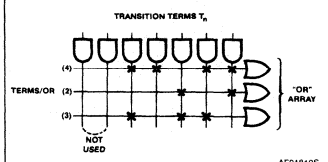


Figure 2. Typical OR Array Interconnect Pattern.

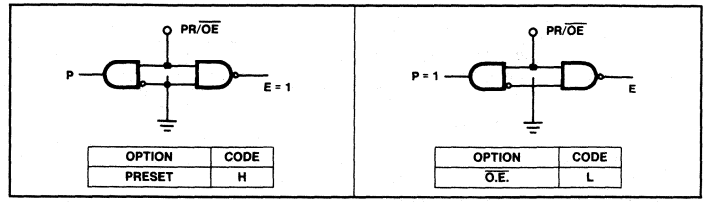
LOGIC PROGRAMMING

The FPLS can be programmed by means of Logic programming equipment.

With Logic programming, the AND/OR gate input connections necessary to implement the desired logic function are coded directly from the State Diagram using the Program Table on the following page.

In this table, the logic state or action of control variables C, I, P, N, and F, associated with each Transition Term T_n, is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

PRESET/$\overline{O.E.}$ OPTION – (P/E)



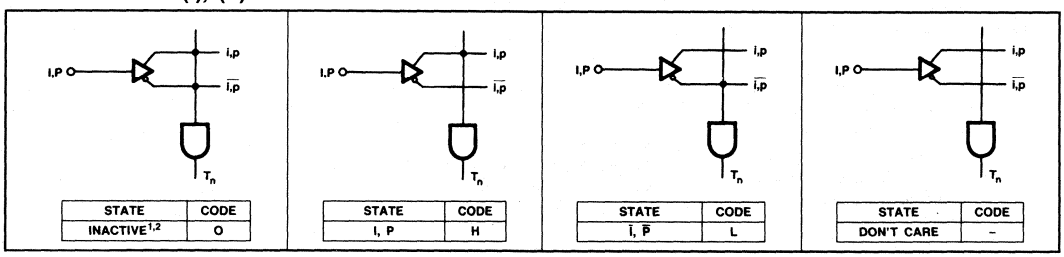
OPTION	CODE
PRESET	H

OPTION	CODE
$\overline{O.E.}$	L

PROGRAMMING:

The PLS168 has a power-up preset feature. This feature insures that the device will power-up in a known state with all register elements (state and output register) at a logic high (H). When programming the device it is important to realize this is the initial state of the device. You *must* provide a next state jump if you do not wish to use all highs (H) as the present state.

"AND" ARRAY – (I), (P)



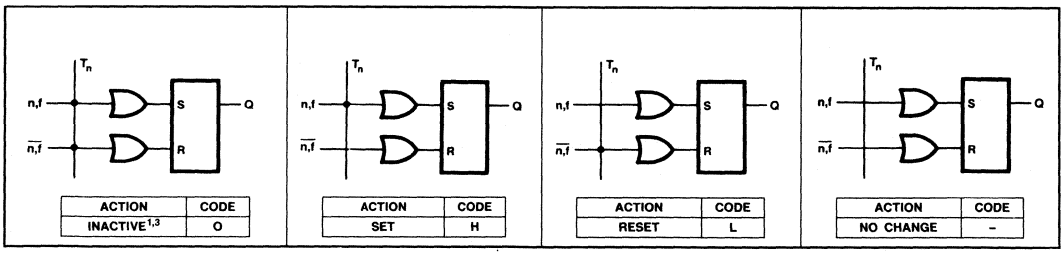
STATE	CODE
INACTIVE[1,2]	O

STATE	CODE
I, P	H

STATE	CODE
$\overline{I}$, $\overline{P}$	L

STATE	CODE
DON'T CARE	–

"OR" ARRAY – (N), (F)



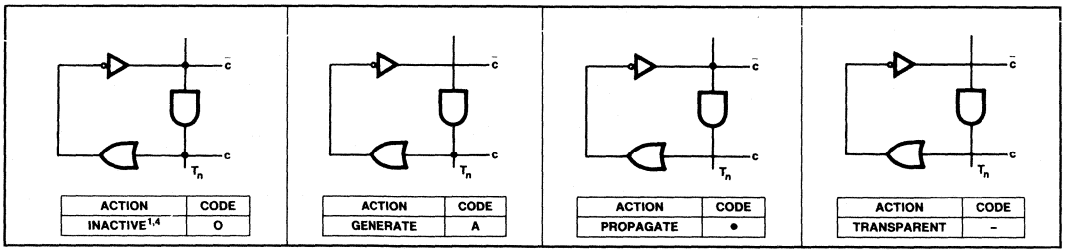
ACTION	CODE
INACTIVE[1,3]	O

ACTION	CODE
SET	H

ACTION	CODE
RESET	L

ACTION	CODE
NO CHANGE	–

"COMPLEMENT" ARRAY – (C)



ACTION	CODE
INACTIVE[1,4]	O

ACTION	CODE
GENERATE	A

ACTION	CODE
PROPAGATE	•

ACTION	CODE
TRANSPARENT	–

NOTES:

1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates T_n
2. Any gate T_n will be unconditionally inhibited if any one of its I or P link pairs is left intact.
3. To prevent simultaneous Set and Reset flip-flop commands, this state is not allowed for N and F link pairs coupled to active gates T_n (see flip-flop truth tables).
4. To prevent oscillations, this state is not allowed for C link pairs coupled to active gates T_n.

FPLS PROGRAM TABLE

CUSTOMER NAME _____

PURCHASE ORDER # _____

SIGNETICS DEVICE # CF (XXXX) _____

CUSTOMER SYMBOLIZED PART # _____

TOTAL NUMBER OF PARTS _____

PROGRAM TABLE # _____

REV _____

DATE _____

PROGRAM TABLE ENTRIES

AND			OR		
INACTIVE	0	Cn	INACTIVE	0	Ns, Fr
GENERATE	A		SET	H	
PROPAGATE	•		RESET	L	
TRANSPARENT	—		NO CHANGE	—	
INACTIVE	0	Im, Ps	OPTION		
I, P	H		PRESET	H	P/E
$\overline{I}$, $\overline{P}$	L		$\overline{OE}$	L	
DON'T CARE	—				

TERM	Cn	AND: INPUT (I_M) 13 12 11 10 9 8 7 6 5 4 3 2 1 0	AND: PRESENT STATE (P_S) 7 6 5 4 3 2 1 0	REMARKS	OPTION (P/E) OR: NEXT STATE (N_S) 7 6 5 4 3 2 1 0	OUTPUT (Fr) 3 2 1 0
0						
1						
2						
3						
4						
5						
6						
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8						
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41						
42						
43						
44						
45						
46						
47						
PIN NO.		17 18 19 20 21 22 23 2 3 4 5 6 7 8			15 14	13 11 10 9
VARIABLE NAME						

TB01620S

NOTES:
1. The FPLS is shipped with all links initially intact. Thus, a background of "0" for all Terms, and an "H" for the P/E option, exits in the table, shown BLANK instead for clarity.
2. Unused Cn, Im, and Ps bits are normally programmed Don't Care (—).
3. Unused Transition Terms can be left for future code modification or programmed as (—) for maximum speed.
4. Letters in variable fields are used as identifiers by logic type programmers.

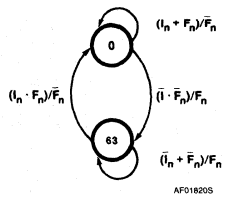
Field Programmable Logic Sequencer (14 x 48 x 6) PLS167

TEST ARRAY

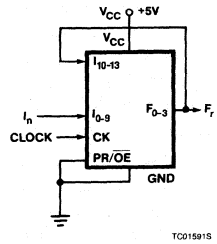
The FPLS may be subjected to AC and DC parametric tests prior to programming via an on-chip test array.

The array consists of test transition terms 48 and 49, factory programmed as shown below.

Testing is accomplished by clocking the FPLS and applying the proper input sequence to $I_{0\text{-}9}$ as shown in the test circuit timing diagram.



State Diagram



FPLS Under Test

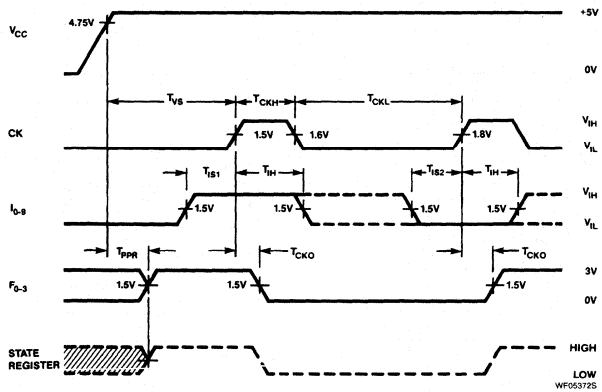
TERM	C	AND: INPUT (Im) 13	12	11	10	9	8	7	6	5	4	3	2	1	0	PRESENT STATE (Ps) 7	6	5	4	3	2	1	0
48	A	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H
49	●	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L

OPTION (P/E)	H
OR	
NEXT STATE (Ns)	OUTPUT (Fr)
7 6 5 4 3 2 1 0	3 2 1 0
L L L L L L L L	L L L L
H H H H H H H H	H H H H

TB01600S

Test Array Program

Both terms 48 and 49 must be deleted during user programming to avoid interfering with the desired logic function. This is accomplished automatically by any Signetic's qualified programming equipment.



Test Circuit Timing Diagram

TERM	C	AND: INPUT (Im) 13	12	11	10	9	8	7	6	5	4	3	2	1	0	PRESENT STATE (Ps) 7	6	5	4	3	2	1	0
48	–	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H
49	●	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L

OPTION (P/E)	H
OR	
NEXT STATE (Ns)	OUTPUT (Fr)
7 6 5 4 3 2 1 0	3 2 1 0
– – – – – – – –	– – – –
– – – – – – – –	– – – –

TB01610S

Test Array Deleted

Signetics

PLS167A
Field Programmable Logic Sequencer (14 x 48 x 6)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 24**

DESCRIPTION

The PLS167A is a bipolar, programmable state machine of the Mealy type.The Field Programmable Logic Sequencer (FPLS) contains logic AND-OR gate arrays with user programmable connections which control the inputs of on-chip state and output registers. These consist respectively of 8 Q_p, and 4 Q_f edge-triggered, clocked S/R flip-flops, with an asynchronous preset option.

All flip-flops are unconditionally preset to "1" during power turn-on.

The AND array combines 14 external inputs, $I_{0\text{-}13}$, with 8 internal inputs, $P_{0\text{-}7}$, fed back from the State register to form up to 48 transition terms (AND terms). In addition, P_0 and P_1 of the internal state register are brought off-chip to allow extending the output register to 6 bits, if so desired.

All transition terms can include True, False, or Don't Care states of the controlling variables, and are merged in the OR array to issue next-state and next-output commands to their respective registers on the low to high transition of the Clock pulse.

Both True and Complement transition terms can be generated by optional use of the internal variable (C) from the complement array. Also, if desired, the Preset input can be converted to output-enable function, as an additional user programmable option.

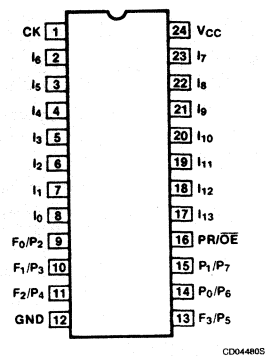
Order codes are contained on the pages following.

FEATURES

- **Field programmable (Ni-Cr link)**
- **14 True/Complement buffered inputs**
- **48 programmable AND gates**
- **25 programmable OR gates**
- **8-bit state register**
- **2-bit shared state/output register**
- **4-bit output register**
- **Transition complement array**
- **Programmable asynchronous preset/output enable**
- **Positive edge-trigger clock**
- **Power-on preset to logic "1" of all registers**
- **Automatic logic "HOLD" state via S/R flip-flops**
- **On/chip test array**
- **$f_{(max)}$: 20MHz**
- **Power: 650mW (typ)**
- **TTL compatible**
- **Tri-state outputs**
- **Single +5V supply**
- **300 mil wide 24-pin DIP**

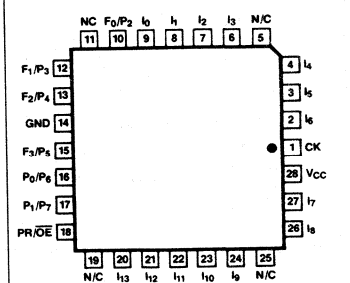
PIN CONFIGURATION

N PACKAGE



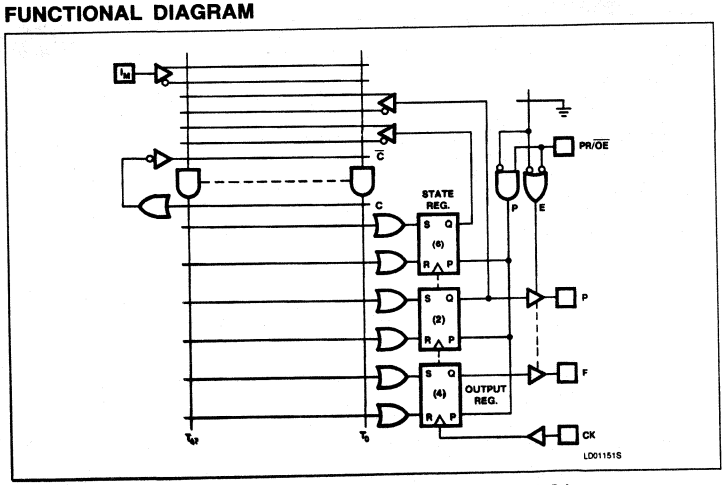
N = Plastic

A PACKAGE



A = Plastic Leaded Chip Carrier

FUNCTIONAL DIAGRAM



APPLICATIONS

- **Interface protocols**
- **Sequence detectors**
- **Peripheral controllers**
- **Timing generators**
- **Sequential circuits**
- **Security locking systems**

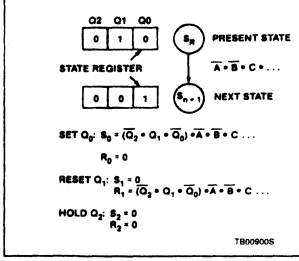
Field Programmable Logic Sequencer (14 x 48 x 6) PLS167A

PIN DESCRIPTION

PIN NO.	SYMBOL	NAME AND FUNCTION	POLARITY
1	CK	**Clock:** The Clock input to the state and output registers. A low-to-high transition on this line is necessary to update the contents of both registers.	Active-high
2 – 7 17 – 23	I_{1-13}	**Logic Inputs:** The 13 external inputs to the AND array used to program jump conditions between machine states, as determined by a given logic sequence.	Active-high/low
8	I_0	**Logic/Diagnostic Input:** A 14th external logic input to the AND array, as above, when exercised with standard TTL levels. When I_0 is held at +10V, device outputs F_{0-3} and P_{0-1} reflect the contents of state register bits P_{2-7} (see Diagnostic Output Mode diagram on page 7). The contents of flip-flops P_{0-1} and F_{0-3} remain unaltered.	Active-high/low
9 – 11 13	F_{0-3}	**Logic/Diagnostic Outputs:** Four device outputs which normally reflect the contents of output register bits Q_{0-3}, when enabled. When I_0 is held at +10V, $F_{0-3} = (P_{2-5})$.	Active-high
14 – 15	P_{0-1}	**Logic/Diagnostic Outputs:** Two register bits with shared function as least significant state register bits, or most significant output register bits. When I_0 is held at +10V, $P_{0-1} = (P_{6-7})$.	Active-high
16	PR/$\overline{O.E.}$	**Preset or $\overline{\text{Output Enable}}$ Input:** A user programmable function: • **Preset:** Provides an asynchronous preset to logic "1" of all state and output register bits. Preset overrides Clock, and when held high, clocking is inhibited and P_{0-1} and F_{0-3} are high. Normal clocking resumes with the first full clock pulse following a high-to-low clock transition, after Preset goes low.	Active-high (H)
		• **$\overline{\text{Output Enable}}$:** Provides an Output Enable function to all output buffers.	Active-low (L)

LOGIC FUNCTION

Typical State Transition:



VIRGIN STATE

A factory shipped virgin device contains all fusible links intact, such that:

1. PR/$\overline{OE}$ option is set to PR. Thus, all outputs will be at "1", as preset by initial power-up procedure.
2. All transition terms are disabled (0).
3. All S/R flip-flop inputs are disabled (0).
4. The device can be clocked via a Test Array pre-programmed with a standard test pattern.
   NOTE: The Test Array pattern MUST be deleted before incorporating a user program.

TRUTH TABLE[1, 2, 3, 4, 5, 6]

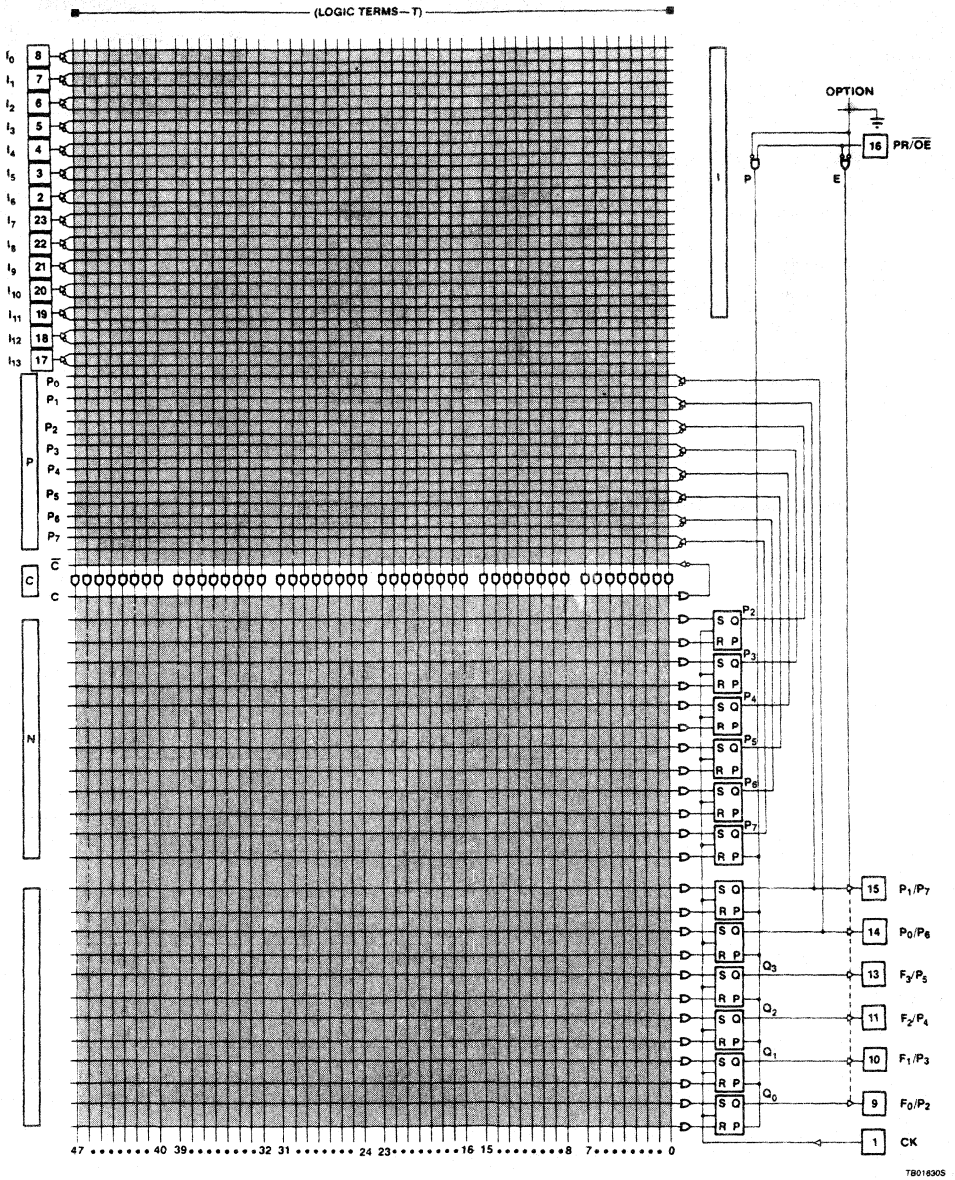
V_{CC}	OPTION PR	OPTION $\overline{O.E.}$	I_0	CK	S	R	$Q_{P/F}$	F
+5V	H		*	X	X	X	H	H
	L		+10V	X	X	X	Q_n	$(Q_P)_n$
	L		X	X	X	X	Q_n	$(Q_F)_n$
		H	*	X	X	X	Q_n	Hi-Z
		L	+10V	X	X	X	Q_n	$(Q_P)_n$
		L	X	X	X	X	Q_n	$(Q_F)_n$
		L	X	↑	L	L	Q_n	$(Q_F)_n$
		L	X	↑	L	H	L	L
		L	X	↑	H	L	H	H
		L	X	↑	H	H	IND.	IND.
↑	X	X	X	X	X	X	H	

NOTES:

1. Positive Logic:
   $S/R = T_0 + T_1 + T_2 + \ldots + T_{47}$
   $T_n = C(I_0\ I_1\ I_2 \ldots)\ (P_0\ P_1\ P_5)$
2. Either Preset (active-HIGH) or $\overline{\text{Output Enable}}$ (active-LOW) are available, but not both. The desired function is a user programmable option.
3. ↑ denotes transition from LOW-to-HIGH level.
4. R = S = HIGH is an illegal input condition.
5. * = H/L/+10V
6. X = Don't care ($\leq$ 5.5V)

Field Programmable Logic Sequencer (14 x 48 x 6) PLS167A

FPLS LOGIC DIAGRAM



NOTES:
1. All AND gate inputs with a blown link float to a logic "1".
2. All OR gate inputs with a blown link float to a logic "0".
3. Programmable connection.

Field Programmable Logic Sequencer (14 x 48 x 6) PLS167A

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 300mil 24 pin	PLS167AN
Plastic Leaded Chip Carrier 28 pin	PLS167AA

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING Min	RATING Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input currents	−30	+30	mA
I_{OUT}	Output currents		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	−65	+150	

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq 75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage[3]						
V_{IH}	High	V_{CC} = Max	2			V
V_{IL}	Low	V_{CC} = Min			0.8	
V_{IC}	Clamp[4]	V_{CC} = Min, I_{IN} = −12mA		−0.8	−1.2	
Output voltage[3]		V_{CC} = Min				
V_{OH}	High[5]	I_{OH} = −2mA	2.4			V
V_{OL}	Low[6]	I_{OL} = 9.6mA		0.35	0.45	
Input current						
I_{IH}	High	V_{IN} = 5.5V		< 1	25	μA
I_{IL}	Low	V_{IN} = 0.45V		−10	−100	
I_{IL}	Low (CK input)	V_{IN} = 0.45V		−50	−250	
Output current		V_{CC} = Max				
$I_{O(OFF)}$	Hi-Z state[7]	V_{CC} = 5.5V		1	40	μA
		V_{OUT} = 0.45V		−1	−40	
I_{OS}	Short circuit[4, 8]	V_{OUT} = 0V	−15		−70	mA
I_{CC}	V_{CC} supply current[9]	V_{CC} = Max		120	180	mA
Capacitance[7]		V_{CC} = 5.0V				
C_{IN}	Input	V_{IN} = 2.0V		8		pF
C_{OUT}	Output	V_{OUT} = 2.0V		10		

NOTES:

1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other condition above those indicated in the operational and programming specification of the device is not implied.
2. All typical values are at V_{CC} = 5V. T_A = 25°C.
3. All voltage values are with respect to network ground terminal.
4. Test one at a time.
5. Measured with V_{IL} applied to $\overline{O.E.}$ and a logic high stored, or with V_{IH} applied to PR.
6. Measured with a programmed logic condition for which the output is at a low logic level, and V_{IL} applied to PR/$\overline{O.E.}$ Output sink current is supplied through a resistor to V_{CC}.
7. Measured with V_{IH} applied to PR/$\overline{O.E.}$.
8. Duration of short circuit should not exceed 1 second.
9. I_{CC} is measured with the PR/$\overline{O.E.}$ input grounded, all other inputs at 4.5V and the outputs open.

Field Programmable Logic Sequencer (14 x 48 x 6) PLS167A

AC ELECTRICAL CHARACTERISTICS $R_1 = 470\Omega$, $R_2 = 1k\Omega$, $C_L = 30pF$, $0°C \leq T_A \leq +75°C$, $4.75V \leq V_{CC} \leq 5.25V$

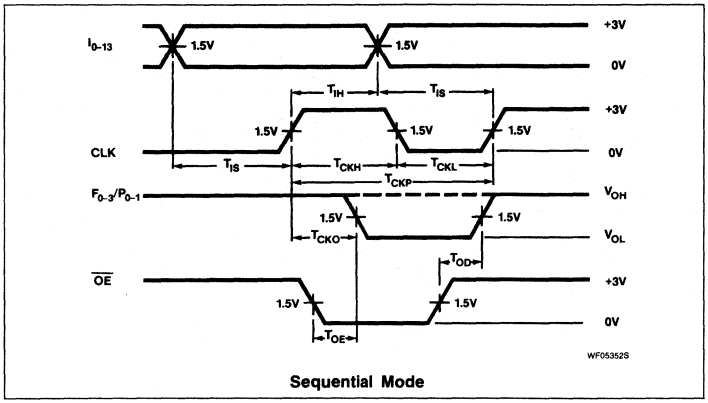
PARAMETER		TO	FROM	LIMITS			UNIT
				Min	Typ[1]	Max	
Pulse width							
T_{CKH}	Clock[2] high	CK –	CK +	25	15		ns
T_{CKL}	Clock low	CK +	CK –	25	15		
$T_{CKP1}B$	Period (w/o C-array)	CK +	CK +	50	40		
$T_{CKP2}B$	Period (w/C-array)	CK +	CK +	80	50		
T_{PRH}	Preset pulse	PR +	PR –	25	15		
Set-up time[3]							
$T_{IS1}A$	Input	CK +	Input ±	40			ns
$T_{IS1}B$	Input	CK +	Input ±	30			
$T_{IS2}A$	Input (through Complement array)	CK +	Input ±	70			
$T_{IS2}B$	Input (through Complement array)	CK +	Input	60			
T_{VS}	Power-on preset	CK –	V_{CC} +	0	–10		
T_{PRS}	Preset	CK –	PR –	0	–10		
Hold time							
T_{IH}	Input	Input ±	CK +	5	–10		ns
Propagation delay							
T_{CKO}	Clock	Output ±	CK +		15	20	ns
T_{OE}	Output enable	Output –	O.E. –		20	30	
T_{OD}	Output disable	Output +	O.E. +		20	30	
T_{PR}	Preset	Output +	PR +		18	30	
T_{PPR}	Power-on preset	Output +	V_{CC} +		0	10	
Frequency of operation[3]							
$f_{MAX}C$	w/o C-array					20.0	MHz
$f_{MAX}C$	w/C-array					12.5	

NOTES:
1. All typical values are at $V_{CC} = 5V$, $T_A = 25°C$.
2. To prevent spurious clocking, clock rise time (10% – 90%) ≤ 30ns.
3. See "Speed vs. OR Loading" on page 8.

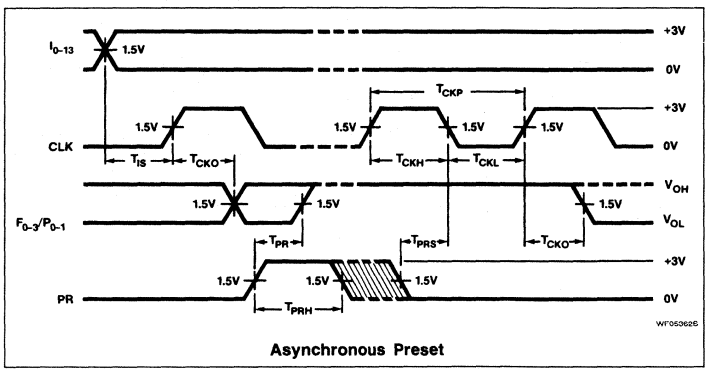
5

Field Programmable Logic Sequencer (14 x 48 x 6) PLS167A

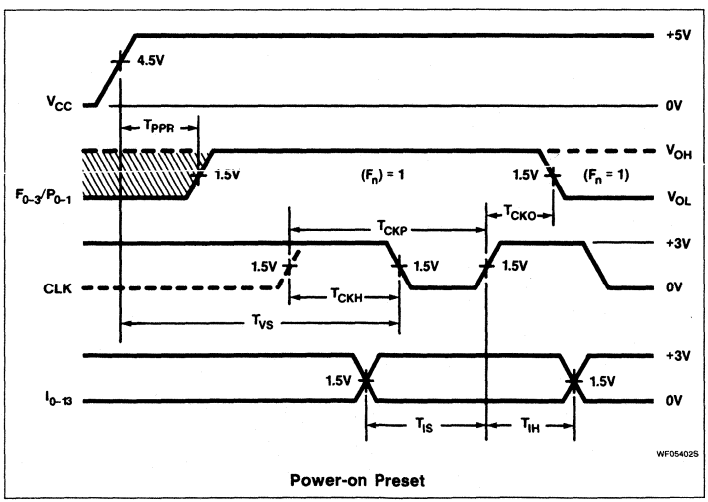
TIMING DIAGRAMS



Sequential Mode



Asynchronous Preset

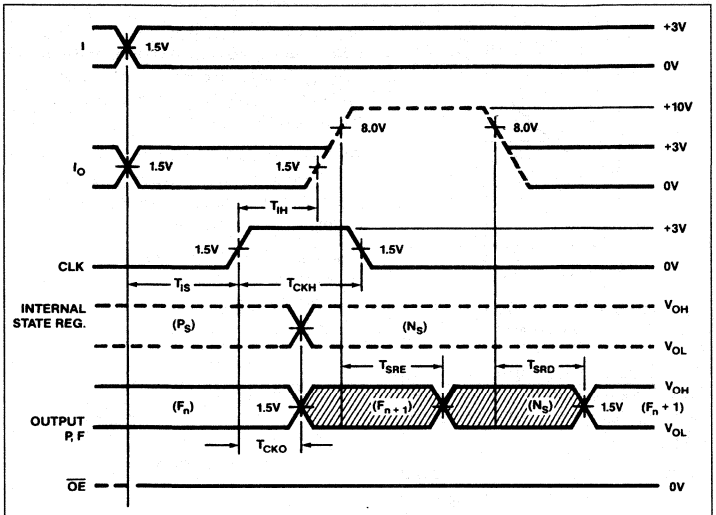


Power-on Preset

TIMING DEFINITIONS

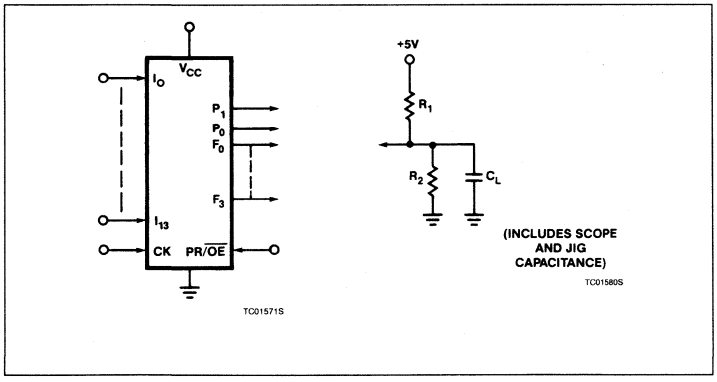
T_{CKH}	Width of input clock pulse.
T_{CKL}	Interval between clock pulses.
T_{CKP1}	Clock period – when not using Complement array.
T_{IS1}	Required delay between beginning of valid input and positive transition of clock.
T_{CKP2}	Clock period – when using complement array.
T_{IS2}	Required delay between beginning of valid input and positive transition of clock, when using optional Complement Array (two passes necessary through the AND array).
T_{VS}	Required delay between V_{CC} (after power-on) and negative transition of clock preceding first reliable clock pulse.
T_{PRS}	Required delay between negative transition of asynchronous Preset and negative transition of clock preceding first reliable clock pulse.
T_{IH}	Required delay between positive transition of clock and end of valid Input data.
T_{CKO}	Delay between positive transition of clock and when Outputs become valid (with PR/$\overline{O.E.}$ low).
T_{OE}	Delay between beginning of Output Enable Low and when Outputs become valid.
T_{OD}	Delay between beginning of Output Enable High and when Outputs are in the off state.
T_{SRE}	Delay between input I_0 transition to Diagnostic mode and when the Outputs reflect the contents of the State Register.
T_{SRD}	Delay between input I_0 transition to Logic mode and when the Outputs reflect the contents of the Output Register.
T_{PR}	Delay between positive transition of Preset and when Outputs become valid at "1".
T_{PPR}	Delay between V_{CC} (after power-on) and when Outputs become preset at "1".
T_{PRH}	Width of preset input pulse.
f_{MAX}	Maximum clock frequency.

TIMING DIAGRAMS (Continued)

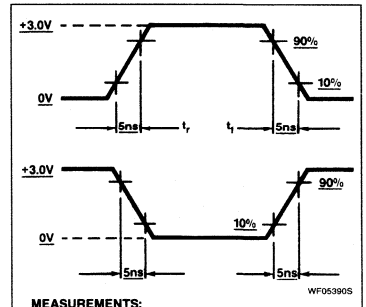


Diagnostic Mode

TEST LOAD CIRCUIT



VOLTAGE WAVEFORM



MEASUREMENTS:
All circuit delays are measured at the +1.5V level of inputs and outputs, unless otherwise specified.

Input Pulses

5

Field Programmable Logic Sequencer (14 x 48 x 6) PLS167A

SPEED VS. "OR" LOADING

The maximum frequency at which the FPLS can be clocked while operating in *sequential mode* is given by:

$$(1/f_{MAX}) = T_{CY} = T_{IS} + T_{CKO}$$

This frequency depends on the number of transition terms T_n used. Having all 48 terms connected in the AND array does not appreciably impact performance; but the number of terms connected to each OR line affects T_{IS}, due to capacitive loading. The effect of this loading can be seen in Figure 1, showing the variation of T_{IS1} with the number of terms connected per OR.

The AC electrical characteristics contain two limits for the parameters T_{IS1} and T_{IS2}. The first, T_{IS1A} is guaranteed for a device with 24 terms connected to any OR line. T_{IS1B} is guaranteed for a device with 16 terms connected to any OR line.

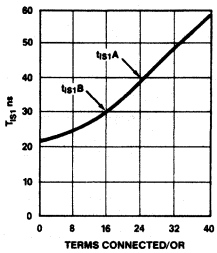


Figure 1. T_{IS1} vs. Terms/OR Connected.

The two other entries in the AC table, T_{IS2} A and B are corresponding 24 and 16 term limits when using the on-chip Complement Array.

The worst case of T_{IS} for a given application can be determined by identifying the OR line with the maximum number of T_n connections. This can be done by referring to the interconnect pattern in the FPLS logic diagram, typically illustrated in Figure 2, or by counting the maximum number of "H" *or* "L" entries in one of the columns of the device Program Table.

This number plotted on the curve in Figure 1 will yield the worst case T_{IS} and, by implication, the maximum clocking frequency for reliable operation.

Note that for maximum speed all UNUSED transition terms should be disconnected from the OR array.

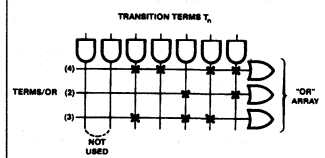


Figure 2. Typical OR Array Interconnect Pattern.

Field Programmable Logic Sequencer (14 x 48 x 6) PLS167A

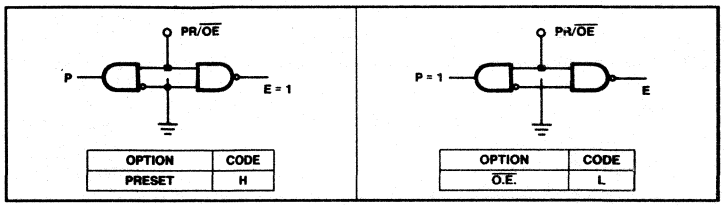
LOGIC PROGRAMMING

The FPLS can be programmed by means of Logic programming equipment.

With Logic programming, the AND/OR gate input connections necessary to implement the desired logic function are coded directly from the State Diagram using the Program Table on the following page.

In this table, the logic state or action of control variables C, I, P, N, and F, associated with each Transition Term T_n, is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

PRESET/$\overline{O.E.}$ OPTION – (P/E)



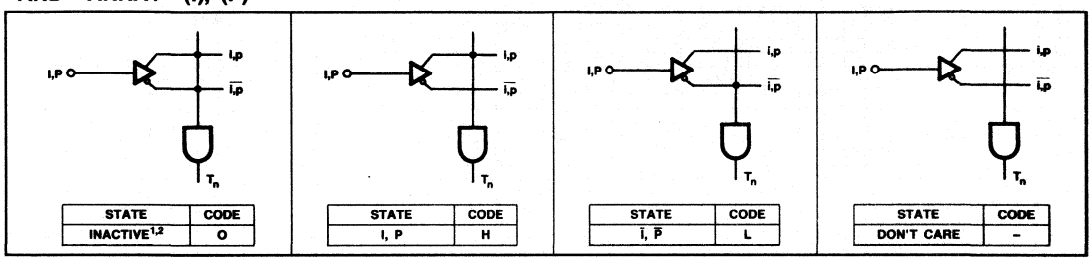
OPTION	CODE
PRESET	H

OPTION	CODE
$\overline{O.E.}$	L

PROGRAMMING:

The PLS167A has a power-up preset feature. This feature insures that the device will power-up in a known state with all register elements (state and output register) at a logic High (H). When programming the device it is important to realize this is the initial state of the device. You *must* provide a next state jump if you do not wish to use all Highs (H) as the present state.

"AND" ARRAY – (I), (P)



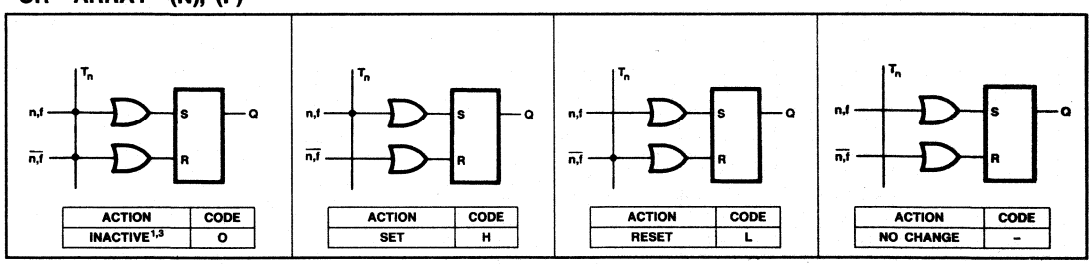
STATE	CODE
INACTIVE[1,2]	O

STATE	CODE
I, P	H

STATE	CODE
$\overline{I}$, $\overline{P}$	L

STATE	CODE
DON'T CARE	-

"OR" ARRAY – (N), (F)



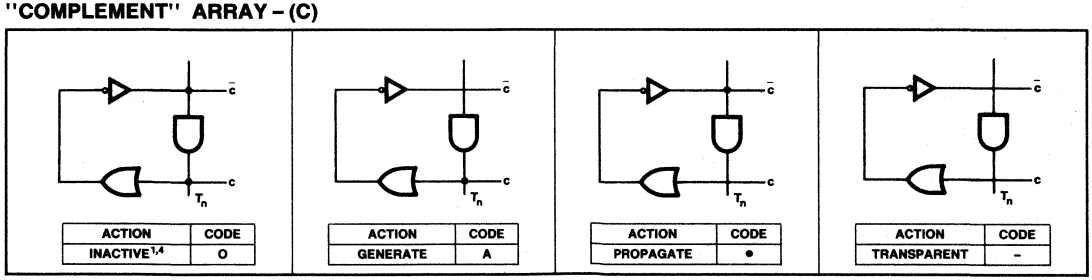
ACTION	CODE
INACTIVE[1,3]	O

ACTION	CODE
SET	H

ACTION	CODE
RESET	L

ACTION	CODE
NO CHANGE	-

"COMPLEMENT" ARRAY – (C)



ACTION	CODE
INACTIVE[1,4]	O

ACTION	CODE
GENERATE	A

ACTION	CODE
PROPAGATE	•

ACTION	CODE
TRANSPARENT	-

NOTES:

1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates T_n.
2. Any gate T_n will be unconditionally inhibited if any one of its I or P link pairs is left intact.
3. To prevent simultaneous Set and Reset flip-flop commands, this state is not allowed for N and F link pairs coupled to active gates T_n (see flip-flop truth tables).
4. To prevent oscillations, this state is not allowed for C link pairs coupled to active gates T_n.

Field Programmable Logic Sequencer (14 x 48 x 6) | PLS167A

FPLS PROGRAM TABLE

CUSTOMER NAME ____________________

PURCHASE ORDER # ____________________

SIGNETICS DEVICE # CF (XXXX)

CUSTOMER SYMBOLIZED PART # ____________________

TOTAL NUMBER OF PARTS ____________________

PROGRAM TABLE # ____________________

REV ____________________

DATE ____________________

PROGRAM TABLE ENTRIES

AND			OR		
INACTIVE	0	Cn	INACTIVE	0	Ns, Fr
GENERATE	A		SET	H	
PROPAGATE	•		RESET	L	
TRANSPARENT	–		NO CHANGE	–	
INACTIVE	0	Im, Ps	**OPTION**		
I, P	H		PRESET	H	P/E
$\overline{I}$, $\overline{P}$	L		$\overline{OE}$	L	
DON'T CARE	–				

AND | OPTION (P/E) | OR

TERM	Cn	INPUT (I_M) 13	12	11	10	9	8	7	6	5	4	3	2	1	0	PRESENT STATE (P_S) 7	6	5	4	3	2	1	0	REMARKS	NEXT STATE (N_S) 7	6	5	4	3	2	1	0	OUTPUT (Fr) 3	2	1	0
0																																				
1																																				
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PIN NO.		17	18	19	20	21	22	23	2	3	4	5	6	7	8																15	14	13	11	10	9
VARIABLE NAME																																				

TB01620S

NOTES:

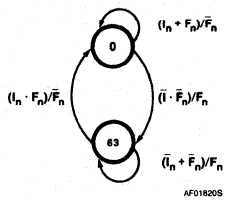
1. The FPLS is shipped with all links initially intact. Thus, a background of "0" for all Terms, and an "H" for P/E option, exists in the table, shown BLANK instead for clarity.
2. Unused Cn, Im, and Ps bits are normally programmed Don't Care (–).
3. Unused Transition Terms can be left blank for future code modification or programmed as (–) for maximun speed.
4. Letters in variable fields are used as identifiers by logic programmers.

TEST ARRAY

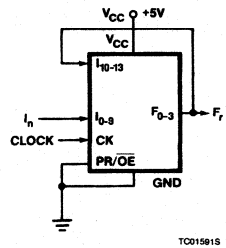
The FPLS may be subjected to AC and DC parametric tests prior to programming via an on-chip test array.

The array consists of test transition terms 48 and 49, factory programmed as shown below.

Testing is accomplished by clocking the FPLS and applying the proper input sequence to $I_{0\text{-}9}$ as shown in the test circuit timing diagram.



State Diagram



FPLS Under Test

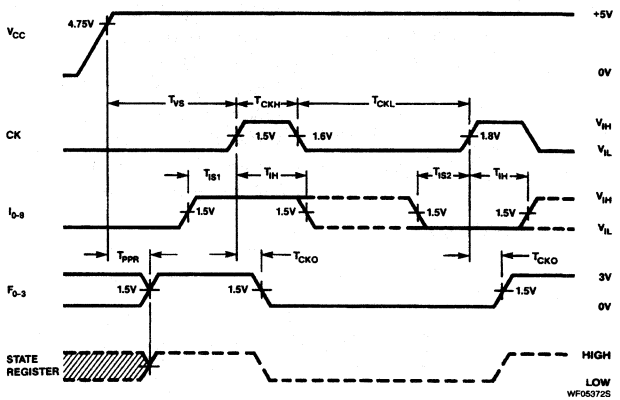
TERM	C	AND: INPUT (Im) 13	12	11	10	9	8	7	6	5	4	3	2	1	0	PRESENT STATE (Ps) 7	6	5	4	3	2	1	0
48	A	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H
49	●	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L

OPTION (P/E)	H											
OR												
NEXT STATE (Ns)									OUTPUT (Fr)			
7	6	5	4	3	2	1	0		3	2	1	0
L	L	L	L	L	L	L	L		L	L	L	L
H	H	H	H	H	H	H	H		H	H	H	H

TB01600S

Test Array Program

Both terms 48 and 49 must be deleted during user programming to avoid interfering with the desired logic function. This is accomplished automatically by any Signetic's qualified programming equipment.



Test Circuit Timing Diagram

TERM	C	AND: INPUT (Im) 13	12	11	10	9	8	7	6	5	4	3	2	1	0	PRESENT STATE (Ps) 7	6	5	4	3	2	1	0
48	–	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H
49	●	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L

OPTION (P/E)	H											
OR												
NEXT STATE (Ns)									OUTPUT (Fr)			
7	6	5	4	3	2	1	0		3	2	1	0
–	–	–	–	–	–	–	–		–	–	–	–
–	–	–	–	–	–	–	–		–	–	–	–

TB01610S

Test Array Deleted

Signetics

PLS168
Field Programmable Logic Sequencer (12 x 48 x 8)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 24**

DESCRIPTION

The PLS168 is a bipolar, programmable state machine of the Mealy type. It contains logic AND-OR gate arrays with user programmable connections which control the inputs of on-chip state and output registers. These consist respectively of 10 Q_p, and 4 Q_f edge-triggered, clocked S/R flip-flops, with an asynchronous preset option.

All flip-flops are unconditionally preset to "1" during power turn-on.

The AND array combines 12 external inputs, $I_{0\text{-}11}$, with 10 internal inputs, $P_{0\text{-}9}$, fed back from the State register to form up to 48 transition terms (AND terms). In addition, P_0-P_3 of the internal state register are brought off-chip to allow extending the output register to 8 bits, if so desired.

All transition terms can include True, False, or Don't Care states of the controlling variables, and are merged in the OR array to issue next-state and next-output commands to their respective registers on the low to high transition of the Clock pulse.

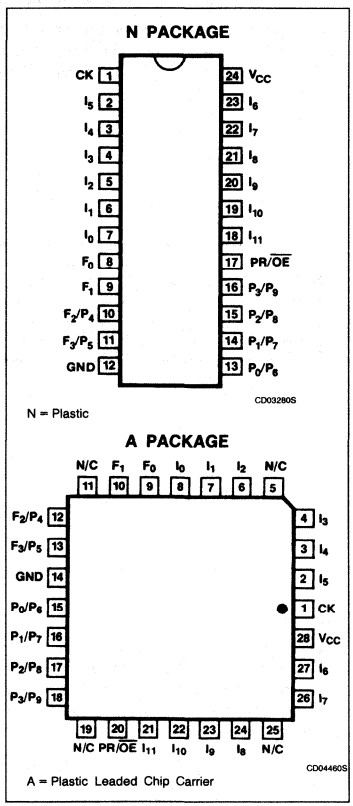
Both True and Complement transition terms can be generated by optional use of the internal variable (C) from the complement array. Also, if desired, the Preset input can be converted to output-enable function, as an additional user programmable option.

Order codes for this device are contained on the pages following.

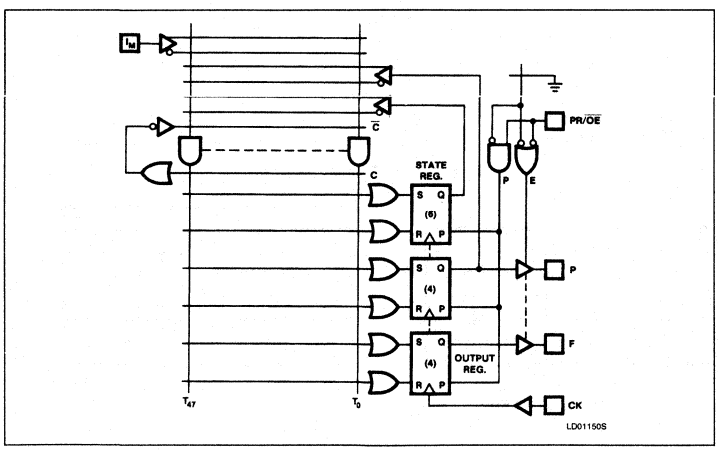
FEATURES

- **Field programmable (Ni-Cr link)**
- **12 True/Complement buffered inputs**
- **48 programmable AND gates**
- **29 programmable OR gates**
- **10-bit state register**
- **4-bit shared state/output register**
- **4-bit output register**
- **Transition complement array**
- **Programmable asynchronous preset/output enable**
- **Positive edge-trigger clock**
- **Power-on preset to logic "1" of all registers**
- **Automatic logic "HOLD" state via S/R flip-flops**
- **On/chip test array**
- **$f_{(max)}$: 13.9MHz**
- **Power: 600mW**
- **TTL compatible**
- **Three-state outputs**
- **Single +5V supply**
- **300 mil wide 24-pin DIP**

PIN CONFIGURATION



FUNCTIONAL DIAGRAM



APPLICATIONS

- **Interface protocols**
- **Sequence detectors**
- **Peripheral controllers**
- **Timing generators**
- **Sequential circuits**
- **Elevator controllers**
- **Security locking systems**
- **Counters**
- **Shift registers**

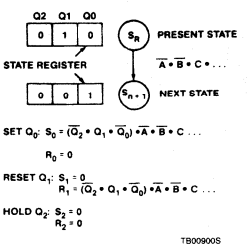
Field Programmable Logic Sequencer (12 x 48 x 8) PLS168

PIN DESCRIPTION

PIN NO.	SYMBOL	NAME AND FUNCTION	POLARITY
1	CK	**Clock:** The Clock input to the state and output registers. A low-to-high transition on this line is necessary to update the contents of both registers.	Active-high
2 – 7 18 – 23	I_{1-11}	**Logic Inputs:** The 11 external inputs to the AND array used to program jump conditions between machine states, as determined by a given logic sequence.	Active-high/low
7	I_0	**Logic/Diagnostic Input:** A 12th external logic input to the AND array, as above, when exercised with standard TTL levels. When I_0 is held at +10V, device outputs F_{2-3} and P_{0-3} reflect the contents of state register bits P_{4-9} (see Diagnostic Output Mode diagram on page 7). The contents of flip-flops P_{0-1} and F_{0-3} remain unaltered.	Active-high/low
13 – 16	P_{0-3}	**Logic/Diagnostic Outputs:** Four device outputs which normally reflect the contents of state register bits P_{0-3}. When I_0 is held at +10V these pins reflect ($P_6 - P_9$).	Active-high
10 – 11	$F_2 - F_3$	**Logic/Diagnostic Outputs:** Two register bits ($F_2 - F_3$) which normally reflect output register bits ($Q_2 - Q_3$). When I_0 is held at +10V these pins reflect ($P_4 - P_5$).	Active-high
17	PR/$\overline{O.E.}$	**Preset or $\overline{\text{Output Enable}}$ Input:** A user programmable function: • **Preset:** Provides an asynchronous preset to logic "1" of all state and output register bits. Preset overrides Clock, and when held high, clocking is inhibited and P_{0-9} and F_{0-3} are high. Normal clocking resumes with the first full clock pulse following a high-to-low clock transition, after Preset goes low. • **$\overline{\text{Output Enable}}$:** Provides an Output Enable function to all output buffers.	Active-high (H) Active-low (L)
8, 9	$F_0 - F_1$	**Logic Output:** Two device outputs which reflect output registers $Q_0 - Q_1$. When I_0 is held at +10V $F_0 - F_1$ = Logic "1"	

LOGIC FUNCTION

Typical State Transition:



VIRGIN STATE

A factory shipped virgin device contains all fusible links intact, such that:

1. PR/$\overline{OE}$ option is set to PR. Thus, all outputs will be at "1", as preset by initial power-up procedure.
2. All transition terms are disabled (0).
3. All S/R flip-flop inputs are disabled (0).
4. The device can be clocked via a Test Array pre-programmed with a standard test pattern.
   NOTE: The Test Array pattern MUST be deleted before incorporating a user program.

TRUTH TABLE[1, 2, 3, 4, 5, 6]

V_{CC}	OPTION		I_0	CK	S	R	$Q_{P/F}$	F
	PR	$\overline{O.E.}$						
+5V	H		*	X	X	X	H	H
	L		+10V	X	X	X	Q_n	$(Q_P)_n$
	L		X	X	X	X	Q_n	$(Q_F)_n$
		H	*	X	X	X	Q_n	Hi-Z
		L	+10V	X	X	X	Q_n	$(Q_P)_n$
		L	X	X	X	X	Q_n	$(Q_F)_n$
		L	X	↑	L	L	Q_n	$(Q_F)_n$
		L	X	↑	L	H	L	L
		L	X	↑	H	L	H	H
		L	X	↑	H	H	IND.	IND.
↑	X	X	X	X	X	X	H	

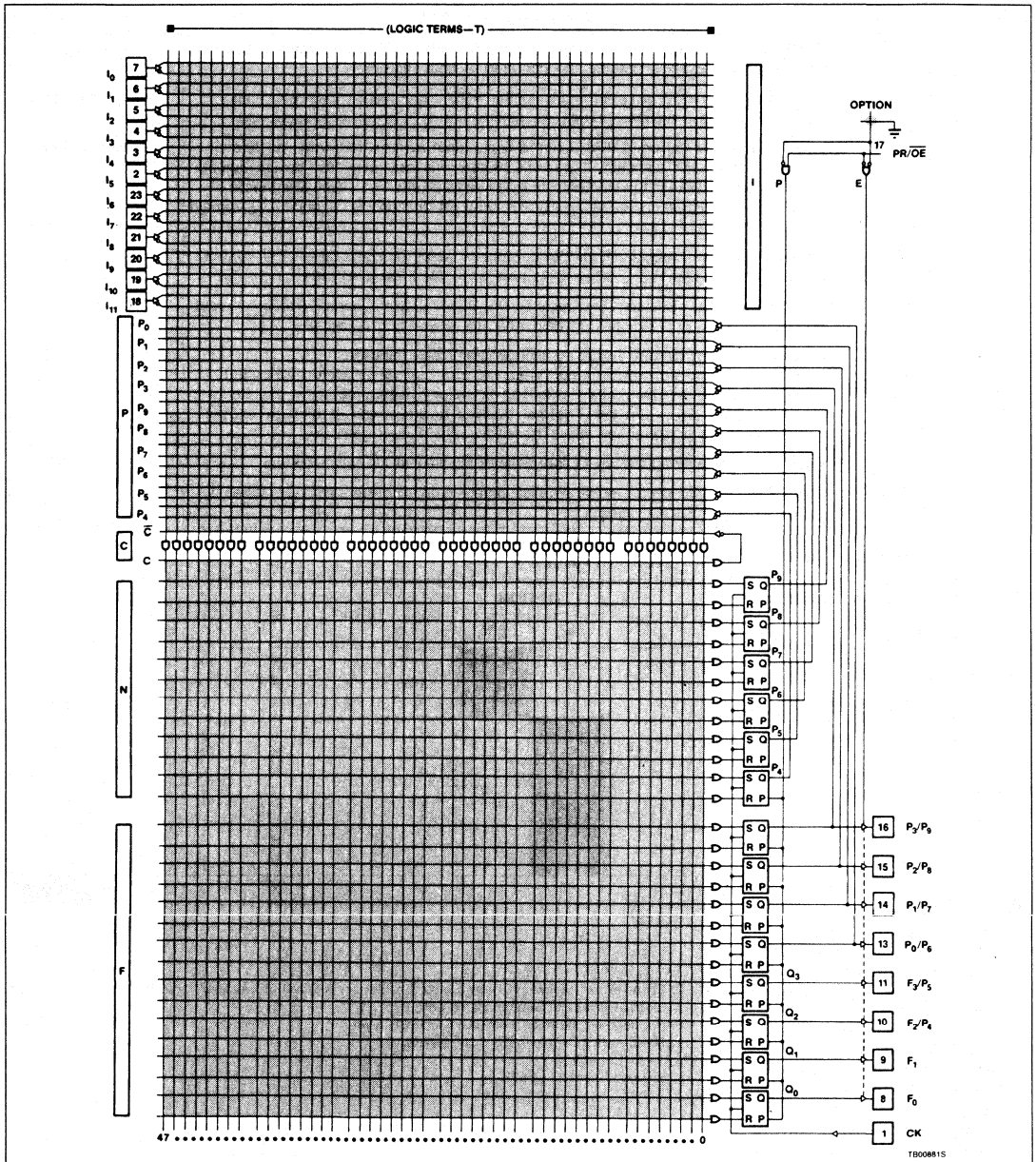
NOTES:

1. Positive Logic:
   $S/R = T_0 + T_1 + T_2 + \ldots + T_{47}$
   $T_n = C(I_0\ I_1\ I_2 \ldots)\ (P_0\ P_1 \ldots P_5)$
2. Either Preset (active-HIGH) or $\overline{\text{Output Enable}}$ (active-LOW) are available, but not both. The desired function is a user programmable option.
3. ↑ denotes transition from LOW to HIGH level.
4. R = S = HIGH is an illegal input condition.
5. * = H/L/+10V
6. X = Don't care ($\leq$ 5.5V)

5

Field Programmable Logic Sequencer (12 x 48 x 8) PLS168

FPLS LOGIC DIAGRAM



NOTES:
1. All programmed "AND" gate locations are pulled to logic "1".
2. All programmed "OR" gate locations are pulled to logic "0".
3. ▒ Programmable connection.

Field Programmable Logic Sequencer (12 x 48 x 8) PLS168

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 300mil 24 pin	PLS168N
Plastic Leaded Chip Carrier 28 pin	PLS168A

THERMAL RATING

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING Min	RATING Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input currents	−30	+30	mA
I_{IN}	Output currents		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	−65	+150	

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq 75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage[3]						
V_{IH}	High	V_{CC} = Max	2			V
V_{IL}	Low	V_{CC} = Min			0.8	
V_{IC}	Clamp[4]	V_{CC} = Min, I_{IN} = −12mA		−0.8	−1.2	
Output voltage[3]		V_{CC} = Min				
V_{OH}	High[5]	I_{OH} = −2mA	2.4			V
V_{OL}	Low[6]	I_{OL} = 9.6mA		0.35	0.45	
Input current						
I_{IH}	High	V_{IN} = 5.5V		< 1	25	μA
I_{IL}	Low	V_{IN} = 0.45V		−10	−100	
I_{IL}	Low (CK input)	V_{IN} = 0.45V		−50	−250	
Output current		V_{CC} = Max				
$I_{O(OFF)}$	Hi-Z State[7]	V_{CC} = 5.5V		1	40	μA
		V_{OUT} = 0.45V		−1	−40	
I_{OS}	Short circuit[4, 8]	V_{OUT} = 0V	−15		−70	mA
I_{CC}	V_{CC} supply current[9]	V_{CC} = Max		120	180	mA
Capacitance[7]		V_{CC} = 5.0V				
C_{IN}	Input	V_{IN} = 2.0V		8		pF
C_{OUT}	Output	V_{OUT} = 2.0V		10		

NOTES:
1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other condition above those indicated in the operational and programming specification of the device is not implied.
2. All typical values are at V_{CC} = 5V. T_A = 25°C.
3. All voltage values are with respect to network ground terminal.
4. Test one at a time.
5. Measured with V_{IL} applied to $\overline{O.E.}$ and a logic high stored, or with V_{IH} applied to PR.
6. Measured with a programmed logic condition for which the output is at a low logic level, and V_{IL} applied to PR/$\overline{O.E.}$ Output sink current is supplied through a resistor to V_{CC}.
7. Measured with V_{IH} applied to PR/$\overline{O.E.}$.
8. Duration of short circuit should not exceed 1 second.
9. I_{CC} is measured with the PR/$\overline{O.E.}$ input grounded, all other inputs at 4.5V and the outputs open.

Field Programmable Logic Sequencer (12 x 48 x 8) PLS168

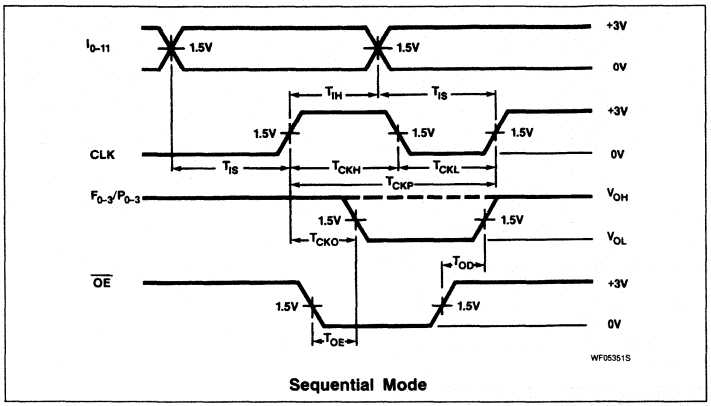
AC ELECTRICAL CHARACTERISTICS $R_1 = 470\Omega$, $R_2 = 1k\Omega$, $C_L = 30pF$ $0°C \leq T_A \leq +75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TO	FROM	LIMITS			UNIT
				Min	Typ[1]	Max	
Pulse width							
T_{CKH}	Clock[2] high	CK –	CK +	25	15		ns
T_{CKL}	Clock low	CK +	CK –	25	15		
$T_{CKP1}B$	Period (w/o c-array)	CK +	CK +	80	40		
$T_{CKP2}B$	Period (w/c-array)	CK +	CK +	120	60		
T_{PRH}	Preset pulse	PR +	PR –	25	15		
Set-up time[3]							
$T_{IS1}A$	Input	CK +	Input ±	60			ns
$T_{IS1}B$	Input	CK +	Input ±	50			
$T_{IS1}C$	Input	CK +	Input ±	42			
$T_{IS2}A$	Input (through Complement array)	CK +	Input ±	90			
$T_{IS2}B$	Input (through Complement array)	CK +	Input	80			
$T_{IS2}C$	Input (through Complement array)	CK +	Input	72			
T_{VS}	Power-on preset	CK –	V_{CC} +	0	–10		
T_{PRS}	Preset	CK –	PR –	0	–10		
Hold time							
T_{IH}	Input	Input ±	CK +	5	–10		ns
Propagation delay							
T_{CKO}	Clock	Output ±	CK +		15	30	ns
T_{OE}	Output enable	Output –	O.E. –		20	30	
T_{OD}	Output disable	Output +	O.E. +		20	30	
T_{PR}	Preset	Output +	PR +		18	30	
T_{PPR}	Power-on preset	Output +	V_{CC} +		0	10	
Frequency of operation[3]							
$f_{MAX}C$	w/o c-array					13.9	MHz
$f_{MAX}C$	w/c-array					9.8	

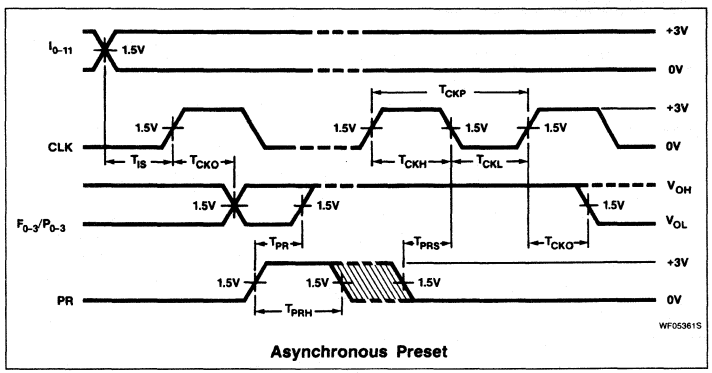
NOTES:
1. All typical values are at $V_{CC} = 5V$, $T_A = 25°C$.
2. To prevent spurious clocking, clock rise time (10%-90%) ≤ 30ns.
3. See "Speed vs. OR Loading" on page 8.

Field Programmable Logic Sequencer (12 x 48 x 8) PLS168

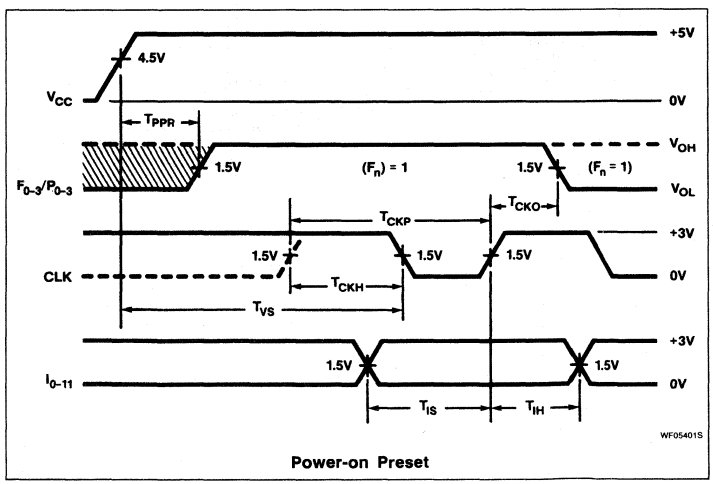
TIMING DIAGRAMS



Sequential Mode



Asynchronous Preset



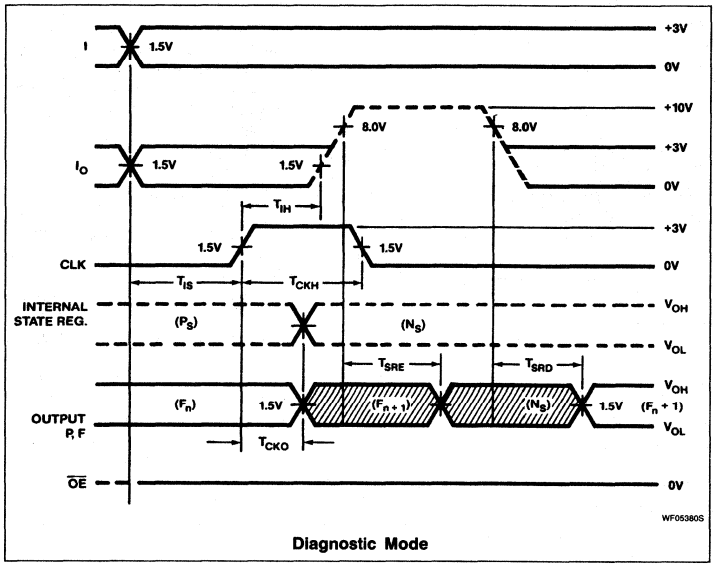
Power-on Preset

TIMING DEFINITIONS

T_{CKH}	Width of input clock pulse.
T_{CKL}	Interval between clock pulses.
T_{CKP1}	Clock period – when not using Complement array.
T_{IS1}	Required delay between beginning of valid input and positive transition of clock.
T_{CKP2}	Clock period – when using complement array.
T_{IS2}	Required delay between beginning of valid input and positive transition of clock, when using optional Complement Array (two passes necessary through the AND array).
T_{VS}	Required delay between V_{CC} (after power-on) and negative transition of clock preceding first reliable clock pulse.
T_{PRS}	Required delay between negative transition of asynchronous Preset and negative transition of clock preceding first reliable clock pulse.
T_{IH}	Required delay between positive transition of clock and end of valid input data.
T_{CKO}	Delay between positive transition of clock and when Outputs become valid (with PR/$\overline{O.E.}$ low).
T_{OE}	Delay between beginning of Output Enable Low and when Outputs become valid.
T_{OD}	Delay between beginning of Output Enable High and when Outputs are in the off state.
T_{SRE}	Delay between input I_0 transition to Diagnostic mode and when the Outputs reflect the contents of the State Register.
T_{SRD}	Delay between input I_0 transition to Logic mode and when the Outputs reflect the contents of the Output Register.
T_{PR}	Delay between positive transition of Preset and when Outputs become valid "1".
T_{PPR}	Delay between V_{CC} (after power-on) and when Outputs become preset at "1".
T_{PRH}	Width of preset input pulse.
f_{MAX}	Maximum clock frequency.

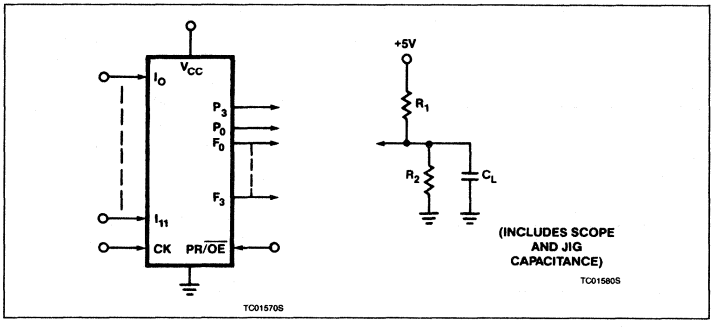
5

TIMING DIAGRAMS (Continued)

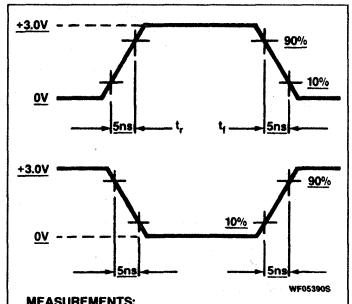


Diagnostic Mode

TEST LOAD CIRCUIT



VOLTAGE WAVEFORM



MEASUREMENTS:
All circuit delays are measured at the +1.5V level of inputs and output, unless otherwise specified.

Input Pulses

Field Programmable Logic Sequencer (12 x 48 x 8) PLS168

SPEED VS. "OR" LOADING

The maximum frequency at which the FPLS can be clocked while operating in *sequential mode* is given by:

$$(1/f_{MAX}) = T_{CY} = T_{IS} + T_{CKO}$$

This frequency depends on the number of transition terms T_n used. Having all 48 terms connected in the AND array does not appreciably impact performance; but the number of terms connected to each OR line affects T_{IS}, due to capacitive loading. The effect of this loading can be seen in Figure 1, showing the variation of T_{IS1} with the number of terms connected per OR.

The AC electrical characteristics contain three limits for the parameters T_{IS1} and T_{IS2}. The first, T_{IS1A} is guaranteed for a device with 48 terms connected to any OR line. T_{IS1B} is guaranteed for a device with 32 terms connected to any OR line. And T_{IS1C} is guaranteed for a device with 24 terms connected to any OR line.

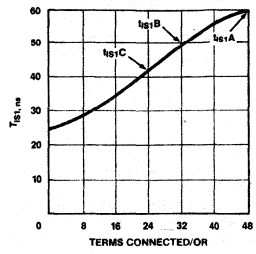


Figure 1. T_{IS1} vs. Terms/OR Connected.

The three other entries in the AC table, T_{IS2} A, B and C are corresponding 48, 32 and 24 term limits when using the on-chip Complement Array.

The worst case of T_{IS} for a given application can be determined by identifying the OR line with the maximum number of T_n connections. This can be done by referring to the interconnect pattern in the FPLS logic diagram, typically illustrated in Figure 2, or by counting the maximum number of "H" *or* "L" entries in one of the columns of the device Program Table.

This number plotted on the curve in Figure 1 will yield the worst case T_{IS} and, by implication, the maximum clocking frequency for reliable operation.

Note that for maximum speed all UNUSED transition terms should be disconnected from the OR array.

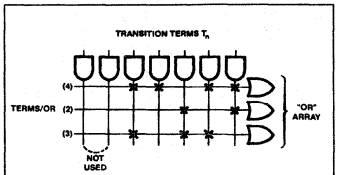


Figure 2. Typical OR Array Interconnect Pattern.

5

Field Programmable Logic Sequencer (12 x 48 x 8) PLS168

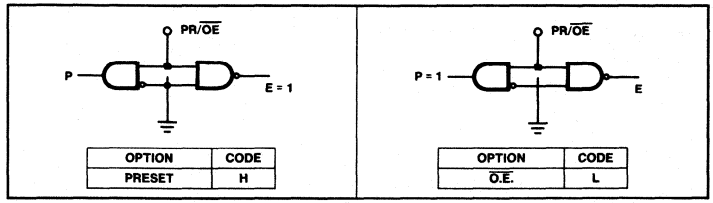
LOGIC PROGRAMMING

The FPLS can be programmed by means of Logic programming equipment.

With Logic programming, the AND/OR gate input connections necessary to implement the desired logic function are coded directly from the State Diagram using the Program Table on the following page.

In this table, the logic state or action of control variables C, I, P, N, and F, associated with each Transition Term T_n, is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

PRESET/$\overline{O.E.}$ OPTION – (P/E)



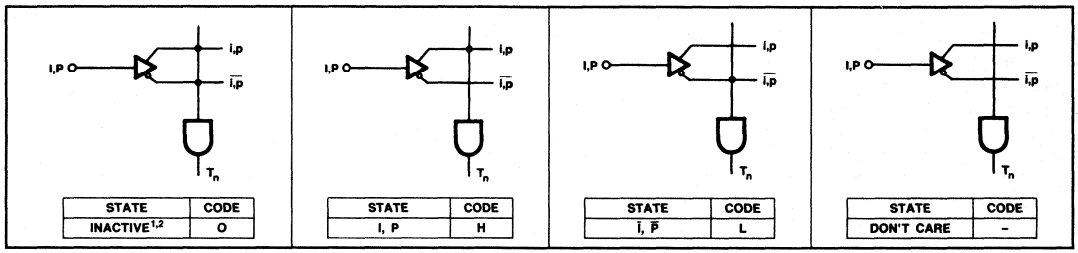
OPTION	CODE
PRESET	H

OPTION	CODE
$\overline{O.E.}$	L

PROGRAMMING:

The PLS168 has a power-up preset feature. This feature insures that the device will power-up in a known state with all register elements (state and output register) at a logic high (H). When programming the device it is important to realize this is the initial state of the device. You *must* provide a next state jump if you do not wish to use all highs (H) as the present state.

"AND" ARRAY – (I), (P)



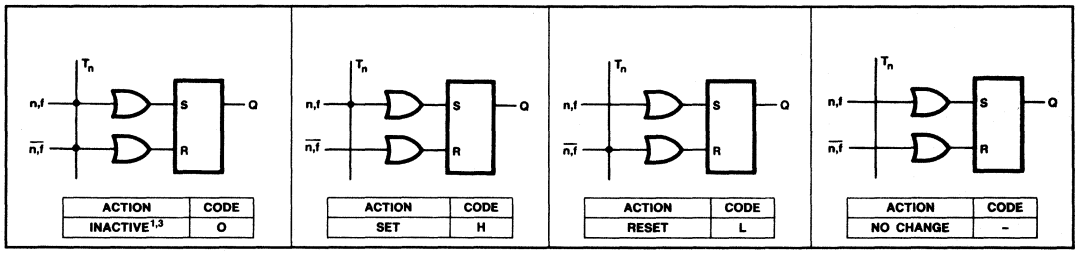
STATE	CODE
INACTIVE[1,2]	O

STATE	CODE
I, P	H

STATE	CODE
$\overline{I}$, $\overline{P}$	L

STATE	CODE
DON'T CARE	-

"OR" ARRAY – (N), (F)



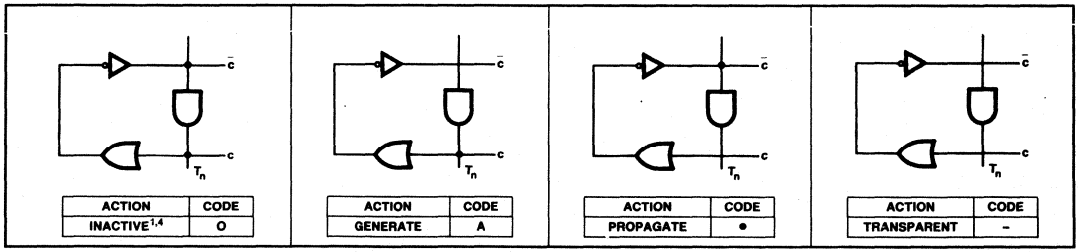
ACTION	CODE
INACTIVE[1,3]	O

ACTION	CODE
SET	H

ACTION	CODE
RESET	L

ACTION	CODE
NO CHANGE	-

"COMPLEMENT" ARRAY – (C)



ACTION	CODE
INACTIVE[1,4]	O

ACTION	CODE
GENERATE	A

ACTION	CODE
PROPAGATE	•

ACTION	CODE
TRANSPARENT	-

NOTES:

1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates T_n.
2. Any gate T_n will be unconditionally inhibited if any one of its I or P link pairs is left intact.
3. To prevent simultaneous Set and Reset flip-flop commands, this state is not allowed for N and F link pairs coupled to active gates T_n (see flip-flop truth tables).
4. To prevent oscillations, this state is not allowed for C link pairs coupled to active gates T_n.

Field Programmable Logic Sequencer (12 x 48 x 8) PLS168

FPLS PROGRAM TABLE PLS168

CUSTOMER NAME _____
PURCHASE ORDER # _____
SIGNETICS DEVICE # CF (XXXX)
CUSTOMER SYMBOLIZED PART # _____
TOTAL NUMBER OF PARTS _____
PROGRAM TABLE # _____
REV _____
DATE _____

AND

INACTIVE	0	C_n
GENERATE	A	
PROPAGATE	+	
TRANSPARENT	–	
INACTIVE	0	I_m P_s
I, P	H	
I, $\overline{P}$	L	
DON'T CARE	–	

OR

INACTIVE	0	N_s, F_r
SET	H	
RESET	L	
NO CHANGE	–	

OPTION

PRESET	H	P/E
OE	L	

TERM	C_n	INPUT(Im) 11 10 9 8 7 6 5 4 3 2 1 0	PRESENT STATE (Ps) (Px) 9 8 7 6 5 4 3 2 1 0	REMARKS	NEXT STATE (Ns) (Px) 9 8 7 6 5 4	OUTPUT (Fr) 3 2 1 0	OPTION (P/E) 3 2 1 0
0							
1							
2							
3							
4							
5							
6							
7							
8							
9							
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44							
45							
46							
47							

PIN NO.	18	19	20	21	22	23	2	3	4	5	6	7	16	15	14	13	11	10	9	8
VARIABLE NAME																				

TB02030S

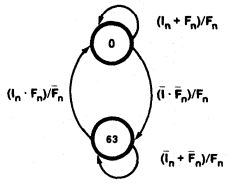
Field Programmable Logic Sequencer (12 x 48 x 8) PLS168

TEST ARRAY

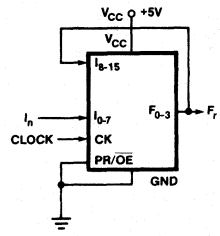
The FPLS may be subjected to AC and DC parametric tests prior to programming via an on-chip test array.

The array consists of test transition terms 48 and 49, factory programmed as shown below.

Testing is accomplished by clocking the FPLS and applying the proper input sequence to I_{0-9} as shown in the test circuit timing diagram.



State Diagram



FPLS Under Test

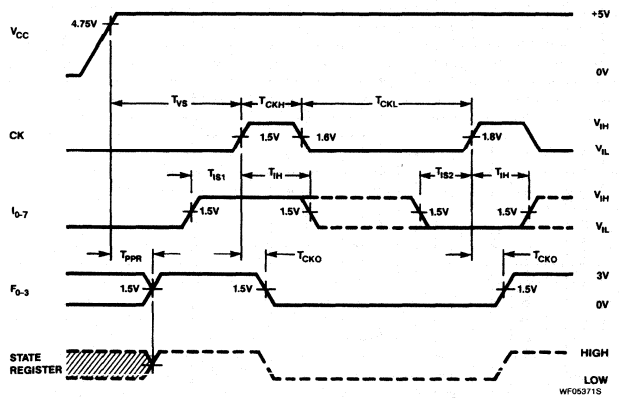
TERM	C_n	INPUT (Im)	PRESENT STATE (Ps) (Px)	REMARKS	NEXT STATE (Ns) (Px)	OUTPUT (Fr)
		11 10 9 8 7 6 5 4 3 2 1 0	9 8 7 6 5 4 3 2 1 0		9 8 7 6 5 4 3 2 1 0	3 2 1 0
48	A	H H H H H H H H H H H H	H H H H H H H H H H		L L L L L L L L L L	L L L L
49	•	L L L L L L L L L L L L	L L L L L L L L L L		H H H H H H H H H H	H H H H

AND — OR — OPTION (P E) H

TB00920S

Test Array Program

Both terms 48 and 49 must be deleted during user programming to avoid interfering with the desired logic function. This is accomplished automatically by any Signetic's qualified programming equipment.



Test Circuit Timing Diagram

TERM	C_n	INPUT (Im)	PRESENT STATE (Ps) (Px)	REMARKS	NEXT STATE (Ns) (Px)	OUTPUT (Fr)
		11 10 9 8 7 6 5 4 3 2 1 0	9 8 7 6 5 4 3 2 1 0		9 8 7 6 5 4 3 2 1 0	3 2 1 0
48	–	H H H H H H H H H H H H	H H H H H H H H H H		– – – – – – – – – –	– – – –
49	•	L L L L L L L L L L L L	L L L L L L L L L L		– – – – – – – – – –	– – – –

AND — OR — OPTION (P E) H

TB00910S

Test Array Deleted

Signetics

PLS168A
Field Programmable Logic Sequencer (12 x 48 x 8)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 24**

DESCRIPTION

The PLS168A is a bipolar, programmable state machine of the Mealy type. It contains logic AND-OR gate arrays with user programmable connections which control the inputs of on-chip state and output registers. These consist respectively of 10 Q_p, and 4 Q_f edge-triggered, clocked S/R flip-flops, with an asynchronous preset option.

All flip-flops are unconditionally preset to "1" during power turn-on.

The AND array combines 12 external inputs, $I_{0\text{-}11}$, with 10 internal inputs, $P_{0\text{-}9}$, fed back from the State register to form up to 48 transition terms (AND terms). In addition, P_0-P_3 of the internal state register are brought off-chip to allow extending the output register to 8 bits, if so desired.

All transition terms can include True, False, or Don't Care states of the controlling variables, and are merged in the OR array to issue next-state and next-output commands to their respective registers on the low to high transition of the Clock pulse.

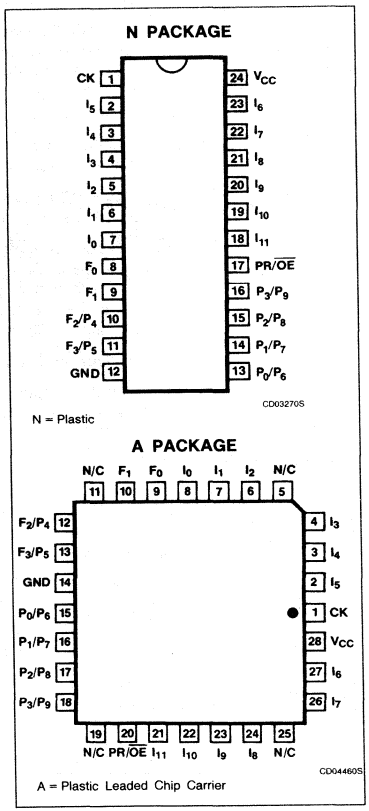
Both True and Complement transition terms can be generated by optional use of the internal variable (C) from the complement array. Also, if desired, the Preset input can be converted to output-enable function, as an additional user programmable option.

Order codes for this device are contained on the pages following.

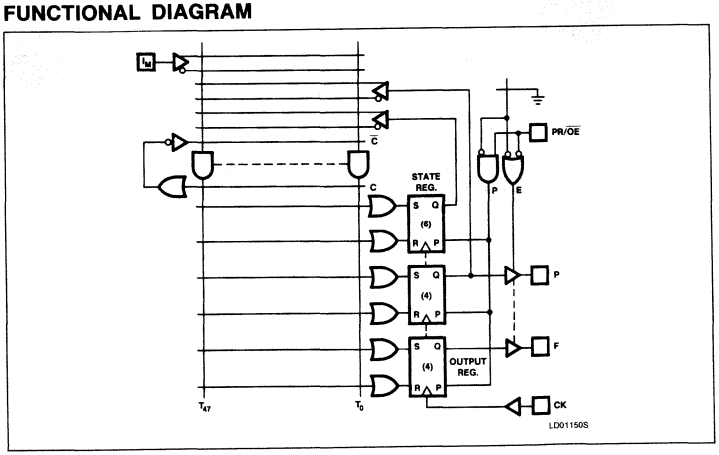
FEATURES

- **Field programmable (Ni-Cr link)**
- **12 True/Complement buffered inputs**
- **48 programmable AND gates**
- **29 programmable OR gates**
- **10-bit state register**
- **4-bit shared state/output register**
- **4-bit output register**
- **Transition complement array**
- **Programmable asynchronous preset/output enable**
- **Positive edge-trigger clock**
- **Power-on preset to logic "1" of all registers**
- **Automatic logic "HOLD" state via S/R flip-flops**
- **On/chip test array**
- **$f_{(max)}$: 20MHz**
- **Power: 600mW typ**
- **TTL compatible**
- **Three-state outputs**
- **Single +5V supply**
- **300 mil wide 24-pin DIP**

PIN CONFIGURATION



FUNCTIONAL DIAGRAM



APPLICATIONS

- **Interface protocols**
- **Sequence detectors**
- **Peripheral controllers**
- **Timing generators**
- **Sequential circuits**
- **Elevator controllers**
- **Security locking systems**
- **Counters**
- **Shift registers**

5

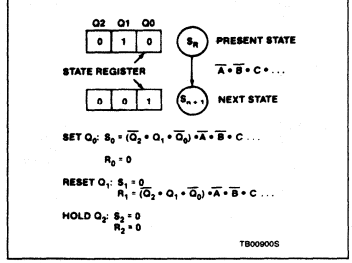
Field Programmable Logic Sequencer (12 x 48 x 8) PLS168A

PIN DESCRIPTION

PIN NO.	SYMBOL	NAME AND FUNCTION	POLARITY
1	CK	**Clock:** The Clock input to the state and output registers. A low-to-high transition on this line is necessary to update the contents of both registers.	Active-high
2 – 7 18 – 23	I_{1-11}	**Logic Inputs:** The 11 external inputs to the AND array used to program jump conditions between machine states, as determined by a given logic sequence.	Active-high/low
7	I_0	**Logic/Diagnostic Input:** A 12th external logic input to the AND array, as above, when exercised with standard TTL levels. When I_0 is held at +10V, device outputs $F_2 - F_3$ and $P_0 - P_3$ reflect the contents of state register bits P_{4-9} (see Diagnostic Output Mode diagram on page 7). The contents of flip-flops P_{0-1} and F_{0-3} remain unaltered.	Active-high/low
13 – 16	P_{0-3}	**Logic/Diagnostic Outputs:** Four device outputs which normally reflect the contents of state register bits P_{0-3}. When I_0 is held at +10V these pins reflect ($P_6 - P_9$).	Active-high
10 – 11	$F_2 - F_3$	**Logic/Diagnostic Outputs:** Two register bits ($F_2 - F_3$) which reflect output register bits ($Q_2 - Q_3$). When I_0 is held at +10V these pins reflect ($P_4 - P_5$).	Active-high
17	PR/$\overline{O.E.}$	**Preset or $\overline{\text{Output Enable}}$ Input:** A user programmable function: • **Preset:** Provides an asynchronous preset to logic "1" of all state and output register bits. Preset overrides Clock, and when held high, clocking is inhibited and P_{0-9} and F_{0-3} are high. Normal clocking resumes with the first full clock pulse following a high-to-low clock transition, after Preset goes low. • **$\overline{\text{Output Enable}}$:** Provides an Output Enable function to all output buffers.	Active-high (H) Active-low (L)
8, 9	$F_0 - F_1$	**Logic Output:** Two device outputs which reflect output registers $Q_0 - Q_1$. When I_0 is held at +10V $F_0 - F_1$ = Logic "1"	

LOGIC FUNCTION

Typical State Transition:



VIRGIN STATE

A factory shipped virgin device contains all fusible links intact, such that:

1. PR/$\overline{OE}$ option is set to PR. Thus, all outputs will be at "1", as preset by initial power-up procedure.
2. All transition terms are disabled (0).
3. All S/R flip-flop inputs are disabled (0).
4. The device can be clocked via a Test Array pre-programmed with a standard test pattern.
   NOTE: The Test Array pattern MUST be deleted before incorporating a user program.

TRUTH TABLE[1, 2, 3, 4, 5, 6]

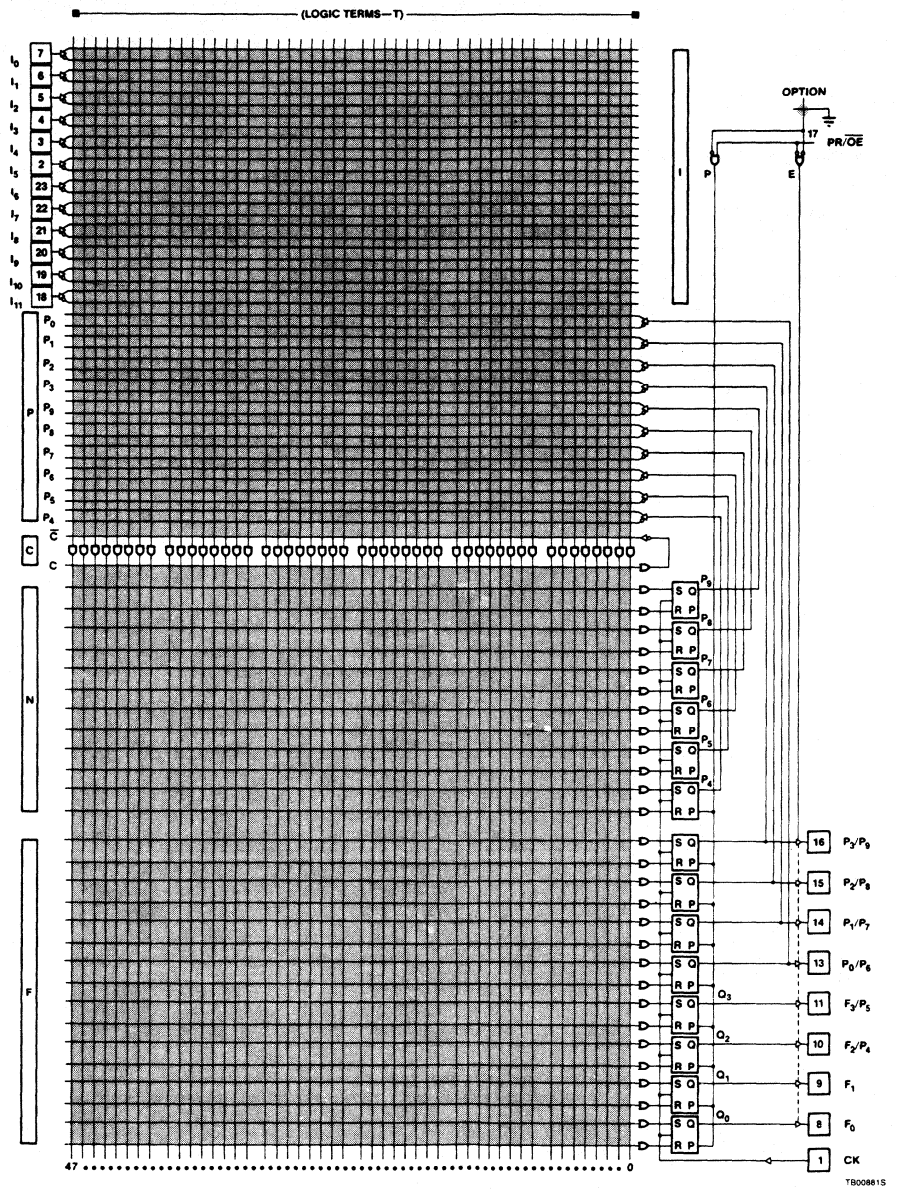
V_{CC}	OPTION		I_0	CK	S	R	$Q_{P/F}$	F
	PR	$\overline{O.E.}$						
+5V	H		*	X	X	X	H	H
	L		+10V	X	X	X	Q_n	$(Q_P)_n$
	L		X	X	X	X	Q_n	$(Q_F)_n$
		H	*	X	X	X	Q_n	Hi-Z
		L	+10V	X	X	X	Q_n	$(Q_P)_n$
		L	X	X	X	X	Q_n	$(Q_F)_n$
		L	X	↑	L	L	Q_n	$(Q_F)_n$
		L	X	↑	L	H	L	L
		L	X	↑	H	L	H	H
		L	X	↑	H	H	IND.	IND.
↑	X	X	X	X	X	X	H	

NOTES:

1. Positive Logic:
   $S/R = T_0 + T_1 + T_2 + ... + T_{47}$
   $T_n = C(I_0\ I_1\ I_2...)\ (P_0\ P_1...P_5)$
2. Either Preset (active-HIGH) or $\overline{\text{Output Enable}}$ (active-LOW) are available, but not both. The desired function is a user programmable option.
3. ↑ denotes transition from LOW to HIGH level.
4. R = S = HIGH is an illegal input condition.
5. * = H/L/+10V
6. X = Don't care ($\leq$5.5V)

Field Programmable Logic Sequencer (12 x 48 x 8) PLS168A

FPLS LOGIC DIAGRAM



NOTES:
1. All programmed "AND" gate locations are pulled to logic "1".
2. All programmed "OR" gate locations are pulled to logic "0".
3. ▒ Programmable connection.

Field Programmable Logic Sequencer (12 x 48 x 8) PLS168A

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 300mil 24 pin	PLS168AN
Plastic Leaded Chip Carrier 28 pin	PLS168AA

THERMAL RATING

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING Min	RATING Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input currents	−30	+30	mA
I_{IN}	Output currents		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	−65	+150	

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq 75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage[3]						
V_{IH}	High	V_{CC} = Max	2			V
V_{IL}	Low	V_{CC} = Min			0.8	
V_{IC}	Clamp[4]	V_{CC} = Min, I_{IN} = −12mA		−0.8	−1.2	
Output voltage[3]		V_{CC} = Min				
V_{OH}	High[5]	I_{OH} = −2mA	2.4			V
V_{OL}	Low[6]	I_{OL} = 9.6mA		0.35	0.45	
Input current						
I_{IH}	High	V_{IN} = 5.5V		< 1	25	μA
I_{IL}	Low	V_{IN} = 0.45V		−10	−100	
I_{IL}	Low (CK input)	V_{IN} = 0.45V		−50	−250	
Output current		V_{CC} = Max				
$I_{O(OFF)}$	Hi-Z State[7]	V_{CC} = 5.5V		1	40	μA
		V_{OUT} = 0.45V		−1	−40	
I_{OS}	Short circuit[4, 8]	V_{OUT} = 0V	−15		−70	mA
I_{CC}	V_{CC} supply current[9]	V_{CC} = Max		120	180	mA
Capacitance[7]		V_{CC} = 5.0V				
C_{IN}	Input	V_{IN} = 2.0V		8		pF
C_{OUT}	Output	V_{OUT} = 2.0V		10		

NOTES:

1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other condition above those indicated in the operational and programming specification of the device is not implied.
2. All typical values are at V_{CC} = 5V. T_A = 25°C.
3. All voltage values are with respect to network ground terminal.
4. Test one at a time.
5. Measured with V_{IL} applied to $\overline{O.E.}$ and a logic high stored, or with V_{IH} applied to PR.
6. Measured with a programmed logic condition for which the output is at a low logic level, and V_{IL} applied to PR/$\overline{O.E.}$ Output sink current is supplied through a resistor to V_{CC}.
7. Measured with V_{IH} applied to PR/$\overline{O.E.}$.
8. Duration of short circuit should not exceed 1 second.
9. I_{CC} is measured with the PR/$\overline{O.E.}$ input grounded, all other inputs at 4.5V and the outputs open.

Field Programmable Logic Sequencer (12 x 48 x 8) PLS168A

AC ELECTRICAL CHARACTERISTICS $R_1 = 470\Omega$, $R_2 = 1k\Omega$, $C_L = 30pF$ $0°C \leq T_A \leq +75°C$, $4.75V \leq V_{CC} \leq 5.25V$

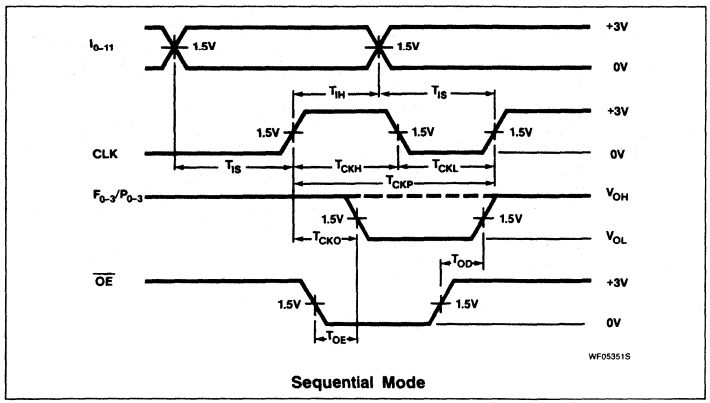
PARAMETER		TO	FROM	LIMITS			UNIT
				Min	Typ[1]	Max	
Pulse width							
T_{CKH}	Clock[2] high	CK –	CK +	25	15		ns
T_{CKL}	Clock low	CK +	CK –	25	15		
$T_{CKP1}B$	Period (w/o c-array)	CK +	CK +	50	40		
$T_{CKP2}B$	Period (w/c-array)	CK +	CK +	80	50		
T_{PRH}	Preset pulse	PR +	PR –	25	15		
Set-up time[3]							
$T_{IS1}A$	Input	CK +	Input ±	40			ns
$T_{IS1}B$	Input	CK +	Input ±	30			
$T_{IS2}A$	Input (through Complement array)	CK +	Input ±	70			
$T_{IS2}B$	Input (through Complement array)	CK +	Input	60			
T_{VS}	Power-on preset	CK –	V_{CC} +	0	–10		
T_{PRS}	Preset	CK –	PR –	0	–10		
Hold time							
T_{IH}	Input	Input ±	CK +	5	–10		ns
Propagation delay							
T_{CKO}	Clock	Output ±	CK +		15	20	ns
T_{OE}	Output enable	Output –	O.E. –		20	30	
T_{OD}	Output disable	Output +	O.E. +		20	30	
T_{PR}	Preset	Output +	PR +		18	30	
T_{PPR}	Power-on preset	Output +	V_{CC} +		0	10	
Frequency of operation[3]							
$f_{MAX}C$	w/o c-array					20	MHz
$f_{MAX}C$	w/c-array					12.5	

NOTES:
1. All typical values are at $V_{CC} = 5V$, $T_A = 25°C$.
2. To prevent spurious clocking, clock rise time (10%-90%) ≤ 30ns.
3. See "Speed vs. OR Loading" on page 8.

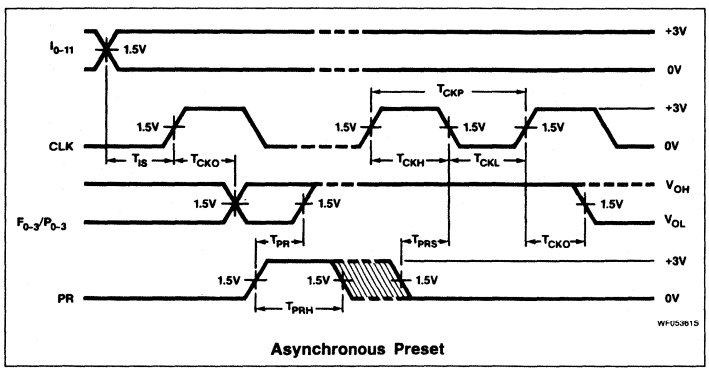
5

Field Programmable Logic Sequencer (12 x 48 x 8) PLS168A

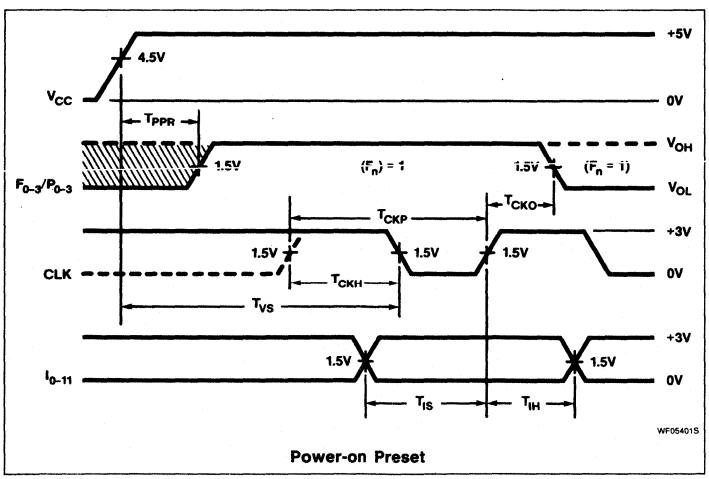
TIMING DIAGRAMS



Sequential Mode



Asynchronous Preset



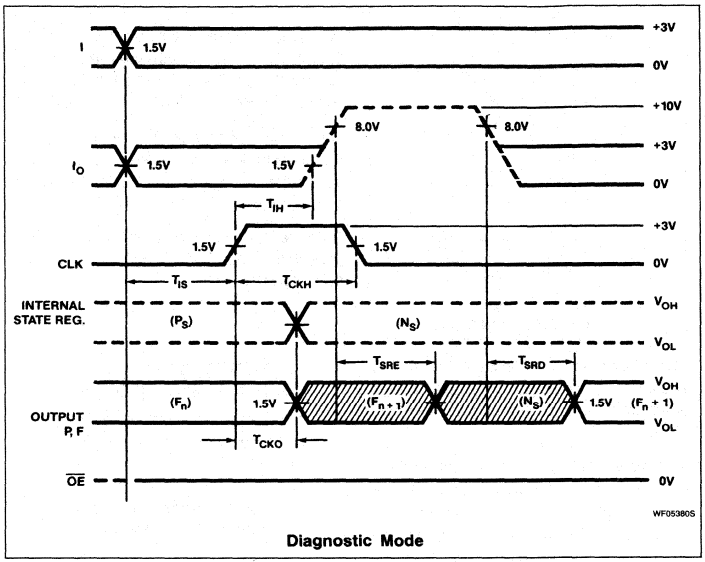
Power-on Preset

TIMING DEFINITIONS

T_{CKH}	Width of input clock pulse.
T_{CKL}	Interval between clock pulses.
T_{CKP1}	Clock period – when not using Complement array.
T_{IS1}	Required delay between beginning of valid input and positive transition of clock.
T_{CKP2}	Clock period – when using complement array.
T_{IS2}	Required delay between beginning of valid input and positive transition of clock, when using optional Complement Array (two passes necessary through the AND array).
T_{VS}	Required delay between V_{CC} (after power-on) and negative transition of clock preceding first reliable clock pulse.
T_{PRS}	Required delay between negative transition of asynchronous Preset and negative transition of clock preceding first reliable clock pulse.
T_{IH}	Required delay between positive transition of clock and end of valid input data.
T_{CKO}	Delay between positive transition of clock and when Outputs become valid (with PR/$\overline{O.E.}$ low).
T_{OE}	Delay between beginning of Output Enable Low and when Outputs become valid.
T_{OD}	Delay between beginning of Output Enable High and when Outputs are in the off state.
T_{SRE}	Delay between input I_0 transition to Diagnostic mode and when the Outputs reflect the contents of the State Register.
T_{SRD}	Delay between input I_0 transition to Logic mode and when the Outputs reflect the contents of the Output Register.
T_{PR}	Delay between positive transition of Preset and when Outputs become valid "1".
T_{PPR}	Delay between V_{CC} (after power-on) and when Outputs become preset at "1".
T_{PRH}	Width of preset input pulse.
f_{MAX}	Maximum clock frequency.

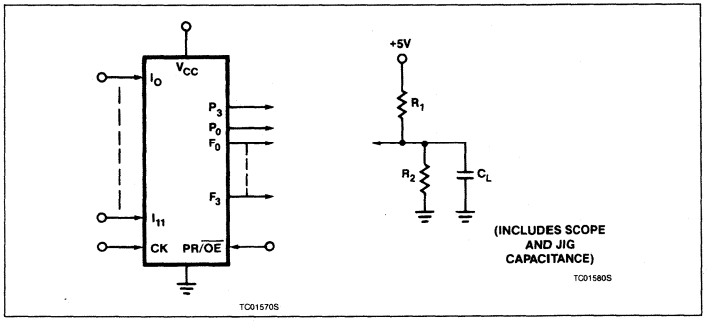
Field Programmable Logic Sequencer (12 x 48 x 8) PLS168A

TIMING DIAGRAMS (Continued)

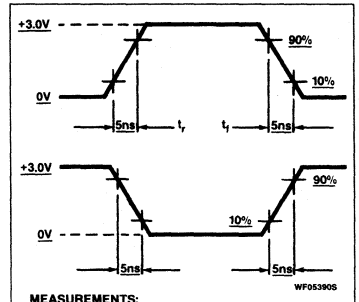


Diagnostic Mode

TEST LOAD CIRCUIT



VOLTAGE WAVEFORM



MEASUREMENTS:
All circuit delays are measured at the +1.5V level of inputs and output, unless otherwise specified.

Input Pulses

SPEED VS. "OR" LOADING

The maximum frequency at which the FPLS can be clocked while operating in *sequential mode* is given by:

$$(1/f_{MAX}) = T_{CY} = T_{IS} + T_{CKO}$$

This frequency depends on the number of transition terms T_n used. Having all 48 terms connected in the AND array does not appreciably impact performance; but the number of terms connected to each OR line affects T_{IS}, due to capacitive loading. The effect of this loading can be seen in Figure 1, showing the variation of T_{IS1} with the number of terms connected per OR.

The AC electrical characteristics contain two limits for the parameters T_{IS1} and T_{IS2}. The first, T_{IS1A} is guaranteed for a device with 24 terms connected to any OR line. T_{IS1B} is guaranteed for a device with 16 terms connected to any OR line.

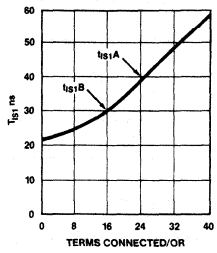


Figure 1. T_{IS1} vs. Terms/OR Connected.

The three other entries in the AC table, T_{IS2} A and B are corresponding 24 and 16 term limits when using the on-chip Complement Array.

The worst case of T_{IS} for a given application can be determined by identifying the OR line with the maximum number of T_n connections. This can be done by referring to the interconnect pattern in the FPLS logic diagram, typically illustrated in Figure 2, or by counting the maximum number of "H" *or* "L" entries in one of the columns of the device Program Table.

This number plotted on the curve in Figure 1 will yield the worst case T_{IS} and, by implication, the maximum clocking frequency for reliable operation.

Note that for maximum speed all UNUSED transition terms should be disconnected from the OR array.

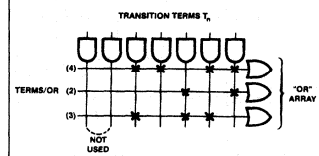


Figure 2. Typical OR Array Interconnect Pattern.

Field Programmable Logic Sequencer (12 x 48 x 8) PLS168A

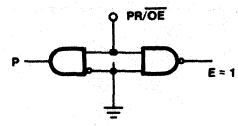
LOGIC PROGRAMMING

The FPLS can be programmed by means of Logic programming equipment.

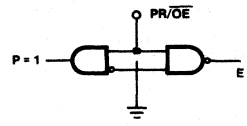
With Logic programming, the AND/OR gate input connections necessary to implement the desired logic function are coded directly from the State Diagram using the Program Table on the following page.

In this table, the logic state or action of control variables C, I, P, N, and F, associated with each Transition Term T_n, is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

PRESET/$\overline{O.E.}$ OPTION – (P/E)



OPTION	CODE
PRESET	H

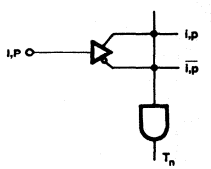


OPTION	CODE
$\overline{O.E.}$	L

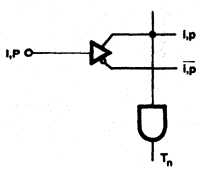
PROGRAMMING:

The PLS168A has a power-up preset feature. This feature insures that the device will power-up in a known state with all register elements (state and output register) at a logic high (H). When programming the device it is important to realize this is the initial state of the device. You *must* provide a next state jump if you do not wish to use all highs (H) as the present state.

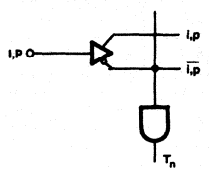
"AND" ARRAY – (I), (P)



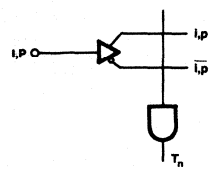
STATE	CODE
INACTIVE[1,2]	O



STATE	CODE
I, P	H

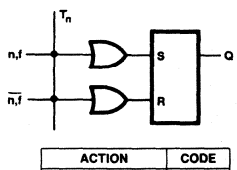


STATE	CODE
$\overline{I}$, $\overline{P}$	L

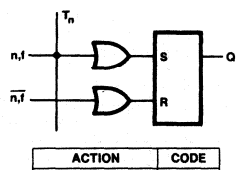


STATE	CODE
DON'T CARE	-

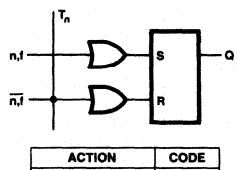
"OR" ARRAY – (N), (F)



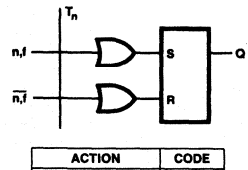
ACTION	CODE
INACTIVE[1,3]	O



ACTION	CODE
SET	H

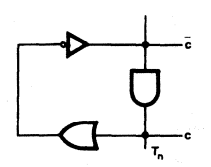


ACTION	CODE
RESET	L

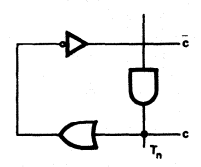


ACTION	CODE
NO CHANGE	-

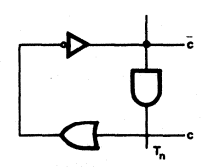
"COMPLEMENT" ARRAY – (C)



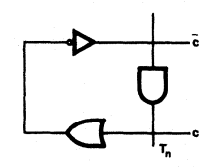
ACTION	CODE
INACTIVE[1,4]	O



ACTION	CODE
GENERATE	A



ACTION	CODE
PROPAGATE	•



ACTION	CODE
TRANSPARENT	-

NOTES:

1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates T_n.
2. Any gate T_n will be unconditionally inhibited if any one of its I or P link pairs is left intact.
3. To prevent simultaneous Set and Reset flip-flop commands, this state is not allowed for N and F link pairs coupled to active gates T_n (see flip-flop truth tables).
4. To prevent oscillations, this state is not allowed for C link pairs coupled to active gates T_n.

Field Programmable Logic Sequencer (12 x 48 x 8) PLS168A

FPLS PROGRAM TABLE PLS168A

CUSTOMER NAME ______

PURCHASE ORDER # ______

SIGNETICS DEVICE # CF (XXXX)

CUSTOMER SYMBOLIZED PART # ______

TOTAL NUMBER OF PARTS ______

PROGRAM TABLE # ______

REV ______

DATE ______

AND		
INACTIVE	O	C_n
GENERATE	A	
PROPAGATE	•	
TRANSPARENT	—	
INACTIVE	O	I_m P_s
I, P	H	
$\bar{I}, \bar{P}$	L	
DON'T CARE	—	

OR		
INACTIVE	O	$N_s \cdot F_r$
SET	H	
RESET	L	
NO CHANGE	—	

OPTION		
PRESET	H	P/E
OE	L	

AND — OPTION (P/E) — OR

TERM	C_n	INPUT (I_m) 11	10	9	8	7	6	5	4	3	2	1	0	PRESENT STATE (P_s) (P_x) 9	8	7	6	5	4	3	2	1	0	REMARKS	NEXT STATE (N_s) (P_x) 9	8	7	6	5	4	3	2	1	0	OUTPUT (F_r) 3	2	1	0
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PIN NO.		18	19	20	21	22	23	2	3	4	5	6	7																		16	15	14	13	11	10	9	8
VARIABLE NAME																																						

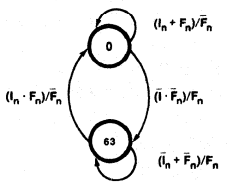
TB02030S

TEST ARRAY

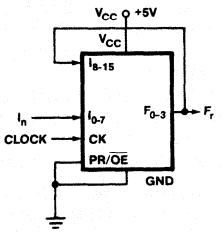
The FPLS may be subjected to AC and DC parametric tests prior to programming via an on-chip test array.

The array consists of test transition terms 48 and 49, factory programmed as shown below.

Testing is accomplished by clocking the FPLS and applying the proper input sequence to $I_{0\text{-}9}$ as shown in the test circuit timing diagram.



State Diagram

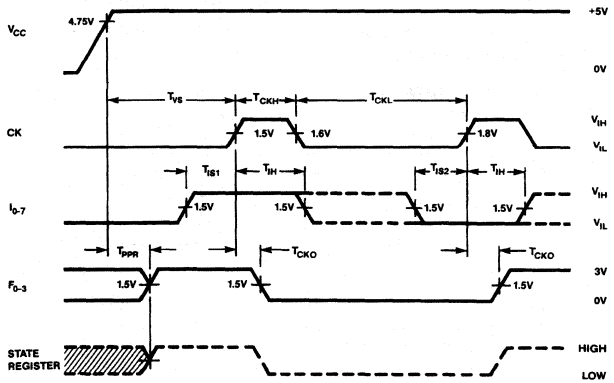


FPLS Under Test

TERM	C_n	AND: INPUT(Im) 11 10 9 8 7 6 5 4 3 2 1 0	AND: PRESENT STATE (Ps) (Px) 9 8 7 6 5 4 3 2 1 0	REMARKS	OPTION (P E) H; OR; NEXT STATE (Ns) (Px) 9 8 7 6 5 4 3 2 1 0	OUTPUT (Fr) 3 2 1 0
48	A	H H H H H H H H H H H H	H H H H H H H H H H		L L L L L L L L L L	L L L L
49	•	L L L L L L L L L L L L	L L L L L L L L L L		H H H H H H H H H H	H H H H

Test Array Program

Both terms 48 and 49 must be deleted during user programming to avoid interfering with the desired logic function. This is accomplished automatically by any Signetic's qualified programming equipment.



Test Circuit Timing Diagram

TERM	C_n	AND: INPUT(Im) 11 10 9 8 7 6 5 4 3 2 1 0	AND: PRESENT STATE (Ps) (Px) 9 8 7 6 5 4 3 2 1 0	REMARKS	OPTION (P E) H; OR; NEXT STATE (Ns) (Px) 9 8 7 6 5 4 3 2 1 0	OUTPUT (Fr) 3 2 1 0
48	-	H H H H H H H H H H H H	H H H H H H H H H H		- - - - - - - - - -	- - - -
49	•	L L L L L L L L L L L L	L L L L L L L L L L		- - - - - - - - - -	- - - -

Test Array Deleted

Signetics

PLS173
Field Programmable Logic Array (22 x 42 x 10)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 24**

DESCRIPTION

The PLS173 is a two-level logic element consisting of 42 AND gates and 10 OR gates with fusible link connections for programming I/O polarity and direction.

All AND gates are linked to 12 inputs (I) and 10 bidirectional I/O lines (B). These yield variable I/O gate configurations via 10 direction control gates (D), ranging from 22 inputs to 10 outputs.

On chip T/C buffers couple either True (I, B) or Complement ($\bar{I}$, $\bar{B}$) input polarities to all AND gates, whose outputs can be optionally linked to all OR gates. Their output polarity, in turn, is individually programmable through a set of EX-OR gates for implementing AND/OR or AND/NOR logic functions.

The PLS173 is field programmable, enabling the user to quickly generate custom patterns using standard programming equipment.

Order codes for this device are contained in the pages following.

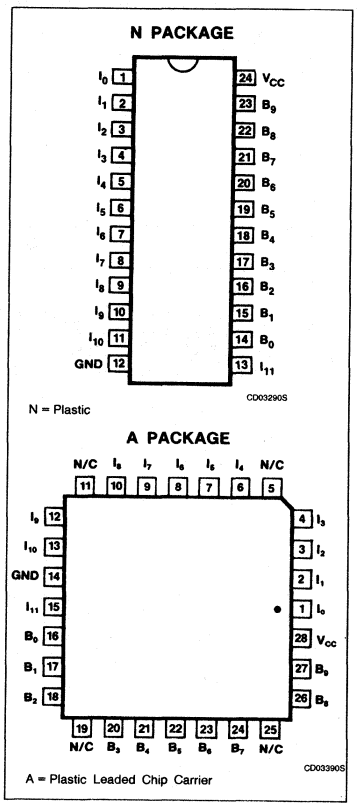
FEATURES

- **Field Programmable (Ni-Cr links)**
- **12 inputs**
- **42 AND gates**
- **10 OR gates**
- **10 bidirectional I/O lines**
- **Active high or low outputs**
- **42 Product Terms:**
  - **32 Logic Terms**
  - **10 Control Terms**
- **I/O propagation delay: 30 nSec (max)**
- **Input loading: −100μA max**
- **Power dissipation: 750mW typ**
- **Output: three-state**
- **TTL compatible**

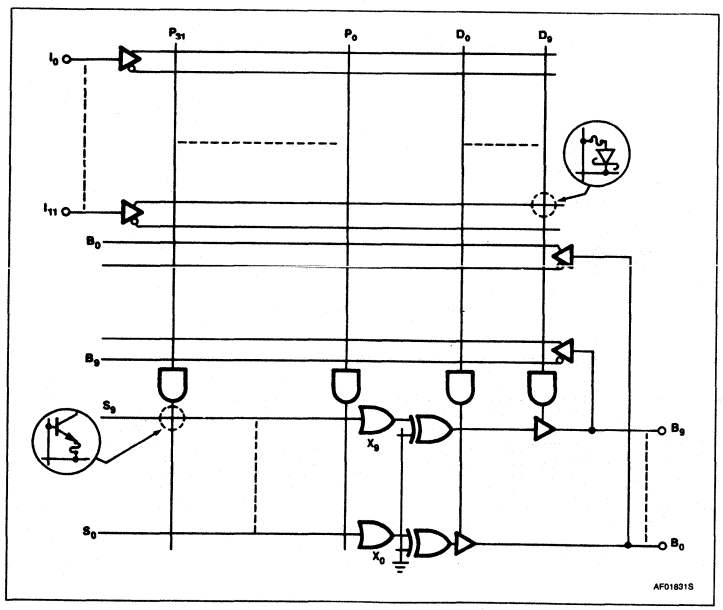
APPLICATIONS

- **Random logic**
- **Code converters**
- **Fault detectors**
- **Function generators**
- **Address mapping**
- **Multiplexing**

PIN CONFIGURATION



FUNCTIONAL DIAGRAM



LOGIC FUNCTION

TYPICAL PRODUCT TERM:
$Pn = A \cdot \bar{B} \cdot C \cdot D \cdot \ldots$

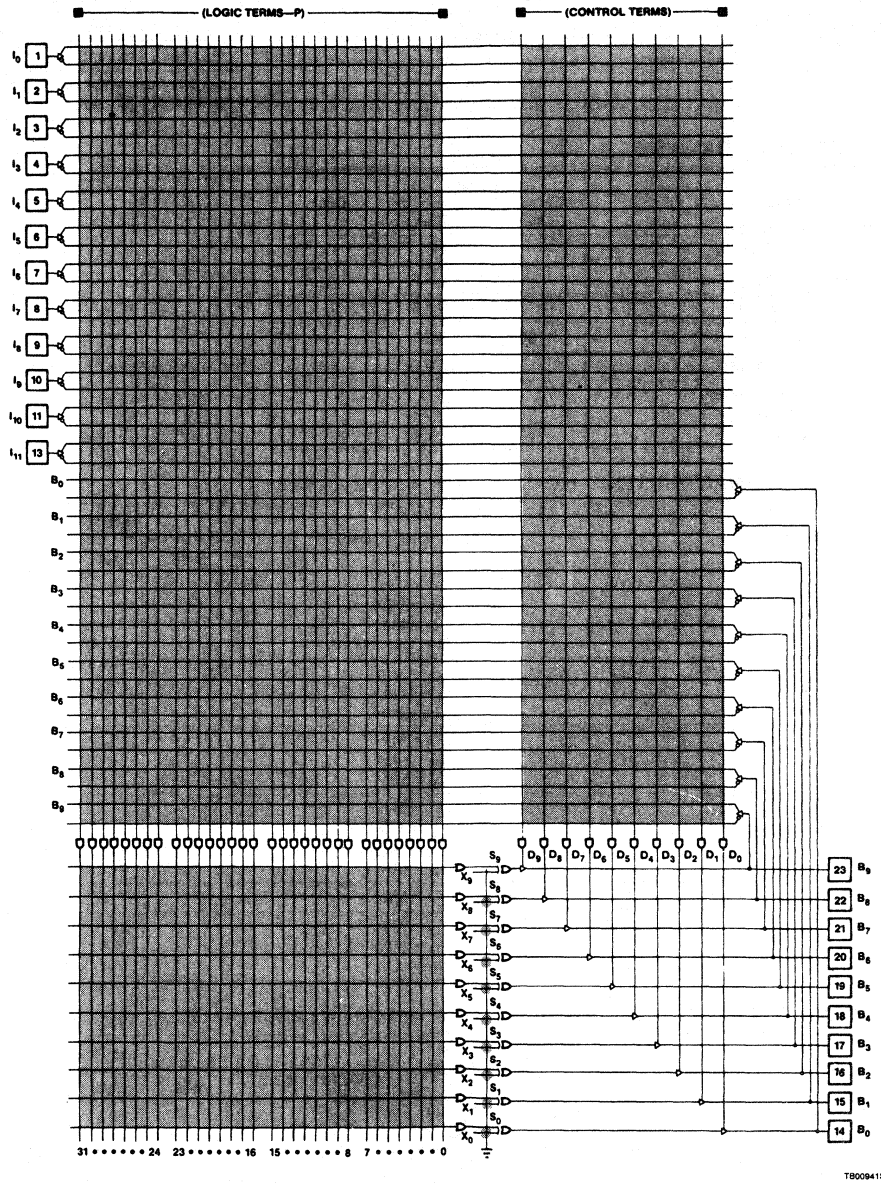
TYPICAL LOGIC FUNCTION:
AT OUTPUT POLARITY = H
$Z = P0 + P1 + P2 \ldots$

AT OUTPUT POLARITY = L
$Z = \overline{P0 + P1 + P2 + \ldots}$
$Z = \overline{P0} \cdot \overline{P1} \cdot \overline{P2} \cdot \ldots$

NOTES:
1. For each of the 10 outputs, either function Z (active-high) or Z (active-low) is available, but not both. The desired output polarity is programmed via the EX-OR gates.
2. Z, A, B, C, etc. are user defined connections to fixed inputs (I) and bidirectional pins (B).

Field Programmable Logic Array (22 x 42 x 10) PLS173

FPLA LOGIC DIAGRAM



NOTES:
1. All programmed "AND" gate locations are pulled to logic "1".
2. All programmed "OR" gate locations are pulled to logic "0".
3. ⊗ Programmable connection.

Field Programmable Logic Array (22 x 42 x 10) PLS173

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 300mil wide 24 pin	PLS173N
Plastic Leaded Chip Carrier 28 pin	PLS173A

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING Min	RATING Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input currents	−30	+30	mA
I_{OUT}	Output currents		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	−65	+150	

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq +75°C$, $4.75 \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage[3]						
V_{IL}	Low	V_{CC} = Min			.80	V
V_{IH}	High	V_{CC} = Max	2.0			
V_{IC}	Clamp[3, 4]	V_{CC} = Min, I_{in} = −12mA		−.8	−1.2	
Output voltage		V_{CC} = Min				
V_{OL}	Low[3, 5]	I_{OL} = 15mA			.5	V
V_{OH}	High[3, 6]	I_{OH} = −2mA	2.4			
Input current		V_{CC} = Max				
I_{IL}	Low	V_{IN} = 0.45V			−100	μA
I_{IH}	High	V_{IN} = 5.5V			40	
Output current		V_{CC} = Max				
$I_{O(OFF)}$	Hi-Z State[10]	V_{OUT} = 5.5V			80	μA
		V_{OUT} = .45V			−140	
I_{OS}	Short circuit[4, 6, 7]	V_{OUT} = 0V	−15		−70	mA
I_{CC}	V_{CC} supply current[8]	V_{CC} = Max		150	170	mA
Capacitance		V_{CC} = 5V				
I_{IN}	Input	V_{IN} = 2.0V		8		pF
C_B	I/O	V_B = 2.0V		15		

AC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq +75°C$, $4.75 \leq V_{CC} \leq 5.25V$, $R_1 = 470\Omega$, $R_2 = 1k\Omega$

PARAMETER		TO	FROM	TEST CONDITIONS	LIMITS Min	LIMITS Typ	LIMITS Max	UNIT
T_{PD}	Propagation delay	Output ±	Input ±	C_L = 30pF		20	30	ns
T_{OE}	Output enable	Output −	Input ±			20	30	
T_{OD}	Output disable[9]	Output +	Input ±	C_L = 5pF		20	30	ns

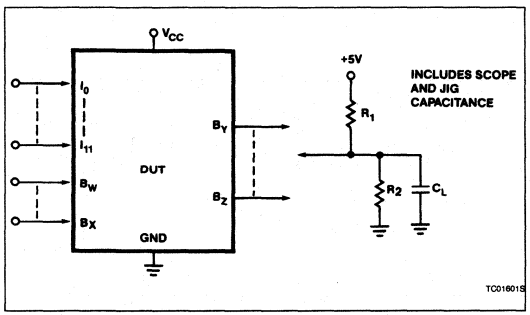
Notes on following page

Field Programmable Logic Array (22 x 42 x 10) PLS173

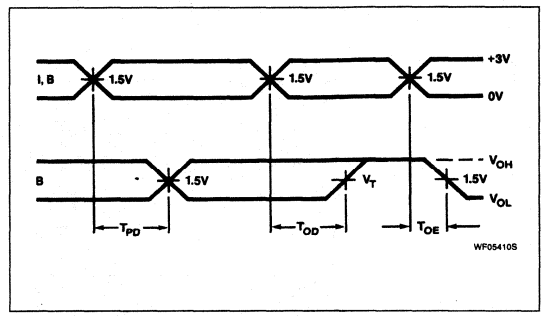
NOTES:

1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other condition above those indicated in the operational and programming specification of the device is not implied.
2. All typical values are at V_{CC} = 5V. T_A = 25°C.
3. All voltage values are with respect to network ground terminal.
4. Test one at a time.
5. Measured with V_{IL} applied to I_{11}. Pins 1 – 5 = 0V, Pins 6 – 10 = 4.5V, Pin 11 = 0V and Pin 13 = 10V.
6. Same conditions as Note 5 except Pin 11 = + 10V.
7. Duration of short circuit should not exceed 1 second.
8. I_{CC} is measured with I_0 and I_1 = 0V and $I_2 - I_{11}$ and $B_0 - B_9$ = 4.5V. Part in Virgin State.
9. Measured at $V_T = V_{OL} + 0.5V$.
10. Leakage values are a combination of input and output leakage.

TEST LOAD CIRCUIT



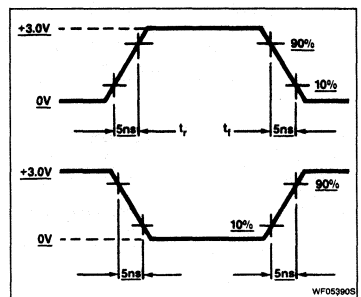
TIMING DIAGRAM



TIMING DEFINITIONS

T_{PD}	Propagation delay between input and output.
T_{OD}	Delay between input change and when output is off (Hi-Z or High).
T_{OE}	Delay between input change and when output reflects specified output level.

VOLTAGE WAVEFORM



MEASUREMENTS:
All circuit delays are measured at the + 1.5V level of inputs and outputs, unless otherwise specified.

Input Pulses

Field Programmable Logic Array (22 x 42 x 10) PLS173

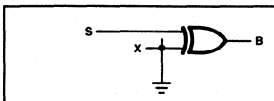
LOGIC PROGRAMMING

The FPLS can be programmed by means of Logic programming equipment.

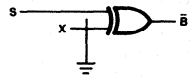
With Logic programming, the AND/OR/EX-OR gate input connections necessary to implement the desired logic function are coded directly from logic equations using the Program Table on the following page.

In this table, the logic state of variables I, P, and B associated with each Sum Term S is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

OUTPUT POLARITY - (B)

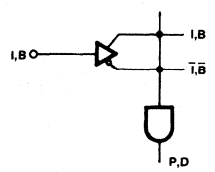


ACTIVE LEVEL	CODE
HIGH	H

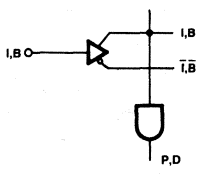


ACTIVE LEVEL	CODE
LOW	L

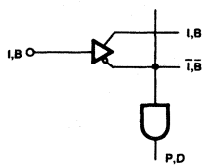
"AND" ARRAY - (I, B)



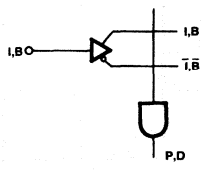
STATE	CODE
INACTIVE[1,2]	O



STATE	CODE
I, B	H

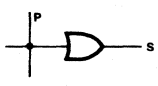


STATE	CODE
Ī, B̄	L

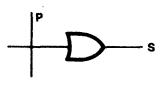


STATE	CODE
DON'T CARE	-

OR ARRAY - (B)



P_n STATUS	CODE
ACTIVE	A



P_n STATUS	CODE
INACTIVE	•

NOTES:

1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates P_n, D_n.
2. Any gate P_n, D_n will be unconditionally inhibited if any one of its (I, B) link pairs is left intact.

VIRGIN STATE

A factory shipped virgin device contains all fusible links intact, such that:

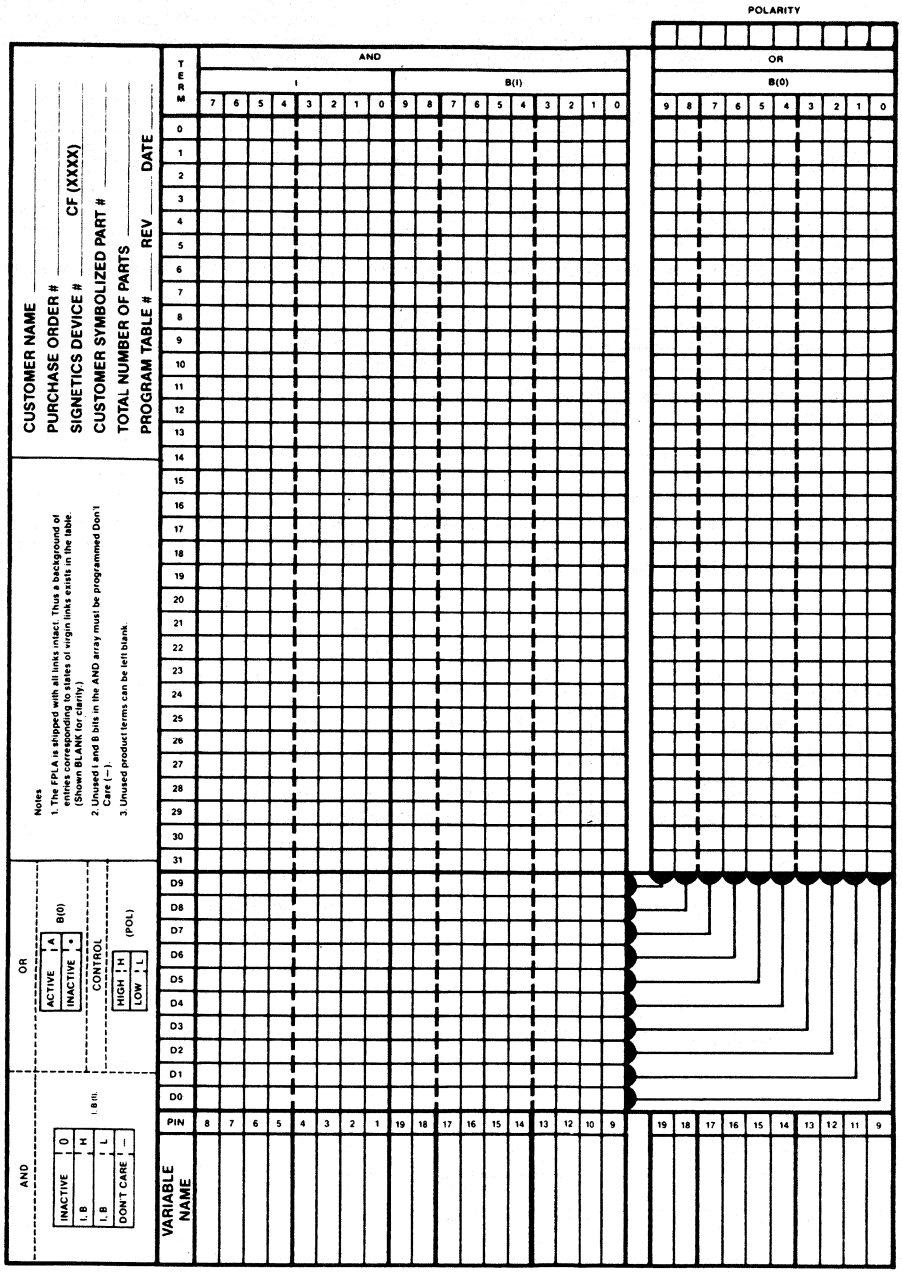
1. All outputs at "H" polarity.
2. All P_n terms are disabled.
3. All P_n terms are active on all outputs.

CAUTION: PLS173 TEST COLUMNS

The PLS173 incorporates two columns not shown in the logic block diagram. These columns are used for in-house testing of the device in the unprogrammed state. These columns must be disabled prior to using the PLS173 in your application. If you are using a Signetics approved programmer, the disabling is accomplished during the device programming sequence. If these columns are not disabled, abnormal operation is possible.

Field Programmable Logic Array (22 x 42 x 10) PLS173

FPLA PROGRAM TABLE

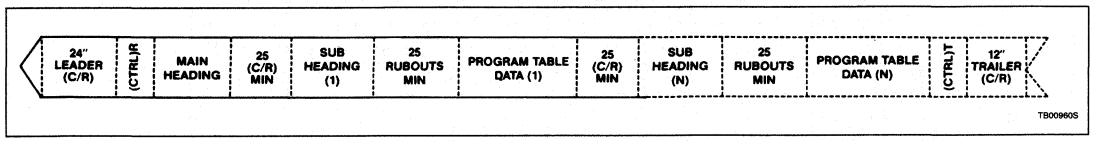


TB00951S

TWX TAPE CODING (LOGIC FORMAT)

The FPLA Program Table can be sent to Signetics in ASCII code format via airmail using any type of 8-level tape (paper, mylar, fanfold, etc.), or via TWX: just dial (910) 339-9283, tell the operator to turn the paper puncher on, and acknowledge. At the end of transmission instruct the operator to send tape to Signetics Order Entry.

A number of Program Tables can be sequentially assembled on a continuous tape as follows, however, limit tape length to a roll of 1.75 inch inside diameter and 4.25 inch outside diameter.



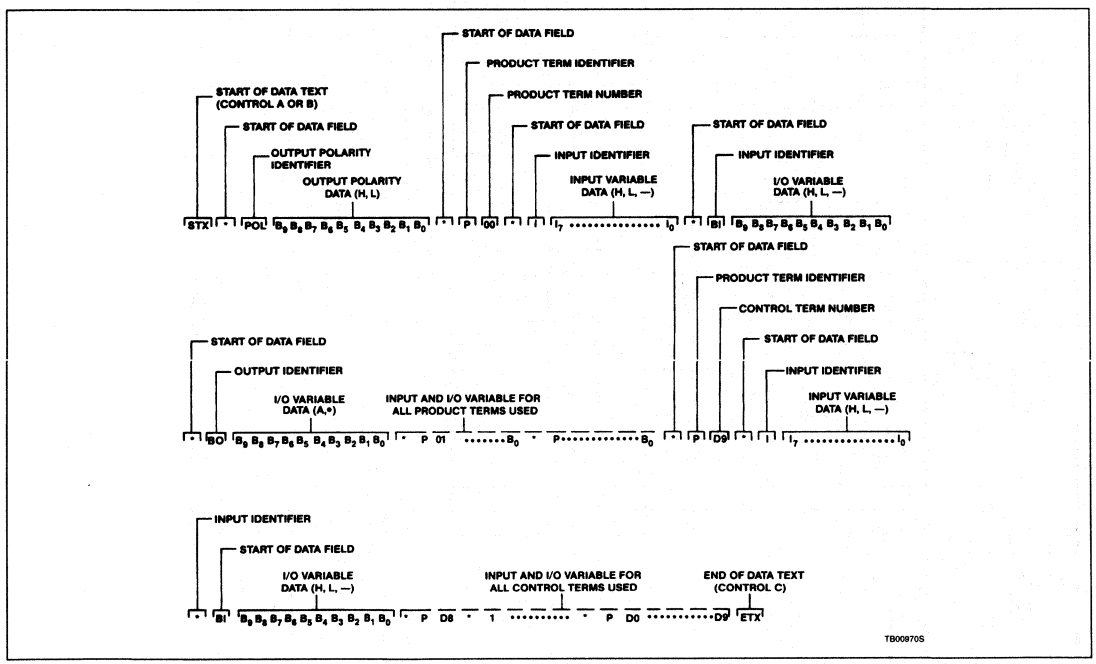
A. The MAIN HEADING at the beginning of tape includes the following information, with each entry preceded by a ($) character, whether used or not:

1. Customer Name
2. Customer TWX No.
3. Date
4. Purchase Order No.
5. Number of Program Tables
6. Total Number of Parts

B. Each SUB HEADING should contain specific information pertinent to each Program Table as follows, with each entry preceded by a ($) character, whether used or not:

1. Signetics Device No.
2. Program Table No.
3. Revision
4. Date
5. Customer Symbolized Part No.
6. Number of Parts

C. Program Table data blocks are initiated with an STX character, and terminated with an ETX character. The body of the data consists of output polarity, product term, and output information separated by appropriate identifiers in accordance with the following format. Entries for the data fields correspond to those defined in the Logic PROGRAM TABLE:



Signetics

PLS179
Field Programmable Logic Sequencer (20 x 45 x 12)

Signetics Programmable Logic
Preliminary Specification

Application Specific Products
- **Series 24**

DESCRIPTION

The PLS179 is a Three-State output, registered logic element combining AND/OR gate arrays with clocked J-K flip-flops. These J-K flip-flops are dynamically convertible to D-type via a "foldback" inverting buffer and control gate F_C. It features 8 registered I/O outputs (F) in conjunction with 4 bidirectional I/O lines (B). There are 8 dedicated inputs. These yield variable I/O gate and register configurations via control gates (D, L) ranging from 20 inputs to 12 outputs.

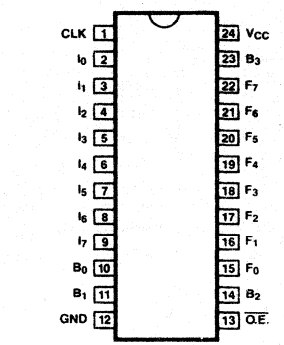
The AND/OR arrays consist of 32 logic AND gates, 13 control AND gates, and 21 OR gates with fusible link connections for programming I/O polarity and direction. All AND gates are linked to 8 inputs (I), bidirectional I/O lines (B), internal flip-flop outputs (Q), and Complement Array output ($\overline{C}$). The Complement Array consists of a NOR gate optionally linked to all AND gates for generating and propagating complementary AND terms.

FEATURES

- **Field programmable (Ni-Cr link)**
- **8 dedicated inputs**
- **13 control gates**
- **32 AND gates**
- **21 OR gates**
- **45 product terms:**
  - **32 logic terms**
  - **13 control terms**
- **4 bidirectional I/O lines**
- **8 bidirectional registers**
- **J/K, T, or D-type flip-flops**
- **Asynchronous Preset/Reset**
- **Complement Array**
- **Active high or low outputs**
- **Programmable $\overline{O.E.}$ control**
- **Positive edge trigger clock**
- **Power-on reset on flip-flop (Fn = "1")**
- **Clock frequency: PLS179: 18MHz (max)**
- **Input loading: PLS179: - 100μA (max)**
- **Power dissipation: 725mW (typ)**
- **TTL Compatible**

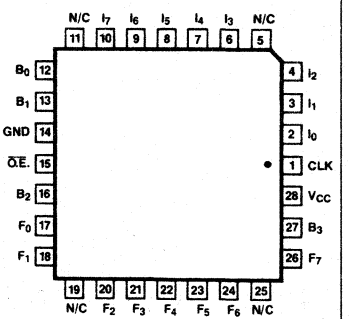
PIN CONFIGURATION

N PACKAGE



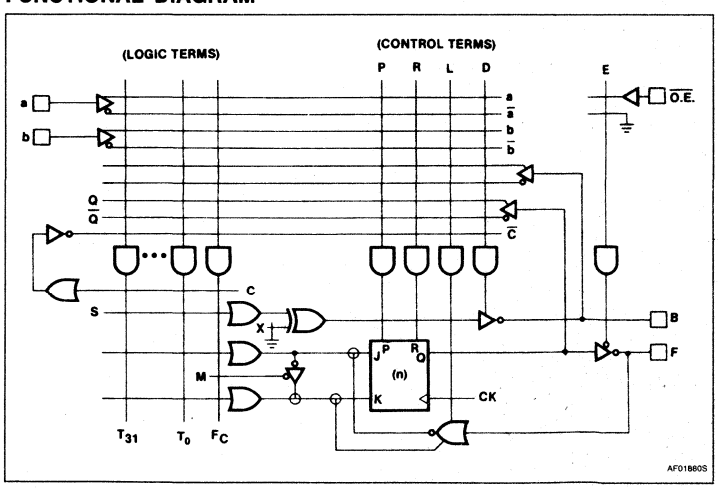
N = Plastic

A PACKAGE*



A = Plastic Leaded Chip Carrier

FUNCTIONAL DIAGRAM



APPLICATIONS

- **Random sequential logic**
- **Synchronous up/down counters**
- **Shift registers**
- **Bidirectional data buffers**
- **Timing function generators**
- **System controllers/synchronizers**
- **Priority encoder/registers**

5

Field Programmable Logic Sequencer (20 x 45 x 12) PLS179

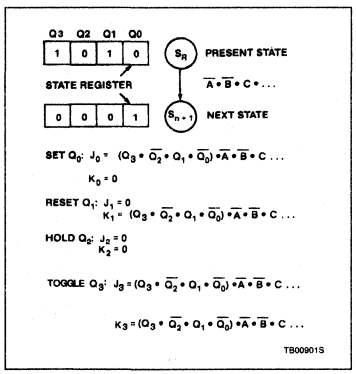
On-chip T/C buffers couple either True (I, B, Q) or Complement ($\overline{I}$, $\overline{B}$, $\overline{Q}$, $\overline{C}$) input polarities to all AND gates, whose outputs can be optionally linked to all OR gates. One group of AND gates drives bidirectional I/O lines (B), whose output polarity is individually programmable through a set of EX-OR gates for implementing AND-OR or AND-NOR logic functions. Another group drives the J-K inputs of all flip-flops, as well as asynchronous Preset and Reset lines (P, R).

All flip-flops are positive edge-triggered and can be used as input, output or I/O (for interfacing with a bidirectional data bus) in conjunction with load control gates (L), steering inputs (I), (B), (Q) and programmable output select lines (E).

The PLS179 is field programmable, enabling the user to quickly generate custom patterns using standard programming equipment.

Order codes are contained on the pages following.

LOGIC FUNCTION



NOTES:
Similar logic functions are applicable for D and T mode flip-flops.

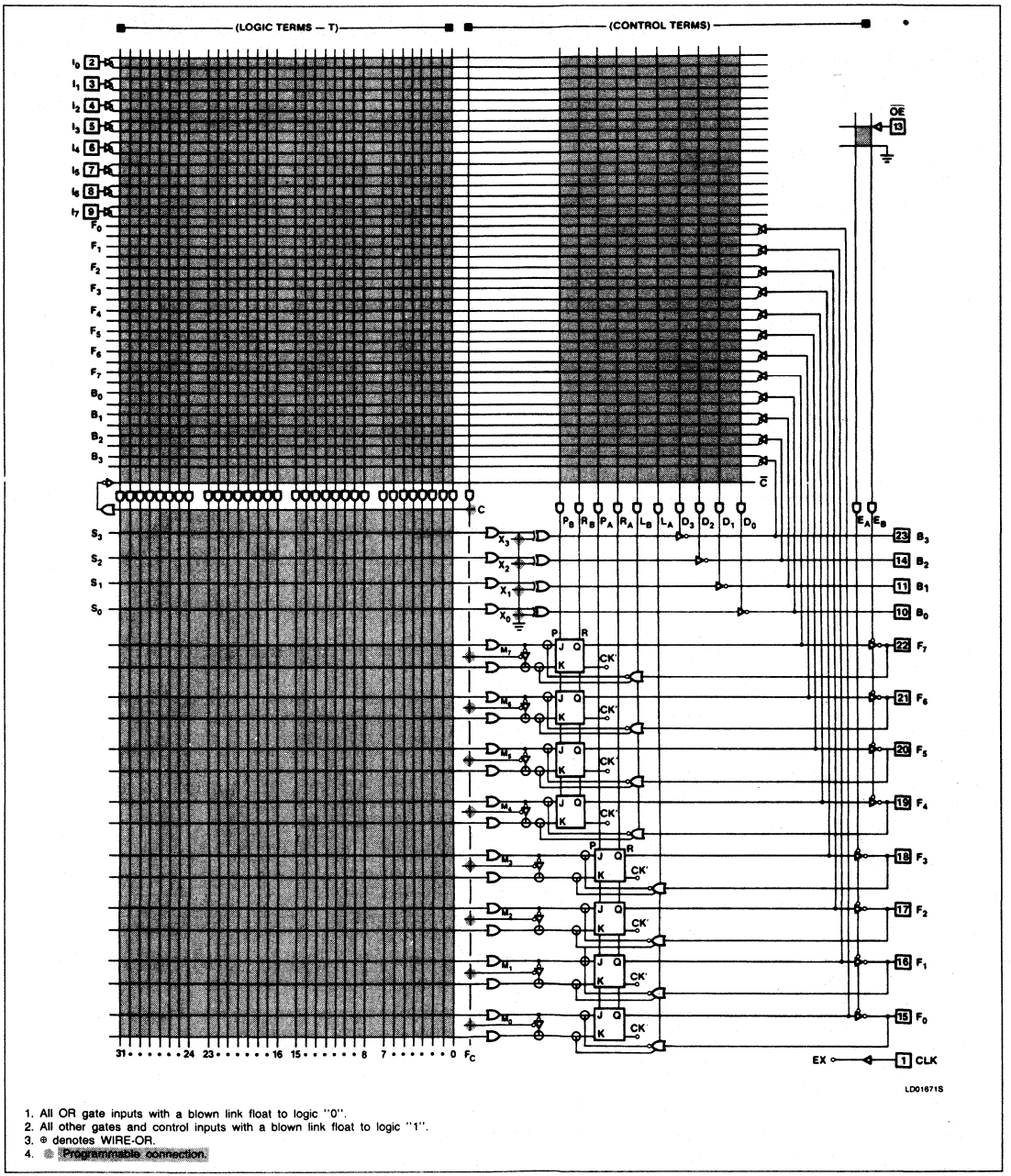
FLIP-FLOP TRUTH TABLE

O.E.	L	CK	P	R	J	K	Q	F
H								H/Hi-Z
L	X	X	L	X	X	X	L	H
L	X	X	H	L	X	X	H	L
L	X	X	L	H	X	X	L	H
L	L	↑	L	L	L	L	Q	$\overline{Q}$
L	L	↑	L	L	L	H	L	H
L	L	↑	L	L	H	L	H	L
L	L	↑	L	L	H	H	$\overline{Q}$	Q
H	H	↑	L	L	L	H	L	H*
H	H	↑	L	L	H	L	H	L*
+10V	X	↑	X	X	L	H	L	H**
	X	↑	X	X	H	L	H	L**

NOTES:
1. Positive Logic:
   $J/K = T_0 + T_1 + T_2 + \ldots + T_{32}$
   $T_n = \overline{C} \cdot (I_0 \cdot I_1 \cdot I_2 \ldots) \cdot (Q_0 \cdot Q_1 \ldots) \cdot (B_0 \cdot B_1 \ldots)$
2. ↑ denotes transition from Low to High level.
3. X = Don't care
4. * = Forced at F_n pin for loading J/K flip-flop in I/O mode. L must be enabled, and other active T_n disabled via steering input(s) I, B, or Q.
5. At P = R = H, Q = H. The final state of Q depends on which is released first.
6. ** = Forced at F_n pin to load J/K flip-flop independent of program code (Diagnostic mode).

Field Programmable Logic Sequencer (20 x 45 x 12) PLS179

FPLS LOGIC DIAGRAM



1. All OR gate inputs with a blown link float to logic "0".
2. All other gates and control inputs with a blown link float to logic "1".
3. ⊕ denotes WIRE-OR.
4. ● Programmable connection.

Field Programmable Logic Sequencer (20 x 45 x 12) PLS179

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 300mil wide 24 pin	PLS179N
Plastic leaded Chip Carrier 28 pin	PLS179A

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING Min	RATING Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input currents	−30	+30	mA
I_{OUT}	Output currents		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	−65	+150	

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq 75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	PLS179 Min	PLS179 Typ[2]	PLS179 Max	UNIT
Input voltage[3]						
V_{IH}	High	V_{CC} = Max	2			V
V_{IL}	Low	V_{CC} = Min			0.80	
V_{IC}	Clamp	V_{CC} = Min, I_{IN} = −12mA		−0.8	−1.2	
Output voltage[3]		V_{CC} = Min				
V_{OH}	High	I_{OH} = −2mA	2.4			V
V_{OL}	Low	I_{OL} = 10mA		0.35	0.5	
Input current		V_{CC} = MAX				
I_{IH}	High	V_{IN} = 5.5V		<1	40	μA
I_{IL}	Low	V_{IN} = 0.45V		−10	−100	
I_{IL}	Low (CK input)	V_{IN} = 0.45V		−50	−250	
Output current		V_{CC} = Max				
$I_{O(OFF)}$	Hi-Z State[5, 8]	V_{OUT} = 5.5V		1	80	μA
		V_{OUT} = 0.45V			−140	
I_{OS}	Short circuit[6, 4]	V_{OUT} = 0V	−15		−70	mA
I_{CC}	V_{CC} supply current[7]	V_{CC} = Max		145	195	mA
Capacitance		V_{CC} = 5.0V				
C_{IN}	Input	V_{IN} = 2.0V		8		pF
C_{OUT}	Output	V_{OUT} = 2.0V		15		

NOTES:

1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other condition above those indicated in the operational and programming specification of the device is not implied.
2. All typical values are at V_{CC} = 5V, T_A = +25°C.
3. All voltage values are with respect to network ground terminal.
4. Test one at a time.
5. Measured with V_{IH} applied to $\overline{O.E.}$.
6. Duration of short circuit should not exceed 1 second.
7. I_{CC} is measured with the $\overline{OE}$ input grounded, all other inputs at 4.5V, and the outputs open.
8. Leakage values are a combination of input and output leakage.

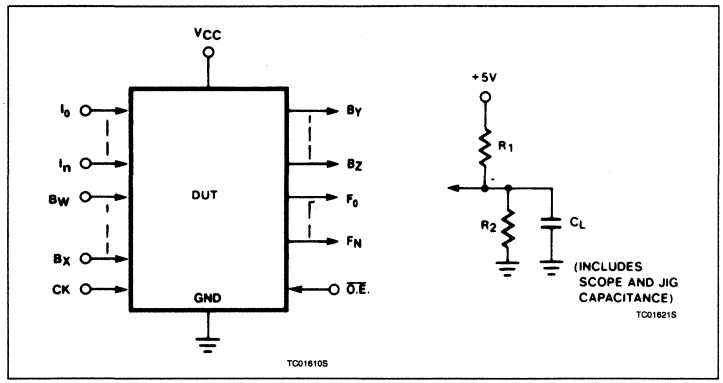
AC ELECTRICAL CHARACTERISTICS $R_1 = 470\Omega$, $R_2 = 1k\Omega$, NPLS179: $0°C \leq T_A \leq +75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TO	FROM	TEST CONDITIONS	PLS179			UNIT
					Min[5]	Typ[1]	Max	
Pulse width								
T_{CKH}	Clock[2] high	CK –	CK +		20	15		
T_{CKL}	Clock low	CK +	CK –		20	15		ns
T_{CKP}	Period	CK +	CK +		55	45		
T_{PRH}	Preset/Reset pulse	(1,B) +	(1,B) –		35	30		
Set-up time								
T_{IS1}	Input	CK +	(1,B) ±		35	30		
T_{IS2}	Input (through F_n)	CK +	F ±	C_L = 30pF	15	10		ns
T_{IS3}	Input (through Complement array)[4]	CK +	(1,B) ±		55	45		
Propagation delay								
T_{CKO}	Clock	F ±	CK ±	C_L = 30pF		15	20	
T_{OE1}	Output enable	F –	$\overline{O.E.}$ –			20	25	
T_{OD1}	Output disable[3]	F +	$\overline{O.E.}$ +	C_L = 5pF		20	25	
T_{PD}	Output	B ±	(I,B) ±			25	35	ns
T_{OE2}	Output enable	B ±	(I,B) +	C_L = 30pF		20	30	
T_{OD2}	Output disable[3]	B +	(I,B) –	C_L = 5pF		20	30	
T_{PRO}	Preset/Reset	F ±	(I,B) +			35	45	
T_{PPR}	Power-on preset	F –	V_{CC} +	C_L = 30pF		0	10	

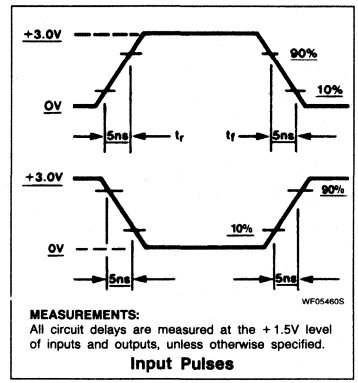
NOTES:
1. All typical values are at $V_{CC} = 5V$, $T_A = 25°C$.
2. To prevent spurious clocking, clock rise time (10%-90%) ⩽ 10ns.
3. Measured at $V_T = V_{OL} + 0.5V$.
4. When using the Complement Array $T_{CKP} = 75ns$ (min).
5. Limits are guaranteed with 12 product terms maximum connected to each sum term line.

Field Programmable Logic Sequencer (20 x 45 x 12) PLS179

TEST LOAD CIRCUIT



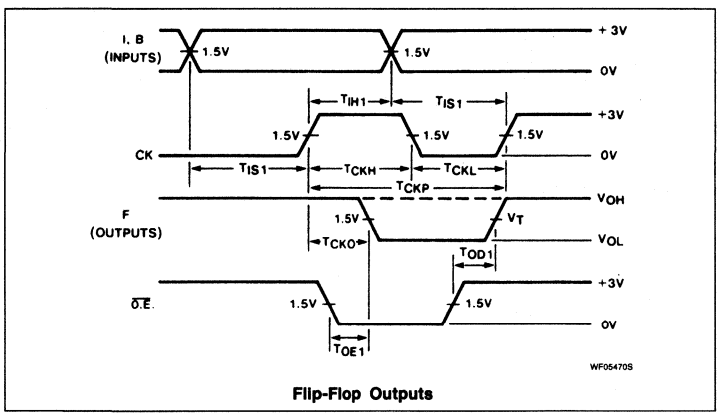
VOLTAGE WAVEFORM



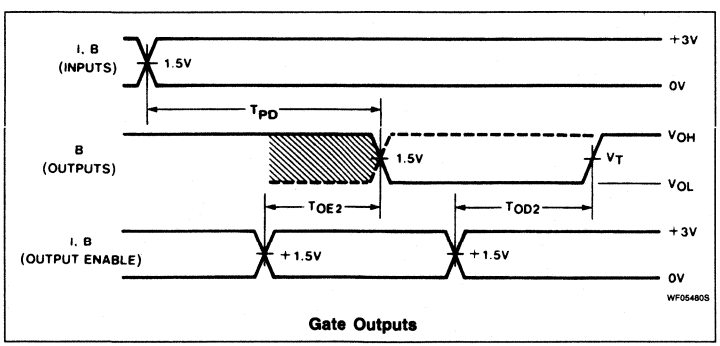
MEASUREMENTS:
All circuit delays are measured at the +1.5V level of inputs and outputs, unless otherwise specified.

Input Pulses

TIMING DIAGRAMS



Flip-Flop Outputs



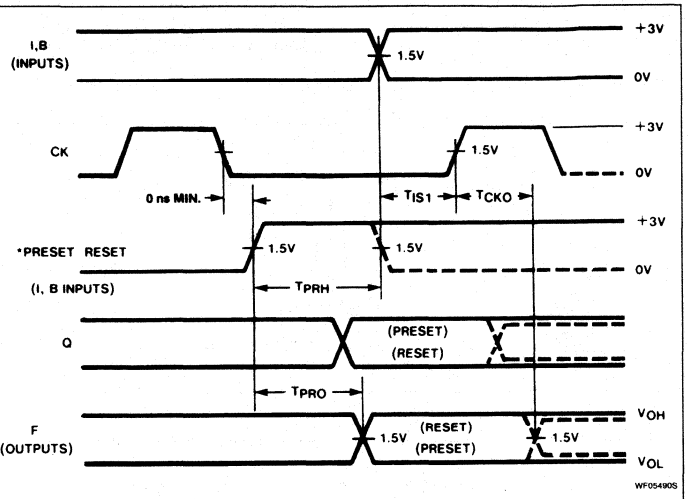
Gate Outputs

MEMORY TIMING DEFINITIONS

T_{CKH}	Width of input clock pulse.
T_{CKL}	Interval between clock pulses.
T_{CKP}	Clock period.
T_{PRH}	Width of preset input pulse.
T_{IS1}	Required delay between beginning of valid input and positive transition of clock.
T_{IS2}	Required delay between beginning of valid input forced at flip-flop output pins, and positive transition of clock.
T_{IH1}	Required delay between positive transition of clock and end of valid input data.
T_{IH2}	Required delay between positive transition of clock and end of valid input data forced at flip-flop output pins.
T_{CKO}	Delay between positive transition of clock and when Outputs become valid (with $\overline{O.E.}$ low).
T_{OE1}	Delay between beginning of Output Enable Low and when Outputs become valid.
T_{OD1}	Delay between beginning of Output Enable High and when Outputs are in the off state.

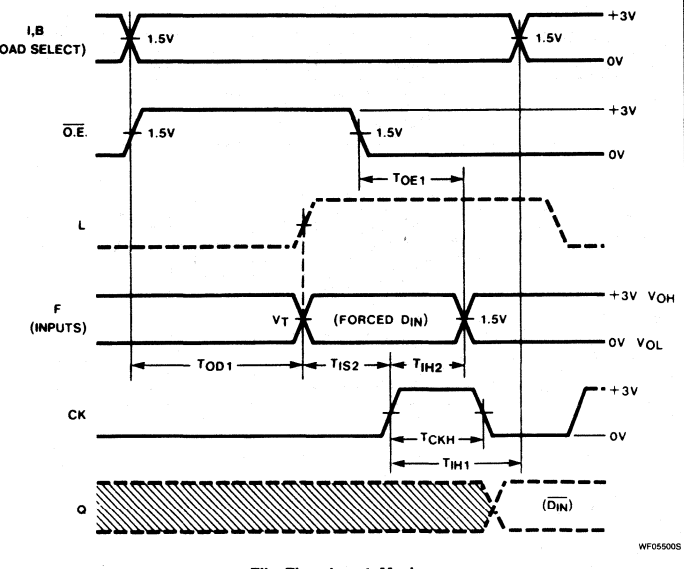
Field Programmable Logic Sequencer (20 x 45 x 12) PLS179

TIMING DIAGRAMS (Continued)



*Preset and Reset functions override Clock. However, F outputs may glitch with the first positive Clock Edge if T_{IS1} cannot be guaranteed by the user.

Asynchronous Preset/Rest



Flip-Flop Input Mode

MEMORY TIMING DEFINITIONS (Continued)

T_{PD} Propagation delay between combinational inputs and outputs.

T_{OE2} Delay between predefined Output Enable High, and when combinational Outputs become valid.

T_{OD2} Delay between predefined Output Enable Low and when combinational Outputs are in the off state.

T_{PRO} Delay between positive transition of predefined Preset/Reset input, and when flip-flop outputs become valid.

5

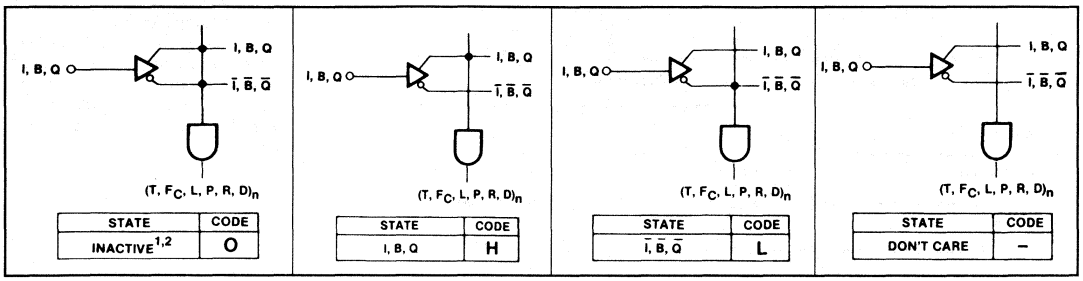
Field Programmable Logic Sequencer (20 x 45 x 12) PLS179

The FPLS can be programmed by means of Logic Programming equipment.

With Logic programming, the AND/OR-EX-OR input connections necessary to implement the desired logic function are coded directly from the State Diagram using the Program Tables on the following pages.

In these Tables, the logic state or action of all I/O, control, and state variables is assigned a symbol which results in the proper fusing pattern of corresponding links defined as follows:

"AND" ARRAY – (I), (B), (Qp)



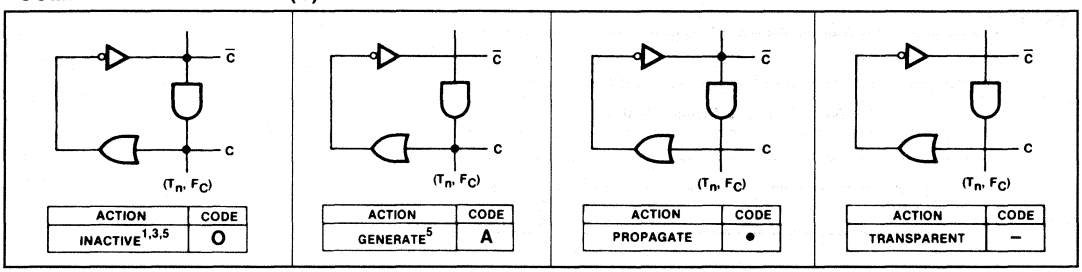
STATE	CODE
INACTIVE[1,2]	O

STATE	CODE
I, B, Q	H

STATE	CODE
$\bar{I}, \bar{B}, \bar{Q}$	L

STATE	CODE
DON'T CARE	–

"COMPLEMENT" ARRAY – (C)



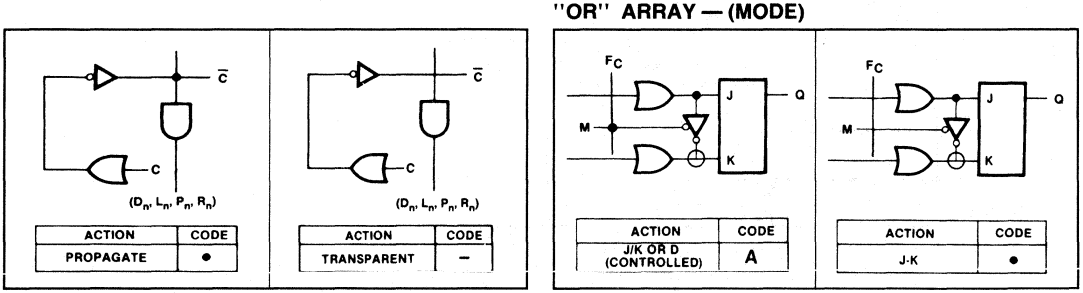
ACTION	CODE
INACTIVE[1,3,5]	O

ACTION	CODE
GENERATE[5]	A

ACTION	CODE
PROPAGATE	•

ACTION	CODE
TRANSPARENT	–

"OR" ARRAY — (MODE)



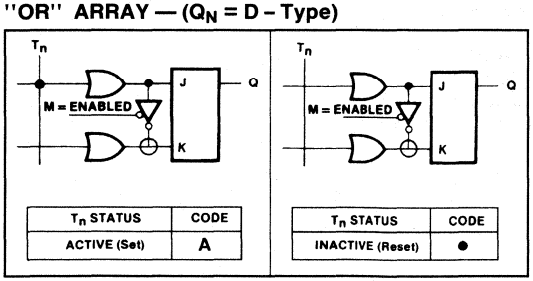
ACTION	CODE
PROPAGATE	•

ACTION	CODE
TRANSPARENT	–

ACTION	CODE
J/K OR D (CONTROLLED)	A

ACTION	CODE
J-K	•

"OR" ARRAY — (Q_N = D – Type)



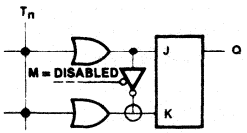
T_n STATUS	CODE
ACTIVE (Set)	A

T_n STATUS	CODE
INACTIVE (Reset)	•

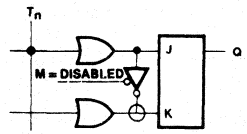
Notes on following page.

Field Programmable Logic Sequencer (20 x 45 x 12) PLS179

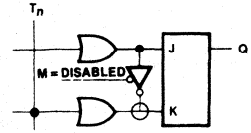
"AND" ARRAY — (Q_N = J - K Type)



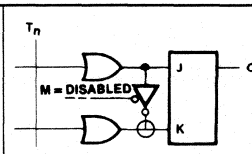
ACTION	CODE
TOGGLE	O



ACTION	CODE
SET	H

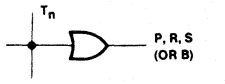


ACTION	CODE
RESET	L

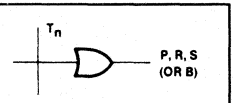


ACTION	CODE
HOLD	–

"OR" ARRAY — (S or B),(P),(R)

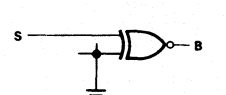


T_n STATUS	CODE
ACTIVE	A

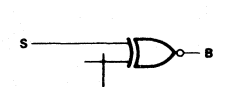


T_n STATUS	CODE
INACTIVE	•

"EX-OR" ARRAY — (B)

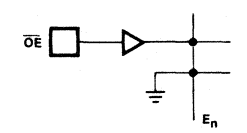


POLARITY	CODE
LOW	L

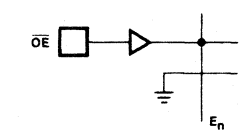


POLARITY	CODE
HIGH	H

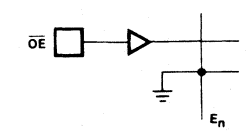
"O.E. " ARRAY — (E)



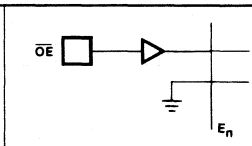
ACTION	CODE
IDLE[4]	O



ACTION	CODE
CONTROL	A



ACTION	CODE
ENABLE[4]	•



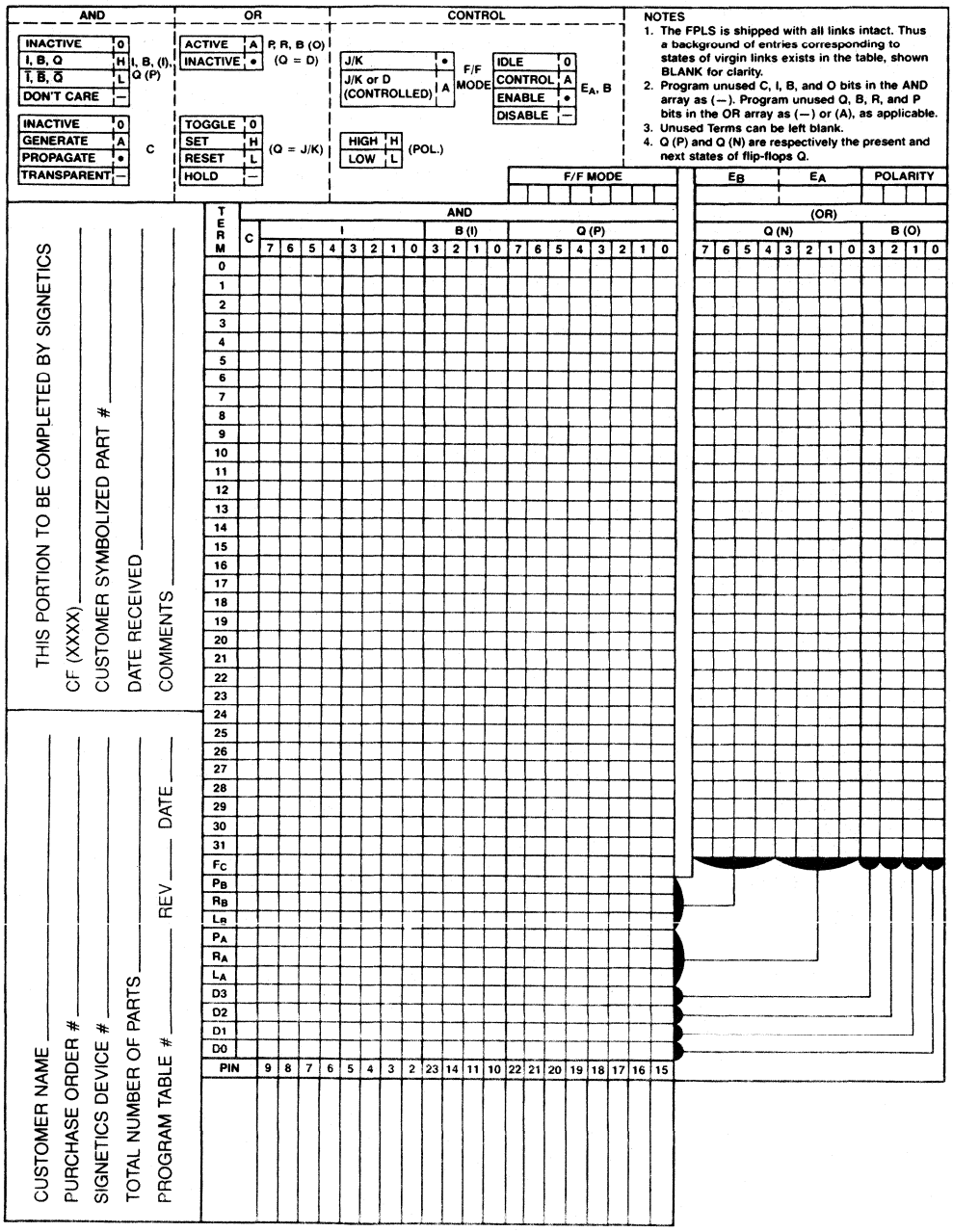
ACTION	CODE
DISABLE	–

NOTES:
1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates.
2. Any gate (T, F_C, L, P, R, $D)_n$ will be unconditionally inhibited if any one of the I, B, or Q link pairs is left intact.
3. To prevent oscillations, this state is not allowed for C link, pairs coupled to active gates T_n, F_C.
4. E_n = O and E_n = • are logically equivalent states, since both cause F_n outputs to be unconditionally enabled.
5. These states are not allowed for control gates (L, P, R, $D)_n$ due to their lack of "OR" array links.

5

Field Programmable Logic Sequencer (20 x 45 x 12) PLS179

FPLS PROGRAM TABLE



T901711S

Signetics

Application Specific Products

Section 6
PLD Data Sheets

INDEX

Signetics

PLS100/PLS101
Field Programmable Array (16 x 48 x 8)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 28**

DESCRIPTION

The PLS100 (Three-State) and PLS101 (Open Collector) are bipolar, fuse Programmable Logic Arrays (FPLAs). Each device utilizes the standard AND/OR/Invert architecture to directly implement custom sum of product logic equations.

Each device consists of 16 dedicated inputs and 8 dedicated outputs. Each output is capable of being actively controlled by any or all of the 48 product terms. The true, complement, or don't care condition of each of the 16 inputs ANDed together comprise one P-term. All 48 P-terms are selectively ORed to each output. The user must then only select which P-terms will activate an output by disconnecting terms which do not affect the output. In addition, each output can be fused as active HIGH (H) or active-LOW (L).

The PLS100 and PLS101 are fully TTL compatible, and include chip enable control for expansion of input variables and output inhibit. They feature either Open Collector or Three-State outputs for ease of expansion of product terms and application in bus-organized systems.

Order codes are contained on the pages following.

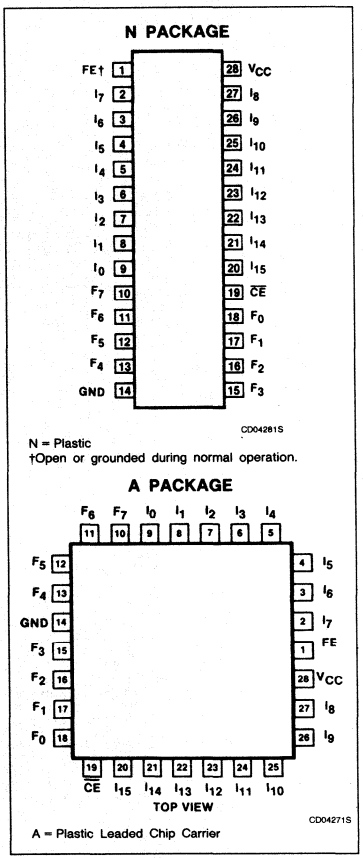
FEATURES

- **Field programmable (Ni-Cr link)**
- **Input variables: 16**
- **Output functions: 8**
- **Product terms: 48**
- **I/O propagation delay: 50ns max**
- **Power dissipation: 600mW typ**
- **Input loading: −100μA max**
- **Chip enable input**
- **Output option:**
  - **PLS100: Three-state**
  - **PLS101: Open Collector**
- **Output disable function:**
  - **Three-state: Hi-Z**
  - **Open Collector: Hi**
- **Separate I/O architecture**

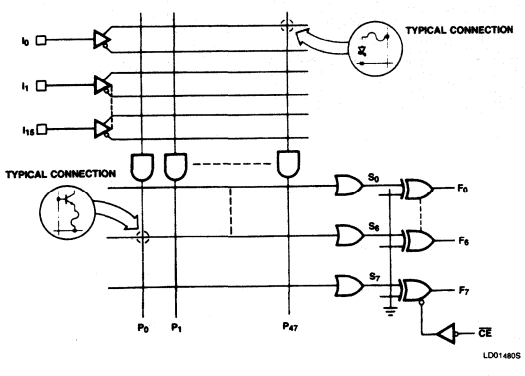
APPLICATIONS

- **CRT display systems**
- **Code conversion**
- **Peripheral controllers**
- **Function generators**
- **Look-up and decision tables**
- **Microprogramming**
- **Address mapping**
- **Character generators**
- **Data security encoders**
- **Fault detectors**
- **Frequency synthesizers**
- **16-bit to 8-bit bus interface**
- **Random logic replacement**

PIN CONFIGURATION



FUNCTIONAL DIAGRAM



Fusible Ni-Cr links are initially intact at all array cross-points.

LOGIC FUNCTION

TYPICAL PRODUCT TERM:
$Pn = A \cdot \overline{B} \cdot C \cdot D \cdot \ldots$

TYPICAL LOGIC FUNCTION:
AT OUTPUT POLARITY = H
$Z = P0 + P1 + P2 \ldots$

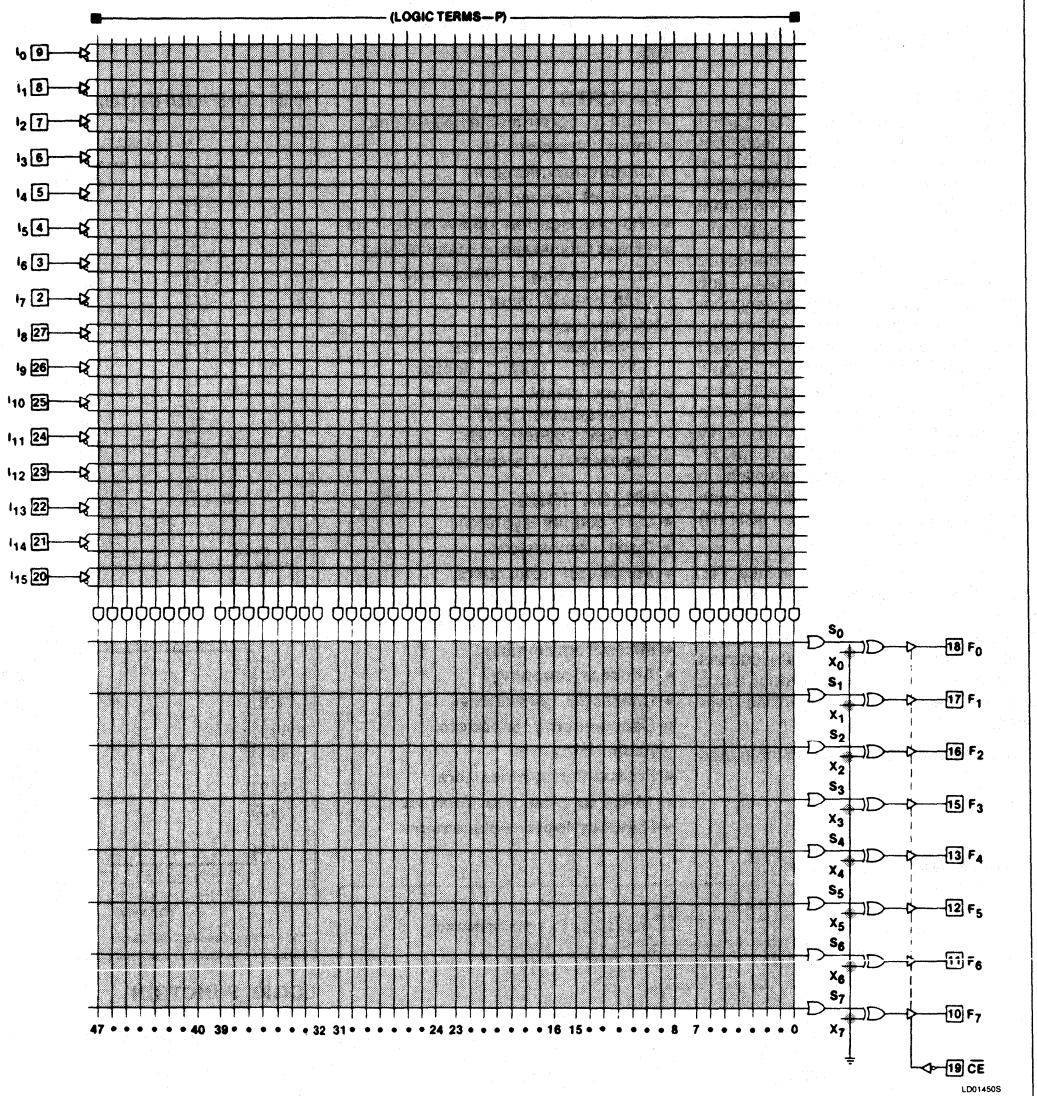
AT OUTPUT POLARITY = L
$\overline{Z} = \overline{P0 + P1 + P2 + \ldots}$
$Z = \overline{P0} \cdot \overline{P1} \cdot \overline{P2} \cdot \ldots$

NOTES:
1. For each of the 8 outputs, either function Z (active-high) or $\overline{Z}$ (active-low) is available, but not both. The desired output polarity is programmed via the EX-OR gates.
2. Z, A, B, C, etc. are user defined connections to fixed inputs (I) and output pins (O).

6

Field Programmable Array (16 x 48 x 8) PLS100/PLS101

FPLA LOGIC DIAGRAM



NOTES:
1. All AND gate inputs with a blown link float to a logic "1".
2. All OR gate inputs with a blown fuse float to logic "0".
3. • Programmable connection.

Field Programmable Array (16 x 48 x 8) PLS100/PLS101

ORDERING CODE

DESCRIPTION	THREE STATE	OPEN COLLECTOR
Plastic DIP 600mil 28 pin	PLS100N	PLS101N
Plastic Leaded Chip Carrier 28 pin	PLS100A	PLS101A

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING Min	RATING Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input currents	−30	+30	mA
I_{OUT}	Output currents		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	−65	+150	

The PLS100 device is also processed to military requirements for operation over the military temperature range. For specifications and ordering information consult the Signetics Military Data Book.

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq +75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage[3]						
V_{IH}	High	V_{CC} = Max	2			V
V_{IL}	Low	V_{CC} = Min			0.8	
V_{IC}	Clamp[3, 4]	V_{CC} = Min, I_{IN} = −12mA		−0.8	−1.2	
Output voltage[3]		V_{CC} = Min				
V_{OH}	High (PLS100)[5]	I_{OH} = −2mA	2.4			V
V_{OL}	Low[6]	I_{OL} = 9.6mA		0.35	0.45	
Input current						
I_{IH}	High	V_{IN} = 5.5V		< 1	25	μA
I_{IL}	Low	V_{IN} = 0.45V		−10	−100	
Output current		$\overline{CE}$ = HIGH, V_{CC} = Max				
$I_{O(OFF)}$	Hi-Z State (PLS100)	V_{OUT} = 5.5V		1	40	μA
		V_{OUT} = 0.45V		−1	−40	
I_{OS}	Short circuit (PLS100)[4, 7]	$\overline{CE}$ = LOW, V_{OUT} = 0V	−15		−70	mA
I_{CC}	V_{CC} supply current[8]	V_{CC} = Max		120	170	mA
Capacitance		$\overline{CE}$ = HIGH, V_{CC} = 5.0V				
C_{IN}	Input	V_{IN} = 2.0V		8		pF
C_{OUT}	Output	V_{OUT} = 2.0V		17		

Notes on following page.

AC ELECTRICAL CHARACTERISTICS $R_1 = 470\Omega$, $R_2 = 1k\Omega$, $C_L = 30pF$, $0°C \leq T_A \leq +75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER	TO	FROM	LIMITS			UNIT
			Min	Typ[2]	Max	
Propagation delay						
T_{PD} Input	Output	Input		35	50	ns
T_{CE} Chip enable	Output	Chip enable		15	30	
Disable time						
T_{CD} Chip disable	Output	Chip enable		15	30	ns

NOTES:

1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other conditions above those indicated in the operational and programming specification of the device is not implied.
2. All values are at $V_{CC} = 5V$, $T_A = 25°C$.
3. All voltage values are with respect to network ground terminal.
4. Test one pin at a time.
5. Measured with V_{IL} applied to $\overline{CE}$ and a logic high stored.
6. Measured with a programmed logic condition for which the output test is at a low logic level. Output sink current is applied thru a resistor to V_{CC}.
7. Duration of short circuit should not exceed 1 second.
8. I_{CC} is measured with the chip enable input grounded, all other inputs at 4.5V and the outputs open.

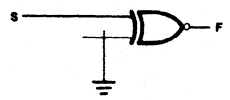
LOGIC PROGRAMMING

The FPLA can be programmed by means of Logic programming equipment.

With Logic programming, the AND/OR/EX-OR gate input connections necessary to implement the desired logic function are coded directly from logic equations using the Program Table.

In this Table the logic state or action of variables I, P, and F, associated with each Sum Term S_n, is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

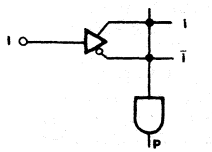
OUTPUT POLARITY – (F)



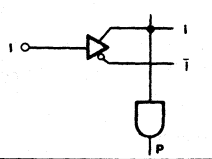
ACTIVE LEVEL	CODE
HIGH	H

ACTIVE LEVEL	CODE
LOW	L

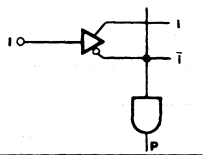
"AND" ARRAY – (I)



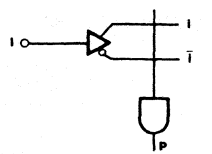
STATE	CODE
INACTIVE[1,2]	O



STATE	CODE
I	H

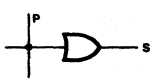


STATE	CODE
I	L

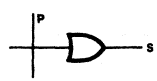


STATE	CODE
DON'T CARE	—

"OR" ARRAY – (F)



P_n STATUS	CODE
ACTIVE	A



P_n STATUS	CODE
INACTIVE	•

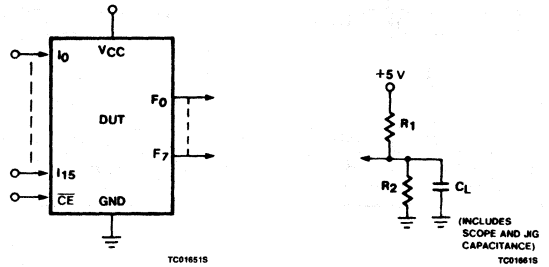
NOTES:

1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates P_n.
2. Any gate P_n will be unconditionally inhibited if any one of its (I) link pairs is left intact.

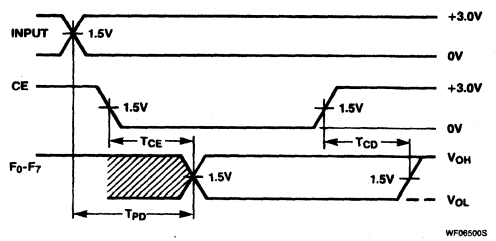
6

Field Programmable Array (16 x 48 x 8) PLS100/PLS101

TEST LOAD CIRCUIT

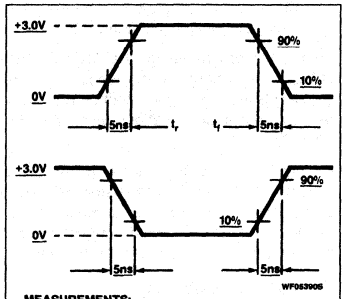


TIMING DIAGRAM



Read Cycle

VOLTAGE WAVEFORM



MEASUREMENTS:
All circuit delays are measured at the +1.5V level of inputs and outputs, unless otherwise specified.

Input Pulses

TIMING DEFINITIONS

T_{CE}	Delay between beginning of Chip Enable low (with Input valid) and when Data Output becomes valid.
T_{CD}	Delay between when Chip Enable becomes high and Data Output is in off state (Hi-Z or high).
T_{PD}	Delay between beginning of valid Input (with Chip Enable low) and when Data Output becomes valid.

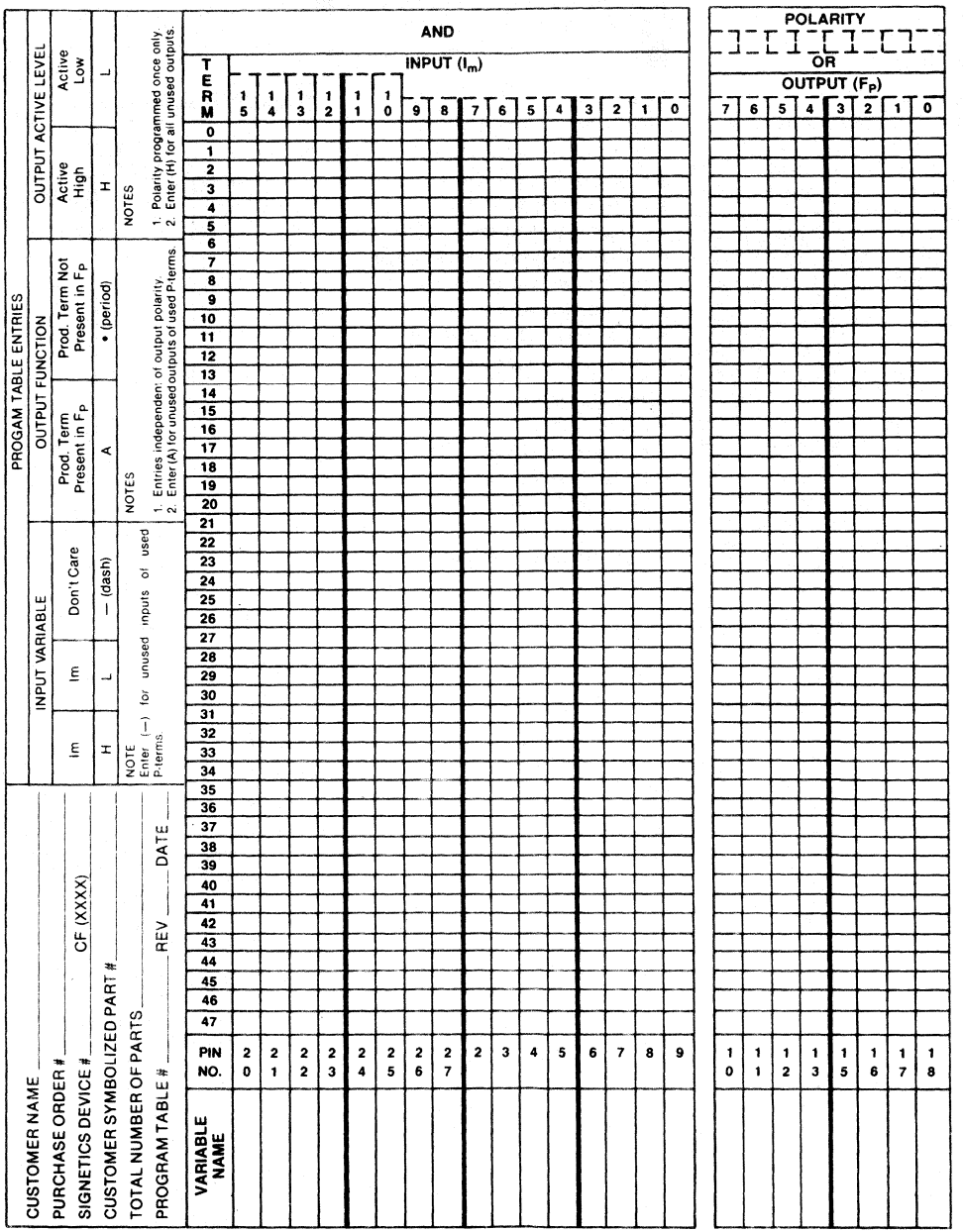
VIRGIN STATE

The PLS100/101 virgin devices are factory shipped in an unprogrammed state, characterized by:

1. All internal Ni-Cr links are intact.
2. Each product term (P-term) contains both true and complement values of every input variable I_m (P-terms always logically "false").
3. The "OR" Matrix contains all 48 P-terms.
4. The polarity of each output is set to active high (Fp function).
5. All outputs are at a low logic level.

Field Programmable Array (16 x 48 x 8) PLS100/PLS101

FPLA PROGRAM TABLE



TB01560S

Signetics

PLS103
Field Programmable Gate Array (16 x 9 x 9)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 28**

DESCRIPTION

The PLS103 is a bipolar, fuse Programmable Gate Array. The device consists of nine AND/NAND gates which share 16 common inputs. The type of gate is selected by programming the output as active-HIGH (H) or active-LOW (L). Each of the 16 inputs $I_0 - I_{15}$ can be programmed to provide the True (H), Complement (L), or Don't Care (—) state to each of the nine AND/NAND gates. OR/NOR logic functions can also be implemented by complementing the inputs and outputs via on-chip inverting buffers.

The device is field programmable, which means that custom patterns are immediately available.

The PLS103 includes chip-enable control for output strobing and inhibit. It features Three-State outputs for ease of expansion of input variables and application in bus-organized systems.

Order codes are contained on the pages following.

FEATURES

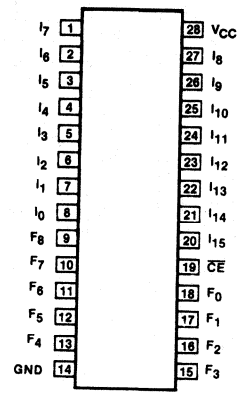
- **Field programmable (Ni-Cr link)**
- **16 input variables**
- **9 output functions**
- **Chip enable input**
- **I/O propagation delay: 35ns max**
- **Power dissipation: 600mW typ**
- **Input loading: −100μA max**
- **Output: Three-state**
- **Output disable function: Hi-Z**
- **Fully TTL compatible**

APPLICATIONS

- **Random logic**
- **Address decoders**
- **Code detectors**
- **Peripheral selectors**
- **Fault monitors**
- **Machine state decoders**

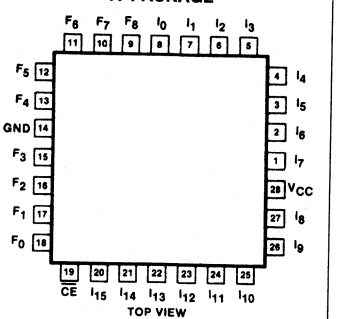
PIN CONFIGURATION

N PACKAGE



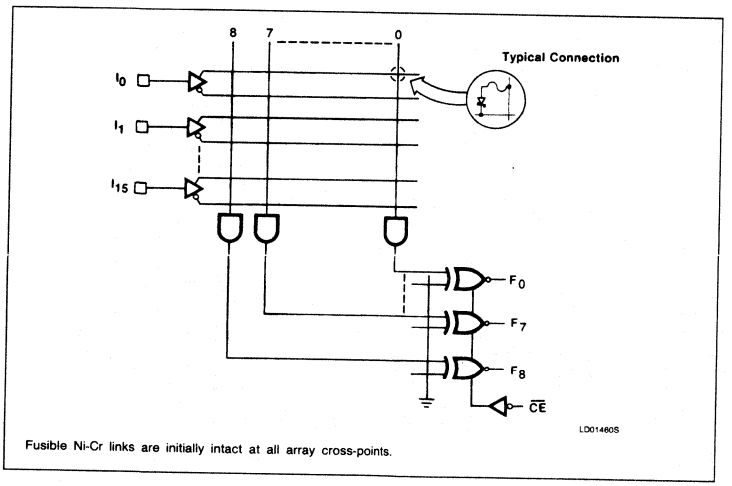
N = Plastic

A PACKAGE



A = Plastic Leaded Chip Carrier

FUNCTIONAL DIAGRAM



Fusible Ni-Cr links are initially intact at all array cross-points.

LOGIC FUNCTION

TYPICAL OUTPUT FUNCTIONS:

ACTIVE-HIGH

$$X = A \cdot \overline{B} \cdot C \cdot \ldots$$

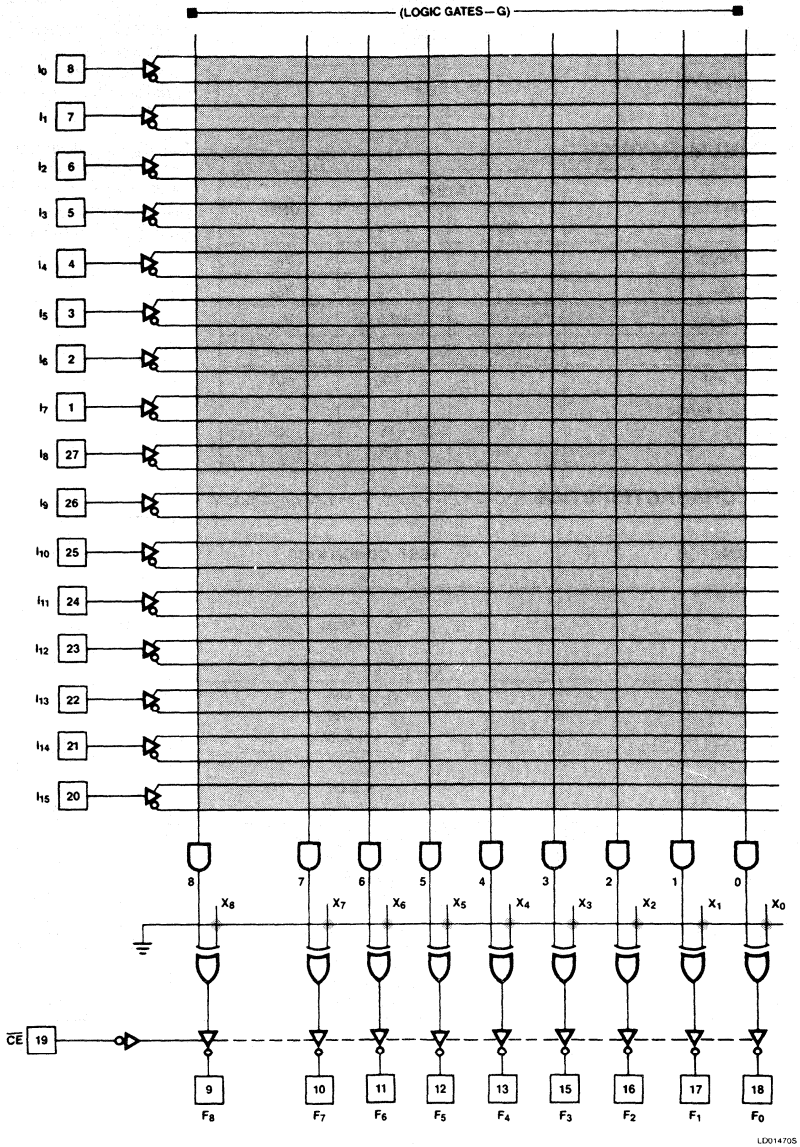
ACTIVE-LOW

$$\overline{X} = A \cdot \overline{B} \cdot C \cdot \ldots$$
$$X = \overline{A} + B + \overline{C} + \ldots$$

NOTES:
1. For each of the 9 outputs, either function X (active-high) or $\overline{X}$ (active-low) is available, but not both. The desired output polarity is programmed via the EX-OR gates.
2. X, A, B, C, etc. are user defined connections to fixed inputs (I) and output pins (O).

Field Programmable Gate Array (16 x 9 x 9) PLS103

FPGA LOGIC DIAGRAM



NOTES:
1. All gate inputs when a blown link float to a logic "1".
2. ◌ Programmable connection.

Field Programmable Gate Array (16 x 9 x 9) PLS103

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 600mil 28 pin	PLS103N
Plastic Leaded Chip Carrier 28 pin	PLS103A

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS

PARAMETER		RATING Min	RATING Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input current	−30	+30	mA
I_{OUT}	Output current		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	−65	+150	

The PLS103 device is also processed to military requirements for operation over the military temperature range. For specifications and ordering information consult the Signetics Military Data Book.

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq +75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage[1]						
V_{IH}	High	V_{CC} = Max	2.0			V
V_{IL}	Low	V_{CC} = Min			0.8	
V_{IC}	Clamp[3]	V_{CC} = Min, I_{IN} = −12mA		−0.8	−1.2	
Output voltage[1]		V_{CC} = Min				
V_{OH}	High[5]	I_{OH} = −2mA	2.4			V
V_{OL}	Low[4]	I_{OL} = 9.6mA		0.35	0.45	
Input current						
I_{IH}	High	V_{IN} = 5.5V		< 1	25	μA
I_{IL}	Low	V_{IN} = 0.45V		−10	−100	
Output current		$\overline{CE}$ = HIGH, V_{CC} = Max				
$I_{O(OFF)}$	Hi-Z State	V_{OUT} = 5.5V		1	40	μA
		V_{OUT} = 0.45V		−1	−40	
I_{OS}	Short circuit[3, 6]	$\overline{CE}$ = LOW, V_{OUT} = 0V	−15		−70	mA
I_{CC}	V_{CC} supply current[7]	V_{CC} = Max		120	170	mA
Capacitance		V_{CC} = 5.0V				
C_{IN}	Input	V_{IN} = 2.0V		8		pF
C_{OUT}	Output	V_{OUT} = 2.0V		15		

Notes on following page.

Field Programmable Gate Array (16 x 9 x 9) PLS103

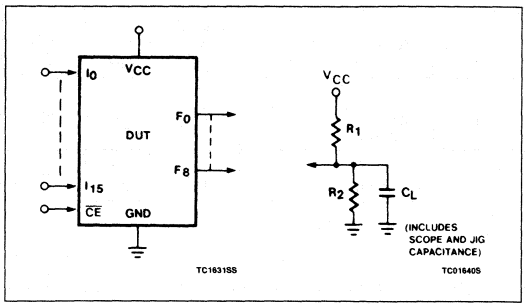
AC ELECTRICAL CHARACTERISTICS $R_1 = 470\Omega$, $R_2 = 1k\Omega$, $C_L = 30pF$, $0°C \leq T_A \leq +75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER	TO	FROM	LIMITS			UNIT
			Min	Typ[2]	Max	
Propagation delay						
T_{PD} Input	Output	Input		20	35	ns
T_{CE} Chip enable	Output	Chip enable		15	30	
Disable time						
T_{CD} Chip disable	Output	Chip enable		15	30	ns

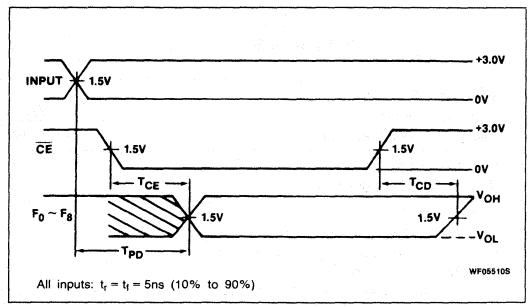
NOTES:
1. All voltage values are with respect to network ground terminal.
2. All typical values are at $V_{CC} = 5V$, $T_A = 25°C$.
3. Test one pin at a time.
4. Measure with a programmed logic condition for which the output under test is at a low logic level. Output sink current is supplied through a resistor to V_{CC}.
5. Measured with V_{IL} applied to $\overline{CE}$ and a logic high at the output.
6. Duration of short circuit should not exceed 1 second.
7. I_{CC} is measured with the chip enable input grounded, all other inputs at 4.5V, and the outputs open.
8. Stresses above those listed under "Absolute Maximum Ratings " may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other conditions above those listed in the operational and programming specification of the device is not implied.

Field Programmable Gate Array (16 x 9 x 9) PLS103

TEST LOAD CIRCUIT



VOLTAGE WAVEFORM



LOGIC PROGRAMMING

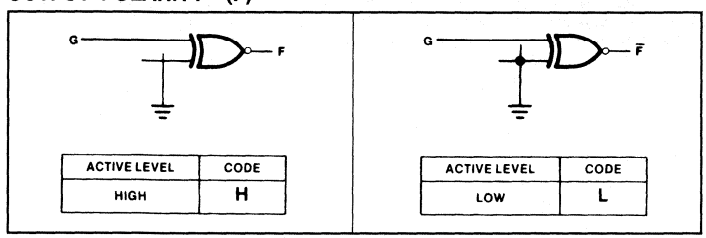
In a virgin device all Ni-Cr links are intact.

The FPGA can be programmed by means of Logic programming equipment.

With Logic programming, the AND/EX-OR gate input connections necessary to implement the desired logic function are coded directly from logic equations using the Program Table.

In this table, the logic state of variables I and F associated with each P-term P_n is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

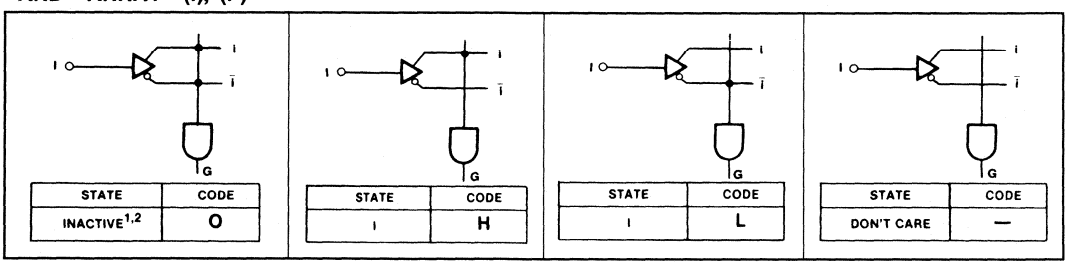
OUTPUT POLARITY – (F)



ACTIVE LEVEL	CODE
HIGH	H

ACTIVE LEVEL	CODE
LOW	L

"AND" ARRAY – (I), (P)



STATE	CODE
INACTIVE[1,2]	O

STATE	CODE
i	H

STATE	CODE
I	L

STATE	CODE
DON'T CARE	—

NOTES:

1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates G_n.
2. Any gate G_n will be unconditionally inhibited if any one of its (I) link pairs is left intact.

VIRGIN STATE

The PLS103 virgin device is factory shipped in an unprogrammed state, characterized by:

1. All internal Ni-Cr links are intact.
2. Each AND gate contains both true and complement values of every input variable I_m (logic Null state).
3. The polarity of each output is set to active low ($\overline{F}_p$ function).
4. All outputs are at a high logic level.

Field Programmable Gate Array (16 x 9 x 9) PLS103

FPGA PROGRAM TABLE

CUSTOMER NAME _____	*THIS PORTION TO BE COMPLETED BY SIGNETICS*
PURCHASE ORDER # _____	*CF (XXXX)* _____
SIGNETICS DEVICE # _____	*CUSTOMER SYMBOLIZED PART #* _____
TOTAL NUMBER OF PARTS _____	*DATE RECEIVED* _____
PROGRAM TABLE # _____	*COMMENTS* _____

F_0 (18) _____ =
F_1 (17) _____ =
F_2 (16) _____ =
F_3 (15) _____ =
F_4 (13) _____ =
F_5 (12) _____ =
F_6 (11) _____ =
F_7 (10) _____ =
F_8 (9) _____ =

GATE / POLARITY		INPUT I_{15}	I_{14}	I_{13}	I_{12}	I_{11}	I_{10}	I_9	I_8	I_7	I_6	I_5	I_4	I_3	I_2	I_1	I_0
F_0																	
F_1																	
F_2																	
F_3																	
F_4																	
F_5																	
F_6																	
F_7																	
F_8																	
PIN NO.		20	21	22	23	24	25	26	27	1	2	3	4	5	6	7	8
VARIABLE NAME																	

NOTES:
1. **The FPGA is shipped with all links intact. Thus a background of entries corresponding to states of virgin links exists in the table, shown BLANK for clarity.**
2. **Unused inputs are normally programmed Don't Care (—).**
3. **Unused Gates can be left blank.**

PROGRAM TABLE ENTRIES

AND	
INACTIVE	0
I	H
T	L
Don't Care	—
(I)	

CONTROL	
HIGH	H
LOW	L
(POL.)	

LD02260S

Signetics

PLS105
Field Programmable Logic Sequencer (16 x 48 x 8)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 28**

DESCRIPTION

The PLS105 is a bipolar programmable state machine of the Mealy type. It contains logic AND-OR gate arrays with user programmable connections which control the inputs of on-chip State and Output Registers. These consist respectively of 6 Q_P, and 8 Q_F edge-triggered, clocked S/R flip-flops, with an asynchronous Preset option. All flip-flops are unconditionally preset to "1" during power turn on.

The AND array combines 16 external inputs I_{0-15} with six internal inputs P_{0-5} fed back from the State Register to form up to 48 transition terms (AND terms). All transition terms can include True, False, or Don't Care states of the controlling variables, and are merged in the OR array to issue next-state and next-output commands to their respective registers on the LOW-to-HIGH transition of the Clock pulse. Both True and Complement transition terms can be generated by optional use of the internal input variable (C) from the Complement Array. Also, if desired, the Preset input can be converted to $\overline{\text{Output Enable}}$ function, as an additional user-programmable option.

Order codes are contained on the pages following.

FEATURES

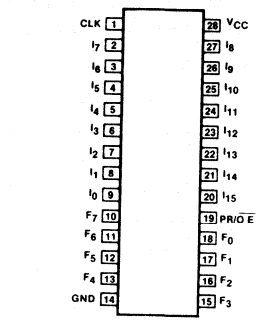
- **Field programmable (Ni-Cr link)**
- **16 input variables**
- **8 output functions**
- **48 transition terms**
- **6-bit State Register**
- **8-bit Output Register**
- **Transition Complement Array**
- **Positive edge trigger clock**
- **Programmable asynchronous preset or Output Enable**
- **Power-on preset to all "1" of internal registers**
- **f_{MAX} = 13.9MHz**
- **650mW power dissipation (typical)**
- **TTL compatible**
- **Single +5V supply**
- **Tri-state outputs**

APPLICATIONS

- **Interface protocols**
- **Sequence detectors**
- **Peripheral controllers**
- **Timing generators**
- **Sequential circuits**
- **Elevator controllers**
- **Security locking systems**
- **Counters**
- **Shift registers**

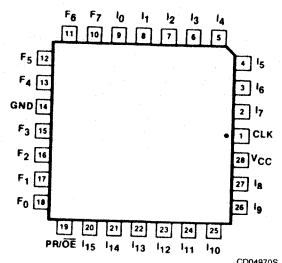
PIN CONFIGURATION

N PACKAGE



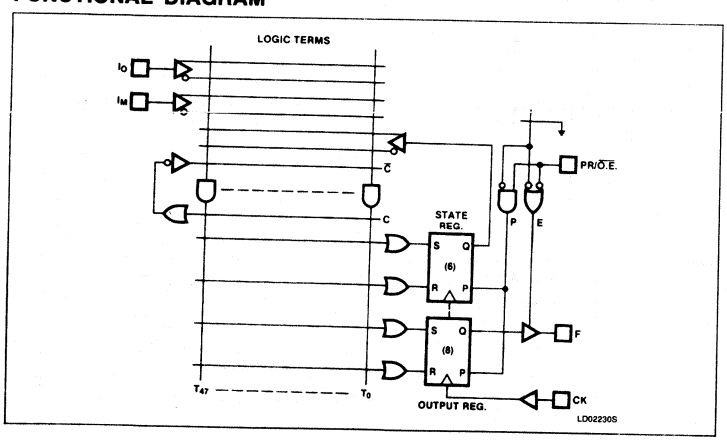
N = Plastic

A PACKAGE



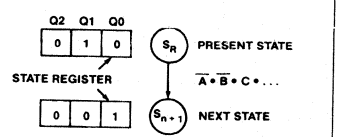
A = Plastic Leaded Chip Carrier

FUNCTIONAL DIAGRAM



LOGIC FUNCTION

Typical State Transition:



SET Q_0: $S_0 = (\overline{Q_2} \cdot Q_1 \cdot \overline{Q_0}) \cdot \overline{A} \cdot \overline{B} \cdot C \ldots$
$R_0 = 0$

RESET Q_1: $S_1 = 0$
$R_1 = (\overline{Q_2} \cdot Q_1 \cdot \overline{Q_0}) \cdot \overline{A} \cdot \overline{B} \cdot C \ldots$

HOLD Q_2: $S_2 = 0$
$R_2 = 0$

TB00900S

Field Programmable Logic Sequencer (16 x 48 x 8) PLS105

PIN DESCRIPTION

PIN NO.	SYMBOL	NAME AND FUNCTION	POLARITY
1	CK	**Clock:** The Clock input to the State and Output Registers. A Low-to-High transition on this line is necessary to update the contents of both registers.	Active-high
2 – 8 20 – 27	I_{1-15}	**Logic Inputs:** The 15 external inputs to the AND array used to program jump conditions between machine states, as determined by a given logic sequence.	Active-high/low
9	I_0	**Logic/Diagnostic Input:** A 16th external logic input to the AND array, as above, when exercised with standard TTL levels. When I_0 is held at +10V, device outputs F_{0-5} reflect the contents of State Register bits P_{0-5}. The contents of each Output Register remains unaltered.	Active-high/low
10 – 13 15 – 18	F_{0-7}	**Logic/Diagnostic Outputs:** Eight device outputs which normally reflect the contents of Output Register bits Q_{0-7}, when enabled. When I_0 is held at +10V, $F_{0-5} = (P_{0-5})$, and $F_{6,7}$ = Logic "1".	Active-high
19	PR/$\overline{O.E.}$	**Preset or $\overline{\text{Output Enable}}$ Input:** A user programmable function: • **Preset:** Provides an asynchronous preset to logic "1" of all State and Output Register bits. Preset overrides Clock, and when held High, clocking is inhibited and F_{0-7} are High. Normal clocking resumes with the first full clock pulse following a high-to-low clock transition, after Preset goes Low. • **$\overline{\text{Output Enable}}$:** Provides an output enable function to all output buffers F_{0-7} from the Output Register.	Active-high (H) Active-low (L)

TRUTH TABLE [1, 2, 3, 4, 5, 6]

V_{CC}	OPTION		I_0	CK	S	R	$Q_{P/F}$	F
	PR	$\overline{O.E.}$						
+5V	H		*	X	X	X	H	H
	L		+10V	X	X	X	Q_n	$(Q_P)_n$
	L		X	X	X	X	Q_n	$(Q_F)_n$
		H	*	X	X	X	Q_n	Hi-Z
		L	+10V	X	X	X	Q_n	$(Q_P)_n$
		L	X	X	X	X	Q_n	$(Q_F)_n$
		L	X	↑	L	L	Q_n	$(Q_F)_n$
		L	X	↑	L	H	L	L
		L	X	↑	H	L	H	H
		L	X	↑	H	H	IND.	IND.
↑	X	X	X	X	X	X	H	

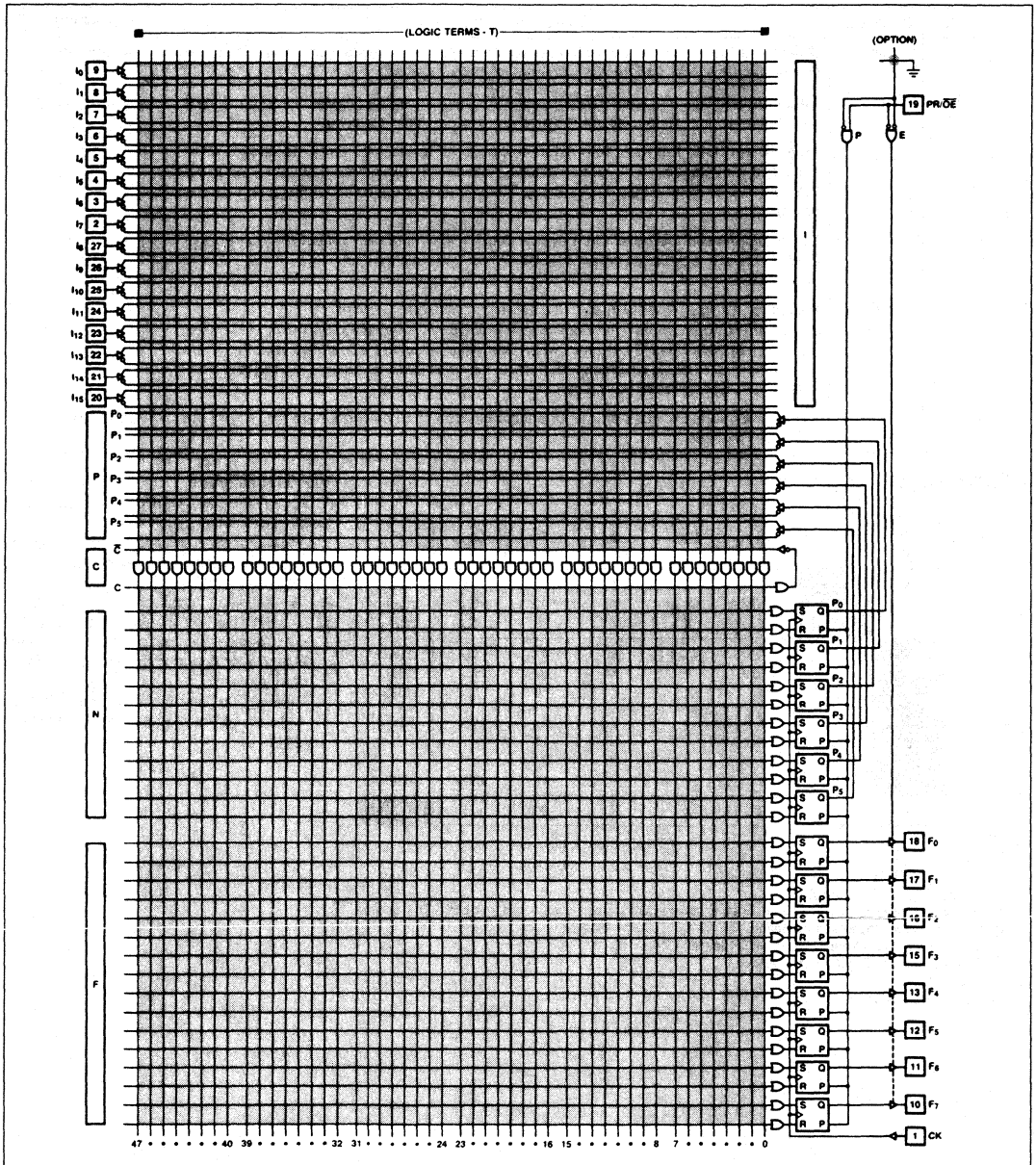
NOTES:
1. Positive Logic:
   $S/R = T_0 + T_1 + T_2 + ... + T_{47}$
   $T_n = C(I_0\ I_1\ I_2...)\ (P_0\ P_1...P_5)$
2. Either Preset (active-HIGH) or $\overline{\text{Output Enable}}$ (active-LOW) are available, but not both. The desired function is a user-programmable option.
3. ↑ denotes transition from LOW to HIGH level.
4. R = S = HIGH is an illegal input condition.
5. * = H/L/+10V
6. X = Don't care ($\leq$ 5.5V)

VIRGIN STATE

A factory shipped virgin device contains all fusible links intact, such that:
1. PR/$\overline{OE}$ option is set to PR. Thus, all outputs will be at "1", as preset by initial power-up procedure.
2. All transition terms are disabled (0).
3. All S/R flip-flop inputs are disabled (0).
4. The device can be clocked via a Test Array pre-programmed with a standard test pattern.
   NOTE: The Test Array pattern MUST be deleted before incorporating a user program.

Field Programmable Logic Sequencer (16 x 48 x 8) PLS105

FPLS LOGIC DIAGRAM



NOTES:
1. All AND inputs with a blown link float to a logic "1".
2. All OR gate inputs with a blown link float to logic "0".
3. Programmable connection.

Field Programmable Logic Sequencer (16 x 48 x 8) PLS105

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 600mil 28 pin	PLS105N
Plastic leaded Chip Carrier 28 pin	PLS105A

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING Min	RATING Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input currents	-30	+30	mA
I_{OUT}	Output currents		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	-65	+150	

The PLS105 device is also processed to military requirements for operation over the military temperature range. For specifications and ordering information consult the Signetics Military Data Book.

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq 75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage[3]						
V_{IH}	High	V_{CC} = Max	2			V
V_{IL}	Low	V_{CC} = Min			0.8	
V_{IC}	Clamp[4]	V_{CC} = Min, I_{IN} = -12mA		-0.8	-1.2	
Output voltage[3]		V_{CC} = Min				
V_{OH}	High[5]	I_{OH} = -2mA	2.4			V
V_{OL}	Low[6]	I_{OL} = 9.6mA		0.35	0.45	
Input current						
I_{IH}	High	V_{IN} = 5.5V		< 1	25	μA
I_{IL}	Low	V_{IN} = 0.45V		-10	-100	
I_{IL}	Low (CK input)	V_{IN} = 0.45V		-50	-250	
Output current		V_{CC} = Max				
$I_{O(OFF)}$	Hi-Z state[7]	V_{OUT} = 5.5V		1	40	μA
		V_{OUT} = 0.45V		-1	-40	
I_{OS}	Short circuit[4, 8]	V_{OUT} = 0V	-15		-70	mA
I_{CC}	V_{CC} supply current[9]	V_{CC} = Max		120	180	mA
Capacitance[7]		V_{CC} = 5.0V				
C_{IN}	Input	V_{IN} = 2.0V		8		pF
C_{OUT}	Output	V_{OUT} = 2.0V		10		

NOTES:
1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other condition above those indicated in the operational and programming specification of the device is not implied.
2. All typical values are at V_{CC} = 5V, T_A = 25°C.
3. All voltage values are with respect to network ground terminal.
4. Test one at a time.
5. Measured with V_{IL} applied to $\overline{OE}$ and a logic high stored, or with V_{IH} applied to PR.
6. Measured with a programmed logic condition for which the output is at a low logic level, and V_{IL} applied to PR/$\overline{OE}$ Output sink current is supplied through a resistor to V_{CC}.
7. Measured with V_{IH} applied to PR/$\overline{OE}$.
8. Duration of short circuit should not exceed 1 second.
9. I_{CC} is measured with the PR/$\overline{OE}$ input grounded, all other inputs at 4.5V and the outputs open.

Field Programmable Logic Sequencer (16 x 48 x 8) PLS105

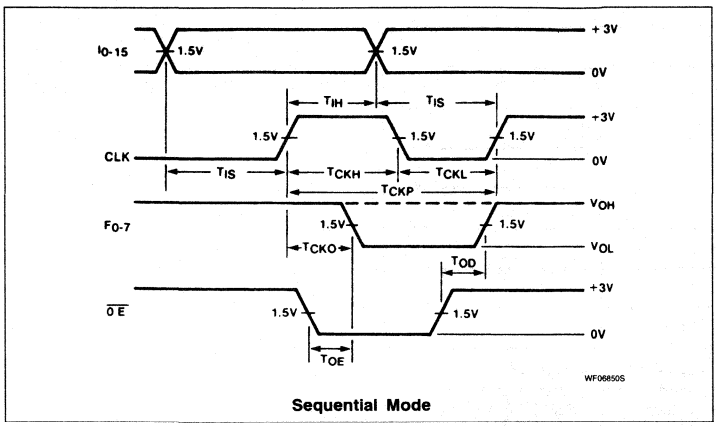
AC ELECTRICAL CHARACTERISTICS $R_1 = 470\Omega$, $R_2 = 1k\Omega$, $C_L = 30pF$, $0°C \leq T_A \leq +75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TO	FROM	LIMITS			UNIT
				Min	Typ[1]	Max	
Pulse width							
T_{CKH}	Clock[2] high	CK –	CK +	25	15		ns
T_{CKL}	Clock low	CK +	CK –	25	15		
$T_{CKP1}B$	Period (w/o c-array)	CK +	CK +	80	40		
$T_{CKP2}B$	Period (w/c-array)	CK +	CK +	120	60		
T_{PRH}	Preset pulse	PR +	PR –	25	15		
Set-up time[3]							
$T_{IS1}A$	Input	CK +	Input ±	60			ns
$T_{IS1}B$	Input	CK +	Input ±	50			
$T_{IS1}C$	Input	CK +	Input ±	42			
$T_{IS2}A$	Input (through Complement Array)	CK +	Input ±	90			
$T_{IS2}B$	Input (through Complement Array)	CK +	Input	80			
$T_{IS2}C$	Input (through Complement Array)	CK +	Input	72			
T_{VS}	Power-on preset	CK –	V_{CC} +	0	–10		
T_{PRS}	Preset	CK –	PR –	0	–10	•	
Hold time							
T_{IH}	Input	Input ±	CK +	5	–10		ns
Propagation delay							
T_{CKO}	Clock	Output ±	CK +		15	30	ns
T_{OE}	Output enable	Output –	O.E. –		20	30	
T_{OD}	Output disable	Output +	O.E. +		20	30	
* T_{PR}	Preset	Output +	PR +		18	30	
T_{PPR}	Power-on preset	Output +	V_{CC} +		0	10	
Frequency of operation[3]							
$f_{MAX}C$	w/o c-array					13.9	MHz
$f_{MAX}C$	w/c-array					9.8	

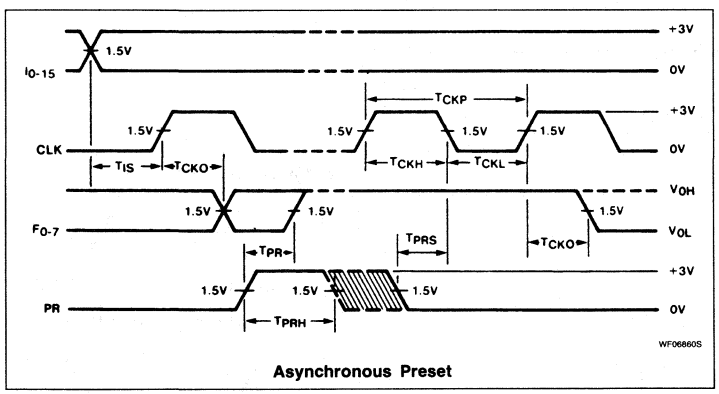
NOTES:
1. All typical values are at $V_{CC} = 5.V$, $T_A = +25°C$.
2. To prevent spurious clocking, clock rise time (10%-90%) $\leq$ 30ns.
3. See "Speed vs. OR Loading" on page 8.

Field Programmable Logic Sequencer (16 x 48 x 8) PLS105

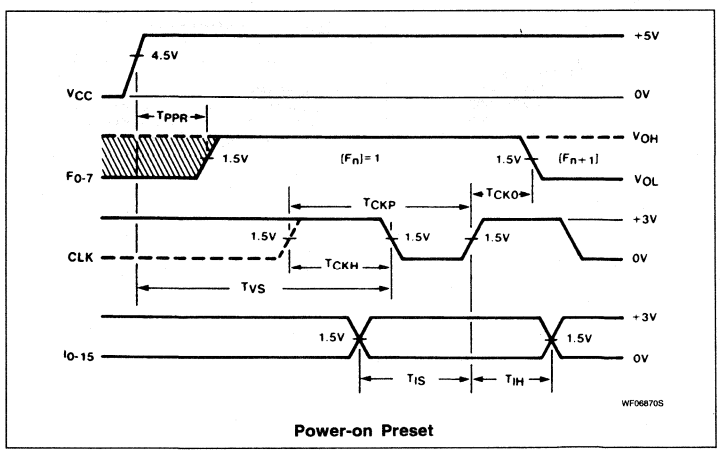
TIMING DIAGRAMS



Sequential Mode



Asynchronous Preset



Power-on Preset

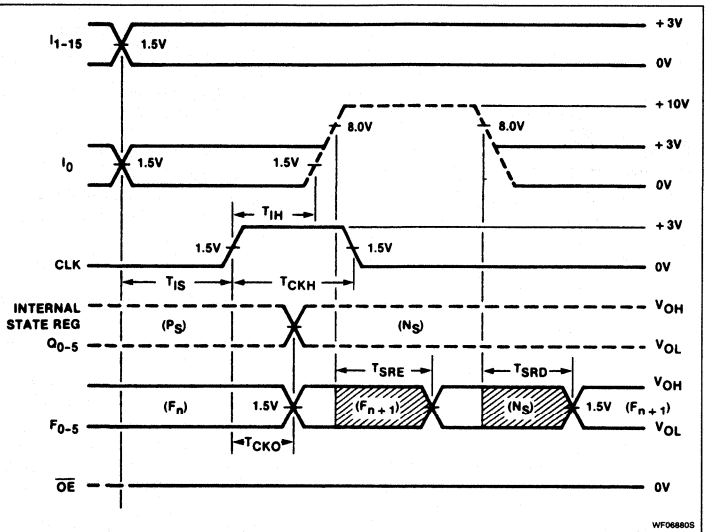
TIMING DEFINITIONS

T_{CKH}	Width of input clock pulse.
T_{CKL}	Interval between clock pulses.
T_{CKP1}	Clock period – when not using Complement Array.
T_{IS1}	Required delay between beginning of valid input and positive transition of Clock.
T_{CKP2}	Clock period – when using Complement Array.
T_{IS2}	Required delay between beginning of valid input and positive transition of Clock, when using optional Complement Array (two passes necessary through the AND Array).
T_{VS}	Required delay between V_{CC} (after power-on) and negative transition of Clock preceding first reliable clock pulse.
T_{PRS}	Required delay between negative transition of Asynchronous Preset and negative transition of Clock preceding first reliable clock pulse.
T_{IH}	Required delay between positive transition of Clock and end of valid Input data.
T_{CKO}	Delay between positive transition of clock and when outputs become valid (with PR/$\overline{OE}$ low).
T_{OE}	Delay between beginning of Output Enable Low and when Outputs become valid.
T_{OD}	Delay between beginning of Output Enable High and when Outputs are in the off state.
T_{SRE}	Delay between input I_0 transition to Diagnostic Mode and when the Outputs reflect the contents of the State Register.
T_{SRD}	Delay between input I_0 transition to Logic mode and when the Outputs reflect the contents of the Output Register.
T_{PR}	Delay between positive transition of Preset and when Outputs become valid at "1".
T_{PPR}	Delay between V_{CC} (after power-on) and when Outputs become preset at "1".
T_{PRH}	Width of preset input pulse.
f_{MAX}	Maximum clock frequency.

6

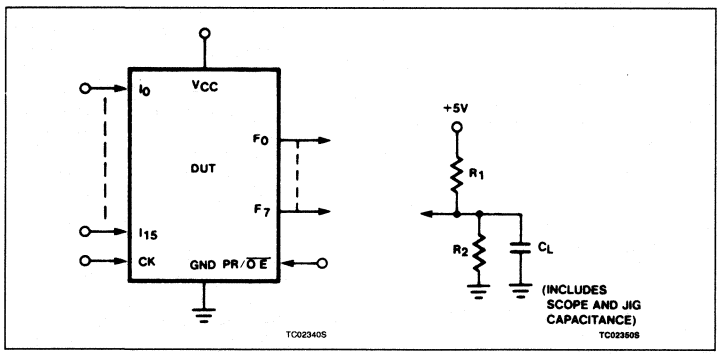
Field Programmable Logic Sequencer (16 x 48 x 8) PLS105

TIMING DIAGRAMS (Continued)

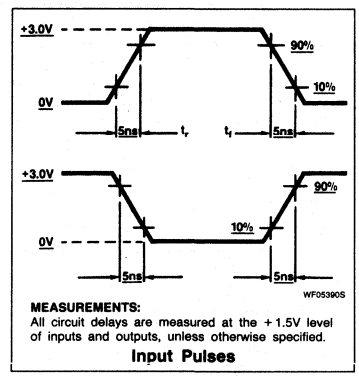


Diagnostic Mode

TEST LOAD CIRCUIT



VOLTAGE WAVEFORM



MEASUREMENTS:
All circuit delays are measured at the +1.5V level of inputs and outputs, unless otherwise specified.

Input Pulses

Field Programmable Logic Sequencer (16 x 48 x 8) PLS105

SPEED VS. "OR" LOADING

The maximum frequency at which the FPLS can be clocked while operating in *sequential mode* is given by:

$$(1/f_{MAX}) = T_{CY} = T_{IS} + T_{CKO}$$

This frequency depends on the number of transition terms T_n used. Having all 48 terms connected in the AND array does not appreciably impact performance; but the number of terms connected to each OR line affects T_{IS}, due to capacitive loading. The effect of this loading can be seen in Figure 1, showing the variation of T_{IS1} with the number of terms connected per OR.

The AC electrical characteristics contain three limits for the parameters T_{IS1} and T_{IS2}. The first, T_{IS1A} is guaranteed for a device with 48 terms connected to any OR line. T_{IS1B} is guaranteed for a device with 32 terms connected to any OR line. And T_{IS1C} is guaranteed for a device with 24 terms connected to any OR line.

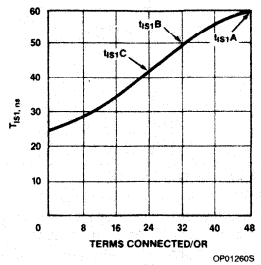


Figure 1. T_{IS1} vs. Terms/OR Connected

The three other entries in the AC table, T_{IS2} A, B, and C are corresponding 48, 32, and 24 term limits when using the on-chip Complement Array.

The worst case T_{IS} for a given application can be determined by identifying the OR line with the maximum number of T_n connections. This can be done by referring to the interconnect pattern in the FPLS logic diagram, typically illustrated in Figure 2, or by counting the maximum number of "H" or "L" entries in one of the columns of the device Program Table.

This number plotted on the curve in Figure 1 will yield the worst case T_{IS} and, by implication, the maximum clocking frequency for reliable operation.

Note that for maximum speed all UNUSED transition terms should be disconnected from the OR array.

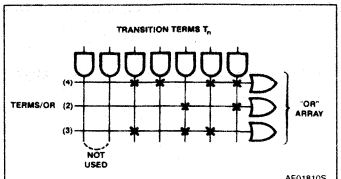


Figure 2. Typical OR Array Interconnect Pattern

Field Programmable Logic Sequencer (16 x 48 x 8) PLS105

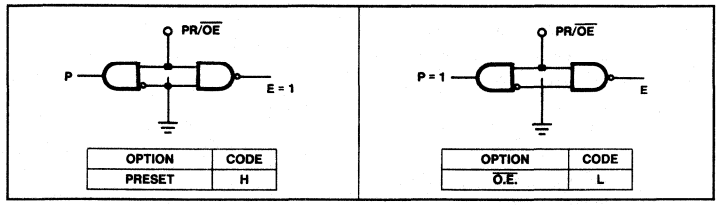
LOGIC PROGRAMMING

The FPLS can be programmed by means of Logic programming equipment.

With Logic programming, the AND/OR gate input connections necessary to implement the desired logic function are coded directly from the State Diagram using the Program Table on the following page.

In this Table, the logic state or action of control variables C, I, P, N, and F, associated with each Transition Term T_n, is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

PRESET/$\overline{O.E.}$ OPTION – (P/E)



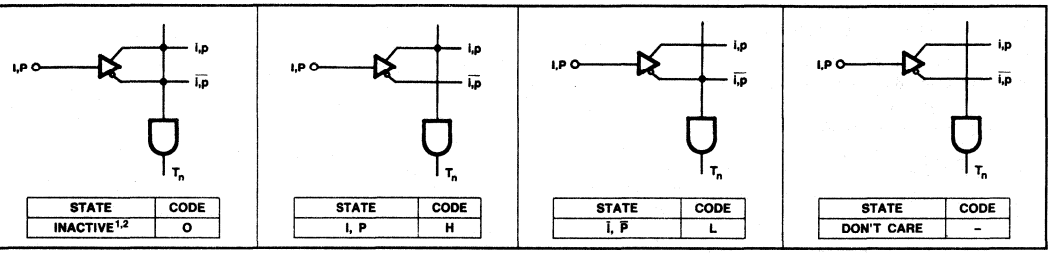
OPTION	CODE
PRESET	H

OPTION	CODE
$\overline{O.E.}$	L

PROGRAMMING THE PLS105:

The PLS105 has a power-up preset feature. This feature insures that the device will power-up in a known state with all register elements (state and output register) at a logic high (H). When programming the device it is important to realize this is the initial state of the device. You *must* provide a next state jump if you do not wish to use all highs (H) as the present state.

"AND" ARRAY – (I), (P)



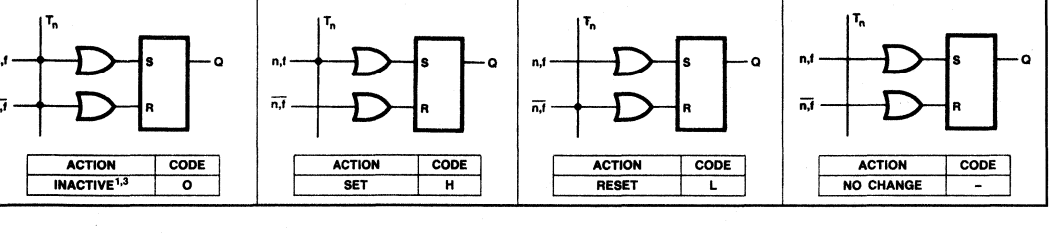
STATE	CODE
INACTIVE[1,2]	O

STATE	CODE
I, P	H

STATE	CODE
$\overline{I}$, $\overline{P}$	L

STATE	CODE
DON'T CARE	–

"OR" ARRAY – (N), (F)



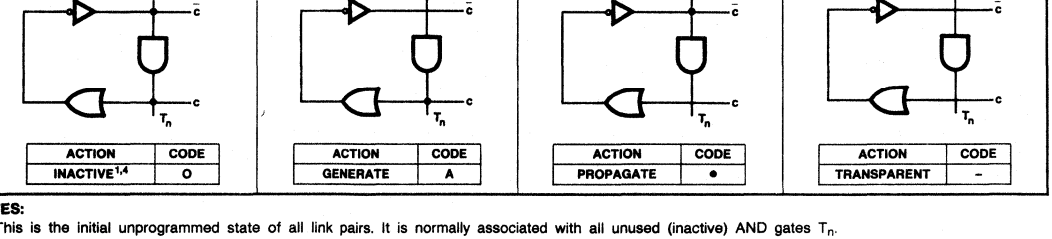
ACTION	CODE
INACTIVE[1,3]	O

ACTION	CODE
SET	H

ACTION	CODE
RESET	L

ACTION	CODE
NO CHANGE	–

"COMPLEMENT" ARRAY – (C)



ACTION	CODE
INACTIVE[1,4]	O

ACTION	CODE
GENERATE	A

ACTION	CODE
PROPAGATE	•

ACTION	CODE
TRANSPARENT	–

NOTES:

1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates T_n.
2. Any gate T_n will be unconditionally inhibited if any one of its I or P link pairs is left intact.
3. To prevent simultaneous Set and Reset flip-flop commands, this state is not allowed for N and F link pairs coupled to active gates T_n (see flip-flop truth tables).
4. To prevent oscillations, this state is not allowed for C link pairs coupled to active gates T_n.

Field Programmable Logic Sequencer (16 x 48 x 8) PLS105

FPLS PROGRAM TABLE

CUSTOMER NAME _____

PURCHASE ORDER # _____

SIGNETICS DEVICE # CF (XXXX)

CUSTOMER SYMBOLIZED PART # _____

TOTAL NUMBER OF PARTS _____

PROGRAM TABLE _____

REV _____

DATE _____

PROGRAM TABLE ENTRIES

AND

INACTIVE	0	Cn
GENERATE	A	
PROPAGATE	•	
TRANSPARENT	—	

INACTIVE	0	Im, Ps
I, P	H	
$\overline{I}$, $\overline{P}$	L	
DON'T CARE	—	

OR

INACTIVE	0	Ns, Fr
SET	H	
RESET	L	
NO CHANGE	—	

OPTION

PRESET	H	P/E
$\overline{OE}$	L	

TERM	Cn	AND INPUT (Im) 15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	PRESENT STATE (Ps) 5	4	3	2	1	0	REMARKS	OPTION (P/E) OR NEXT STATE (Ns) 5	4	3	2	1	0	OUTPUT (Fr) 7	6	5	4	3	2	1	0
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PIN NO.		20	21	22	23	24	25	26	27	2	3	4	5	6	7	8	9													10	11	12	13	15	16	17	18
VARIABLE NAME																																						

LD02250S

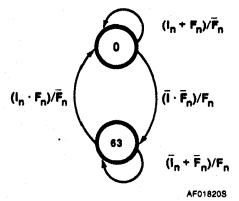
NOTES:
1. The FPLS is shipped with all links initially intact. Thus, a background of "0" for all Terms, and an "H" for the P/E option, exits in the table, shown BLANK instead for clarity.
2. Unused Cn Im, and Ps bits are normally programmed Don't Care (–).
3. Unused Transition Terms can be left blank for future code modification, or programmed as (–) for maximum speed.
4. Letters in variable fields are used as identifiers by logic type programmed.

TEST ARRAY

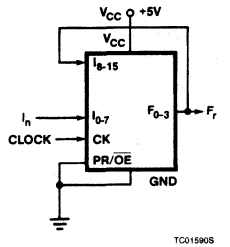
The FPLS may be subjected to AC and DC parametric tests prior to programming via an on-chip test array.

The array consists of test transition terms 48 and 49, factory programmed as shown below.

Testing is accomplished by clocking the FPLS and applying the proper input sequence to I_{0-7} as shown in the test circuit timing diagram.



State Diagram



FPLS Under Test

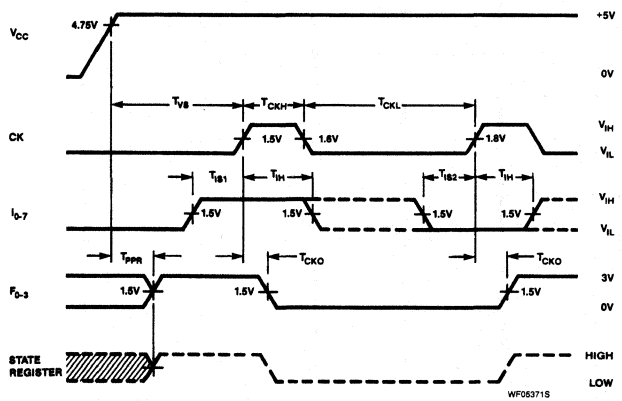
TEST ARRAY PROGRAM

TERM	C	AND: INPUT (Im) 15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	PRESENT STATE (Ps) 5	4	3	2	1	0	OPTION (P/E)	OR: NEXT STATE (Ns) 5	4	3	2	1	0	OUTPUT (Fr) 7	6	5	4	3	2	1	0
48	A	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	L	L	L	L	L	L	L	L	L	L	L	L	L
49	●	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	H	H	H	H	H	H	H	H	H	H	H	H	H	H

TB01760S

Test Array Program

Both terms 48 and 49 must be deleted during user programming to avoid interfering with the desired logic function. This is accomplished automatically by any Signetic's qualified programming equipment.



Test Circuit Timing Diagram

TEST ARRAY DELETED

TERM	C	AND: INPUT (Im) 15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	PRESENT STATE (Ps) 5	4	3	2	1	0	OPTION (P/E)	OR: NEXT STATE (Ns) 5	4	3	2	1	0	OUTPUT (Fr) 7	6	5	4	3	2	1	0
48	—	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	—	—	—	—	—	—	—	—	—	—	—	—	—	—
49	●	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	H	—	—	—	—	—	—	—	—	—	—	—	—	—	—

TB01750S

Test Array Deleted

Signetics

PLS105A
Field Programmable Logic Array (16 x 48 x 8)

Signetics Programmable Logic
Product Specification

Application Specific Products
- **Series 28**

DESCRIPTION

The PLS105A is a bipolar programmable state machine of the Mealy type. It contains logic AND-OR gate arrays with user programmable connections which control the inputs of on-chip State and Output Registers. These consist respectively of 6 Q_P, and 8 Q_F edge-triggered, clocked S/R flip-flops, with an asynchronous Preset option. All flip-flops are unconditionally preset to "1" during power turn on.

The AND array combines 16 external inputs I_{0-15} with 6 internal inputs P_{0-5} fed back from the State Register to form up to 48 Transition terms (AND terms). All Transition terms can include True, False, or Don't Care states of the controlling variables, and are merged in the OR array to issue next-state and next-output commands to their respective registers on the Low to High transition of the Clock pulse. Both True and Complement Transition terms can be generated by optional use of the internal input variable (C) from the Complement Array. Also, if desired, the Preset input can be converted to $\overline{\text{Output-Enable}}$ function, as an additional user programmable option.

Order codes are contained on the pages following.

FEATURES

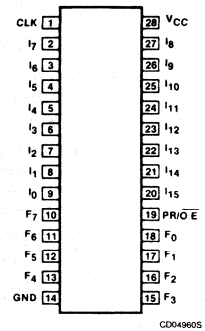
- **Field programmable (Ni-Cr link)**
- **16 input variables**
- **8 output functions**
- **48 transition terms**
- **6-bit State Register**
- **8-bit Output Register**
- **Transition complement array**
- **Positive edge trigger clock**
- **Programmable asynchronous preset or output enable**
- **Power-on preset to all "1" of internal registers**
- **$f_{(MAX)}$ = 20MHz**
- **650mW power dissipation (typical)**
- **TTL compatible**
- **Single +5V supply**
- **Tri-state outputs**

APPLICATIONS

- **Interface protocols**
- **Sequence detectors**
- **Peripheral controllers**
- **Timing generators**
- **Sequential circuits**
- **Elevator controllers**
- **Security locking systems**
- **Counters**
- **Shift registers**

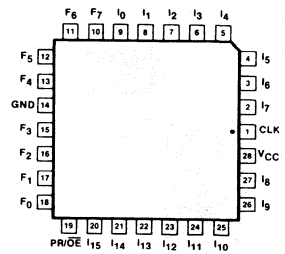
PIN CONFIGURATION

N PACKAGE



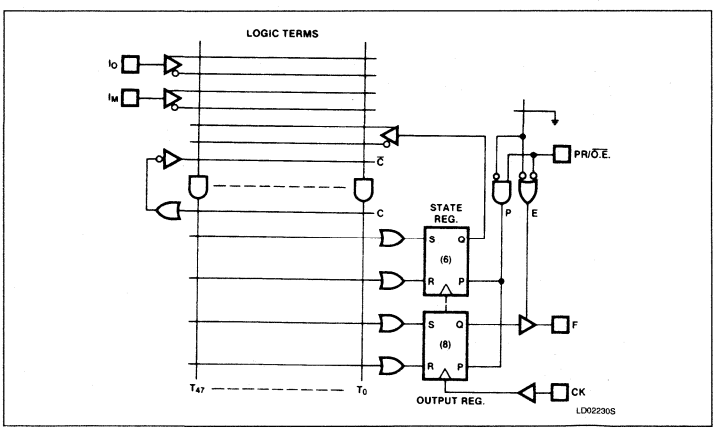
N = Plastic

A PACKAGE



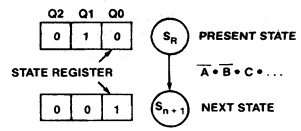
A = Plastic Leaded Chip Carrier

FUNCTIONAL DIAGRAM



LOGIC FUNCTION

Typical State Transition:



SET Q_0: $S_0 = (\overline{Q_2} \cdot Q_1 \cdot \overline{Q_0}) \cdot \overline{A} \cdot \overline{B} \cdot C \ldots$

$R_0 = 0$

RESET Q_1: $S_1 = 0$

$R_1 = (\overline{Q_2} \cdot Q_1 \cdot \overline{Q_0}) \cdot \overline{A} \cdot \overline{B} \cdot C \ldots$

HOLD Q_2: $S_2 = 0$

$R_2 = 0$

TB00900S

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Field Programmable Logic Array (16 x 48 x 8) PLS105A

PIN DESCRIPTION

PIN NO.	SYMBOL	NAME AND FUNCTION	POLARITY
1	CK	**Clock:** The Clock input to the State and Output Registers. A Low-to-High transition on this line is necessary to update the contents of both registers.	Active-high
2 – 8 20 – 27	I_{1-15}	**Logic Inputs:** The 15 external inputs to the AND array used to program jump conditions between machine states, as determined by a given logic sequence.	Active-high/low
9	I_0	**Logic/Diagnostic Input:** A 16th external logic input to the AND array, as above, when exercised with standard TTL levels. When I_0 is held at +10V, device outputs F_{0-5} reflect the contents of State Register bits P_{0-5}. The contents of each Output Register remains unaltered.	Active-high/low
10 – 13 15 – 18	F_{0-7}	**Logic/Diagnostic Outputs:** Eight device outputs which normally reflect the contents of Output Register bits Q_{0-7}, when enabled. When I_0 is held at +10V, $F_{0-5} = (P_{0-5})$, and $F_{6,7}$ = Logic "1".	Active-high
19	PR/$\overline{O.E.}$	**Preset or Output Enable Input:** A user programmable function: • **Preset:** Provides an asynchronous preset to logic "1" of all State and Output Register bits. Preset overrides Clock, and when held High, clocking is inhibited and F_{0-7} are high. Normal clocking resumes with the first full clock pulse following a High-to-Low clock transition, after Preset goes Low.	Active-high (H)
		• **Output Enable:** Provides an output enable function to buffers F_{0-7} from the Output Register.	Active-low (L)

TRUTH TABLE [1, 2, 3, 4, 5, 6]

V_{CC}	OPTION		I_0	CK	S	R	$Q_{P/F}$	F
	PR	$\overline{O.E.}$						
+5V	H		*	X	X	X	H	H
	L		+10V	X	X	X	Q_n	$(Q_P)_n$
	L		X	X	X	X	Q_n	$(Q_F)_n$
		H	*	X	X	X	Q_n	Hi-Z
		L	+10V	X	X	X	Q_n	$(Q_P)_n$
		L	X	X	X	X	Q_n	$(Q_F)_n$
		L	X	↑	L	L	Q_n	$(Q_F)_n$
		L	X	↑	L	H	L	L
		L	X	↑	H	L	H	H
		L	X	↑	H	H	IND.	IND.
↑	X	X	X	X	X	X	H	

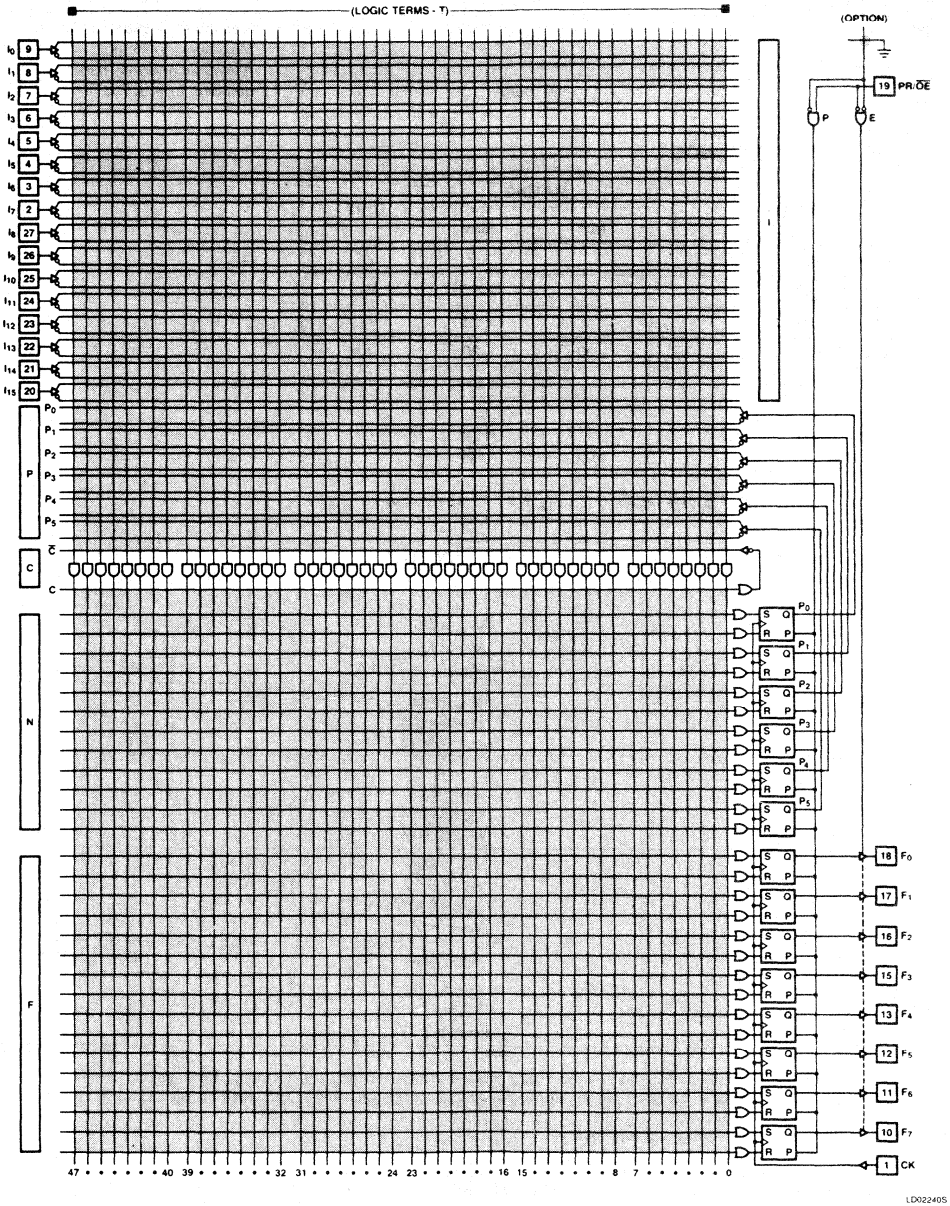
NOTES:
1. Positive Logic:
   $S/R = T_0 + T_1 + T_2 + ... + T_{47}$
   $T_n = C(I_0\ I_1\ I_2...)\ (P_0\ P_1...P_5)$
2. Either Preset (active-HIGH) or Output Enable (active-LOW) are available, but not both. The desired function is a user-programmable option.
3. ↑ denotes transition from LOW to HIGH level.
4. R = S = HIGH is an illegal input condition.
5. * = H/L/+10V
6. X = Don't care (≤ 5.5V)

VIRGIN STATE

A factory shipped virgin device contains all fusible links intact, such that:
1. PR/$\overline{OE}$ option is set to PR. Thus, all outputs will be at "1", as preset by initial power-up procedure.
2. All transition terms are disabled (0).
3. All S/R flip-flop inputs are disabled (0).
4. The device can be clocked via a Test Array pre-programmed with a standard test pattern.
   NOTE: The Test Array pattern MUST be deleted before incorporating a user program.

Field Programmable Logic Array (16 x 48 x 8) PLS105A

FPLS LOGIC DIAGRAM



NOTES:
1. All AND gate inputs with a blown link float to a logic "1".
2. All OR gate inputs with a blown fuse float to logic "0".
3. ⊗ Programmable connection.

Field Programmable Logic Array (16 x 48 x 8) PLS105A

ORDERING CODE

DESCRIPTION	ORDER CODE
Plastic DIP 600mil 28 pin	PLS105AN
Plastic leaded Chip Carrier 28 pin	PLS105AA

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

ABSOLUTE MAXIMUM RATINGS[1]

PARAMETER		RATING Min	RATING Max	UNIT
V_{CC}	Supply voltage		+7	V_{dc}
V_{IN}	Input voltage		+5.5	V_{dc}
V_{OUT}	Output voltage		+5.5	V_{dc}
I_{IN}	Input currents	-30	+30	mA
I_{OUT}	Output currents		+100	mA
	Temperature range			
T_A	Operating	0	+75	°C
T_{STG}	Storage	-65	+150	

DC ELECTRICAL CHARACTERISTICS $0°C \leq T_A \leq 75°C$, $4.75V \leq V_{CC} \leq 5.25V$

PARAMETER		TEST CONDITIONS	LIMITS Min	LIMITS Typ[2]	LIMITS Max	UNIT
Input voltage[3]						
V_{IH}	High	V_{CC} = Max	2			V
V_{IL}	Low	V_{CC} = Min			0.8	
V_{IC}	Clamp[4]	V_{CC} = Min, I_{IN} = -12mA		-0.8	-1.2	
Output voltage[3]		V_{CC} = Min				
V_{OH}	High[5]	I_{OH} = -2mA	2.4			V
V_{OL}	Low[6]	I_{OL} = 9.6mA		0.35	0.45	
Input current						
I_{IH}	High	V_{IN} = 5.5V		< 1	25	μA
I_{IL}	Low	V_{IN} = 0.45V		-10	-100	
I_{IL}	Low (CK input)	V_{IN} = 0.45V		-50	-250	
Output current		V_{CC} = Max				
$I_{O(OFF)}$	Hi-Z State[7]	V_{CC} = 5.5V		1	40	μA
		V_{OUT} = 0.45V		-1	-40	
I_{OS}	Short circuit[4, 8]	V_{OUT} = 0V	-15		-70	mA
I_{CC}	V_{CC} supply current[9]	V_{CC} = Max		120	180	mA
Capacitance[7]		V_{CC} = 5.0V				
C_{IN}	Input	V_{IN} = 2.0V		8		pF
C_{OUT}	Output	V_{OUT} = 2.0V		10		

NOTES:

1. Stresses above those listed under "Absolute Maximum Ratings" may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other condition above those indicated in the operational and programming specification of the device is not implied.
2. All typical values are at V_{CC} = 5V, T_A = 25°C.
3. All voltage values are with respect to network ground terminal.
4. Test one at a time.
5. Measured with V_{IL} applied to $\overline{OE}$ and a logic high stored, or with V_{IH} applied to PR.
6. Measured with a programmed logic condition for which the output is at a low logic level, and V_{IL} applied to PR/$\overline{OE}$ Output sink current is supplied through a resistor to V_{CC}.
7. Measured with V_{IH} applied to PR/$\overline{OE}$.
8. Duration of short circuit should not exceed 1 second.
9. I_{CC} is measured with the PR/$\overline{OE}$ input grounded, all other inputs at 4.5V and the outputs open.

Field Programmable Logic Array (16 x 48 x 8) PLS105A

AC ELECTRICAL CHARACTERISTICS $R_1 = 470\Omega$, $R_2 = 1k\Omega$, $C_L = 30pF$, $0°C \leq T_A \leq +75°C$, $4.75V \leq V_{CC} \leq 5.25V$

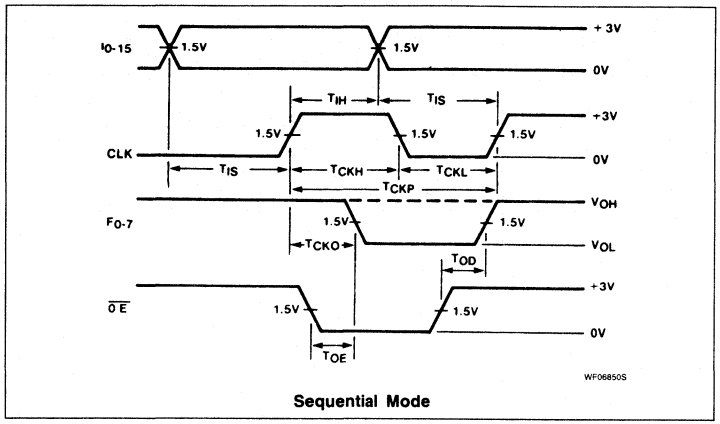
PARAMETERS		TO	FROM	LIMITS			UNIT
				Min	Typ[1]	Max	
Pulse width							
T_{CKH}	Clock[2] high	CK –	CK +	25	15		ns
T_{CKL}	Clock low	CK +	CK –	25	15		
$T_{CKP1}B$	Period (w/o c-array)	CK +	CK +	50	40		
$T_{CKP2}B$	Period (w/c-array)	CK +	CK +	80	50		
T_{PRH}	Preset pulse	PR +	PR –	25	15		
Set-up time[3]							
$T_{IS1}A$	Input	CK +	Input ±	40			ns
$T_{IS1}B$	Input	CK +	Input ±	30			
$T_{IS2}A$	Input (through Complement Array)	CK +	Input ±	70			
$T_{IS2}B$	Input (through Complement Array)	CK +	Input	60			
T_{VS}	Power-on preset	CK –	V_{CC} +	0	–10		
T_{PRS}	Preset	CK –	PR –	0	–10		
Hold time							ns
T_{IH}	Input	Input ±	CK +	5	–10		
Propagation delay							
T_{CKO}	Clock	Output ±	CK +		15	20	ns
T_{OE}	Output enable	Output –	O.E. –		20	30	
T_{OD}	Output disable	Output +	O.E. +		20	30	
T_{PR}	Preset	Output +	PR +		18	30	
T_{PPR}	Power-on preset	Output +	V_{CC} +		0	10	
Frequency of operation							
$f_{MAX}B$	w/o c-array					20	MHz
$f_{MAX}B$	w/c-array					12.5	

NOTES:
1. All typical values are at $V_{CC} = 5V$, $T_A = +25°C$.
2. To prevent spurious clocking, clock rise time (10%-90%) ≤ 30ns.
3. See "Speed vs. OR Loading" on page 8.

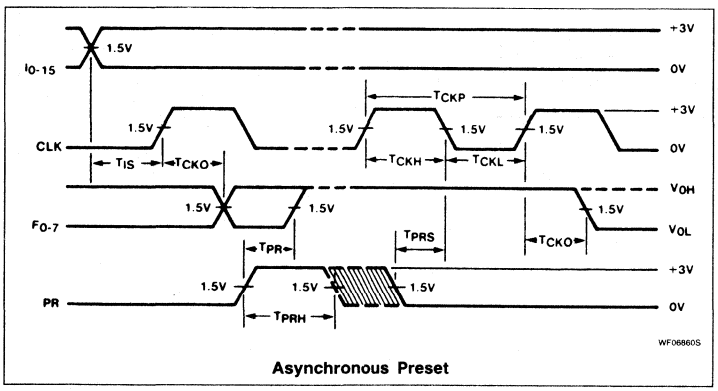
6

Field Programmable Logic Array (16 x 48 x 8) PLS105A

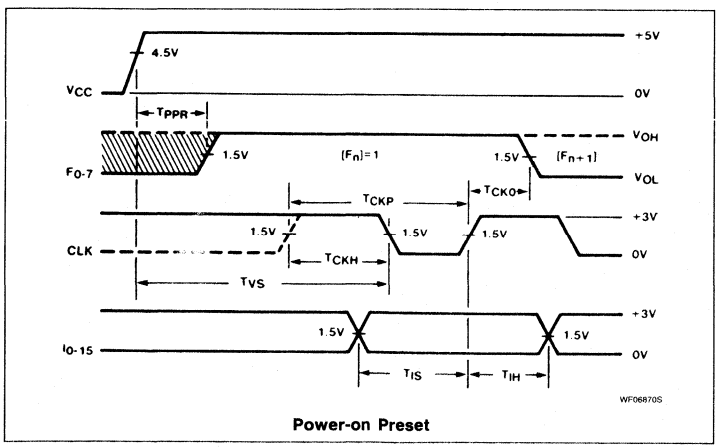
TIMING DIAGRAMS



Sequential Mode



Asynchronous Preset



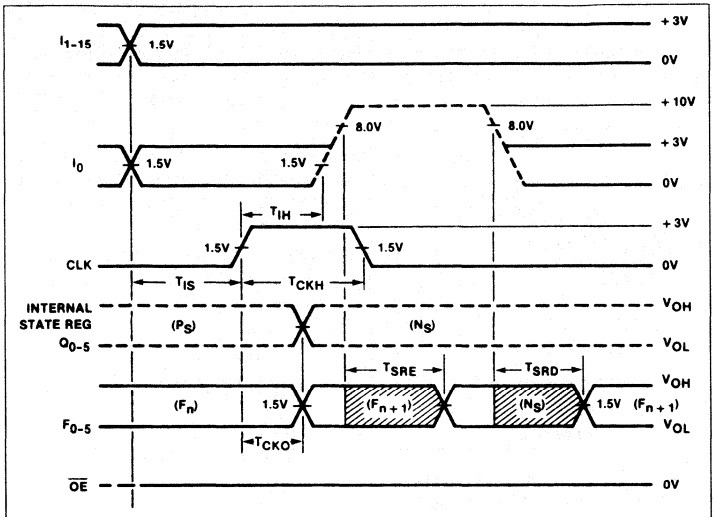
Power-on Preset

TIMING DEFINITIONS

T_{CKH}	Width of input clock pulse.
T_{CKL}	Interval between clock pulses.
T_{CKP}	Clock period — when not using Complement Array.
T_{IS1}	Required delay between beginning of valid input and positive transition of Clock.
T_{CKP2}	Clock period — when using Complement Array.
T_{IS2}	Required delay between beginning of valid Input and positive transition of Clock, when using optional Complement Array (two passes necessary through the AND Array).
T_{VS}	Required delay between V_{CC} (after power-on) and negative transition of Clock preceding first reliable clock pulse.
T_{PRS}	Required delay between negative transition of Asynchronous Preset and negative transition of Clock preceding first reliable clock pulse.
T_{IH}	Required delay between positive transition of Clock and end of valid Input data.
T_{CKO}	Delay between positive transition of Clock and when Outputs become valid (with PR/$\overline{OE}$ low).
T_{OE}	Delay between beginning of Output Enable Low and when Outputs become valid.
T_{OD}	Delay between beginning of Output Enable High and when Outputs are in the off state.
T_{SRE}	Delay between input I_0 transition to Diagnostic Mode and when the Outputs reflect the contents of the State Register.
T_{SRD}	Delay between input I_0 transition to Logic mode and when the Outputs reflect the contents of the Output Register.
T_{PR}	Delay between positive transition of Preset and when Outputs become valid at "1".
T_{PPR}	Delay between V_{CC} (after power-on) and when Outputs become preset at "1".
T_{PRH}	Width of preset input pulse.
f_{MAX}	Maximum clock frequency.

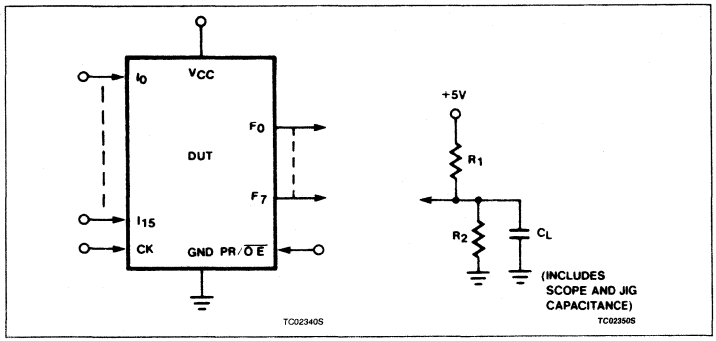
Field Programmable Logic Array (16 x 48 x 8) PLS105A

TIMING DIAGRAMS (Continued)

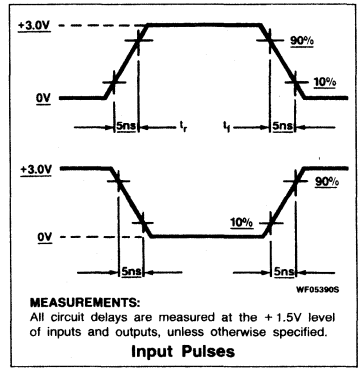


Diagnostic Mode

TEST LOAD CIRCUIT



VOLTAGE WAVEFORM



MEASUREMENTS:
All circuit delays are measured at the +1.5V level of inputs and outputs, unless otherwise specified.

Input Pulses

6

SPEED VS. "OR" LOADING

The maximum frequency at which the FPLS can be clocked while operating in *sequential mode* is given by:

$$(1/f_{MAX}) = T_{CY} = T_{IS} + T_{CKO}$$

This frequency depends on the number of transition terms T_n used. Having all 48 terms connected in the AND array does not appreciably impact performance; but the number of terms connected to each OR line affects T_{IS}, due to capacitive loading. The effect of this loading can be seen in Figure 1, showing the variation of T_{IS1} with the number of terms connected per OR.

The AC electrical characteristics contain two limits for the parameters T_{IS1} and T_{IS2}. The first, T_{IS1A} is guaranteed for a device with 24 terms connected to any OR line. T_{IS1B} is guaranteed for a device with 16 terms connected to any OR line.

The two other entries in the AC table, T_{IS2} A and B are corresponding 24 and 16 term limits when using the on-chip Complement array.

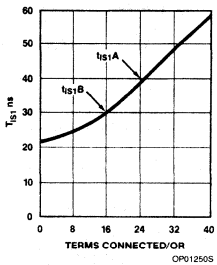


Figure 1. T_{IS1} vs. Terms/OR Connected.

The worst case of T_{IS} for a given application can be determined by identifying the OR line with the maximum number of T_n connections. This can be done by referring to the interconnect pattern in the FPLS logic diagram, typically illustrated in Figure 2, or by counting the maximum number of "H" *or* "L" entries in one of the columns of the device Program Table.

This number plotted on the curve in Figure 1 will yield the worst case T_{IS} and, by implication, the maximum clocking frequency for reliable operation.

Note that for maximum speed all UNUSED transition terms should be disconnected from the OR array.

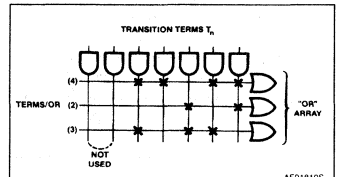


Figure 2. Typical OR Array Interconnect Pattern.

Field Programmable Logic Array (16 x 48 x 8) PLS105A

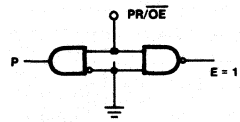
LOGIC PROGRAMMING

The FPLS can be programmed by means of Logic programming equipment.

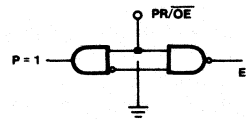
With Logic programming, the AND/OR gate input connections necessary to implement the desired logic function are coded directly from the State Diagram using the Program Table of the following page.

In this Table, the logic state or action of control variables C, I, P, N, and F, associated with each Transition Term T_n, is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

PRESET/$\overline{O.E.}$ OPTION - (P/E)



OPTION	CODE
PRESET	H

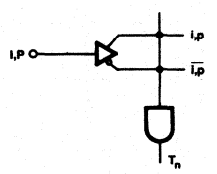


OPTION	CODE
$\overline{O.E.}$	L

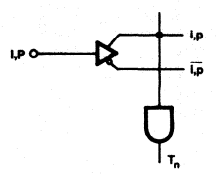
PROGRAMMING THE PLS105A:

The PLS105A has a power-up preset feature. This feature insures that the device will power-up in a known state with all register elements (state and output register) at a logic high (H). When programming the device it is important to realize this is the initial state of the device. You *must* provide a next state jump if you do not wish to use all highs (H) as the present state.

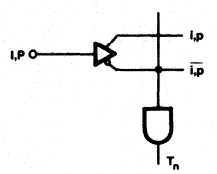
"AND" ARRAY - (I), (P)



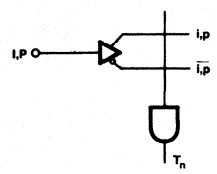
STATE	CODE
INACTIVE[1,2]	O



STATE	CODE
I, P	H

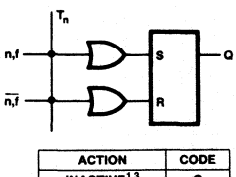


STATE	CODE
$\overline{I}$, $\overline{P}$	L

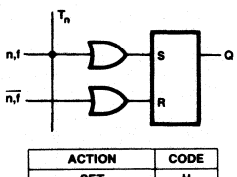


STATE	CODE
DON'T CARE	-

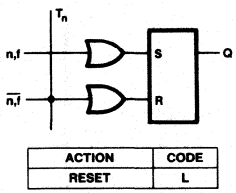
"OR" ARRAY - (N), (F)



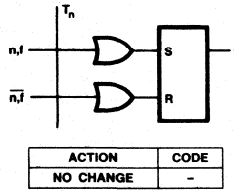
ACTION	CODE
INACTIVE[1,3]	O



ACTION	CODE
SET	H

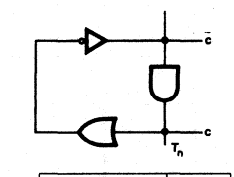


ACTION	CODE
RESET	L

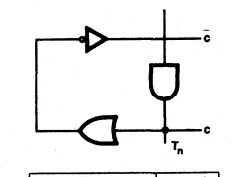


ACTION	CODE
NO CHANGE	-

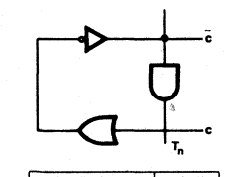
"COMPLEMENT" ARRAY - (C)



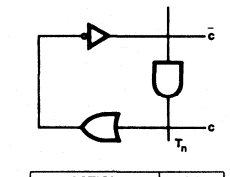
ACTION	CODE
INACTIVE[1,4]	O



ACTION	CODE
GENERATE	A



ACTION	CODE
PROPAGATE	•



ACTION	CODE
TRANSPARENT	-

NOTES:

1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates T_n.
2. Any gate T_n will be unconditionally inhibited if any one of its I or P link pairs is left intact.
3. To prevent simultaneous Set and Reset flip-flop commands, this state is not allowed for N and F link pairs coupled to active gates T_n (see flip-flop truth tables).
4. To prevent oscillations, this state is not allowed for C link pairs coupled to active gates T_n.

Field Programmable Logic Array (16 x 48 x 8) PLS105A

FPLS PROGRAM TABLE

CUSTOMER NAME _____

PURCHASE ORDER # _____

SIGNETICS DEVICE # CF (XXXX)

CUSTOMER SYMBOLIZED PART # _____

TOTAL NUMBER OF PARTS _____

PROGRAM TABLE _____

REV _____

DATE _____

PROGRAM TABLE ENTRIES

AND

INACTIVE	0
GENERATE	A
PROPAGATE	•
TRANSPARENT	—

Cn

INACTIVE	0
I, P	H
$\overline{I}$, $\overline{P}$	L
DON'T CARE	—

Im, Ps

OR

INACTIVE	0
SET	H
RESET	L
NO CHANGE	—

Ns, Fr

OPTION

PRESET	H
$\overline{OE}$	L

P/E

TERM	AND: C_n	AND: INPUT (Im) 15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	AND: PRESENT STATE (Ps) 5	4	3	2	1	0	REMARKS	OPTION (P/E) / OR: NEXT STATE (Ns) 5	4	3	2	1	0	OR: OUTPUT (Fr) 7	6	5	4	3	2	1	0
0																																					
1																																					
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PIN NO		20	21	22	23	24	25	26	27	2	3	4	5	6	7	8	9													10	11	12	13	15	16	17	18
VARIABLE NAME																																					

LD02250S

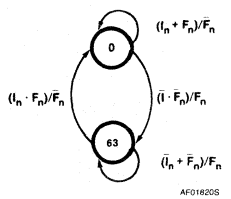
NOTES:
1. The FPLS is shipped with all links initially intact. Thus, a background of "0" for all Terms, and an "H" for the P/E option, exits in the table, shown BLANK instead for clarity.
2. Unsed Cn, Im, and Ps bits are normally programmed Don't Care (–).
3. Unused Transition Terms can be left blank for future code modification, or programmed as (–) for maximum speed.
4. Letters in variable fields are used as identifiers by logic type programmers.

TEST ARRAY

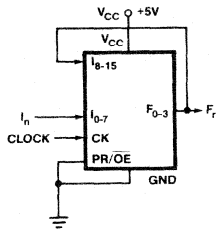
The FPLS may be subjected to AC and DC parametric tests prior to programming via an on-chip test array.

The array consists of test transition terms 48 and 49, factory programmed as shown below.

Testing is accomplished by clocking the FPLS and applying the proper input sequence to I_{0-7} as shown in the test circuit timing diagram.



State Diagram



FPLS Under Test

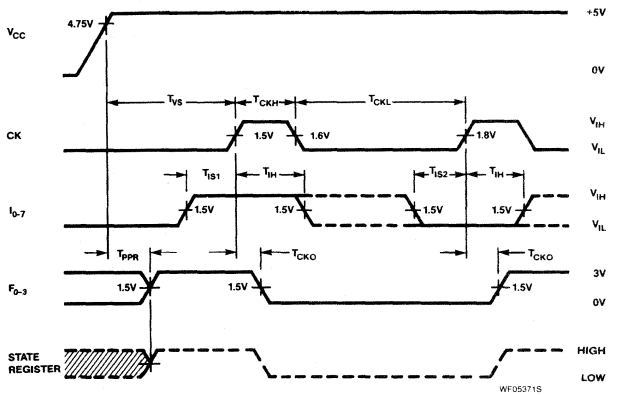
TEST ARRAY PROGRAM

TERM	C	AND INPUT (Im) 15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	PRESENT STATE (Ps) 5	4	3	2	1	0	OPTION (P/E) H; OR; NEXT STATE (Ns) 5	4	3	2	1	0	OUTPUT (Fr) 7	6	5	4	3	2	1	0
48	A	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	L	L	L	L	L	L	L	L	L	L	L	L	L	L
49	●	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	H	H	H	H	H	H	H	H	H	H	H	H	H	H

TB01760S

Test Array Program

Both terms 48 and 49 must be deleted during user programming to avoid interfering with the desired logic function. This is accomplished automatically by any Signetic's qualified programming equipment.



Test Circuit Timing Diagram

TEST ARRAY DELETED

TERM	C	AND INPUT (Im) 15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	PRESENT STATE (Ps) 5	4	3	2	1	0	OPTION (P/E) H; OR; NEXT STATE (Ns) 5	4	3	2	1	0	OUTPUT (Fr) 7	6	5	4	3	2	1	0
48	—	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	—	—	—	—	—	—	—	—	—	—	—	—	—	—
49	●	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	L	—	—	—	—	—	—	—	—	—	—	—	—	—	—

TB01750S

Test Array Deleted

Signetics

Application Specific Products

Section 7
Military Errata

Effective January 1, 1985, this section has been superseded by the 1985 Military Products Data Manual. Information regarding this manual can be obtained from the Military Division in Sacramento. (916) 925-6700.
Electrical specification herein as described for products with the "S" prefix do not necessarily describe the performance characterization of military processed products.

Signetics

Application Specific Products

Section 8
Development Software

INDEX

Signetics

AMAZE
Programmable Logic Development Software

Application Specific Products

SOFTWARE SUPPORT FOR USER PROGRAMMABLE LOGIC

Computer Aided Design (CAD) support is becoming necessary to address the time-consuming details required by the more complex programmable logic devices available today. The design effort can include the manipulation of Boolean equations, truth tables, state diagrams, flowcharts etc, to create the binary fuse map required to program such devices.

For many years, design engineers have used read-only memories (PROM's) to replace conventional logic. The architecture of the PROM can be described as a programmable logic device containing a **fixed** AND array followed by a **programmable** OR array. The fixed structure of the PROM requires a full assignment of output words to be programmed for every input combination. Therefore, little use can be made of programmable logic software programs for logic minimization or other compiling efforts when using PROM's.

Signetics Programmable Logic Devices are the most advanced approach to solving the inherent limitations of PROM's. Their architecture consists of a **programmable** AND array, followed by a **programmable** OR array - with the addition of a **programmable** Invert function for flexible output control.

A Signetics PLD device can implement **any** set of Boolean expressions, provided that they are first put into the standard sum of products form. The logical AND's are implemented at the first gate level of the programmable logic device and the logical OR's are implemented by the second gate level within the PLD. The only limitations on the expressions are those imposed by the number of inputs, outputs, and internal product terms provided by the particular PLD circuit selected. The efficiency of implementing the set of equations can be increased significantly by applying DeMorgan's theorem, and utilizing the programmable invert function on each output.

If there seems to be too few product terms to handle a relatively large equation set, one of several minimization methods can be pursued.

The probability of reducing such equations to manageable size is enhanced through the flexibility of Shared AND terms for each output function, the accessibility of all AND terms to each output, and having a programmable Invert function on each output. All of these features can be utilized by applying the manual manipulation of Venn Diagrams or Karnaugh Maps. However, the time and effort to accomplish these tasks as well as document the effort for procurement specification purposes increase the need and desire to have software programs to automatically perform such manipulations.

Many types of software programs are being developed to provide this assistance for operation on a wide range of computer hardware. This list of software is expanding rapidly, consisting of both Signetics generated software and some independent software houses' contributions.

This discussion is intended to outline the Signetics developed software program called AMAZE (**A**utomatic **M**ap **A**nd **Z**ap **E**quation **E**ntry) The AMAZE software program currently consists of five modules, BLAST ('**B**oolean **L**ogic **A**nd **S**tate **T**ransfer' entry program), PTP ('**P**AL **T**o **P**LD' conversion program), DPI ('**D**evice **P**rogrammer **I**nterface' program), PLD SIM ('**PLD Sim**ulator'' program) and the PTE ('**P**rogram **T**able **E**ditor' program). Other modules will be added when product developments require additional software tools.

It must be noted that the AMAZE program is not by any means the total extent of software available for use in designing with PLD (Programmable Logic Devices). Please contact your local Signetics representative for the latest word on the most currently available software.

Programmable Logic Development Software — AMAZE

AMAZE

Description

Automatic **M**ap **A**nd **Z**ap **E**quation **E**ntry software program. The AMAZE software program consists of the following five modules:

- **BLAST** ('**B**oolean **L**ogic **A**nd **S**tate **T**ransfer' entry program)
- **PTE** ('**P**rogram **T**able **E**ditor')
- **PTP** ('**P**AL **T**o **P**LD' conversion program)
- **DPI** ('**D**evice **P**rogrammer **I**nterface' program)
- **PLD SIM** ('**PLD Si**mulator' program)

Each module performs specific tasks as outlined in the following sections. Each AMAZE software package will be made available in various combinations of the above modules.

Features

- **Multiple modules allowing expansion for future requirements**
- **Each module designed to be user friendly**
- **Both HELP and ERROR messages**
- **Document printout: Header, Pin diagram, Boolean equation and Fuse map**
- **Interface with most commercial programmers**
- **SIMULATOR programs provide both test and applications assistance**

Equipment

- **The PC version of AMAZE is capable of operating on an IBM-PC with MS-DOS operating system and having 256K bytes of on-board RAM**
- **The VAX version of AMAZE is capable of operating on a VAX computer with VMS operating system**

Please contact your Signetics Sales Representative for availability and ordering information.

Products Supported

AMAZE will support the following products:

- **20-pin PLD:** **PLS151**, **PLS153**, **PLS153A**, **PLS155**, **PLS157**, **PLS159**, **PLHS18P8**
- **24-pin PLD:** **PLS161**, **PLS162**, **PLS163**, **PLS167**, **PLS167A**, **PLS168**, **PLS168A**, **PLS173**, **PLS179**, **PLHS473**
- **28-pin PLD:** **PLS100/101**, **PLS103**, **PLS105**, **PLS105A**

Programmable Logic Development Software — AMAZE

BLAST

Boolean **L**ogic **A**nd **S**tate **T**ransfer program is a menu driven software package that supports the engineer in implementing logic designs into Signetics Integrated Fuse Logic. It checks design data and automatically compiles a program table from Boolean and State Machine equations. Data from the program table is then used to produce a **S**tandard **F**ile which contains the fusing codes in a form acceptable to all the AMAZE modules (i.e. PLD-SIM and DPI).

BLAST reports the logic and syntax errors, and lists the equations in a Sum of Products form, which can help the user to minimize the entered logic equations. It will automatically partition State machine designs into specified devices, and then delete redundant terms during compilation.

BLAST also provides the capability of modifying a current logic set programmed into a device by overlaying new data onto unused fuses.

Features

- **Screen Menus for inputs**
- **Full compiler to perform product term manipulation**
- **Document printout: Header, Pin diagram, Boolean equation and Fuse Map, etc**

PTE

Program **T**able **E**ntry is an interactive editor which allows the logic designer to enter data into AMAZE in the form of SIGNETICS APPROVED PROGRAM TABLES. Each Signetics PLD data sheet has the program table format which applies to that devide. In addition, PTE can be used to document completed designs and to make changes in logic functions which have been previously defined in the BLAST module.

Features

- **Program Tables are exactly as defined in the Signetics PLD data sheet.**
- **Interactive with BLAST**
- **Uses standard Signetics H and L input format.**

PTP

PAL™ **T**o **P**LD is a conversion program to allow easy transfer of the various PAL20 circuits to the Signetics PLD 20 pin series circuits.

PTP can automatically upload the PAL™ pattern from a Commercial programmer, convert the pattern into a PLD pattern, and then download the PLD pattern into the programmer. The PAL™ pattern and it's corresponding PLD pattern are documented, and the PLD pattern can be directed to other AMAZE modules.

PTP can also convert the PAL™ fuse file in a HEXPLOT format.

Features

- **Automatic assembler**
- **Reduces duplicated P-Terms**

Products Supported

- **All 20 Pin PLD PLS15X Series**

DPI

Device **P**rogrammer **I**nterface is the software module that provides the interface between the Standard File created by the AMAZE modules and a commercial programmer. This module allows both download (Sending from Host to programmer) and upload (Sending from programmer into the host) operations.

DPI supports both JEDEC and Signetics H & L formats to convey fusing information to and from the highest number of commercial programmers.

Features

- **Screen Menus for inputs**
- **Provides JEDEC or Signetics H & L formats**
- **Download to commercial programmers**
- **Upload from commercial programmers**

PLD SIMULATOR

The **PLD Simulator** program is a software package that simulates the operation of the logic that has been defined for Signetics PLD products. The input to the program is the Standard File generated by other AMAZE modules. The simulator has the capability of running manually or automatically. In the automatic mode the simulator creates a file of test vectors that can be used to test the programmed devices. In the manual mode the program will allow the operator to assigned an input vector and observe the resultant output.

Features

- **Simple Input Form**
- **Test Vector Generation (on Rev. D or later)**
- **Output can be used as input to PLD fault grader**
- **Software Applications Support prior to device programming**

AMAZE INFORMATION

P/N	Hardware Requirements
82SOFT523-SS	IBM-PC or IBM-XT or compatible computer 256K Memory PC-DOS Operating System Version 2.0 or higher. 2 Floppy Disk Drives or 1 Floppy and 1 Hard disk
82SOFT211-SS	VAX Series Computer VMS operating system – all revisions.

AMAZE comes fully documented with appropriate magnetic media. Applications support is provided by Signetics Field Application Engineers in most areas. Contact the Sales Office in your area for information on AMAZE and Signetics Programmable Logic Products.

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PALASM is a trademark of Monolithic Memories, Inc.

Signetics

Application Specific Products

Section 9
Application Notes

INDEX

Signetics

AN7
Single Chip Multiprocessor Arbiter

Application Note

Application Specific Products

INTRODUCTION

In multiprocessor environments there is considerable savings to be made through sharing system resources. If each processor must support its own bus structure, I/O devices, and bulk storage medium, system cost could be very high. In the configuration shown in Figure 1, all processors share a common communication bus, and a number of system resources.

Since every processor must use the common system bus to communicate with its peripherals, a priority structure that resolves simultaneous processor bus requests into a single bus grant must be integrated into the system. In addition to making request-grant transactions, transient bus contention due to grant switching must be removed by inserting precise guard band times between bus grants.

Signetics' Field Programmable Logic Sequencer provides a convenient and cost-effective means for implementing a synchronous arbiter to perform these tasks within a single chip.

ARBITER STRUCTURE

Within a multiprocessor system, two general classes of processors can be recognized: Priority A and Priority b. Priority A processors have the highest request priority and must only compete with other Priority A processors for bus control. The arbiter must issue "A" grants in manner that prevents any high priority "A" processor from locking out another Priority A processor. To enable this, the Priority A rules implemented here use a Last Granted Lowest Priority (LGLP) ring structure. After an "A" processor has completed a bus-related task, its next arbitrated request priority will be lowest in the "A" request group. The previously second highest priority "A" processor will then become highest priority requester. The net effect of the "round robin" exchange is that every Priority A processor will have a turn at being highest priority processor. Priority A processors are typically ones that perform real-time operations or vital system tasks.

Priority b processors are lower in priority than the "A's" and may only be granted system control when no "A" requests are pending. "b" processors usually perform background tasks. Within the Priority b group, further priority ordering exists such that each "b" processor has a fixed priority position.

Plumber[1], Pearce[2], and Hojberg[3] present asynchronous techniques of arbiter implementation. These methods all have hard-wired priority rules and imprecise guard band times during grant switching. As pointed out by Hojberg, a synchronous state machine can be configured as a Mealy-type controller to provide not only precise guard band times and programmable priority rules, but also programmable input/output polarity. The state machine in Figure 2 is made from a control PROM array and an edge-triggered latch. The "A" and "b" requests and the machine's present state are used by the control PROM to determine the next "A" and "b" grants and the next state.

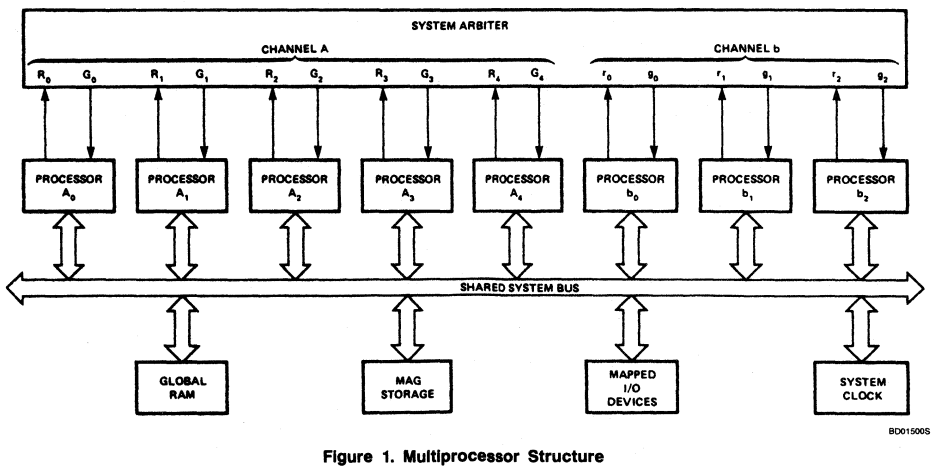
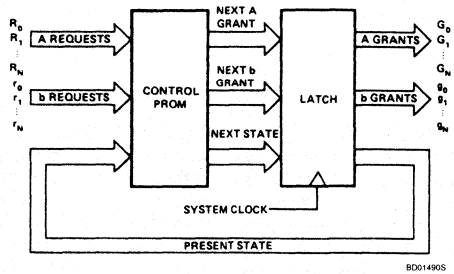
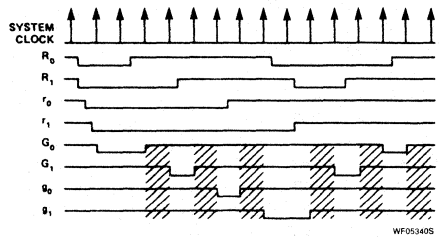


Figure 1. Multiprocessor Structure

Single Chip Multiprocessor Arbiter AN7



a. A and b service requests (R_N, r_N) plus the present state determine, through the control PROM, the next state and the next grant outputs (G_N, g_N).



b. Requests R_0, R_1, r_0, and r_1 are asserted low in the same clock sample period. The priority rules that determine the order in which the grants are issued and the shaded guard-band areas are programmed into the control PROM. Note that the A and b request lines and the present state input to the PROM must have a set-up time equal or greater than the latch set-up time plus the PROM access time.

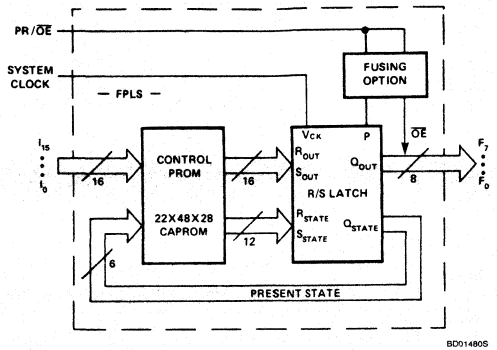
Figure 2. Arbiter Constructed From A Mealy-Type State Machine

SYSTEM OPERATION

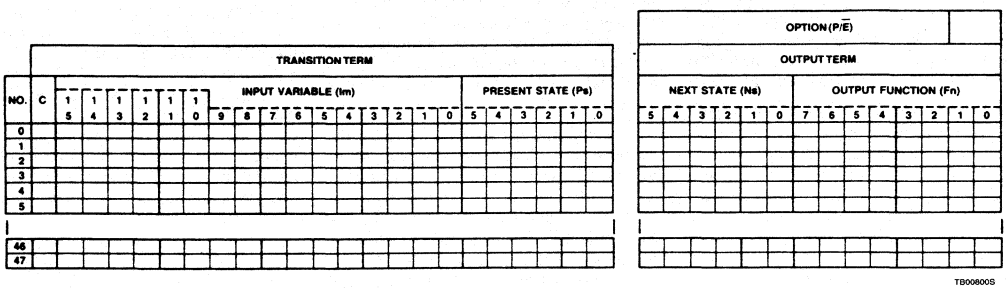
Two machine states can be identified by inspection: a wait state and a grant state. The state machine enters a grant state as a response to a system request on either R_N or r_N. The machine will remain in this state with a single grant line asserted as long as the request remains asserted. Upon releasing the request line, the machine will pass through a single wait state before considering other pending requests. This provides a single state guard band time. The requests received must meet the set-up requirement of the edge-triggered latch after propagating through the control PROM. If these time considerations do not fit within a given multiprocessor structure, an input latch may be added such that the R_N and r_N lines are clocked through the latch by the system clock, thereby removing asynchronous set-up time considerations. On the basis of a state machine approach, two techniques of implementation are feasible: 1) using an architecturally advanced single IC controller, the FPLS, and, 2) a traditional PROM/LATCH configuration.

Single Chip Multiprocessor Arbiter

AN7



a. FPLS Single Chip System



b. FPLS Standard Program Table

CK	S	R	Q
↑	0	0	Q
↑	0	1	0
↑	1	0	1
↑	1	1	Undefined

NOTE:
(↑) denotes positive clock transition. S = R = 1 is an illegal input condition.

c. Transition Table Of Clocked S/R Flip-flop

Figure 3

FPLS ARBITER IMPLEMENTATION

A five Priority "A" and three Priority "b" arbiter will be constructed such that all grant outputs will be asserted low for grants and all request inputs will be asserted low for system requests.

Brief FPLS Description

The FPLS block diagram shown in Figure 3(a) consists of a control PLA and 14 clocked S/R flip-flops. The control PLA is actually an AND-OR logic array that functions as a Content Addressable PROM. The PLA is organized as 48 words of 28 bits with 16 external input lines, and six internal inputs fed back from the State Register. The 28 PLA outputs drive the S/R inputs of the six-bit State Register and eight-bit Output Register. Note that the state feedback path is made inside the FPLS.

I_N and present state inputs, P_S, represent 2^{22} possible input codes; 48 of these codes may be mapped in the PLA to provide a 14 bit register control word. As shown in Figure 3(b) each input code may be specified by assigning to the variables either Low "L", High "H", or Don't Care "-" logic states. If any input code falls logically outside the programmed codes, the PLA asserts a Low on all its 28 internal outputs, thereby issuing a "no change" command to the R/S flip-flops.

This is an important architectural feature because it requires that only state or output transition terms be programmed. Looping terms that change neither state nor output need not be programmed in the FPLS, owing to the functional characteristics of S/R flip-flops tabulated in Figure 3(c). An example of this is shown in Figure 4.

The S/R inputs of both state and output registers are specified by using PLA outputs ("AND" functions of request inputs and present state) in the program table of Figure 3(c).

Single Chip Multiprocessor Arbiter

AN7

The corresponding next state of each bit will be set to 0 for "L", 1 for "H", and No Change for "-". The FPLS's PR/OE line may be assigned either Asynchronous Preset or Output Enable functions, via a user programmable option.

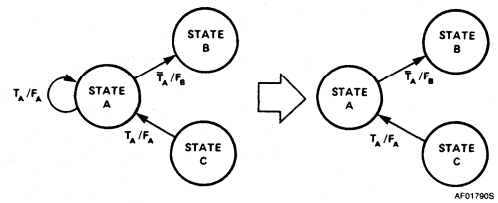
The entire function is integrated into a single 28-pin package designated as PLS105.

State Algorithm

Figure 5(a) displays the circular state form and all possible state transitions of the LGLP priority structure. Hex states 3F, 3E, 3D, 3C, and 3B are arbiter wait states W_{0-4}. In these states, processor "A" and "b" requests are monitored. Figure 5(b) illustrates a typical grant to processor A_1 in hex state 07. As long as A_1 asserts its request line low, the next state will be 07_{16} and the next output will remain with G_1 asserted low and all the other grant outputs asserted high. Since no change in state or grant output results from this transition, no PLA resources are required.

As soon as processor A_1 returns its request line, R_1, to 1, a state transition is made to 3D, and an output transition is made to set all grant outputs to 1. Since processor A_1 was the last to be granted system resources, it will now have the lowest A level request priority (LGLP). In wait state W_2, the highest priority processor will be A_2, second A_3, third A_4, and fourth A_0. To maintain the LGLP rule, grant transitions must follow the state rule $G_N \rightarrow W_{(N+1)}$, and wait states, W_M, must set their "A" priorities so that processor A_M is highest priority. Priority decreases as one proceeds clockwise around the state ring to the lowest priority processor, $A_{(m-1)}$.

When no "A" requests are pending, "b" requests may be granted. To avoid upsetting the LGLP priority rule, a "b" grant must leave and return to the same wait state. Since the "b" priority structure is the same regardless of the wait state, only a single set of "b" transition terms are required.



NOTE:
T_N/F_N = Inputs/outputs.
The FPLS requires that only two out of the three transition terms be programmed.

Figure 4. FPLS State And Output Transitions

For example, a grant transition to g_2 (Hex 20 – 25) can be issued only if there are no "A", "b_0", or "b_1" requests pending. Given the binary wait state code 111XXX, where "X's" represent Don't Cares, a request code of 01111111 will transfer the arbiter to the grant state g_2 from any of the wait states, W_{0-4}.

It is important to realize that in making this transition, the lower three-state bits will not be changed — they provide the wait state return address. When r_2 returns high, 1XXXXXXX, a transition back to the previously exited wait state is made by forcing a "1" in the three most significant state bits and leaving the lower three-state bits unchanged.

All output and state bits are initially preset to "1" through the use of the optional preset function. Grant output lines are only forced low when transitions are made to grant states and are returned to "1" when jumping back to a wait state.

Table 1 provides the complete arbiter program. The complete arbiter circuit diagram is shown in Figure 6. The AMAZE equations are shown in Figure 7.

PROM/LATCH IMPLEMENTATION

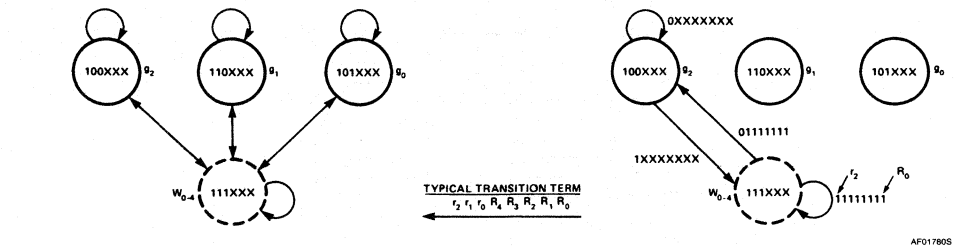
The same five "A" processor and three "b" processor arbiter can be implemented with discrete PROM's and Latches using the same state diagrams for the FPLS, except that now looping transition terms must be programmed. Coding of all state and output transitions requires programming of two memory fields: the "A" request PROM's (2KX6) and the "b" request PROM (64 x 3). The complete circuit diagram is shown in Figure 6(b).

The "A" request PROM's determine the next machine state (N_{0-5}) at all times, except when there are no "A" requests pending and there is a "b" request, or if the machine is presently in a "b" grant state. In these cases, the "b" request PROM controls the machine's next state.

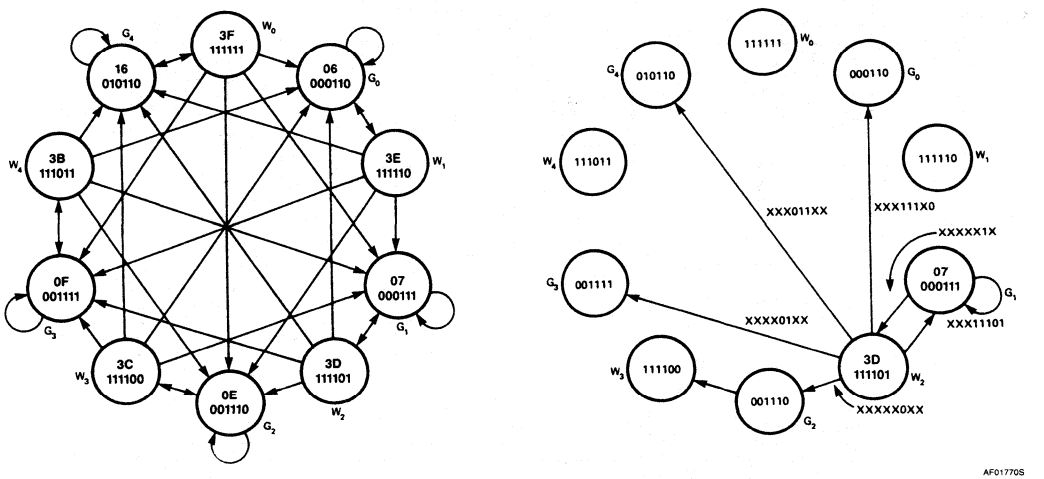
The grant control lines are decoded from the next state lines and latched in two quad output latches. This PROM/LATCH organization is conceptually the same as that shown in Figure 2.

Single Chip Multiprocessor Arbiter

AN7



a.

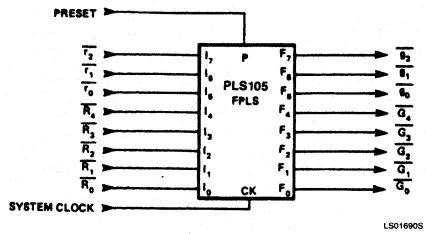


b.

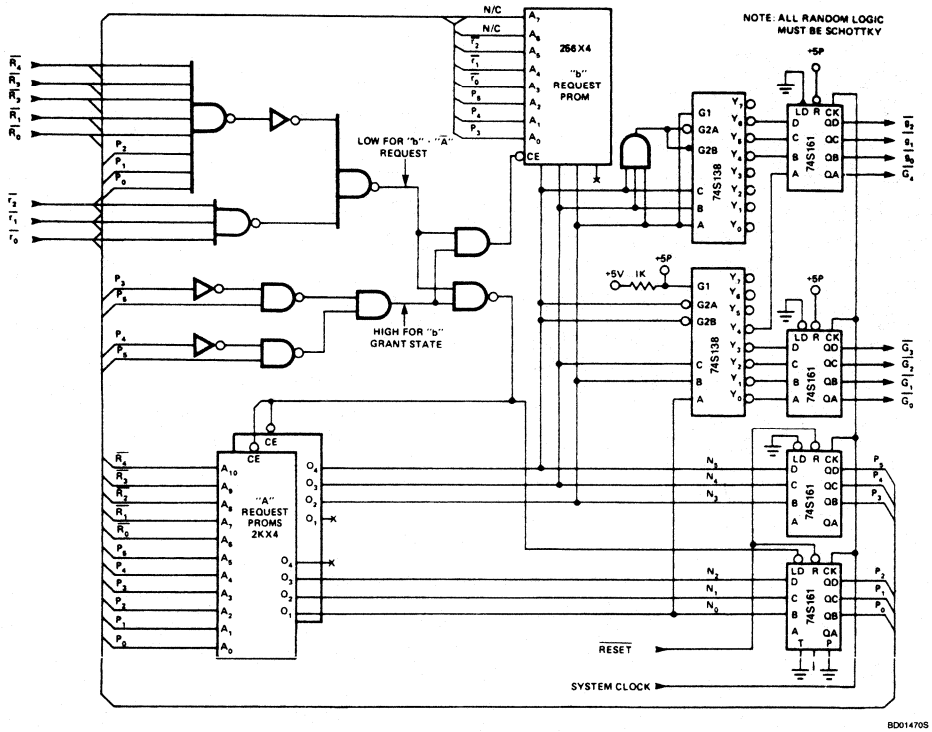
Figure 5. Arbiter State Transition Diagram

Single Chip Multiprocessor Arbiter

AN7



a.



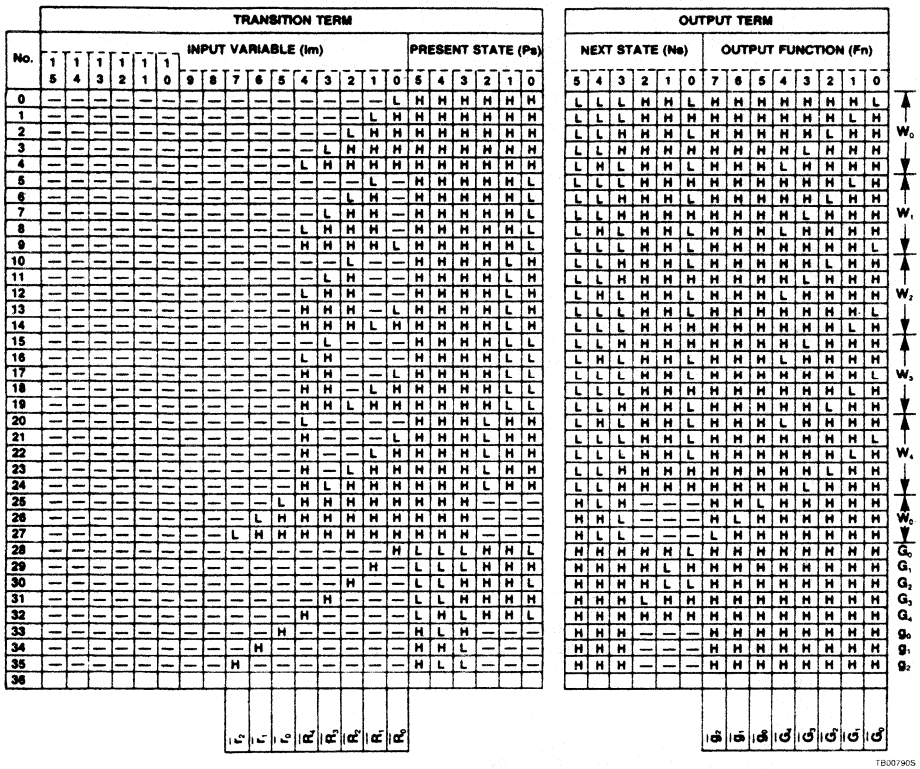
b.

Figure 6. Arbiter Circuit Diagram Summary

Single Chip Multiprocessor Arbiter

AN7

Table 1. FPLS Program Table for Priority Arbiter



No.	TRANSITION TERM: INPUT VARIABLE (Im) 15 14 13 12 11 10 9 8 7 6 5 4 3 2 1 0	TRANSITION TERM: PRESENT STATE (Pn) 5 4 3 2 1 0	OUTPUT TERM: NEXT STATE (Ns) 5 4 3 2 1 0	OUTPUT TERM: OUTPUT FUNCTION (Fn) 7 6 5 4 3 2 1 0
0	— — — — — — — — — — — — — — L	H H H H H H	L L L H H L	H H H H H H H L
1	— — — — — — — — — — — — — L H	H H H H H H	L L L H H H	H H H H H L H H
2	— — — — — — — — — — — — L H H	H H H H H H	L L H H H L	H H H H L H H W0
3	— — — — — — — — — — — L H H H	H H H H H H	L L H H H H	H H H H L H H H
4	— — — — — — — — — — L H H H H	H H H H H H	L H L H H L	H H H L H H H H
5	— — — — — — — — — — — — — L —	H H H H H L	L L L H H H	H H H H H H L H
6	— — — — — — — — — — — — L H —	H H H H H L	L L H H H L	H H H H L H H
7	— — — — — — — — — — — L H H —	H H H H H L	L L H H H H	H H H L H H H W1
8	— — — — — — — — — — L H H H —	H H H H H L	L H L H H L	H H H L H H H H
9	— — — — — — — — — — H H H H L	H H H H H L	L L L H H L	H H H H H H H L
10	— — — — — — — — — — — — L — —	H H H H H L	L L H H H L	H H H H L H H
11	— — — — — — — — — — — L H — —	H H H H L H	L L H H H H	H H H L H H H
12	— — — — — — — — — — L H H — —	H H H H L H	L H L H H L	H H H L H H H W2
13	— — — — — — — — — — H H H — L	H H H H L H	L L L H H L	H H H H H H L H
14	— — — — — — — — — — H H H L H	H H H H L H	L L L H H H	H H H H H L H
15	— — — — — — — — — — — L — — —	H H H H H L	L L H H H H	H H H L H H H
16	— — — — — — — — — — L H — — —	H H H H H L	L H L H H L	H H H L H H H W3
17	— — — — — — — — — — H H — — L	H H H H L H	L L L H H L	H H H H H H L H
18	— — — — — — — — — — H H — L H	H H H H L H	L L L H H H	H H H H H L H
19	— — — — — — — — — — H H L H H	H H H H L H	L L H H H L	H H H H L H H
20	— — — — — — — — — — L — — — —	H H H H L H	L H L H H L	H H H L H H H
21	— — — — — — — — — — H — — — L	H H H H L H	L L L H H L	H H H H H H L W4
22	— — — — — — — — — — H — — L H	H H H H L H	L L L H H H	H H H H H L H
23	— — — — — — — — — — H — L H H	H H H H L H	L L H H H H	H H H H L H H
24	— — — — — — — — — — H L H H H	H H H H L H	L L H H H H	H H H H L H H
25	— — — — — — — — — L H H H H H	H H H H — — —	H L H — — —	H H L H H H H H
26	— — — — — — — — L H H H H H H	H H H H — — —	H H L — — —	H L H H H H H W0
27	— — — — — — — — L H H H H H H	H H H H — — —	H L L — — —	L H H H H H H H
28	— — — — — — — — — — — — — — H	L L L H H L	H H H H H H	H H H H H H H G0
29	— — — — — — — — — — — — — H —	L L L H H H	H H H H H H	H H H H L H H G1
30	— — — — — — — — — — — — H — —	L L H H H L	H H H H H H	H H H H L H H G2
31	— — — — — — — — — — — H — — —	L L H H H H	H H H L H H	H H H H L H H G3
32	— — — — — — — — — — H — — — —	L H L H H L	H H H H H H	H H H H H H H G4
33	— — — — — — — — — H — — — — —	H L H — — —	H H H H H H	H H H H H H H g0
34	— — — — — — — — H — — — — — —	H H L — — —	H H H H H H	H H H H H H H g1
35	— — — — — — — — H — — — — — —	H L L — — —	H H H H H H	H H H H H H H g2
36				

TB00790S

```
 ******************** ARBITERS ********************
@DEVICE SELECTION
ARBITERB/82S105
@STATE VECTORS
[ FF5, FF4, FF3, FF2, FF1, FF0 ]
W0  = 03Fh ;
W1  = 03Eh ;
W2  = 03Dh ;
W3  = 03Ch ;
W4  = 03Bh ;
W04 = 111---b ;
GA0 = 06h ;
GA1 = 07h ;
GA2 = 0Eh ;
GA3 = 0Fh ;
GA4 = 16h ;
GB0 = 101---b ;
GB1 = 110---b ;
GB2 = 100---b ;

@INPUT VECTORS
@OUTPUT VECTORS
[OB2, OB1, OB0, OA4, OA3, OA2, OA1, OA0]
QA0' = FEh ;
QA1' = FDh ;
QA2' = FBh ;
QA3' = F7h ;
QA4' = EFh ;
QB0' = DFh ;
QB1' = BFh ;
QB2' = 7Fh ;
NOGRANT' = FFh ;

@TRANSITIONS
WHILE [W0]
  CASE
    [/RA0] :: [GA0] WITH [QA0']
    [/RA1 * RA0] :: [GA1] WITH [QA1']
    [/RA2 * RA1 * RA0] :: [GA2] WITH [QA2']
    [/RA3 * RA2 * RA1 * RA0] :: [GA3] WITH [QA3']
    [/RA4 * RA3 * RA2 * RA1 * RA0] :: [GA4] WITH [QA4']
  ENDCASE

WHILE [W1]
  CASE
    [/RA1] :: [GA1] WITH [QA1']
    [/RA2 * RA1] :: [GA2] WITH [QA2']
    [/RA3 * RA2 * RA1] :: [GA3] WITH [QA3']
    [/RA4 * RA3 * RA2 * RA1] :: [GA4] WITH [QA4']
    [/RA0 * RA4 * RA3 * RA2 * RA1] :: [GA0] WITH [QA0']
  ENDCASE
```

TB00750S

a. Arbiter State Equations

Figure 7

```
WHILE [W2]
  CASE
    [/RA2] :: [GA2] WITH [QA2']
    [/RA3 * RA2] :: [GA3] WITH [QA3']
    [/RA4 * RA3 * RA2] :: [GA4] WITH [QA4']
    [/RA0 * RA4 * RA3 * RA2] :: [GA0] WITH [QA0']
    [/RA1 * RA0 * RA4 * RA3 * RA2] :: [GA1] WITH [QA1']
  ENDCASE

WHILE [W3]
  CASE
    [/RA3] :: [GA3] WITH [QA3']
    [/RA4 * RA3] :: [GA4] WITH [QA4']
    [/RA0 * RA4 * RA3] :: [GA0] WITH [QA0']
    [/RA1 * RA0 * RA4 * RA3] :: [GA1] WITH [QA1']
    [/RA2 * RA1 * RA0 * RA4 * RA3] :: [GA2] WITH [QA2']
  ENDCASE

WHILE [W4]
  CASE
    [/RA4] :: [GA4] WITH [QA4']
    [/RA0 * RA4] :: [GA0] WITH [QA0']
    [/RA1 * RA0 * RA4] :: [GA1] WITH [QA1']
    [/RA2 * RA1 * RA0 * RA4] :: [GA2] WITH [QA2']
    [/RA3 * RA2 * RA1 *RA1 * RA4] :: [GA3] WITH [QA3']
  ENDCASE

WHILE [W04]
  CASE
    [/RB0 * RA4 * RA3 * RA2 * RA1 * RA0] :: [GB0] WITH [QB0']
    [/RB1 * RB0 * RA4 * RA3 * RA2 * RA1 * RA0] :: [GB1] WITH [QB1']
    [/RB2 * RB1 * RB0 * RA4 * RA3 * RA2 * RA1 * RA0] :: [GB2] WITH [QB2']
  ENDCASE

WHILE [GA0]
  IF [RA0] THEN [W1] WITH [NOGRANT']

WHILE [GA1]
  IF [RA1] THEN [W2] WITH [NOGRANT']

WHILE [GA2]
  IF [RA2] THEN [W3] WITH [NOGRANT']

WHILE [GA3]
  IF [RA3] THEN [W4] WITH [NOGRANT']

WHILE [GA4]
  IF [RA4] THEN [W0] WITH [NOGRANT']

WHILE [GB0]
  IF [RB0] THEN [GB1] WITH [NOGRANT']

WHILE [GB1]
  IF [RB1] THEN [GB2] WITH [NOGRANT']

WHILE [GB2]
  IF [RB2] THEN [GB0] WITH [NOGRANT']
```

TB00751S

a. Arbiter State Equations (Continued)

Figure 7 (Continued)

9

```
********************* ARBITERB *********************
######################## P I N   L I S T ########################

   LABEL     ** FNC **PIN --------- PIN** FNC **     LABEL
CLOCK        ** CK  **  1-|         |-28 ** +5V **VCC
RB2          ** I   **  2-|         |-27 ** I   **N/C
RB1          ** I   **  3-|         |-26 ** I   **N/C
RB0          ** I   **  4-|    8    |-25 ** I   **N/C
RA4          ** I   **  5-|    2    |-24 ** I   **N/C
RA3          ** I   **  6-|    S    |-23 ** I   **N/C
RA2          ** I   **  7-|    1    |-22 ** I   **N/C
RA1          ** I   **  8-|    0    |-21 ** I   **N/C
RA0          ** I   **  9-|    5    |-20 ** I   **N/C
OB2          ** O   ** 10-|         |-19 ** PR  **PRESET
OB1          ** O   ** 11-|         |-18 ** O   **OA0
OB0          ** O   ** 12-|         |-17 ** O   **OA1
OA4          ** O   ** 13-|         |-16 ** O   **OA2
GND          ** 0V  ** 14-|         |-15 ** O   **OA3
                          ----------
```

TB007805

b. Arbiter Pin List

```
******************** ARBITERB ********************
@DEVICE TYPE
82S105
@DRAWING
************ MULTI-PROCESSOR BUS ARBITOR
@REVISION
************ ARBITERB REV. 0
@DATE
************ JULY 26, 1985
@SYMBOL
************ ARBITERB
@COMPANY
************ SIGNETICS
@NAME
************ DAVID K. WONG
@DESCRIPTION
@INTERNAL SR FLIP FLOP LABELS
FF0 FF1 FF2 FF3 FF4 FF5

@COMMON PRODUCT TERM
@COMPLEMENT ARRAY
@LOGIC EQUATION
```

TB00770S

c. Arbiter Boolean Equations

Figure 7 (Continued)

Table 2. Arbiter Program Table

```
********************** ARBITERB **********************
Cust/Project - ************* DAVID K. WONG
Date         - ************* JULY 26, 1985
Rev/I. D.    - ************* ARBITERB REV. 0

82S105
___                                                    ------------------------------------------
 T !                                                  !              OPTION P/E          !H!
 E !------------------------------------------------------------------------------------------
 R ! !               INPUT VARIABLE        !PRESENT ST ! NEXT ST    !      OUTPUT         !
 M !C!1 1 1 1 1 1 ------------------------------------------------------------------------
___!_!5_4_3_2_1_0_9_8_7_6_5_4_3_2_1_0!5_4_3_2_1_0!5_4_3_2_1_0!7_6_5_4_3_2_1_0!
  0!A!- - - -,- - - -,- - - -,- - - L!H H,H H H H!L L,L H H L!H H H H,H H H L!
  1!A!- - - -,- - - -,- - - -,- - L H!H H,H H H H!L L,L H H H!H H H H,H H L H!
  2!A!- - - -,- - - -,- - - -,- L H H!H H,H H H H!L L,H H H L!H H H H,H L H H!
  3!A!- - - -,- - - -,- - - -,L H H H!H H,H H H H!L L,H H H H!H H H H,L H H H!
  4!A!- - - -,- - - -,- - - L,H H H H!H H,H H H H!L H,L H H L!H H H L,H H H H!
  5!A!- - - -,- - - -,- - - -,- - L -!H H,H H H L!L L,L H H H!H H H H,H H L H!
  6!A!- - - -,- - - -,- - - -,- L H -!H H,H H H L!L L,H H H L!H H H H,H L H H!
  7!A!- - - -,- - - -,- - - -,L H H -!H H,H H H L!L L,H H H H!H H H H,L H H H!
  8!A!- - - -,- - - -,- - - L,H H H -!H H,H H H L!L H,L H H L!H H H L,H H H H!
  9!A!- - - -,- - - -,- - - H,H H H L!H H,H H H L!L L,L H H L!H H H H,H H H L!
 10!A!- - - -,- - - -,- - - -,- L - -!H H,H H L H!L L,H H H L!H H H H,H L H H!
 11!A!- - - -,- - - -,- - - -,L H - -!H H,H H L H!L L,H H H H!H H H H,L H H H!
 12!A!- - - -,- - - -,- - - L,H H - -!H H,H H L H!L H,L H H L!H H H L,H H H H!
 13!A!- - - -,- - - -,- - - H,H H - L!H H,H H L H!L L,L H H L!H H H H,H H H L!
 14!A!- - - -,- - - -,- - - H,H H L H!H H,H H L H!L L,L H H H!H H H H,H H L H!
 15!A!- - - -,- - - -,- - - -,L - - -!H H,H H L L!L L,H H H H!H H H H,L H H H!
 16!A!- - - -,- - - -,- - - L,H - - -!H H,H H L L!L H,L H H L!H H H L,H H H H!
 17!A!- - - -,- - - -,- - - H,H - - L!H H,H H L L!L L,L H H L!H H H H,H H H L!
 18!A!- - - -,- - - -,- - - H,H - L H!H H,H H L L!L L,L H H H!H H H H,H H L H!
 19!A!- - - -,- - - -,- - - H,H L H H!H H,H H L L!L L,H H H L!H H H H,H L H H!
 20!A!- - - -,- - - -,- - - L,- - - -!H H,H L H H!L H,L H H L!H H H L,H H H H!
 21!A!- - - -,- - - -,- - - H,- - - L!H H,H L H H!L L,L H H L!H H H H,H H H L!
 22!A!- - - -,- - - -,- - - H,- - L H!H H,H L H H!L L,L H H H!H H H H,H H L H!
 23!A!- - - -,- - - -,- - - H,- L H H!H H,H L H H!L L,H H H L!H H H H,H L H H!
 24!A!- - - -,- - - -,- - - H,L H H -!H H,H L H H!L L,H H H H!H H H H,L H H H!
 25!A!- - - -,- - - -,- - L H,H H H H!H H,H - - -!H L,H - - -!H H L H,H H H H!
 26!A!- - - -,- - - -,- L H H,H H H H!H H,H - - -!H H,L - - -!H L H H,H H H H!
 27!A!- - - -,- - - -,L H H H,H H H H!H H,H - - -!H L,L - - -!L H H H,H H H H!
 28!A!- - - -,- - - -,- - - -,- - - H!L L,L H H L!H H,H H H L!H H H H,H H H H!
 29!A!- - - -,- - - -,- - - -,- - H -!L L,L H H H!H H,H H L H!H H H H,H H H H!
 30!A!- - - -,- - - -,- - - -,- H - -!L L,H H H L!H H,H H L L!H H H H,H H H H!
 31!A!- - - -,- - - -,- - - -,H - - -!L L,H H H H!H H,H L H H!H H H H,H H H H!
 32!A!- - - -,- - - -,- - - H,- - - -!L H,L H H L!H H,H H H H!H H H H,H H H H!
 33!A!- - - -,- - - -,- - H -,- - - -!H L,H - - -!H H,L - - -!H H H H,H H H H!
 34!A!- - - -,- - - -,- H - -,- - - -!H H,L - - -!H L,L - - -!H H H H,H H H H!
 35!A!- - - -,- - - -,H - - -,- - - -!H L,L - - -!H L,H - - -!H H H H,H H H H!
 36!0!0 0 0 0,0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0!0 0,0 0 0 0!0 0 0 0,0 0 0 0!
 37!0!0 0 0 0,0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0!0 0,0 0 0 0!0 0 0 0,0 0 0 0!
 38!0!0 0 0 0,0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0!0 0,0 0 0 0!0 0 0 0,0 0 0 0!
 39!0!0 0 0 0,0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0!0 0,0 0 0 0!0 0 0 0,0 0 0 0!
 40!0!0 0 0 0,0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0!0 0,0 0 0 0!0 0 0 0,0 0 0 0!
 41!0!0 0 0 0,0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0!0 0,0 0 0 0!0 0 0 0,0 0 0 0!
 42!0!0 0 0 0,0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0!0 0,0 0 0 0!0 0 0 0,0 0 0 0!
 43!0!0 0 0 0,0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0!0 0,0 0 0 0!0 0 0 0,0 0 0 0!
 44!0!0 0 0 0,0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0!0 0,0 0 0 0!0 0 0 0,0 0 0 0!
 45!0!0 0 0 0,0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0!0 0,0 0 0 0!0 0 0 0,0 0 0 0!
 46!0!0 0 0 0,0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0!0 0,0 0 0 0!0 0 0 0,0 0 0 0!
 47!0!0 0 0 0,0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0!0 0,0 0 0 0!0 0 0 0,0 0 0 0!

     N N N N N N N N R R R R R R R R F F F F F F F F F F F F 0 0 0 0 0 0 0 0
     / / / / / / / / B B B A A A A A F F F F F F F F F F F F B B B A A A A A
     C C C C C C C C 2 1 0 4 3 2 1 0 5 4 3 2 1 0 5 4 3 2 1 0 2 1 0 4 3 2 1 0
```

TB00780S

9

Single Chip Multiprocessor Arbiter AN7

SUMMARY

As can be seen from the circuit diagrams, the FPLS can offer significant advantages over discrete MSI arrays in the design of state machines. The tradeoff in both design alternatives for the Priority Arbiter is shown in Table 2. Clearly, the FPLS approach uses fewer parts, with savings in PC board space and power requirements.

Table 3. Design Alternatives for the Priority Arbiter

PARAMETER	F.P.L.S.	PROM/LATCH
Parts count	1 IC	≈19IC's
PCB space	.84 in^2	7.92 in^2
Power	.65W	2.85W
Voltage	+5V	+5V

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2. R.C. Pearce, J.A. Field, and W.D. Little: "Asynchronous Arbiter Module"; *IEEE Transactions on Computers,* September 1975, pp. 931 – 933.
3. K. Soe Hojberg: "An Asynchronous Arbiter Resolves Resource Allocation Conflicts on a Random Priority Basis"; *Computer Design,* August 1977, pp. 120 – 123.
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Signetics

AN8
Introduction To Signetics Programmable Logic

Application Note

Application Specific Products

Author: K. A. H. Noach

INTRODUCTION

Custom logic is expensive – too expensive if your production run is short. 'Random logic' is cheaper but occupies more sockets and board space. Signetics Programmable Logic bridges the gap. Using PLD, you can configure an off-the-shelf chip to perform just the logic functions you need. Design and development times are much shorter, and risk much lower than for custom logic. Connections are fewer than for random logic, and, for all but the simplest functions, propagation delay is usually shorter. Yet another advantage that PLD has over custom logic is that it allows you to redesign the functions without redesigning the chip – giving you an invaluable margin not only for cut-and-try during system development, but also for later revision of system design. You're not tied down by the need to recover capital invested in a custom chip.

A PLD chip is an array of logic elements – gates, inverters, and flip-flops, for instance. In the virgin state, everything is connected to everything else by nichrome fuses, and although the chip has the capacity to perform an extensive variety of logic functions, it doesn't have the ability to. What gives it that is programming: selectively blowing undesired fuses so that those that remain provide the interconnections necessary for the required functions.

Signetics Series 20 PLD, named for the number of pins, supplements the well-known Series 28. The package is smaller – little more than a third the size, in fact – but the improved architecture, with user-programmable shared I/O. compensates for the fewer pins. The series comprises the following members, in order of increasing complexity:

- **PLS151 – field-programmable gate array**
- **PLS153 – field-programmable logic array**
- **PLS155 – field-programmable logic sequencer**
- **PLS157 – field-programmable logic sequencer**
- **PLS159 – field-programmable logic sequencer**

Entry to all the devices is via a product matrix, an array of input and shared I/O lines fuse-connected to the multiple inputs of an array of AND gates (see Figures 1, 2 and 5). To exploit the capacity of any device, it is important to make the most economical use of the AND gates it has available. Application of de Morgan's theorem can help in this. For example, inputs for the function

$$F = A + B + C + D$$

would occupy four of the AND gates of the product matrix. However, the same function rewritten as

$$\overline{F} = \overline{A}\,\overline{B}\,\overline{C}\,\overline{D}$$

would occupy only one. Moreover, the second function could be done on the simplest of the Series 20 devices (*and* leave eleven gates over for other functions), whereas the first could not. The fact that all inputs of the Series 20 devices, including the shared ones, incorporate double buffers that make the true and complement forms of all input variables equally accessible, greatly facilitates the use of de Morgan's theorem for logic minimization.

To convert the minimized logic equations to the pattern of fuses to be blown, you can use either a programming sheet (see e.g. Table 1) or Boolean equation program-entry software that lets you enter the equations via the keyboard of a terminal. The direct programmability of logic equations makes system design with PLD simple and sure. Functional changes can be made by replacing one PLD chip by another differently programmed. In many cases you can even remove the original one, reprogram it on the spot, and re-insert it. Programming machines qualified for the Series 20 are at present available from DATA I/O, KONTRON, and STAG.

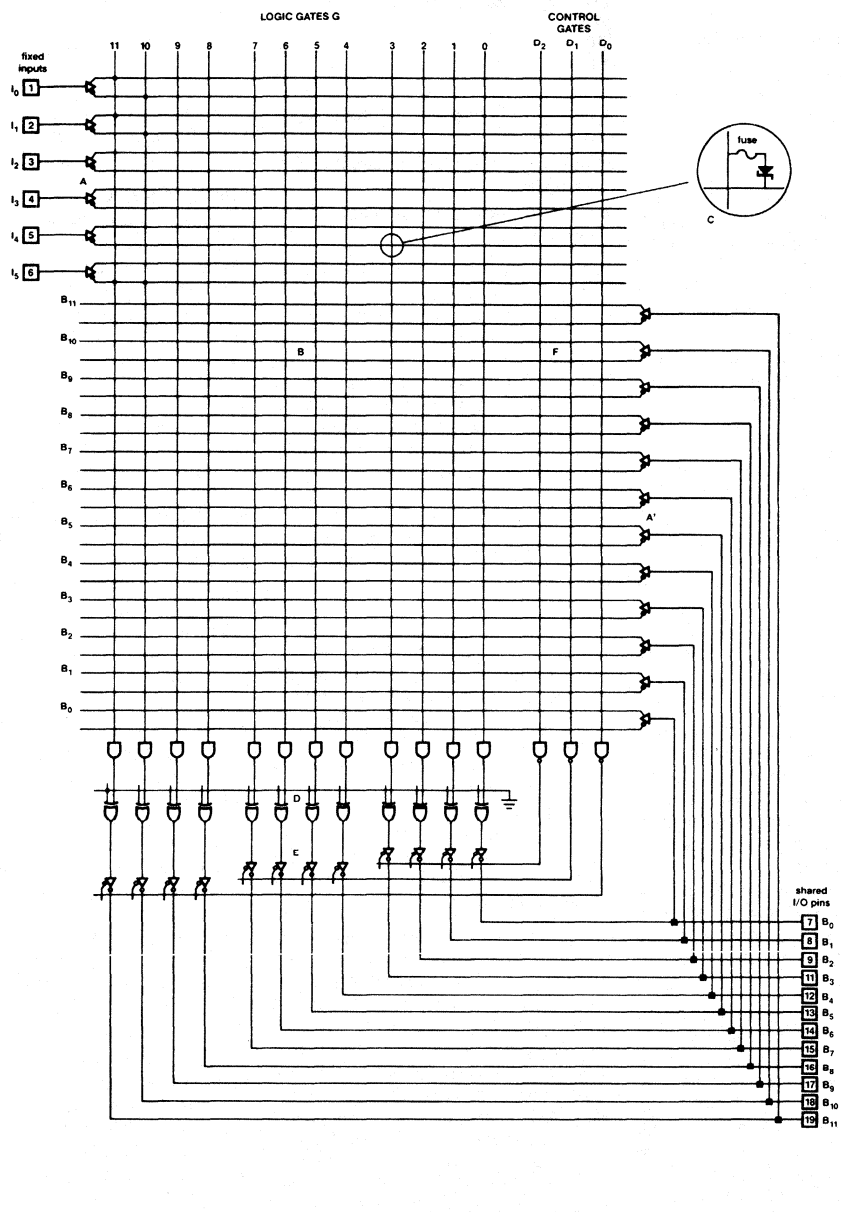
FPGA PLS151

The field-programmable gate array is the simplest of the Series 20 PLD devices; Figure 1 shows the functional diagram. The array can accept up to 18 inputs. There are six dedicated input pins (A) and twelve (A') that can be programmed as inputs, outputs, or bidirectional I/O. All input variables, whether on dedicated or programmed input pins, are available in both true and complement form in the product matrix (B), and both forms are buffered: either form can drive all 12 product lines if required. In the virgin state, all the input variables and their complements are connected to all the product lines via a diode and a fuse (C), and the product matrix is effectively inoperative. To enable it to generate the required functions, unrequired connections between individual input lines and product lines are severed by blowing the connecting fuses.

At the output of the product matrix are 12 NAND gates, each with 36 inputs to accommodate the 18 possible input variables and their complements. Each of the product terms is normally active-Low, but a unique feature of Signetics PLD is that any or all of them can be independently programmed active-High. This is done by means of an array of exclusive-OR gates (D) at the NAND-gate outputs; when the fuse that grounds the second input of each OR gate is blown, the output of that gate is inverted.

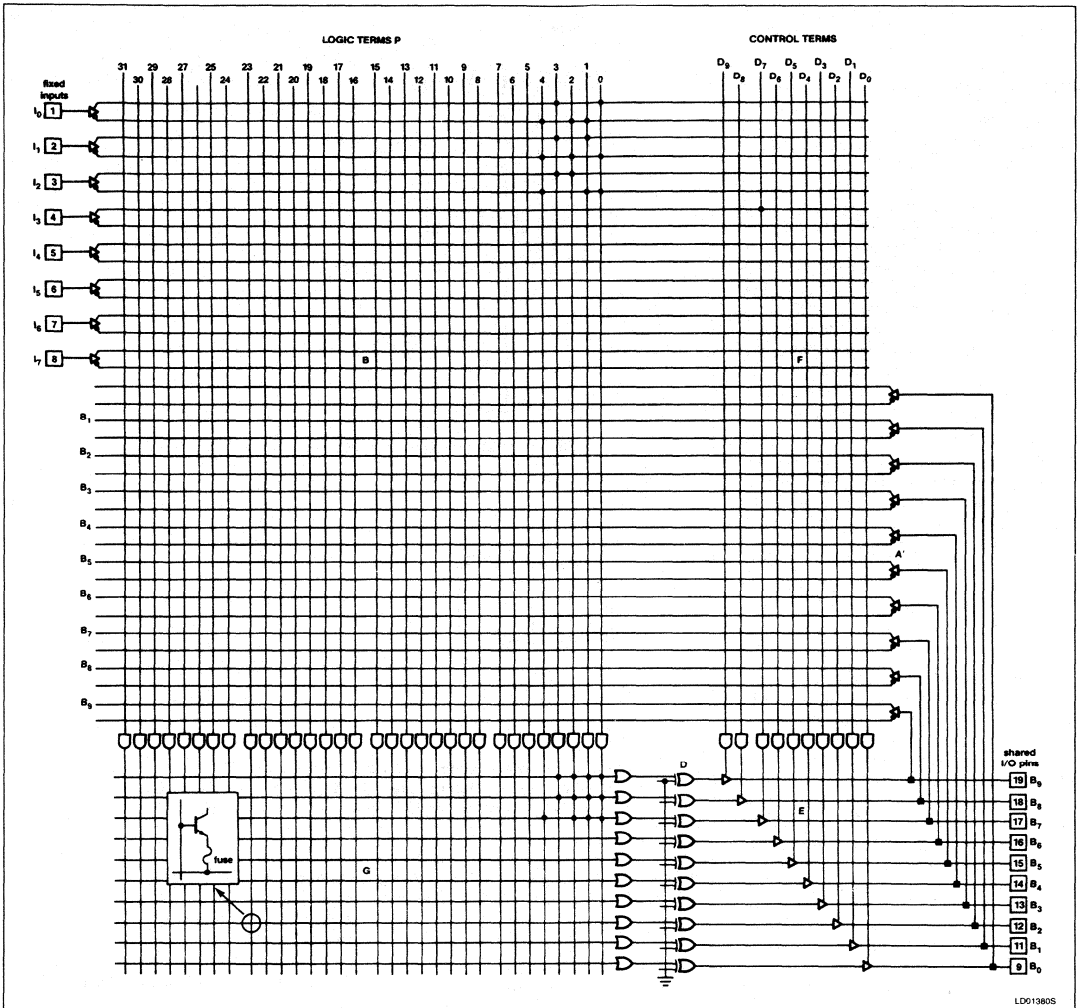
The product matrix and exclusive OR-gate connections shown in Figure 1 illustrate the flexibility conferred by having buffered complements of all input variables internally available, together with independently programmable output polarities. Output B_{11}, shown with its exclusive OR-gate fuse intact, is programmed

$$\overline{B_{11}} = I_0 I_1 \overline{I_5}$$



NOTE:
A, dedicated inputs; A', programmable I/O. B, product (NAND) matrix with fused connections C; each of the vertical lines in the matrix represents 36 inputs to the terminating NAND gated. D, exclusive-OR array with inputs grounded via fuses for polarity control. E, programmable three-state output buffers. F, fuse-programmable control matrix. Square dots (■) represent permanent connections; round dots (●) intact fuse connections. Connected as shown, the array is programmed for the functions $\overline{B}_{11} = I_0\ I_1\ \overline{I}_5$ and $B_{10} = \overline{I}_0\ \overline{I}_1\ \overline{I}_5$.

Figure 1. Field-programmable Gate Array PLS151A



NOTE:
A to F, as in Figure 1. G, sum (OR) matrix. Connected as shown, the array is programmed as a single-bit adder with Carry Enable.

Figure 2. Field-programmable Logic Array PLS153

At the same time, and without using any additional inputs, output B_{10} (fuse blown) is programmed

$$B_{10} = \overline{I_0}\,\overline{I_1}\,\overline{I_5}$$

Each of the exclusive-OR gates drives a three-state output buffer. In the virgin state all the buffers (E) are disabled and therefore in the high-impedance state. The function of the programmable I/O pins (A') is then determined by the I/O control matrix (F). The three AND gates at the control-matrix output are active-High, and when one of them is in the High state, the four output buffers it controls are enabled; the corresponding I/O pins then act as outputs. conversely, when a control-matrix AND-gate output is Low and the control fuse for the corresponding three-state buffer is intact, the pins controlled by that gate act as inputs. Thus, these pins can be programmed in groups of up to four to act as inputs or outputs according to the state of selected input variables. If required, any of the programmable I/O pins can be made a dedicated output by blowing the control fuse of the output buffer associated with it.

The speed of the FPGA compares favorably with TTL, although its propagation delay is longer than the individual gate delay of TTL. When the number of inputs required is large, however, the FPGA more than makes up for this. When more than eight inputs are required, for example, the FPGA has a distinct advantage. Then, the overall propagation de-

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lay of TTL often amounts to two or three gate delays, but that of the FPGA to only one.

FPLA PLS153

Architecture

With two levels of logic embodied in a product matrix terminating in 32 AND gates coupled to a ten-output OR matrix (Figure 2), the FPLA is a step up in complexity from the FPGA. Again, there is provision for 18 input variables, internally complemented and buffered, but here divided between eight dedicated input pins and ten individually programmable I/O pins. As before, exclusive-OR gates grounded by fuses provide output polarity control, and any of the programmable I/O pins can be made a dedicated output by blowing the control fuse of the output buffer associated with it.

Programming

When the required functions have been defined, corresponding programming instructions are entered in a programming table, the layout of which reflects the FPLA architecture. (A Signetics computer program named AMAZE, which accepts Boolean equations as input and generates an FPLA programming table as output, is also available.) The programming machine blows the FPLA fuses in the pattern prescribed by the table.

As an illustration of FPLA programming, consider a full adder. Figure 3 shows a TTL version (74LS80) and the corresponding logic equations. Note that the feedback of $\overline{C}_{n+1}$ introduces a second propagation delay. In the FPLA this is eliminated by redefining Σ in terms of A, B, and C_n, as shown in Figure 4, and using the right side of the equation for $\overline{C}_{n+1}$ instead of the term itself. At first glance this would appear to require a minimum of three product terms for $\overline{C}_{n+1}$ plus four for Σ, or a total of seven. The Karnaugh maps, however, show considerable overlap between the two functions: the map for $\overline{C}_{n+1}$ differs from that for Σ only by having A B C_n instead of $\overline{A}\,\overline{B}\,\overline{C_n}$. Rewriting the equation for $\overline{C}_{n+1}$ to introduce $\overline{A}\,\overline{B}\,\overline{C_n}$ and eliminate A B C_n,

$$\overline{C}_{n+1} = A\,\overline{B}\,\overline{C_n} + \overline{A}\,B\,\overline{C_n} + \overline{A}\,\overline{B}\,C_n + \overline{A}\,\overline{B}\,\overline{C_n}$$

increases the number of product terms by one, but now $\overline{C}_{n+1}$ and Σ have three terms in common. Therefore, since the FPLA allows multiple use of product terms, it is sufficient to program each of the common terms only once; thus, the original seven product terms are effectively reduced to five.

To fill in the programming table (Table 1), first allocate inputs and outputs.

Inputs:		Outputs:	
A	$= I_0$	$\overline{C}_{n+1}$	$= B_7$
B	$= I_1$	$\overline{\Sigma}$	$= B_8$
C_n	$= I_2$	Σ	$= B_9$

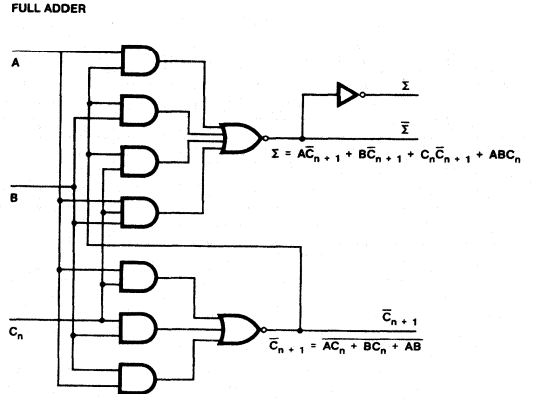


Figure 3. Single-bit Full Adder In TTL (e.g. 74LS80)

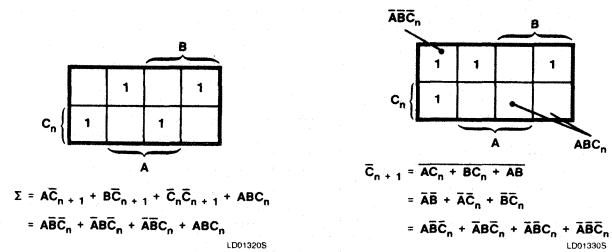


Figure 4. Karnaugh Maps And Logic Equations For The Full Adder Of Figure 3, Illustrating How The Equations Are Reduced For The FPLA Implementation Shown In Figure 2 And Table 1

Next, enter the product terms of Σ in the product-matrix (AND) part of the table, using H to indicate a true input and L a false one.

- Term 0 is A $\overline{B}$ $\overline{C_n}$: mark H, L, L in columns I_0, I_1, I_2 of row 0
- Term 1 is $\overline{A}$ B $\overline{C_n}$: mark L, H, L in columns I_0, I_1, I_2 of row 1
- Term 2 is $\overline{A}$ $\overline{B}$ C_n: mark L, L, H in columns I_0, I_1, I_2 of row 2
- Term 3 is A B C_n: mark H, H, H in columns I_0, I_1, I_2 of row 3.

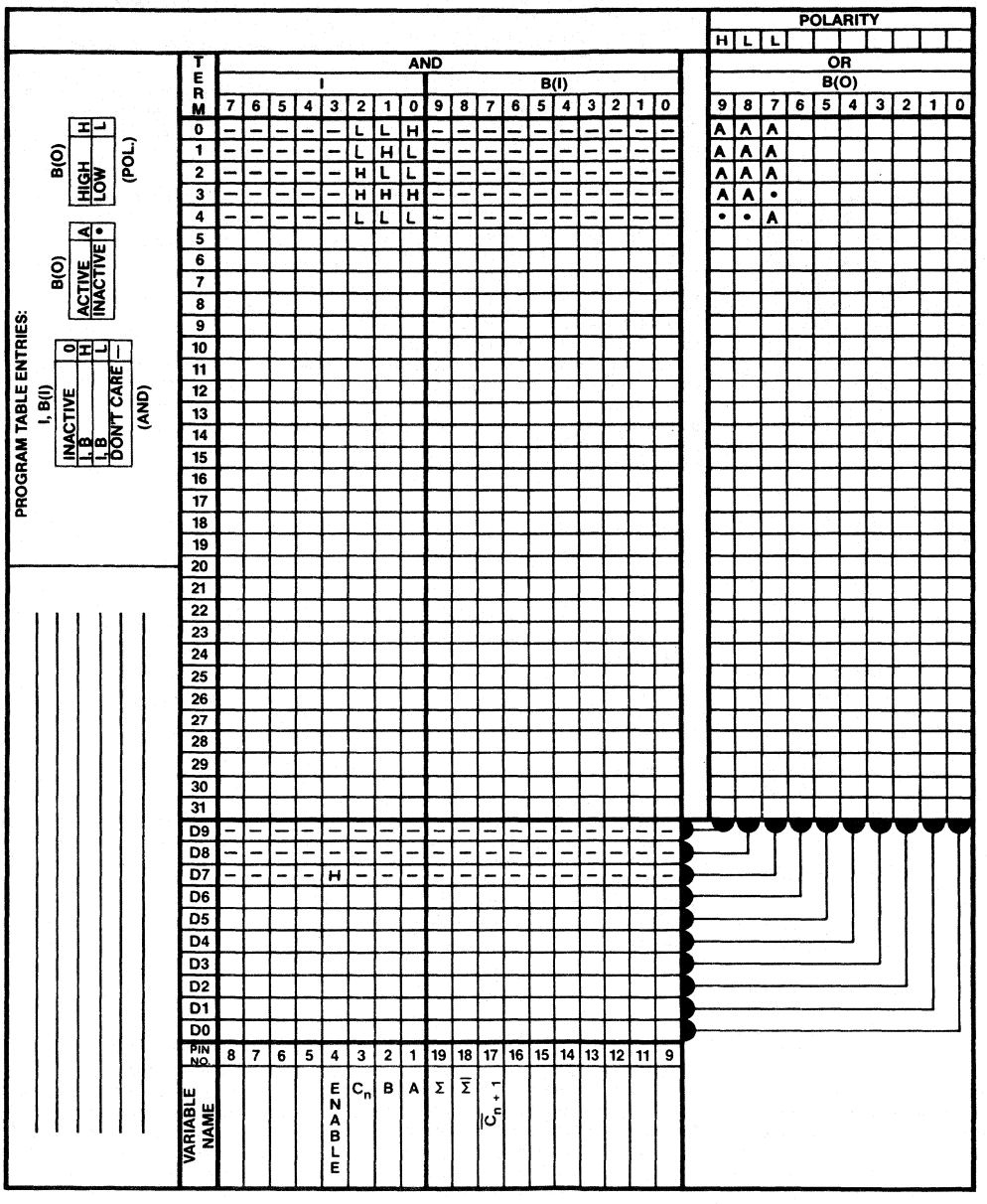
Fill the rest of rows 0, 1, 2, and 3 with dashes to indicate that all other inputs are to be disconnected from Terms 0, 1, 2, and 3 (fuses blown).

The product terms of Σ must be added to form the sum-of-products required at output B_9. Indicate the required addition by putting an A (for Attached, i.e. fuse unblown) in the Term 0, 1, 2, and 3 spaces of column $B(O)_9$; Term 4 is not required for Σ, so put a dot in the Term 4 space to indicate that it is to be disconnected (fuse blown). To indicate that the output is to be active-High, put an H in the polarity square above the $B(O)_9$ column. Finally, fill row D_9 with dashes to indicate that all fuses on line D_9 of the control matrix are to be blown and B_9 is to be a dedicated output. This completes the programming of Σ.

The $\overline{\Sigma}$ output on B_8 is programmed in just the same way, except that the polarity square above the $B(O)_8$ column is marked L to indicate active-Low. (Note that in the FPLA, the Σ and $\overline{\Sigma}$ outputs change simultaneously, because all output signals traverse the exclusive-OR array (D), whether they are active-High or active-Low. In the TTL full adder shown in Figure 3, the output inverter delays the change of Σ with respect to $\overline{\Sigma}$.)

The output C_{n+1} on B_7 contains three of the same terms as Σ, plus the term $\overline{A}\,\overline{B}\,\overline{C_n}$. Only this last term needs to be additionally programmed in the product matrix: mark L, L, L in columns I_0, I_1, I_2 of the Term 4 row. Indicate the addition

Table 1. FPLA Programming Table Filled in for the Full Adder of Figure 2



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$A\ \overline{B}\ \overline{C_n} + \overline{A}\ B\ \overline{C_n} + \overline{A}\ \overline{B}\ C_n + \overline{A}\ \overline{B}\ \overline{C_n}$

by putting an A in rows 0, 1, 2, and 4 of column $B(O)_7$, and show that Term 3 ($A\ B\ C_n$) is not required by putting a dot in the Term 3 row to indicate disconnection (fuse blown). Put an L in the $B(O)_7$ polarity square to indicate active-Low.

Identifying B_7 as a dedicated output by indicating that all the fuses to control term D_7 are to be blown, would now complete the programming of the full adder. However, a useful supplementary feature would be a Carry Enable function to keep the B_7 output buffer in the high-impedance state except when the enable input I_3 is true. The output buffer is enabled when both the fuses of a control term are blown, or when one is blown and the term that controls the output buffer is true. Thus, a Carry Enable can be provided via the I_3 input by leaving intact the fuse for active-High operation of the enable signal to control term D_7. To indicate this, put an H in the I_3 column of row D_7 and fill the rest of the row with dashes.

The full adder with output Carry Enable uses only four of the eight dedicated inputs, three of the ten programmable I/O pins, and five of the 32 AND gates. The remaining capacity can be used for programming other functions which may, if required, also make use of AND-gate outputs already programmed for the full adder.

All fuses not indicated as blown in the programming table are normally left intact to preserve capacity for later program revisions or the addition of supplementary functions. If it is essential to minimize propagation delay, however, the finalized program should include instructions for blowing all unused fuses to minimize load capacitance.

FPLS PLS155 – PLS157 – PLS159

Architecture

The FPLS (Figure 5) is the most complex of the Series 20 PLD devices. Like the FPLA, it has a 32-term product matrix followed by an OR matrix. In the FPLS, however, the OR matrix is larger and comprises three distinct parts, with architecture differing in detail from type to type. In the PLS155, for instance, the first part consists of eight 32-input gates coupled, like those of the FPLA, to an output-polarity-controlling exclusive-OR array. The second consists of twelve additional gates which control four flip-flops. These are what give the FPLS its sequential character, enabling it to dictate its next state as a function of its present state. The third part is the deceptively simple complement array (I in Figure 5): a single OR gate with its output inverted and fed back into the product matrix. This enables a chosen sum-of-products to become a common factor of any or all the product terms and makes it possible to work factored sum-of-products equations. it is also useful for handshaking control when interfacing with a processor and for altering the sequence of a state machine without resorting to a large number of product terms.

PLS155 has four dedicated inputs and eight programmable I/O pins that can be allocated in the same way as in the FPLA. It also has four shared I/O pins (L) whereby the flip-flops can be interfaced with a bidirectional data bus. Two product terms, L_A and L_B in the control matrix F, control the loading of the flip-flops, in pairs, synchronized with the clock.

Figure 6 shows the architecture of the flip-flop circuitry in the PLS155. The flip-flops are positive-edge – triggered and can be dynamically changed to J-K, T, or D types according to the requirements of the function being performed; this considerably lessens the demands on the logic. The three-state inverter between the J and K inputs governs the mode of operation, under the control of the product term F:

- When the inverter is in the high-impedance state, the flip-flop is a J-K type, or a T type when J = K.
- When the inverter is active, $K = \overline{J}$ and the flip-flop is a D type; the K input must then be disconnected from the OR matrix.

All the product terms from the product matrix (T_0 to T_{31} in Figure 5) are fuse-connected to the J and K input OR gates. if both fuses of any one product term are left intact, J = K and the flip-flop is a T type.

The flip-flops of the PLS155 have asynchronous Preset and Reset controlled by terms in the OR matrix that take priority over the clock. Their three-state output buffers can be controlled from the enable pin OE or permanently enabled or disabled by blowing fuses or leaving them intact in the enable array (K in Figure 5).

The PLS157 and PLS159 sequencers have, respectively, six and eight flip-flops. The architecture differs in detail but is similar in principle to that of PLS155.

Programming

The FPLS is programmed in much the same way as the FPLA, using a table to instruct the machine that blows the undesired fuses. It is not necessary to work with a circuit diagram; in fact, it is even undesirable to do so, since applying the necessary logic reduction techniques would in most cases make the diagram difficult to read and more a hindrance than a help. An example of how to program the FPLS as a universal counter/shift-register is given in the Appendix.

DEVELOPMENT AND PRODUCTION ECONOMY WITH PLD

Underlying the design philosophy of the Signetics Series 20 PLD is the concept of programmable arrays whose architecture emulates logic equation formats rather than mere aggregations of gates. The unique combination of features which support this philosophy includes:

- double-buffered true and complement inputs
- programmable-polarity outputs
- programmable I/O for internal feedback and maximum freedom in allocating inputs and outputs
- truth-table programming format

These features are common to all the PLD devices. In the field-programmable logic sequencers they are further supported by:

- flip-flops with dynamically alterable operating modes
- a complement array for simplified handshaking control

From the development engineer's point of view an important advantage of PLD is that it eliminates breadboarding. Once the functions required in terms of minimized logic equations are worked out, a PLD can be programmed accordingly. Once programmed, it will perform those functions.

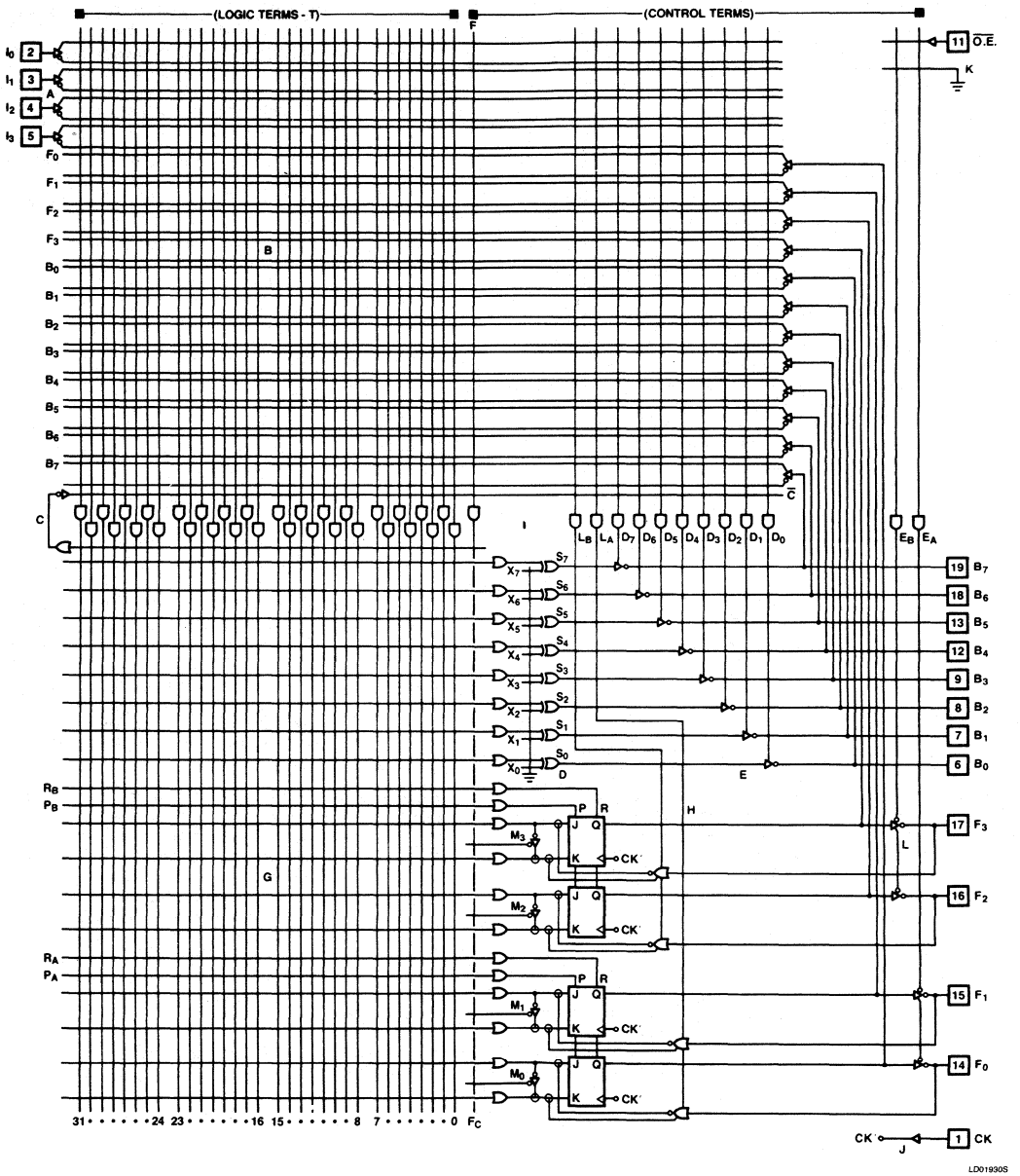
Loading the instructions into the programming machine usually takes no more than a couple of hours; after that, the machine can program the devices at a rate of 100 an hour. Moreover, since any PLD can be programmed in many different ways, PLD has considerable potential for simplifying purchasing and stock control. One type of device can be programmed to perform a diversity of tasks for which it would otherwise be necessary to purchase and stock many different devices.

Series 20 PLD is second-sourced by Harris Semiconductor.

APPENDIX

Programming an FPLS as a Counter/Shift-register

Objective: to program a PLS155 FPLS as a count-up, count-down, shift-right, shift-left machine governed by three control terms – COUNT/$\overline{\text{SHIFT}}$, RIGHT/UP, LEFT/DOWN. Direct implementation would result in a machine with 64 state transitions (see Table A-1), which is beyond the scope of the PLS155 or even the 28-pin PLS105. Logic reduction is therefore necessary.



NOTE:
A to G, As In Figure 2. H, Flip-flops And Bus-load Buffer. J, Clock Input. K, Output-Buffer Enable. L, Three-state Flip-flop Output Buffers.

Figure 5. Field-programmable Logic Sequencer PLS155

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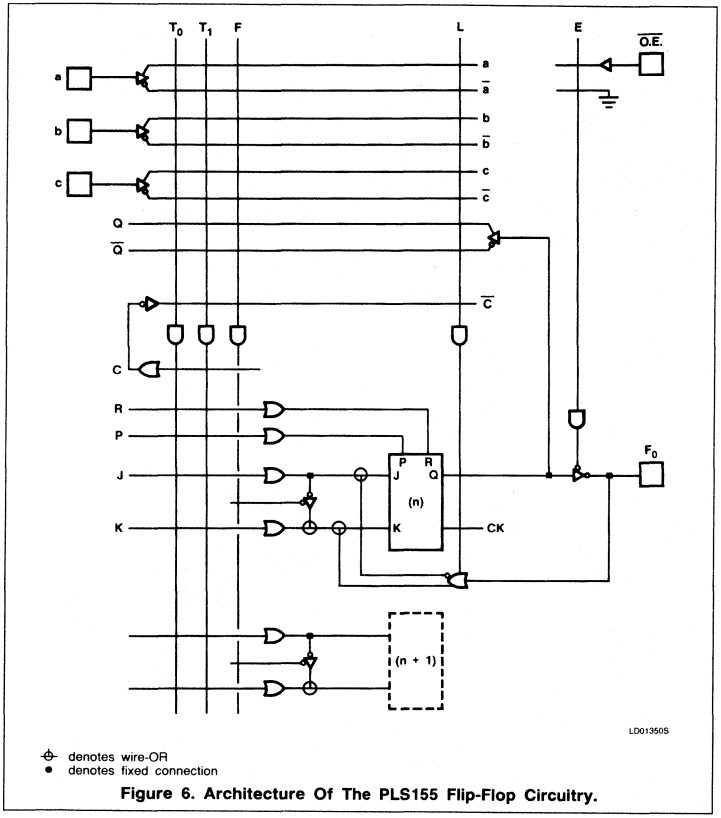

Figure 6. Architecture Of The PLS155 Flip-Flop Circuitry.

As there are only four feedback variables (D, C, B, A), you can do the reduction by hand, one mode at a time; the control terms need not be included till the summary equations are written. Using the transition mapping method suggested here, you can examine the excitation equations for all types of flip-flops (R-S, J-K, D, T) and choose those types that will perform the required functions using the fewest product terms. Table A-2 summarizes the rules for flip-flop implementation using transition maps; the transition symbols used in the table mean:

PRESENT STATE	NEXT STATE	TRANSITION SYMBOL
0	0	0
0	1	α
1	0	β
1	1	1

Using these symbols, construct Table A-3 from Table A-1 to enable you to examine the excitation equations for all types of flip-flops. Proceeding one mode at a time, transfer the state conditions from Table A-3 to Karnaugh maps, as in Figure A-1. Following the rules in Table A-2, derive the excitation equations for the different types of flip-flops (the examples shown in Figure A-1 omit the T type because it is the same as the J-K type when J = K). In deciding which types of flip-flop to use, remember that logic minimization with PLD is different from logic minimization with 'random logic': with random logic you seek to reduce the number of standard packages required; with PLD you seek to reduce the number of product terms.

From Figure A-1 it is evident that you should choose J-K or T flip-flops for the counter mode and D flip-flops for the shift mode, for you then require only one product term per flip-flop per mode. Table A-4 summarizes the number of product terms per mode the various types of flip-flops would require.

Table A-5 shows the completed programming table for the counter/shift-register. The programming of Terms 0 to 15 reflects the flip-flop excitation equations and illustrates the value of being able to switch the flip-flops dynamically from one type of operation to another. Terms 16, 17 and 18, respectively, provide for INITIALIZE, asynchronous RESET, and STOP functions.

The programming of the two additional inputs $\overline{\text{HALT}}$ and $\overline{\text{BUSY}}$ illustrates the value of the complementary, which is made active when $\overline{\text{HALT}}$ and $\overline{\text{BUSY}}$ are Low (A in the Complement square of Term 18) and propagated into all the other terms (dot in the Complement squares of Terms 0 to 17). This means that unless the $\overline{\text{HALT}}$ and $\overline{\text{BUSY}}$ inputs are High, none of the product terms will be true and the state of the machine will not change. If the complement array were not used, twice the number of product terms would be required, even if one of the additional inputs were omitted.

As it is, the design uses only 19 of the 32 product terms available, so there is ample capacity for extending its capabilities. For example, the shift-left function can be augmented by a binary multiplication capability, using a D type flip-flop to make it shift one, two, or three places according to the state of two extra inputs, X and Y. Table A-6 shows the revised programming table. The binary multiplication function occupies nine additional product terms.

ACKNOWLEDGEMENT

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Table A-1. Present-state/Next-state Table for Counter/Shift-register

STATE NO.	PRESENT STATE				NEXT STATE															
					Count Down				Count Up				Shift Left				Shift Right			
	D	C	B	A	D	C	B	A	D	C	B	A	D	C	B	A	D	C	B	A
0	0	0	0	0	1	1	1	1	0	0	0	1	0	0	0	0	0	0	0	0
1	0	0	0	1	0	0	0	0	0	0	1	0	0	0	1	0	1	0	0	0
2	0	0	1	0	0	0	0	1	0	0	1	1	0	1	0	0	0	0	0	1
3	0	0	1	1	0	0	1	0	0	1	0	0	0	1	1	0	1	0	0	1
4	0	1	0	0	0	0	1	1	0	1	0	1	1	0	0	0	0	0	1	0
5	0	1	0	1	0	1	0	0	0	1	1	0	1	0	1	0	1	0	1	0
6	0	1	1	0	0	1	0	1	0	1	1	1	1	1	0	0	0	0	1	1
7	0	1	1	1	0	1	1	0	1	0	0	0	1	1	1	0	1	0	1	1
8	1	0	0	0	0	1	1	1	1	0	0	1	0	0	0	1	0	1	0	0
9	1	0	0	1	1	0	0	0	1	0	1	0	0	0	1	1	1	1	0	0
10	1	0	1	0	1	0	0	1	1	0	1	1	0	1	0	1	0	1	0	1
11	1	0	1	1	1	0	1	0	1	1	0	0	0	1	1	1	1	1	0	1
12	1	1	0	0	1	0	1	1	1	1	0	1	1	0	0	1	0	1	1	0
13	1	1	0	1	1	1	0	0	1	1	1	0	1	0	1	1	1	1	1	0
14	1	1	1	0	1	1	0	1	1	1	1	1	1	1	0	1	0	1	1	1
15	1	1	1	1	1	1	1	0	0	0	0	0	1	1	1	1	1	1	1	1
CONTROL TERMS																				
COUNT/$\overline{\text{SHIFT}}$					1				1				0				0			
RIGHT/UP					0				1				0				1			
LEFT/DOWN					1				0				1				0			

Table A-2. Rules for Flip-flop Implementation Using Transition Maps

FLIP-FLOP TYPE	INPUT	MUST INCLUDE	MUST EXCLUDE	REDUNDANT
R-S	S	α	β,0	1,x
	R	β	α,1	0,x
D	D	α,1	β,0	x
T	T	α,β	0,1	x
J-K	J	α	0	1,β,x
	K	β	1	0,α,x

Table A-3. Transition Table for Counter/Shift-register

STATE NO.	PRESENT STATE				TRANSITION															
					Count Down				Count Up				Shift Left				Shift Right			
	D	C	B	A	D	C	B	A	D	C	B	A	D	C	B	A	D	C	B	A
0	0	0	0	0	α	α	α	α	0	0	0	α	0	0	0	0	0	0	0	0
1	0	0	0	1	0	0	0	β	0	0	α	β	0	0	α	β	α	0	0	β
2	0	0	1	0	0	0	β	α	0	0	1	α	0	α	β	0	0	0	β	α
3	0	0	1	1	0	0	1	β	0	α	β	β	0	α	1	β	α	0	β	1
4	0	1	0	0	0	β	α	α	0	1	0	α	α	β	0	0	0	β	α	0
5	0	1	0	1	0	1	0	β	0	1	α	β	α	β	α	β	α	β	α	β
6	0	1	1	0	0	1	β	α	0	1	1	α	α	1	β	0	0	β	1	α
7	0	1	1	1	0	1	1	β	α	β	β	β	α	1	1	β	α	β	1	1
8	1	0	0	0	β	α	α	α	1	0	0	α	β	0	0	α	β	α	0	0
9	1	0	0	1	1	0	0	β	1	0	α	β	β	0	α	1	1	α	0	β
10	1	0	1	0	1	0	β	α	1	0	1	α	β	α	β	α	β	α	β	α
11	1	0	1	1	1	0	1	β	1	α	β	β	β	α	1	1	1	α	β	1
12	1	1	0	0	1	β	α	α	1	1	0	α	1	β	0	α	β	1	α	0
13	1	1	0	1	1	1	0	β	1	1	α	β	1	β	α	1	1	1	α	β
14	1	1	1	0	1	1	β	α	1	1	1	α	1	1	β	α	β	1	1	α
15	1	1	1	1	1	1	1	β	β	β	β	β	1	1	1	1	1	1	1	1

Table A-4. Number of Product Terms Required for Counter/Shift-register Flip-flop Excitation

FLIP-FLOP TYPE	COUNT UP	COUNT DOWN	SHIFT RIGHT	SHIFT LEFT	TOTAL
SR only	8	8	8	8	32
JK only	4	4	8	8	24
D only	10	10	4	4	28
FPLS	4(J-K)	4(J-K)	4(D)	4(D)	16

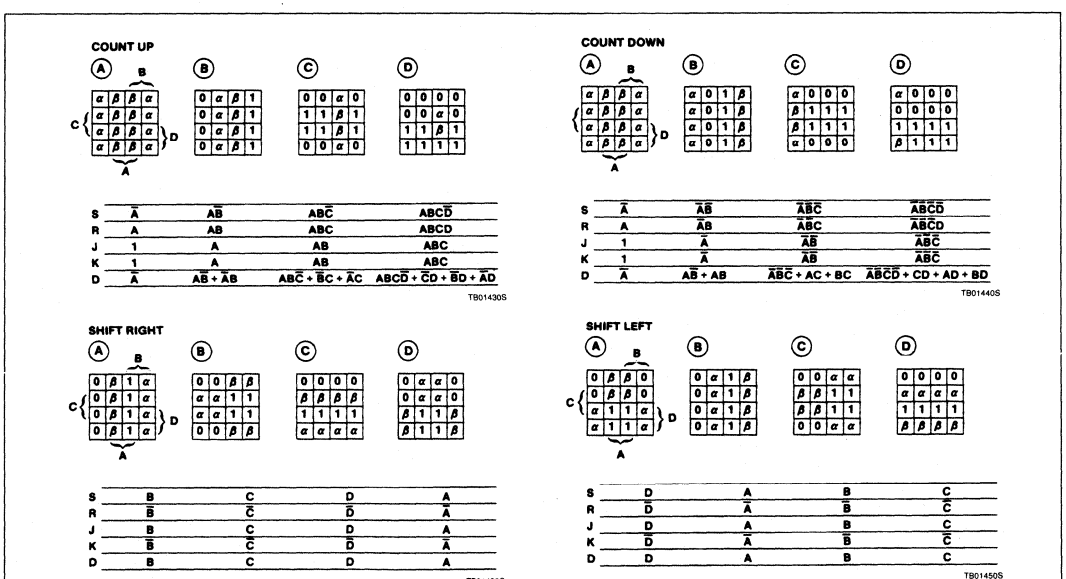

Figure A-1 Karnaugh Maps And Flip-flop Excitation Functions For The Counter/Shift-Register

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Table A-5. PLS155 FPLS Programming Table For The Counter/Shift-Register

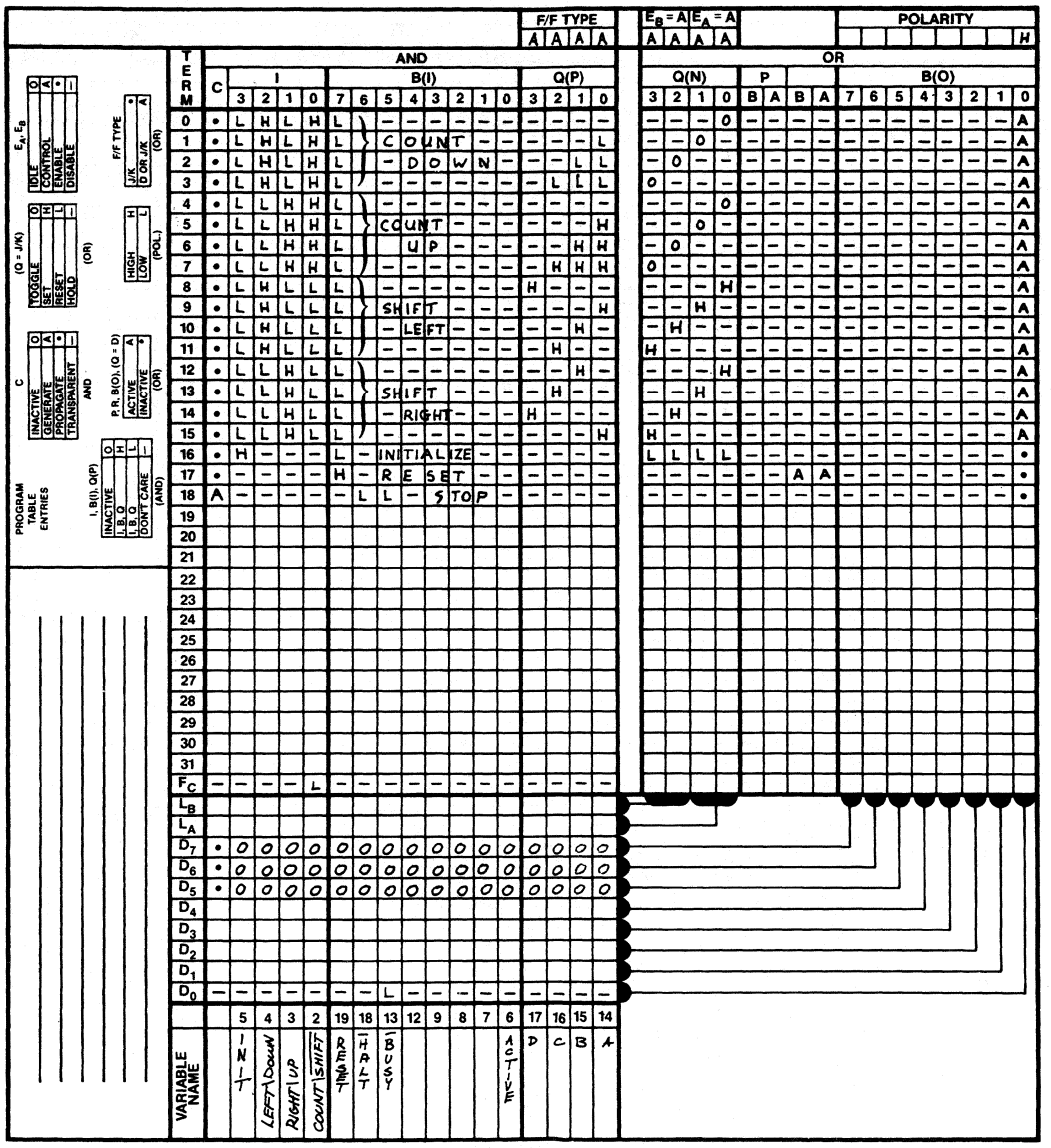

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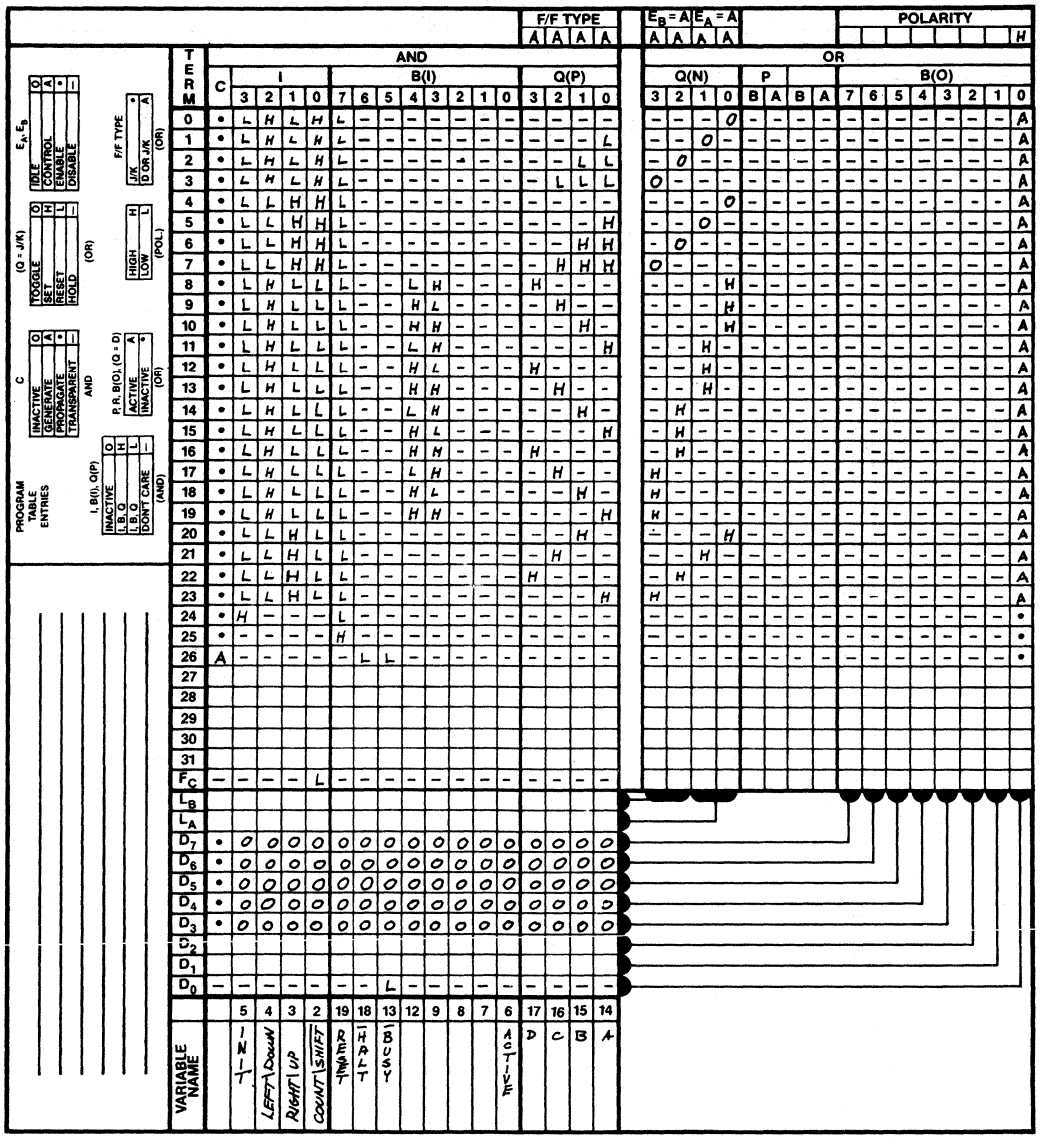
Table A-6. Modified PLS155 FPLS Programming Table for the Counter/Shift-Register with the Addition of a Binary Multiplier



TB01460S

Signetics

AN10
4-Bit Binary-To-7 Segment Decoder

Application Note

Application Specific Products

INTRODUCTION

Using the PLS153 or PLS153A, a 4-bit binary-to-7 segment decoder may be easily constructed. This paper will cover Hex-to-7 segment decoder, BCD-to-7 segment decoder, decoder with latches, and decoder with multiplexer. The architecture of PLS153/153A is basically an AND-OR matrix. The large number of inputs of each AND term is ideal for decoder applications, and the ability to drive the entire OR array makes possible the efficient use of AND terms such that, together with the programmable output polarity, a minimum number of AND terms is needed to implement the decoder function. Another important feature of the PLS153/153A architecture is the 10 bi-directional I/O pins. The bi-directionality of these pins provides internal feedback to the AND matrix, which eliminates the need for external wiring and, more importantly, it saves I/O pin requirements. All I/O pins of the PLS153/153A have tri-state output buffers, each may be enabled or disabled by its own controlling AND terms. In applications where high current drive is necessary but low power consumption is still desirable, the AND term controlled tri-state buffers are ideal for multiplexing. The LED display may be driven at a higher current and lower duty cycle to get better brightness/current efficiency and reduce the overall power dissipation.

DESCRIPTION

Hex-To-7 Segment Decoder

A 7 segment display (Figure 1) may be used to represent a hexadecimal number as shown in Table 1. The format serves merely as an example. Some designers may prefer other configurations, particularly for letters B and D. Before implementing the truth table with programmable logic devices, one has to decide whether the outputs should be active HIGH or active LOW. If a moderate drive current of 15mA or less is needed, and if a common anode LED display is used, then an active LOW output configuration is sufficient. On the other hand, if only a common cathode LED display is available and the current drive requirement is not very critical, an active HIGH output configuration may be used. The change of output polarity may be easily affected by putting in the POLARITY section 'H' for active HIGH and 'L' for active LOW. Since the output polarity is programmable, one may choose to describe the logic in terms of outputs equal to '1's or outputs equal to '0's.

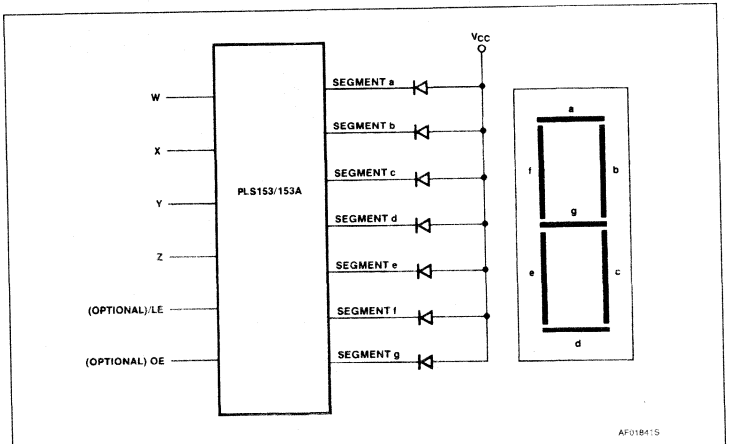


Figure 1. 7 Segment Decoder Driving A Common Anode LED Display

```
A>###################### P I N   L I S T ######################

   LABEL     ** FNC **PIN ---------- PIN** FNC **     LABEL
W            ** I   **  1-¦         ¦-20 ** +5V **VCC
X            ** I   **  2-¦         ¦-19 ** B   **N/C
Y            ** I   **  3-¦         ¦-18 ** B   **N/C
Z            ** I   **  4-¦    8    ¦-17 ** B   **/SEG_A
N/C          ** I   **  5-¦    2    ¦-16 ** B   **/SEG_B
N/C          ** I   **  6-¦    S    ¦-15 ** B   **/SEG_C
N/C          ** I   **  7-¦    1    ¦-14 ** B   **/SEG_D
/OE          ** I   **  8-¦    5    ¦-13 ** B   **/SEG_E
N/C          ** B   **  9-¦    3    ¦-12 ** B   **/SEG_F
GND          ** 0V  ** 10-¦         ¦-11 ** B   **/SEG_G
                          ----------
```

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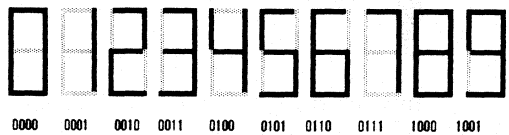
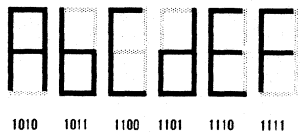
Figure 2. Pin List of Binary-To-7 Segment Decoder

NOTE:
PLSXXX and 82SXXX are interchangeable part numbers.

Table 1. Truth Table of Hex – to – 7 – Segment Decoder





Z Y X W	a	b	c	d	e	f	g
0 0 0 0	1	1	1	1	1	1	0
0 0 0 1	0	1	1	0	0	0	0
0 0 1 0	1	1	0	1	1	0	1
0 0 1 1	1	1	1	1	0	0	1
0 1 0 0	0	1	1	0	0	1	1
0 1 0 1	1	0	1	1	0	1	1
0 1 1 0	1	0	1	1	1	1	1
0 1 1 1	1	1	1	0	0	0	0
1 0 0 0	1	1	1	1	1	1	1
1 0 0 1	1	1	1	1	0	1	1
1 0 1 0	1	1	1	0	1	1	1
1 0 1 1	0	0	1	1	1	1	1
1 1 0 0	1	0	0	1	1	1	0
1 1 0 1	0	1	1	1	1	0	1
1 1 1 0	1	0	0	1	1	1	1
1 1 1 1	1	0	0	0	1	1	1

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Table 2. H/L Programming Table for Binary-To-7-Segment Decoder

82S153/153A PROGRAMMING TABLE DRAWING ID: B TO 7 SEG DECODER REV. —

DESIGNER: D.K. WONG DATE: 12/15/84

	AND I 7	6	5	4	AND I 3	2	1	0	AND B(I) 9	8	AND B(I) 7	6	5	4	AND B(I) 3	2	1	0	OR B(O) 9	8	OR B(O) 7	6	5	4	OR B(O) 3	2	1	0	INPUT	OUTPUT
POLARITY																			H	H	L	L	L	L	L	L	L	H		
0	-	-	-	-	L	L	L	L	-	-	-	-	-	-	-	-	-	-	•	•	A	A	A	A	A	A	•	•	0	0
1	-	-	-	-	L	L	L	H	-	-	-	-	-	-	-	-	-	-	•	•	•	A	A	•	•	•	•	•	1	1
2	-	-	-	-	L	L	H	L	-	-	-	-	-	-	-	-	-	-	•	•	A	A	•	A	A	•	A	•	2	2
3	-	-	-	-	L	L	H	H	-	-	-	-	-	-	-	-	-	-	•	•	A	A	A	A	•	•	A	•	3	3
4	-	-	-	-	L	H	L	L	-	-	-	-	-	-	-	-	-	-	•	•	•	A	A	•	•	A	A	•	4	4
5	-	-	-	-	L	H	L	H	-	-	-	-	-	-	-	-	-	-	•	•	A	•	A	A	•	A	A	•	5	5
6	-	-	-	-	L	H	H	L	-	-	-	-	-	-	-	-	-	-	•	•	A	•	A	A	A	A	A	•	6	6
7	-	-	-	-	L	H	H	H	-	-	-	-	-	-	-	-	-	-	•	•	A	A	A	•	•	•	•	•	7	7
8	-	-	-	-	H	L	L	L	-	-	-	-	-	-	-	-	-	-	•	•	A	A	A	A	A	A	A	•	8	8
9	-	-	-	-	H	L	L	H	-	-	-	-	-	-	-	-	-	-	•	•	A	A	A	A	•	A	A	•	9	9
10	-	-	-	-	H	L	H	L	-	-	-	-	-	-	-	-	-	-	•	•	A	A	A	•	A	A	A	•	10	A
11	-	-	-	-	H	L	H	H	-	-	-	-	-	-	-	-	-	-	•	•	-	•	•	A	A	A	A	•	11	b
12	-	-	-	-	H	H	L	L	-	-	-	-	-	-	-	-	-	-	•	•	A	•	•	A	A	A	A	•	12	C
13	-	-	-	-	H	H	L	H	-	-	-	-	-	-	-	-	-	-	•	•	•	A	A	A	A	•	A	•	13	d
14	-	-	-	-	H	H	H	L	-	-	-	-	-	-	-	-	-	-	•	•	A	•	•	A	A	A	A	•	14	E
15	-	-	-	-	H	H	H	H	-	-	-	-	-	-	-	-	-	-	•	•	A	•	•	•	A	A	A	•	15	F
16																														
17																														
18																														
19																														
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21																														
22																														
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29																														
30																														
31																														
D9																														
D8																														
D7	L	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-												
D6	L	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-												
D5	L	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-												
D4	L	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-												
D3	L	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-												
D2	L	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-												
D1	L	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-												
D0																														
NAME	IDE				N	Y	X	M											A	B	C	D	E	F	G					

COMMENTS

ENABLE B7 FOR OUTPUT (SEG A)
" B6 " " " B
" B5 " " " C
" B4 " " " D
" B3 " " " E
" B2 " " " F
" B1 " " " G

TB01001S

4-Bit Binary-To-7 Segment Decoder

AN10

Table 3. H/L Programming Table for Binary-To-7 Segment Decoder

82S153/153A PROGRAMMING TABLE DRAWING ID: B TO 7 SEG DECODER REV. A

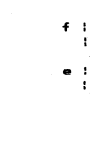
DESIGNER: D. K. WONG DATE: 12/15/84

	AND I 7:6:5:4	AND I 3:2:1:0	AND B(I) 9:8	AND B(I) 7:6:5:4	AND B(I) 3:2:1:0	POLARITY	OR B(O) 9:8	OR B(O) 7:6:5:4	OR B(O) 3:2:1:0	COMMENTS
0	- - - -	L L L L	- -	- - - -	- - - -	H H H H H H H H H H	• •	• • • •	• • • A	0
1	- - - -	L L L H	- -	- - - -	- - - -		• •	A • • •	A A A •	1
2	- - - -	L L H L	- -	- - - -	- - - -		• •	• A • •	• A • •	2
3	- - - -	L L H H	- -	- - - -	- - - -		• •	• • • •	A A • •	3
4	- - - -	L H L L	- -	- - - -	- - - -		• •	A • • •	A A • •	4
5	- - - -	L H L H	- -	- - - -	- - - -		• •	• A • •	A • • •	5
6	- - - -	L H H L	- -	- - - -	- - - -		• •	• A • •	• • • •	6
7	- - - -	L H H H	- -	- - - -	- - - -		• •	• • • •	A A A •	7
8	- - - -	H L L L	- -	- - - -	- - - -		• •	• • • •	• • • •	8 (*)
9	- - - -	H L L H	- -	- - - -	- - - -		• •	• • • •	A • • •	9
10	- - - -	H L H L	- -	- - - -	- - - -		• •	• • • A	• • • •	A
11	- - - -	H L H H	- -	- - - -	- - - -		• •	A A • •	• • • •	b
12	- - - -	H H L L	- -	- - - -	- - - -		• •	• • A •	• • • A	C
13	- - - -	H H L H	- -	- - - -	- - - -		• •	A • • •	• A • •	d
14	- - - -	H H H L	- -	- - - -	- - - -		• •	• A A •	• • • •	E
15	- - - -	H H H H	- -	- - - -	- - - -		• •	• A A A	• • • •	F
16										
17										
18										
19										
20										
21										
22										
23										
24										
25										
26										
27										
28										
29										
30										
31										
D9										
D8										
D7	H									
D6	H									
D5	H									
D4	H									
D3	H									
D2	H									
D1	H									
D0										
NAME	OE	A X 3					ACCEPTED			

(*) SINCE THIS TERM IS "INACTIVE", IT MAY BE DELETED. THEREFORE, THE TOTAL # OF TERMS REQUIRED IS 15.

TB01011S

```
@DEVICE TYPE
82S153
@DRAWING
********************* BINARY-TO-7 SEGMENT DECODER
@REVISION
********************* REV. -
@DATE
********************* OCT 1, 1984
@SYMBOL
********************* FILE ID: 7deco
@COMPANY
********************* SIGNETICS
@NAME
********************* DAVID K. WONG
@DESCRIPTION
*****************************************************************************
*   This circuit converts a 4-bit binary code ( HEX ) into                  *
*   a 7-segment display. The display is a common anode 7-segment LED.       *
*   The output of the 82S153 goes LOW for each segment that is ON.          *
*****************************************************************************
```



TRUTH TABLE

Z	Y	X	W	a	b	c	d	e	f	g
0	0	0	0	0	0	0	0	0	0	1
0	0	0	1	1	0	0	1	1	1	1
0	0	1	0	0	0	1	0	0	1	0
0	0	1	1	0	0	0	0	1	1	0
0	1	0	0	1	0	0	1	1	0	0
0	1	0	1	0	1	0	0	1	0	0
0	1	1	0	0	1	0	0	0	0	0
0	1	1	1	0	0	0	1	1	1	1
1	0	0	0	0	0	0	0	0	0	0
1	0	0	1	0	0	0	0	1	0	0
1	0	1	0	0	0	0	1	0	0	0
1	0	1	1	1	1	0	0	0	0	0
1	1	0	0	0	1	1	0	0	0	1
1	1	0	1	1	0	0	0	0	1	0
1	1	1	0	0	1	1	0	0	0	0
1	1	1	1	0	1	1	1	0	0	0

```
@COMMON PRODUCT TERM
ZER = /z * /y * /x * /w  ;
ONE = /z * /y * /x *  w  ;
TWO = /z * /y *  x * /w  ;
THR = /z * /y *  x *  w  ;
FOU = /z *  y * /x * /w  ;
FIV = /z *  y * /x *  w  ;
SIX = /z *  y *  x * /w  ;
SEV = /z *  y *  x *  w  ;
EIG =  z * /y * /x * /w  ;
NIN =  z * /y * /x *  w  ;
AAA =  z * /y *  x * /w  ;
BBB =  z * /y *  x *  w  ;
CCC =  z *  y * /x * /w  ;
DDD =  z *  y * /x *  w  ;
EEE =  z *  y *  x * /w  ;
FFF =  z *  y *  x *  w  ;
```

TB01020S

Figure 3. Boolean Equation for Binary-To-7 Segment Decoder

```
@LOGIC EQUATION
/SEG_A =   ONE + FOU + BBB + DDD                    ;
/SEG_B =   FIV + SIX + BBB + CCC + EEE + FFF        ;
/SEG_C =   TWO + CCC + EEE + FFF                    ;
/SEG_D =   ONE + FOU + SEV + AAA + FFF              ;
/SEG_E =   ONE + THR + FOU + FIV + SEV + NIN        ;
/SEG_F =   ONE + TWO + THR + SEV + DDD              ;
/SEG_G =   ZER + ONE + SEV + CCC                    ;

@I/O DIRECTION 150/1, 152/3, 154-9
"
*************************************************************************
*              OUTPUTS ARE ENABLED WHEN /OE GOES LOW.                   *
*              THEREFORE, D1...D7 = /(/OE)   =   OE      ;              *
*************************************************************************
"
D1 = OE  ;
D2 = OE  ;
D3 = OE  ;
D4 = OE  ;
D5 = OE  ;
D6 = OE  ;
D7 = OE  ;

"
*************************************************************************
*                          END OF LOGIC EQUATIONS                       *
*************************************************************************
"
```

TB01090S

Figure 3 (Continued)

In this example, an active LOW output goes LOW when a segment is to be turned on. The truth table shown in Table 1 is translated into an H/L programming table as shown in Table 2. Since the LED display used here is common anode, the output polarity of each output pin is programmed "L" so that an output goes low when a segment is to be turned on. The decoder takes 16 AND terms. Notice that all outputs go LOW when input equals "8". If the logic is written for "0s" instead of "1s", one AND term could be saved. Table 3 shows that the same circuit may be implemented by using only 15 AND terms. Notice that the polarity is the reverse of that of Table 2. The outputs may be turned on and off by I_7, /OE, which controls the 7 tri-state output buffers through control terms (AND terms D_1 to D_7). The same design is also implemented using Boolean equations with AMAZE. Figures 2 through 4 are, respectively, pin list, logic equations, and logic simulation results of the hex-to-7 segment decoder circuit generated by AMAZE. In the process of generating Boolean equations for the decoder, common product terms are used to economize the usage of AND terms.

Table 4. H/L Table Generated by AMAZE for Binary-To-7 Segment Decoder

```
Cust/Project - ********************** DAVID K. WONG
Date         - ********************** OCT 1, 1984
Rev/I. D.    - ********************** REV. -

82S153                                  !      POLARITY       !
                                        !H:H:H:H:H:H:H:H:H:H!
 T !
 E !-----------------------------------------------------------
 R !       I        !        B(i)       !        B(o)         !
 M !-----------------------------------------------------------
___!7_6_5_4_3_2_1_0!9_8_7_6_5_4_3_2_1_0!9_8_7_6_5_4_3_2_1_0!
  0!- - - -,L L L H!- -,- - - -,- - - -!A A,A . . A,A A A A!
  1!- - - -,L H L L!- -,- - - -,- - - -!A A,A . . A,A . . A!
  2!- - - -,H L H H!- -,- - - -,- - - -!A A,A A . .,. . . A!
  3!- - - -,H H L H!- -,- - - -,- - - -!A A,A . . .,. A . A!
  4!- - - -,L H L H!- -,- - - -,- - - -!A A,. A . .,A . . A!
  5!- - - -,L H H L!- -,- - - -,- - - -!A A,. A . .,. . . A!
  6!- - - -,H H L L!- -,- - - -,- - - -!A A,. A A .,. . A A!
  7!- - - -,H H H L!- -,- - - -,- - - -!A A,. A A .,. . . A!
  8!- - - -,H H H H!- -,- - - -,- - - -!A A,. A A A,. . . A!
  9!- - - -,L L H L!- -,- - - -,- - - -!A A,. . A .,. A . A!
 10!- - - -,L H H H!- -,- - - -,- - - -!A A,. . . A,A A A A!
 11!- - - -,H L L H!- -,- - - -,- - - -!A A,. . . .,A . . A!
 12!- - - -,H L H L!- -,- - - -,- - - -!A A,. . . A,. . . A!
 13!- - - -,L L H H!- -,- - - -,- - - -!A A,. . . .,A A . A!
 14!- - - -,L L L L!- -,- - - -,- - - -!A A,. . . .,. . A A!
 15!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 16!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 17!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 18!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 19!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 20!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 21!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 22!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 23!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 24!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 25!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 26!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 27!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 28!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 29!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 30!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 31!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 D9!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!
 D8!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!
 D7!L - - -,- - - -!- -,- - - -,- - - -!
 D6!L - - -,- - - -!- -,- - - -,- - - -!
 D5!L - - -,- - - -!- -,- - - -,- - - -!
 D4!L - - -,- - - -!- -,- - - -,- - - -!
 D3!L - - -,- - - -!- -,- - - -,- - - -!
 D2!L - - -,- - - -!- -,- - - -,- - - -!
 D1!L - - -,- - - -!- -,- - - -,- - - -!
 D0!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!

   / N N N Z Y X W N N / / / / / / / N N N / / / / / / / N
   0 / / /         / / S S S S S S S / / / S S S S S S S /
   E C C C         C C E E E E E E E E C C C E E E E E E E C
                     G G G G G G G G       G G G G G G G G

                     A B C D E F G         A B C D E F G

                                                TB01040S
```

```
B2S153   A:7deco153.STD
" 4-bit binary to 7-segment decoder simulation
"
"  INPUTS  <=B(I/O)=>   TRACE TERMS
" 76543210 9876543210
"
  00000000 ..LLLLLLH. ;
  00000001 ..HLLHHHH. ;
  00000010 ..LLHLLHL. ;
  00000011 ..LLLLHHL. ;
  00000100 ..HLLHHLL. ;
  00000101 ..LHLLHLL. ;
  00000110 ..LHLLLLL. ;
  00000111 ..LLLHHHH. ;
  00001000 ..LLLLLLL. ;
  00001001 ..LLLLHLL. ;
  00001010 ..LLLHLLL. ;
  00001011 ..HHLLLLL. ;
  00001100 ..LHHLLLH. ;
  00001101 ..HLLLLHL. ;
  00001110 ..LHHLLLL. ;
  00001111 ..LHHHLLL. ;
  10001111 .......... ;
  10000000 .......... ;
"
" X------- ----------   I/O CONTROL LINES
"          IIBBBBBBBI   DESIGNATED I/O USAGE
"          IIBBBBBBBI   ACTUAL I/O USAGE
"
" PIN LIST...
" 08 07 06 05 04 03 02 01 19 18 17 16 15 14 13 12 11 09 ;
                                                    TB01050S
```

Figure 4

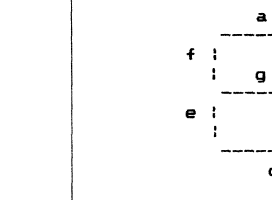
```
#################### P I N   L I S T ####################

   LABEL     ** FNC **PIN ---------- PIN** FNC **    LABEL
W            ** I   **  1-|        |-20 ** +5V **VCC
X            ** I   **  2-|        |-19 ** B   **N/C
Y            ** I   **  3-|        |-18 ** B   **N/C
Z            ** I   **  4-|   8    |-17 ** B   **/SEG_A
N/C          ** I   **  5-|   2    |-16 ** B   **/SEG_B
N/C          ** I   **  6-|   S    |-15 ** B   **/SEG_C
N/C          ** I   **  7-|   1    |-14 ** /B  **/SEG_D
/OE          ** I   **  8-|   5    |-13 ** /B  **/SEG_E
N/C          ** B   **  9-|   3    |-12 ** /B  **/SEG_F
GND          ** OV  ** 10-|        |-11 ** /B  **/SEG_G
                          ----------
                                                    TB01060S
```

Figure 5. Pin List Of Binary-To-7 Segment Decoder Generated By AMAZE

BCD-To-7 Segment Decoder

Using the same principle as in the previous example, a BCD input may be converted to a 7 segment display. If the input will always be within the range of 0000B to 1001B, the design will take ten AND terms to implement the decoding function. But if the display of an error message is desired when input exceeds 1001B, the design shown in Figures 5 and 6 and Table 5, may be used. Alternatively, the error message "E" will be displayed if the input does not equal anything between 0000B and 1001B inclusively. The circuit used to detect that none of the ten AND terms being true is shown in Figure 7 where if the input is outside of the range of 0000B to 1001B, none of the terms ZER to NIN will be active, which in turn causes the output of the NOR term to be HIGH. The HIGH output then causes the "E" term to be active and thus an output "E" is displayed. This scheme takes two propagation delays before "E" is displayed but only one delay for "0" to "9" to be displayed. The circuit shown in Figure 7 is implemented as shown in Table 4, column $B(O)_0$ of terms 0 to 9, and term #11. The output $B(O)_0$ becomes HIGH when terms 0 to 9 are inactive, $(T_0 + T_1 + T_2 + T_3 + T_4 + T_5 + T_6 + T_7 + T_8 + T_9) = 0$ where T_0 is term #0, T_1 is term #1, T_2 is . . ., etc. $B(O)_0$ is then fed back to the input of term #11 which, when active, causes outputs B and C to be HIGH, segments B and C to turn off and the other segments to turn on. Term #10 is left blank to separate the main decoding function and the feedback function for the sake of clarity of this demonstration. A similar feature (the COMPLEMENT ARRAY) may be found in PLS155/157/159 where the feedback path is buried inside the chip without having to use up one I/O pin. Notice that this feature greatly reduces the number of AND terms needed. But for device architectures which do not allow common AND terms, this logic minimization will not be possible. Figure 8 and Table 6 implement design with AMAZE. The circuit is then simulated as shown in Figure 9.

```
N@DEVICE TYPE
82S153
@DRAWING
********************** BCD-TO-7 SEGMENT DECODER
@REVISION
********************** REV. -
@DATE
********************** OCT 1, 1984
@SYMBOL
********************** FILE ID: BCD-7153
@COMPANY
********************** SIGNETICS
@NAME
********************** DAVID K. WONG
@DESCRIPTION
*****************************************************************************
*   This circuit converts a 4-bit BCD code into a 7-segment display.        *
*   The display is a common anode 7-segment LED.                            *
*   The output of the 82S153 goes LOW for each segment that is ON.          *
*****************************************************************************
```



TRUTH TABLE

Z	Y	X	W	a	b	c	d	e	f	g	
0	0	0	0	0	0	0	0	0	0	1	
0	0	0	1	1	0	0	1	1	1	1	
0	0	1	0	0	0	1	0	0	1	0	
0	0	1	1	0	0	0	0	1	1	0	
0	1	0	0	1	0	0	1	1	0	0	
0	1	0	1	0	1	0	0	1	0	0	
0	1	1	0	0	1	0	0	0	0	0	
0	1	1	1	0	0	0	1	1	1	1	
1	0	0	0	0	0	0	0	0	0	0	
1	0	0	1	0	0	0	0	1	0	0	
1	0	1	0	1	0	0	1	1	1	1	Display E (error)
1	0	1	1	1	0	0	1	1	1	1	"
1	1	0	0	1	0	0	1	1	1	1	"
1	1	0	1	1	0	0	1	1	1	1	"
1	1	1	0	1	0	0	1	1	1	1	"
1	1	1	1	1	0	0	1	1	1	1	"

```
@COMMON PRODUCT TERM
ZER = /z * /y * /x * /w  ;
ONE = /z * /y * /x *  w  ;
TWO = /z * /y *  x * /w  ;
THR = /z * /y *  x *  w  ;
FOU = /z *  y * /x * /w  ;
FIV = /z *  y * /x *  w  ;
SIX = /z *  y *  x * /w  ;
SEV = /z *  y *  x *  w  ;
EIG =  z * /y * /x * /w  ;
NIN =  z * /y * /x *  w  ;
AAA =  z * /y *  x * /w  ;
BBB =  z * /y *  x *  w  ;
CCC =  z *  y * /x * /w  ;
DDD =  z *  y * /x *  w  ;
EEE =  z *  y *  x * /w  ;
FFF =  z *  y *  x *  w  ;
```

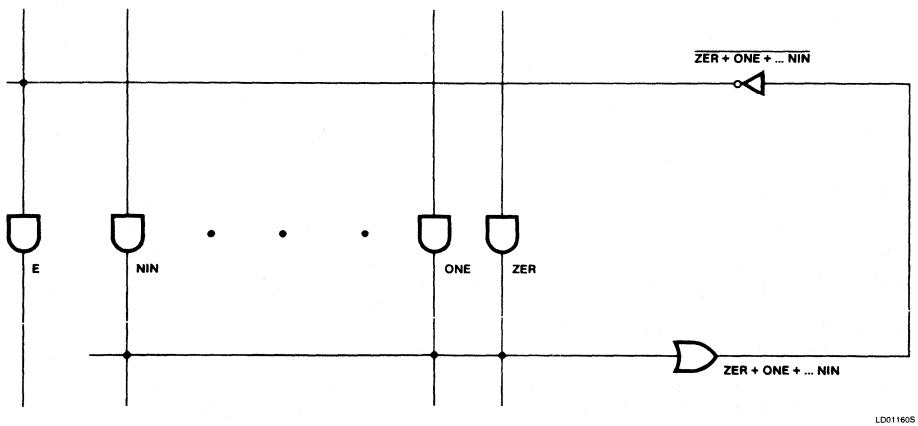
TB01071S

Figure 6. Boolean Equations for BCD-To-7 Segment Decoder for AMAZE

```
@LOGIC EQUATION
/SEG_A =      ONE + FOU + AAA
/SEG_B =      FIV + SIX
/SEG_C =      TWO
/SEG_D =   /( ZER + TWO + THR
/SEG_E =   /( ZER + TWO + SIX
/SEG_F =   /( ZER + FOU + FIV
/SEG_G =   /( TWO + THR + FOU

@I/O DIRECTION 150/1, 152/3,
"
*****************************
*              OUTPUTS ARE ENA
*              THEREFORE, D1..
*****************************
"
D1 = OE  ;
D2 = OE  ;
D3 = OE  ;
D4 = OE  ;
D5 = OE  ;
D6 = OE  ;
D7 = OE  ;

"
*****************************
*                        END
*****************************
"
```

TB01081S

Figure 6 (Continued)



LD01160S

Figure 7. Complement Array — "None of the Above" Detection Circuit

Table 5. H/L Table for BCD-To-7 Segment Decoder Generated by AMAZE

```
Cust/Project - ********************** DAVID K. WONG
Date         - ********************** OCT 1, 1984
Rev/I. D.    - ********************** REV. -

82S153                                  !      POLARITY       !
                                        !H:H:H:H:H:L:L:L:L:H!
 T !
 E !-----------------------------------------------------------
 R !        I         !         B(i)          !         B(o)
 M !-----------------------------------------------------------
___!7_6_5_4_3_2_1_0!9_8_7_6_5_4_3_2_1_0!9_8_7_6_5_4_3_2_1_0!
 0!- - - -,L L L H!- -,- - - -,- - - -!A A,A . . .,. . . A!
 1!- - - -,L H L L!- -,- - - -,- - - -!A A,A . . .,. A A A!
 2!- - - -,H L H L!- -,- - - -,- - - -!A A,A . . .,. . . A!
 3!- - - -,H L H H!- -,- - - -,- - - -!A A,A . . .,. . . A!
 4!- - - -,H H L L!- -,- - - -,- - - -!A A,A . . .,. . . A!
 5!- - - -,H H L H!- -,- - - -,- - - -!A A,A . . .,. . . A!
 6!- - - -,H H H L!- -,- - - -,- - - -!A A,A . . .,. . . A!
 7!- - - -,H H H H!- -,- - - -,- - - -!A A,A . . .,. . . A!
 8!- - - -,L H L H!- -,- - - -,- - - -!A A,. A . A,. A A A!
 9!- - - -,L H H L!- -,- - - -,- - - -!A A,. A . A,A A A A!
10!- - - -,L L H L!- -,- - - -,- - - -!A A,. . A A,A . A A!
11!- - - -,L L L L!- -,- - - -,- - - -!A A,. . . A,A A . A!
12!- - - -,L L H H!- -,- - - -,- - - -!A A,. . . A,. . A A!
13!- - - -,H L L L!- -,- - - -,- - - -!A A,. . . A,A A A A!
14!- - - -,H L L H!- -,- - - -,- - - -!A A,. . . A,. A A A!
15!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
16!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
17!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
18!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
19!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
20!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
21!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
22!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
23!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
24!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
25!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
26!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
27!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
28!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
29!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
30!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
31!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
D9!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!
D8!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!
D7!L - - -,- - - -!- -,- - - -,- - - -!
D6!L - - -,- - - -!- -,- - - -,- - - -!
D5!L - - -,- - - -!- -,- - - -,- - - -!
D4!L - - -,- - - -!- -,- - - -,- - - -!
D3!L - - -,- - - -!- -,- - - -,- - - -!
D2!L - - -,- - - -!- -,- - - -,- - - -!
D1!L - - -,- - - -!- -,- - - -,- - - -!
D0!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!

   / N N N Z Y X W N N / / / / / / / N N N / / / / / / / N
   0 / / /         / / S S S S S S S / / / S S S S S S S /
   E C C C         C C E E E E E E E C C C E E E E E E E C
                     G G G G G G G       G G G G G G G
                     - - - - - - -       - - - - - - -
                     A B C D E F G       A B C D E F G
                                                  TB01090S
```

```
@DEVICE TYPE
********************** 82S153
@DRAWING
********************** BINARY-TO-7 SEGMENT DECODER
@REVISION
********************** REV. -
@DATE
********************** OCT 1, 1984
@SYMBOL
********************** FILE ID: BCD77153
@COMPANY
********************** SIGNETICS
@NAME
********************** DAVID K. WONG
@DESCRIPTION
*****************************************************************************
*   This circuit converts a 4-bit BCD code into a 7-segment display.        *
*   The display is a common anode 7-segment LED.                            *
*   The output of the 82S153 goes LOW for each segment that is ON.          *
*****************************************************************************
```


TRUTH TABLE

Z	Y	X	W	a	b	c	d	e	f	g	
0	0	0	0	0	0	0	0	0	0	1	
0	0	0	1	1	0	0	1	1	1	1	
0	0	1	0	0	0	1	0	0	1	0	
0	0	1	1	0	0	0	0	1	1	0	
0	1	0	0	1	0	0	1	1	0	0	
0	1	0	1	0	1	0	0	1	0	0	
0	1	1	0	0	1	0	0	0	0	0	
0	1	1	1	0	0	0	1	1	1	1	
1	0	0	0	0	0	0	0	0	0	0	
1	0	0	1	0	0	0	0	1	0	0	
1	0	1	0	0	1	1	0	0	0	0	Over Range, Display E (error)
1	0	1	1	0	1	1	0	0	0	0	"
1	1	0	0	0	1	1	0	0	0	0	"
1	1	0	1	0	1	1	0	0	0	0	"
1	1	1	0	0	1	1	0	0	0	0	"
1	1	1	1	0	1	1	0	0	0	0	"

```
@COMMON PRODUCT TERM
ZER = /z * /y * /x * /w  ;
ONE = /z * /y * /x *  w  ;
TWO = /z * /y *  x * /w  ;
THR = /z * /y *  x *  w  ;
FOU = /z *  y * /x * /w  ;
FIV = /z *  y * /x *  w  ;
SIX = /z *  y *  x * /w  ;
SEV = /z *  y *  x *  w  ;
EIG =  z * /y * /x * /w  ;
NIN =  z * /y * /x *  w  ;
```

TB01101S

Figure 8. Boolean Equation for BCD-To-7 Segment Decoder

```
@LOGIC EQUATION

"
*************************************************************************
*  When input is greater than 9, OVR ( Over Range ) will go HIGH, WHICH  *
*  will be fed-back to the AND array to control the segments.            *
*  Here the OVR pin and the feedback loop is used as COMPLEMENT ARRAY.   *
*  The COMPLEMENT ARRAY saves 5 P-terms but loses one I/O pin.           *
*************************************************************************
"

OVR = /( ZER + ONE + TWO + THR + FOU + FIV + SIX + SEV + EIG + NIN  ) ;
/SEG_A =     ONE + FOU                                               ;
/SEG_B =     FIV + SIX + OVR                                         ;
/SEG_C =     TWO + OVR                                               ;
/SEG_D =     ONE + FOU + SEV                                         ;
/SEG_E =  /( ZER + TWO + SIX + EIG + OVR                           ) ;
/SEG_F =     ONE + TWO + THR + SEV                                   ;
/SEG_G =     ZER + ONE + SEV                                         ;

@I/O DIRECTION 150/1, 152/3, 154-9
"
*************************************************************************
*             OUTPUTS ARE ENABLED WHEN /OE GOES LOW.                    *
*             THEREFORE, D1...D7 = /(/OE)  =  OE      ;                 *
*************************************************************************
"
D1 = OE  ;
D2 = OE  ;
D3 = OE  ;
D4 = OE  ;
D5 = OE  ;
D6 = OE  ;
D7 = OE  ;

"
*************************************************************************
*                          END OF LOGIC EQUATIONS                       *
*************************************************************************
"
```

TB01111S

Figure 8 (Continued)

Table 6. H/L Table of BCD-To-7 Segment Decoder Generated by AMAZE

```
Cust/Project - ********************** DAVID K. WONG
Date         - ********************** OCT 1, 1984
Rev/I. D.    - ********************** REV. -

82S153                                          !      POLARITY       !
___                                             !---------------------!
 T !                                            !H:H:H:H:H:H:L:H:H:L!
 E !-------------------------------------------------------------------
 R !        I          !          B(i)          !          B(o)        !
 M !-------------------------------------------------------------------
___!7_6_5_4_3_2_1_0!9_8_7_6_5_4_3_2_1_0!9_8_7_6_5_4_3_2_1_0!
  0!- - - -,L L L L!- -,- - - -,- - - -!A A,. . . .,A . A A!
  1!- - - -,L L L H!- -,- - - -,- - - -!A A,A . . A,. A A A!
  2!- - - -,L L H L!- -,- - - -,- - - -!A A,. . A .,A A . A!
  3!- - - -,L L H H!- -,- - - -,- - - -!A A,. . . .,. A . A!
  4!- - - -,L H L L!- -,- - - -,- - - -!A A,A . . A,. . . A!
  5!- - - -,L H L H!- -,- - - -,- - - -!A A,. A . .,. . . A!
  6!- - - -,L H H L!- -,- - - -,- - - -!A A,. A . . ,A . . A!
  7!- - - -,L H H H!- -,- - - -,- - - -!A A,. . . A,. A A A!
  8!- - - -,H L L L!- -,- - - -,- - - -!A A,. . . .,A . . A!
  9!- - - -,H L L H!- -,- - - -,- - - -!A A,. . . .,. . . A!
 10!- - - -,- - - -!- -,- - - -,- - - H!A A,. A A .,A . . .!
 11!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 12!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 13!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 14!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 15!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 16!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 17!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 18!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 19!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 20!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 21!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 22!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 23!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 24!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 25!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 26!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 27!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 28!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 29!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 30!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 31!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 D9!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!
 D8!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!
 D7!L - - -,- - - -!- -,- - - -,- - - -!
 D6!L - - -,- - - -!- -,- - - -,- - - -!
 D5!L - - -,- - - -!- -,- - - -,- - - -!
 D4!L - - -,- - - -!- -,- - - -,- - - -!
 D3!L - - -,- - - -!- -,- - - -,- - - -!
 D2!L - - -,- - - -!- -,- - - -,- - - -!
 D1!L - - -,- - - -!- -,- - - -,- - - -!
 D0!- - - -,- - - -!- -,- - - -,- - - -!

   / N N N Z Y X W N N / / / / / / / O N N / / / / / / / O
   O / / /         / / S S S S S S S V / / S S S S S S S V
   E C C C         C C E E E E E E E R C C E E E E E E E R
                     G G G G G G G       G G G G G G G
                     _ _ _ _ _ _ _       _ _ _ _ _ _ _
                     A B C D E F G       A B C D E F G

                                                    TB01120S
```

4-Bit Binary-To-7 Segment Decoder

AN10

```
B2S153    A:bcd77153.STD
" yhgfikuhyfouiy
"
"  INPUTS  <=B(I/O)=>    TRACE TERMS
" 76543210 9876543210
"
  00000000 ..LLLLLLHL ;
  00001111 ..LHHLLLLH ;
  10001111 .........H ;
  00000000 ..LLLLLLHL ;
  01000001 ..HLLHHHHL ;
  01000010 ..LLHLLHLL ;
  01000011 ..LLLLHHLL ;
  01000100 ..HLLHHLLL ;
  01000101 ..LHLLHLLL ;
  01000110 ..LHLLLLLL ;
  01000111 ..LLLHHHHL ;
  01001000 ..LLLLLLLL ;
  01001001 ..LLLLHLLL ;
  01001010 ..LHHLLLLH ;
  01001011 ..LHHLLLLH ;
  01001100 ..LHHLLLLH ;
  01001101 ..LHHLLLLH ;
  01001110 ..LHHLLLLH ;
  01001111 ..LHHLLLLH ;
  11001111 .........H ;
  10000000 .........L ;
"
" X------- ----------   I/O CONTROL LINES
"          IIBBBBBBBO   DESIGNATED I/O USAGE
"          IIBBBBBBBO   ACTUAL I/O USAGE
"
" PIN LIST...
" 08 07 06 05 04 03 02 01 19 18 17 16 15 14 13 12 11 09 ;
                                                    TB01130S
```

Figure 9. Simulation Results of H/L Table

BCD-To-7 Segment Decoder with Output Latches

Output latches may be constructed by using the bi-directional I/Os of PLS153/153A as shown in Figure 10. When /LE (latch enable) is HIGH, the output equals the input. But when /LE is LOW, the output is latched. Changing the input will not effect the output. Segments a and e are used to illustrate the decoding and latch circuit as shown in Figures 11 and 12 which are expressed in H/L format as shown in Table 8. The complete design of the decoder is shown in Figures 13 and 14 and Table 7. With the output latches, the circuit cannot be tri-stated since the tri-state condition will interrupt the feedback path. An alternative approach is shown in Figure 15 where the display is a common cathode, the segment drivers are always on and the duty cycling is implemented with a digit driver which pulls the common cathode of the display to ground as the input "Duty Cycle" goes HIGH. A common practice is to drive the segments with 10 time the desired DC current and drive the digit with a 10% duty cycle pulse. The H/L implementation is as shown in Tables 9 and 10. The "Duty Cycle" control input is generated externally.

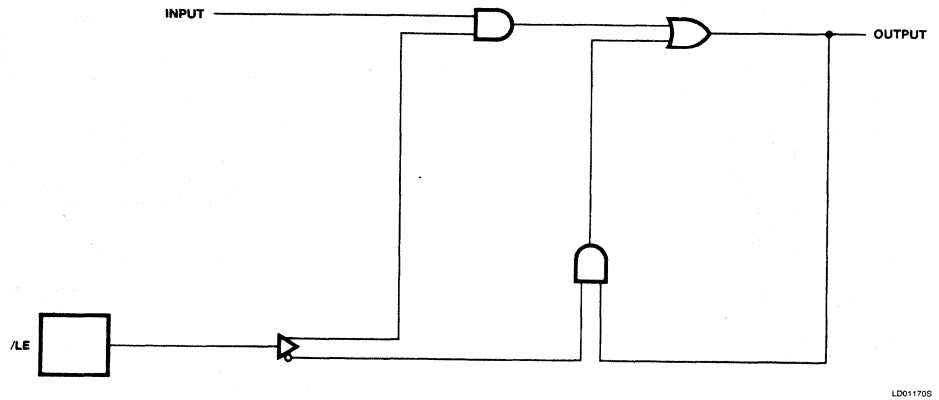


Figure 10. Block Diagram Of A Simple D-Latch

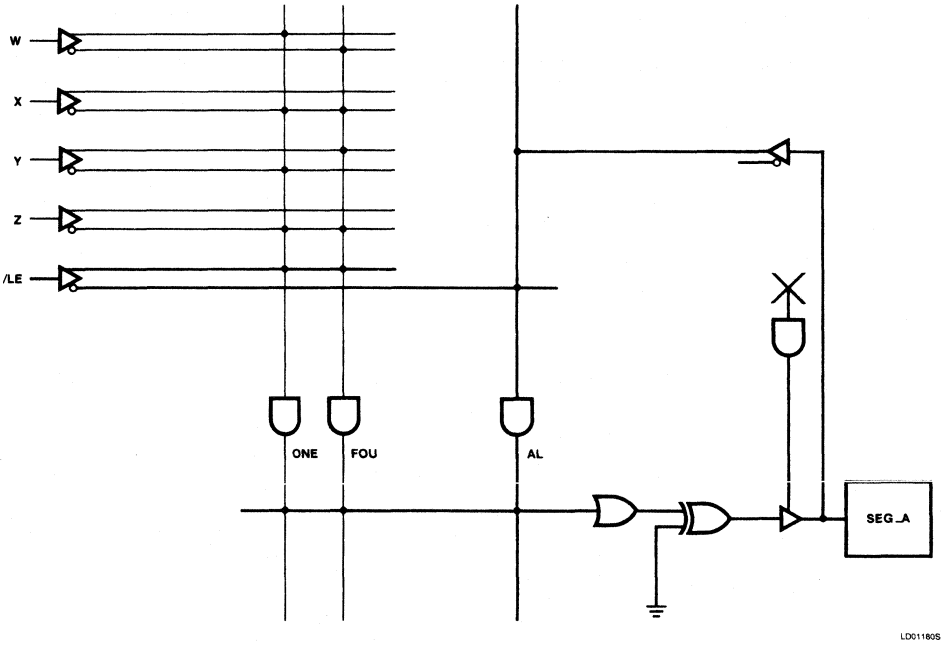


Figure 11. Segment-A Latch Circuit

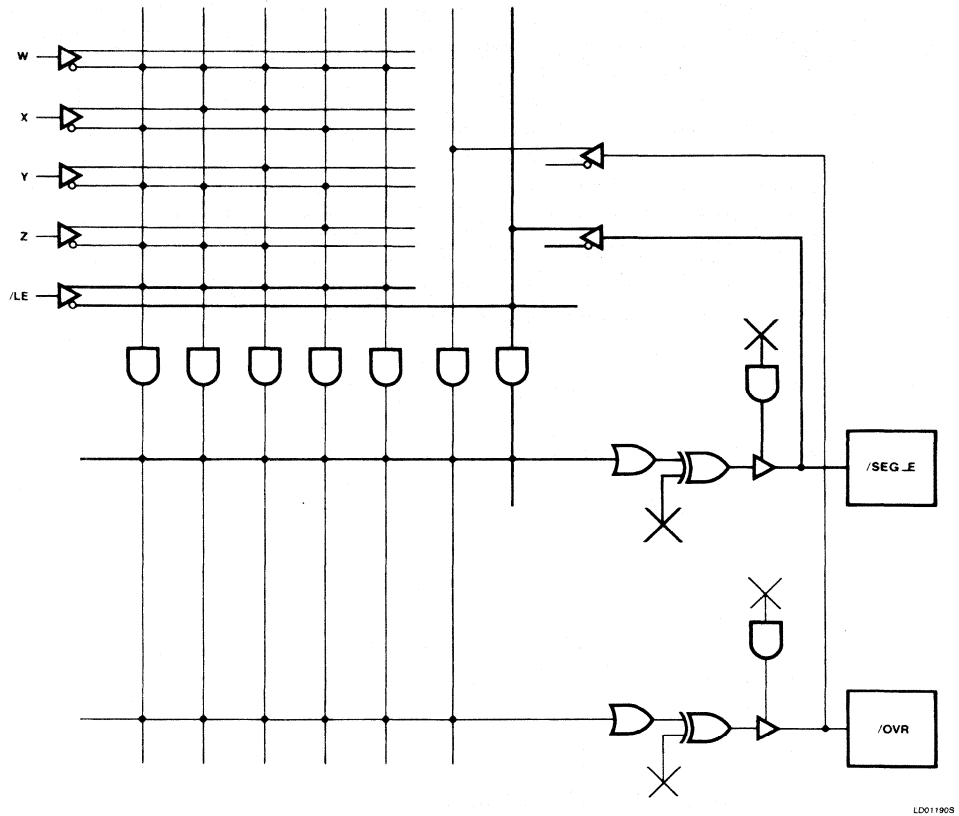


Figure 12. Segment-E Latch

```
********************* P I N   L I S T **********************

   LABEL     ** FNC **PIN --------- PIN** FNC **    LABEL
W            ** I   **  1-¦        ¦-20 ** +5V **VCC
X            ** I   **  2-¦        ¦-19 ** B   **N/C
Y            ** I   **  3-¦        ¦-18 ** B   **N/C
Z            ** I   **  4-¦   8    ¦-17 ** O   **/SEG_A
N/C          ** I   **  5-¦   2    ¦-16 ** O   **/SEG_B
N/C          ** I   **  6-¦   5    ¦-15 ** O   **/SEG_C
/LE          ** I   **  7-¦   1    ¦-14 ** O   **/SEG_D
N/C          ** I   **  8-¦   5    ¦-13 ** /O  **/SEG_E
OVR          ** /O  **  9-¦   3    ¦-12 ** O   **/SEG_F
GND          ** OV  ** 10-¦        ¦-11 ** O   **/SEG_G
                         ---------
                                                TB01140S
```

Figure 13. Pin List of BCD-To-7 Segment Decoder with Latches

9

```
@DEVICE TYPE
82S153
@DRAWING
********************** BCD-TO-7 SEGMENT DECODER
@REVISION
********************** REV. -
@DATE
********************** OCT 1, 1984
@SYMBOL
********************** FILE ID: BCD7L153
@COMPANY
********************** SIGNETICS
@NAME
********************** DAVID K. WONG
@DESCRIPTION
*****************************************************************************
*   This circuit converts a 4-bit BCD code into a 7-segment display.        *
*   The display is a common anode 7-segment LED.                            *
*   The output of the 82S153 goes LOW for each segment that is ON.          *
*   The outputs are latched when /LE goes LOW.                              *
*****************************************************************************

                                    TRUTH TABLE
          a                  Z Y X W      a  b  c  d  e  f  g
       -------              ------------------------------------
   f  |       | b           0 0 0 0      0  0  0  0  0  0  1
      |   g   |             0 0 0 1      1  0  0  1  1  1  1
       -------              0 0 1 0      0  0  1  0  0  1  0
   e  |       | c           0 0 1 1      0  0  0  0  1  1  0
      |       |             0 1 0 0      1  0  0  1  1  0  0
       -------              0 1 0 1      0  1  0  0  1  0  0
          d                 0 1 1 0      0  1  0  0  0  0  0
                            0 1 1 1      0  0  0  1  1  1  1
                            1 0 0 0      0  0  0  0  0  0  0
                            1 0 0 1      0  0  0  0  1  0  0

          Over Range        1 0 1 0      0  1  1  0  0  0  0   Display E (error)
                "           1 0 1 1      0  1  1  0  0  0  0         "
                "           1 1 0 0      0  1  1  0  0  0  0         "
                "           1 1 0 1      0  1  1  0  0  0  0         "
                "           1 1 1 0      0  1  1  0  0  0  0         "
                "           1 1 1 1      0  1  1  0  0  0  0         "

@COMMON PRODUCT TERM
ZER = /z * /y * /x * /w * /LE  ;
ONE = /z * /y * /x *  w * /LE  ;
TWO = /z * /y *  x * /w * /LE  ;
THR = /z * /y *  x *  w * /LE  ;
FOU = /z *  y * /x * /w * /LE  ;
FIV = /z *  y * /x *  w * /LE  ;
SIX = /z *  y *  x * /w * /LE  ;
SEV = /z *  y *  x *  w * /LE  ;
EIG =  z * /y * /x * /w * /LE  ;
NIN =  z * /y * /x *  w * /LE  ;

"
*****************************************************************************
*                 Feedback circuits to form D-latches.                      *
*****************************************************************************
TB01150S
```

Figure 14. Boolean Equation of BCD-To-7 Segment Decoder with Latches

```
"
AL  =  LE * /SEG_A  ;
BL  =  LE * /SEG_B  ;
CL  =  LE * /SEG_C  ;
DL  =  LE * /SEG_D  ;
EL  =  LE *  SEG_E  ; "Note that in LOGIC EQUATION definition, SEG_E is
                       inverted. Therefore, the feedback for E has to
                       be inverted too."
FL  =  LE * /SEG_F  ;
GL  =  LE * /SEG_G  ;

@LOGIC EQUATION

"
*************************************************************************
*  When input is greater than 9, OVR ( Over Range ) will go HIGH, WHICH  *
*  will be fed-back to the AND array to control the segments.            *
*  Here the OVR pin and the feedback loop is used as COMPLEMENT ARRAY.   *
*  The COMPLEMENT ARRAY saves 5 P-terms but uses up one I/O pin.         *
*************************************************************************
"

OVR = /( ZER + ONE + TWO + THR + FOU + FIV + SIX + SEV + EIG + NIN + LE ) ;
/SEG_A =      ONE + FOU +  AL                                            ;
/SEG_B =      FIV + SIX + OVR + BL                                       ;
/SEG_C =      TWO + OVR +  CL                                            ;
/SEG_D =      ONE + FOU + SEV + DL                                       ;
/SEG_E =  /( ZER + TWO + SIX + EIG + OVR + EL                          ) ;
/SEG_F =      ONE + TWO + THR + SEV + FL                                 ;
/SEG_G =      ZER + ONE + SEV + GL                                       ;

@I/O DIRECTION
"
*************************************************************************
*                          END OF LOGIC EQUATIONS                       *
*************************************************************************
"
```

TB01160S

Figure 14 (Continued)

4-Bit Binary-To-7 Segment Decoder

AN10

Table 7. H/L Table of BCD-To-7 Segment Decoder with Latches

```
Cust/Project - ********************** DAVID K. WONG
Date         - ********************** OCT 1, 1984
Rev/I. D.    - ********************** REV. -

82S153                                          !     POLARITY      !
                                                !H:H:H:H:H:H:L:H:H:L!
 T !
 E !-----------------------------------------------------------------
 R !       I          !        B(i)            !        B(o)        !
 M !-----------------------------------------------------------------
   !7_6_5_4_3_2_1_0!9_8_7_6_5_4_3_2_1_0!9_8_7_6_5_4_3_2_1_0!
 0!- H - -,L L L L!- -,- - - -,- - - -!A A,. . . .,A . A A!
 1!- H - -,L L L H!- -,- - - -,- - - -!A A,A . . A,. A A A!
 2!- H - -,L L H L!- -,- - - -,- - - -!A A,. . A .,A A . A!
 3!- H - -,L L H H!- -,- - - -,- - - -!A A,. . . .,. A . A!
 4!- H - -,L H L L!- -,- - - -,- - - -!A A,A . . A,. . . A!
 5!- H - -,L H L H!- -,- - - -,- - - -!A A,. A . .,. . . A!
 6!- H - -,L H H L!- -,- - - -,- - - -!A A,. A . .,A . . A!
 7!- H - -,L H H H!- -,- - - -,- - - -!A A,. . . A,. A A A!
 8!- H - -,H L L L!- -,- - - -,- - - -!A A,. . . .,A . . A!
 9!- H - -,H L L H!- -,- - - -,- - - -!A A,. . . .,. . . A!
10!- L - -,- - - -!- -,- - - -,- - - -!A A,. . . .,. . . A!
11!- L - -,- - - -!- -,H - - -,- - - -!A A,A . . .,. . . .!
12!- - - -,- - - -!- -,- - - -,- - - H!A A,. A A .,A . . .!
13!- L - -,- - - -!- -,- H - -,- - - -!A A,. A . .,. . . .!
14!- L - -,- - - -!- -,- - H -,- - - -!A A,. . A .,. . . .!
15!- L - -,- - - -!- -,- - - H,- - - -!A A,. . . A,. . . .!
16!- L - -,- - - -!- -,- - - -,L - - -!A A,. . . .,A . . .!
17!- L - -,- - - -!- -,- - - -,- H - -!A A,. . . .,. A . .!
18!- L - -,- - - -!- -,- - - -,- - H -!A A,. . . .,. . A .!
19!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
20!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
21!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
22!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
23!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
24!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
25!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
26!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
27!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
28!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
29!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
30!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
31!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
D9!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!
D8!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!
D7!- - - -,- - - -!- -,- - - -,- - - -!
D6!- - - -,- - - -!- -,- - - -,- - - -!
D5!- - - -,- - - -!- -,- - - -,- - - -!
D4!- - - -,- - - -!- -,- - - -,- - - -!
D3!- - - -,- - - -!- -,- - - -,- - - -!
D2!- - - -,- - - -!- -,- - - -,- - - -!
D1!- - - -,- - - -!- -,- - - -,- - - -!
D0!- - - -,- - - -!- -,- - - -,- - - -!

   N / N N Z Y X W N N / / / / / / / O N N / / / / / / / O
   / L / /         / / S S S S S S S V / / S S S S S S S V
   C E C C         C C E E E E E E E R C C E E E E E E E R
                     G G G G G G G       G G G G G G G
                     _ _ _ _ _ _ _       _ _ _ _ _ _ _
                     A B C D E F G       A B C D E F G
                                                    TB01170S
```

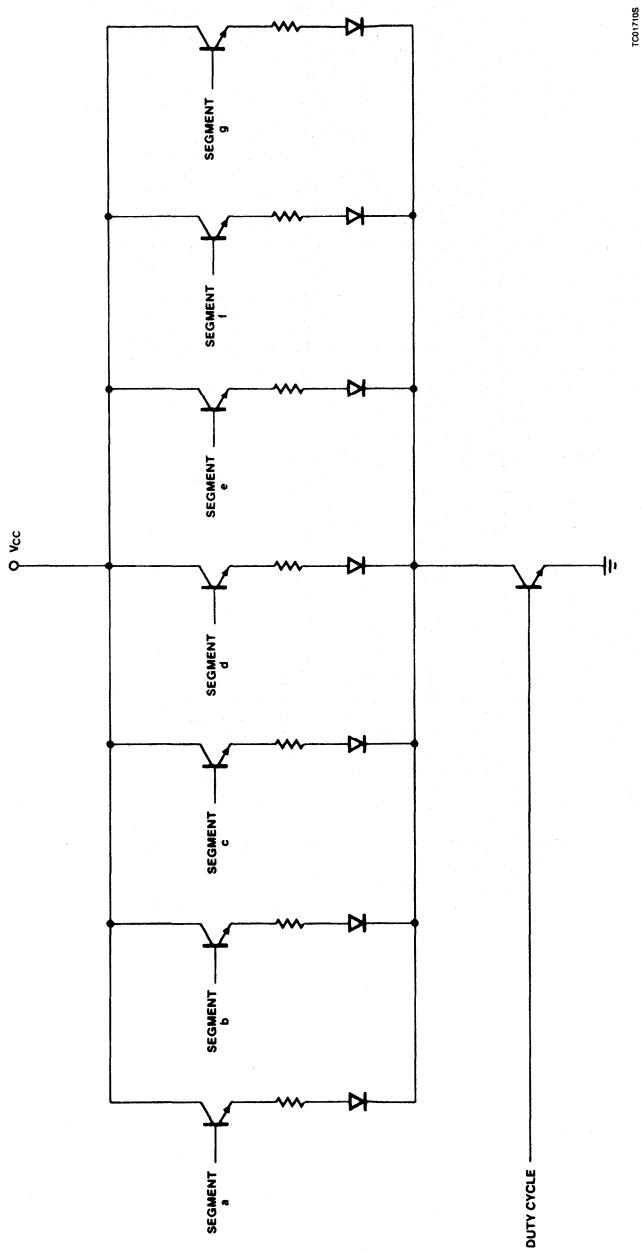


Figure 15. Segment Drivers & Digit Driver

4-Bit Binary-To-7 Segment Decoder

AN10

Table 8. BCD-To-7 Segment Decoder Using Complement Array

82S153/153A PROGRAMMING TABLE DRAWING ID: BCD TO 7SEG DECODER REV. —

DESIGNER: D.K. WONG DATE: 12/15/84

	AND I 7:6:5:4	AND I 3:2:1:0	AND B(I) 9:8	AND B(I) 7:6:5:4	AND B(I) 3:2:1:0	OR B(O) 9:8	OR B(O) 7:6:5:4	OR B(O) 3:2:1:0	
POLARITY	H:H:H:H	L:L:L:H	H:H	H:H:H:H	H:H:H:L	H:H	H:H:H:H	H:H:H:L	
0	— — — —	L L L L	— —	— — — —	— — — —	· ·	· · · ·	· · · A	A
1	— — — —	L L L H	— —	— — — —	— — — —	· ·	· · · A	· · · A	A
2	— — — —	L L H L	— —	— — — —	— — — —	· ·	· · A ·	· · · A	A
3	— — — —	L L H H	— —	— — — —	— — — —	· ·	· · A A	· · · ·	A
4	— — — —	L H L L	— —	— — — —	— — — —	· ·	· A · ·	· · · A	A
5	— — — —	L H L H	— —	— — — —	— — — —	· ·	· A · A	· · · ·	A
6	— — — —	L H H L	— —	— — — —	— — — —	· ·	· A A ·	· · · ·	A
7	— — — —	L H H H	— —	— — — —	— — — —	· ·	· A A A	· · · ·	A
8	— — — —	H L L L	— —	— — — —	— — — —	· ·	· · · ·	· · · ·	A (*)
9	— — — —	H L L H	— —	— — — —	— — — —	· ·	· A · ·	· · · A	A
10									
11						· ·	· A A ·	· · · ·	"E" FOR OVER-RANGE. B(2)0 AND TRA11 FORM A COMPLEMENT ARRAY.
12									
13									
14									
15									
16									
17									
18									
19									
20									
21									
22									
23									
24									
25									
26									
27									
28									
29									
30									
31									
D9									
D8									
D7	L								
D6	L								
D5	L								
D4	L								
D3	L								
D2	L								
D1	L								
D0	L								
NAME	DE	Z Y X W			LOW	A B C D E F G		LOW	

(*) NOTICE THAT IN THIS PARTICULAR APPLICATION, THIS TERM MUST BE PRESENT FOR THE COMPLEMENT ARRAY TO FUNCTION PROPERLY.

TB01180S

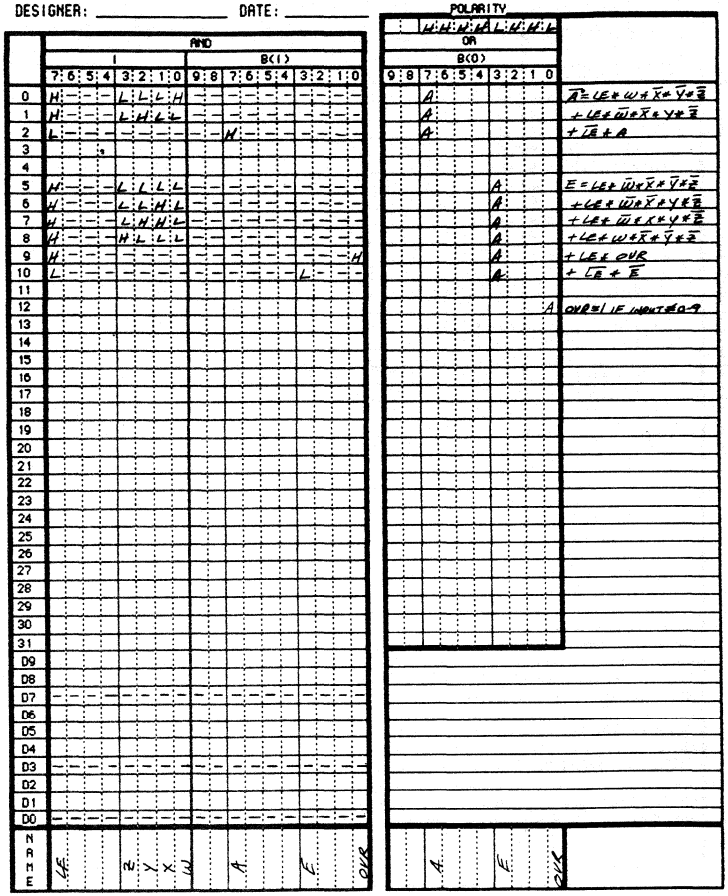
4-Bit Binary-To-7 Segment Decoder

AN10

Table 9. Segments A and E with Latches

82S153/153A PROGRAMMING TABLE DRAWING ID:_____ REV. _____

DESIGNER: _____ DATE: _____



TB01191S

4-Bit Binary-To-7 Segment Decoder — AN10

Table 10. H/L Table of BCD-To-7 Segment Decoder with Latches with Outputs Active High

82S153/153A PROGRAMMING TABLE DRAWING ID: BCD 7LM REV. —

DESIGNER: D. K. WONG DATE: 12/26/84

POLARITY: L L L L L L L L

	AND I								AND B(I)								OR B(O)								
	7	6	5	4	3	2	1	0	9	8	7	6	5	4	3	2	1	0	9	8	7	6	5	4	3	2	1	0	
0	-	H	-	-	L	L	L	L	-	-	-	-	-	-	-	-	-	-			•	•	•	•	•	•	A	A	0
1	-	H	-	-	L	L	L	H	-	-	-	-	-	-	-	-	-	-			A	•	•	A	A	A	A	A	1
2	-	H	-	-	L	L	H	L	-	-	-	-	-	-	-	-	-	-			•	•	A	•	•	A	•	A	2
3	-	H	-	-	L	L	H	H	-	-	-	-	-	-	-	-	-	-			•	•	•	•	A	A	•	A	3
4	-	H	-	-	L	H	L	L	-	-	-	-	-	-	-	-	-	-			A	•	•	A	A	•	•	A	4
5	-	H	-	-	L	H	L	H	-	-	-	-	-	-	-	-	-	-			•	A	•	•	A	•	•	A	5
6	-	H	-	-	L	H	H	L	-	-	-	-	-	-	-	-	-	-			•	A	•	•	•	•	•	A	6
7	-	H	-	-	L	H	H	H	-	-	-	-	-	-	-	-	-	-			•	•	•	A	A	A	A	A	7
8	-	H	-	-	H	L	L	L	-	-	-	-	-	-	-	-	-	-			•	•	•	•	•	•	•	A	8
9	-	H	-	-	H	L	L	H	-	-	-	-	-	-	-	-	-	-			•	•	•	•	A	•	•	A	9
10																													
11	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	H			•	A	A	•	•	•	•	•	E (ERROR)
12																													
13	-	L	-	-	-	-	-	-	L	-	-	-	-	-	-	-	-	-			A	•	•	•	•	•	•	•	SEG A LATCH
14	-	L	-	-	-	-	-	-	-	L	-	-	-	-	-	-	-	-			•	A	•	•	•	•	•	•	" B "
15	-	L	-	-	-	-	-	-	-	-	L	-	-	-	-	-	-	-			•	•	A	•	•	•	•	•	" C "
16	-	L	-	-	-	-	-	-	-	-	-	L	-	-	-	-	-	-			•	•	•	A	•	•	•	•	" D "
17	-	L	-	-	-	-	-	-	-	-	-	-	L	-	-	-	-	-			•	•	•	•	A	•	•	•	" E "
18	-	L	-	-	-	-	-	-	-	-	-	-	-	L	-	-	-	-			•	•	•	•	•	A	•	•	" F "
19	-	L	-	-	-	-	-	-	-	-	-	-	-	-	L	-	-	-			•	•	•	•	•	•	A	•	" G "
20																													
21																													
22																													
23																													
24																													
25																													
26																													
27																													
28																													
29																													
30																													
31																													
D9																													
D8																													
D7																													
D6																													
D5																													
D4																													
D3																													
D2																													
D1																													
D0																													
NAME	I/E				I	X	X	X										OVR			A	B	C	D	E	F	G	OVR	

ALL OUTPUT POLARITIES ARE INVERTED SO THAT AN "A" CAUSES A "LOW" OUTPUT, A "•" CAUSES A "HIGH" OUTPUT.

SINCE ALL OUTPUTS ARE INVERTED, THE FEEDBACK CIRCUITS FOR THE LATCHES ARE ALSO INVERTED.

THE OVR OUTPUT CREATES THE "ERROR" DISPLAY IF INPUT ≠ (0 TO 9)

TB01200S

Signetics

AN11
PLD Programmable Retriggerable One-Shot

Application Note

Application Specific Products

FEATURES

- **Programmable pulse-width/delay**
- **Maximum 256 clock cycles**
- **Asynchronous TRIGGER input**
- **Active HIGH and active LOW outputs**
- **Asynchronous RESET**
- **20-pin package**

THEORY OF OPERATION

The one-shot consists of an FPLS PLS159 and an external clock which may be part of the system in which this one-shot is to work. As shown in Figure 1 and Table 1 the FPLS is configured to have a latch and an eight-bit binary up counter which is presettable by input data to any number less than 256. Since the input data is inverted before it is loaded into the registers, counting from the complements of the input to FF will give the correct number of counts as counting from the input down to 00.

Pulse-width/delay inputs may be the outputs of another device or switches. When /RESET goes LOW, flip flops are set to all 1's (terms PB and PA). At the rising edge of the next clock, data is latched into the registers (terms LB and LA). When /TRIG goes LOW, it is latched into the input latch formed by term # 0, 1, 2 and 13. The output O_1 of the latch goes HIGH and O_2 goes LOW which enables the 8-bit counting cycle. The O_1 and $/O_1$ will maintain their output levels until the end of the counting cycle at which time the counter reaches the count FF, resets the latch by term # 13, and sets O_2 HIGH. At the rising edge of the next clock, terms LA and LB cause data to be loaded again into the registers, and the device is ready for another /TRIG input. The output wave-forms are illustrated in Figure 2.

If the /TRIG pulse-width is longer than the desired pulse-width of the one-shot, the device will react as mentioned above, and at the end of the count cycle new data will be loaded, another count cycle begins while the outputs remain set by the /TRIG input without changing throughout the change-over of one count cycle to another. O_{1a}, on the other hand, will go LOW for one clock period at the change-over. As long as the /TRIG is LOW, O_{1a} will continue to pulse LOW for one clock period at the change-over of one count cycle to another. The output O_2 will pulse HIGH for one clock cycle at the change-over. Figure 2 illustrates output wave-forms for both cases. The output wave-forms are as illustrated in Figure 2.

The one-shot is implemented by programming the PLS159 as shown in Table 1. The logic representation of the program is shown in Figure 3.

Written by: David Wong

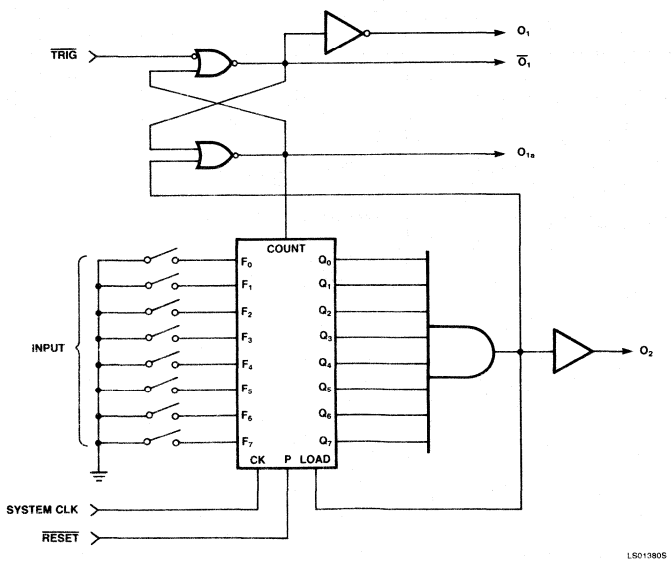


Figure 1. Programmable Retriggerable One-Shot

9

PLD Programmable Retriggerable One-Shot

AN11

Table 1. PLS159 FPLS Program Table

PROGRAMMABLE RETRIGGERABLE ONE-SHOT

TERM	AND: C	I: 3	I: 2	I: 1	I: 0	B(I): 3	B(I): 2	B(I): 1	B(I): 0	Q(P): 7	Q(P): 6	Q(P): 5	Q(P): 4	Q(P): 3	Q(P): 2	Q(P): 1	Q(P): 0	REMARK	(OR): E_B	(OR): E_A	Q(N): 7	Q(N): 6	Q(N): 5	Q(N): 4	Q(N): 3	Q(N): 2	Q(N): 1	Q(N): 0	POLARITY: L	POLARITY: L	POLARITY: H	POLARITY: H	B(O): 3	B(O): 2	B(O): 1	B(O): 0	REMARK
										A	A	A	A	A	A	A	A		—	—																	
0	–	L	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	LATCH			–	–	–	–	–	–	–	–	A	●	●	A	$B_0 = \overline{O_3}$				
1	–	–	–	–	–	–	H	–	–	–	–	–	–	–	–	–	–	"			–	–	–	–	–	–	–	–	A	●	●	A					
2	–	–	–	–	–	H	–	–	–	–	–	–	–	–	–	–	–	"			–	–	–	–	–	–	–	–	●	A	●						
3																																					
4	–	–	–	H	–	–	H	–	–	–	–	–	–	–	–	–	–	COUNT CYCLE			–	–	–	–	–	–	–	0	●	●	●	●					
5	–	–	–	H	–	–	H	–	–	–	–	–	–	–	–	H	H				–	–	–	–	–	–	0	–	●	●	●	●					
6	–	–	–	H	–	–	H	–	–	–	–	–	–	–	H	H	H				–	–	–	–	–	0	–	–	●	●	●	●					
7	–	–	–	H	–	–	H	–	–	–	–	–	–	H	H	H	H				–	–	–	–	0	–	–	–	●	●	●	●					
8	–	–	–	H	–	–	H	–	–	–	–	–	H	H	H	H	H				–	–	–	0	–	–	–	–	●	●	●	●					
9	–	–	–	H	–	–	H	–	–	–	–	–	H	H	H	H	H				–	–	0	–	–	–	–	–	●	●	●	●					
0	–	–	–	H	–	–	H	–	–	–	–	H	H	H	H	H	H				–	0	–	–	–	–	–	–	●	●	●	●					
11	–	–	–	H	–	–	H	–	–	–	H	H	H	H	H	H	H				0	–	–	–	–	–	–	–	●	●	●	●					
12																																					
13	–	–	–	–	–	–	–	–	–	H	H	H	H	H	H	H	H	LATCH			–	–	–	–	–	–	–	–	●	A	A	●					
14																																					
15																																					
16																																					
17																																					
18																																					
19																																					
20																																					
21																																					
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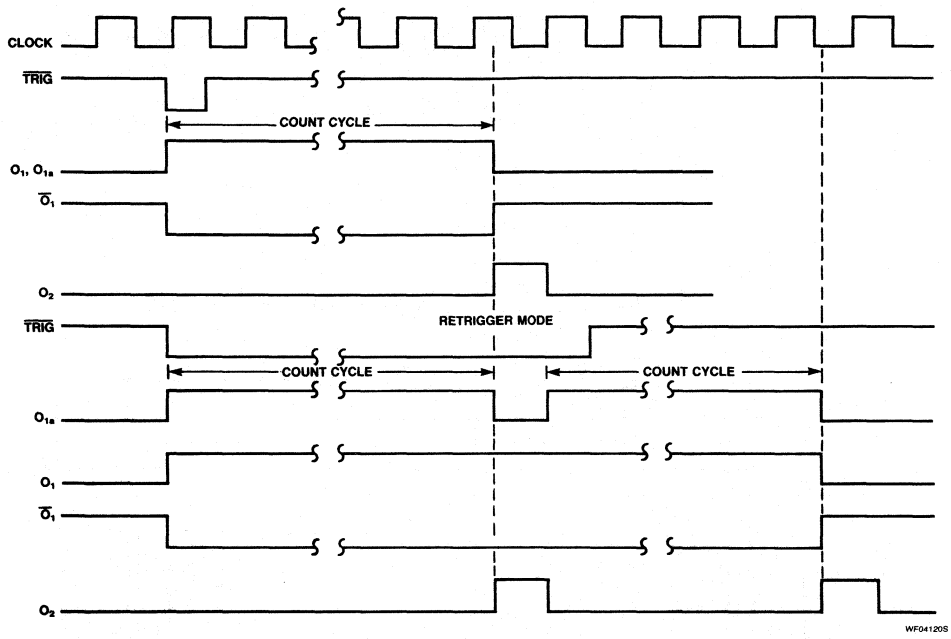
25																																					
26																																					
27																																					
28																																					
29																																					
30																																					
31																																					
2	F_C																																				
3	P_B	–	–	–	L	–	–	–	–	–	–	–	–	–	–	–	–	SET Q_4 TO Q_7 HIGH																			
4	R_B																																				
5	L_B	–	–	–	–	–	–	–	–	H	H	H	H	H	H	H	H	LOAD DATA AT NEXT CK																			
6	P_A	–	–	–	L	–	–	–	–	–	–	–	–	–	–	–	–	SET Q_0 TO Q_3 HIGH																			
7	R_A																																				
8	L_A	–	–	–	–	–	–	–	–	H	H	H	H	H	H	H	H	LOAD DATA AT NEXT CK																			
9	D3	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–																				
0	D2	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–																				
1	D1	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–																				
2	D0	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–																				
	PIN	5	4	3	2	9	8	7	6	19	18	17	16	15	14	13	12																				
	NAMES		/TRIG		/RESET		O_{1a}	/O1	O2	O1																												

TB00421S

COMMENTS:
This one-shot will load data at the end of the count cycle. If $\overline{TRIG}$ pulse-width is longer than the count cycle, output B3 will go LOW for one clock period and go HIGH again for another count cycle. Outputs B_2 and B_0 stay LOW and HIGH respectively until $\overline{TRIG}$ goes HIGH and count cycle is completed without interruption.

PLD Programmable Retriggerable One-Shot AN11



PLS159 Programmable One-Shot

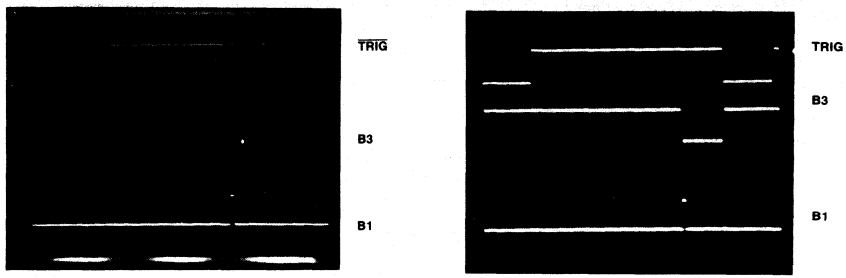


Figure 2. Timing Diagram of Programmable Retriggerable One-Shot

PLD Programmable Retriggerable One-Shot AN11

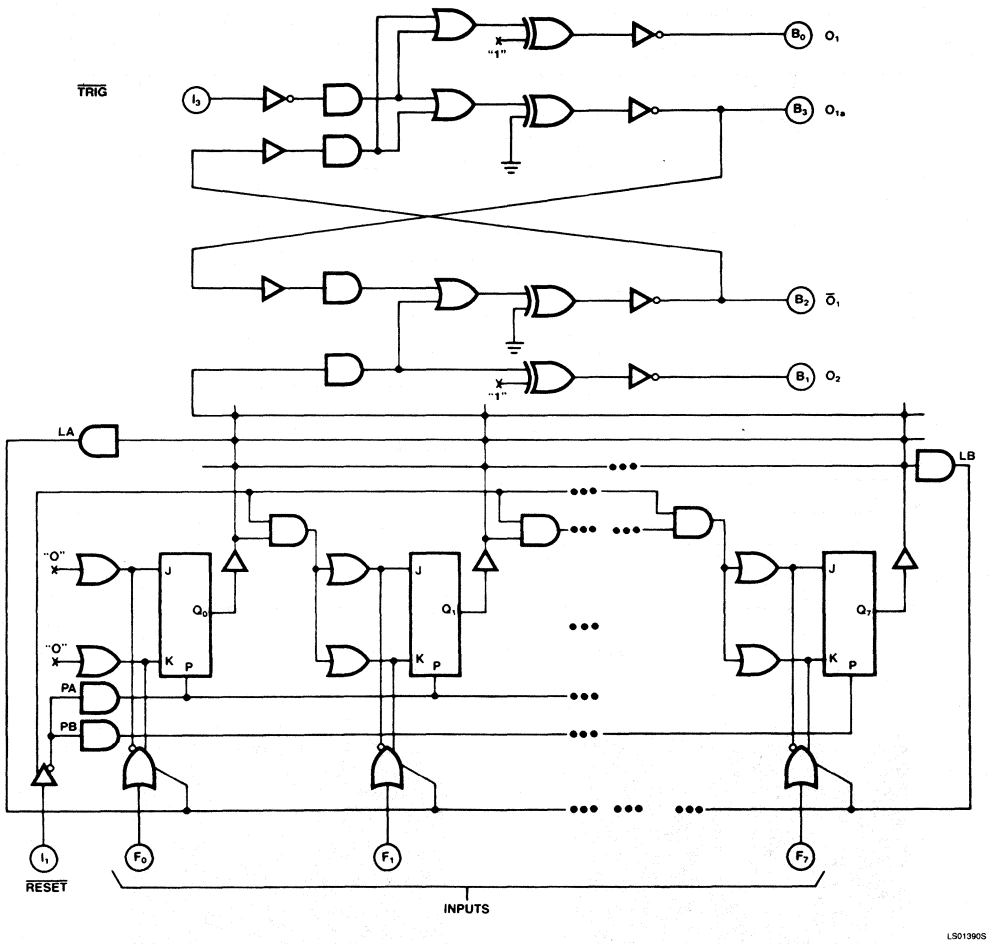


Figure 3. Logic Representation of Table 1

Signetics

AN12
Low Cost Programmer For PLD 20-Pin Series

Application Note

Application Specific Products

INTRODUCTION

The Low Cost Programmer (LCP) is designed to provide the user with a low cost alternative to program Signetics' PLD 20-pin series programmable logic devices. This system is a peripheral device which is to be controlled by a computer running Signetics software, AMAZE, or by a terminal. The LCP is connected to the hose computer via the RS232 interface and will accept ASCII codes. The data transfer rate can be either 9600 or 4800 baud. The LCP system clock is 4800 baud. The basic measure of time in the system is in units of 13μs. After every fuse is programmed, the LCP will automatically perform a verification cycle and feed data back to the computer. The system can be set to TEST mode which causes the outputs to cycle through the fusing sequence in an endless loop.

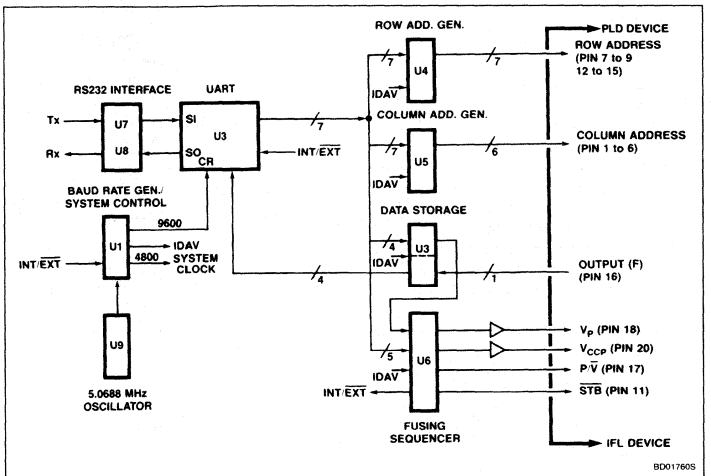


Figure 1. Block Diagram

THEORY OF OPERATION

A block diagram of the LCP is shown in Figure 1. U1 generates the 9600 baud clock for U3 (UART) and the 4800 baud clock for the rest of the system. When data is transferred into U3, it is put on the system bus. U1 generates IDAV which enables the rest of the system to react to the input. Since each device can decode the input instruction, very few controls are necessary.

Figure 2 shows the system instruction set. Each consists of seven bits with the upper 3 bits being the instruction code and the lower 4 bits being data or finer resolution of the instruction code. Figures 2 and 3 of Appendix 1 show the fuse address tables of PLS153 and PLS159, respectively. Note that the Variable Addresses have seven bits (3 upper bits and 4 lower bits), whereas the Term Addresses have six bits (2 upper bits and 4 lower bits). Therefore, it takes up to four nibbles to define a fuse address. Once an address is defined, the Variable Address generator will increment automatically to generate the subsequent fuse addresses for the same Term Address. Loading a Term Address in the Term Address generator will always reset the Variable Address generator. Therefore, the Term Address should be entered first and then the Variable Address. The last entry is the fusing data in a 4-bit nibble. The system will automatically increment the Variable Address generator to program four fuses. Once

C2 (D6)	C1 (D5)	C0 (D4)	D3	D2	D1	D0	FUNCTION
0	0	0	X	X	X	X	System internal use
0	0	1	X	X	X	X	System internal use
0	1	0	0	0	0	0	System reset
0	1	0	0	0	0	1	Set system ON-LINE
0	1	0	0	0	1	0	Set system OFF-LINE
0	1	1	4-bit data				Load fusing data
1	0	0	4-bit data				Load 4-bit lower TERM ADD.
1	0	1	2-bit data				Load 2-bit upper TERM ADD.
1	1	0	4-bit data				Load 4-bit upper VAR ADD.
1	1	1	3-bit data				Load 3-bit upper VAR ADD.

NOTE:
The upper and lower VARIABLE ADDRESSES will be reset to zero if upper or lower TERM ADDRESS is loaded into the LCP.

Figure 2. LCP Instruction Set

Low Cost Programmer For PLD 20-Pin Series

AN12

the 4-bit fusing data is loaded, the system goes into an internal mode until the fusing cycle for the four fuses are completed.

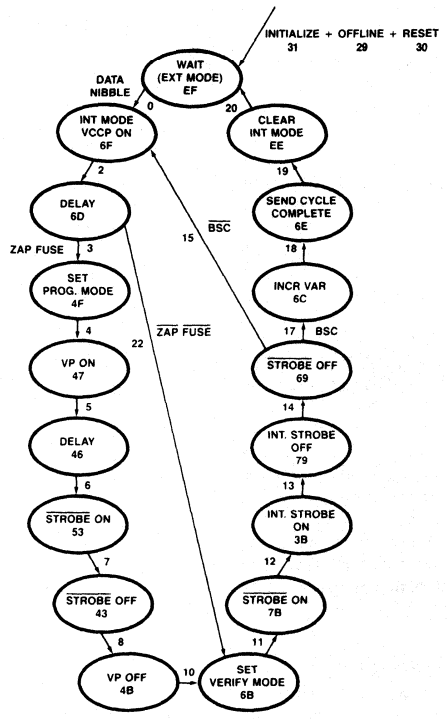
The following illustrates the sequence of programming operation:

1. Switch LCP to ON-LINE
2. Input 010 0000 – reset LCP
3. Input 010 0001 – put LCP "ON-LINE"
4. Input 100 —– – load 4-bit lower TERM ADDRESS
5. Input 101 00– – load 2-bit upper TERM ADDRESS
6. Input 110—– – load 4-bit lower VARIABLE ADDRESS
7. Input 111 0—– – load 3-bit upper VARIABLE ADDRESS
8. Input 011—– – load 4-bit fusing data, a "1" causes a fuse to be blown
9. U6, the fusing sequencer, causes the system to go into INTERN mode
10. Fusing sequence starts. See Figures 3 and 4
11. Fusing cycle completed. Input next address:
    a. If next TERM ADDRESS is different from the previous one, go to (4)
    b. If next address is in sequence with the previous VARIABLE ADDRESS and in the same TERM, go to (8)
    c. The Variable Address generator will always reset to 0 if TERM ADDRESS is loaded.

Figure 3 shows the sequence of fusing operation while the system is in internal mode. Figure 4 shows the timing diagram and voltage waveform of the fusing sequence of four consecutive fuses.

Analog Drivers:

V_P — This signal is current limited to 325mA. It is 1.25V to 1.75V when not fusing (idle).



NOTES:
1. State numbers in hex.
2. State changes on every clock.
3. 13μS cycle time.

Figure 3. State Diagram Fusing Sequence And Control PLD U6

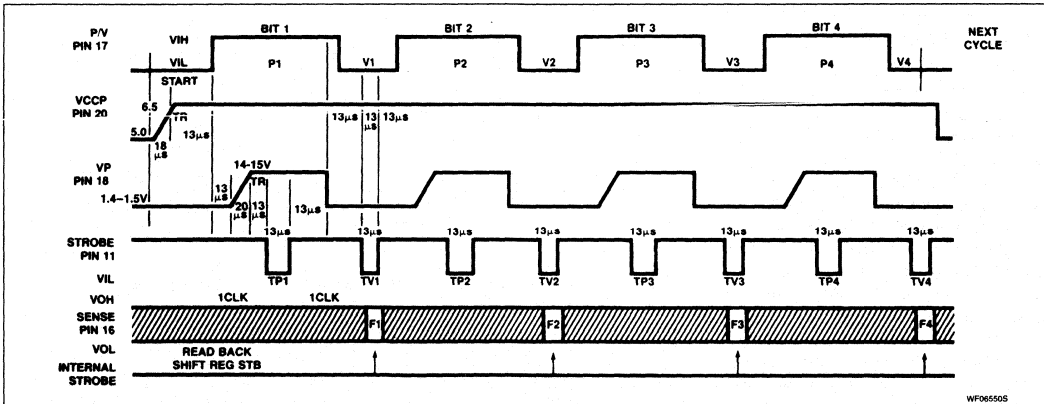


Figure 4. Timing Diagram And Voltage Waveforms

Low Cost Programmer For PLD 20-Pin Series

AN12

During the fusing cycle it takes on a value of 14.25V to 14.75V for a short time. The leading edge is slew rate limited to about 10μs.

V_{CCP} — This signal is the programming power supply. It can source up to 1A. It has a value of 1.1V to 1.3V when not fusing (idle). During the fusing cycle it assumes a value of 8.25V to 8.75V for the duration of the entire cycle (four fusing pulses – See Figure 4).

V_P Driver Circuitry — The V_P signal is toggled by the Fusing Sequencer, U6, Pin 15. This TTL signal is buffered up by the switching transistor, Q3, and its associated resistors, R6 and R9. Transistor Q4 inverts the signal to achieve the correct phase relationship. It also performs the following circuit functions:

1. It clamps the base of the Darlington transistor, Q5, to near ground through the R10 resistor.
2. Transistor Q4 discharges the slew rate time constant capacitor, C1, through the resistor, R10, and shunts the current from the current source, VR2, to near ground. This prepares the circuit for the next controlled slew rate edge at the beginning of the next fuse blowing cycle.
3. It provides a current sinking path to pull current out of the fusing socket enable line, thus creating a rapidly falling V_{CCP} trailing edge. The diode, D2, provides sourcing isolation while the resistor, R11, limits inrush currents. A ferrite bead on the R11 lead slows down this path. This prevents large currents from flowing through transistor Q4 at the low level switching transition time.

The voltage regulator, VR1, forms the 325mA current limit circuit in conjunction with the voltage dropping resistor, R8.

The controlled slew rate of the leading edge and the final level of the enable high output voltage V_P are generated in the following manner:

1. A 10mA current source is formed by the voltage regulator, VR2, and the dropping resistor, R7.
2. This current is shunted to ground through Q4 when the enable pulse is low.
3. At the instant when Q4 turns off, the 10mA current is diverted into the slew rate control capacitor, C1. The capacitor, C1, will continue to charge linearly until the voltage across it reaches the value of the zener diode stack D1A and D1B.
4. The current is then shunted down the zener diodes until Q4 is turned back on.
5. The base of the Darlington transistor, Q5, follows the voltage across the capacitor, C1, and draws very little current due to its very high current gain. Since the Q5 transistor is configured as an emitter follower, the voltage seen on the fusing socket enable line will be about 1V lower than the base of transistor Q5. Resistor R12 stabilizes the value of the V_{BE} on transistor Q5 by pulling a small amount of current early in the ramp.

V_{CCP} Driver Circuitry — V_{CCP} is toggled by the internal/external signal from the Fusing Sequencer, U6. Again, the signal is buffered and inverted twice by transistors Q1 and Q2 along with resistors R4 and R3.

Low Voltage (Idle)
Resistor R2 is shorted to ground through transistor Q2 in order to generate the 1.1V to 1.3V low output level. This is an intrinsic value generated by the internal reference of the voltage regulator.

High Voltage (V_{CCP})
When transistor Q2 is turned off, the output voltage ramps to the 8.25V to 8.75V level. This value is determined by the ratio of resistors R1 and R2 in conjunction with the actual value of the voltage regulator's internal reference.

Power Supply Consideration

1. The Low Cost Programmer circuitry draws about 1A.
2. The Enable and V_{CCP} currents may reach about 1.4A.
3. The Enable signal is about 15V and needs at least 5V of head room.
4. The RS232 drivers require ± 12V at about 60mA.

In a bridge circuit, a rule of thumb says that the transformer's current rating should be from 1.2 to 1.6 times the load current. Using this rule, the secondary of the transformer that supplies V_{CC} and ± 12V should be rated at 18V center tapped at about 1.6A.

The transformer that supplies the Enable and V_{CCP} circuits should have an 18V secondary at about 2.2A.

PROGRAMMING THE LCP

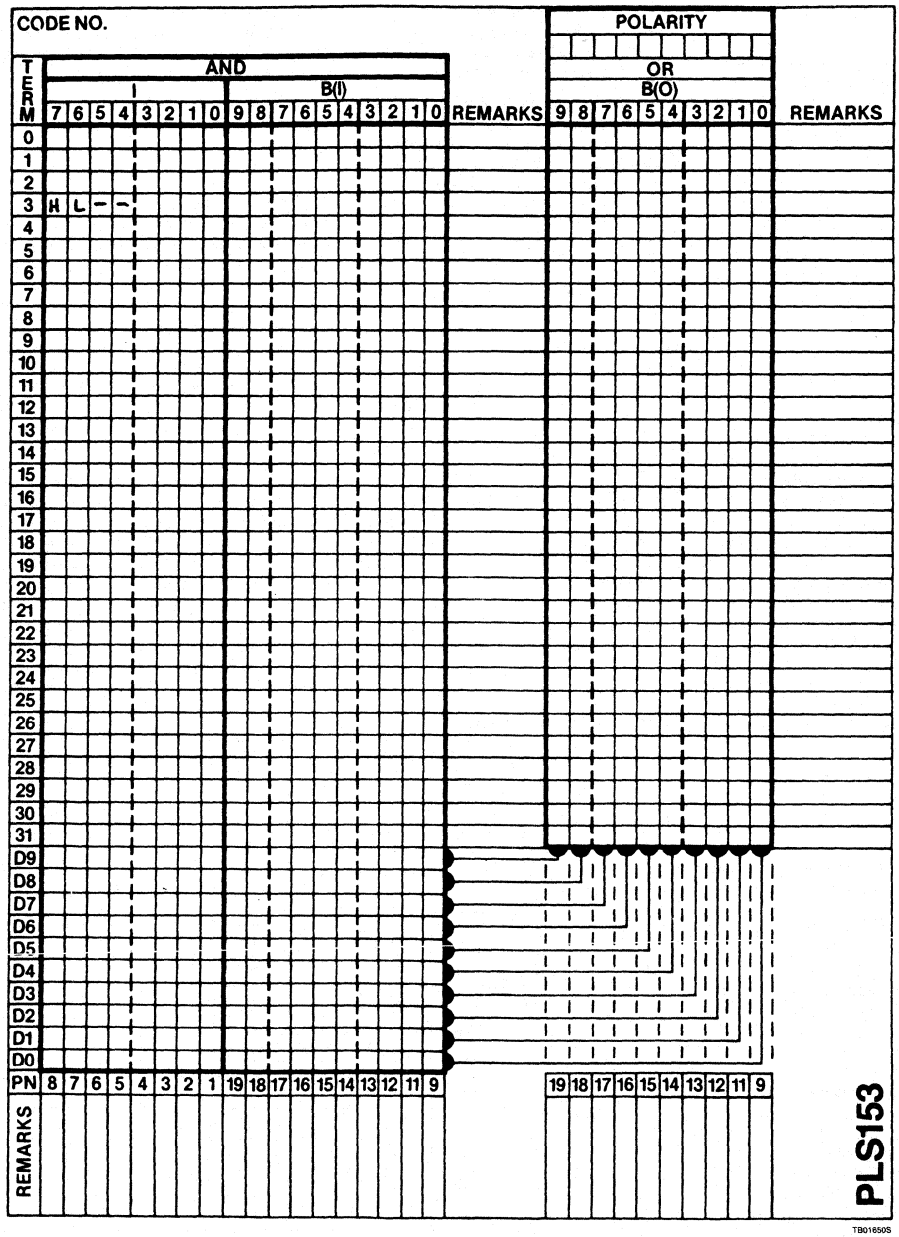
The addresses and fusing data can be generated by the host computer using AMAZE or a terminal nibble by nibble. The fuse address of each PLD 20-pin device is available in the Signetics PLD data manual. Copies of the fuse address tables of PLS153 and PLS159 are included in Appendix A Tables A-1 and A-2. These fuse addresses, together with the 3-bit instruction code, form a 7-bit instruction which can be represented by a single ASCII character. Table 1 is a table of ASCII characters.

The following example illustrates the conversion of program table entries into fuse addresses and fusing data. Table 2 shows a simple entry in an PLS153 program table. To keep things simple, only four entries are made. The first entry is term 3, variable I7. The fuse of the non-inverting buffer is to remain intact, whereas the fuse to be blown is the inverting buffer, I7. For this entry, from Table A-1 of Appendix A, the Term Address is 03hex or 00 0011b, the Variable Addresses of

Table 1. ASCII Character Table

		0000	0001	0010	0011	0100	0101	0110	0111
		0	1	2	3	4	5	6	7
0000	0	NUL	DLE	SP	0	•	P	·	p
0001	1	SOH	DC1	!	1	A	Q	a	q
0010	2	STX	DC2	"	2	B	R	b	r
0011	3	ETX	DC3	#	3	C	S	c	s
0100	4	EOT	DC4	$	4	D	T	d	t
0101	5	ENQ	NAK	%	5	E	U	e	u
0110	6	ACK	SYN	&	6	F	V	f	v
0111	7	BEL	ETB	'	7	G	W	g	w
1000	8	BS	CAN	(	8	H	X	h	x
1001	9	HT	EM	)	9	I	Y	i	y
1010	A	LF	SUB	*	:	J	Z	j	z
1011	B	VT	ESC	+	;	K	[	k	{
1100	C	FF	FS	,	<	L	^	l	:
1101	D	CR	GS	—	=	M	]	m	}
1110	E	SO	RS	.	>	N		n	~
1111	F	SI	US	/	?	O	÷	o	DEL

Table 2. FPLA Program Table



the two buffers are 0Ehex or 000 1110b, and 0Fhex or 000 1111. The fusing data is 01. The second entry is Term 3, I6. The fuse of the inverting buffer is to be kept intact while that of the non-inverting buffer will be blown. The Term Address is the same as the previous entry; the Variable Addresses of the two buffers are 0Chex or 000 1100b and 0Dhex or 000 1101b. The fusing data is 10. The four fusing data can be combined into one nibble (0110) since the two entries are in sequence. Only the first address has to be loaded (Term Address 03hex and Variable Address 0F). The next two entries are in sequence with the first two, therefore only fusing data nibble 1111 has to be loaded.

The instruction and data nibbles can be loaded into the LCP in ASCII characters (see Table 1).

LCP CHECK OUT AND CALIBRATION

This section deals with the check out and calibration of the Low Cost Programmer.

The voltage regulator, VR4, dissipates a lot of heat. It should be mounted on a metal chassis with an isolation mount.

Notice that the fusing socket, P1, has three columns of pads. Use the left set if the socket is to be mounted on the component side of the PCB. Use the right set if the socket is to be placed on the blank side of the PCB. The LEDs may also be mounted on the blank side, allowing for very easy panel mounting of the finished LCP.

Power Supplies

1. $+10V_{DC}$ to $+14V_{DC}$ at the positive side of C4.
2. $-10V_{DC}$ to $-14V_{DC}$ at the negative side of C3.
3. $+4.75V_{DC}$ to $+5.25V_{DC}$ at the $+5V_{DC}$ input pad of the PCB.
4. $+20V_{DC}$ to $+26V_{DC}$ at the positive side of C2.

Turn off the LCP and insert ICs U1 through U5, U7 and U8. Do not insert U6 yet.

Turn on the LCP and repeat steps 1 through 4 above.

Driver Calibration

The Fusing Sequencer, U6, must not be in the LCP for the following steps:

1. Measure $1.25V_{DC}$ to $1.75V_{DC}$ at Pin 18 of P1. (The fusing socket.)
2. Place a clip lead from the U6 Pin 15 end of resistor R6 to V_{CC} ($+5V_{DC}$).
3. Measure $14.0V_{DC}$ to $15.0V_{DC}$ at Pin 18 of P1.
4. Momentarily place a 75Ω 3W resistor from Pin 18 of P1 to ground and observe the voltage to still read $14.0V_{DC}$ to $15.0V_{DC}$.
5. Disconnect the clip lead between R6 and V_{CC}.
6. Measure the voltage at Pin 18 of P1 to once again be 1.25 to $1.75V_{DC}$.
7. Place a jumper from the U6 Pin 19 side of resistor R4 to ground.
8. Measure the voltage at Pin 20 of P1. It should be $1.10V_{DC}$ to $1.30V_{DC}$.
9. Place a jumper from the U6 Pin 19 side of resistor R4 to V_{CC}.
10. The voltage should be from $8.25V_{DC}$ to $8.75V_{DC}$ at Pin 20 of P1.
11. Place a 30Ω 3W load resistor momentarily from Pin 20 of P1 to ground and measure the voltage. It should remain within the $8.25V_{DC}$ to $8.75V_{DC}$ range. The value of R2 may have to be selected in order to give the correct voltage reading.
12. Reconnect the jumper from R4 to ground.
13. The voltage at Pin 20 of P1 should be $1.10V_{DC}$ to $1.30V_{DC}$.
14. Turn off power and insert U6 into its socket.

Baud Rate Generation

1. Using an oscilloscope, look at the waveform on Pin 17 of the Baud Rate Generator, U1. This signal should swing from < 450mV to > 2.4V and have about a 50% duty cycle.
2. The frequency at this pin should be 153.6kHz. This results in a period of 6.51μs.
3. Repeat Steps 1 and 2 for Pin 18 of U1. The frequency should be 76.8kHz, resulting in a period of 13.0μs.

Control Functions

Connect an ASCII RS232 terminal to the computer connector, C1, on the LCP. The set up should be:

1. 9600 baud.
2. 8 bits.
3. 1 Stop bit.
4. No parity.
5. Terminal Tx to Pin 3 of the LCP C1 connector.
6. Terminal Rx to Pin 2 of the LCP C1 connector.

The following steps send ASCII characters to the LCP, which it should interpret as instructions. It will not echo the characters sent, but it should perform the instructions. Refer to Figure 5 for the ASCII equivalent instruction characters.

1. Turn on the LCP.
2. Set the ON-LINE/OFF-LINE switch to ON-LINE.
3. Type ".
4. Type !. The ON-LINE LED should illuminate. If the ON-LINE LED does not light at this point, check for the correct interfacing of Pins 2 and 3 on the RS232 terminal connector.
5. Type ". The ON-LINE LED should go back off.

TERM ADDRESS GENERATION

The purpose of this section is to test the ability of the LCP to uniquely load the bits of the term address. This is done by sending ASCII characters to the LCP and then checking the term address pins of P1.

Send the following lines of characters and check the P1 pins after each.

CHAR	1	2	3	4	5	6
!	On-Line — Address at Previous State					
SO	H	H	H	H	H	H
space	L	L	L	L	L	L
A	L	L	L	L	L	L
B	L	L	L	L	H	H
D	L	L	L	H	L	L
H	L	L	H	L	L	L
@Q	L	H	L	L	L	L
R	H	L	L	L	L	L
SO	H	H	H	H	H	H
N	H	H	H	H	H	L
M	H	H	H	H	L	H
K	H	H	H	L	H	H
G	H	H	L	H	H	H
OR	H	L	H	H	H	H
Q	L	H	H	H	H	H
S	H	H	H	H	H	H
@ P	L	L	L	L	L	L
	Off-Line — Address Not Altered					

VARIABLE ADDRESS GENERATION

The purpose of this section is to test the ability of the LCP to uniquely load and increment the bits of the Variable Address. This is done by sending the appropriate ASCII characters to the LCP and then checking the Term Address pins of P1.

Send each line of characters and check the specified P1 pins after each.

Low Cost Programmer For PLD 20-Pin Series

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CHAR	7	8	9	12	13	14	15
!	On-Line — Address Same as Previous						
wo	H	H	H	H	H	H	H
space	L	L	L	L	L	L	L
a	L	L	L	L	L	L	H
b	L	L	L	L	L	H	L
d	L	L	L	L	H	L	L
h	L	L	L	H	L	L	L
space q	L	L	H	L	L	L	L
r	L	H	L	L	L	L	L
t	H	L	L	L	L	L	L
ow	H	H	H	H	H	H	H
n	H	H	H	H	H	H	L
m	H	H	H	H	H	L	H
k	H	H	H	H	L	H	H
g	H	H	H	L	H	H	H
ov	H	H	L	H	H	H	H
u	H	L	H	H	H	H	H
s	L	H	H	H	H	H	H
w	H	H	H	H	H	H	H
A	L	L	L	L	L	L	L
owQ	L	L	L	L	L	L	L
1	L	L	L	L	H	L	L
1	L	L	L	H	L	L	L
2	L	L	L	H	H	L	L
2	L	L	H	L	L	L	L
l2	L	H	L	L	L	L	L
ls2	H	L	L	L	L	L	L
	Off-Line — Address Not Altered						

Fusing Cycle/Test Mode

Place a jumper from U1 Pin 3 to ground. This enables test mode. Send any data character and the LCP will continuously loop through the fusing sequence. Verify the voltages and timing per Figure 4.

Remove the jumper.

Pass Through

Turn the LCP ON-LINE/OFF-LINE switch to OFF-LINE.

Connect the Host Computer to the C1 connector of the LCP and the Terminal to T1 of the LCP. Make certain the Tx and Rx signals of both are associated with the correct LCP RS232 pins on the respective connectors.

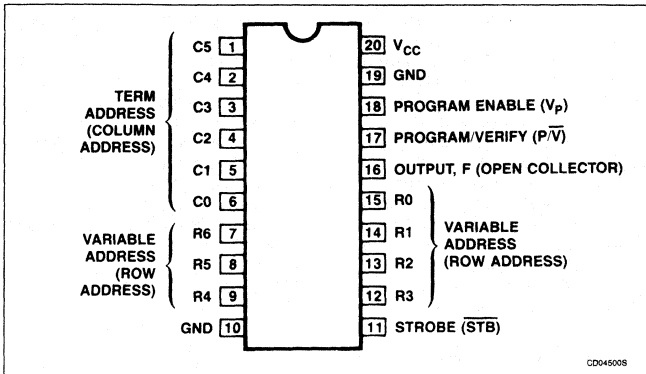

Figure A-1. Programming Pin Functions

Type on the terminal keyboard. The computer should behave normally – usually with an echo.

This completes the LCP calibration and checkout.

APPENDIX A

HOW TO PROGRAM PLD 20-PIN SERIES DEVICES

An PLD device is basically a group of logic functions interconnected to each other by fuses which can be blown to open a circuit, or left intact to make a connection. Each fuse can be identified by its own unique address which consists of a 7-bit Variable Address (ROW ADDRESS) and a 6-bit Term Address (COLUMN ADDRESS). The programming pin function is the same throughout the 20-pin series see Figure A-1). Tables A-1 and A-2 are fuse address tables of the PLS153 and PLS159, respectively.

The programming cycle can be separated into four stages:

Set-Up

1. Set Program Enable (V_P) to GND
2. Apply Column and Row Address to pins 1-6 and 7-9, 11-15
3. Set STROBE (STB) to V_{IH}
4. Set PROGRAM/VERIFY (P/V) to V_{IL}
5. Wait 1-50μs
6. Set V_{CCP} to 8.5V

To Blow a Fuse

1. Wait 1-10μs
2. Set P/V to V_{IH}
3. Wait 1-50μs
4. Set V_P to 14.5V
5. Wait 1-5μs
6. Pulse STB to V_{IL} for 10μs
7. Wait 1-5μs
8. Set V_P to GND
9. Wait 1-5μs
10. Set P/V to V_{IL}

To Verify

1. Wait 1-5μs
2. Pulse STB to V_{IL} for 1-10μs
3. While STB is LOW, OUTPUT (F) will be V_{IL} for a fuse intact and 2-8.75V for a blown fuse (note: F is an open-collector, a pull-up circuit may be needed)

Go To Set-Up for Next Fuse

Table A-1. Program Cycle Row/Column Fuse Addressing

PLS153

Variable Select Table[1]

ROW HEX ADDRESS		SELECTED VARIABLE	
$I_6I_7B_0$	$B_2B_3B_4B_5$		
0	0	AND Array	I_0
0	1		$\overline{I_0}$
0	2		I_1
0	3		$\overline{I_1}$
0	4		I_2
0	5		$\overline{I_2}$
0	6		I_3
0	7		$\overline{I_3}$
0	8		I_4
0	9		$\overline{I_4}$
0	A		I_5
0	B		$\overline{I_5}$
0	C		I_6
0	D		$\overline{I_6}$
0	E		I_7
0	F		$\overline{I_7}$
1	0		B_9
1	1		$\overline{B_9}$
1	2		B_8
1	3		$\overline{B_8}$
1	4		B_7
1	5		$\overline{B_7}$
1	6		B_6
1	7		$\overline{B_6}$
1	8		B_5
1	9		$\overline{B_5}$
1	A		B_4
1	B		$\overline{B_4}$
1	C		B_3
1	D		$\overline{B_3}$
1	E		B_2
1	F		$\overline{B_2}$
1	0		B_1
1	1		$\overline{B_1}$
1	2		B_0
1	3		$\overline{B_0}$

ROW HEX ADDRESS		SELECTED VARIABLE	
$I_6I_7B_0$	$B_2B_3B_4B_5$		
2 ↓ 2	4 ↓ F	Empty Address Space	
3	0	OR Array	9
3	1		8
3	2		7
3	3		6
3	4		5
3	5		4
3	6		3
3	7		2
3	8		1
3	9		0
3	A	Polarity Enable	
3 ↓ 3	B ↓ F	Enpty Address Space	

Term Select Table[2]

COLUMN HEX ADDRESS		SELECTED PRODUCT TERM	
I_0I_1	$I_2I_3I_4I_5$		
0	0	Logic Terms	0
0	1		1
0	2		2
0	3		3
0	4		4
0	5		5
0	6		6
0	7		7
0	8		8
0	9		9
0	A		10
0	B		11
0	C		12
0	D		13
0	E		14
0	F		15
1	0		16
1	1		17
1	2		18
1	3		19
1	4		20
1	5		21
1	6		22
1	7		23
1	8		24
1	9		25
1	A		26
1	B		27
1	C		28
1	D		29
1	E		30
1	F		31
2	0	Control Terms	0
2	1		1
2	2		2
2	3		3
2	4		4
2	5		5
2	6		6
2	7		7
2	8		8
2	9		9
2	A	Polarity Terms	0
2	B		1
2	C		2
2	D		3
2	E		4
2	F		5
3	0		6
3	1		1
3	2		8
3	3		9

NOTES:
1. A row address identifies a particular variable coupled to all product terms.
2. With a variable selected by the row address the column address further selects a coupling fuse for each term.

Table A-2. Program Cycle Row/Column Fuse Addressing (Continued)

PLS159

Variable Select Table[1]

ROW HEX ADDRESS $B_1B_2B_3$	ROW HEX ADDRESS $F_0F_1F_2F_3$	SELECTED VARIABLE	
0	0	AND Array	$\overline{B}_3$
0	1		B_3
0	2		$\overline{B}_2$
0	3		B_2
0	4		$\overline{B}_1$
0	5		B_1
0	6		$\overline{B}_0$
0	7		B_0
0	8		$\overline{I}_3$
0	9		I_3
0	A		$\overline{I}_2$
0	B		I_2
0	C		$\overline{I}_1$
0	D		I_1
0	E		$\overline{I}_0$
0	F		I_0
2	0		$\overline{F}_0$
2	1		F_0
2	2		$\overline{F}_1$
2	3		F_1
2	4		$\overline{F}_2$
2	5		F_2
2	6		$\overline{F}_3$
2	7		F_3
2	8		$\overline{F}_4$
2	9		F_4
2	A		$\overline{F}_5$
2	B		F_5
2	C		$\overline{F}_6$
2	D		F_6
2	E		$\overline{F}_7$
2	F		F_7
4	F		C_N

ROW HEX ADDRESS $B_1B_2B_3$	ROW HEX ADDRESS $F_0F_1F_2F_3$	SELECTED VARIABLE	
5	0	Flip-flop Control Terms	F_7 J
5	1		F_7 K
5	2		F_6 J
5	3		F_6 K
5	4		F_5 J
5	5		F_5 K
5	6		F_4 J
5	7		F_4 K
5	8		F_3 J
5	9		F_3 K
5	A		F_2 J
5	B		F_2 K
5	C		F_1 J
5	D		F_1 K
5	E		F_0 J
5	F		F_0 K
6	0	J-K/D Option	F_7
6	1		F_6
6	2		F_5
6	3		F_4
6	4		F_3
6	5		F_2
6	6		F_1
6	7		F_0
7	1	OR Array	B_3
7	2		B_2
7	3		B_1
7	4		B_0
7	5	C-Array	C_N
7	6	OE	EA
7	8	Polarity Terms	B_0
7	A		B_1
7	D		B_2
7	F		B_3

Term Select Table[2]

COLUMN HEX ADDRESS $CLKI_0$	COLUMN HEX ADDRESS $I_1I_2I_3B_0$	SELECTED TERM	
0	0	Transition Term	0
0	1		1
0	2		2
0	3		3
0	4		4
0	5		5
0	6		6
0	7		7
0	8		8
0	9		9
0	A		10
0	B		11
0	C		12
0	D		13
0	E		14
0	F		15
1	0		16
1	1		17
1	2		18
1	3		19
1	4		20
1	5		21
1	6		22
1	7		23
1	8		24
1	9		25
1	A		26
1	B		27
1	C		28
1	D		29
1	E		30
1	F		31
2	1	Control Term	PA
2	2		PB
2	3		RA
2	4		RB
2	5		LA
2	6		LB
2	7		FC
2	8	Output Enable	$\overline{EA}$
2	9		EB
2	C		A $\overline{EA}$
2	A		A EB
2	D		Polarity
2	E	Direction Control	D_0
2	F		D_1
3	0		D_2
3	1		D_3
2	0		Test Col. 2
3	2		Test Col. 1

NOTES:
1. A row address identifies a particular variable coupled to all product terms.
2. With a variable selected by the row address the column address further selects a coupling fuse for each term.

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AN12

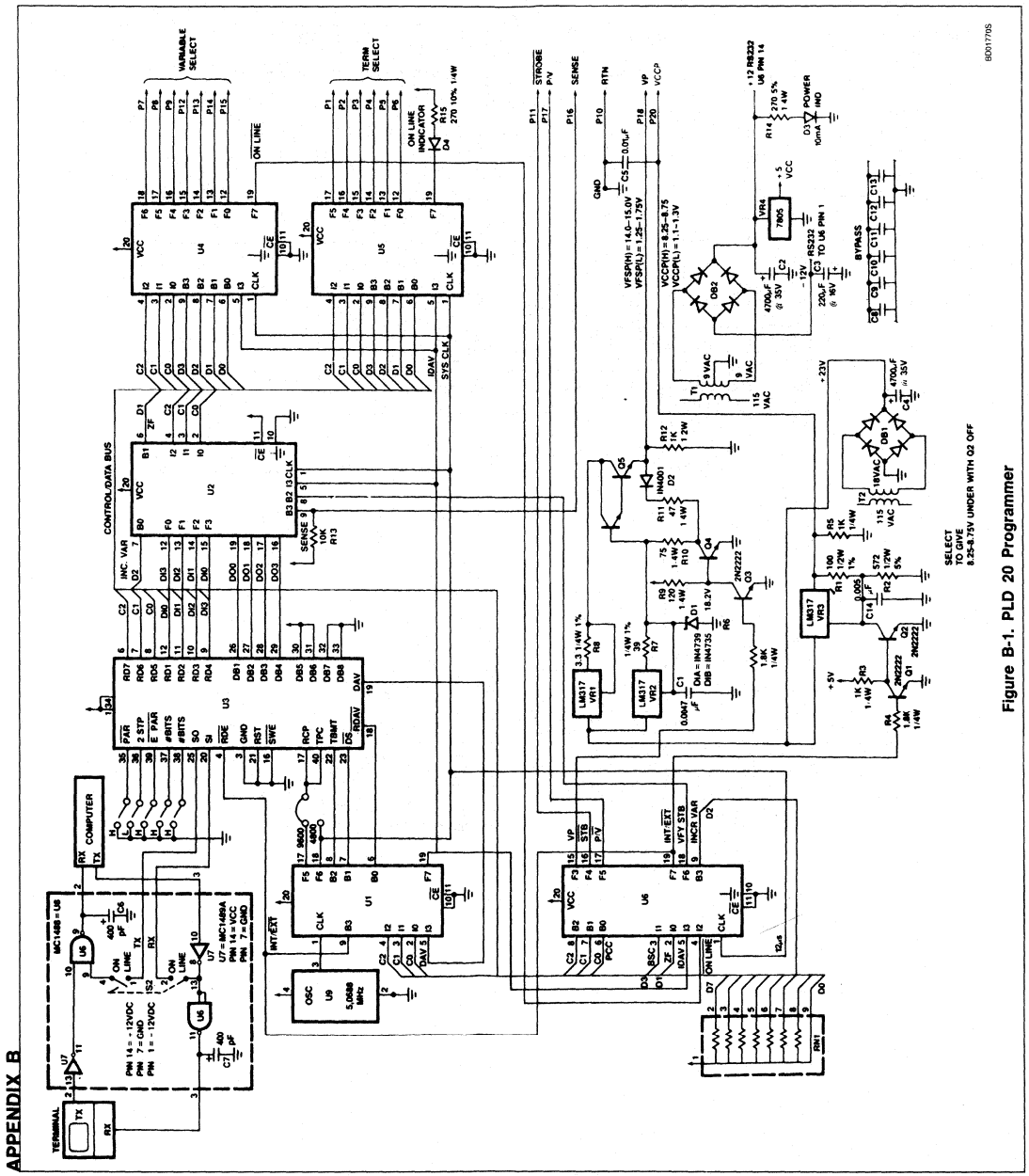

Figure B-1. PLD 20 Programmer

Table B-1. Baud Rate Generation and UART Control PLD U1 Revision "B" Adds Test Mode

CODE NO. U1

FF MODE: • • • • • • • •

E_B: • E_A: • POLARITY: H H L L

TERM	C	AND I 3	I 2	I 1	I 0	B(I) 3	B(I) 2	B(I) 1	B(I) 0	Q(P) 7	Q(P) 6	Q(P) 5	Q(P) 4	Q(P) 3	Q(P) 2	Q(P) 1	Q(P) 0	REMARKS	(OR) Q(N) 7	Q(N) 6	Q(N) 5	Q(N) 4	Q(N) 3	Q(N) 2	Q(N) 1	Q(N) 0	B(O) 3	B(O) 2	B(O) 1	B(O) 0	REMARKS
0	•	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–		–	–	–	–	–	–	–	0	•	•	•	•	
1	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	H		–	–	–	–	–	–	0	–	•	•	•	•	
2	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	H	H		–	–	–	–	–	0	–	–	•	•	•	•	GEN. BAUD RATE ×16
3	–	–	–	–	–	–	–	–	–	–	–	–	–	–	H	H	H		–	–	–	–	0	–	–	–	•	•	•	•	" "
4	–	–	–	–	–	–	–	–	–	–	–	L	–	H	H	H	H		–	–	0	–	–	–	–	–	•	•	•	•	" "
5	–	–	–	–	–	–	–	–	–	–	–	H	–	H	H	H	H		–	–	–	0	–	–	–	–	•	•	•	•	" "
6	A	–	–	–	–	–	–	–	–	–	–	H	H	L	L	L	L		–	0	0	0	–	–	–	–	•	•	•	•	" "
7	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	" "
8	–	H	–	H	–	L	H	–	–	H	H	H	H	L	L	L	L		L	–	–	–	–	–	–	–	•	•	•	•	" "
9	–	–	–	–	–	L	–	–	–	L	H	H	H	L	L	L	L		H	–	–	–	–	–	–	–	•	•	•	•	SET IDAV (EXT)
10	–	–	–	–	–	L	–	–	–	L	–	–	–	–	–	–	–		–	–	–	–	–	–	–	–	•	•	•	A	RESET IDAV (EXT)
11	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
12	–	–	–	–	L	H	–	–	–	H	H	H	H	L	L	L	L		L	–	–	–	–	–	–	–	•	•	•	•	GEN IDAV (INT.)
13	–	–	–	–	H	H	–	–	–	L	H	H	H	L	L	L	L		H	–	–	–	–	–	–	–	•	•	•	•	RESET IDAV (INT)
14	–	–	–	–	H	H	–	–	–	–	–	–	–	–	–	–	–		–	–	–	–	–	–	–	–	•	•	A	•	
15	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	TEST MODE
16	–	–	–	L	–	L	H	–	–	H	H	H	H	L	L	L	L		L	–	–	–	–	–	–	–	•	•	•	•	
17	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
18	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
19	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
20	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
21	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
22	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
23	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
24	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
25	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
26	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
27	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
28	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
29	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
30	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
31	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
FC	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0														
PB	•	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0														
RB	•	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0														
LB	•	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0														
PA	•	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0														
RA	•	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0														
LA	•	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0														
D3	•	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0														
D2	•	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0														
D1	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–														
D0	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–														
PIN		5	4	3	2	9	8	7	6	19	18	17	16	15	14	13	12		19	18	17	16	15	14	13	12	9	8	7	6	
REMARKS		DAV		$\overline{TEST}$	CO	INT/EXT	TBMT	DS	RDAV	IDAV	4800 SYS CLK	9600	÷32	÷16	÷8	÷4	÷2														PLS159

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Table B-2. Low Cost Programmer PLD #U4 Variable Address Generator

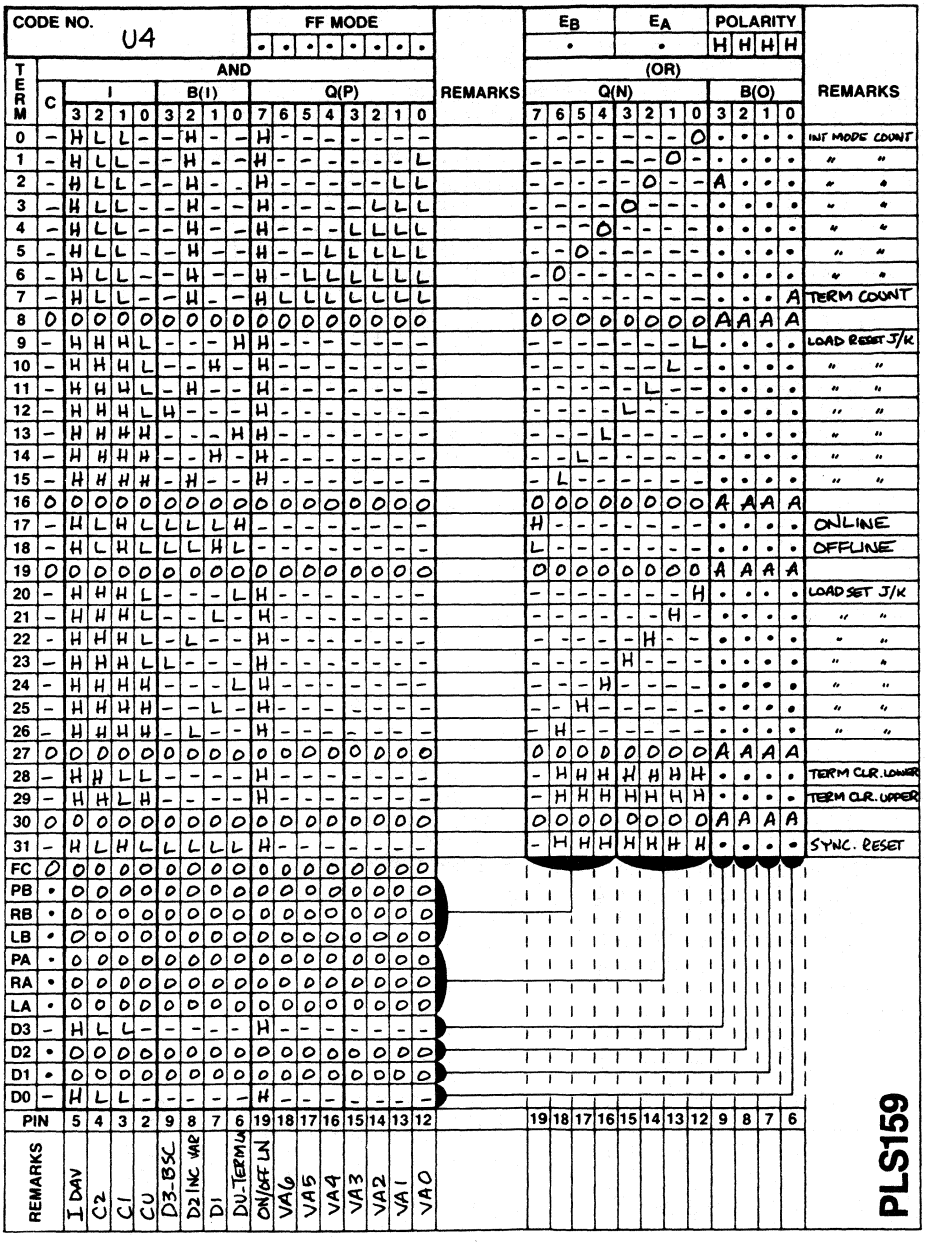

Table B-3. Low Cost Programmer PLD #U4 Variable Address Generator

CODE NO. U5

FF MODE: • • • • • • • •

E_B: •　E_A: •　POLARITY: H H H H

TERM	C	AND I 3	I 2	I 1	I 0	B(I) 3	B(I) 2	B(I) 1	B(I) 0	Q(P) 7	Q(P) 6	Q(P) 5	Q(P) 4	Q(P) 3	Q(P) 2	Q(P) 1	Q(P) 0	REMARKS	(OR) Q(N) 7	Q(N) 6	Q(N) 5	Q(N) 4	Q(N) 3	Q(N) 2	Q(N) 1	Q(N) 0	B(O) 3	B(O) 2	B(O) 1	B(O) 0	REMARKS
0	–	H	L	L	–	–	–	–	H	H	–	–	–	–	–	–	–		–	–	–	–	–	–	–	O	•	•	•	•	INT. MODE CNT.
1	–	H	L	L	–	–	–	–	–	H	–	–	–	–	–	–	L		–	–	–	–	–	–	–	–	•	•	•	•	NOT USED
2	–	H	L	L	–	–	–	–	–	H	–	–	–	–	–	L	L		–	–	–	–	–	–	–	–	•	•	•	•	" "
3	–	H	L	L	–	–	–	–	–	H	–	–	–	–	L	L	L		–	–	–	–	–	–	–	–	•	•	•	•	" "
4	–	H	L	L	–	–	–	–	–	H	–	–	–	L	L	L	L		–	–	–	–	–	–	–	–	•	•	•	•	" "
5	–	H	L	L	–	–	–	–	–	H	–	–	L	L	L	L	L		–	–	–	–	–	–	–	–	•	•	•	•	" "
6	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O		O	O	O	O	O	O	O	O	A	A	A	A	
7	–	H	H	L	L	–	–	–	H	H	–	–	–	–	–	–	–		–	–	–	–	–	–	–	L	•	•	•	•	LOAD SET
8	–	H	H	L	L	–	–	H	–	H	–	–	–	–	–	–	–		–	–	–	–	–	–	L	–	•	•	•	•	" "
9	–	H	H	L	L	–	H	–	–	H	–	–	–	–	–	–	–		–	–	–	–	–	L	–	–	•	•	•	•	" "
10	–	H	H	L	L	H	–	–	–	H	–	–	–	–	–	–	–		–	–	–	–	L	–	–	–	•	•	•	•	" "
11	–	H	H	L	H	–	–	–	H	H	–	–	–	–	–	–	–		–	–	–	L	–	–	–	–	•	•	•	•	" "
12	–	H	H	L	H	–	–	H	–	H	–	–	–	–	–	–	–		–	–	L	–	–	–	–	–	•	•	•	•	" "
13	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O		O	O	O	O	O	O	O	O	A	A	A	A	
14	–	H	L	H	L	L	L	L	H	–	–	–	–	–	–	–	–		H	–	–	–	–	–	–	–	•	•	•	•	ON LINE
15	–	H	L	H	L	L	L	H	L	–	–	–	–	–	–	–	–		L	–	–	–	–	–	–	–	•	•	•	•	OFF LINE
16	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O		O	O	O	O	O	O	O	O	A	A	A	A	
17	–	H	H	L	L	–	–	–	L	H	–	–	–	–	–	–	–		–	–	–	–	–	–	–	H	•	•	•	•	LOAD RESET
18	–	H	H	L	L	–	–	L	–	H	–	–	–	–	–	–	–		–	–	–	–	–	–	H	–	•	•	•	•	" "
19	–	H	H	L	L	–	L	–	–	H	–	–	–	–	–	–	–		–	–	–	–	–	H	–	–	•	•	•	•	" "
20	–	H	H	L	L	L	–	–	–	H	–	–	–	–	–	–	–		–	–	–	–	H	–	–	–	•	•	•	•	" "
21	–	H	H	L	H	–	–	–	L	H	–	–	–	–	–	–	–		–	–	–	H	–	–	–	–	•	•	•	•	" "
22	–	H	H	L	H	–	–	L	–	H	–	–	–	–	–	–	–		–	–	H	–	–	–	–	–	•	•	•	•	" "
23	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O		O	O	O	O	O	O	O	O	A	A	A	A	
24	–	H	L	L	–	–	–	–	H	H	–	–	–	–	–	–	L		–	–	–	–	–	–	O	–	•	•	•	•	INT. MODE COUNT
25	–	H	L	L	–	–	–	–	H	H	–	–	–	–	–	L	L		–	–	–	–	–	O	–	–	•	•	•	•	" "
26	–	H	L	L	–	–	–	–	H	H	–	–	–	–	L	L	L		–	–	–	–	O	–	–	–	•	•	•	•	" "
27	–	H	L	L	–	–	–	–	H	H	–	–	–	L	L	L	L		–	–	–	O	–	–	–	–	•	•	•	•	" "
28	–	H	L	L	–	–	–	–	H	H	–	–	L	L	L	L	L		–	–	O	–	–	–	–	–	•	•	•	•	" "
29	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O		O	O	O	O	O	O	O	O	A	A	A	A	" "
30	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O		O	O	O	O	O	O	O	O	A	A	A	A	
31	–	H	L	H	L	L	L	L	L	H	–	–	–	–	–	–	–		–	H	H	H	H	H	H	H	•	•	•	•	SYNC. RESET
FC	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O														
PB	•	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O														
RB	•	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O														
LB	•	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O														
PA	•	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O														
RA	•	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O														
LA	•	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O														
D3	•	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O														
D2	•	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O														
D1	•	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O														
D0	•	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O	O														
PIN		5	4	3	2	9	8	7	6	19	18	17	16	15	14	13	12		19	18	17	16	15	14	13	12	9	8	7	6	
REMARKS		IDAV	C2	C1	C0	D3	D2	D1	D0 TERM CNT.	ON/OFF LN.	N/A	TA5	TA4	TA3	TA2	TA1	TA0														PLS159

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Table B-4. Low Cost Programmer PLD #U2B Revision "3" Data Register

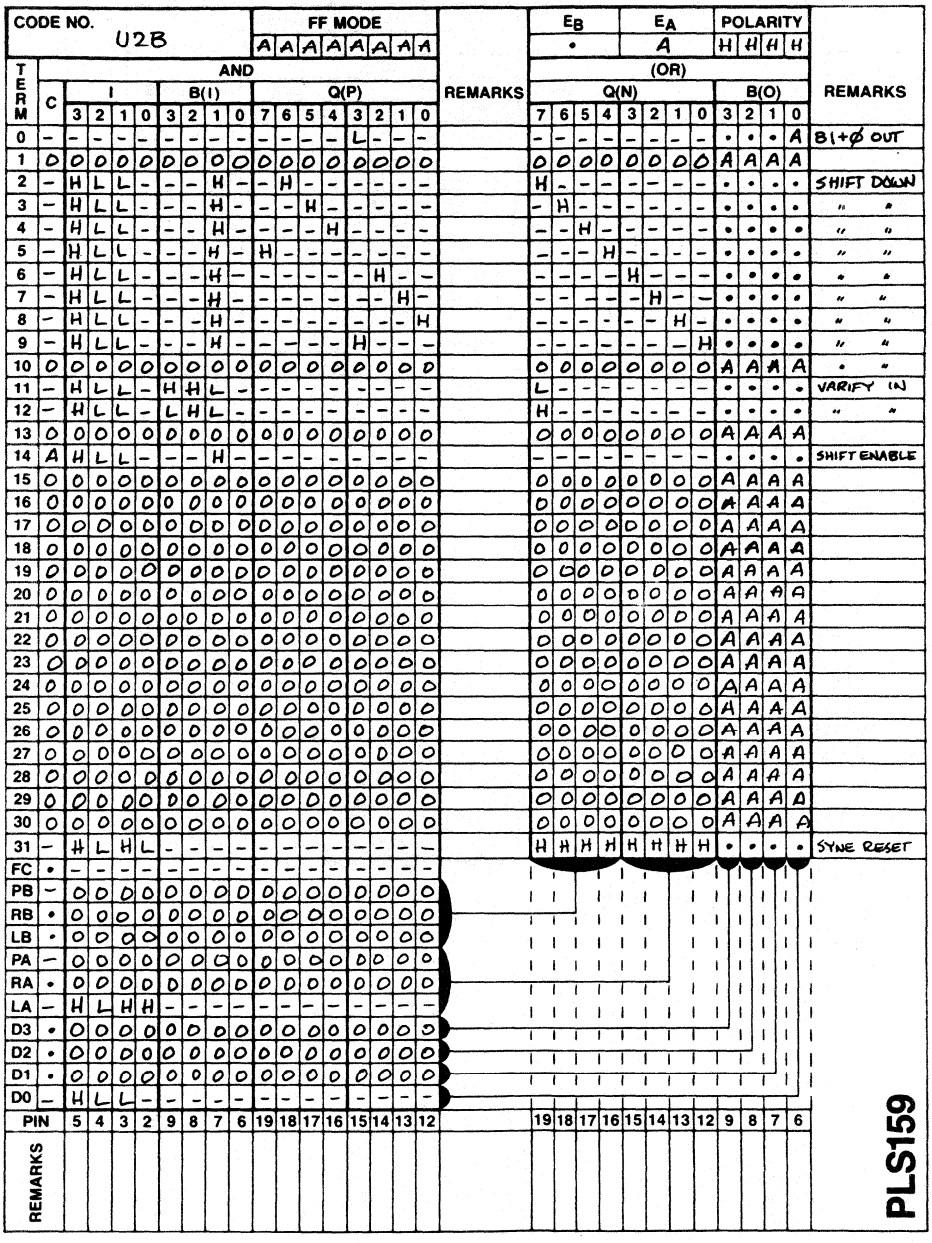


Table B-5. Low Cost Programmer PLD #U6 Revision "B" Results in New Timing Figures

CODE NO. U6										FF MODE								REMARKS	E_B	E_A	POLARITY				REMARKS
										•	•	•	•	•	•	•	•		•	•	H	L	L	L	
TERM	AND																		(OR)							
	C	I				B(I)				Q(P)									Q(N)							B(O)				
		3	2	1	0	3	2	1	0	7	6	5	4	3	2	1	0		7	6	5	4	3	2	1	0	3	2	1	0	
0	–	H	L	–	–	–	L	H	H	H	H	H	L	H	H	H	H		L	–	–	–	–	–	–	–	•	•	•	•	SET INT. MODE
1	–	–	L	–	–	–	–	–	–	L	–	–	–	–	–	–	–		–	–	–	–	–	–	–	–	•	A	A	•	SEND INT. MD. C4, C2
2	–	–	L	–	–	–	–	–	–	L	H	H	L	H	H	H	H		–	–	–	–	–	–	L	–	•	•	•	•	DELAY
3	–	H	L	–	H	–	–	–	–	L	H	H	L	H	H	L	H		–	–	L	–	–	–	H	–	•	•	•	•	SET PRD. MD. SAP F33
4	–	–	L	–	–	–	–	–	–	L	H	L	L	H	H	H	H		–	–	–	–	L	–	–	–	•	•	•	•	VSP ON
5	–	–	L	–	–	–	–	–	–	L	H	L	L	L	H	H	H		–	–	–	–	–	–	–	L	•	•	•	•	DELAY
6	–	–	L	–	–	–	–	–	–	L	H	L	L	L	H	H	L		–	–	–	H	–	L	–	H	•	•	•	•	STROBE ON (DOWN
7	–	–	L	–	–	–	–	–	–	L	H	L	H	L	L	H	H		–	–	–	L	–	–	–	–	•	•	•	•	STROBE OFF
8	–	–	L	–	–	–	–	–	–	L	H	L	L	L	L	H	H		–	–	–	–	H	–	–	–	•	•	•	•	VP OFF
9	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
10	–	–	L	–	–	–	–	–	–	L	H	L	L	H	L	H	H		–	–	H	–	–	–	–	–	•	•	•	•	SET VERIFY MODE
11	–	–	L	–	–	–	–	–	–	L	H	H	L	H	L	H	H		–	–	–	H	–	–	–	–	•	•	•	•	STROBE ON
12	–	–	L	–	–	–	–	–	–	L	H	H	H	H	L	H	H		–	L	–	–	–	–	–	–	•	•	•	•	INT. STROBE ON
13	–	–	L	–	–	–	–	–	–	L	L	H	H	H	L	H	H		–	H	–	–	–	–	L	–	•	•	•	•	INT. STROBE OFF
14	–	–	L	–	–	–	–	–	–	L	H	H	H	H	L	L	H		–	–	–	L	–	–	–	–	•	•	•	•	STROBE OFF
15	–	–	L	L	–	–	–	–	–	L	H	H	L	H	L	L	H		–	–	–	–	–	H	H	–	A	•	•	•	INCR. VAR (ESC)
16	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
17	–	–	L	H	–	–	–	–	–	L	H	H	L	H	L	L	H		–	–	–	–	–	H	–	L	A	•	•	•	BAIL OUT
18	A	–	L	–	–	–	–	–	–	L	H	H	L	H	H	L	L		–	–	–	–	–	–	H	–	•	•	•	•	SEND CYCLE COMP.
19	–	–	L	–	–	–	–	–	–	L	H	H	L	H	H	H	L		H	–	–	–	–	–	–	–	•	•	•	•	CLEAR INT. MODE
20	–	–	L	–	–	–	–	–	–	H	H	H	L	H	H	H	L		–	–	–	–	–	–	–	H	•	•	•	•	WAIT (EXT. MODE)
21	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
22	–	H	L	–	L	–	–	–	–	L	H	H	L	H	H	L	H		–	–	–	–	–	L	H	–	•	•	•	•	SET VFY (ZAP)
23	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
24	•	–	L	–	–	–	–	–	–	L	–	–	–	–	–	–	–		–	–	–	–	–	–	–	–	•	•	•	A	SEND INT MD (LO)
25	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
26	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
27	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
28	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		0	0	0	0	0	0	0	0	A	A	A	A	
29	–	–	H	–	–	–	–	–	–	–	–	–	–	–	–	–	–		H	H	H	L	H	H	H	H	•	•	•	•	OFFLINE INITIAL
30	–	H	L	–	–	–	L	H	L	–	–	–	–	–	–	–	–		–	H	H	L	H	H	H	H	•	•	•	•	COMPUTER INITIAL
31	–	–	–	–	–	–	–	–	–	L	L	L	L	L	L	L	L		H	H	H	–	H	H	H	H	•	•	•	•	PWR UP INITIAL
FC	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0														
PB	•	0	0	0	0	0	0	0	0	0	•	0	0	0	0	0	0														
RB	•	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0														
LB	•	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0														
PA	•	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0														
RA	•	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0														
LA	•	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0														
D3	–	–	–	–	–	–	–	–	–	L	–	–	–	–	–	–	–														
D2	–	–	–	–	–	–	–	–	–	L	–	–	–	–	–	–	–														
D1	–	–	–	–	–	–	–	–	–	L	–	–	–	–	–	–	–														
D0	–	–	–	–	–	–	–	–	–	L	–	–	–	–	–	–	–														
PIN		5	4	3	2	9	8	7	6	19	18	17	16	15	14	13	12		19	18	17	16	15	14	13	12	9	8	7	6	
REMARKS		DAV	ONLINE	D3-BSC	D1-ZF	D2 INC. VAR.	C2	C1	C0	INT/EXT	VEY S B	MODE P/V	EN	VFSP	UP-DOWN	TD1	TD0														

PLS159

TB01700S

Table B-6. Low Cost Programmer Parts List

REF. DES.	QUANT.	DESCRIPTION	RADIO SHACK#
Resistors			
R1	1	100Ω 1/4W 5%	
R2	1	620Ω 1/4W 5%	
R3, R5	2	1KΩ 1/4W 5%	271-1421
R14, R15	2	270Ω 1/4W 5%	
R4, R6	2	1.8KΩ 1/4W 5%	271-1324
R7	1	39Ω 1/4W 5%	
R8	1	3.3Ω 1/4W 5%	
R9	1	120Ω 1/4W 5%	
R10	1	75Ω 1/4W 5%	
R11	1	47Ω 1/4W 5%	271-1307
R12*	1	1KΩ 1/4W 5%	271-023
R13	1	10KΩ 1/4W 5%	
RN1	1	10KΩ 1/4W 5% 8-Pin SIP	
Capacitors			
C1	1	0.047μF	
C2, C4	2	4700μF Elec. 35V Axial	272-1022
C3	1	220μF Elec. 35V Axial	272-1017
C6, C7	2	470μF	
C5, C8 – C13	7	0.01μF	
Diodes			
D1A	1	6.2V Zener 1N4735	276-561
D1B	1	9.1V Zener 1N4739	276-563
D2	1	1N4001	276-1101
D3, D4	2	10mA Red LED	276-041
DB1, DB2	2	1.4A Full-Wave Bridge	276-1151
Voltage regulators			
VR1 – VR3	3	LM317 TO-220	276-1778
VR4	1	7805 TO-3	
Integrated circuits			
U1, U2, U4 – U6	5	PLS159IFL — Codes Req'd	
U3	1	AY-3-1015 UART	276-1794
Transformers			
T1, T2	2	18.0VAC CT, 2A	273-1515
FB1	1	Ferrite Bead FB-75B-01 Amidon Associates	
Transistors			
Q1 – Q4	4	2N2222 Transistors	276-2009
Q5	1	TIP 120 Power Dar.	

APPENDIX C

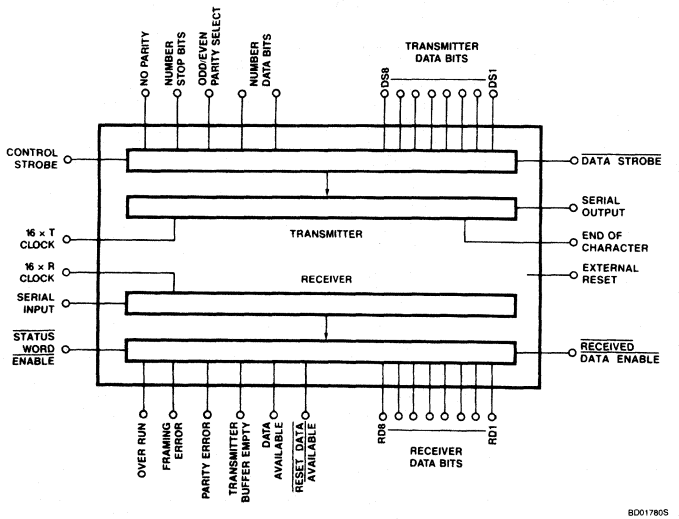


Figure C-1. Block Diagram

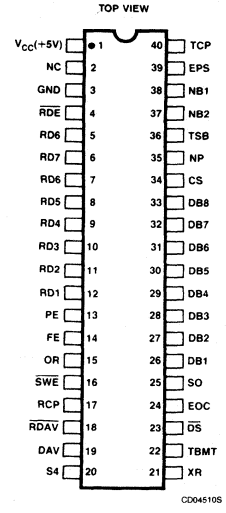


Figure C-2

AN13
Oscillator With PLS159

Application Note

Application Specific Products

INTRODUCTION

The Field Programmable Logic Sequencer PLS159 may be a self-contained system except that it requires a system clock which is generally provided by an external source. Using a simple R-C network, two bi-directional I/O pins, one can make a simple oscillator which can provide a clock frequency up to 7MHz (typical) with a pulse width of about 75ns. The frequency of oscillation is set by adjusting the RC network, or by adjusting a reference voltage, V. The circuit is shown in Figure 1. This circuit may be used to clock the flip flops on the same chip, or provide a clock for a bigger system. While this circuit uses only two AND-terms and one control term, the rest of the chip may be used for other circuits.

Initially, the capacitor has zero charge and thus is at zero volt. Output is also at a LOW, which disables the tri-state buffer. As the capacitor is being charged up, its voltage increases. At about 1.6 volts, the non-inverting input buffer begins to turn on. One propagation delay later, the output goes HIGH, which enables the tri-state buffer after another propagation delay. Since the tri-state buffer is unconditionally programmed to a LOW, it begins to discharge the capacitor at a fast rate. As the input voltage to the non-inverting buffer drops below 1.6 volts, the buffer begins to change state. One propagation delay later, output goes LOW, which disables the tri-state buffer after another propagation delay. The R-C network is ready to start all over again.

To implement this circuit, we first choose B_1 to input voltage from the RC network and B_0 to be the output pin. As shown in Table 1, we enable the output $B(O)_0$ by "dashing out" the AND-term D_0, make the output non-inverting by programming POLARITY "H" and connect it to term-0 by entering an A in column $B(O)_0$ term 0. We then program an H in $B(I)_1$, term-0 to connect the non-inverting input of B_1 to term-0. Since we don't need the rest of the inputs and outputs, we "dash out" all other input entries and "dot out" all unused outputs in term-0. To create a LOW output on $B(O)_1$, we may either have a LOW input on the OR and have the output non-inverted, or have a HIGH on the input of OR and have the output inverted to produce a LOW. We will arbitrarily use the second method. Here we dash out all inputs and outputs in term-1 except $B(O)_1$ which is programmed an A. We then program the POLARITY of $B(O)_1$ "L" to be inverting.

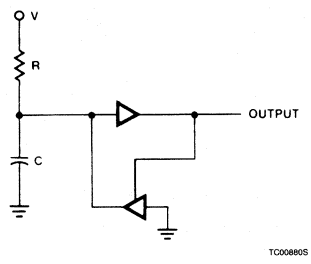


Figure 1. R-C Network Circuit

Finally we program an H in $B(I)_0$ and term-D_1 and dash out all unused inputs so that when $B(O)_0$ becomes HIGH, D_1 will enable the output buffer $B(O)_1$. The program is further illustrated by Figure 2.

Since the HIGH output pulsewidth is about two propagation delays of B_1 to B_0, it is wide enough to drive the clock input of the PLS159. If a square wave is desired, one of the flip flops may be programmed to toggle, as shown in TABLE 1, term-4, in which case the output frequency of the square wave is half that of $B(O)_0$.

The stability of the output frequency can be controlled by:

1. Making V a stable voltage source,
2. making the charging current of the RC network much greater than the input current of $B(I)_1$ (see Figure 4 for input current characteristics),
3. making the period of oscillation much greater than four times the internal propagation delay (typical t_{PD} = 35nS).

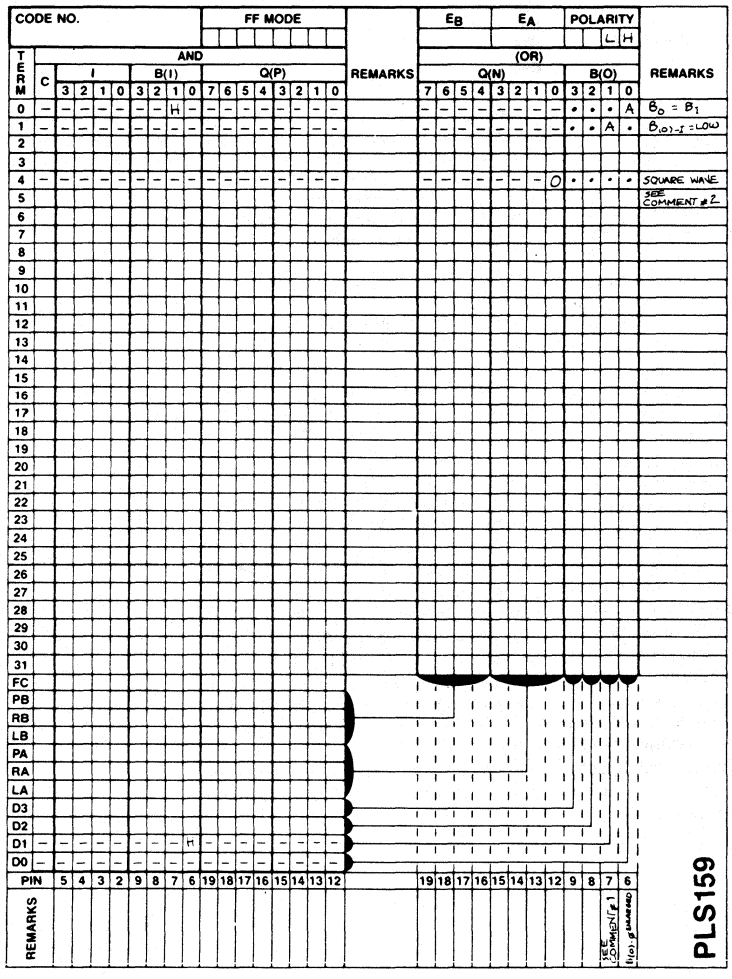
Recommendations:

a) Use capacitance less than 500pf.

b) Choose R such that $V/R >> I_{IL}$ (since $I_{IL} = -100\mu A$, worst case, over temperature range, V/R may be 1mA, for example).

The recommendations above put a limit to the range of frequency which the PLS159 may operate in exchange for stable operating frequency. One may extend its range by reducing C to zero (remove the capacitor) and thus operate the circuit at its maximum frequency, or increase the resistance to infinite (remove the resistor), and let the external capacitor be charged by the input current I_{IL}, which gives a much lower frequency.

Table 1. PLS159 FPLS Program Table



COMMENTS:

1. D_1 is controlled by $B(1)_0$, which enables $B(O)_1$ when $B(O)_0$ outputs a HIGH.
2. $Q(N)_{-0}$ is programmed as J-K flip-flop, and will toggle automatically at each rising-edge of the clock.

NOTE:

1. In order for the flip-flop to work the clock out (B_O) must be externally connected to pin 1.

Oscillator With PLS159

AN13

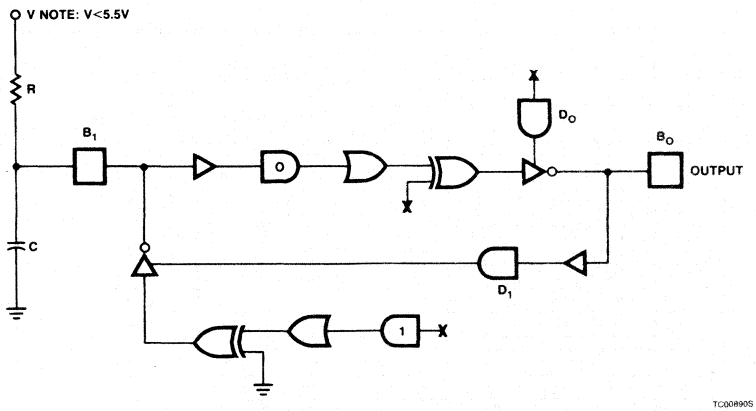
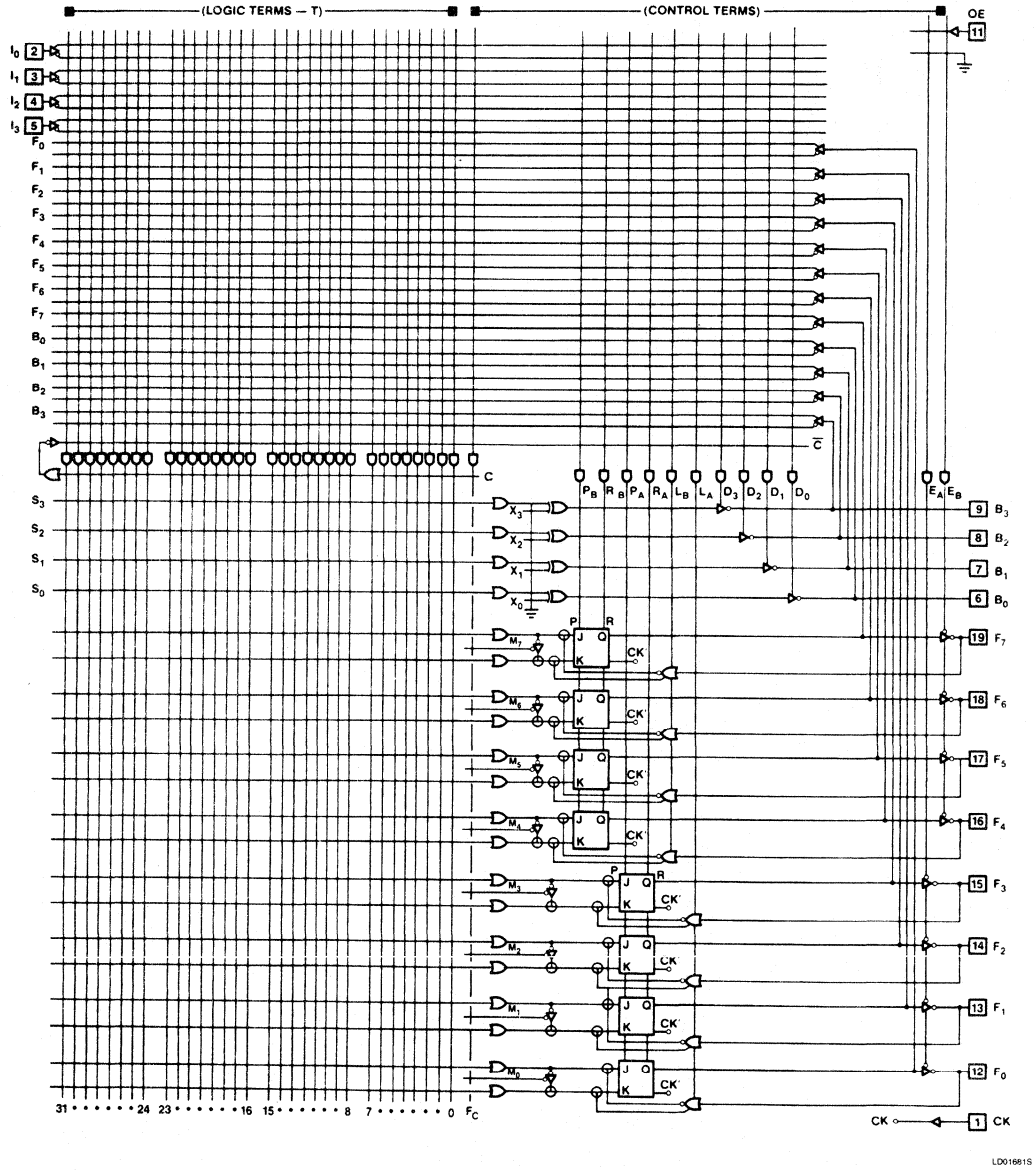


Figure 2. Logic Diagram of Oscillator Circuit

9

Oscillator With PLS159

AN13



NOTES:
1. All OR gate inputs with a blown link float to logic "0".
2. All other gates and control inputs with a blown link float to logic "1".
3. ⊕ denotes WIRE-OR.

Figure 3. Logic Diagram of PLS159 FPLS

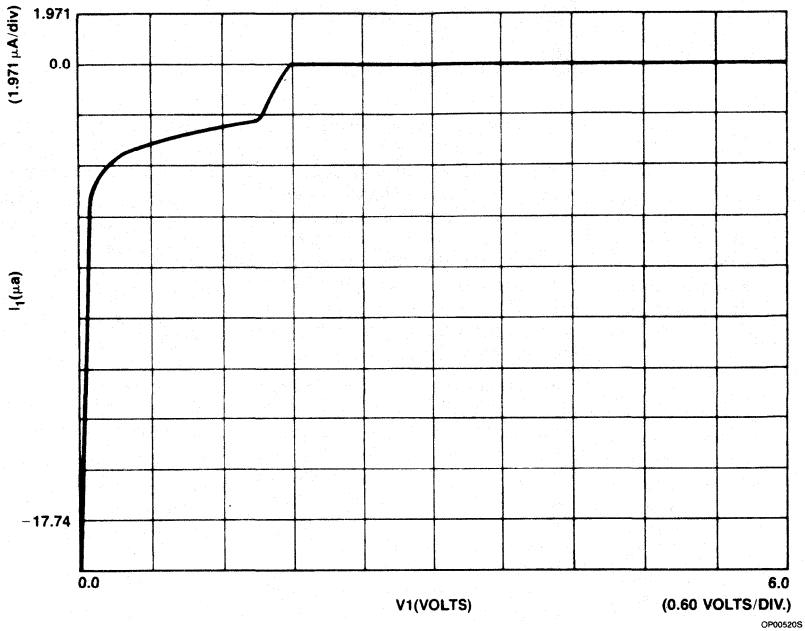
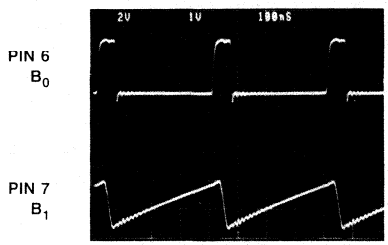
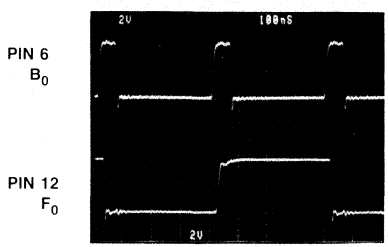


Figure 4. Input Current vs Input Voltage Characteristics of I/O Pins



V_{CC} = 5.0V, V = 5.0V, T_A = 25 C

R = 2.2K, C = 500pF



V_{CC} = 5.0V, V = 5.0V, T_A = 25 C

R = 2.2K, C = 500pF

WF05030S

Figure 5. Output Waveforms of Oscillator Circuit

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Signetics

AN14
Latches & Flip-Flops With PLS153

Application Note

Application Specific Products

DESCRIPTION

Using the simple AND, OR and INVERT logic functions of the PLS153, memory functions such as latches and edge-triggered flip-flops may be implemented with a relatively small part of the chip and without external wiring. In this application note, we will discuss the implementation of two R-S latches, a D-latch, an edge-triggered R-S flip-flop, and an edge-triggered D flip-flop.

INTRODUCTION TO PLS153

To implement this function, let's first take a look at the PLS153 logic diagram and its programming table as shown in Appendices A and B. On the left side of the logic diagram (Appendix A) are eight dedicated inputs, I_0 to I_7, each of which has a true and a complement output. Each output is connected to the inputs of 32 AND functions (we will call them AND-terms from now on), the outputs of which are, in turn, connected to the inputs of ten OR functions. The output of each OR function is connected to one input of an Exclusive-OR function, which is in turn connected to a non-inverting output buffer. The function of the XOR is to control the output polarity. The output, in its virgin state, is non-inverting, since one side of the XOR is connected to ground by the fuse X_n, where n = 0, 1, 3...9. To have the output inverted, one needs only to blow fuse X_n open so that the X_n input is unconditionally HIGH. The output buffers are all three-state buffers which may be enabled or disabled by their corresponding AND gates. The output buffers are disabled in their virgin state. All pins labeled "B" are bidirectional. Input buffers of the "B" pins are identical to those of the "I" pins.

The programming table shown in Appendix B emulates a truth table. All the inputs to the device are positioned on the left side, and all the outputs are on the right side. Each row in the table corresponds to an 18-input AND-term with up to ten outputs. On the left side, or the input side of the table, each column represents an input. The 18 columns represent input buffers I_0 to I_7, B_0 to B_9. To distinguish between inputs and outputs of the bidirectional pin, B(I) is used for input and B(O) is used for outputs as shown in the programming table. On the right side of the table, each column represents an output circuit ($B(O)_{0-9}$) which consists of an OR gate, an XOR, and a non-inverting three-state buffer. The output buffers are controlled by AND-terms D_0 to D_9, the inputs of which may be connected to any number of the 18 inputs. The polarity of the outputs is defined by the POLARITY entries which are on the upper right corner of the programming table.

To program the inputs to the AND-terms, an "H" will cause the fuse of the inverting input buffer to be blown, leaving the non-inverting buffer connected to the AND-term; an "L" will do the opposite. A " – " will cause both fuses to be blown, and therefore the programmed input is a "Don't care". A "0", the virgin state of the device, has both fuses intact, which causes the output of the AND-term to be unconditionally LOW.

To program the outputs, a "." causes the fuse that connects the output of AND-term to the input of an OR to be blown and thus renders the output inactive. An "A" causes the fuse to remain intact and thus the output is active.

The output polarity of each output buffer may be programmed by entering an "H" or an "L" in the POLARITY section. An "L" causes the XOR to blow its grounding fuse and become inverted, whereas an "H" leaves the fuse intact and the output is non-inverted.

To AND several inputs, we put them in a row; to OR several inputs, we put them in different rows, as shown in illustrations in Appendix B.

Latches & Flip-Flops With PLS153 AN14

SIMPLE R-S LATCH

A simple R-S latch may be formed by cross-coupling two NAND functions together as shown in Figure 1.

As an illustration, let's assign the input R to I_0 of the PLS153, input S to I_1, output Q to B_0, and output $\overline{Q}$ to B_1. As shown in Table 1, to form the NAND gates we need to program the POLARITY LOW on $B(O)_0$ and $B(O)_1$. To unconditionally enable the output buffers, we "dash" out all inputs to D_0 and D_1. As for the inputs, we put an "H" on I_0, term-0 for the input R, non-inverted; another "H" on $B(I)_1$, term-0 for the feedback from Q. In the same manner, we program I_1, term-1 and $B(O)_0$ "H". The POLARITY, rows 0, 1, D_0 and D_1, forms a "truth table" with which one can analyze his own or someone else's design. The program in Table 1 may be illustrated as shown in Figure 2.

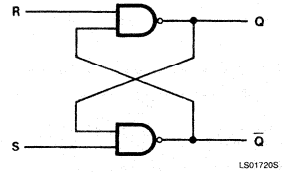


Figure 1. RS Latch

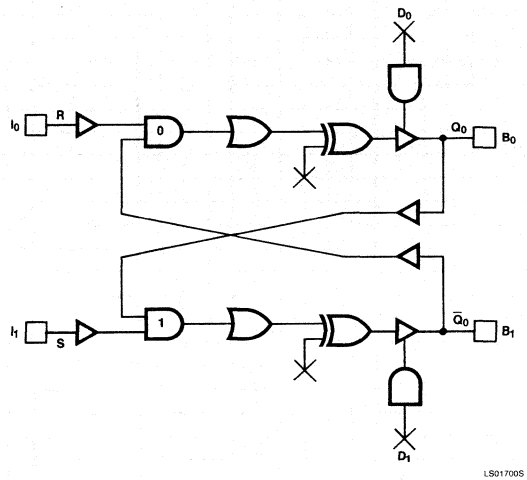
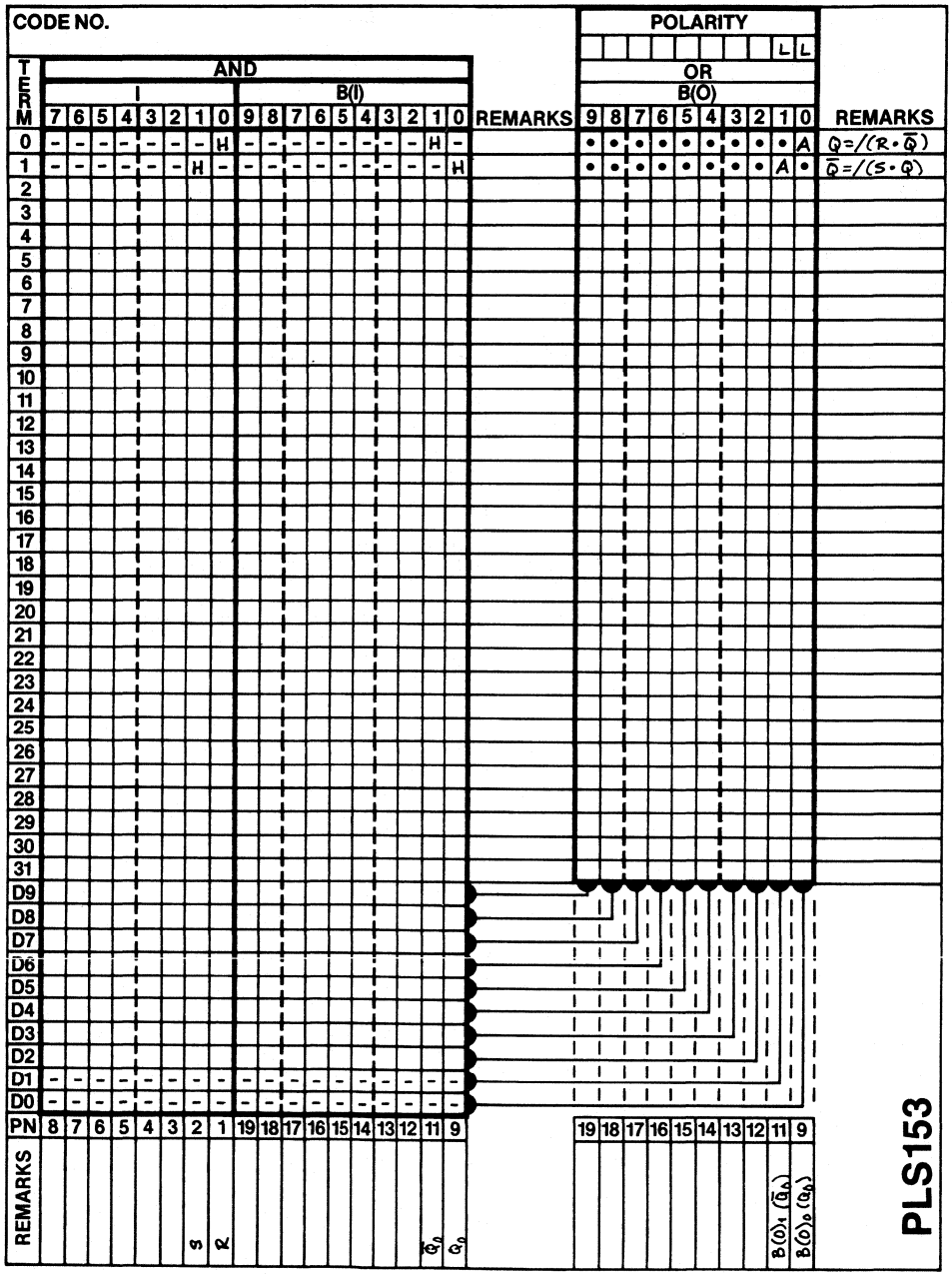


Figure 2. RS Latch

Latches & Flip-Flops With PLS153

AN14

Table 1. PLS153/153A Programming Table



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ANOTHER SIMPLE R-S LATCH

Another way to implement a simple latch is shown in Figure 3, in which two NOR functions are cross-coupled to form a latch.

As with the previous example, we first define the input and output pins. For this example, we use I_2 for the R input, I_3 for the S input, B_2 for the Q output, and B_3 for the $\overline{Q}$ output. We program B_2 and B_3 to have inverted outputs by programming POLARITY of B_2 and B_3 LOW, as shown in Table 2. Terms 6 and 7 are ORed together by $B(O)_2$, rows 6 and 7. In the same manner $B(O)_3$ ORs Terms 8 and 9. The programmed table of this design may be represented as shown in Figure 4.

Since each AND-term of the PLS153 can accommodate up to 18 inputs (true or inverting inputs of eight from I_0 to I_7 and ten from B_0 to B_9), and each OR circuit can be connected to up to thirty-two AND-terms, we can add additional features such as those shown in Figure 5.

The programming of this design is left to the reader as an exercise.

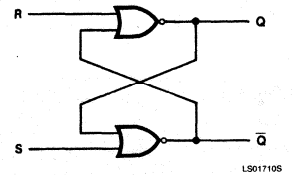


Figure 3. RS Latch

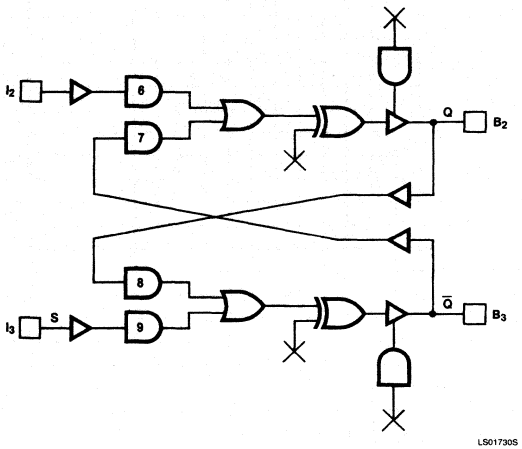


Figure 4. RS Latch

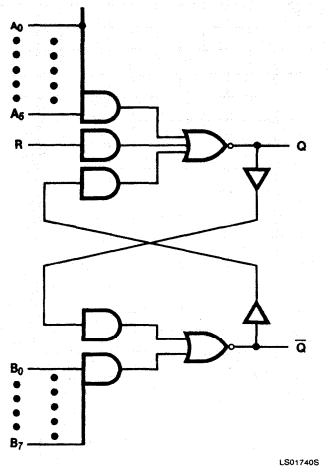
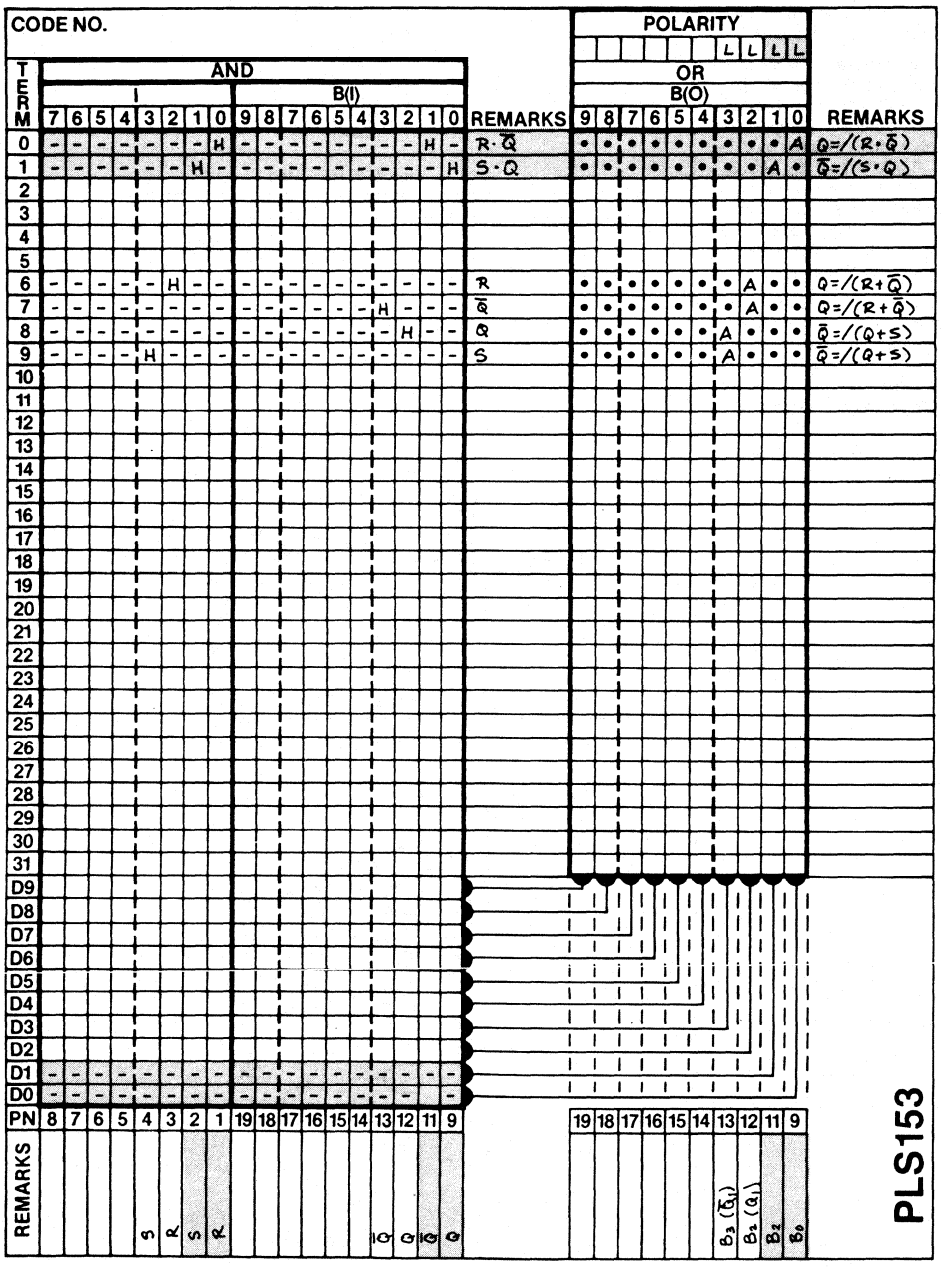


Figure 5. RS Latch

Table 2. PLS153/153A Programming Table



D-LATCH

A simple D-latch can be constructed with an PLS153 as shown in Figure 6.

This circuit may be easily programmed into the PLS153 as shown in Table 3. The program may, in turn, be represented as shown in Figure 7.

This circuit may be expanded to have multiple D-latches using the same latch enable (LE).

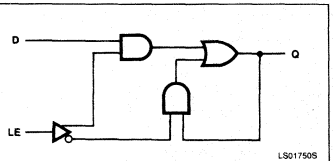


Figure 6. D Latch

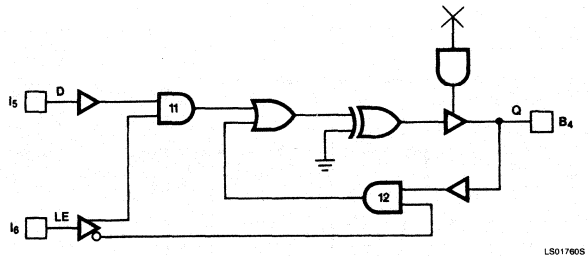


Figure 7. D Latch

R-S FLIP-FLOP

Two R-S latches may be combined to form a master-save flip-flop that is triggered at the rising-edge of the clock (or the falling-edge of the clock, if the designer so desires). Figure 8 shows a combination of two sets of cross-coupled NOR gates concatenated to form the flip-flop. The implementation of this circuit using PLS153 is as illustrated in Table 4 and Figure 9.

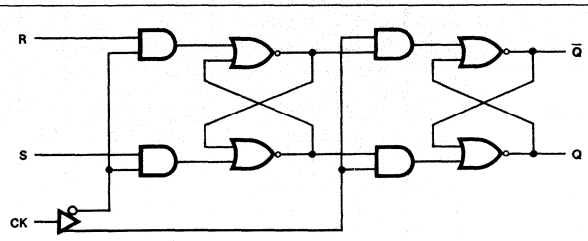


Figure 8. RS Flip-Flop

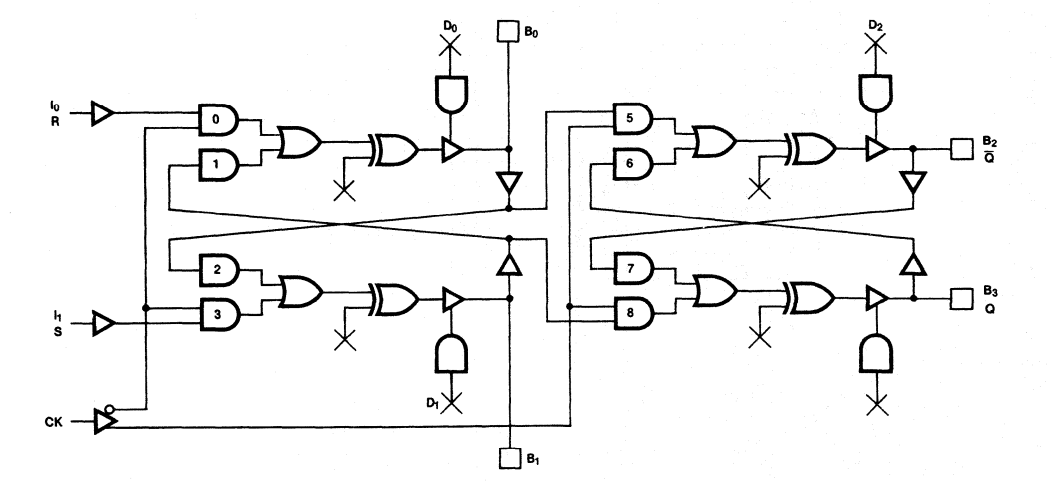


Figure 9. RS Flip-Flop

Table 3. PLS153/153A Programming Table

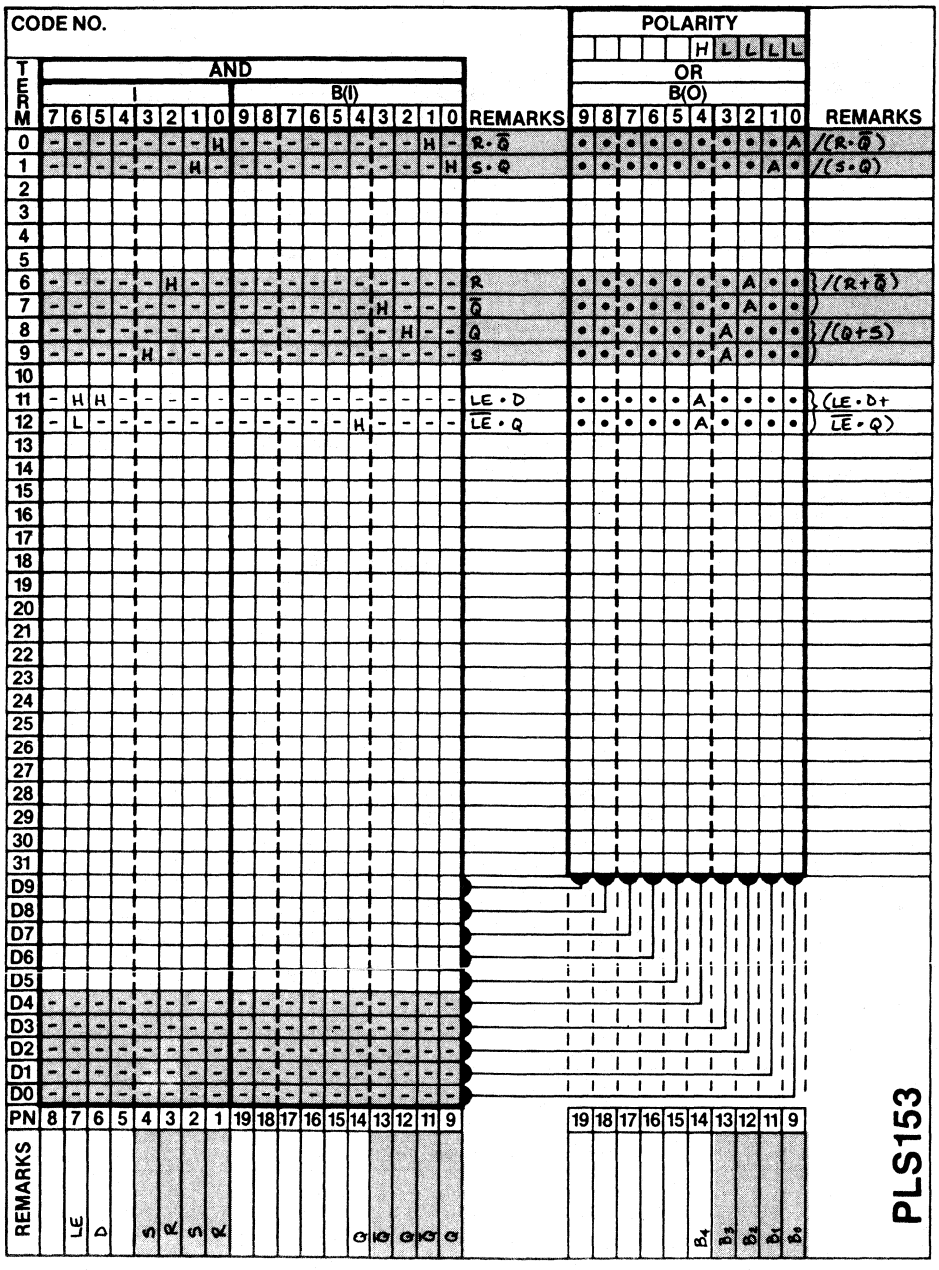
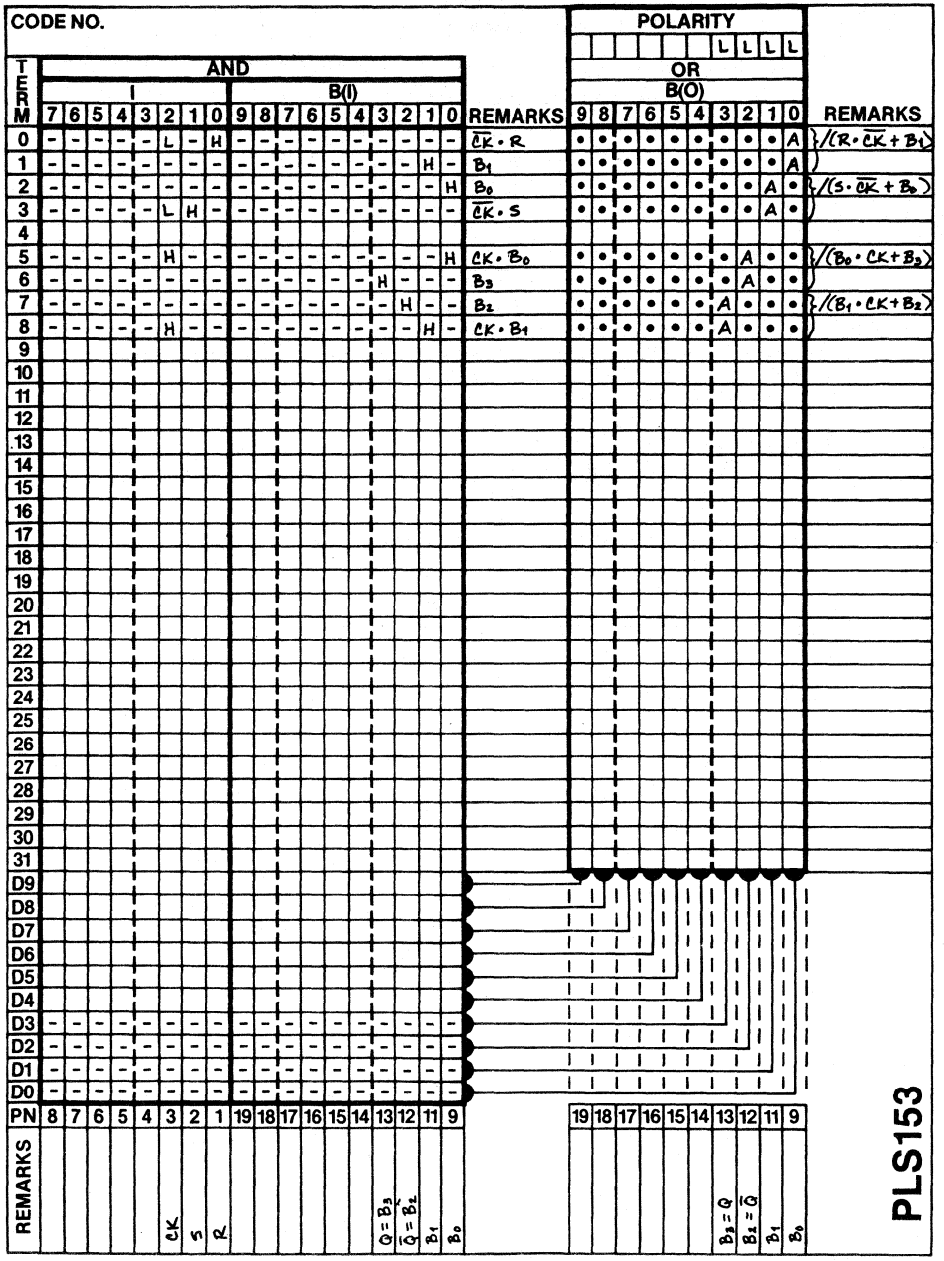


Table 4. PLS153/153A Programming Table



Latches & Flip-Flops With PLS153 AN14

D FLIP-FLOP

An edge-triggered master-slave D flip-flop may be constructed with two D-latches in the manner shown in Figure 10.

An PLS153 may be programmed as shown in Figure 11 to implement the D flip-flop which is equivalent to the circuit shown in Table 5 in the PLS153 logic representation.

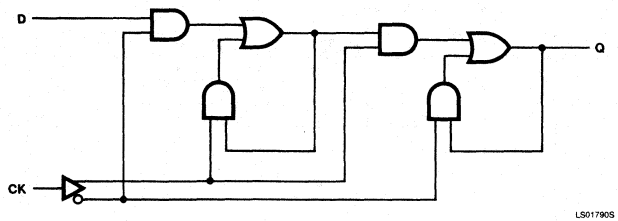


Figure 10. D Flip-Flop

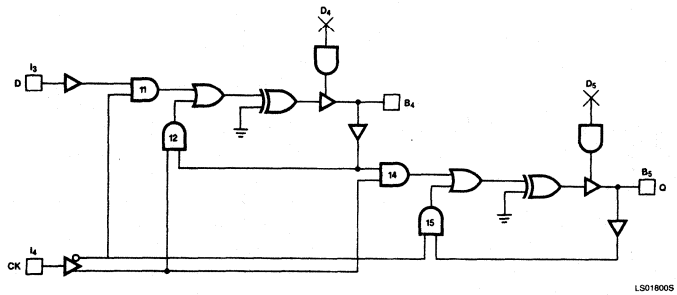
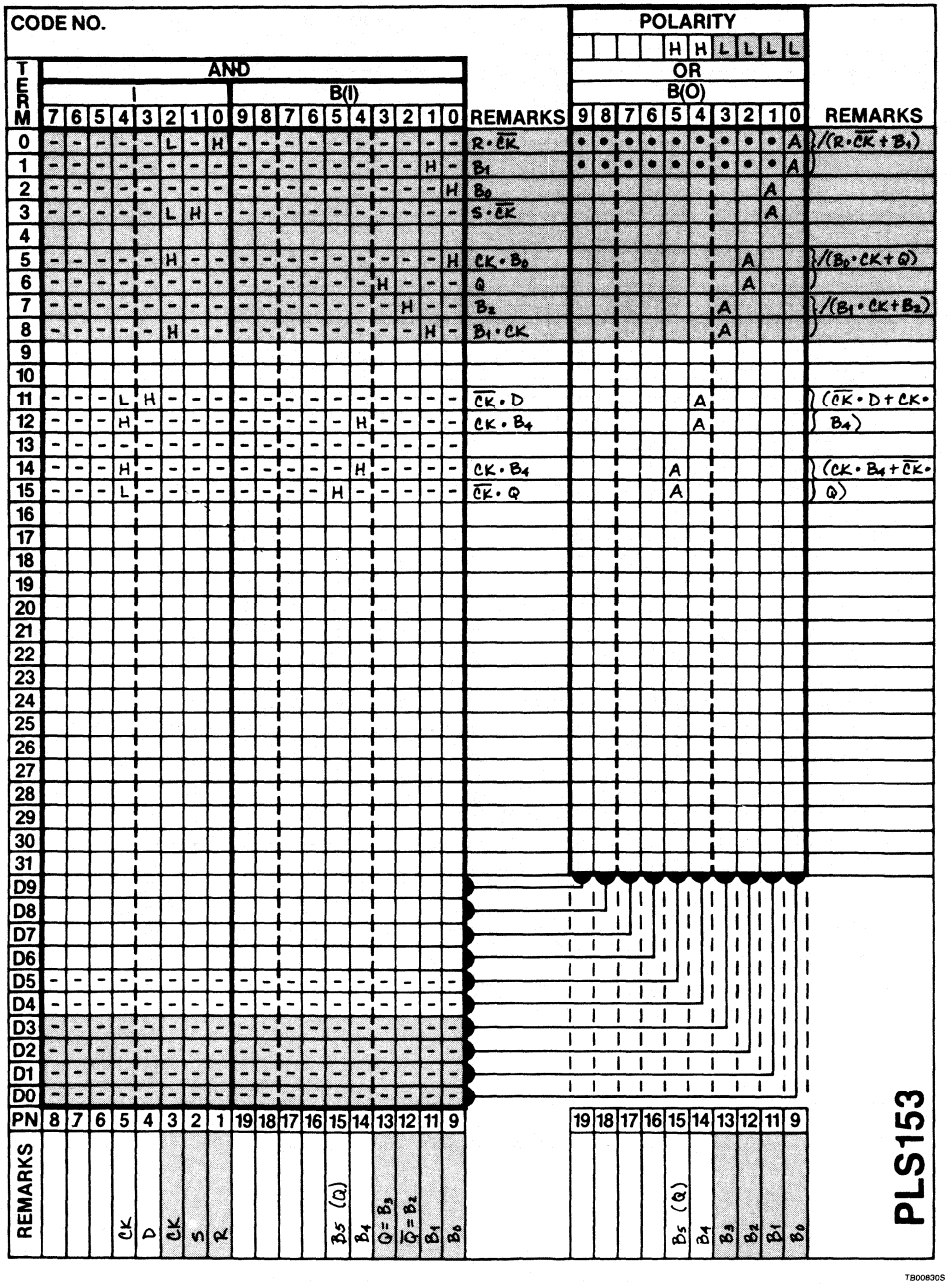
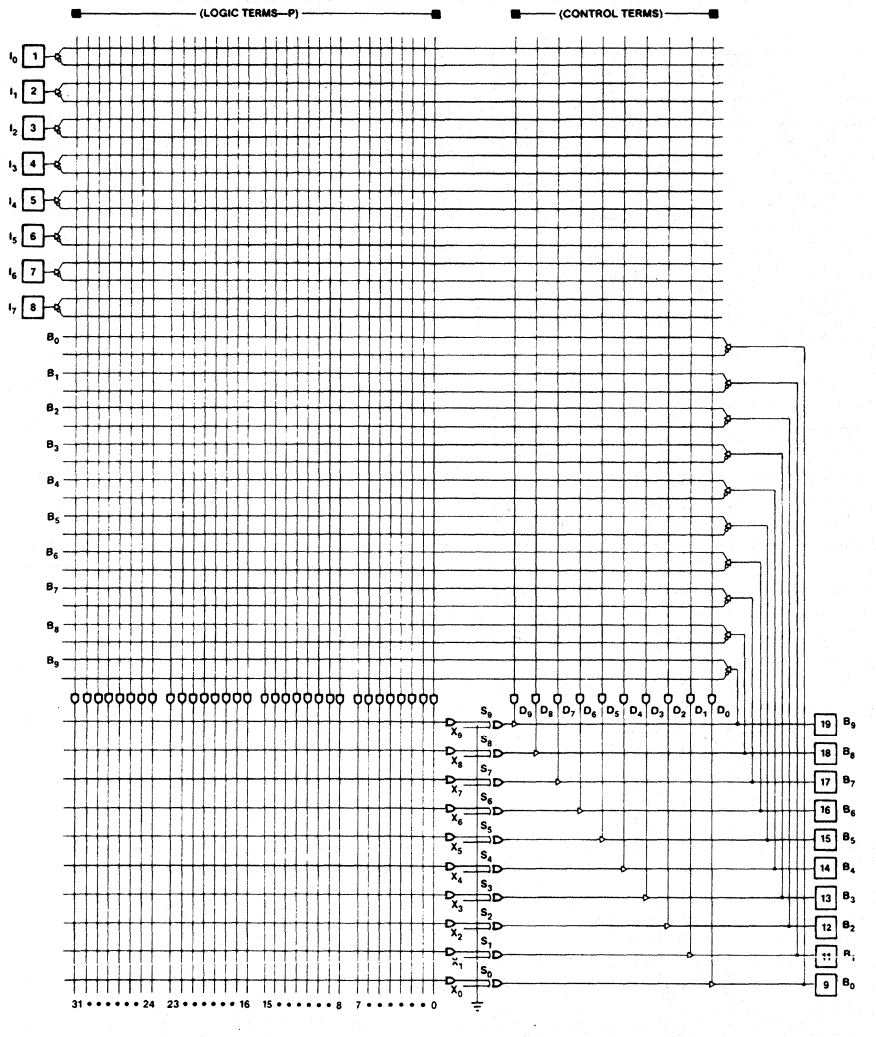


Figure 11. D Flip-Flop

Table 5. PLS153/153A Programming Table



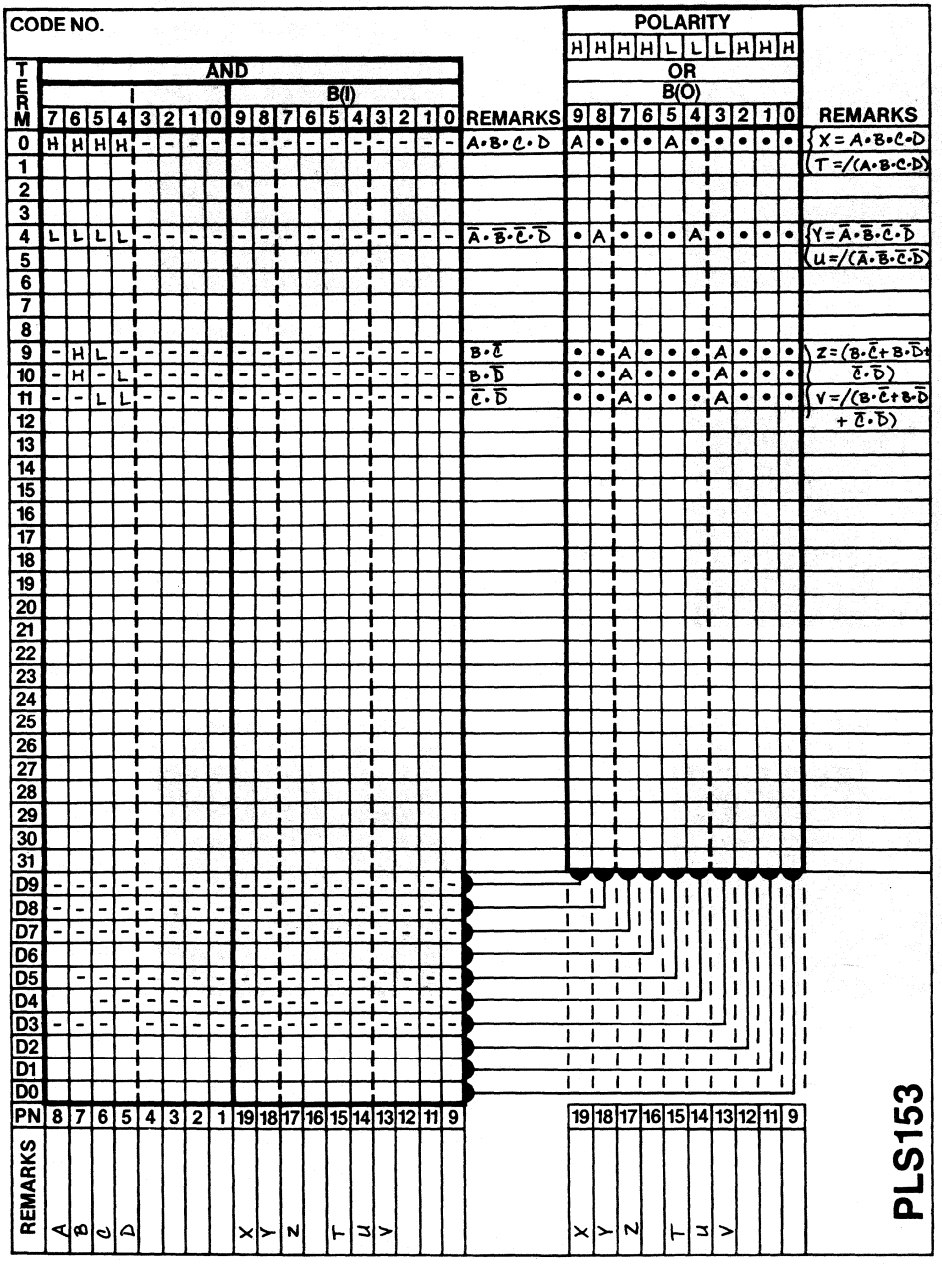
APPENDIX A



NOTES:
1. All programmed "AND" gate locations are pulled to logic "1".
2. All programmed "OR" gate locations are pulled to logic "0".
3. Programmable connection.

Figure A-1. FPLA Logic Diagram

Appendix B. PLS153/153A Programming Table

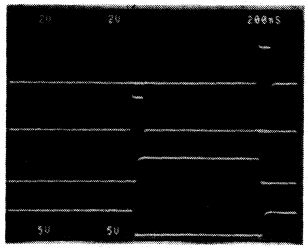


TB00820S

Latches & Flip-Flops With PLS153 — AN14

APPENDIX C

R-S LATCH (Cross-Coupled NOR)
See Figures 3 and 4 and Table 2



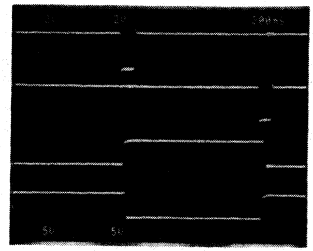
R Pin 3

S PIN 4

Q PIN 12

$\overline{Q}$ PIN 13

R-S LATCH (Cross-Coupled NAND)
See Figures 1 and 2 and Table 1



$\overline{S}$PIN 1

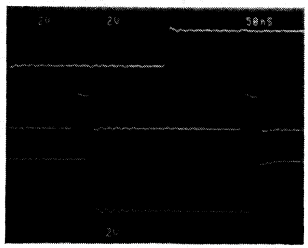
$\overline{R}$ PIN 2

Q PIN 9

$\overline{Q}$ PIN 11

Typical set-up time ≅ 0ns
Typical hold time ≅ 0 – 5ns
Typical propagation delay ≅ 20ns

D-LATCH
See Figures 6 and 7 and Table 3

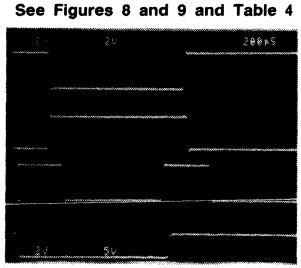


D PIN 6

LE PIN 7

Q PIN 14

EDGE-TRIGGERED R-S Flip-Flop
See Figures 8 and 9 and Table 4



R PIN 1

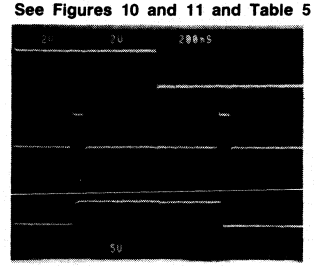
S Pin 2

CLOCK PIN 3

Q PIN 13

NOTE: Timing requirements/performances are the same as the R-S latches

EDGE-TRIGGERED D Flip-Flop –
See Figures 10 and 11 and Table 5



D PIN 4

CLOCK PIN 5

Q PIN 15

NOTE: Timing requirements/performances are the same as the D-latch

Figure C-1. Timing Photos

Signetics

AN15
PLS159 Primer

Application Note

Application Specific Products

INTRODUCTION

The PLS159 is a field programmable logic sequencer which consists of four dedicated inputs, four bidirectional I/O's, eight flip flops, thirty two 16-input AND gates, twenty 32-input OR gates, and a complement array. Each flip flop has a bidirectional I/O and may be individually programmed as J-K or D flip flop, or switch between the two types dynamically. The flip flops will accept data from the internal logic array or from the bidirectional I/O, or they may be set or reset asynchronously from the AND array. The output polarity of the four bidirectional I/O's are programmable and the direction is controlled by the AND array. Figure 1 is the logic diagram of PLS159.

PROGRAMMING THE PLS159

The programming table is shown in Table 1 where there is a place for everything that is shown in Figure 1. The program table is basically divided into two main sections. The left hand side of the table, section A, represents the input side of the AND gates, while the right hand side, section B, represents the OR gates sections which includes the flip flops and the combinatorial outputs B(0) to B(3). The flip flops modes are defined in section C and the output polarities of the combinatorial outputs are defined in section E. The programming symbols are detailed in Figure 2.

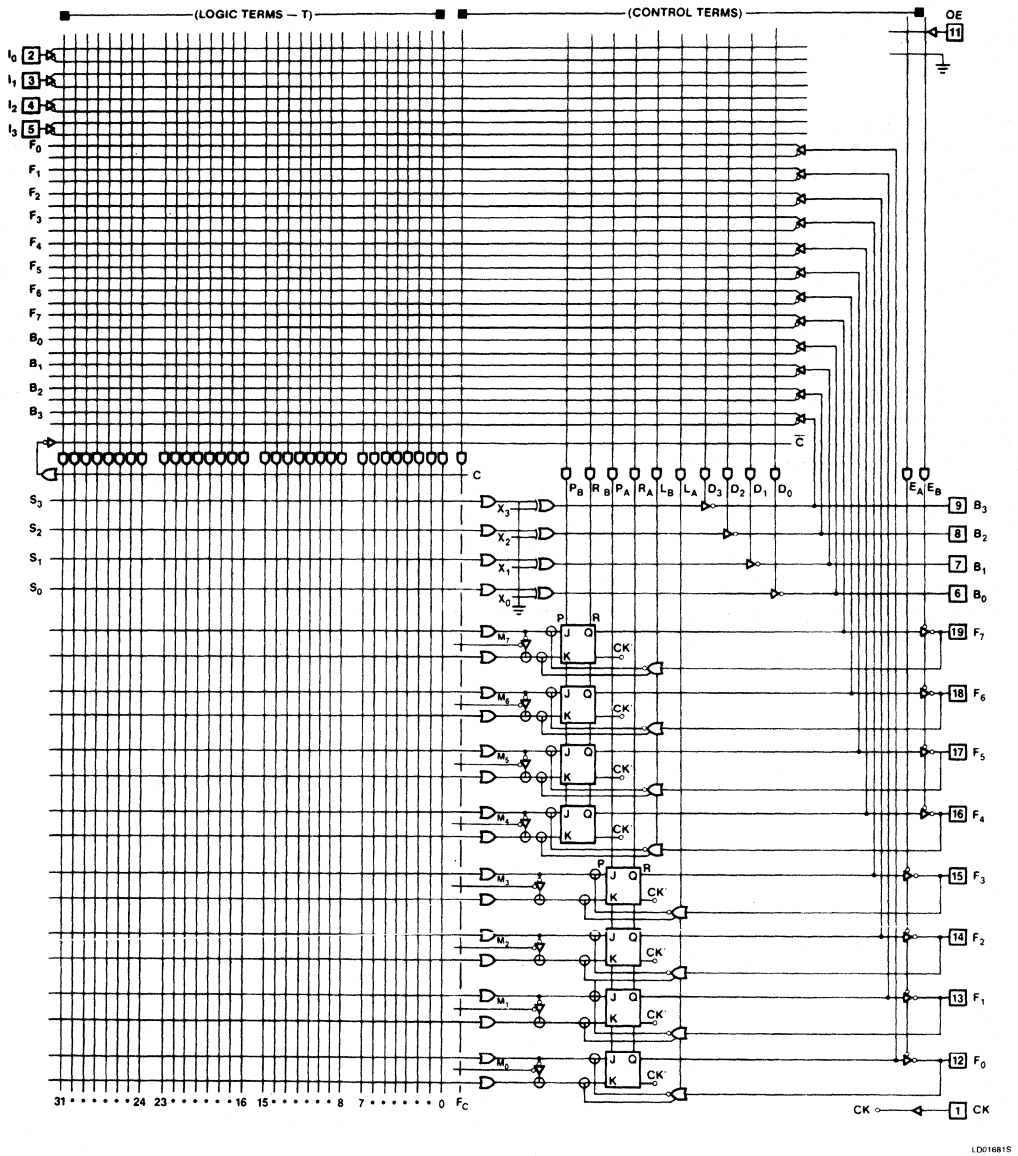
As shown in Table 1, the programming table is very similar to a truth table. Each column in section A represents an input to the 32 AND gates, and each row represents an AND gate connecting to 17 inputs. Columns I_0 to I_3 represent the 4 dedicated inputs, I_0 to I_3. Columns $B(I)_0$ to $B(I)_3$ represent the inputs of the 4 bidirectional I/O, B_0 to B_3. Columns $Q(P)_0$ to $Q(P)_7$ represent the feedback, F_0 to F_7, from the flip flops (the present state). Column "C" represents the complement array.

As shown in Figure 1, the outputs of the AND gates are connected to an array of OR gates which, in turn, are connected to either flip flops or output circuits. Columns $Q(N)_0$ to $Q(N)_7$ represent the next state which the flip flops will be in. Columns $B(O)_0$ to $B(O)_3$ represent the combinatorial outputs B_0 to B_3.

Each row represents an AND gate with 17 inputs each of which may be true and/or complement and is, therefore, a perfect decoder. Referring to the programming symbols in Figure 2, to implement the equation

$$Z = A * B * C * D,$$

all one has to do is to enter one line as shown in Table 2, term–0.



NOTES:
1. All OR gate inputs with a blown link float to logic "0".
2. All other gates and control inputs with a blown link float to logic "1".
3. ⊕ denotes WIRE-OR.

Figure 1. FPLS Logic Diagram

Table 1. FPLS Program Table

PLS159 Primer

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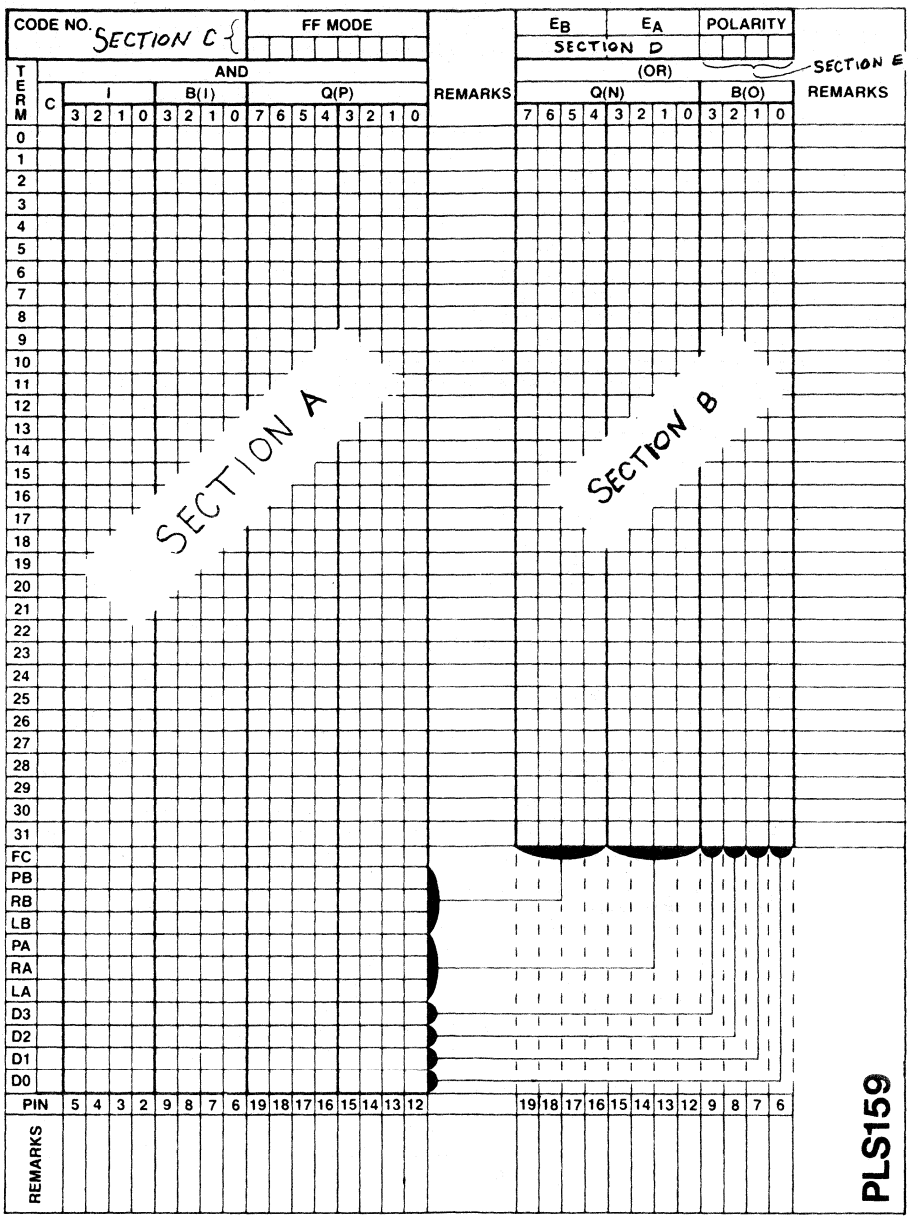
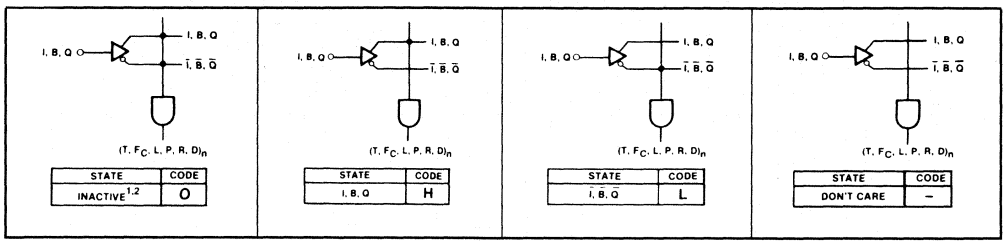


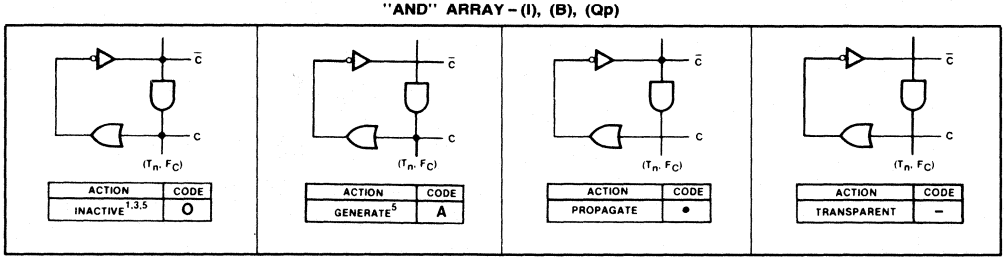
The FPLS can be programmed by means of Logic Programming equipment.

With Logic programming, the AND/OR-EX-OR input connections necessary to implement the desired logic function are coded directly from the State Diagram using the Program Tables on the following pages.

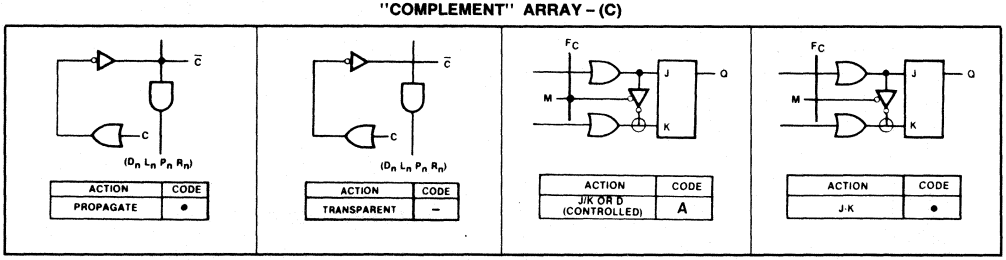
In these Tables, the logic state or action of all I/O, control, and state variables is assigned a symbol which results in the proper fusing pattern of corresponding links defined as follows:



"AND" ARRAY – (I), (B), (Qp)

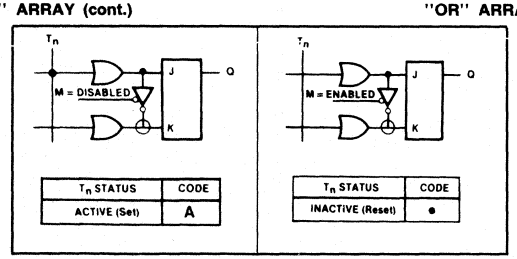


"COMPLEMENT" ARRAY – (C)



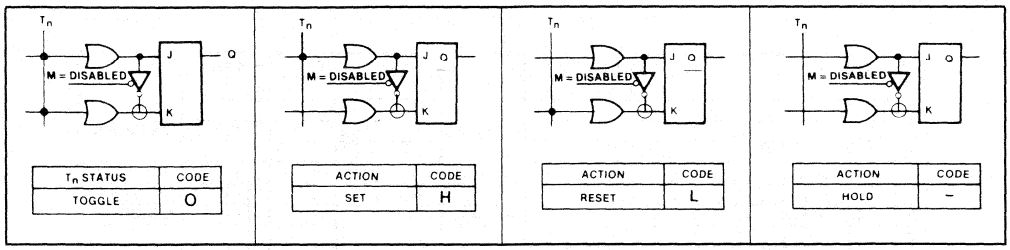
"COMPLEMENT" ARRAY (cont.)

"OR" ARRAY – (MODE)

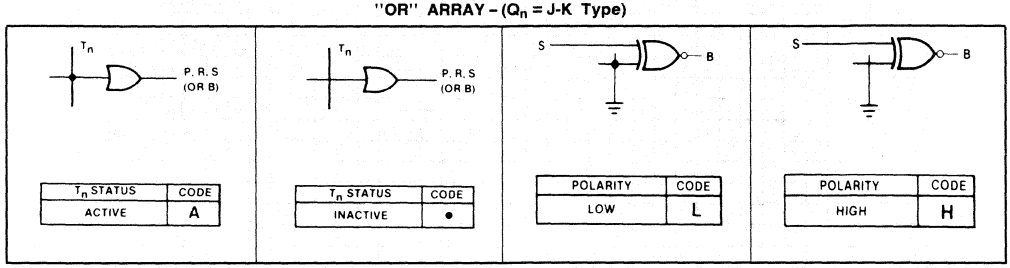


"OR" ARRAY – (Q_N = D-Type)

Figure 2

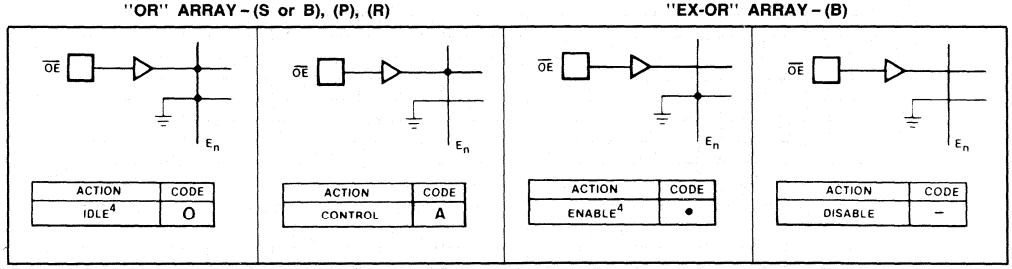


"OR" ARRAY – (Q_n = J-K Type)



"OR" ARRAY – (S or B), (P), (R)

"EX-OR" ARRAY – (B)

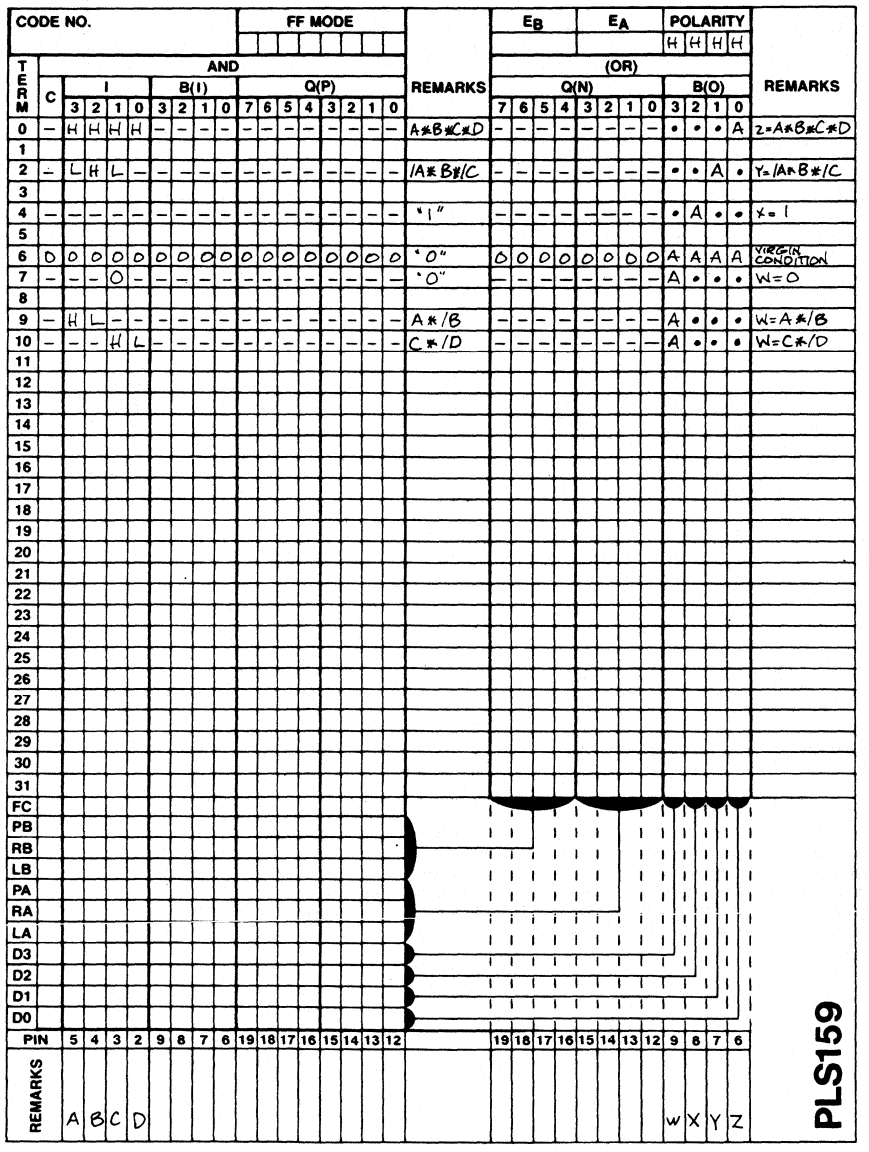


"$\overline{O.E.}$" ARRAY – (E)

Notes:
1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates.
2. Any gate (T, F_C, L, P, R, $D)_n$ will be unconditionally inhibited if any one of the I, B, or Q link pairs is left intact.
3. To prevent oscillations, this state is not allowed for C link pairs coupled to active gates T_n, F_C.
4. E_n = O and E_n = • are logically equivalent states, since both cause F_n outputs to be unconditionally enabled.
5. These states are not allowed for control gates (L, P, R, $D)_n$ due to their lack of "OR" array links.

Figure 2 (continued)

Table 2. FPLS Program Table



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Notice that only I_0 to I_3 on the left hand side and $B(O)_4$ on the right hand side have entries to implement the equation. All unused columns are dashed out or dotted out.

To implement the equation

Y = /A * B * /C,

enter one line as shown in Table 2, term-2 where the entry "H" represents the non-inverting input buffer while the entry "L" represents the inverting buffer. To have the AND gate to be unconditionally "HIGH", dash out all the inputs of that particular AND gate as shown in Table 2, term-4. The virgin condition of the device, as shipped from the factory, has all connections intact, which means that the inverting and the non-inverting buffers of the same inputs are connected together. Such connection will cause the AND gate to be unconditionally "LOW" as shown in Table 2, terms 6 and 7. The unconditional HIGH and LOW states are normally useful only internally and seldom brought out to the output pins.

To implement the equation

W = A * /B + C * /D,

enter one line for A * /B and another line for C * /D as shown in Table 2, terms 9 and 10. Use one line to AND something together; use different lines to OR something together — one line per item to be OR'ed.

All the pins which are labelled B's are bidirectional I/O pins. Their input buffers are represented by the B(I) columns on the left hand side of the programming table. An "H" entry represents the non-inverting buffer and an "L" entry represents the inverting buffer. Their output buffers are represented by the B(O) columns on the right hand side of the table. An "A" entry means that the output is active (connected to the AND gates); a "." entry means that the output is inactive (not connected). The outputs may be programmed to be inverting or noninverting. The polarity of each output is determined by its exclusive OR gate (Figure 1 and Figure 2). To have a non-inverting output, enter an "H" in the section labelled "POLARITY" (Table 1, Section E). To have an inverting output, enter an "L". For example, Table 3, terms-0 and-2 implement the equation

Z = /(A * B)
and Y = A * B

respectively. The above two equations may also be implement by term-4 which uses the same AND gate to drive two OR gates.

Besides being able to have programmable active high or active low output, the programmable output polarity feature also allows the user to minimize his AND term utilization by converting his logic equation into other forms such as conversion by De Morgan Theorem.

Example:
The equation

X = A + B + C + D

takes four AND terms to implement as shown in Table 3, terms 6 to 9. By using De Morgan Theorem, the same equation is changed to

/W = /A * /B * /C * /D

The result is as shown in term 11 – a saving of three AND terms. The output buffers are disabled in their virgin states so that they all behave as inputs. The buffers are enabled or disabled by their corresponding Control AND terms D_0 to D_3 (see Figure 1). The Control AND terms are represented in the programming table on the last four rows on the left hand side. Dashing out all the inputs will cause the output buffer to be unconditionally enabled, whereas a "0" (zero) will cause the buffer to be unconditionally disabled. The buffers may also be controlled by a logical condition, e.g. A * /B * /C, etc.

There are eight flip flops on the chip each of which may be programmed as a J/K or a D flip flop, or they may be programmed to switch dynamically. As shown in Figure 1, each flip flop is a J/K to begin with. A tri-state inverter is connected in between the J and K inputs of each flip flop, which when enabled by the AND gate F_C, will cause the flip flop to function as a D flip flop. The inverters are enabled by F_C through fuses M_0 to M_7. A "." in the F/F Mode entry of the programming table means that particular fuse is to be disconnected and that particular flip flop is to be J/K. An "A" entry will leave the M fuses intact, which allow the flip flop to be D or J/K as controlled by the output of F_C (see Figure 2, "OR" ARRAY – (MODE)). The inputs to the flip flops are represented by the programming table as the next state, $Q(N)_{0\ to\ 7}$ since their inputs are from the OR array. The outputs of these registers are connected to their respective tri-state inverting output buffers, four of which are controlled by EA and the other four by EB. A "." in EA will enable outputs F_0 to F_3, whereas a "-" will disable them. An "A" will allow the output buffers to be controlled by /OE, pin 11. Table 4, terms 0, 1 and 3 represent the following equations

Q_0: J = A * C + /B * /E eq. 1

Q_0: K = A * /C eq. 2

Notice that the J input in equation 1 is represented by the "H" entry in terms-0 and 1, column $Q(N)_0$ while the K input in equation 2 is represented by the "L" entry in term-3, column $Q(N)_0$. An undefined input, J or K, is considered "LOW".

Table 3. FPLS Program Table

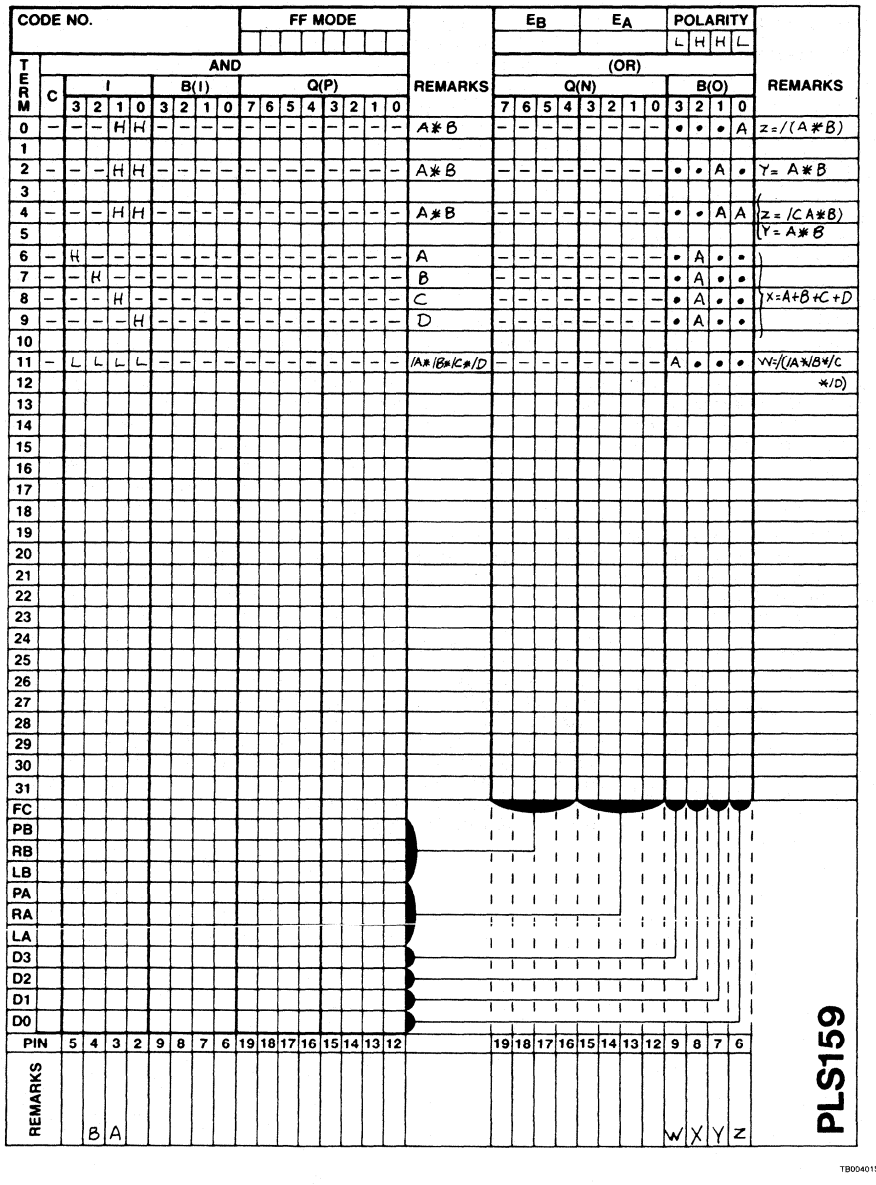
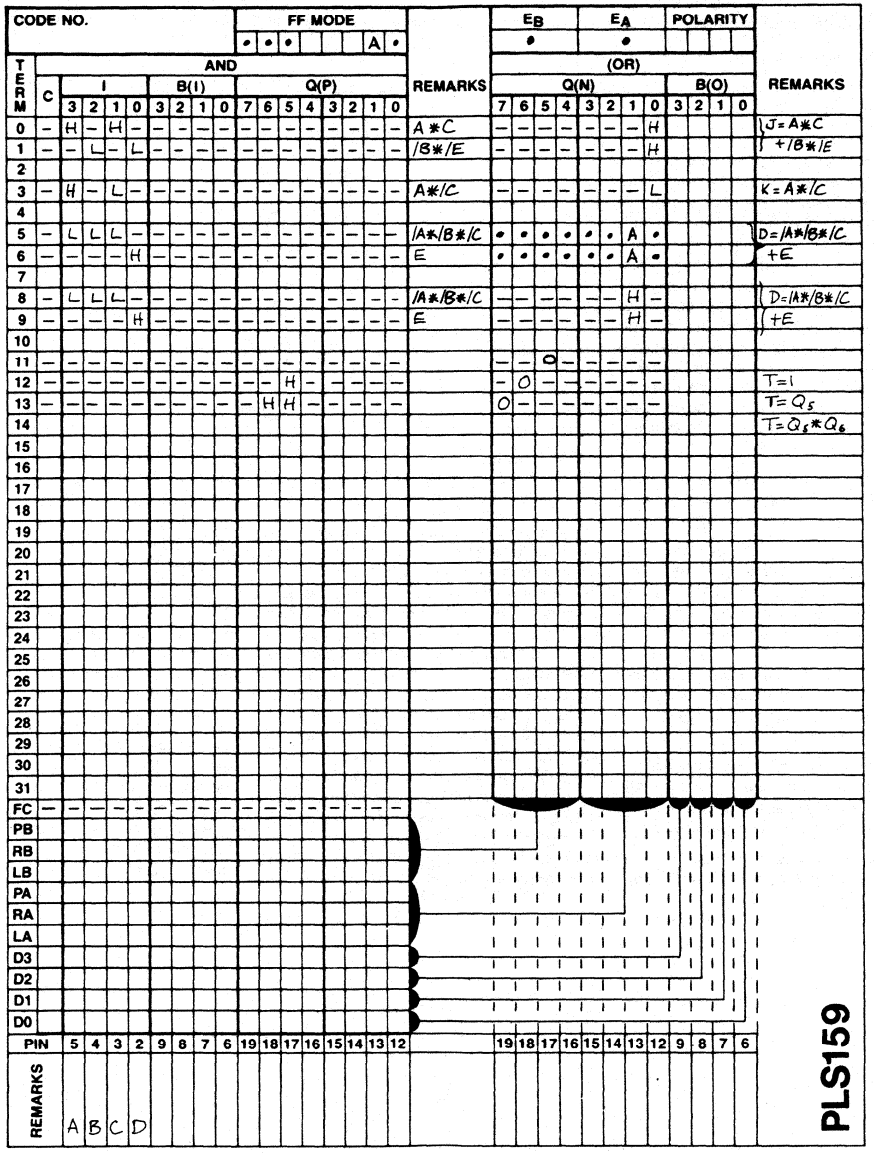


Table 4. FPLS Program Table



PLS159 Primer

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A D flip flop may be implemented by first entering an "A" in F/F MODE. Then enter "0" in the row F_C, which will unconditionally enable the tri-state inverter between the J and K inputs. The following logic equation may be implemented as shown in Table 4, term 5

Q_1: D = /A * /B * /C + E.

Notice that the entries in term 5, columns $Q(N)_{0\ to\ 7}$ are "A" and "." instead of "H" and "L" as in the case of J/K flip flops. The entry "A" will cause the fuse connecting to the "K" input to be disconnected and the "J" fuse to be intact. Whereas the entry "." will cause both fuses to be disconnected. This feature enables the user to quickly recognize the mode in which the flip flops are operating without having to go through the control terms. Some commercially available device programmers in the market may not have the software capability to implement this feature, in which case an "H" and a "-" may be used in place of "A" and "." respectively as shown in Table 4, terms 8 and 9.

Of course, the term F_C may have inputs instead of zeros and dashes, in which case the flip flop modes are controlled dynamically.

When both the J and K inputs are "1's", the flip flop will toggle. A simple 3-bit counter may be implemented using only AND terms as shown in Table 4 terms 11, 12 and 13. The logic equations for the three flip flops are as the following:

Q_5: T = 1; (Q_5 toggles unconditionally)
Q_6: T = Q_5; (Q_6 toggles when Q_5 = 1)
Q_7: T = Q_5 * Q_6; (Q_7 toggles when Q_5 * Q_6 = 1)

The above equations represent an octal up-counter. However, since the outputs of the flip flops are inverted, the counting sequence of the outputs is that of a down-counter.

The flip flops may be asynchronously set and reset by the Control AND terms PA/PB and RA/RB respectively. As shown in Figure 1, PA and RA controls flip flops F_0 to F_3, while PB and RB control F_4 to F_7.

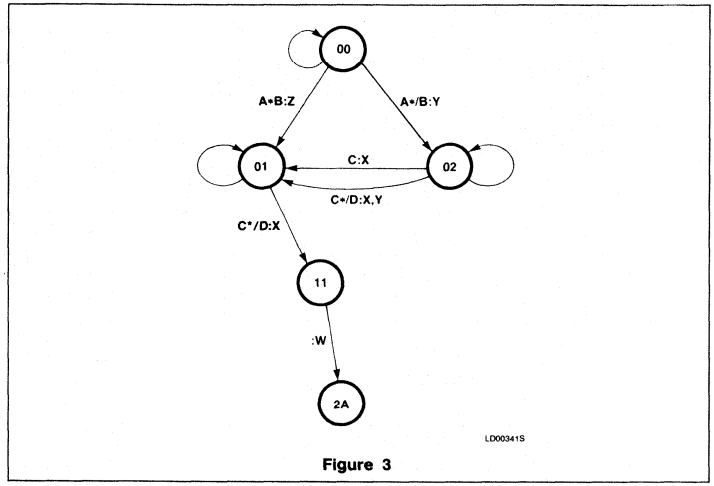


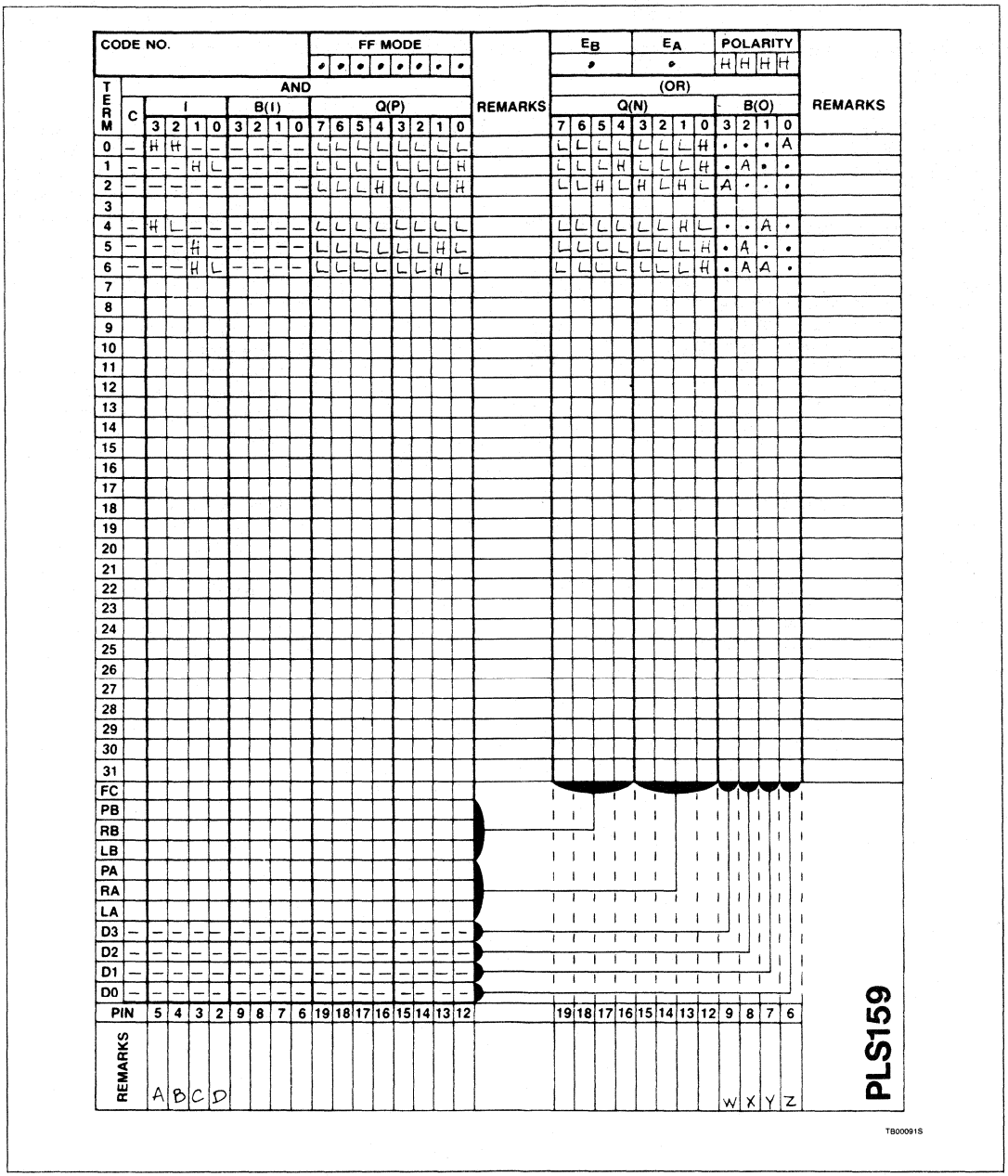
Figure 3

In order to save the number of input pins, the eight flip flops may be synchronously loaded directly from their own output pins. To use this feature, EA and/or EB must be programmed "A" or "-" so that the output buffers may be disabled before loading. As shown in Figure 1, every flip flop has an OR/NOR gate the input of which is directly connected to the output pin and the outputs of the OR/NOR are connected to the K and J inputs respectively. This OR/NOR gate inverts the input and feeds it to the flip flop in a "wire-OR" fashion. Therefore, when loading data directly into the flip flops from the output pins, caution must be exercised to insure that the inputs from the OR array does not interfere with the data being loaded. For example, if the data being loaded is a "1" on the output pin, the J input will be a "0" and the K input will be a "1". If, at the same time, a "1" is present at the J-input from the OR array, the flip flop will see "1's" in both J and K inputs. It will toggle as a result. The OR/NOR gates are enabled by the Control AND terms LA and LB. LA controls flip flops F_0 to F_3 and LB controls F_4 to F_7.

All Control AND terms function and are programmed in the same manner as the other AND terms. The only difference is that the Control AND terms are not connected to the OR array.

The outputs of the flip flops may be fed back into the AND array as the present state, Q(P). The output of the AND array into the OR array and the inputs to the flip flops is the next state, Q(N). As an example, Figure 3 is a state machine implemented in a PLS159 as shown in Table 5, terms 0 to 6.

Table 5. FPLS Program Table



Signetics

AN16
PLS159 As Modulo Counters

Application Note

Application Specific Products

DESCRIPTION

The field programmable logic sequencer (FPLS) PLS159 has eight edge-triggered flip flops which may be individually programmed to be J/K, D, or toggle flip flops. The detail logic diagram of the device is shown in Figure 2.

A counter may be constructed by having individual flip flops toggle when they are at certain states. Implementing such counters requires one toggle flip flop per bit and an associating AND gate as a decoder for each flip flop. Such a method allows the PLS159 to be a counter from modulo 2 to 256 or from one bit to 8 bits.

MODULO-8 UP/DOWN COUNTER

The Up-Counter

The PLS159 has an inverting output buffer for each flip flop. Therefore the counting sequence of the flip flops is from 7 to 0 so that the outputs will count from 0 to 7. Table 1 is the truth table of the internal counting sequence.

Table 1

COUNT	Q_2	Q_1	Q_0
0	1	1	1
1	1	1	0
2	1	0	1
3	1	0	0
4	0	1	1
5	0	1	0
6	0	0	1
7	0	0	0

From Table 1, logic equations for the flip flops may be generated as the following:

Q_0: T = 1; (Q_0 unconditionally toggles)

Q_1: T = /Q_0; (Q_1 toggles if Q_0 = 0)

Q_2: T = /Q_0 * /Q_1; (Q_2 toggles if both Q_0 and Q_1 = 0)

The equations are implemented as shown in Table 2, terms 0, 1, and 2. E_A is enabled, and the mode for the three flip flops is set to J/K. All unused flip flops and outputs (the B(0)'s) associating to AND-terms are "dashed" or "dotted" out. The event to be counted is connected to the clock input, pin 1 of the device.

The Down-Counter

The down-counter is constructed in the same manner as the up-counter except that the counting sequence is reversed. The down-counter is implemented in Table 2, terms 4 to 6 with the corresponding flip flop mode set to J/K and E_B enabled.

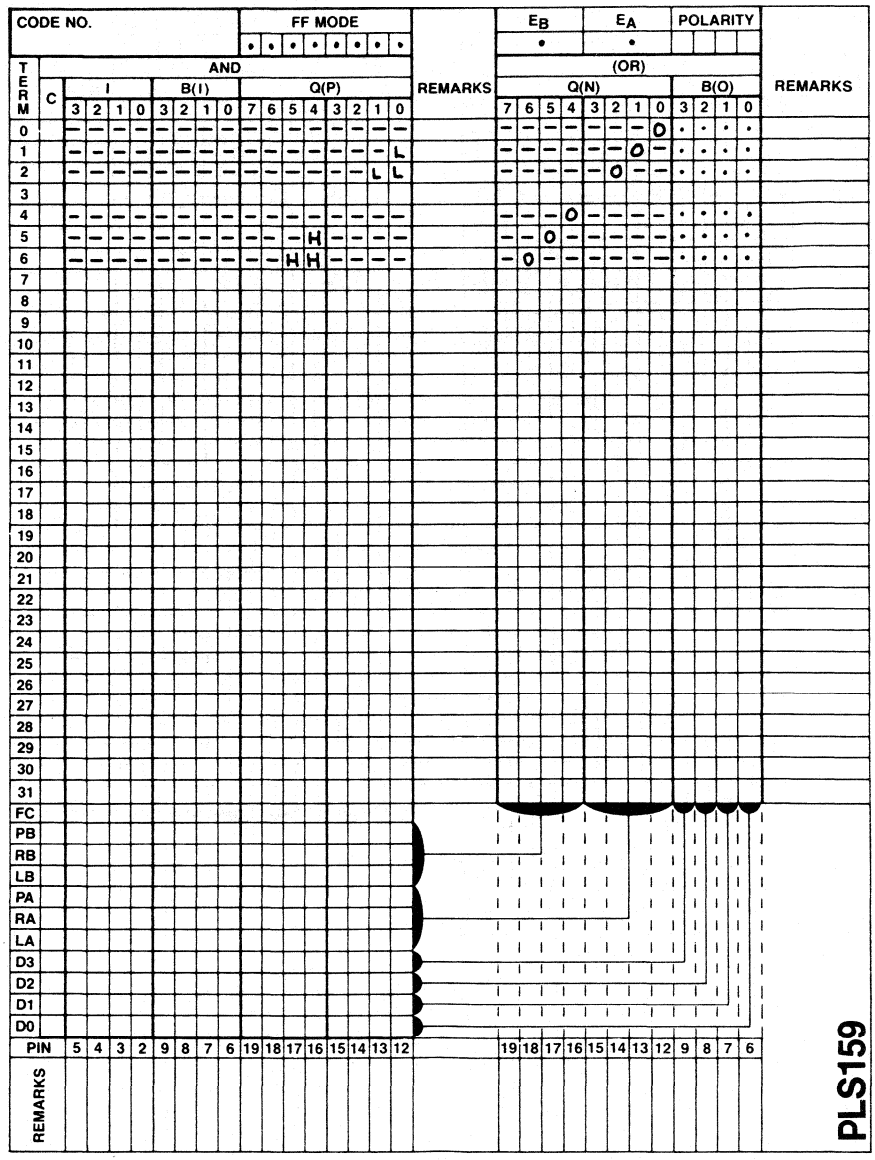
Modulo-16 Counter

Expanding the modulo-8 counter to 4-bit, the counter becomes modulo-16, Table 3, terms 0 to 3 and the associating F/F MODE and E_A implement a modulo-16 up-counter, while terms 5 to 8 and the associating F/F MODE and E_B implement the modulo-16 down-counter.

PLS159 As Modulo Counters

AN16

Table 2



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PLS159 As Modulo Counters

AN16

Table 3

CODE NO.																	FF MODE								REMARKS	E_B				E_A				POLARITY				REMARKS
																	•	•	•	•	•	•	•	•		•				•								
TERM	C	AND I				AND B(I)											AND Q(P)									(OR) Q(N)									(OR) B(O)				
		3	2	1	0	3	2	1	0	7	6	5	4	3	2	1	0									7	6	5	4	3	2	1	0	3	2	1	0	
0		–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–									–	–	–	–	–	–	–	O	•	•	•	•	
1		–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	L									–	–	–	–	–	–	O	–	•	•	•	•	
2		–	–	–	–	–	–	–	–	–	–	–	–	–	–	L	L									–	–	–	–	–	O	–	–	•	•	•	•	
3		–	–	–	–	–	–	–	–	–	–	–	–	–	L	L	L									–	–	–	–	O	–	–	–	•	•	•	•	
4																																						
5		–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–									–	–	–	O	–	–	–	–	•	•	•	•	
6		–	–	–	–	–	–	–	–	–	–	–	H	–	–	–	–									–	–	O	–	–	–	–	–	•	•	•	•	
7		–	–	–	–	–	–	–	–	–	–	H	H	–	–	–	–									–	O	–	–	–	–	–	–	•	•	•	•	
8		–	–	–	–	–	–	–	–	–	H	H	H	–	–	–	–									O	–	–	–	–	–	–	–	•	•	•	•	
9																																						
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31																																						
FC																																						
PB																																						
RB																																						
LB																																						
PA																																						
RA																																						
LA																																						
D3																																						
D2																																						
D1																																						
D0																																						
PIN		5	4	3	2	9	8	7	6	19	18	17	16	15	14	13	12									19	18	17	16	15	14	13	12	9	8	7	6	
REMARKS																																						

PLS159

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PLS159 As Modulo Counters — AN16

DECADE COUNTER

The Decade Up-Counter

The truth table of a decade counter is as shown in Table 4.

Table 4

COUNT	Q_3	Q_2	Q_1	Q_0
0	1	1	1	1
1	1	1	1	0
2	1	1	0	1
3	1	1	0	0
4	1	0	1	1
5	1	0	1	0
6	1	0	0	1
7	1	0	0	0
8	0	1	1	1
9	0	1	1	0
0	1	1	1	1

Logic equations may be generated from Table 4 as the following:

Q_0: T = 1;
Q_1: T = /Q_0 * Q_3;
Q_2: T = /Q_0 * /Q_1 * Q_3;
Q_3: T = /Q_0 * /Q_1 * /Q_2 * Q_3 +
/Q_0 * Q_1 * Q_2 * /Q_3;

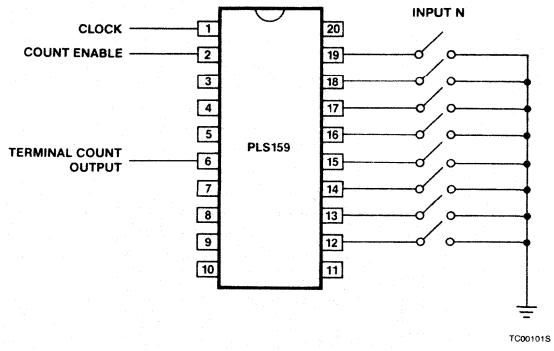


Figure 1

The equations are implemented as shown in Table 5, terms 0 to 4 and the associating flip flop mode and E_A settings.

Decade Down-Counter

The decade down-counter is similar to the decade up-counter except that the counting sequence is reversed from 0 to 9 as shown in Table 5, terms 6 to 11 with the associating F/F MODE set to J/K and E_B to ENABLE.

Decade Down Counter

COUNT	Q_7	Q_6	Q_5	Q_4
9	0	1	1	0
8	0	1	1	1
7	1	0	0	0
6	1	0	0	1
5	1	0	1	0
4	1	0	1	1
3	1	1	0	0
2	1	1	0	1
1	1	1	1	0
0	1	1	1	1
9	0	1	1	0

Q_4: T = 1;
Q_5: T = Q_4 * Q_5 * Q_6 * /Q_7 +
Q_4 * /Q_5 * /Q_6 * Q_7 +
Q_4 * Q_5 * /Q_6 * Q_7 +
Q_4 * /Q_5 * Q_6 * Q_7 ;
Q_6: T = Q_4 * Q_5 * Q_6 * /Q_7 +
Q_4 * Q_5 * /Q_6 * Q_7 ;
Q_7: T = Q_4 * Q_5 * Q_6 * /Q_7 +
Q_4 * Q_5 * Q_6 * Q_7 ;

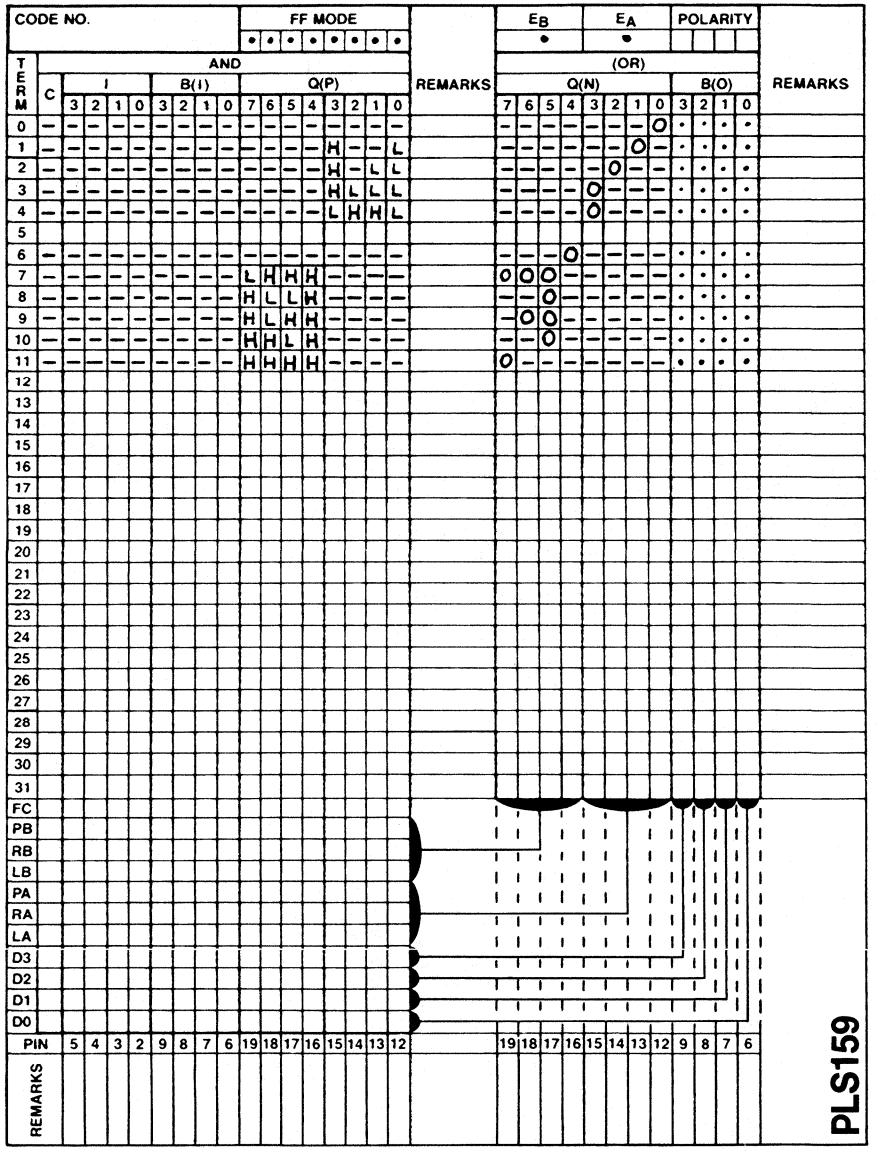
DIVIDE-BY-N COUNTER

This counter, shown in Figure 1 and Table 6, takes an input (maximum = 8 bits for each device), complements it, and counts until all flip flops become 1, then a terminal count is sent out at $B(O)_0$ (divide-by-N). At the end of the count, where all flip flops are 1's, terms LA and LB are activated which causes the flip flops to load data from F_0 to F_7, and the cycle starts again. Since there are 8 flip flops, the maximum count is 256.

PLS159 As Modulo Counters

AN16

Table 5



PLS159 As Modulo Counters AN16

Table 6

CODE NO.									FF MODE								REMARKS	E_B			E_A				POLARITY				REMARKS
									•	•	•	•	•	•	•	•		–			–							H	
TERM	C	AND I				AND B(I)												(OR) Q(N)								(OR) B(O)				
		3	2	1	0	3	2	1	0	7	6	5	4	3	2	1	0	7	6	5	4	3	2	1	0	3	2	1	0	
0		–	–	–	L	–	–	–	L	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	0	•	•	•	•	
1		–	–	–	L	–	–	–	L	–	–	–	–	–	–	–	H	–	–	–	–	–	–	0	–	•	•	•	•	
2		–	–	–	L	–	–	–	L	–	–	–	–	–	–	H	H	–	–	–	–	–	0	–	–	•	•	•	•	
3		–	–	–	L	–	–	–	L	–	–	–	–	–	H	H	H	–	–	–	–	0	–	–	–	•	•	•	•	
4		–	–	–	L	–	–	–	L	–	–	–	–	H	H	H	H	–	–	–	0	–	–	–	–	•	•	•	•	
5		–	–	–	L	–	–	–	L	–	–	–	H	H	H	H	H	–	–	0	–	–	–	–	–	•	•	•	•	
6		–	–	–	L	–	–	–	L	–	–	H	H	H	H	H	H	–	0	–	–	–	–	–	–	•	•	•	•	
7		–	–	–	L	–	–	–	L	–	H	H	H	H	H	H	H	0	–	–	–	–	–	–	–	•	•	•	•	
8		–	–	–	L	–	–	–	–	H	H	H	H	H	H	H	H	–	–	–	–	–	–	–	–	•	•	•	A	
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31																														
FC																														
PB																														
RB																														
LB	–	–	–	–	–	–	–	–	–	H	H	H	H	H	H	H	H													
PA																														
RA																														
LA	–	–	–	–	–	–	–	–	–	H	H	H	H	H	H	H	H													
D3																														
D2																														
D1																														
D0	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–													
PIN		5	4	3	2	9	8	7	6	19	18	17	16	15	14	13	12	19	18	17	16	15	14	13	12	9	8	7	6	
REMARKS				/ENABLE																										

PLS159

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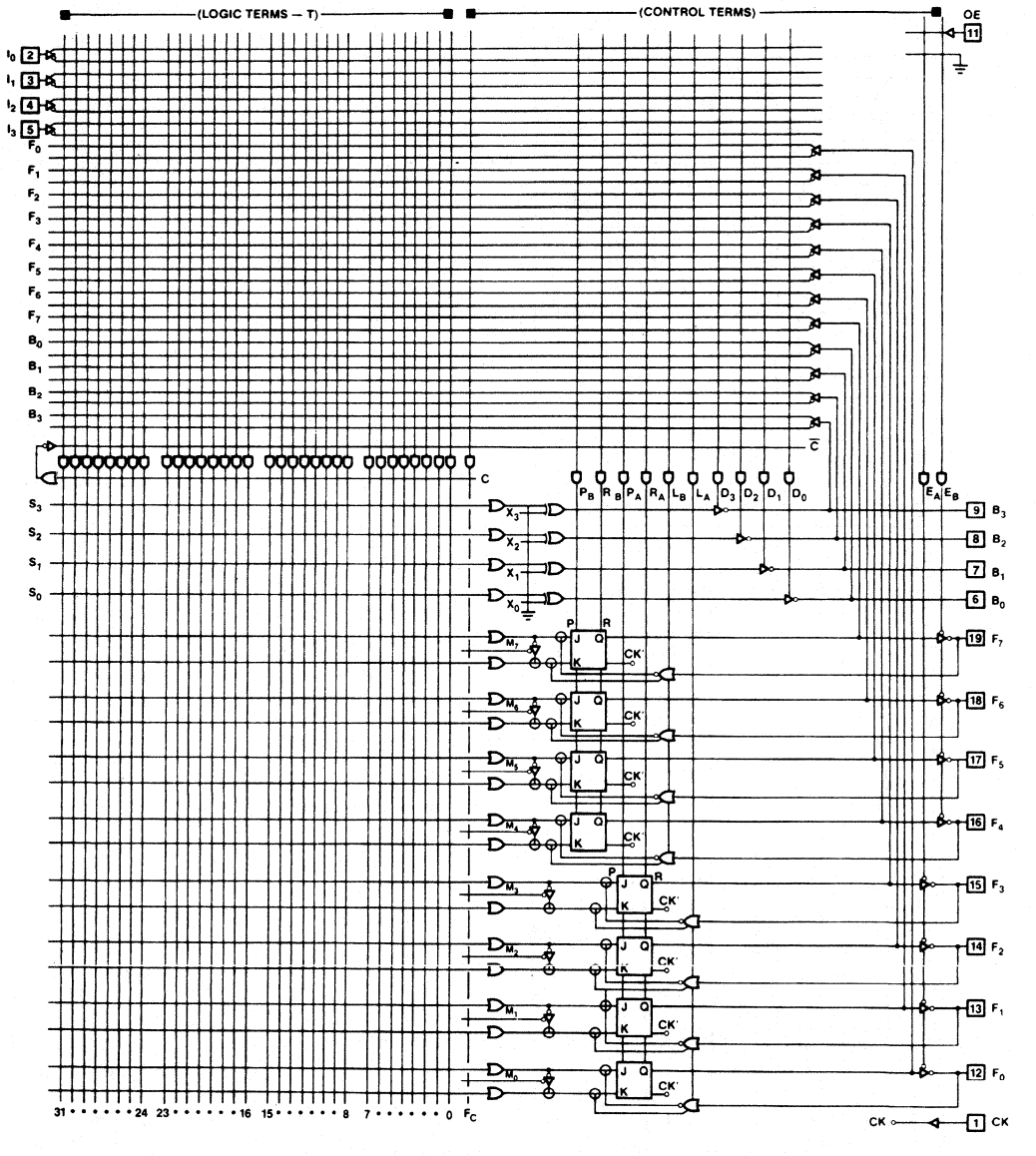
PLS159 As Modulo Counters

AN16



NOTES:
1. All OR gate inputs with a blown link float to logic "0".
2. All other gates and control inputs with a blown link float to logic "1".
3. ⊕ denotes WIRE-OR.

Figure 2

Signetics

AN17
Electronic Combination Lock

Application Note

Application Specific Products

INTRODUCTION

A combination lock may be opened by entering the correct numbers which match the preset security code that may be of any number of digits. Using a PLS157, an electronic combination lock with user settable security code may be constructed. The security code may be one to five hexadecimal digits that can be preset by the user. The lock takes a 4-bit binary input as the "combination" and a "Data Valid" input, which means that the combination may be five digits long and each digit may be from 0 to F. If the input matches the preset digit of the security code, the lock will wait for the next digit. If the input does not match the corresponding digit of the security code, the lock will reset itself to the first digit position again. The user may use as many as five digits for the combination which may be set by using five DIP switches or other means. The lock may be used in conjunction with a 4-bit binary encoded rotary switch, or an encoded push button key pad, or an optical card reader, or a magnetic strip reader. The design takes advantage of the six JK flip-flops of the PLS157, the bidirectional I/O's, the complement array, and the general architecture of common product terms.

DESCRIPTION

Figure 1 shows an example of an electronic lock which uses five DIP switches to set the security code (hexadecimal 0 to E, F is reserved for reset), a 4-bit binary encoded rotary switch to enter the combination at I_0 to I_3, and a single pole double throw push button switch, "Data Valid", as the clock which is debounced by the associated circuitry of pin B_5. The security code is set with five DIP switches which are connected to a four line input ($B(I)_0$ to $B(I)_3$). The five DIP switches are multiplexed by the outputs of the flip-flops, F_0 to F_4. In normal operation, one of the F/F outputs is LOW (the content of the register being a "1") while the other five are HIGH. The operation is actually a shift register with a zero bit shifting through five one's. Therefore only one DIP switch is pulled LOW (selected) at any one time while the rest is deselected. The pin named "MATCH", $B(O)_4$, is an I/O which outputs a HIGH if the input matches the corresponding digit of the security code, otherwise it outputs a LOW. A HIGH output of $B(O)_4$ enables the shift register to shift one position while a LOW causes the shift register to reset to the starting position which is a "1" in F/F_0 (flip flop 0) (F_0 is LOW due the output inverter) and "0's" in the other five (F_1 to F_5 = HIGH). The state diagram of the design is as shown in Figure 2 where the state numbers are expressed in two hexadecimal digits. The least significant digit consists of F_3, F_2, F_1, and F_0; whereas the most significant digit consists of F_5, and F_4. At the top of the state diagram, the power-up and reset state is 00 hex. When the outputs have more than one LOW, as sometimes happens during power-up, the circuit automatically resets the registers to 00 hex which causes all outputs to be HIGH in order to prevent more than one DIP switch being enabled. After power-up or reset, pushing the "Data Valid" button will initialize the circuit to have the first digit of the security code enabled. Subsequently, any false entry will cause the circuit to go back to the initialized state of 01 hex. When the first digit is correctly set and the "Data Valid" button pressed, the circuit goes to 02 hex and the second DIP switch is enabled while the first DIP switch is disabled. The circuit is now ready for the second digit. By repeating the process, the circuit keeps shifting the "1" in the shift register until it reaches F/F_5 at which time the LOW output may be used to trigger a solenoid. If at any time of the sequence, an incorrect digit is entered, the circuit reverts back to the initialized state of 01 hex.

Notice that any of the five outputs from F_1 to F_5 may be used as an output. Therefore, if, for example, a two digit security code is used, only two DIP switches are needed and the output is taken from F_2 to trigger a solenoid. After the last digit has been entered, all DIP switches are deselected and the inputs $B(I)_0$ to $B(I)_3$ become 1111 binary, or F hex. Therefore, the hex number F is not used as a valid code but as an initialization input entered at I_0 to I_3. When the hex number F is entered, the circuit initializes itself to the 01 hex state. After the last digit of the security code has been entered, if the "Data Valid" button is pressed again, the circuit sees a false entry and reinitializes itself.

The design is implemented using a PLS157 as shown in Table 1, H/L Programming Table of Electronic Lock. P-terms 0 to 14 are programmed as decoders. If an input matches the corresponding digit of the security code, one of the p-terms will be active which causes $B(O)_4$ to output a HIGH which, in turn, enables the registers to shift to the next digit by terms 16 to 20. In the event that an incorrect input is entered, $B(O)_4$ outputs a LOW which, in turn, causes the registers to be set 000001 binary by term 21. If an input of F is entered, term 15 causes the registers to be 000001. Terms 22 to 29 and RB ensure that no more than one register is "1" at a time. Terms 22 to 28 are connected to the complement array, which in turn, drives terms 29 and RB to set the registers to 000000 when terms 22 to 28 are inactive.

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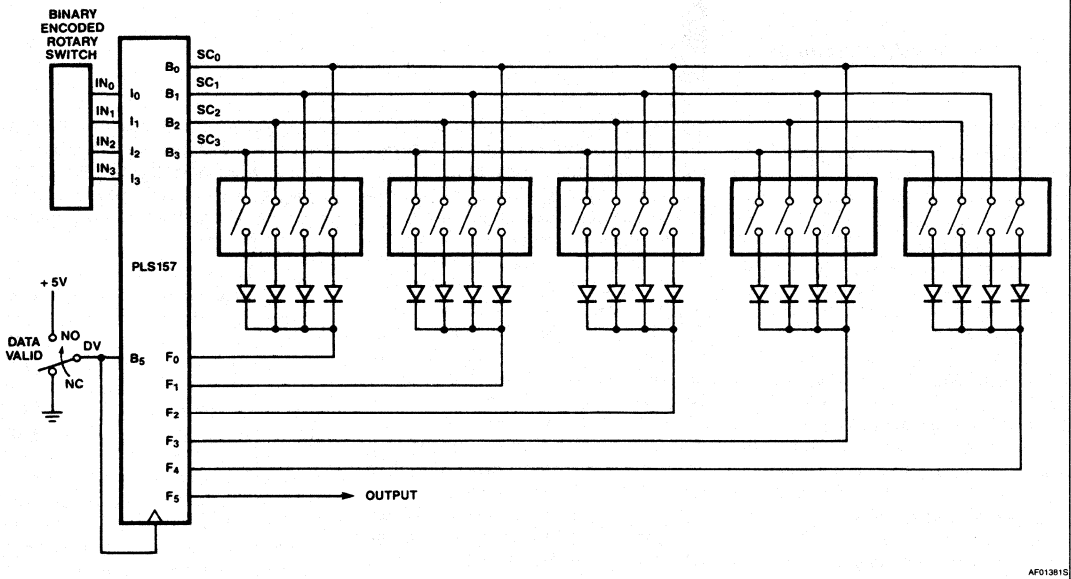
Electronic Combination Lock AN17



NOTES:
1. All diodes are Philips BAT81 Schottky diodes or equivalent.
2. Single pole double throw momentary switch.

Figure 1. Simple Block Diagram of Electronic Lock

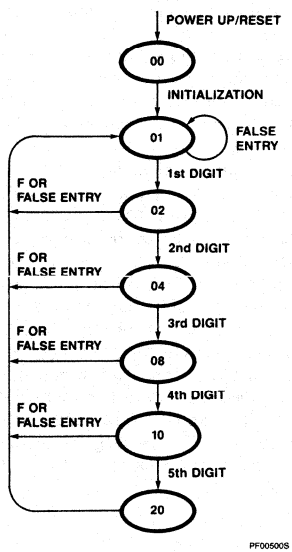
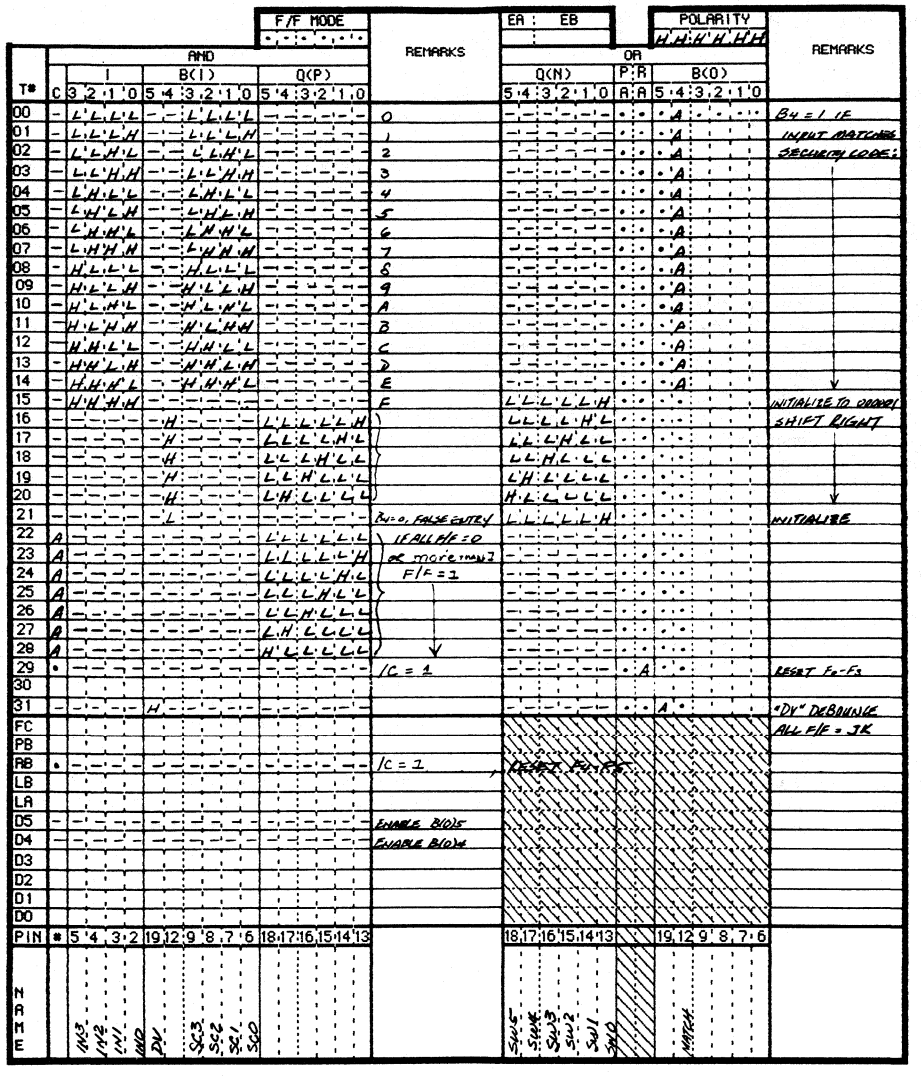


Figure 2. State Diagram of Electronic Lock

Electronic Combination Lock

AN17

Table 1. PLS157 H/L Programming Table



AN18
Schmitt Trigger Using PLS153 and PLS159

Application Note

Application Specific Products

INTRODUCTION

One of the many features of the PLS153 to 159 series is the availability of individually controlled 3-state I/O pins. Taking advantage of this feature, a Schmitt trigger may be constructed using one input pin, two bi-directional I/O pins and additional components of three resistors. The two threshold voltages, as well as the hysterisis, are determined by the values of the three resistors and the parameters of the PLS153/159 device, which are 1) input threshold voltage, V_{TH}, 2) HIGH output voltage, V_{OH}, and 3) LOW output voltage, V_{OL}. The circuit may be simplified if Schmitt function is needed only on LOW going HIGH or HIGH going LOW, and if the hysterisis and threshold voltages are not important.

DESCRIPTION

A simplified block diagram of a non-inverting Schmitt trigger is shown in Figure 1 where R_1, R_2, and R_1, R_3, form two pairs of voltage dividers one of which get into action at input voltage direction of HIGH going LOW and the other LOW going HIGH. Assuming that input voltage starts at zero volt, the output voltage is therefore at V_{OL} which causes Q_2 to pull R_3 towards ground. As the input voltage increases, only a fraction of the voltage is impressed upon the input buffer due to the dividing network R_1 and R_3. As soon as the input voltage reaches a point where $V_1 = V_{TH}$ (V_{TH} = 1.38V typical), the output switches to V_{OH} which, in turn, turns off Q_2 and turns on Q_1. V_1 will jump to a value greater than V_{TH} and Q_1 then pulls the input pin, through R_2, towards V_{OH}, which in turn locks the output to a HIGH state even if the input voltage fluctuates, as long as it does not fluctuate outside of the designed hysterisis. When the input voltage goes from a HIGH to a LOW, the Schmitt function repeats itself except that Q_1 and Q_2 reverse their roles.

The triggering voltages, V_H (LOW going HIGH) and V_L (HIGH going LOW) are: $V_H = V_{TH}\,[(R_1 + R_3)/R_3] - V_{OL}\,(R_1/R_3)$; $V_L = V_{TH}\,[(R_1 + R_2)/R_2] - V_{OH}\,(R_1/R_2)$; where, @ room temperature, V_{CC} = 5.0V, $I_{OH}/I_{OL} < 1$mA. V_{TH} is the threshold voltage of the device, typically 1.38V; V_{OL} is the output LOW voltage of the device, typically 0.36V @ $|\,I_{OL}\,| < 1$mA; V_{OH} is the output HIGH voltage of the device, typically 3.8V @ $|\,I_{OH}\,| < 1$mA.

The implementation of Figure 1 using PLS153/153A is as shown in Table 1, and Figure 2a. A scope photo of the operation of the circuit is shown in the Appendix. The implementation using PLS159 is shown in Table 2 and Figure 2b. In Tables 1 & 2, V_1 is the input pin, V_0 is the output pin, V_2 is the output which pulls down V_1 and V_3 is the output pin that pulls up V_1. The Schmitt output is available at pin B_0 for external use, and is available internally at the input buffers of I_0 and $B(I)_0$. However, there is a propagation delay between the two signals from the I_0 buffer and the $B(I)_0$ buffer.

An inverting Schmitt triggered buffer may be constructed using the same principle. A simple block diagram of such inverter is shown in Figure 3a. The circuit is implemented using H/L programming table as shown in Table 3 for PLS153 and Table 4 for PLS159. Table 3 is also represented in logic symbols in Figure 3b. If the voltage levels (V_L and V_H) and the hysterisis are not critical, one I/O pin may be used to pull the input pin HIGH and LOW. Therefore one I/O pin and a resistor may be saved. The drawback is that the range of V_H and V_L is quite limited. The circuit is as shown in Figure 4.

If Schmitt function is needed only in one direction, one of the resistor/output circuit may be eliminated. The circuit is as shown in Figure 5.

Schmitt Trigger Using PLS153 and PLS159 AN18

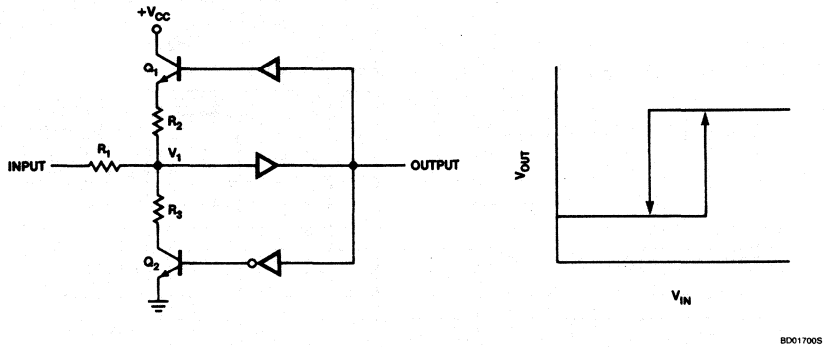
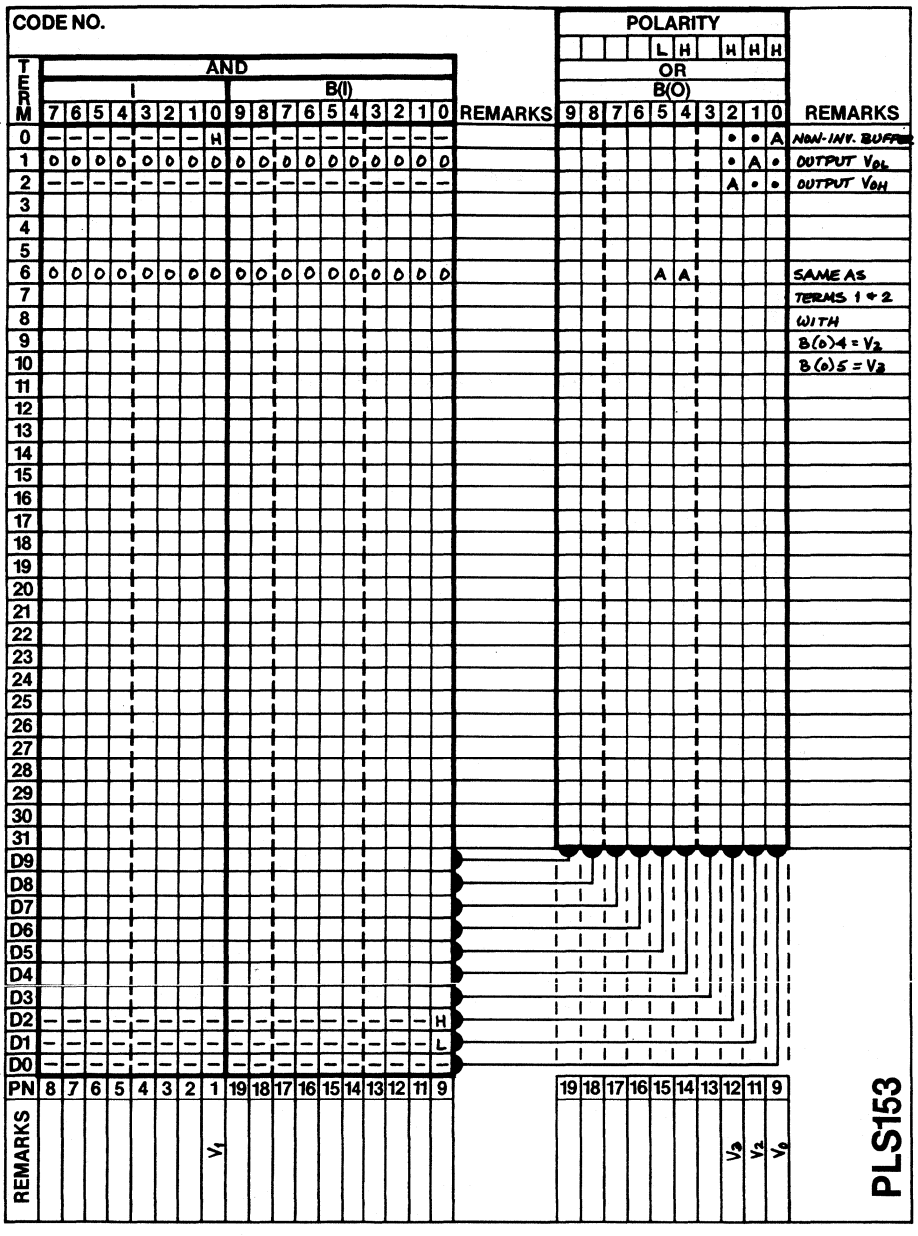


Figure 1. Simplified Block Diagram Of A Schmitt Trigger

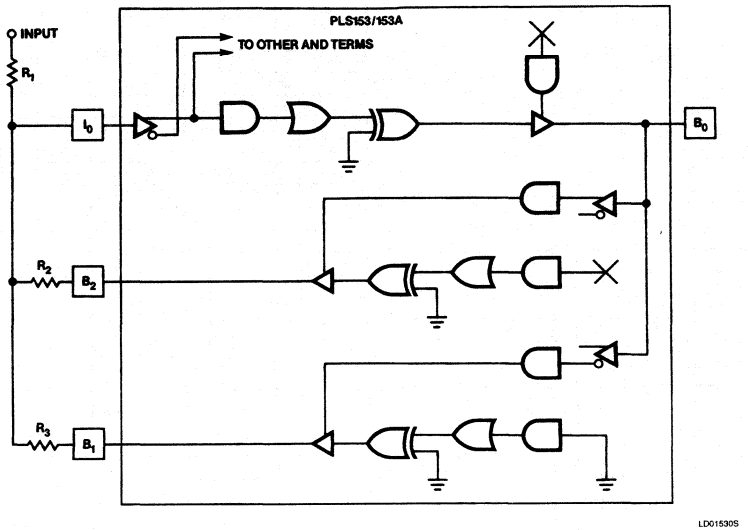
Schmitt Trigger Using PLS153 and PLS159 — AN18

Table 1. PLS153/153A Programming Table

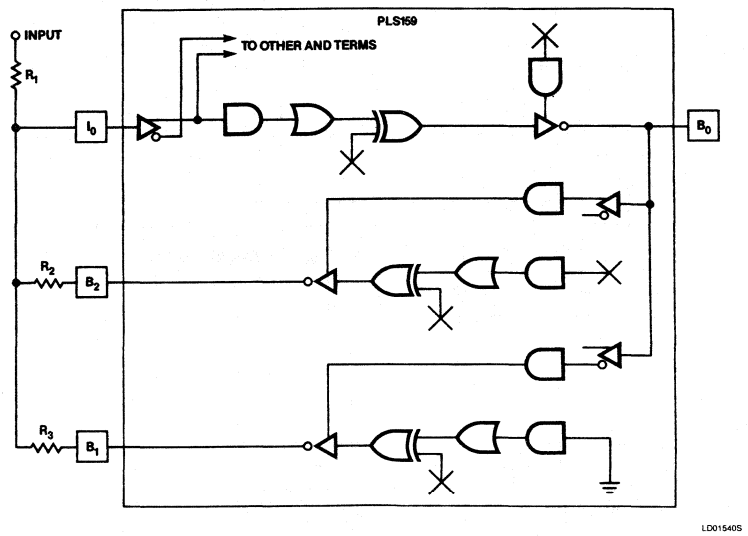


NOTE:
Schmitt trigger output may be obtained from both 1_0 and $B(1)_0$ to drive the AND-ARRAY.

Schmitt Trigger Using PLS153 and PLS159



a. Using PLS153/153A

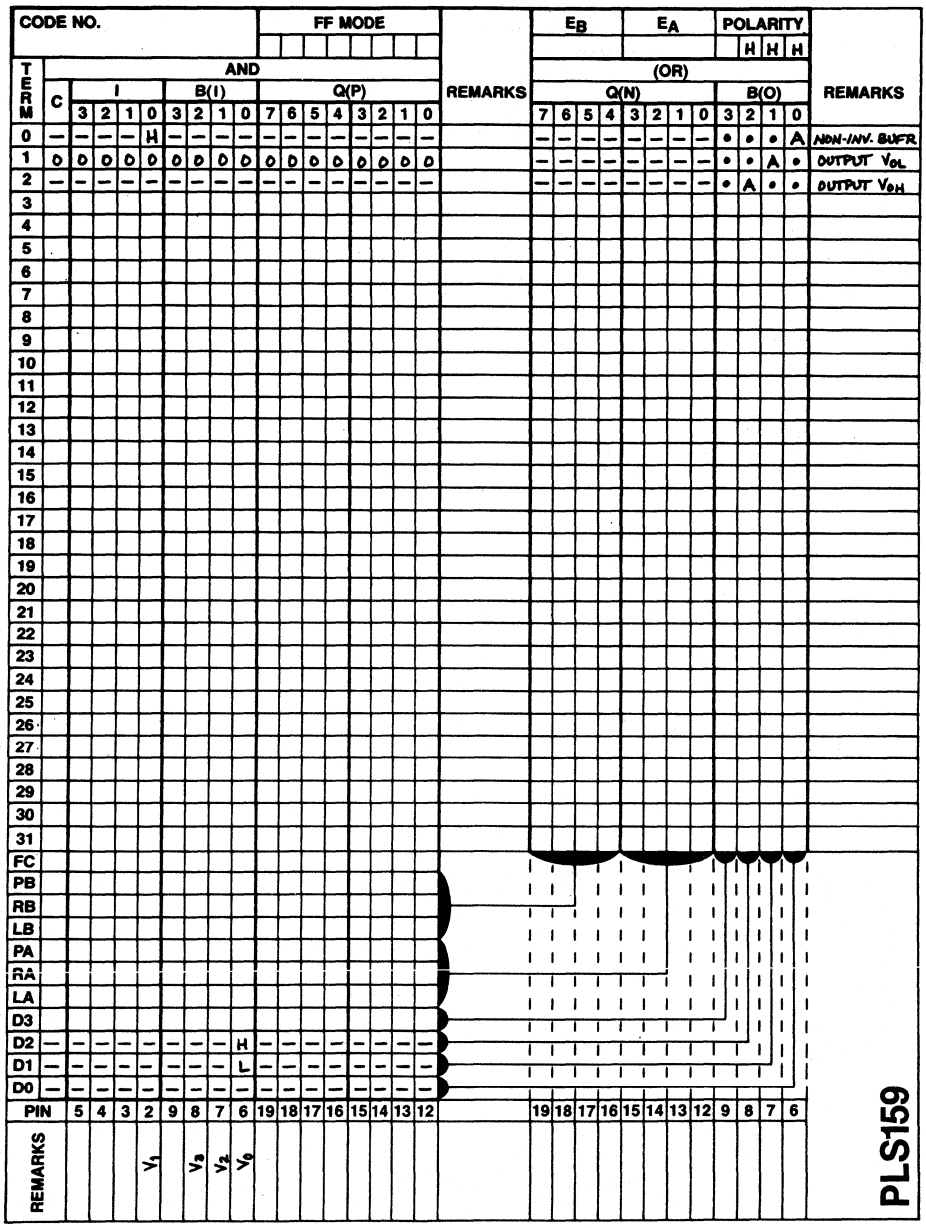


b. Using PLS159

Figure 2. Schmitt Trigger

Schmitt Trigger Using PLS153 and PLS159 — AN18

Table 2. PLS159 FPLS Programming Table



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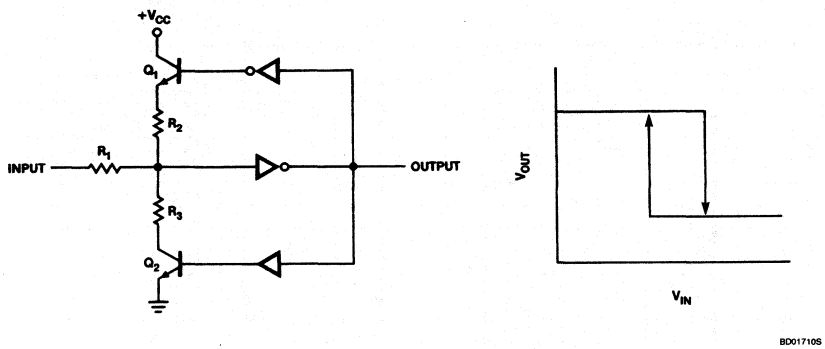
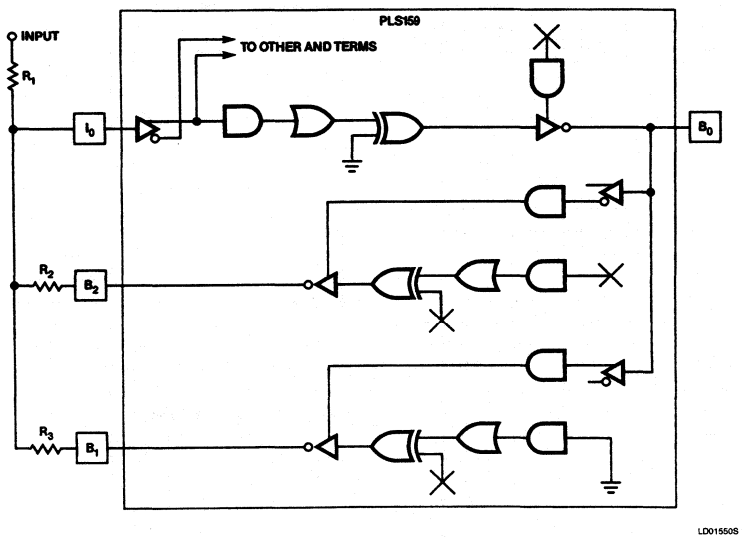
Schmitt Trigger Using PLS153 and PLS159

AN18



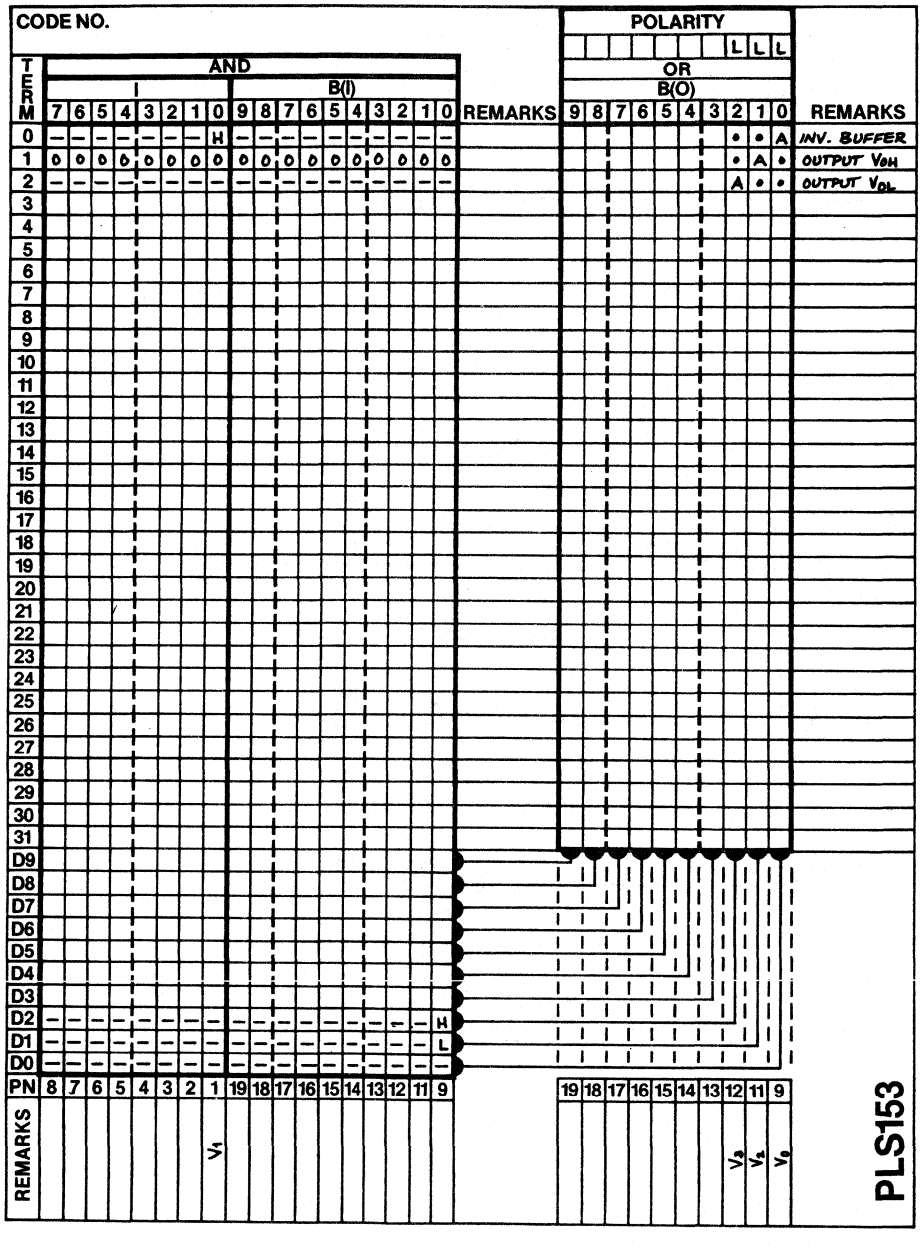
a. Simplified Block Diagram



b. Using PLS159

Figure 3. Inverting Schmitt Trigger

Table 3. PLS153/153A Programming Table



TB01580S

Table 4. PLS159 FPLS Program Table

CODE NO.										FF MODE								REMARKS	E_B				E_A				POLARITY				REMARKS
																											H	H	L		
TERM	C	AND I				AND B(I)				AND Q(P)									(OR) Q(N)								(OR) B(O)				
		3	2	1	0	3	2	1	0	7	6	5	4	3	2	1	0		7	6	5	4	3	2	1	0	3	2	1	0	
0	–	–	–	–	H	–	–	–	–	–	–	–	–	–	–	–	–		–	–	–	–	–	–	–	–	•	•	•	A	INV. BUFFER
1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0		–	–	–	–	–	–	–	–	•	•	A	•	OUTPUT V_{OL}
2	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–		–	–	–	–	–	–	–	–	•	A		•	OUTPUT V_{OH}
3																															
4																															
5																															
6																															
7																															
8																															
9																															
10																															
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29																															
30																															
31																															
FC																															
PB																															
RB																															
LB																															
PA																															
RA																															
LA																															
D3																															
D2	–	–	–	–	–	–	–	–	L	–	–	–	–	–	–	–	–														
D1	–	–	–	–	–	–	–	–	H	–	–	–	–	–	–	–	–														
D0	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–														
PIN		5	4	3	2	9	8	7	6	19	18	17	16	15	14	13	12		19	18	17	16	15	14	13	12	9	8	7	6	
REMARKS					V_1		V_3	V_2	V_0																						

PLS159

TB01590S

Schmitt Trigger Using PLS153 and PLS159 — AN18

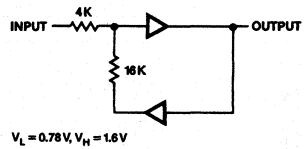
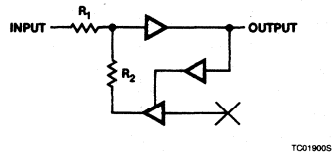
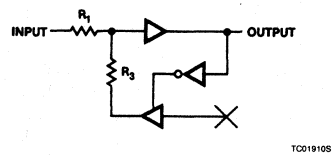


Figure 4. Schmitt Trigger Using One I/O Pin



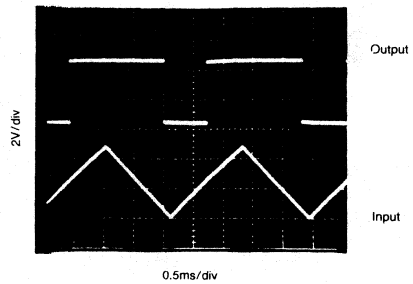
a. HIGH Going Low Direction



b. LOW Going High Direction

Figure 5. Schmitt Trigger

APPENDIX A



NOTE:
$R_1 = 3.9k\Omega$, $R_2 = 10.8k\Omega$, $R_3 = 2.0k\Omega$, $V_{CC} = 5.0V$, Ambient temperature $\approx 25°C$

Figure A-1. A Non-Inverting Schmitt Triggered Buffer

Signetics

AN19
Electronic Dice

Application Note

Application Specific Products

DESCRIPTION

A PLS159 is used to implement a pair of dice. Each die is represented by a series of six different state transitions. Two push button switches are used to "roll" the dice; in other words start/stop the state transitions. Each push button controls one die. When the switches are held low, the state transitions take place for each die and the result is displayed when a push button is released.

Each die is made up of seven LED's which are connected to the outputs of the PLS159. The system also contains its own oscillator which generates the clock cycle necessary for the state transitions.

The random release of the push button provides a random output. The high frequency of the internal oscillator and the fact that the switches are not debounced, add more "randomness" to each event.

The overall system configuration is shown in Figure 3.

LOGIC IMPLEMENTATION

The configuration of each die is shown in Figure 1, with each letter representing an LED.

To represent the numbers one through six the LED's are turned on as shown in Figure 2.

Table 1 is the truth table generated from Figure 2.

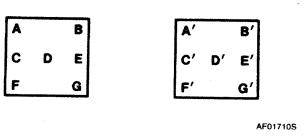


Figure 1. Dice Configuration

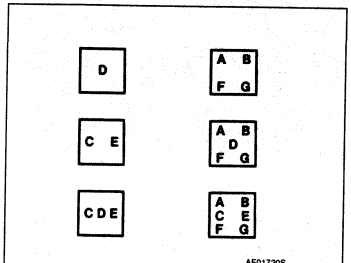


Figure 2. Number Representation

Table 1. Truth Table For Dice

	A	B	C	D	E	F	G
One	0	0	0	1	0	0	0
Two	0	0	1	0	1	0	0
Three	0	0	1	1	1	0	0
Four	1	1	0	0	0	1	1
Five	1	1	0	1	0	1	1
Six	1	1	1	0	1	1	1

The result of Table 1 is the following logic equations:

A = Four + Five + Six;
B = Four + Five + Six;
C = Two + Three + Six;
D = One + Three + Five;
E = Two + Three + Six;
F = Four + Five + Six;
G = Four + Five + Six;

As can be seen from the above logic equations:

A≡B≡F≡G;
C≡E;

Table 2 is the result of Table 1 and the above common terms.

Table 2. Truth Table For PLS159 Outputs

	A, B, F, G	C, E	D
One	0	0	1
Two	0	1	0
Three	0	1	1
Four	1	0	0
Five	1	0	1
Six	1	1	0

For each die, three outputs of the PLS159 are needed to implement the logic in Table 2. These outputs are connected to the LED's as follows:

F0: A, B, F, G;
F1: C, E;
F2: D;

Similarly for the second die:

F3: A', B', F', G';
F4: C', E';
F5: D';

Electronic Dice AN19

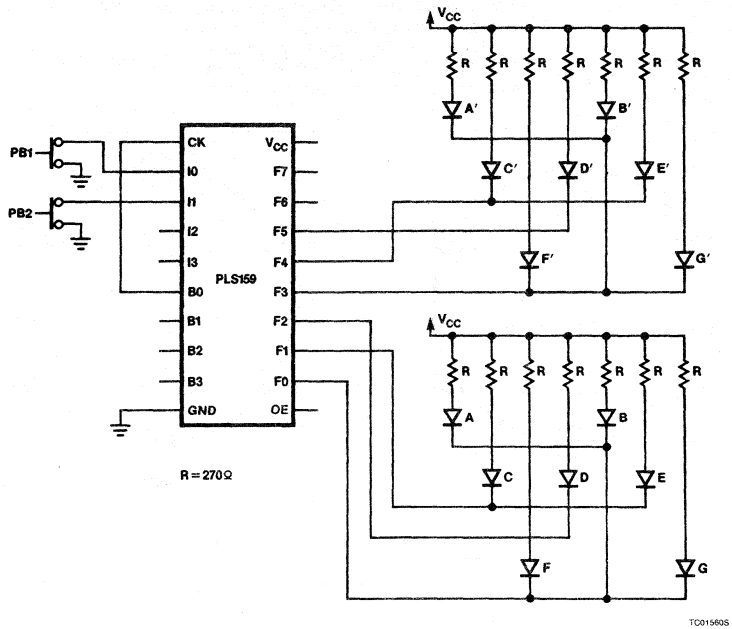


Figure 3. Dice Implementation Using The PLS159

Electronic Dice

AN19

STATE TRANSITIONS

Figure 4 shows two arbitrary state transition sequences which are used to implement each die.

These state transitions are implemented in the program table of the PLS159.

INTERNAL OSCILLATOR

An internal oscillator is also implemented for the system. The internal configuration of the oscillator is shown in Figure 5. For a detailed explanation of the implementation of this oscillator see AN 13: Oscillator with the PLS159. B0 is connected externally to the clock input of the PLS159.

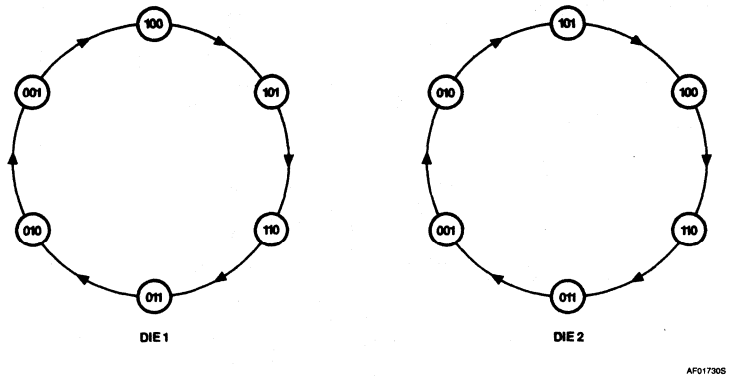


Figure 4. Arbitrary State Transitions

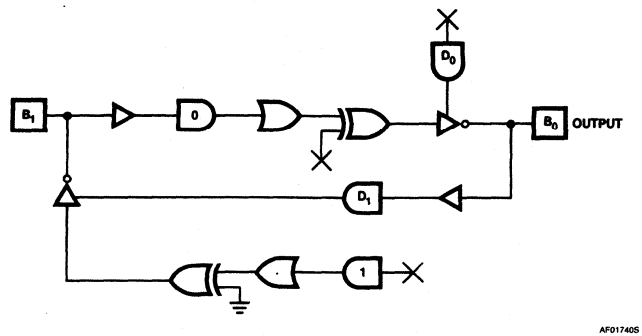


Figure 5. Oscillator Configuration

Electronic Dice AN19

Table 3. Program Table For 2 Dice

CODE NO.										FF MODE								REMARKS	E_B				E_A				POLARITY				REMARKS
										A	A	•	•	•	•	•	•										L	L	H	L	
TERM	AND																		(OR)												
	C	I				B(I)				Q(P)									Q(N)								B(O)				
		3	2	1	0	3	2	1	0	7	6	5	4	3	2	1	0		7	6	5	4	3	2	1	0	3	2	1	0	
0	–	–	–	–	L	–	–	–	–	–	–	–	–		H	L	L	100→101	–	–	–	–	–	H	L	H	•	•	•	•	
1	–	–	–	–	L	–	–	–	–	–	–	–	–		H	L	H	101→110	–	–	–	–	–	H	H	L	•	•	•	•	
2	–	–	–	–	L	–	–	–	–	–	–	–	–		H	H	L	110→011	–	–	–	–	–	L	H	H	•	•	•	•	DIE 1
3	–	–	–	–	L	–	–	–	–	–	–	–	–		L	H	H	011→010	–	–	–	–	–	L	H	L	•	•	•	•	
4	–	–	–	–	L	–	–	–	–	–	–	–	–		L	H	L	010→001	–	–	–	–	–	L	L	H	•	•	•	•	
5	–	–	–	–	L	–	–	–	–	–	–	–	–		L	L	H	001→100	–	–	–	–	–	H	L	L	•	•	•	•	
6																															
7	–	–	–	L	–	–	–	–	–	–	–	H	L	H	–	–	–	101→100	–	–	H	L	L	–	–	–	•	•	•	•	
8	–	–	–	L	–	–	–	–	–	–	–	H	L	L	–	–	–	100→110	–	–	H	H	L	–	–	–	•	•	•	•	
9	–	–	–	L	–	–	–	–	–	–	–	H	H	L	–	–	–	110→011	–	–	L	H	H	–	–	–	•	•	•	•	DIE 2
10	–	–	–	L	–	–	–	–	–	–	–	L	H	H	–	–	–	011→001	–	–	L	L	H	–	–	–	•	•	•	•	
11	–	–	–	L	–	–	–	–	–	–	–	L	L	H	–	–	–	001→010	–	–	L	H	L	–	–	–	•	•	•	•	
12	–	–	–	L	–	–	–	–	–	–	–	L	H	L	–	–	–	010→101	–	–	H	L	H	–	–	–	•	•	•	•	
13																															
14	–	–	–	–	–	–	–	–	–	–	–	–	–	–	L	L	L	Undefined states for DIE 1	–	–	–	–	–	H	L	L	•	•	•	•	Go to 100
15	–	–	–	–	–	–	–	–	–	–	–	–	–	–	H	H	H		–	–	–	–	–	H	L	L	•	•	•	•	
16																															
17	–	–	–	–	–	–	–	–	–	–	–	L	L	L	–	–	–	Undefined states for DIE 2	–	–	–	H	L	H	–	–	•	•	•	•	Go to 101
18	–	–	–	–	–	–	–	–	–	–	–	H	H	H	–	–	–		–	–	–	H	L	H	–	–	•	•	•	•	
19																															
20	–	–	–	–	–	–	–	–	H	–	–	–	–	–	–	–	–	Oscillator	–	–	–	–	–	–	–	–	•	•	•	A	$B_0 = B_1$
21	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–		–	–	–	–	–	–	–	–	•	•	A	•	$B(O)_1$ = Low
22																															
23																															
24																															
25																															
26																															
27																															
28																															
29																															
30																															
31																															
FC																															
PB																															
RB																															
LB																															
PA																															
RA																															
LA																															
D3																															
D2																															
D1	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	–	Enable $B_{(O)}1$													
D0	–	–	–	–	–	–	–	H	–	–	–	–	–	–	–	–	–	Enable $B_{(O)}0$ For term 20													
PIN	5	4	3	2	9	8	7	6	19	18	17	16	15	14	13	12			19	18	17	16	15	14	13	12	9	8	7	6	
REMARKS																															

PLS159

TB00621S

Electronic Dice AN19

EXPLANATION OF PROGRAM TABLE

The program table for the two dice is shown in Table 3.

Terms 0 – 5 and 7 – 12 represent the state transitions for each die.

Terms 14 – 15 and 17 – 18 reset the flip flops to HLL and HLH if undefined states occur, such as during power up.

Terms 20 and 21 and output controls terms D1 and D2 are used to implement the internal oscillator (see AN13).

Inputs I0 and I1 are connected to the two push button switches which roll the dice. These inputs are programmed to be active low. When the push button is closed the state transitions take place, and upon release of the push button, the current states are displayed on the outputs.

The outputs of the PLS159 are inverted and this must be taken into consideration when assigning "H" and "L"s to the F0, F1, F2, F3, F4, and F5. These assignments are shown in Table 4. All the flip flops are set to be of the J – K type.

Table 4. H And L Assignment

	F2, F5	F1, F4	F0, F3
One	H	L	L
Two	L	H	L
Three	H	H	L
Four	L	L	H
Five	H	L	H
Six	L	H	H

Signetics

AN20
Single Pin Debouncer Using 82S153/159

Application Note

Application Specific Products

INTRODUCTION

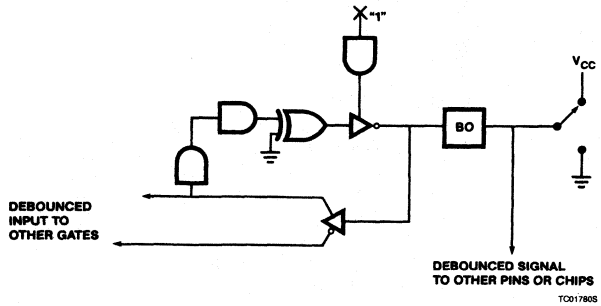
The 82S159 is a field programmable logic sequencer which is self-contained as a logic sequencer except for the need of a system clock and/or one or more debounced switches. Generally, most of the debouncers circuits utilize a cross-coupled NAND/NOR to form an RS-latch which takes two input pins. To economize the I/O pin consumption, a single I/O pin may be used to debounce a single pole double throw switch. This scheme is applicable to all Signetics PLD's (Programmable Logic Devices) that have non-registered bi-directional I/O's, including 82S153/153A, and 82S155.

DESCRIPTION

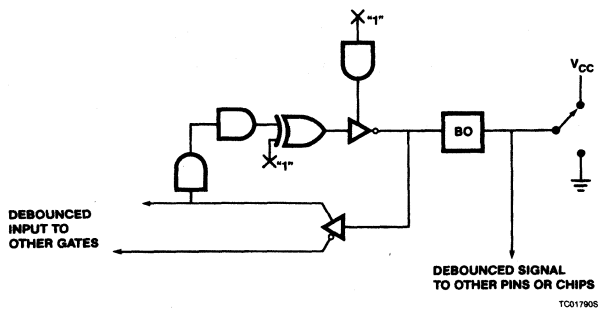
Figures 1a and 1b are logic diagrams of the circuit which utilizes one I/O pin of the 82S153/153A and 82S159 respectively to form a debouncer. The single pole double throw switch is connected, at one terminal, to V_{CC}, and, at another terminal, to ground. The blade of the switch is connected to B0. B0 is programmed as an output. The input buffer of B0 is programmed to drive a p-term which, in turn, drives the output B0. The circuit latches to whichever state it is in. As an example, assuming that the output B0 is connected to V_{CC} through the switch, and its output is a "1". When the switch is flipped from V_{CC} to ground, B0 is momentarily short circuited to ground. After one propagation delay (15-30ns), B0 is set to "0" and no more current will flow from B0. If the switch is flipped back to V_{CC}, B0 will be shorted to V_{CC} for one prop delay and will be set to a "1" and will stay a "1" until the switch is flipped again. The switch may bounce while the blade breaks from one terminal and bounce again while it makes contact with the other terminal. As long as the movement of the blade is smaller than the gap which separates the two terminals, the output will remain stable.

The circuit is implemented in an 82S159 using AMAZE as shown in Figures 2 & 3, and Table 1.

Single Pin Debouncer Using 82S153/159 AN20



a. Using 82S153/153A



b. Using 82S159

Figure 1. Single Pin Switch Debouncer Circuit

Single Pin Debouncer Using 82S153/159 — AN20

```
 ******************** DEBOUNCE ********************
########################## P I N   L I S T ##########################

   LABEL     ** FNC **PIN --------- PIN** FNC **     LABEL
N/C          ** CK  **  1-¦        ¦-20 ** +5V **VCC
N/C          ** I   **  2-¦        ¦-19 ** B   **N/C
N/C          ** I   **  3-¦        ¦-18 ** B   **N/C
N/C          ** I   **  4-¦   8    ¦-17 ** B   **N/C
N/C          ** I   **  5-¦   2    ¦-16 ** B   **N/C
SWITCH       ** O   **  6-¦   S    ¦-15 ** O   **INPUT_LATCH
N/C          ** /B  **  7-¦   1    ¦-14 ** B   **N/C
N/C          ** /B  **  8-¦   5    ¦-13 ** B   **N/C
N/C          ** /B  **  9-¦   9    ¦-12 ** B   **N/C
GND          ** OV  ** 10-¦        ¦-11 ** /OE **N/C
                           ---------
```

TB00550S

Figure 2. Pin List

```
 ******************** DEBOUNCE ********************
@DEVICE TYPE
82S159
@DRAWING
************ SINGLE PIN DEBOUNCER
@REVISION
************ REV -
@DATE
************ xx/xx/xxxx
@SYMBOL
************ DEBOUNCE
@COMPANY
************ SIGNETICS
@NAME
@DESCRIPTION
This circuit accepts a single pole double pole switch which switches between
Vcc and GROUND. BO is used as input, but it is defined in AMAZE  as output.
BO may be used to drive the rest of the logic circuit or it may be used
in conjunction with one of the internal flip flops as registered input to
handle asynchronous input to a state machine.
@COMMON PRODUCT TERM
@COMPLEMENT ARRAY
@I/O DIRECTION
@OUTPUT POLARITY
@FLIP FLOP CONTROL
@OUTPUT ENABLE
@REGISTER LOAD
@ASYNCHRONOUS PRESET/RESET
@FLIP FLOP MODE
@LOGIC EQUATION
SWITCH = SWITCH ;

" ********************************************
  *          BO WITH LATCHED INPUT           *
  ******************************************** "
/INPUT_LATCH : D  =  SWITCH  ;
```

TB00560S

Figure 3. Boolean Equation File

Single Pin Debouncer Using 82S153/159

AN20

Table 1. Programming Table

```
 ********** DEBOUNCE **********
Cust/Project -
Date         - ********** xx/xx/xxxx
Rev/I. D.    - ********** REV -

82S159                ! F/F TYPE      ! E(b)= !E(a) = !POLARTY!
                      !_______________!_______!_______!_______!
 T !                  !A:A:A:A:A:A:A:A!  0    !  0    !L:L:L:H!
 E !-------------------------------------------------------------
 R ! !   I    ! B(i)  !     Q(p)      !      Q(n)     ! B(o)  !
 M !C!-------------------------------------------------------------
___!_!3_2_1_0!3_2_1_0!7_6_5_4_3_2_1_0!7_6_5_4_3_2_1_0!3_2_1_0!
  0!A!- - - -!- - - H!- - - -,- - - -!0 0 0 0,A 0 0 0!A A A A!
  1!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
  2!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
  3!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
  4!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
  5!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
  6!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
  7!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
  8!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
  9!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 10!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 11!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 12!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 13!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 14!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 15!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 16!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 17!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 18!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 19!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 20!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 21!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 22!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 23!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 24!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 25!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 26!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 27!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 28!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 29!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 30!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 31!0!0 0 0 0!0 0 0 0!0 0 0 0,0 0 0 0!0 0 0 0,0 0 0 0!A A A A!
 Fc!0!0 0 0 0!0 0 0 0!0 0 0 0!                                .
 Pb!.!0 0 0 0!0 0 0 0!0 0 0 0!                                .
 Rb!.!0 0 0 0!0 0 0 0!0 0 0 0!                                .
 Lb!.!0 0 0 0!0 0 0 0!0 0 0 0!                                .
 Pa!.!0 0 0 0!0 0 0 0!0 0 0 0!                                .
 Ra!.!0 0 0 0!0 0 0 0!0 0 0 0!                                .
 La!.!0 0 0 0!0 0 0 0!0 0 0 0!                                .
 D3!.!0 0 0 0!0 0 0 0!0 0 0 0!                                .
 D2!.!0 0 0 0!0 0 0 0!0 0 0 0!                                .
 D1!.!0 0 0 0!0 0 0 0!0 0 0 0!                                .
 D0!-!- - - -!- - - -!- - - -!                                .

     N N N N N N N S N N N N I N N N N N N I N N N N N N S
     / / / / / / / W / / / / N / / / / / / N / / / / / / W
     C C C C C C C i C C C C P C C C C C C P C C C C C C I
                   T                       U               T
                   C                       T               C
                   H                       _               H
                                           L
                                           A
                                           T
                                           C
                                           H

                                                    TB00570S
```

Signetics

AN21
9-Bit Parity Generator/Checker With 82S153/153A

Application Note

Application Specific Products

INTRODUCTION

This application note presents the design of a parity generator using Signetics PLD, 82S153 or 82S153A, which enables the designers to customize their circuits in the form of "sum-of-products". The PLA architecture and the 10 bi-directional I/O's make it possible to implement the 9-bit parity generator/checker in one chip without any external wiring between pins. A logic diagram of the device is shown in Appendix A.

The parity of an 8-bit word is generated by counting the number of "1's" in the word. If the number is odd, the word has odd parity. If the number is even, the word has even parity. Thus, a parity generator designed for even parity, for example, will generate a "0" if the parity is even, or a "1" if parity is odd. Conversely, an odd parity generator will generate a "0" if the parity of the word is odd, or a "1" if the parity is even. This bit is then concatinated to the word making it 9-bits long. When the word is used elsewhere, its parity may be checked for correctness.

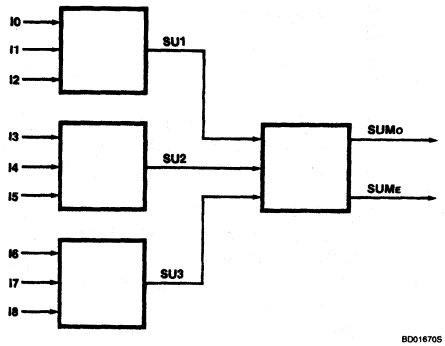
FEATURES

- **Generates even and odd parities (SUM_E and SUM_O)**
- **SUM_E = "1" for even parity, "0" for odd parity**
- **SUM_O = "1" for odd parity, "0" for even parity**
- **Generate parity or check for parity errors**
- **Cascaded to expand word length**

DESCRIPTION

The most straight forward way of implementing the parity generator/checker is to take the 9-input truth table (8 inputs for the 8-bit word, and 1 input for cascading the previous stage) and put it in a 256 x 4 PROM. Since there are 2^9 combinations and half of them is odd, the other half is even, the circuit will take 256 terms. An alternative is to divide the 9-bits into 3 groups of 3-bits as shown in Figure 1. If the sum of the 3-bits is odd, then the intermediate output SU1, or SU2, or SU3 equals 1. Otherwise it equals 0. The intermediate results are grouped together and SUM_O becomes "1" if the sum is odd, otherwise SUM_O equals "0". The circuit is implemented using AMAZE as shown in Figure 3. SU1 is an intermediate output for inputs I_0, I_1 and I_2. In the same manner, SU2 and SU3 are intermediate outputs for I_3, I_4, I_5 and I_6, I_7, I_8. The design uses up 16 product terms and 5 control terms leaving 16 product terms and 4 bi-directional I/O's to implement other logic designs.

The design is tested by using the logic simulator provided by AMAZE. The input test vector is chosen to exhaustively test for all 8 input combinations at all 4 sections of the circuit.



I_0	I_1	I_2	SU1
0	0	0	0
0	0	1	1
0	1	1	0
0	1	0	1
1	0	1	0
1	0	0	1
1	1	0	0
1	1	1	1

I_3	I_4	I_5	SU2
0	0	0	0
0	1	1	0
0	0	1	1
0	1	0	1
1	0	1	0
1	1	0	0
1	0	0	1
1	1	1	1

I_6	I_7	I_8	SU3
0	0	0	0
0	1	1	0
1	0	1	0
1	1	0	0
0	0	1	1
0	1	0	1
1	0	0	1
1	1	1	1

SU1	SU2	SU3	SUM_O	SUM_E
0	0	0	0	1
0	0	1	1	0
0	1	0	1	0
0	1	1	0	1
1	0	0	1	0
1	0	1	0	1
1	1	0	0	1
1	1	1	1	0

Figure 1. Block Diagram Of 9-Bit Parity Generator/Checker

```
********** PARGEN **********
########## P I N   L I S T ##########

  LABEL     ** FNC **PIN ---------- PIN** FNC **     LABEL
I0          ** I   **  1-¦         ¦-20 ** +5V **VCC
I1          ** I   **  2-¦         ¦-19 ** /O  **SUME
I2          ** I   **  3-¦         ¦-18 ** O   **SUMO
I3          ** I   **  4-¦    8    ¦-17 ** B   **N/C
I4          ** I   **  5-¦    2    ¦-16 ** B   **N/C
I5          ** I   **  6-¦    9    ¦-15 ** B   **N/C
I6          ** I   **  7-¦    1    ¦-14 ** B   **N/C
I7          ** I   **  8-¦    5    ¦-13 ** O   **SU3
I8          ** I   **  9-¦    3    ¦-12 ** O   **SU2
GND         ** 0V  ** 10-¦         ¦-11 ** O   **SU1
                        ----------
```

TB00590S

Figure 2. Pin List

```
 ******************** PARGEN ********************
@DEVICE TYPE
82S153
@DRAWING
******************************** PARITY GENERATOR/CHECKER
@REVISION
******************************** REV. -
@DATE
******************************** xx/xx/xxxx
@SYMBOL
******************************** FILE ID: PARGEN
@COMPANY
******************************** SIGNETICS
@NAME
@DESCRIPTION
*************************************************************************
*   This circuit is a 9-bit parity generator/checker commonly used      *
*   for error detection in high speed data transmission/retrieval.      *
*   The odd parity output (SUMO) is high when the sum of the data       *
*   bits is odd. Otherwise it is low.                                   *
*   The even parity output (SUME) is high when the sum of the data      *
*   bits is even. It is low otherwise.                                  *
*************************************************************************
@COMMON PRODUCT TERM
@I/O DIRECTION
"
*************************************************************************
*   SU1, SU2 and SU3 are outputs which are defined in the PIN LIST      *
*   and therefore they don't need to be defined here again.             *
*************************************************************************
"
@OUTPUT POLARITY
"
*************************************************************************
*   The output polarities of different outputs are defined in the       *
*   PIN LIST. They don't have to be defined again here.                 *
*************************************************************************
"
@LOGIC EQUATION
"
*************************************************************************
*   SU1, SU2, and SU3 are intermediate terms                            *
*************************************************************************
                    TRUTH TABLE
          INPUTS                OUTPUTS
     ----------------      ----------------------
     SU3    SU2    SU1      SUMO     SUME = /SUMO
      I8     I7     I6       SU3
      I5     I4     I3       SU2
      I2     I1     I0       SU1

      0      0      0         0         1
      0      0      1         1         0
      0      1      0         1         0
      0      1      1         0         1
      1      0      0         1         0
      1      0      1         0         1
      1      1      0         0         1
      1      1      1         1         0
"

SU1 = /I2 * /I1 *  I0 + /I2 *  I1 * /I0 +
       I2 * /I1 * /I0 +  I2 *  I1 *  I0 ;
SU2 = /I5 * /I4 *  I3 + /I5 *  I4 * /I3 +
       I5 * /I4 * /I3 +  I5 *  I4 *  I3 ;

SU3 = /I8 * /I7 *  I6 + /I8 *  I7 * /I6 +
       I8 * /I7 * /I6 +  I8 *  I7 *  I6 ;

SUMO = /SU1 * /SU2 *  SU3 + /SU1 *  SU2 * /SU3 +
        SU1 * /SU2 * /SU3 +  SU1 *  SU2 *  SU3 ;

SUME = /(/SU1 * /SU2 *  SU3 + /SU1 *  SU2 * /SU3 +
          SU1 * /SU2 * /SU3 +  SU1 *  SU2 *  SU3) ;
```

TB00580S

Figure 3. AMAZE Implementation Of The Parity Generator/Checker Circuit

9-Bit Parity Generator/Checker With 82S153/153A AN21

Table 1. Programming Table

```
 ********** PARGEN **********
Cust/Project -
Date         - ****************************** xx/xx/xxxx
Rev/I. D.    - ****************************** REV. -

82S153                                          !     POLARITY      !
                                                !L:H:H:H:H:H:H:H:H!
 T !                                            !-------------------!
 E !-------------------------------------------------------------------
 R !       I         !         B(i)            !        B(o)         !
 M !-------------------------------------------------------------------
___!7_6_5_4_3_2_1_0!9_8_7_6_5_4_3_2_1_0!9_8_7_6_5_4_3_2_1_0!
  0!- - - -,- L L H!- -,- - - -,- - - -!. .,A A A A,. . A A!
  1!- - - -,- L H L!- -,- - - -,- - - -!. .,A A A A,. . A A!
  2!- - - -,- H L L!- -,- - - -,- - - -!. .,A A A A,. . A A!
  3!- - - -,- H H H!- -,- - - -,- - - -!. .,A A A A,. . A A!
  4!- - L L,H - - -!- -,- - - -,- - - -!. .,A A A A,. A . A!
  5!- - L H,L - - -!- -,- - - -,- - - -!. .,A A A A,. A . A!
  6!- - H L,L - - -!- -,- - - -,- - - -!. .,A A A A,. A . A!
  7!- - H H,H - - -!- -,- - - -,- - - -!. .,A A A A,. A . A!
  8!L H - -,- - - -!- -,- - - -,- - - L!. .,A A A A,A . . A!
  9!H L - -,- - - -!- -,- - - -,- - - L!. .,A A A A,A . . A!
 10!L L - -,- - - -!- -,- - - -,- - - H!. .,A A A A,A . . A!
 11!H H - -,- - - -!- -,- - - -,- - - H!. .,A A A A,A . . A!
 12!- - - -,- - - -!- -,- - - -,H L L -!A A,A A A A,. . . A!
 13!- - - -,- - - -!- -,- - - -,L H L -!A A,A A A A,. . . A!
 14!- - - -,- - - -!- -,- - - -,L L H -!A A,A A A A,. . . A!
 15!- - - -,- - - -!- -,- - - -,H H H -!A A,A A A A,. . . A!
 16!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 17!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 18!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 19!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 20!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 21!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 22!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 23!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 24!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 25!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 26!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 27!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 28!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 29!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 30!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 31!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 D9!- - - -,- - - -!- -,- - - -,- - - -!                    .
 D8!- - - -,- - - -!- -,- - - -,- - - -!                    .
 D7!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!                    .
 D6!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!                    .
 D5!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!                    .
 D4!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!                    .
 D3!- - - -,- - - -!- -,- - - -,- - - -!                    .
 D2!- - - -,- - - -!- -,- - - -,- - - -!                    .
 D1!- - - -,- - - -!- -,- - - -,- - - -!                    .
 D0!0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!                    .

   I I I I I I I I S S N N N N S S S I S S N N N N S S S I
   7 6 5 4 3 2 1 0 U U / / / / U U U 8 U U / / / / U U U 8
                   M M C C C C 3 2 1   M M C C C C 3 2 1
                   E 0                 E 0
```

TB00610S

```
"
*************************************************************************
*   This is a test pattern for the 9-bit parity generator/checker       *
*   circuit. The simulator will use this file as an input to            *
*   simulate the logical function.                                      *
*************************************************************************

"          SS              EXPECTED
"          UU    SSS       OUTPUTS
"IIIIIIII MMBBBBUUUI        BBBBB
"76543210 E076543218        98321
 LLLLLLLL /////////L       "HLLLL
 HLHHLHLL /////////H       "LHLLH
 LHHLLHHL /////////H       "LHLHL
 HHLHLLHL /////////L       "HLLHH
 LLHLHHLH /////////H       "LHHLL
 HLLHHLLH /////////L       "HLHLH
 LHLLHLHH /////////L       "HLHHL
 HHHHHHHH /////////H       "LHHHH
QUIT
```

TB00600S

a. Input Pattern PARGEN.TST

```
82S153   A:pargen.STD
" This file is the result of logic simulation of the parity generator/checker
" circuit. The inputs are read from input file PARGEN.TST
"
"  INPUTS  <=B(I/O)=>   TRACE TERMS
" 76543210 9876543210
"
  00000000 HL....LLLO ;
  10110100 LH....LLH1 ;
  01100110 LH....LHL1 ;
  11010010 HL....LHH0 ;
  00101101 LH....HLL1 ;
  10011001 HL....HLH0 ;
  01001011 HL....HHL0 ;
  11111111 LH....HHH1 ;
"
" -------- ----------   I/O CONTROL LINES
"          OOIIIIOOOI   DESIGNATED I/O USAGE
"          OOIIIIOOOI   ACTUAL I/O USAGE
"
" PIN LIST...
" 08 07 06 05 04 03 02 01 19 18 17 16 15 14 13 12 11 09 ;
```

TB00601S

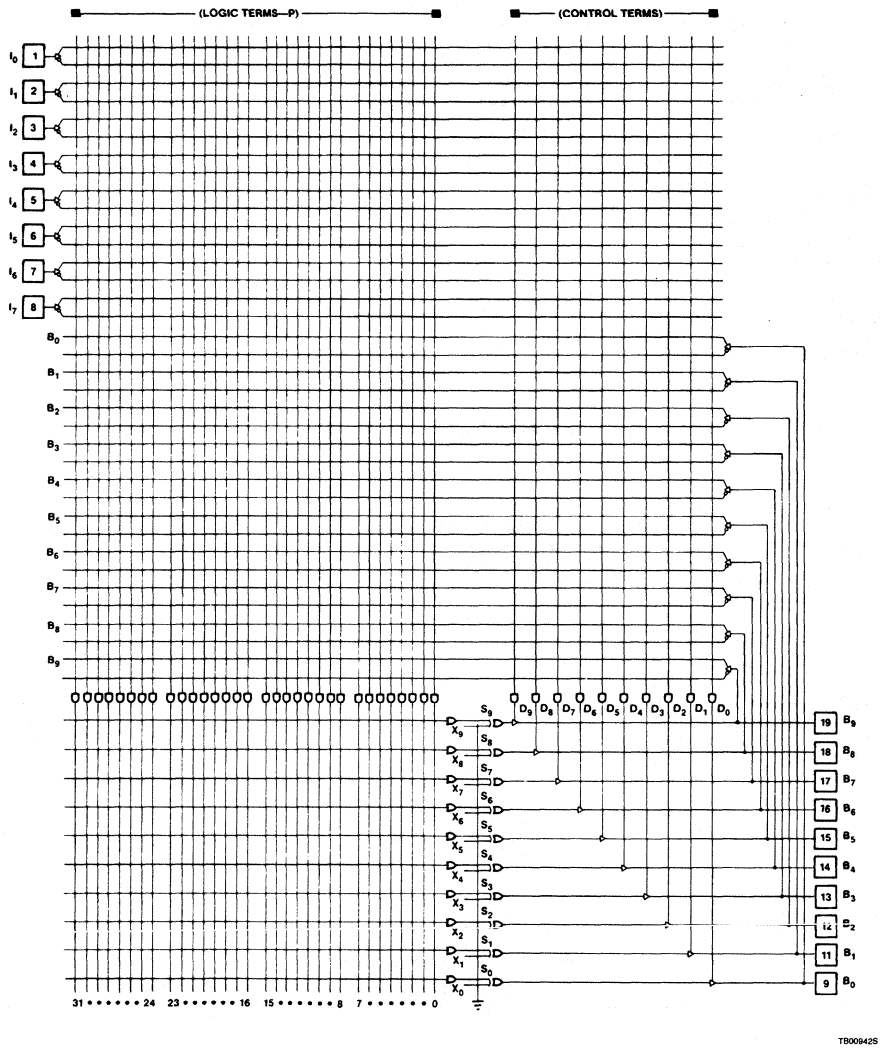
b. Output File From SIMULATOR

Figure 4. Test Vectors

9-Bit Parity Generator/Checker With 82S153/153A

AN21

APPENDIX A

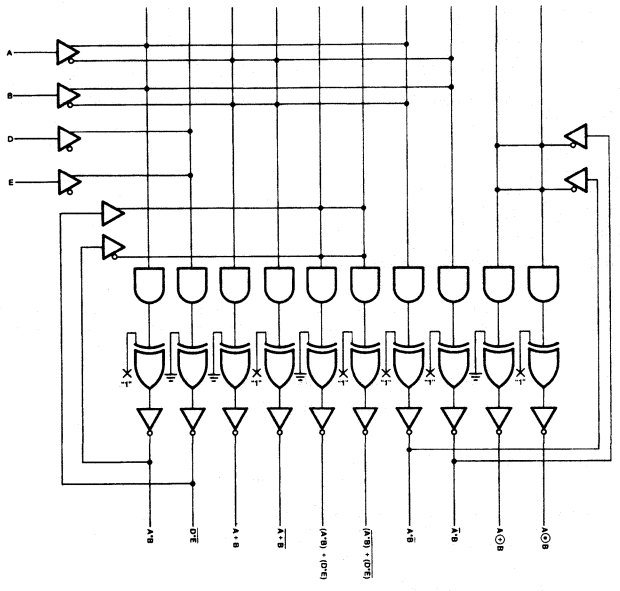


NOTES:
1. All programmed "AND" gate locations are pulled to logic "1".
2. All programmed "OR" gate locations are pulled to logic "0".
3. Programmable connection.

Figure A-1. FPLA Logic Diagram

AN22
PLS151 Toolkit

Application Note



a. Basic Gates Configuration

```
******************** TK151-1 ********************
###################### P I N   L I S T ######################

   LABEL     ** FNC **PIN --------- PIN** FNC **     LABEL
A            ** I   **  1-|         |-20 ** +5V **VCC
B            ** I   **  2-|         |-19 ** O   **A_NOR_B
D            ** I   **  3-|         |-18 ** /O  **A_OR_B
E            ** I   **  4-|    8    |-17 ** /O  **D_NAND_E
N/C          ** I   **  5-|    2    |-16 ** O   **A_AND_B
N/C          ** I   **  6-|    5    |-15 ** /O  **AB_OR_DE
N/C          ** /B  **  7-|    1    |-14 ** O   **AB_NOR_DE
N/C          ** /B  **  8-|    5    |-13 ** /O  **A_XOR_B
A-_N_B       ** O   **  9-|    1    |-12 ** O   **A_EQU_B
GND          ** OV  ** 10-|         |-11 ** O   **A_N_B-
                          ----------
```

TB00640S

b. Pin List

Figure 1

```
 ******************** TK151-1 ********************
@DEVICE TYPE
************ 82S151
@DRAWING
************ FIGURE 1. BASIC GATE CONFIGURATIONS
@REVISION
************ TK151-1 REV. 0
@DATE
************ JULY 10, 1985
@SYMBOL
************ TK151-1
@COMPANY
************ SIGNETICS
@NAME
************ DAVID K. WONG
@DESCRIPTION
This file contains the 6 basic logic gates: AND, NAND, OR, NOR, XOR and EQU.
@COMMON PRODUCT TERM
@I/O DIRECTION
@OUTPUT POLARITY
@I/O STEERING
@LOGIC EQUATION
A_AND_B    = A * B ;
D_NAND_E   = /( D * E ) ;
A_OR_B     = /( /A * /B ) ;
A_NOR_B    = /A * /B ;
AB_OR_DE   = /( /(A_AND_B) * D_NAND_E ) ;
AB_NOR_DE  = /(A_AND_B) * D_NAND_E ;
A_N_B-     = A * /B ;
A-_N_B     = /A * B ;
A_XOR_B    = /(/(A_N_B-) * /(A-_N_B)) ; " Equivalent to (A * /B) + (/A * B) "
A_EQU_B    = /(A_N_B-) * /(A-_N_B) ;    " Equivalent to (/A * /B) + (A * B) "
```

TB00630S

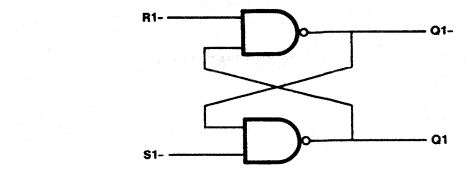
c. Boolean Equations Of Basic Gate Configurations

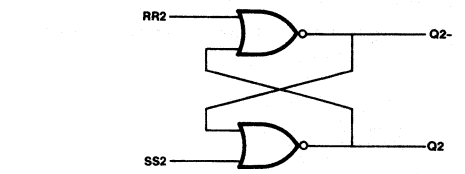
Figure 1 (Continued)

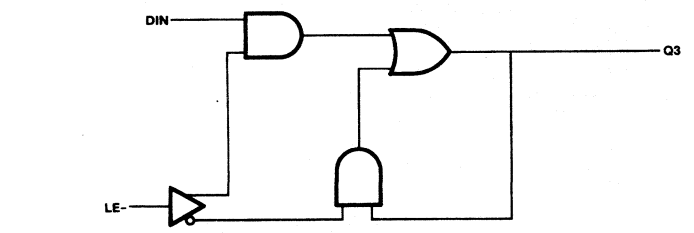
Table 1. Program Table of Basic Gate Configurations

```
 ******************** TK151-1 ********************
Cust/Project - ************ DAVID K. WONG
Date         - ************ JULY 10, 1985
Rev/I. D.    - ************ TK151-1 REV. 0

82S151    DIR  !A:A:A:A:A:A:A:A:A:A:A:A:A!
___
 T !      POL  !H:L:L:H:L:H:L:H:H:H:L:L!
 E !-------------------------------------
 R !       I   !          B(i)          !
 M !-----------!1 1 --------------------
___!5_4_3_2_1_0!1_0_9_8_7_6_5_4_3_2_1_0!
  0!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  1!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  2!- -,- - H L!- - - -,- - - -,- - - -!
  3!- -,- - L H!- - - -,- - - -,- - - -!
  4!- -,- - - -!- - - -,- - - -,L L - -!
  5!- -,- - - -!- - - -,- - - -,L L - -!
  6!- -,- - - -!- - H L,- - - -,- - - -!
  7!- -,- - - -!- - H L,- - - -,- - - -!
  8!- -,- - H H!- - - -,- - - -,- - - -!
  9!- -,H H - -!- - - -,- - - -,- - - -!
 10!- -,- - L L!- - - -,- - - -,- - - -!
 11!- -,- - L L!- - - -,- - - -,- - - -!
 D2!- -,- - - -!- - - -,- - - -,- - - -!
 D1!- -,- - - -!- - - -,- - - -,- - - -!
 D0!- -,- - - -!- - - -,- - - -,- - - -!

   N N E D B A A A D A A A A A A A N N
   / /       _ _ _ _ B B _ _ _ _ - / /
   C C       N O N A _ _ X E N _ C C
             O R A N O N O Q _ N
             R _ N D R O R U B _
             _ B D _ _ R _ _ - B
             B   _ B D _ B B
                 E   E D
                     E
```

TB00680S







a. Basic Latches Configuration

```
******************** TK151-2 ********************
********************** P I N   L I S T **********************

   LABEL     ** FNC **PIN ---------- PIN** FNC **     LABEL
R1-          ** I   **  1-¦         ¦-20 ** +5V **VCC
S1-          ** I   **  2-¦         ¦-19 ** /O  **Q1
RR2          ** I   **  3-¦         ¦-18 ** /O  **Q1-
SS2          ** I   **  4-¦    8    ¦-17 ** O   **Q2
DIN          ** I   **  5-¦    2    ¦-16 ** O   **Q2-
LE-          ** I   **  6-¦    5    ¦-15 ** /O  **Q3
N/C          ** /B  **  7-¦    1    ¦-14 ** O   **D_N_LE
N/C          ** /B  **  8-¦    5    ¦-13 ** O   **Q3_N_LE-
N/C          ** /B  **  9-¦    1    ¦-12 ** /B  **N/C
GND          ** OV  ** 10-¦         ¦-11 ** /B  **N/C
                          ----------

TB00670S
```

b. Pin List

Figure 2

```
 ******************** TK151-2 ********************
@DEVICE TYPE
82S151
@DRAWING
************ FIGURE 2. BASIC LATCHES CONFIGURATION
@REVISION
************ TK151-2 REV. 0
@DATE
************ JULY 10, 1985
@SYMBOL
************ TK151-2
@COMPANY
************ SIGNETICS
@NAME
************ DAVID K. WONG
@DESCRIPTION
This files contains basic configurations of two RS-latches and a D-latch.
@COMMON PRODUCT TERM
@I/O DIRECTION
@OUTPUT POLARITY
@I/O STEERING
@LOGIC EQUATION

" **********************************
  *  CROSS-COUPLED NAND RS-LATCH   *
  ********************************** "
Q1-         = /( /R1- * Q1 ) ;
Q1          = /( /S1- * Q1- ) ;

" **********************************
  *  CROSS-COUPLED NOR RS-LATCH    *
  ********************************** "
Q2-         = RR2 * Q2 ;
Q2          = SS2 * Q2- ;

" **********************************
  *            D-LATCH             *
  ********************************** "
D_N_LE      = DIN * LE- ;
Q3_N_LE-    = Q3 * /LE- ;
Q3          = /( /(D_N_LE) * /(Q3_N_LE-) ) ;
```

TB00660S

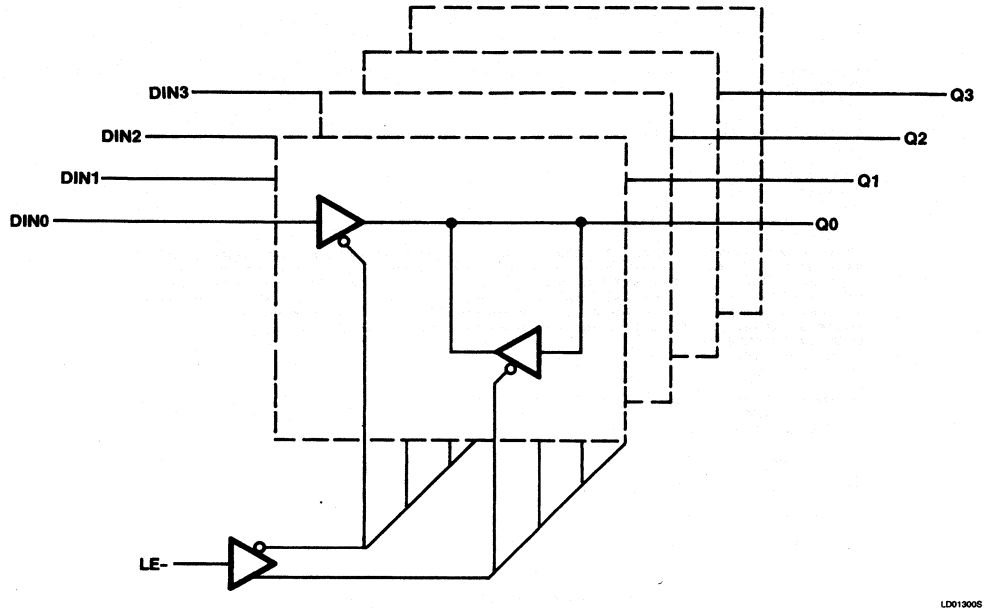
c. Boolean Equations Of Basic Latches Configuration

Figure 2 (Continued)

Table 2. Program Table of Basic Latches

```
 ******************** TK151-2 ********************
Cust/Project - ************ DAVID K. WONG
Date         - ************ JULY 10, 1985
Rev/I. D.    - ************ TK151-2 REV. 0

82S151    DIR  !A:A:A:A:A:A:A:A:A:A:A:A:A!
___              ---------------------------
 T !      POL  !L:L:H:H:L:H:H:L:L:L:L:L:L!
 E !-------------------------------------
 R !        I   !          B(i)          !
 M !------------!1 1 ---------------------
___!5_4_3_2_1_0!1_0_9_8_7_6_5_4_3_2_1_0!
  0!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  1!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  2!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  3!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  4!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  5!L -,- - - -!- - - -,H - - -,- - - -!
  6!H H,- - - -!- - - -,- - - -,- - - -!
  7!- -,- - - -!- - - -,- L L -,- - - -!
  8!- -,- H - -!- - H -,- - - -,- - - -!
  9!- -,H - - -!- - - H,- - - -,- - - -!
 10!- -,- - - L!H - - -,- - - -,- - - -!
 11!- -,- - L -!- H - -,- - - -,- - - -!
 D2!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
 D1!- -,- - - -!- - - -,- - - -,- - - -!
 D0!- -,- - - -!- - - -,- - - -,- - - -!

   L D S R S R Q Q Q Q Q D Q N N N N N
   E I S R 1 1 1 1 2 2 3 _ 3 / / / / /
   - N 2 2 - -   -   -   N _ C C C C C
                         _ N
                         L _
                         E L
                           E
                           -
```

TB00710S



a. 4-Bit D-Latch

```
********************* TK151-3 ********************
********************** P I N   L I S T ***********************

   LABEL     ** FNC **PIN ---------- PIN** FNC **     LABEL
DIN0         ** I   **  1-¦          ¦-20 ** +5V **VCC
DIN1         ** I   **  2-¦          ¦-19 ** B   **Q0
DIN2         ** I   **  3-¦          ¦-18 ** B   **Q1
DIN3         ** I   **  4-¦   8      ¦-17 ** B   **Q2
LE-          ** I   **  5-¦   2      ¦-16 ** B   **Q3
N/C          ** I   **  6-¦   S      ¦-15 ** B   **FB0
N/C          ** /B  **  7-¦   1      ¦-14 ** B   **FB1
N/C          ** /B  **  8-¦   5      ¦-13 ** B   **FB2
N/C          ** /B  **  9-¦   1      ¦-12 ** B   **FB3
GND          ** 0V  ** 10-¦          ¦-11 ** /B  **N/C
                        ----------
```

TB00700S

b. Pin List

Figure 3

```
******************** TK151-3 ********************
@DEVICE TYPE
82S151
@DRAWING
************ FIGURE 3. 4 BIT D-LATCH
@REVISION
************ TK151-3 REV. 0
@DATE
************ JULY 10, 1985
@SYMBOL
************ TK151-3
@COMPANY
************ SIGNETICS
@NAME
************ DAVID K. WONG
@DESCRIPTION
This file contains a 4-bit D-latch. External jumper is required for each latch
between Qn and FBn. When LE- is HIGH, outputs Q0, Q1, Q2, and Q3 are active and
 outputs FB0, FB1, FB2, and FB3 are tri-stated. Qn, therefore, equals Dn when
LE- is HIGH. When LE- becomes LOW, Q outputs are tri-stated, and FB outputs are
active. Since FB outputs feedback to their own inputs, they are latched to
whatever level the Q outputs were in when LE- goes from HIGH to LOW.
@COMMON PRODUCT TERM
@I/O DIRECTION
DO   = /( /LE- ) ;
D1   = /(  LE- ) ;
@OUTPUT POLARITY
@I/O STEERING
@LOGIC EQUATION
Q0   = DIN0 ;
Q1   = DIN1 ;
Q2   = DIN2 ;
Q3   = DIN3 ;
FB0  = Q0   ;
FB1  = Q1   ;
FB2  = Q2   ;
FB3  = Q3   ;
```

TB00690S

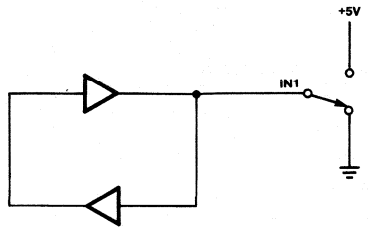
c. Boolean Equations Of 4-Bit D-Latch

Figure 3 (Continued)

Table 3. Program Table of 4-Bit D-Latch

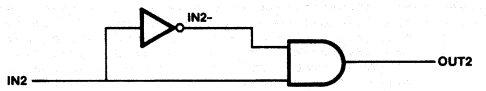
```
******************** TK151-3 ********************
Cust/Project - ************ DAVID K. WONG
Date         - ************ JULY 10, 1985
Rev/I. D.    - ************ TK151-3 REV. 0

82S151    DIR  !A;A;A;A;A;A;A;A;A;A;A;A!
___
 T !      POL  !H;H;H;H;H;H;H;H;L;L;L;L!
 E !-------------------------------------
 R !       I   !          B(i)          !
 M !-----------!1 1 ----------------------
___!5_4_3_2_1_0!1_0_9_8_7_6_5_4_3_2_1_0!
  0!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  1!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  2!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  3!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  4!- -,- - - -!- - - H,- - - -,- - - -!
  5!- -,- - - -!- - H -,- - - -,- - - -!
  6!- -,- - - -!- H - -,- - - -,- - - -!
  7!- -,- - - -!H - - -,- - - -,- - - -!
  8!- -,H - - -!- - - -,- - - -,- - - -!
  9!- -,- H - -!- - - -,- - - -,- - - -!
 10!- -,- - H -!- - - -,- - - -,- - - -!
 11!- -,- - - H!- - - -,- - - -,- - - -!
D2!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
D1!- H,- - - -!- - - -,- - - -,- - - -!
D0!- L,- - - -!- - - -,- - - -,- - - -!

   N L D D D D Q Q Q Q F F F N N N N
   / E I I I I 0 1 2 3 B B B B / / / /
   C - N N N N         0 1 2 3 C C C C
       3 2 1 0
```

TB00740S



TC01800S

Switch Debouncer



LD01310S

Pulse Shaper

a. Single Pin Switch Debouncer And Pulse Shaper

```
******************** TK151-4 ********************
######################## P I N   L I S T ########################

   LABEL     ** FNC **PIN --------- PIN** FNC **     LABEL
IN2          ** I   **  1-¦         ¦-20 ** +5V **VCC
N/C          ** I   **  2-¦         ¦-19 ** O   **IN1
N/C          ** I   **  3-¦         ¦-18 ** /O  **IN2-
N/C          ** I   **  4-¦    8    ¦-17 ** O   **OUT2
N/C          ** I   **  5-¦    2    ¦-16 ** /B  **N/C
N/C          ** I   **  6-¦    S    ¦-15 ** /B  **N/C
N/C          ** /B  **  7-¦    1    ¦-14 ** /B  **N/C
N/C          ** /B  **  8-¦    5    ¦-13 ** /B  **N/C
N/C          ** /B  **  9-¦    1    ¦-12 ** /B  **N/C
GND          ** OV  ** 10-¦         ¦-11 ** /B  **N/C
                          ---------
```

TB00730S

b. Pin List

Figure 4

```
 ******************** TK151-4 ********************
@DEVICE TYPE
82S151
@DRAWING
************ PLS151 TOOLKIT FIGURE 4
@REVISION
************ tk151-4 REV. 0
@DATE
************ JULY 10, 1985
@SYMBOL
************ TK151-4
@COMPANY
************ SIGNETICS
@NAME
************ DAVID K. WONG
@DESCRIPTION
This file contains a single pin debouncer and a pulse shaper.
@COMMON PRODUCT TERM
@I/O DIRECTION
@OUTPUT POLARITY
@I/O STEERING
@LOGIC EQUATION
" ******************************************************************
  * DEBOUNCER -- This circuit uses one bidirectional pin to de-    *
  *              bounce a single pole double throw switch. When    *
  *              the switch is thrown to its opposit polarity,     *
  *              it shorts the output to Vcc or ground. One pro-   *
  *              pagation delay later, the output is switched to   *
  *              the same polarity as the switch.                  *
  ****************************************************************** "
 IN1     = IN1 ;

" ******************************************************************
  * PULSE SHAPER -- This circuit creates a LOW-to-HGH glitch       *
  *                 which has the pulse width of one prop delay.   *
  *                 Wider pulse width may be generated with add-   *
  *                 itional feedback loops.                        *
  ****************************************************************** "
IN2-    = /( IN2 ) ;
OUT2    = IN2- * IN2 ;
```

TB00720S

c. Boolean Equations of Single Pin and Pulse Shaper

Figure 4 (Continued)

Table 4. Program Table of Single Pin Debouncer and Shaper

```
 ******************** TK151-4 ********************
Cust/Project - ************ DAVID K. WONG
Date         - ************ JULY 10, 1985
Rev/I. D.    - ************ tk151-4 REV. 0

82S151    DIR  !A:A:A:A:A:A:A:A:A:A:A:A!
___
 T !      POL  !H:L:H:L:L:L:L:L:L:L:L:L!
 E !-------------------------------------
 R !       I   !          B(i)          !
 M !-----------!1 1 ---------------------
___!5_4_3_2_1_0!1_0_9_8_7_6_5_4_3_2_1_0!
  0!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  1!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  2!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  3!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  4!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  5!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  6!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  7!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  8!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
  9!- -,- - - H!- H - -,- - - -,- - - -!
 10!- -,- - - H!- - - -,- - - -,- - - -!
 11!- -,- - - -!H - - -,- - - -,- - - -!
 D2!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
 D1!0 0,0 0 0 0!0 0 0 0,0 0 0 0,0 0 0 0!
 D0!- -,- - - -!- - - -,- - - -,- - - -!

   N N N N N I I I O N N N N N N N N N
   / / / / / N N N U / / / / / / / / /
   C C C C C 2 1 2 T C C C C C C C C C
             - 2
```

TB00650S

Signetics

AN23
PLS168/168A Primer

Application Note

Application Specific Products

INTRODUCTION

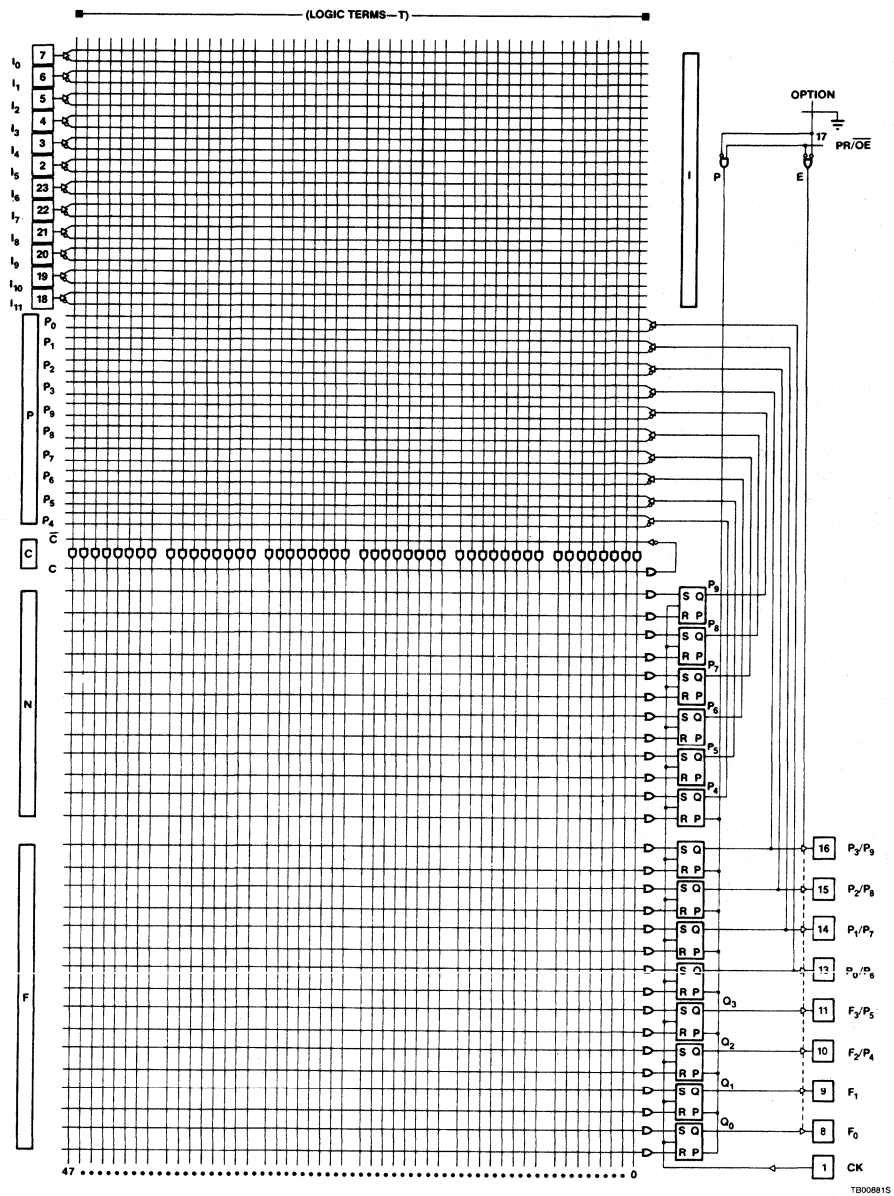
THE PLS168/168A is a bipolar Field-Programmable Logic Sequencer as shown in Figure 1, which consists of 12 inputs, a 48 product term PLA and 14 R/S flip-flops. Out of the 14 flip-flops, six are buried State Registers ($P_4 - P_9$), four Output Registers ($F_0 - F_3$), and four Dual-purpose Registers ($P_0 - P_3$), which may be used as Output or State Registers. All flip-flops are positive edge-triggered. They are preset to "1" at power-up, or may be asynchronously set to "1" by an optional PR/OE pin, which may be programmed either as a preset pin or as an output enable pin. Additional features includes the Complement Array and diagnostics features.

ARCHITECTURE

As shown in Figure 2, the device is organized as a decoding AND-OR network which drives a set of registers some of which, in turn, feedbacks to the AND/OR decoder while the rest serve as outputs. Outputs P_0 to P_3 may be programmed to feedback to the AND/OR decoder as State Registers and, at the same time, used as outputs. The user now can design a 10-bit state machine without external wiring. The AND/OR array is the classical PLA structure in which the outputs of all the AND gates can be programmed to drive all the OR gates. The schematic diagram of the AND-OR array is shown in Figure 3. This structure provides the user a very structured design methodology which can be automated by CAD tools, such as Signetics AMAZE software package. The output of the PLA is in the form of sum-of-products which, together with the RS flip-flops, is the ideal structure for implementation of state machines. (Refer to Appendix A for a brief description of synchronous finite state machines.)

Design Tools

A direct approach to implement a design using the PLS168/168A is the H/L table supplied in the data sheet as shown in Table 1. The table is organized according to input and output of the PLA decoding network. The lefthand side of the table represent the inputs to the AND-array, which includes input from input pins and present state information from the feedback buffers which feedback the contents of the State Register. The righthand side of the table represents the output of the OR-array, which drives the State and Output Registers as the next state and output. Each column in the lefthand side of the table represents an input buffer, which may be inverting, non-inverting, disconnected or unprogrammed. Each column in the righthand side of the table represents a pair of outputs to the flip-flops, which may be set, reset, disconnected, or unprogrammed. The programming symbols are H, L, –, and 0. (See Figure 4 for details.) For inputs buffers, "H" means that the non-inverting buffer is connected, "L" means that the inverting buffer is connected, "–" means that both inverting and non-inverting buffers are disconnected, and "0" means that both inverting and non-inverting buffers are connected which causes that particular AND-term to be unconditionally LOW. On the output side of the table, "H" means that the particular AND-term is connected to the OR-term on the "S" input of the particular flip-flop, "L" means that the AND-term is connected to the "R" side, "–" means that the AND-term is not connected to the flip-flop at all, and "0" means that the AND-term is connected to both the "S" and "R" sides. More details of the symbols and their meanings are shown in Appendix B. Each row in the table represents an AND-term. There are 48 AND-terms in the device. Therefore, there are 48 rows in the table. An example of implementing a transition from one state to another is shown in Figure 4a. The state diagram can be implemented by the PLS168 as shown in Figure 4b. The state diagram is translated into H/L format as shown in Figure 4c. The first column on the lefthand side of the table is for the Complement Array which will be discussed in detail in the next section.



NOTES:
1. All programmed "AND" gate locations are pulled to logic "1".
2. All programmed "OR" gate locations are pulled to logic "0".
3. Programmable connection.

Figure 1. Logic Diagram Of PLS168/168A

Table 1. PLS168/168A Programming Table

CUSTOMER NAME _____
PURCHASE ORDER # _____
SIGNETICS DEVICE # CF (XXXX)
CUSTOMER SYMBOLIZED PART # _____
TOTAL NUMBER OF PARTS _____
PROGRAM TABLE # _____
REV _____
DATE _____

AND

C_n	
INACTIVE	O
GENERATE	A
PROPAGATE	*
TRANSPARENT	–

I_m, P_x	
INACTIVE	O
I, P	H
$\overline{I}$, $\overline{P}$	L
DON'T CARE	–

OR

N_x, F_r	
INACTIVE	O
SET	H
RESET	L
NO CHANGE	–

OPTION

P/E	
PRESET	H
OE	L

TERM	C_n	INPUT(Im) 11 10 9 8 7 6 5 4 3 2 1 0	PRESENT STATE (Px) 9 8 7 6 5 4 3 2 1 0	REMARKS	NEXT STATE (Ns) (Px) 9 8 7 6 5 4 3 2 1 0	OUTPUT (Fr) 3 2 1 0
0						
1						
2						
3						
4						
5						
6						
7						
8						
9						
10						
11						
12						
13						
14						
15						
16						
17						
18						
19						
20						
21						
22						
23						
24						
25						
26						
27						
28						
29						
30						
31						
32						
33						
34						
35						
36						
37						
38						
39						
40						
41						
42						
43						
44						
45						
46						
47						

PIN NO.	18	19	20	21	22	23	2	3	4	5	6	7	16	15	14	13	11	10	9	8
VARIABLE NAME																				

TB02030S

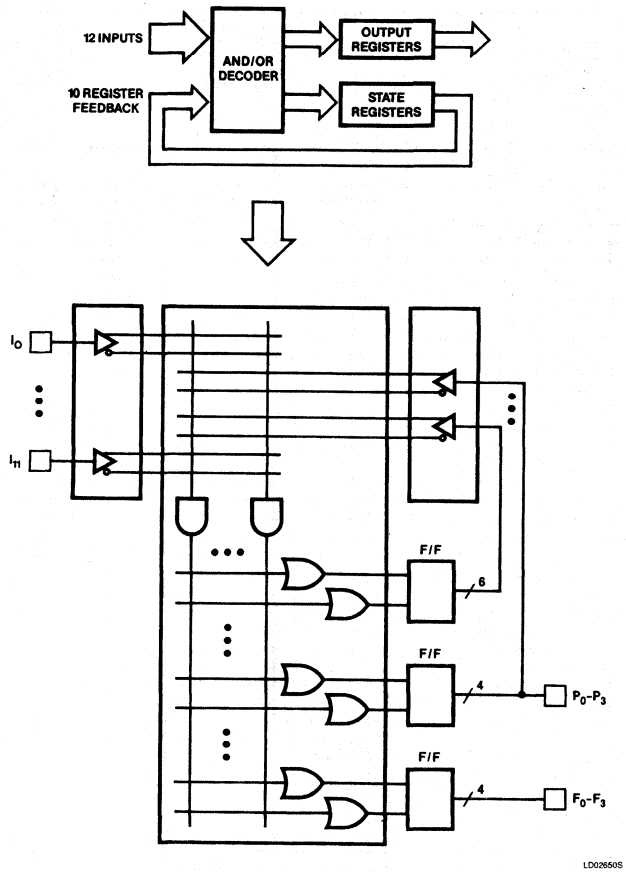


Figure 2. The Architecture Of PLS168/168A

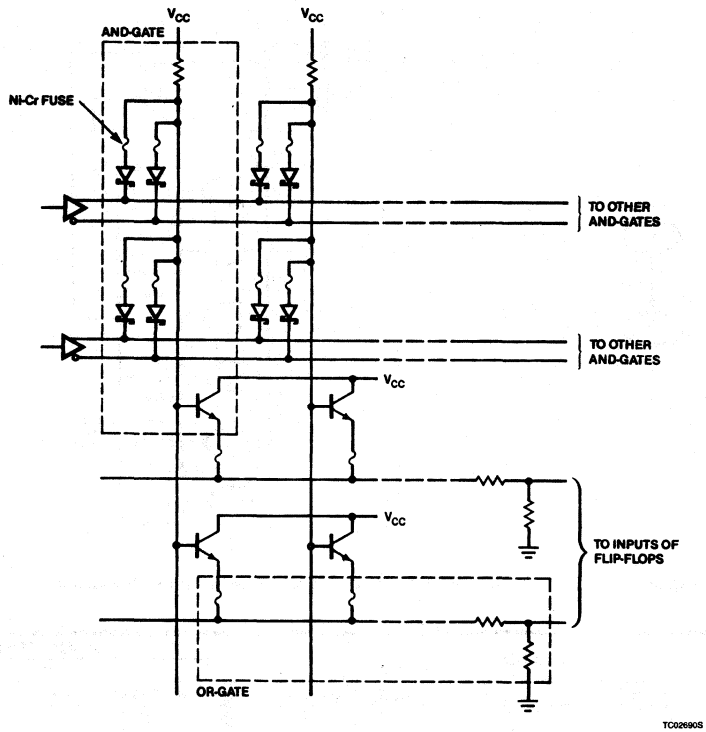
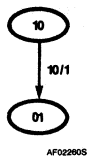
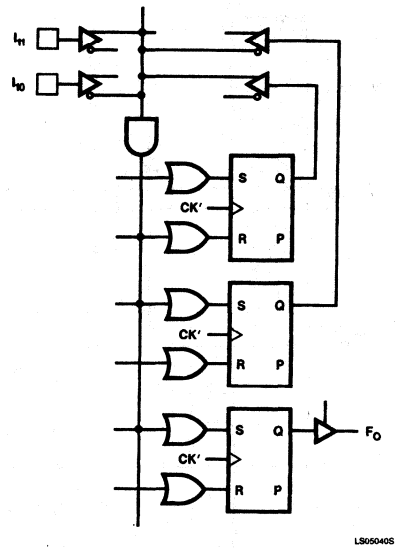


Figure 3. Schematic Diagram Of AND-OR Array



a. State Diagram



b. Implementation Of State Diagram (a) with PLS168

TERM	AND																					OPTION (PR/OE) OR										
	C	INPUT												PRESENT STATE								NEXT STATE						OUTPUT				
		11	10	9	8	7	6	5	4	3	2	1	0	9	8	7	6	5	4	3	2	1	0	9	8	7	6	5	4	3	2	1	0
00	–	H	L	–	–	–	–	–	–	–	–	–	–	–	–	–	–	H	L	–	–	–	–	–	–	–	–	L	H	–	–	–	–
01																																	
PIN NO.		18	19	20	21	22	23	2	3	4	5	6	7															16	15	14	13	11	10	9	8
NAME		IN1	IN0																													OUT0			

TB02010S

c. PLS168 Programming Table

Figure 4. Implementing State Machine With PLS168

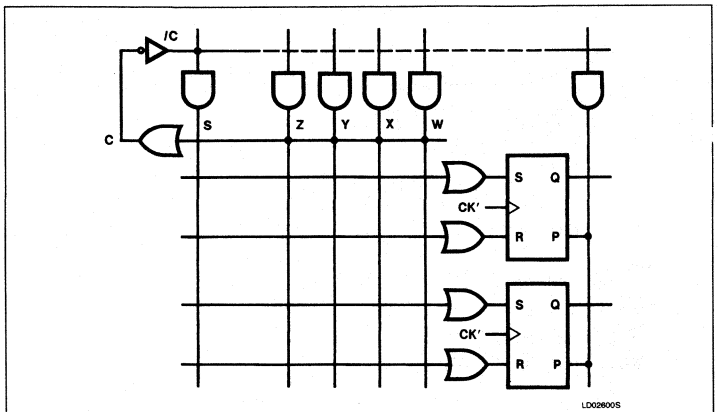
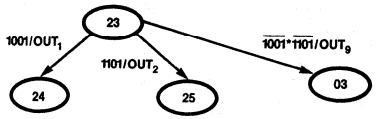


Figure 5. Logic Diagram Of Complement Array

Complement Array

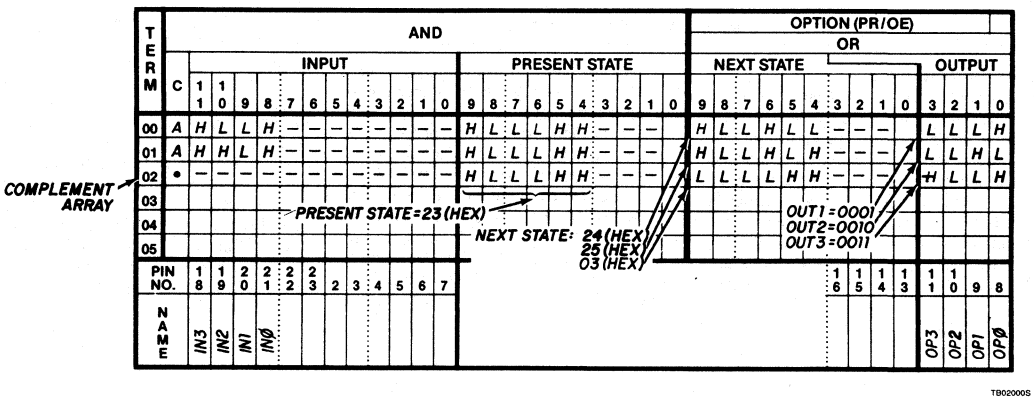
An additional feature is the Complement Array, which is often used to provide escape vectors in case the state machines get into undefined states during power-up or a timing violation due to asynchronous inputs. A logic diagram of the Complement Array is shown in Figure 5. The output of the Complement Array is normally LOW when one or more AND-terms are HIGH. If all of the AND-terms are LOW, then the output of the Complement Array will be HIGH. In this example, if each AND-term is a decoder for a particular state and input combination, and if the circuit gets into an undefined state, none of the AND-terms will be HIGH. Therefore, the output /C will be HIGH, which will then enable the AND-term S which in turn may be used to reset all registers to LOW or HIGH as predefined. The state machine thus escapes from being in an undefined state by using the Complement Array and one AND-term. Without the Complement Array an alternate way of escaping from being in an undefined state is by defining all possible states which are not being defined. This method may require quite a few AND-terms depending on the design. Another application for the Complement Array is illustrated by the following example. As shown in Figure 6, when the machine is in state 23, if input vector equals 1001, it will go to next state 24. If the input is 1101, then go to state 25. But if the input is neither 1001 nor 1101, then go to state 03. It takes only two terms to implement the first two transition vectors. To implement the third vector "go to state 03 if input is neither 1001 nor 1101", the Complement Array accepts the outputs of the first two AND-terms as inputs. If the input vector is neither 1001 nor 1101, then both terms will be LOW, which causes the output of the Complement Array (/C) to be HIGH. A third AND-term is used to AND state 24 and /C together to set the registers to state 03. The State Diagram is translated into AMAZE syntex as shown in Figure 6b, where all vectors are in square brackets and the Complement Array is represented by the ELSE statement. The State diagram Figure 6a can also be expressed in the format of a program table as shown in Figure 6c. The complement array may be used to exit from different present states to different next states. It can be used many times in one state machine design as shown in Figures 7a, b, and c where the state diagram is implemented using the AMAZE state equation syntex and the H/L format.



a. State Diagram

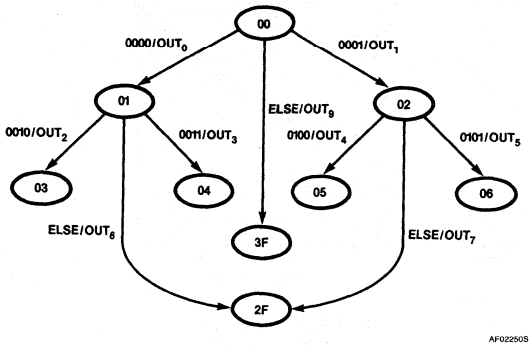
```
WHILE [23]
  IF [1001] THEN [24] WITH
[OUT1]
  IF [1101] THEN [25] WITH
[OUT2]
  ELSE: [03] WITH [OUT9]
```

b. AMAZE State Equation Syntex



c. H/L Format

Figure 6. Application Of Complement Array



a. State Diagram

```
WHILE [00]
  IF [0000] THEN [01] WITH [OUT0]
  IF [0001] THEN [02] WITH [OUT1]
  ELSE: [3F] WITH [OUT9]
WHILE [01]
  IF [0010] THEN [03] WITH [OUT2]
  IF [0011] THEN [04] WITH [OUT3]
  ELSE: [2F] WITH [OUT6]
WHILE [02]
  IF [0100] THEN [05] WITH [OUT4]
  IF [0101] THEN [06] WITH [OUT5]
  ELSE: [2F] WITH [OUT7]
```

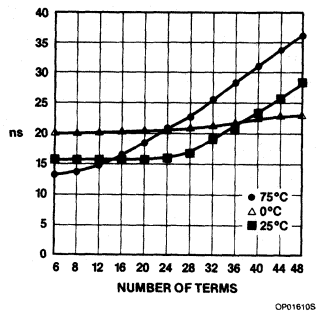
b. AMAZE State Equation

TERM	AND																					OPTION (PR/OE) OR												
	INPUT												PRESENT STATE									NEXT STATE									OUTPUT			
	C	11	10	9	8	7	6	5	4	3	2	1	0	9	8	7	6	5	4	3	2	1	0	9	8	7	6	5	4	3	2	1	0	3	2	1	0
00	A	L	L	L	L	–	–	–	–	–	–	–	–	L	L	L	L	L	L	–	–	–	–	L	L	L	L	L	H	–	–	–	–	L	L	L	L
01	A	L	L	L	H	–	–	–	–	–	–	–	–	L	L	L	L	L	L	–	–	–	–	L	L	L	L	H	L	–	–	–	–	L	L	L	H
02	•	–	–	–	–	–	–	–	–	–	–	–	–	L	L	L	L	L	L	–	–	–	–	H	H	H	H	H	H	–	–	–	–	H	L	L	H
03																																					
04	A	L	L	H	L	–	–	–	–	–	–	–	–	L	L	L	L	L	H	–	–	–	–	L	L	L	L	H	H	–	–	–	–	L	L	H	L
05	A	L	L	H	H	–	–	–	–	–	–	–	–	L	L	L	L	L	H	–	–	–	–	L	L	L	H	L	L	–	–	–	–	L	L	H	H
06	•	–	–	–	–	–	–	–	–	–	–	–	–	L	L	L	L	L	H	–	–	–	–	H	L	H	H	H	H	–	–	–	–	L	H	H	L
07																																					
08	A	L	H	L	L	–	–	–	–	–	–	–	–	L	L	L	L	H	L	–	–	–	–	L	L	L	H	L	H	–	–	–	–	L	H	L	L
09	A	L	H	L	H	–	–	–	–	–	–	–	–	L	L	L	L	H	L	–	–	–	–	L	L	L	H	H	L	–	–	–	–	L	H	L	H
10	•	–	–	–	–	–	–	–	–	–	–	–	–	L	L	L	L	H	L	–	–	–	–	H	L	H	H	H	H	–	–	–	–	L	H	H	H
11																																					
PIN NO.		18	19	20	21	22	23	2	3	4	5	6	7											16	15	14	13							11	10	9	8
NAME		IN3	IN2	IN1	INØ																													OP3	OP2	OP1	OPØ

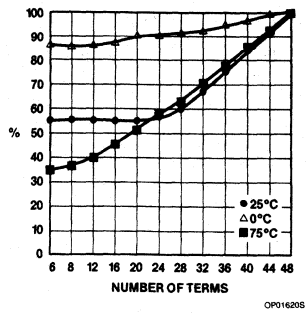
TB01990S

c. PLS168 Programming Table

Figure 7. Applications Of Complement Array



a. PLS168 Set-up Time vs P-Term Loading



b. PLS168 Set-up Time vs P-Term Loading

Figure 8

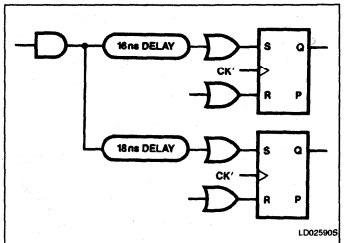


Figure 9. Difference In Propagation Delay Due To Different P-Term Loading

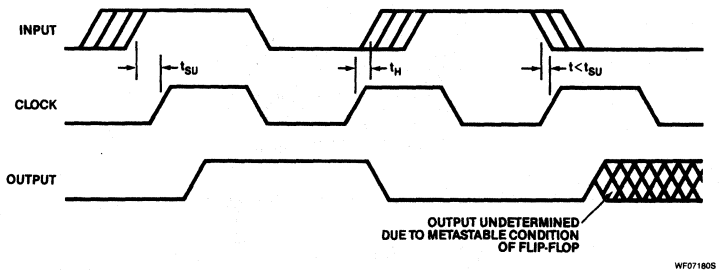


Figure 10. Change Of T_{CKO} Due To Metastable Condition Of Flip-Flop

PLS168/168A Primer

AN23

Optional Preset/Output Enable

The PR/OE pin provides the user with the option of either using that pin to control the Tri-state output buffers of the Output Registers, or have that pin to asynchronously preset all registers to HIGH. The purpose of the preset function is to provide the system a way to set the PLS168 to a known state, all HIGHs. The output enable function are sometimes used where the state machine is connected to a bus which is shared by other output circuits. It is also used during power-up sequence to keep the PLS168 from sending power glitches to other circuits which it drives. By programming the PR/OE pin to control the Tri-state output buffers, the preset function is permanently disabled. By programming the PR/OE pin to control the asynchronous preset of the registers, the output buffers are permanently enabled. While using the present function to asynchronously preset the register, if a rising edge of the clock occurs while the preset input is HIGH, the registers will remain preset. Normal flip-flop operation will resume only after the preset input is LOW and the rising edge of the next clock. Setting the registers to a predefined pattern other than all HIGHs may be accomplished by using a dedicated p-term, which is activated by an input pin which will also inhibit all other p-terms which are being used. The inhibiting of other p-terms eliminates the problem of undetermined state of an RS flip-flop caused by having HIGHs on both R and S inputs.

Diagnostic Features

In debugging a state machine, sometimes it is necessary to know what is the content of the state register. The buried State Register may be read by applying +10V on I_0, which will cause the contents of register bits P_4 to P_5, P_6 to P_9 to be displayed on output pins F_2 to F_3 and P_0 and P_3 respectively. While the device can handle the +10V on pin I_0, prolonged and continuous use will cause the chip to heat up since more power is being dissipated at +10V. To facilitate more expedient functional tests, synchronous preset vectors as described above may be used to set the State Register to different states without having to go through the entire sequence.

Timing Requirements

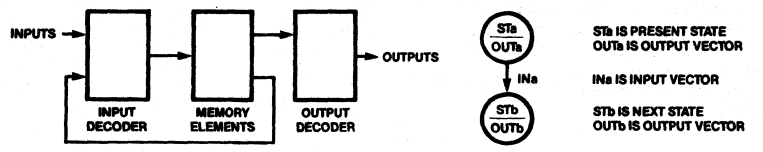
Since the PLS168 is intended to be a synchronous finite state machine, the inputs are expected to be synchronous to the clock and set-up and hold time requirements are expected to be met. In general, the set-up time requirement is measured at its worst case as having the entire AND-array connected to the OR-term being measured and there is only one active AND-term to drive the entire line. The set-up time decreases from there as less p-terms are used. This is due to the capacitance of the unused AND-terms being removed from the line. Figure 8a shows the typical set-up time requirement of a PLS168A device. Figure 8b shows the normalized set-up time as a percentage of the worst case, which is with 48 terms connected. In a typical state machine design, some flip-flops will change states more frequently than others. Those that change more frequently will have more p-term loading on its OR gates than those that change states less frequently. The different loadings on the OR-terms cause different delay on the inputs of the flip-flops as shown in Figure 9. If an input fails to meet the set-up time specification, it is possible that the resultant of the input change gets to one set of flip-flops before the rising edge of the clock while it gets to other flip-flops during or after the clock's rising edge. The result is that some flip-flops have changed states and some have not, or some get into metastable condition as shown in Figure 10. The state machine is now either out of sequence or is in an undefined state. This problem often occurs with asynchronous inputs which is generated totally independent of the clock on the system. A common remedy for the problem of asynchronous inputs is to use latches or flip-flops to catch the input and then synchronously feed it to the state machine. This minimizes the problem with the different propagation delays due to different p-term loading. But there is still a finite probability that the external latches or flip-flops will get into metastable condition, which may be propagated into the state machine. Nevertheless, the window for the flip-flops in state machine to get into undefined states or metastable condition is narrowed by a great extent.

APPENDIX A

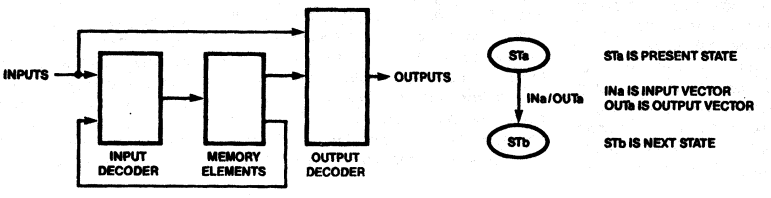
INTRODUCTION TO STATE MACHINE

A state machine is a synchronous sequential circuit which interprets inputs and generates outputs in accordance with a predetermined logic sequence. It is analogous to running a computer program with a computer. The state machine, with its sequence coded in hardware, can run much faster than a computer running the sequence in software. Therefore, it is often used in controller applications where speed is important.

Generally, state machines may be classified as Mealy or Moore machines as shown in Figures 1a and 1b. The fundamental difference of the two types are: the output of a Moore machine is a dependent of only the state of the memory elements whereas the output of a Mealy machine is a dependent of both the state of the memory elements and the inputs to the state machine. The figures also show graphic representations of the logic sequence in the form of state diagram in which the bubbles represent state vectors, and the arrows represent transitions from present states to next states.



Appendix A-1. Moore Machine Model



Appendix A-2. Mealy Machine Model

APPENDIX B

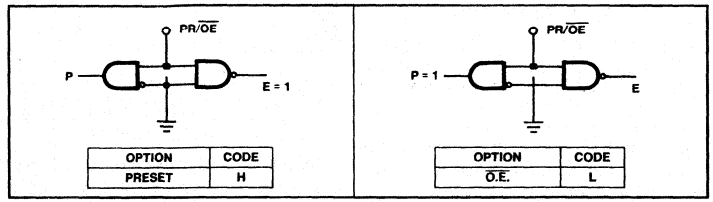
LOGIC PROGRAMMING

The FPLS can be programmed by means of Logic programming equipment.

With Logic programming, the AND/OR gate input connections necessary to implement the desired logic function are coded directly from the State Diagram using the Program Table on the following page.

In this table, the logic state or action of control variables C, I, P, N, and F, associated with each Transition Term T_n, is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

PRESET/$\overline{O.E.}$ OPTION – (P/E)



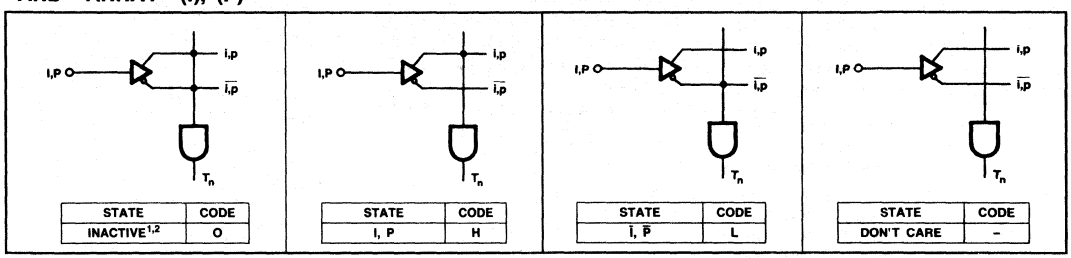
OPTION	CODE
PRESET	H

OPTION	CODE
$\overline{O.E.}$	L

PROGRAMMING:

The PLS168A has a power-up preset feature. This feature insures that the device will power-up in a known state with all register elements (state and output register) at a logic high (H). When programming the device it is important to realize this is the initial state of the device. You *must* provide a next state jump if you do not wish to use all highs (H) as the present state.

"AND" ARRAY – (I), (P)



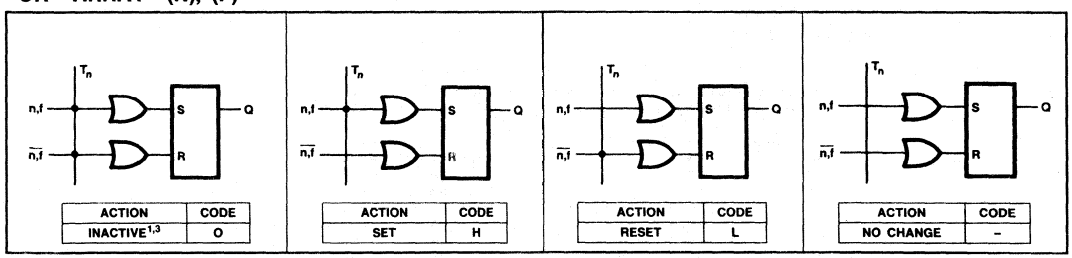
STATE	CODE
INACTIVE[1,2]	O

STATE	CODE
I, P	H

STATE	CODE
$\overline{I}$, $\overline{P}$	L

STATE	CODE
DON'T CARE	–

"OR" ARRAY – (N), (F)



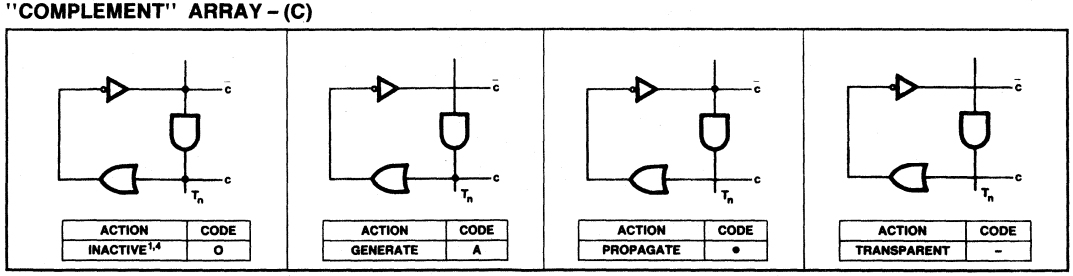
ACTION	CODE
INACTIVE[1,3]	O

ACTION	CODE
SET	H

ACTION	CODE
RESET	L

ACTION	CODE
NO CHANGE	–

"COMPLEMENT" ARRAY – (C)



ACTION	CODE
INACTIVE[1,4]	O

ACTION	CODE
GENERATE	A

ACTION	CODE
PROPAGATE	•

ACTION	CODE
TRANSPARENT	–

NOTES:

1. This is the initial unprogrammed state of all link pairs. It is normally associated with all unused (inactive) AND gates T_n.
2. Any gate T_n will be unconditionally inhibited if any one of its I or P link pairs is left intact.
3. To prevent simultaneous Set and Reset flip-flop commands, this state is not allowed for N and F link pairs coupled to active gates T_n (see flip-flop truth tables).
4. To prevent oscillations, this state is not allowed for C link pairs coupled to active gates T_n.

Signetics

AN24
PLS173 As A 10-Bit Comparator, 74LS460

Application Note

Application Specific Products

DESCRIPTION

The PLS173 is a 24-pin PLA device which has 10 bidirectional outputs and 12 dedicated inputs. The output of the device is the sum of products of the inputs. The polarity of each output may be individually programmed as active HIGH or active LOW. A logic diagram of the device is shown in Appendix A. A 10-bit comparator similar to the 74LS460 compares two 10-bit data inputs to establish if EQUIVALENCE or NOT EQUIVALENCE exists. The output has True and Complement comparison status outputs. The logic diagram of the comparator is shown in Figure 1.

The truth table is as shown in Table 1 where vectors a and b are 10-bit inputs to A9 to A0 and B9 to B0. If the input to A9-A0 is bit-to-bit equivalent to the input to B9-B0, the two input vectors are considered EQUIVALENT, and output EQ goes HIGH and NE goes LOW. If the two input vectors are not bit-to-bit equivalent, then EQ goes LOW and NE goes HIGH. The circuit is implemented with AMAZE as shown in Figures 2a, 2b and 2c. The result of logic simulation of the circuit is shown in Figure 2d.

Notice that on the OR side of the program table in Figure 5, all the fuses in the OR-term are intact, which means that all the AND-terms are still connected to all the OR-terms. This feature provides for future modification. But if all the unused AND-terms are deleted, the device will run faster. There are also many unused AND-terms which will provide for future modification. But if they are deleted (both on the AND and OR side), it will amount to about 450μA per term power saving. Figure 3 is the program table with all unused terms deleted.

Table 1. Function Table

$A_9 - A_0$	$B_9 - B_0$	EQ	NE
a	a	H	L
b	b	H	L
a	b	L	H
b	a	L	H

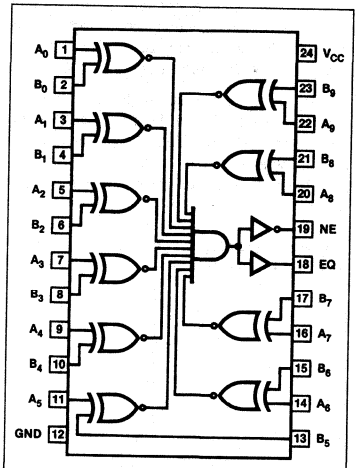


Figure 1. Logical Equivalent Circuit Of 10-Bit Comparator

```
********************* AN24_173 *********************
######################## P I N   L I S T ########################

    LABEL      ** FNC **PIN ---------- PIN** FNC **     LABEL
A0             ** I    **  1-|         |-24 ** +5V **VCC
B0             ** I    **  2-|         |-23 ** I    **B9
A1             ** I    **  3-|         |-22 ** I    **A9
B1             ** I    **  4-|    8    |-21 ** I    **B8
A2             ** I    **  5-|    2    |-20 ** I    **A8
B2             ** I    **  6-|    5    |-19 ** O    **NE
A3             ** I    **  7-|    1    |-18 ** /O   **EQ
B3             ** I    **  8-|    7    |-17 ** I    **B7
A4             ** I    **  9-|    3    |-16 ** I    **A7
B4             ** I    ** 10-|         |-15 ** I    **B6
A5             ** I    ** 11-|         |-14 ** I    **A6
GND            ** 0V   ** 12-|         |-13 ** I    **B5
                               ----------

                                                    TB01770S
```

a. Pin List Of 10-Bit Comparator

Figure 2

```
 ******************** AN24_173 ********************
@DEVICE TYPE
82S173
@DRAWING
..................... 10-BIT COMPARATOR USING PLS173
@REVISION
..................... REV-0
@DATE
..................... OCT-14-85
@SYMBOL
..................... AN24_173
@COMPANY
..................... SIGNETICS
@NAME
..................... DAVID WONG
@DESCRIPTION
This circuit compares two 10-bit inputs. If they are bit-to-bit equivalent,
outputs EQ goes HIGH and NE goes LOW. If the inputs are not bit-to-bit equiv-
alent to each other, outputs EQ goes LOW and NE goes HIGH.
@COMMON PRODUCT TERM

T0  =  A0 * /B0 ;
T1  = /A0 *  B0 ;
T2  =  A1 * /B1 ;
T3  = /A1 *  B1 ;
T4  =  A2 * /B2 ;
T5  = /A2 *  B2 ;
T6  =  A3 * /B3 ;
T7  = /A3 *  B3 ;
T8  =  A4 * /B4 ;
T9  = /A4 *  B4 ;
T10 =  A5 * /B5 ;
T11 = /A5 *  B5 ;
T12 = /A6 *  B6 ;
T13 =  A6 * /B6 ;
T14 =  A7 * /B7 ;
T15 = /A7 *  B7 ;
T16 =  A8 * /B8 ;
T17 = /A8 *  B8 ;
T18 =  A9 * /B9 ;
T19 = /A9 *  B9 ;

@I/O DIRECTION
@OUTPUT POLARITY
@LOGIC EQUATION

EQ = /( T0 + T1 + T2 + T3 + T4 + T5 + T6 + T7 + T8 + T9 +
        T10 + T11 + T12 + T13 + T14 + T15 + T16 + T17 + T18 + T19 ) ;

NE =    T0 + T1 + T2 + T3 + T4 + T5 + T6 + T7 + T8 + T9 +
        T10 + T11 + T12 + T13 + T14 + T15 + T16 + T17 + T18 + T19 ;
```

TB01780S

b. Boolean Equations Of 10-Bit Comparator

Figure 2 (Continued)

```
********************* AN24_173 *********************
Cust/Project  - .................. DAVID WONG
Date          - .................. OCT-14-85
Rev/I. D.     - .................. REV-0

82S173                                      !      POLARITY       !
 ---                                         ---------------------
 T !                                        !H:H:H:H:H:L:H:H:H:H!
 E !-----------------------------------------------------------------
 R !              I          !       B(i)       !       B(o)         !
 M !1 1 ----------------------------------------------------------------
___!1_0 9 8 7 6_5_4_3 2_1_0!9_8_7_6_5_4_3_2_1 0!9_8_7_6_5 4 3_2_1_0!
  0!- - - -,- - - -,- - L H!- -,- - - -,- - - -!A A,A A A A,A A A A!
  1!- - - -,- - - -,- - H L!- -,- - - -,- - - -!A A,A A A A,A A A A!
  2!- - - -,- - - -,L H - -!- -,- - - -,- - - -!A A,A A A A,A A A A!
  3!- - - -,- - - -,H L - -!- -,- - - -,- - - -!A A,A A A A,A A A A!
  4!- - - -,- - L H,- - - -!- -,- - - -,- - - -!A A,A A A A,A A A A!
  5!- - - -,- - H L,- - - -!- -,- - - -,- - - -!A A,A A A A,A A A A!
  6!- - - -,L H - -,- - - -!- -,- - - -,- - - -!A A,A A A A.A A A A!
  7!- - - -,H L - -,- - - -!- -,- - - -,- - - -!A A,A A A A,A A A A!
  8!- - L H,- - - -,- - - -!- -,- - - -,- - - -!A A,A A A A.A A A A!
  9!- - H L.- - - -,- - - -!- -,- - - -,- - - -!A A,A A A A,A A A A!
 10!L H - -,- - - -,- - - -!- -,- - - -,- - - -!A A,A A A A,A A A A!
 11!H L - -,- - - -,- - - -!- -,- - - -,- - - -!A A,A A A A,A A A A!
 12!- - - -,- - - -,- - - -!- -,- - - -,- - H L!A A,A A A A,A A A A!
 13!- - - -,- - - -,- - - -!- -,- - - -,- - L H!A A,A A A A,A A A A!
 14!- - - -,- - - -,- - - -!- -,- - - -,L H - -!A A,A A A A,A A A A!
 15!- - - -,- - - -,- - - -!- -,- - - -,H L - -!A A,A A A A,A A A A!
 16!- - - -,- - - -,- - - -!- -,L H - -,- - - -!A A,A A A A.A A A A!
 17!- - - -,- - - -,- - - -!- -,H L - -,- - - -!A A,A A A A,A A A A!
 18!- - - -,- - - -,- - - -!L H,- - - -,- - - -!A A,A A A A,A A A A!
 19!- - - -,- - - -,- - - -!H L,- - - -,- - - -!A A,A A A A,A A A A!
 20!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 21!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 22!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 23!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 24!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 25!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 26!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 27!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 28!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 29!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 30!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A,A A A A!
 31!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!A A,A A A A.A A A A!
 D9!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!                   .
 D8!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!                   .
 D7!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!                   .
 D6!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!                   .
 D5!- - - -,- - - -,- - - -!- -,- - - -,- - - -!                   .
 D4!- - - -,- - - -,- - - -!- -,- - - -,- - - -!                   .
 D3!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!                   .
 D2!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!                   .
 D1!0 0 0 0,0 0 0 0,0 0 0 0!0 0,0 0 0 0,0 0 0 0!                   .
 D0!0 0 0 0,0 0 0 0.0 0 0 0!0 0,0 0 0 0,0 0 0 0!                   .

     B A B A B A B A B A B A B A B A N E B A B A B A B A N E B A B A
     5 5 4 4 3 3 2 2 1 1 0 0 9 9 8 8 E 0 7 7 6 6 9 9 8 8 E 0 7 7 6 6
```

TB01790S

c. Program Table Of 10-Bit Comparator After Assembly Of Boolean Equation File

Figure 2 (Continued)

```
82S173   A:AN24_173.STD
" AMAZE FILE ID: AN24_173
" LOGIC SIMULATION OF 10-BIT COMPARATOR
"
" <==INPUTS==> <=B(I/O)=>   TRACE TERMS
" 11
" 109876543210 9876543210
"
  000000000000 0000LH0000 ;
  010000000000 0000HL0000 ;
  100000000000 0000HL0000 ;
  110000000000 0000LH0000 ;
  000100000000 0000HL0000 ;
  001000000000 0000HL0000 ;
  001100000000 0000LH0000 ;
  000001000000 0000HL0000 ;
  000010000000 0000HL0000 ;
  000011000000 0000LH0000 ;
  000000010000 0000HL0000 ;
  000000100000 0000HL0000 ;
  000000110000 0000LH0000 ;
  000000000100 0000HL0000 ;
  000000001000 0000HL0000 ;
  000000001100 0000LH0000 ;
  000000000001 0000HL0000 ;
  000000000010 0000HL0000 ;
  000000000011 0000LH0000 ;
  000000000000 0100HL0000 ;
  000000000000 1000HL0000 ;
  000000000000 1100LH0000 ;
  000000000000 0001HL0000 ;
  000000000000 0010HL0000 ;
  000000000000 0011LH0000 ;
  000000000000 0000HL0100 ;
  000000000000 0000HL1000 ;
  000000000000 0000LH1100 ;
  000000000000 0000HL0001 ;
  000000000000 0000HL0010 ;
  000000000000 0000LH0011 ;
"
" ------------ ----------   I/O CONTROL LINES
"              IIIIOOIIII   DESIGNATED I/O USAGE
"              IIIIOOIIII   ACTUAL I/O USAGE
"
" PINLIST...
" 13 11 10 09 08 07 06 05 04 03 02 01
" 23 22 21 20 19 18 17 16 15 14 ;
```

TB01800S

d. Test Vectors Generated By AMAZE After Logic Simulation

Figure 2 (Continued)

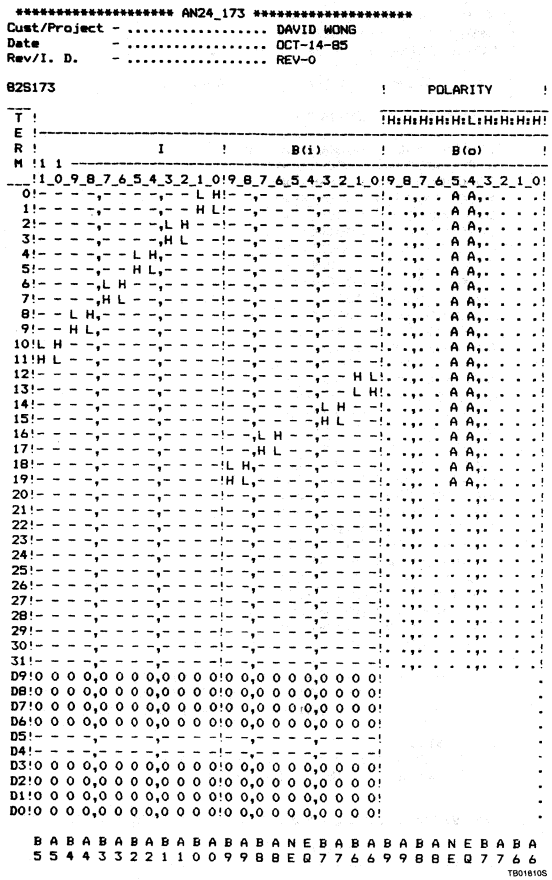
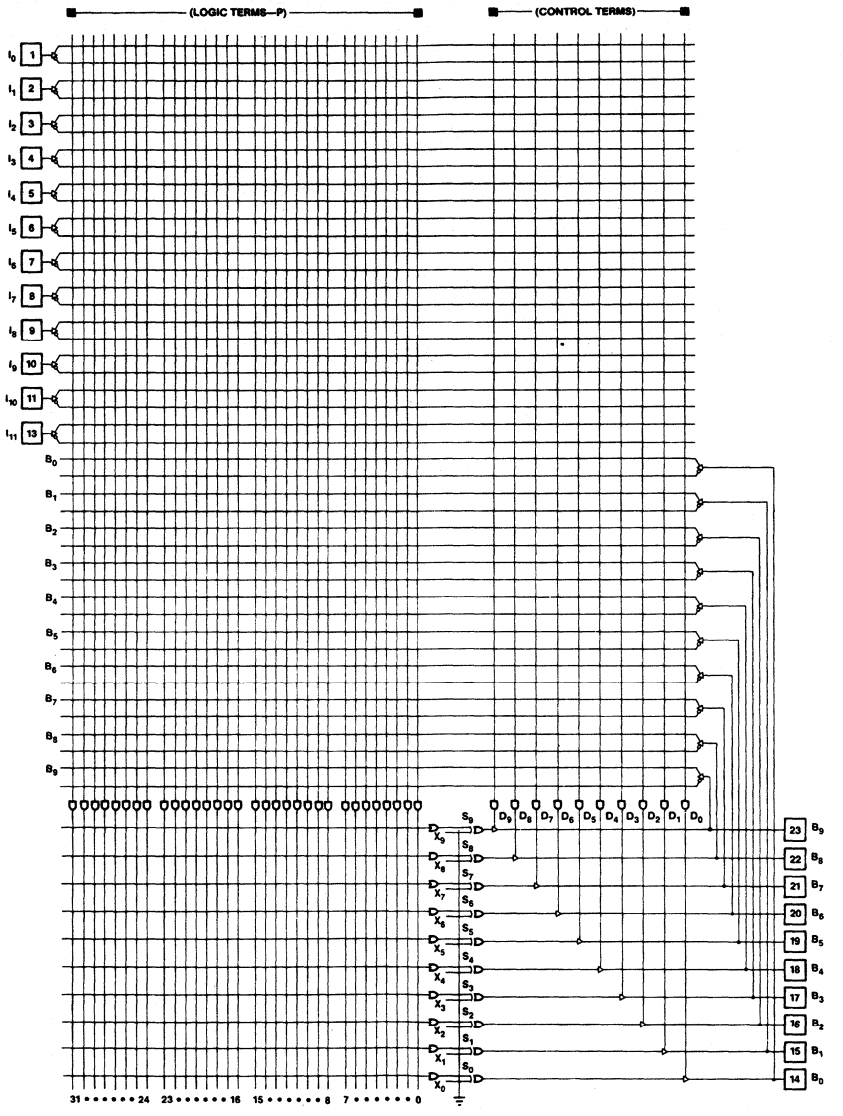


Figure 3. Program Table Of 10-Bit Comparator With All Unused Terms Deleted

PLS173 As A 10-Bit Comparator, 74LS460 — AN24

APPENDIX A

FPLA LOGIC DIAGRAM FOR PLS173



NOTES:
1. All programmed "AND" gate locations are pulled to logic "1".
2. All programmed "OR" gate locations are pulled to logic "0".
3. Programmable connection.

Signetics

Application Specific Products

Section 10
Package Outlines

INDEX

Package Outlines

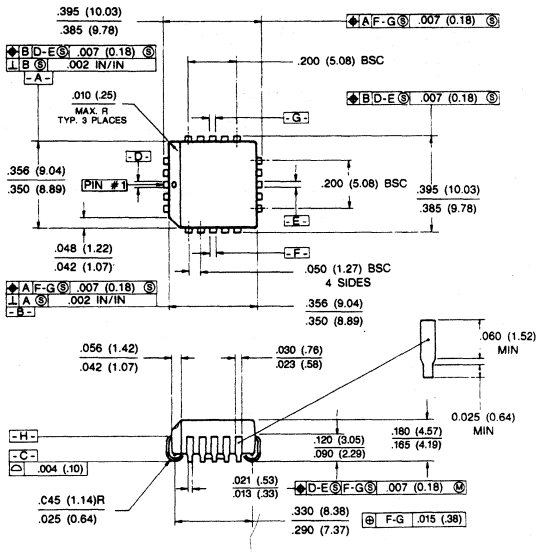
PLASTIC PLCC

1. Package dimensions conform to JEDEC specifications for standard Leaded Chip Carrier outline (PLCC) package.
2. Controlling dimensions are given in inches with dimensions in millimeters contained in parentheses.
3. Dimensions and tolerancing per ANSI Y14.5M - 1982.
4. "D-E" and "F-G" are reference datums on the molded body and do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15mm (0.006″) on any side.
5. Pin numbers start with pin #1 and continue counterclockwise when viewed from the top.
6. Lead material: Olin 194 (Copper Alloy) or equivalent, solder dipped.
7. Body material: Plastic (Epoxy).
8. These figures are measured with a standard die. The package is mounted on a glass epoxy test board with the following dimensions: 2.24″ × 2.24″ × 0.062″.

PLASTIC LEADED CHIP CARRIER (PLCC)

NO. OF LEADS	PACKAGE CODE	θ_{JA}/θ_{JC} (°C/W)	DESCRIPTION
20	AL1	71/32	0.350 in sq.
28	AQ1	60/24	0.450 in. sq.

AL1 PLASTIC PLCC-20



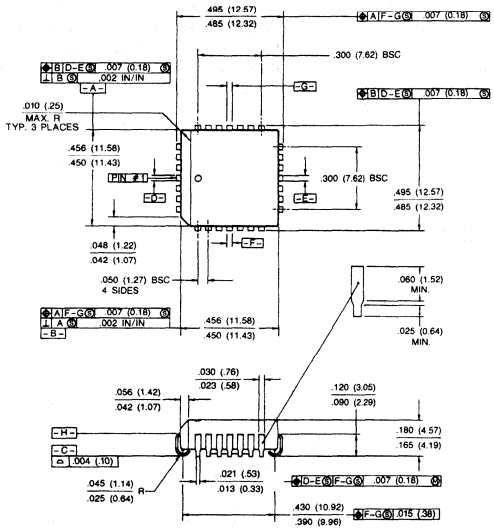
NOTES:
1. Package dimensions conform to JEDEC specification MO-047-AA for plastic leaded chip carrier 20 leads, .050 inch lead spacing, square. (issue A, 10/31/84).
2. Controlling dimensions: inches. Metric are shown in parentheses.
3. Dimensions and tolerancing per ANSI Y14.5M-1982.
4. "A" and "B" are reference datums on the molded body at plane "H" and do not include mold flash. Mold flash protrusion shall not exceed .006" (.15mm) on any side.
5. Datum "D-E" and "F-G" are determined where these center leads exit from the body at plane "H".
6. Pin numbers continue counterclockwise to pin #20 (top view).
7. Signetics order code for product packaged in a PLCC is the suffix A after the product number.

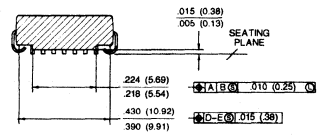
853-0400 081226

PO00632S

Package Outlines

AQ1 PLASTIC PLCC-28





NOTES:

1. Package dimensions conform to JEDEC specification MO-047-AB for plastic leaded chip carrier 28 leads, .050 inch lead spacing, square. (issue A, 10/31/84).
2. Controlling dimensions: inches. Metric are shown in parentheses.
3. Dimensions and tolerancing per ANSI Y14.5M-1982.
4. "A" and "B" are reference datums on the molded body at plane "H" and do not include mold flash. Mold flash protrusion shall not exceed .006" (.15mm) on any side.
5. Datum "D-E" and "F-G" are determined where these center leads exit from the body at plane "H".
6. Pin numbers continue counterclockwise to pin #28 (top view).
7. Signetics order code for product packaged in a PLCC is the suffix A after the product number.

853-0401 081227

PO00612S

Package Outlines

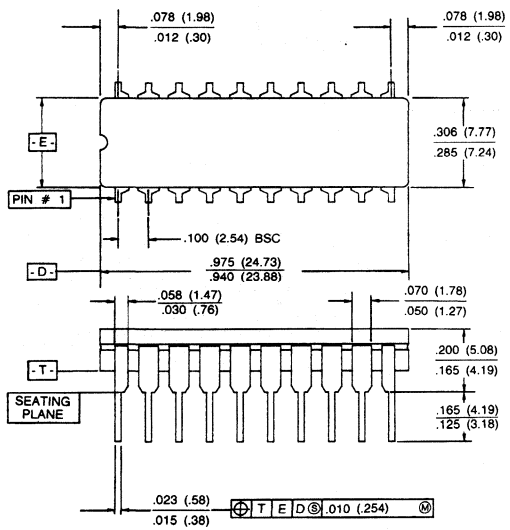
HERMETIC CERDIP

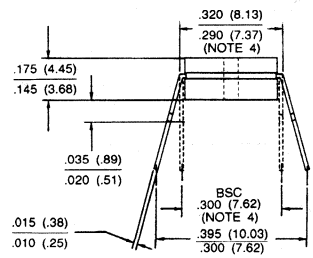
1. Package dimensions conform to JEDEC specifications for standard Ceramic Dual Inline (Cerdip) package.
2. Controlling dimensions are given in inches with dimensions in millimeters, mm, contained in parentheses.
3. Dimensions and tolerancing per ANSI Y14.5M - 1982.
4. Pin numbers start with pin #1 and continue counterclockwise when viewed from the top.
5. These dimensions measured with the leads constrained to be perpendicular to plane T.
6. Lead material: ASTM alloy F-30 (Alloy 42) or equivalent - tin plated or solder dipped.
7. Body Material: Ceramic with glass seal at leads.
8. Thermal test fixture: Device secured in Textool ZIF socket with 0.04" stand off.

HERMETIC DUAL-IN-LINE PACKAGES

NO. OF LEADS	PACKAGE CODE	θ_{JA}/θ_{JC} (°C/W)	DESCRIPTION
20	FL1	72/25	300 mil wide
24	FN1	63/26	300 mil wide
28	FQ3	57/27	600 mil wide

FL1 HERMETIC CDIP-20





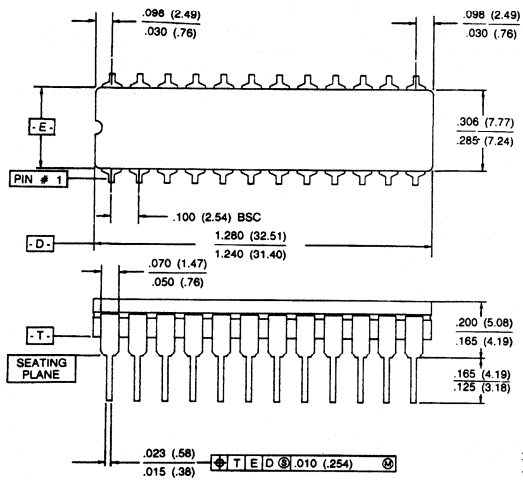
NOTES:
1. Controlling dimension: inches. Millimeters are shown in parentheses.
2. Dimensions and tolerancing per ANSI Y14.5M - 1982.
3. "T", "D", and "E" are reference datums on the body and include allowance for glass overrun and meniscus on the seal line, and lid to base mismatch.
4. These dimensions measured with the leads constrained to be perpendicular to plane T.
5. Pin numbers start with pin #1 and continue counterclockwise to pin #20 when viewed from the top.

853-0584/081594

PO00430S

Package Outlines

FN1 HERMETIC CDIP-24

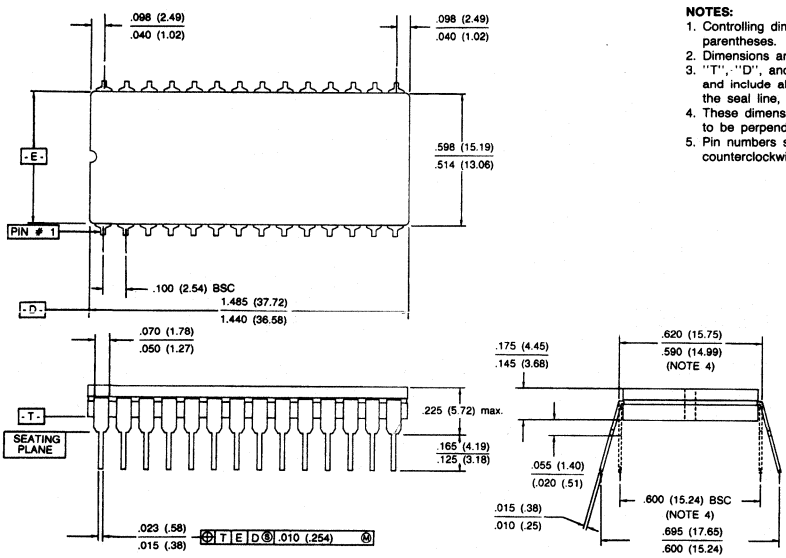


NOTES:
1. Controlling dimension: inches. Millimeters are shown in parentheses.
2. Dimensions and tolerancing per ANSI Y14.5M - 1982.
3. "T", "D", and "E" are reference datums on the body and include allowance for glass overrun and meniscus on the seal line, and lid to base mismatch.
4. These dimensions measured with the leads constrained to be perpendicular to plane T.
5. Pin numbers start with pin #1 and continue counterclockwise to pin #24 when viewed from the top.

853-0586/081594

PO00401S

FQ3 HERMETIC CDIP-28



NOTES:
1. Controlling dimension: inches. Millimeters are shown in parentheses.
2. Dimensions and tolerancing per ANSI Y14.5M - 1982.
3. "T", "D", and "E" are reference datums on the body and include allowance for glass overrun and meniscus on the seal line, and lid to base mismatch.
4. These dimensions measured with the leads constrained to be perpendicular to plane T.
5. Pin numbers start with pin #1 and continue counterclockwise to pin #28 when viewed from the top.

853-0589/081594

PO00390S

Package Outlines

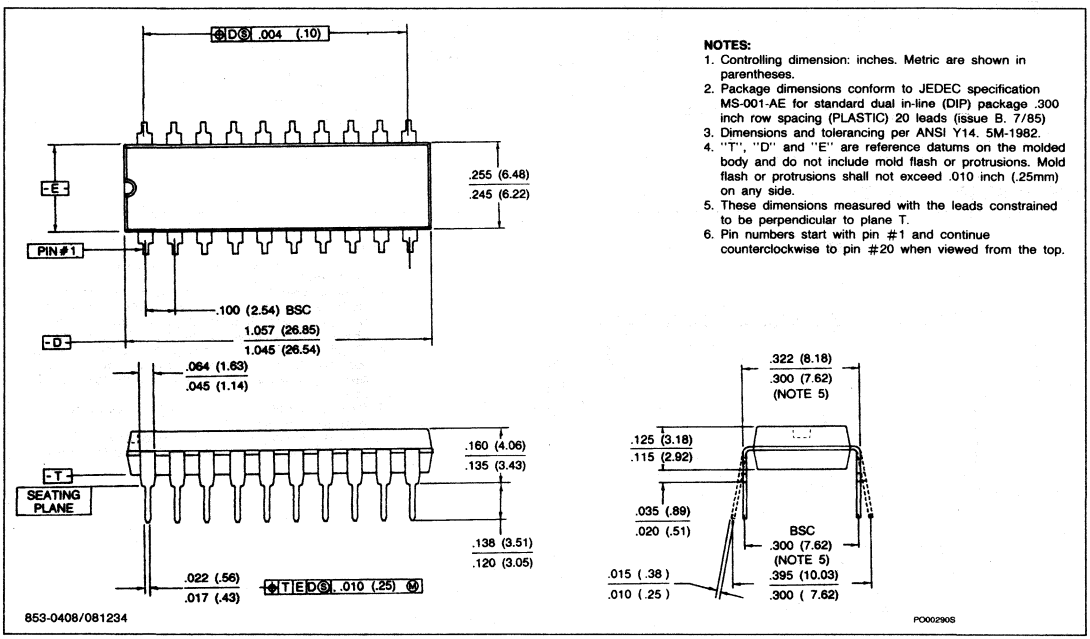
PLASTIC DIP

1. Package dimensions conform to JEDEC specification MS-001-AA for standard Plastic Dual Inline (DIP) package.
2. Controlling dimensions are given in inches with dimensions in millimeters, mm, contained in parentheses.
3. Dimensions and tolerancing per ANSI Y14.5M - 1982.
4. "T", "D" and "E" are reference datums on the molded body and do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.01 inch (0.25mm) on any side.
5. These dimensions measured with the leads constrained to be perpendicular to plane T.
6. Pin numbers start with pin #1 and continue counterclockwise when viewed from the top.
7. Lead material: Olin 194 (Copper Alloy) or equivalent, solder dipped.
8. Body material: Plastic (Epoxy)
9. Thermal test fixture: Device secured in a Textool ZIF socket with 0.04" stand off.

PLASTIC DUAL-IN-LINE PACKAGES

NO. OF LEADS	PACKAGE CODE	θ_{JA}/θ_{JC} (°C/W)	DESCRIPTION
20	NL1	60/24	Cu. Lead Frame 300 mil wide
24	NN1	46/18	Cu. Lead Frame 300 mil wide
28	NQ3	42/16	Cu. Lead Frame 600 mil wide

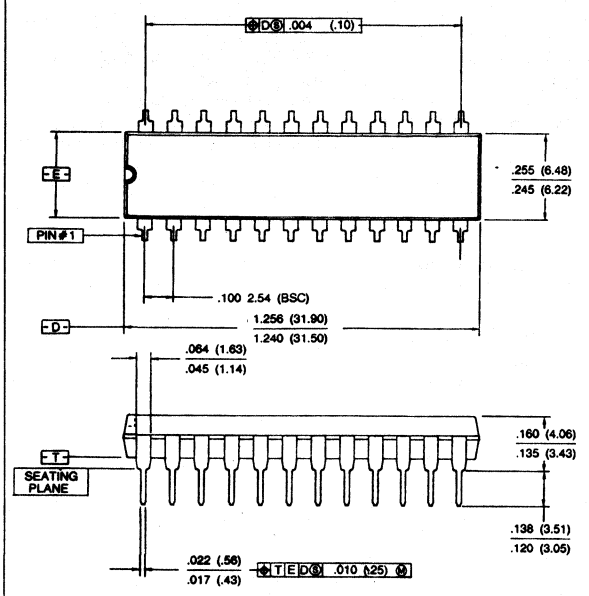
NL1 PLASTIC PDIP-20



NOTES:
1. Controlling dimension: inches. Metric are shown in parentheses.
2. Package dimensions conform to JEDEC specification MS-001-AE for standard dual in-line (DIP) package .300 inch row spacing (PLASTIC) 20 leads (issue B. 7/85)
3. Dimensions and tolerancing per ANSI Y14. 5M-1982.
4. "T", "D" and "E" are reference datums on the molded body and do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010 inch (.25mm) on any side.
5. These dimensions measured with the leads constrained to be perpendicular to plane T.
6. Pin numbers start with pin #1 and continue counterclockwise to pin #20 when viewed from the top.

Package Outlines

NN1 PLASTIC PDIP-24

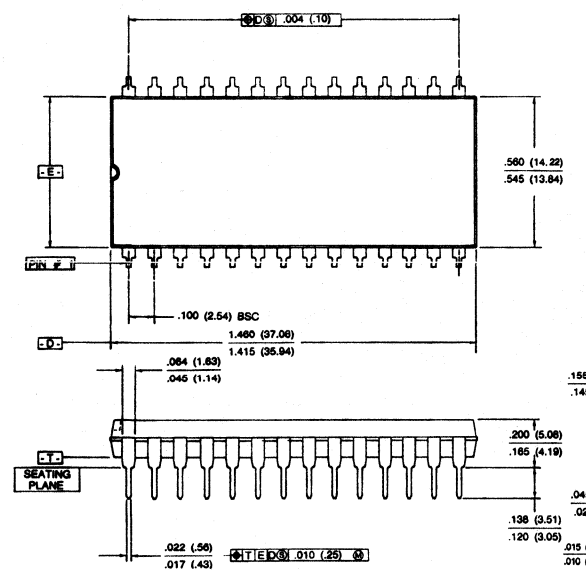


NOTES:
1. Controlling dimension: inches. Metric are shown in parentheses.
2. Package dimensions conform to JEDEC specification MS-001-AR for standard dual in-line (DIP) package .300 inch row spacing (PLASTIC) 24 leads (issue B. 7/85)
3. Dimensions and tolerancing per ANSI Y14. 5M-1982.
4. "T", "D" and "E" are reference datums on the molded body and do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010 inch (.25mm) on any side.
5. These dimensions measured with the leads constrained to be perpendicular to plane T.
6. Pin numbers start with pin #1 and continue counterclockwise to pin #24 when viewed from the top.

853-0410/081236

PO00320S

NQ3 PLASTIC PDIP-28



NOTES:
1. Controlling dimension: inches. Metric are shown in parentheses.
2. Package dimensions conform to JEDEC specification MS-011-AB for standard dual in-line (DIP) package .600 inch row spacing (PLASTIC) 28 leads (issue B. 7/85)
3. Dimensions and tolerancing per ANSI Y14. 5M-1982.
4. "T", "D" and "E" are reference datums on the molded body and do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010 inch (.25mm) on any side.
5. These dimensions measured with the leads constrained to be perpendicular to plane T.
6. Pin numbers start with pin #1 and continue counterclockwise to pin #28 when viewed from the top.

853-0413/081239

PO00371S

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